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FOREWORD

The **International Bulletin on Atomic and Molecular Data for Fusion** is prepared by the Atomic and Molecular Data Unit, **International Atomic Energy Agency**, and published and distributed free of charge by the **IAEA** to assist in the development of fusion research and technology.

The references and indexations included in the Bulletin are provided by atomic data centres at the following institutions:

Oak Ridge National Laboratory, Oak Ridge, USA
National Institute for Standards and Technology, Gaithersburg, USA
Kurchatov Institute, Moscow, Russian Federation
National Institute for Fusion Science, Toki-shi, Japan
Universite de Paris XI, (Paris-Sud), Orsay, France
Nuclear Data Section, IAEA, Vienna, Austria

Information in this Bulletin is presented in four parts. In Part 1, the Atomic and Molecular Data Information System (AMDIS) of the International Atomic Energy Agency is presented. In Part 2, the indexed papers are listed separately for structure and spectra, atomic and molecular collisions, and surface interactions. The structure and spectra indexation lines are grouped by process. Information is summarized for the type of process, the reactants, the energy range where applicable, type of data (Th for theory, Ex for experiment and E/T for both) and the reference number in the Bulletin.

Part 3 contains all the bibliographic data for both the indexed and non-indexed references. Those references which are indexed in Part 1 are identified by the repeated indexation lines. The Author Index (part 4) refers to the bibliographic references contained in part 3. Contributions are solicited on data generation work in progress and on new data in the course of publication. Contributions should include an explanation of their applicability to fusion research and should be sent to:

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In addition to the regular publication of the Bulletin, free data consultation from the entire (1950-present) bibliographic database is available on the **IAEA** Atomic and Molecular Data Unit web site: <http://www-amdis.iaea.org/AMBDAS>

Vienna, August 2003

The Editors

New on the Atomic and Molecular Web Site

The Atomic and Molecular (A+M) Data Unit of the International Atomic Energy Agency is dedicated to continuing to improve the level of access to quality data for use in nuclear fusion energy research. To meet this goal, the Unit will, from time to time, add new features and capabilities to the Unit web page. The Unit web page is located at the URL: <http://www-amdis.iaea.org/> Recent new developments will be summarized in each issue of the Bulletin. In this issue several new additions are briefly described.

GENIE

As new databases become available on-line at various locations, new data relevant to fusion research have the potential to be accessed. However, to make use of different databases it is necessary for the user to understand the protocol for each database. In some cases it is necessary to register on the database as well. In response to this situation the A+M Unit has worked with consultants Y. Ralchenko and D. Humbert to develop a prototype search engine, called GENIE. GENIE makes it possible for a user to enter one request for data, either radiative or collisional, and to have that request sent in proper format to several available databases. Results of the searches are then presented to the user. Currently this prototype is limited to a few databases and the requests are quite limited in nature. However, continued development is foreseen and this promises to be a useful tool.

Online computing

In some cases there are needs for data which are not available in any on-line database. In that case it is often possible that such data could be calculated from existing computer codes, so that at least an estimate of the data would be available. The A+M Unit has been working on making a method for providing access to some A+M codes. J. Peek brought a version of a code for electron impact excitation cross section calculations to the Unit. This code uses the atomic structure calculations of R.D. Cowan. These codes have now been made accessible through the A+M web page, so that it is possible to calculate approximate cross sections for arbitrary ions for most elements. Following the success of this method, the Unit is in the process of encouraging other institutions to pursue similar activities, so that it is hoped that a number of calculational tools will become available for a number of processes.

New data

Considerable new data are constantly being added to the on-line databases. Recently a large amount of data for plasma-surface interaction has been added. In addition, a large amount of data for radiated power from plasmas of interest to fusion were made available on the Unit web page.

AMBDAS

In the past the bibliographic data used in producing this Bulletin were accessible only through a Telnet connection. Recently Y. Ralchenko has worked with the Unit as a consultant and produced a web based interface for the bibliographic database. This allows users to search the entire bibliographic database using a number of criteria, such as author, process, reactants, etc.

The Unit is planning more additions and new features for the home page. Future developments will be summarized in future editions of the Bulletin.

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1 The Atomic and Molecular Data Information System

AMDIS is the **A**tomic and **M**olecular **D**ata **I**nformation **S**ystem of the International Atomic Energy Agency, established and maintained by the Atomic and Molecular Data Unit, Nuclear Data Section.

AMDIS contains two main parts: a bibliographic database for atomic and molecular data for fusion research, and numerical databases of recommended and evaluated atomic, molecular and plasma-surface interaction data.

AMBDAS, **A**tomic and **M**olecular **B**ibliographic **D**ata **S**ystem, is an on-line simple to use bibliographic data retrieval system. It contains more than 40,000 bibliographic entries with atomic, molecular and plasma-surface interaction data of interest to fusion research, dating back to 1950. It contains all references published in the International Bulletin on Atomic and Molecular Data for Fusion, CIAMDA 80, CIAMDA 87, and CIAMDA 98. Entries may be retrieved by author, process, reactants, type of reference, year of publication, energy range and data source (theoretical or experimental). The interface is a web-based application, and only requires a web-browser for use, no registration is required.

ALADDIN, **A** Labelled **A**tomistic **D**ata **I**Nterface, is a database system developed in order to provide a standard and flexible format and interface for the exchange and management of numerical atomic, molecular and plasma-material interaction data of interest to fusion research. It was originally designed by R. Hulse at the Princeton Plasma Physics Laboratory. It is the system adopted by the IAEA and the Atomic Data Centre Network, an international group of fourteen data centres from several countries, for the exchange of data since 1988. AMDIS now contains a new interface to ALADDIN. ALADDIN has recently been converted to an entirely web-driven system, which can be accessed from the Unit homepage at <http://www-amdis.iaea.org>. It is a simple to use interface that facilitates searching for recommended or evaluated atomic, molecular, plasma-surface interaction and material properties data. Options to plot selected data are also available. An ALADDIN entry consists on searchable (hierarchical) labels that characterize the process, reactants and any other important information; boolean labels which give information about the source, year, laboratory or data centre, and reference; comment lines and the numerical data. The data may be given by a parametrization through an analytic fit or the data itself. With the web interface the user may also obtain a figure with data and labels, text accompanying the data, and the Fortran source of the evaluation function.

2 INDEXATION

2.1 Structure and Spectra

Transition probabil., Oscill. Strengths	He I, Z= 3, 12	Th	67
Transition probabil., Oscill. Strengths	Li I	Th	44
Transition probabil., Oscill. Strengths	Li I, Z= 6, 24	Th	12
Transition probabil., Oscill. Strengths	Be I, Z= 4, 14	Th	84
Transition probabil., Oscill. Strengths	Be I, Z= 5, 36	Th	80
Transition probabil., Oscill. Strengths	Be I, Z= 6, 8	Th	55
Transition probabil., Oscill. Strengths	B I	E/T	65
Transition probabil., Oscill. Strengths	B I	E/T	65
Transition probabil., Oscill. Strengths	B I, Z= 5, 82	Th	37
Transition probabil., Oscill. Strengths	C I	Ex	82
Transition probabil., Oscill. Strengths	C I	Th	45
Transition probabil., Oscill. Strengths	C I	Ex	30
Transition probabil., Oscill. Strengths	C I	Th	28
Transition probabil., Oscill. Strengths	C I, Z= 7, 15	Th	25
Transition probabil., Oscill. Strengths	C I	Ex	22
Transition probabil., Oscill. Strengths	C I, Z= 9, 18	Th	15
Transition probabil., Oscill. Strengths	C II	Ex	59
Transition probabil., Oscill. Strengths	C II	Th	48
Transition probabil., Oscill. Strengths	C II	Th	28
Transition probabil., Oscill. Strengths	C II	Th	13
Transition probabil., Oscill. Strengths	C III	Th	70
Transition probabil., Oscill. Strengths	C III	Th	28
Transition probabil., Oscill. Strengths	C III	Th	13
Transition probabil., Oscill. Strengths	C IV	Th	63
Transition probabil., Oscill. Strengths	C IV	Th	28
Transition probabil., Oscill. Strengths	N I	Ex	86
Transition probabil., Oscill. Strengths	N I, Z= 7, 14	Th	10
Transition probabil., Oscill. Strengths	N II	Th	19
Transition probabil., Oscill. Strengths	N III	Th	48
Transition probabil., Oscill. Strengths	N IV	Th	88
Transition probabil., Oscill. Strengths	O I - O VI	Th	49
Transition probabil., Oscill. Strengths	O I	Th	43
Transition probabil., Oscill. Strengths	O I	Th	24
Transition probabil., Oscill. Strengths	O I, Z= 8, 14	Th	10
Transition probabil., Oscill. Strengths	O II	Ex	85
Transition probabil., Oscill. Strengths	O II	Ex	78
Transition probabil., Oscill. Strengths	O II	Ex	36
Transition probabil., Oscill. Strengths	O IV	Th	48
Transition probabil., Oscill. Strengths	O V	Th	88
Transition probabil., Oscill. Strengths	O V	E/T	75
Transition probabil., Oscill. Strengths	O VI	Th	63
Transition probabil., Oscill. Strengths	Ne VII	Th	29
Transition probabil., Oscill. Strengths	Mg I, Z= 13, 92	Th	61
Transition probabil., Oscill. Strengths	Mg I, Z= 13, 16	Th	34
Transition probabil., Oscill. Strengths	Al I	Ex	11
Transition probabil., Oscill. Strengths	Al II	Ex	11
Transition probabil., Oscill. Strengths	Al V	Th	73
Transition probabil., Oscill. Strengths	Al VI	Th	73
Transition probabil., Oscill. Strengths	Al XII	Th	51
Transition probabil., Oscill. Strengths	Al XIII	Th	51
Transition probabil., Oscill. Strengths	Si I, Z= 28, 79	Th	87
Transition probabil., Oscill. Strengths	Si I, Z= 26, 54	Th	64

Transition probabil., Oscill. Strengths	Si I	Th	53
Transition probabil., Oscill. Strengths	Si I, Z= 25, 36	Th	26
Transition probabil., Oscill. Strengths	Si II	Ex	50
Transition probabil., Oscill. Strengths	Si VIII	Th	74
Transition probabil., Oscill. Strengths	Si IX	Th	18
Transition probabil., Oscill. Strengths	Si XII	Th	52
Transition probabil., Oscill. Strengths	Si XIII	Th	52
Transition probabil., Oscill. Strengths	S X	Th	74
Transition probabil., Oscill. Strengths	Cl I, Z= 18, 29	Th	33
Transition probabil., Oscill. Strengths	Ar XIV	Th	89
Transition probabil., Oscill. Strengths	Ar XV	Th	89
Transition probabil., Oscill. Strengths	K III	Th	76
Transition probabil., Oscill. Strengths	K XI	Ex	71
Transition probabil., Oscill. Strengths	K XV	Ex	71
Transition probabil., Oscill. Strengths	K XVI	Ex	71
Transition probabil., Oscill. Strengths	Ca IV	Th	76
Transition probabil., Oscill. Strengths	Sc V	Th	76
Transition probabil., Oscill. Strengths	Ti I, Z= 54, 92	Th	79
Transition probabil., Oscill. Strengths	Ti I, Z= 42, 83	Th	42
Transition probabil., Oscill. Strengths	Ti II	Ex	21
Transition probabil., Oscill. Strengths	Ti II	Ex	14
Transition probabil., Oscill. Strengths	Ti XII	Th	40
Transition probabil., Oscill. Strengths	Ti XII	Th	7
Transition probabil., Oscill. Strengths	Fe II	Ex	68
Transition probabil., Oscill. Strengths	Fe II	Th	56
Transition probabil., Oscill. Strengths	Fe II	Ex	30
Transition probabil., Oscill. Strengths	Fe II	Ex	23
Transition probabil., Oscill. Strengths	Fe II	Ex	20
Transition probabil., Oscill. Strengths	Fe II	Ex	9
Transition probabil., Oscill. Strengths	Fe II	Ex	5
Transition probabil., Oscill. Strengths	Fe V	Th	66
Transition probabil., Oscill. Strengths	Fe VI	Th	2
Transition probabil., Oscill. Strengths	Fe X	Th	60
Transition probabil., Oscill. Strengths	Fe X	Ex	46
Transition probabil., Oscill. Strengths	Fe X	Th	17
Transition probabil., Oscill. Strengths	Fe XI	Ex	46
Transition probabil., Oscill. Strengths	Fe XII	Ex	46
Transition probabil., Oscill. Strengths	Fe XII	Th	4
Transition probabil., Oscill. Strengths	Fe XIII	Ex	46
Transition probabil., Oscill. Strengths	Fe XIV	Ex	46
Transition probabil., Oscill. Strengths	Fe XIV	Th	38
Transition probabil., Oscill. Strengths	Fe XVI	Th	32
Transition probabil., Oscill. Strengths	Fe XVIII	Th	72
Transition probabil., Oscill. Strengths	Fe XXIII	Th	3
Transition probabil., Oscill. Strengths	Fe XXIV	Th	63
Transition probabil., Oscill. Strengths	Co XVII	Th	8
Transition probabil., Oscill. Strengths	Ni I, Z= 74, 84	Th	54
Transition probabil., Oscill. Strengths	Ni III	Th	16
Transition probabil., Oscill. Strengths	Ni XVI	Th	83
Transition probabil., Oscill. Strengths	Ni XVI	Th	38
Transition probabil., Oscill. Strengths	Ni XVIII	Th	1
Transition probabil., Oscill. Strengths	Cu II	Th	27
Transition probabil., Oscill. Strengths	Cu XX	Th	81
Transition probabil., Oscill. Strengths	Kr I	Ex	62
Transition probabil., Oscill. Strengths	Kr I, Z= 37, 42	Th	58
Transition probabil., Oscill. Strengths	Kr II	Th	39
Transition probabil., Oscill. Strengths	Kr II	Ex	6

Transition probabil., Oscill. Strengths	Kr XVII-XIX	E/T	69
Transition probabil., Oscill. Strengths	Kr XXII-XXIII	E/T	69
Transition probabil., Oscill. Strengths	Kr XXV	Th	31
Transition probabil., Oscill. Strengths	Kr XXVI	Th	31
Transition probabil., Oscill. Strengths	Kr XXVII	Th	31
Transition probabil., Oscill. Strengths	Kr XXVIII	Th	31
Transition probabil., Oscill. Strengths	Zr XXXI	Th	31
Transition probabil., Oscill. Strengths	Nb XXXII	Th	31
Transition probabil., Oscill. Strengths	Mo II	Th	47
Transition probabil., Oscill. Strengths	Mo II	E/T	35
Transition probabil., Oscill. Strengths	Mo II	E/T	35
Transition probabil., Oscill. Strengths	Mo XXXIII	Th	31
Transition probabil., Oscill. Strengths	Xe I	Ex	62
Transition probabil., Oscill. Strengths	Er I, Z= 70, 73	Th	57
Transition probabil., Oscill. Strengths	Ta II	Th	41
Transition probabil., Oscill. Strengths	W III	Ex	77

2.2 Atomic and Molecular Collisions

2.2.1 Photon Collisions

$h\nu + \mathbf{H}^{-1+}$	Photon Collisions		Th	271
$h\nu + \mathbf{H}^{-1+}$	Photodetachment	2.15 μm	Ex	348
$h\nu + \mathbf{H}^{-1+}$	Photodetachment		Th	271
$h\nu + \mathbf{H}^{-1+}$	Photodetachment		Th	261
$h\nu + \mathbf{H}^{-1+}$	Photodetachment	6.00-60.00 keV	Th	157
$h\nu + \mathbf{H}^{-1+}$	Photoexcitation	6.00-60.00 keV	Th	157
$h\nu + \mathbf{H}^{-1+}$	Photoionization		Th	261
$h\nu + \mathbf{H}^{-1+}$	Photoionization	4.00-180.00 eV	Th	161
$h\nu + \mathbf{H}^{-1+}$	Photoionization	6.00-60.00 keV	Th	157
$h\nu + \mathbf{H}$	Photon Collisions		Th	307
$h\nu + \mathbf{H}$	Photon Collisions	1.43×10^{12} - 1.83×10^{15} W/cm ²	Th	300
$h\nu + \mathbf{H}$	Total Absor., Scat.	3.40 eV	E/T	338
$h\nu + \mathbf{H}$	Total Absor., Scat.	$1\text{-}20 \times 10^{12}$ W/cm ²	Th	311
$h\nu + \mathbf{H}$	Elastic Scattering	$1\text{-}20 \times 10^{12}$ W/cm ²	Th	311
$h\nu + \mathbf{H}$	Photoionization	200.00-500.00 V/cm	Th	310
$h\nu + \mathbf{H}$	Photoionization		Th	307
$h\nu + \mathbf{H}$	Photoionization		Th	285
$h\nu + \mathbf{H}$	Photoionization	1.71-13.78 eV	Th	283
$h\nu + \mathbf{H}^*$	Photoionization	1.71-13.78 eV	Th	283
$h\nu + \mathbf{H}$	Photoionization		Th	270
$h\nu + \mathbf{H}$	Photoionization		Th	264
$h\nu + \mathbf{H}$	Photoionization	5.00-28.00 eV	Th	240
$h\nu + \mathbf{H}$	Photoionization	5.00 eV	Th	237
$h\nu + \mathbf{H}$	Photoionization	13.78-619.90 eV	Th	176
$h\nu + \mathbf{H}$	Photoionization	1.13-6.53 eV	Th	165
$h\nu + \mathbf{H}$	Photoionization	17.00-50.00 eV	E/T	139
$h\nu + \mathbf{H}_2$	Photodissociation	6.42 eV	Ex	346
$h\nu + \mathbf{H}_2$	Photodissociation	13.10-13.10 eV	Th	331
$h\nu + \mathbf{H}_2$	Photodissociation	$0.65\text{-}8 \times 10^{14}$ W/cm ²	Ex	299
$h\nu + \mathbf{H}_2$	Photodissociation	6×10^{16} W/cm ²	Ex	217
$h\nu + \mathbf{H}_2$	Photoionization	1.57-1.61 eV	Th	322
$h\nu + \mathbf{H}_2$	Photoionization	$0.65\text{-}8 \times 10^{14}$ W/cm ²	Ex	299
$h\nu + \mathbf{H}_2$	Photoionization	76.10-104.00 eV	Ex	293

$h\nu + \text{H}_2$	Photoionization		Th	208
$h\nu + \text{H}_2^{1+}$	Photon Collisions		Th	243
$h\nu + \text{H}_2^{1+}$	Photodissociation	1.57 eV	Ex	359
$h\nu + \text{H}_2^{1+}$	Photodissociation	1.58 eV	Ex	345
$h\nu + \text{H}_2^{1+}$	Photodissociation		Ex	306
$h\nu + \text{H}_2^{1+}$	Photodissociation	1.17 eV	E/T	177
$h\nu + \text{H}_2^{1+}$	Photoexcitation	1.17 eV	E/T	177
$h\nu + \text{H}_2^{1+}$	Photoionization		Th	308
$h\nu + \text{H}_2^{1+}$	Photoionization	4.08-5.44 eV	Th	215
$h\nu + \text{H}_3$	Photon Collisions	3.10-6.20 eV	Ex	245
$h\nu + \text{H}_3$	Fluorescence	3.10-6.20 eV	Ex	245
$h\nu + \text{H}_3$	Photoexcitation	3.10-6.20 eV	Ex	245
$h\nu + \text{H}_3^{1+}$	Photoionization		Th	284
$h\nu + \text{HD}_2$	Photon Collisions	3.10-6.20 eV	Ex	245
$h\nu + \text{HD}_2$	Fluorescence	3.10-6.20 eV	Ex	245
$h\nu + \text{HD}_2$	Photoexcitation	3.10-6.20 eV	Ex	245
$h\nu + \text{HD}_2^{1+}$	Photodissociation	1.17 eV	E/T	177
$h\nu + \text{HD}_2^{1+}$	Photoexcitation	1.17 eV	E/T	177
$h\nu + \text{D}_2$	Photodissociation	$0.65-8 \times 10^{14}$ W/cm ²	Ex	299
$h\nu + \text{D}_2$	Photoionization	$0.65-8 \times 10^{14}$ W/cm ²	Ex	299
$h\nu + \text{D}_2$	Photoionization	76.10-104.00 eV	Ex	293
$h\nu + \text{D}_2^{1+}$	Photon Collisions		Th	243
$h\nu + \text{D}_2^{1+}$	Photodissociation		Ex	306
$h\nu + \text{D}_3$	Photon Collisions	3.10-6.20 eV	Ex	245
$h\nu + \text{D}_3$	Fluorescence	3.10-6.20 eV	Ex	245
$h\nu + \text{D}_3$	Photoexcitation	3.10-6.20 eV	Ex	245
$h\nu + \text{He}^{-1+}$	Photodetachment	37.00-45.00 eV	Th	339
$h\nu + \text{He}^{-1+}$	Photodetachment	37.60-44.00 eV	Th	262
$h\nu + \text{He}^{-1+}$	Photoionization	4.00-180.00 eV	Th	161
$h\nu + \text{He}$	Total Absor., Scat.		Th	323
$h\nu + \text{He}$	Total Absor., Scat.		Th	314
$h\nu + \text{He}$	Photodetachment		Th	261
$h\nu + \text{He}$	Photodetachment	6.00-60.00 keV	Th	157
$h\nu + \text{He}$	Photoexcitation	100.00 a.u.	Th	324
$h\nu + \text{He}$	Photoexcitation	1.45-1.78 a.u.	Th	223
$h\nu + \text{He}^*$	Photoexcitation	1.45-1.78 a.u.	Th	223
$h\nu + \text{He}$	Photoexcitation		Th	214
$h\nu + \text{He}$	Photoexcitation	0.65-0.78 a.u.	Th	180
$h\nu + \text{He}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{He}$	Photoexcitation	6.00-60.00 keV	Th	157
$h\nu + \text{He}$	Photoionization	139.00 eV	E/T	337
$h\nu + \text{He}$	Photoionization	76.00-78.50 eV	Th	330
$h\nu + \text{He}$	Photoionization	74.00-134.00 eV	Ex	326
$h\nu + \text{He}$	Photoionization	75.00-200.00 eV	Th	321
$h\nu + \text{He}$	Photoionization	90.00 eV	Th	316
$h\nu + \text{He}$	Photoionization	9.00-60.00 eV	Th	304
$h\nu + \text{He}$	Photoionization		Th	301
$h\nu + \text{He}$	Photoionization	76.10-104.00 eV	Ex	293
$h\nu + \text{He}$	Photoionization	1.50 keV	Th	282
$h\nu + \text{He}$	Photoionization		Th	278
$h\nu + \text{He}$	Photoionization		Th	261
$h\nu + \text{He}$	Photoionization		Th	255
$h\nu + \text{He}$	Photoionization	1.00 keV	Th	220
$h\nu + \text{He}$	Photoionization		Th	194
$h\nu + \text{He}$	Photoionization	60.00-200.00 eV	Th	190
$h\nu + \text{He}$	Photoionization	139.00 eV	Ex	189
$h\nu + \text{He}$	Photoionization	74.40 eV	Th	188

$h\nu + \text{He}$	Photoionization	12.75-150.00 eV	Th	174
$h\nu + \text{He}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{He}$	Photoionization	6.00-60.00 keV	Th	157
$h\nu + \text{He}$	Photoionization	20.00-300.00 eV	Th	156
$h\nu + \text{He}$	Photoionization	94.40 eV	Ex	153
$h\nu + \text{He}$	Photoionization	65.00-72.00 eV	Th	130
$h\nu + \text{He}$	Photoionization	1.00-50.00 keV	Th	127
$h\nu + \text{He}^{1+}$	Photon Collisions		Th	307
$h\nu + \text{He}^{1+}$	Photodissociation	40.60-42.00 eV	Th	332
$h\nu + \text{He}^{1+}$	Photoionization		Th	307
$h\nu + \text{Li}^{-1+}$	Photodetachment	56.00-65.00 eV	E/T	350
$h\nu + \text{Li}^{-1+}$	Photodetachment	56.00-64.00 eV	Th	347
$h\nu + \text{Li}^{-1+}$	Photodetachment	2.40-2.50 eV	Th	233
$h\nu + \text{Li}^{-1+}$	Photodetachment	56.00-70.00 eV	Ex	184
$h\nu + \text{Li}^{-1+}$	Photoionization	56.00-70.00 eV	Ex	184
$h\nu + \text{Li}$	Photoexcitation		Ex	213
$h\nu + \text{Li}$	Photoionization	59.00-73.00 eV	Th	295
$h\nu + \text{Li}^*$	Photoionization	59.00-73.00 eV	Th	295
$h\nu + \text{Li}$	Photoionization	1.50 keV	Th	282
$h\nu + \text{Li}$	Photoionization	5.00-28.00 eV	Th	240
$h\nu + \text{Li}$	Photoionization	1.00 keV	Th	220
$h\nu + \text{Li}$	Photoionization	20.00-300.00 eV	Th	156
$h\nu + \text{Li}^{1+}$	Photoionization	1.00 keV	Th	220
$h\nu + \text{Li}^{2+}$	Photon Collisions		Th	307
$h\nu + \text{Li}^{2+}$	Photoionization		Th	307
$h\nu + \text{Li}^{2+}$	Photoionization	60.00-200.00 eV	Th	190
$h\nu + \text{Li}$	Elastic Scattering	0.50-0.99 eV	Th	141
$h\nu + \text{Be}$	Photodissociation	115.49-123.16 eV	Ex	195
$h\nu + \text{Be}$	Elastic Scattering	30.00-120.00 eV	Th	315
$h\nu + \text{Be}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Be}$	Photoexcitation	115.49-123.16 eV	Ex	195
$h\nu + \text{Be}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Be}$	Photoionization	30.00-120.00 eV	Th	315
$h\nu + \text{Be}$	Photoionization	1.00-75.00 eV	Th	305
$h\nu + \text{Be}^*$	Photoionization	4.00-20.00 eV	Th	281
$h\nu + \text{Be}$	Photoionization	4.00-20.00 eV	Th	281
$h\nu + \text{Be}$	Photoionization	23.00-117.00 eV	Th	269
$h\nu + \text{Be}$	Photoionization	30.00-125.00 eV	Th	260
$h\nu + \text{Be}^*$	Photoionization	30.00-125.00 eV	Th	260
$h\nu + \text{Be}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Be}$	Photoionization	160.00 eV	Th	206
$h\nu + \text{Be}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Be}$	Photoionization	32.00-80.00 eV	Ex	126
$h\nu + \text{Be}^{2+}$	Photoionization	60.00-200.00 eV	Th	190
$h\nu + \text{B}^{1+}$	Elastic Scattering	30.00-120.00 eV	Th	315
$h\nu + \text{B}^{1+}$	Photoionization	30.00-120.00 eV	Th	315
$h\nu + \text{B}_2\text{O}_3$	Total Absor., Scat.	0.36-1.33 MeV	Ex	234
$h\nu + \text{C}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{C}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{C}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{C}$	Photoexcitation	10.33-10.78 eV	Ex	114
$h\nu + \text{C}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{C}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{C}^{1+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{C}^{1+}$	Total Absor., Scat.	21.75-38.74 eV	Ex	258
$h\nu + \text{C}^{1+}$	Elastic Scattering	21.75-38.74 eV	Ex	258
$h\nu + \text{C}^{1+}$	Photoionization	1.80-2.30 Ry	E/T	334

$h\nu + \text{C}^{1+}$	Photoionization	21.75-38.74 eV	Ex	258
$h\nu + \text{C}^{1+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{C}^{2+}$	Elastic Scattering	30.00-120.00 eV	Th	315
$h\nu + \text{C}^{2+}$	Photoionization	30.00-120.00 eV	Th	315
$h\nu + \text{C}^{3+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{C}^{4+}$	Photoionization	60.00-200.00 eV	Th	190
$h\nu + \text{CO}$	Photodissociation	334.00 eV	Th	294
$h\nu + \text{CO}$	Photodissociation	306.40-419.30 eV	Ex	160
$h\nu + \text{CO}$	Photoexcitation	286.50-288.50 eV	Ex	333
$h\nu + \text{CO}$	Photoionization	286.50-288.50 eV	Ex	333
$h\nu + \text{CO}$	Photoionization	334.00 eV	Th	294
$h\nu + \text{CO}$	Photoionization	2.00-20.00 keV	Th	257
$h\nu + \text{CO}$	Photoionization	306.40-419.30 eV	Ex	160
$h\nu + \text{CO}^{1+}$	Photoionization	25.00-50.00 eV	Th	197
$h\nu + \text{CO}^{1+}$	Photoionization	27.30-50.00 eV	Ex	183
$h\nu + \text{CO}_2$	Photoexcitation	306.00-320.00 eV	Ex	224
$h\nu + \text{CO}_2$	Photoionization	306.00-320.00 eV	Ex	224
$h\nu + \text{N}$	Photoexcitation		Th	105
$h\nu + \text{N}$	Photoionization	1.00 keV	Th	220
$h\nu + \text{N}^{1+}$	Photoexcitation	1.77-3.26 eV	Ex	90
$h\nu + \text{N}^{2+}$	Photoionization		Th	357
$h\nu + \text{N}^{3+}$	Elastic Scattering	30.00-120.00 eV	Th	315
$h\nu + \text{N}^{3+}$	Photoionization		Th	357
$h\nu + \text{N}^{3+}$	Photoionization	30.00-120.00 eV	Th	315
$h\nu + \text{N}^{4+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{N}_2$	Photodissociation	1.20×10^{15} W/cm ²	Ex	246
$h\nu + \text{N}_2$	Photodissociation	306.40-419.30 eV	Ex	160
$h\nu + \text{N}_2$	Photoionization	306.40-419.30 eV	Ex	160
$h\nu + \text{N}_2$	Photoionization	410.00-450.00 eV	Th	125
$h\nu + \text{NO}$	Photodissociation	16.90-19.60 eV	Ex	151
$h\nu + \text{NO}$	Photodissociation	16.27 eV	Ex	148
$h\nu + \text{NO}$	Photoexcitation	399.00-401.00 eV	Ex	169
$h\nu + \text{NO}$	Photoexcitation	16.90-19.60 eV	Ex	151
$h\nu + \text{NO}$	Photoionization	25.00 eV	Th	298
$h\nu + \text{NO}$	Photoionization	16.90-19.60 eV	Ex	151
$h\nu + \text{NO}$	Photoionization	2.33-2.74 eV	Ex	129
$h\nu + \text{O}$	Photoexcitation		Th	105
$h\nu + \text{O}$	Photoionization	13.00-60.00 eV	Th	320
$h\nu + \text{O}$	Photoionization	50.00 eV	E/T	138
$h\nu + \text{O}^{1+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{O}^{1+}$	Photoexcitation		Th	105
$h\nu + \text{O}^{1+}$	Photoionization	30.00-35.00 eV	Ex	349
$h\nu + \text{O}^{1+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{O}^{2+}$	Photoionization	39.00 eV	Th	147
$h\nu + \text{O}^{3+}$	Photoionization		Th	357
$h\nu + \text{O}^{4+}$	Elastic Scattering	30.00-120.00 eV	Th	315
$h\nu + \text{O}^{4+}$	Photoionization		Th	357
$h\nu + \text{O}^{4+}$	Photoionization	30.00-120.00 eV	Th	315
$h\nu + \text{O}^{5+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{O}^{6+}$	Photoionization	60.00-200.00 eV	Th	190
$h\nu + \text{O}_2$	Total Absor., Scat.	14.60-16.20 eV	Ex	142
$h\nu + \text{O}_2$	Photodissociation	1.20×10^{15} W/cm ²	Ex	246
$h\nu + \text{O}_2^*$	Photodissociation	22.70-24.80 eV	E/T	241
$h\nu + \text{O}_2$	Photodissociation	20.50-25.00 eV	E/T	218
$h\nu + \text{O}_2$	Photodissociation	14.60-16.20 eV	Ex	142
$h\nu + \text{O}_2$	Photodissociation	10.97-11.81 eV	Ex	121
$h\nu + \text{O}_2$	Fluorescence	20.50-25.00 eV	E/T	218

$h\nu + \text{O}_2$	Fluorescence	14.60-16.20 eV	Ex	142
$h\nu + \text{O}_2$	Photoexcitation	20.50-25.00 eV	E/T	218
$h\nu + \text{O}_2$	Photoexcitation	14.60-16.20 eV	Ex	142
$h\nu + \text{O}_2$	Photoionization	70.00-531.00 eV	E/T	263
$h\nu + \text{O}_2$	Photoionization	50.00 eV	Th	124
$h\nu + \text{O}_3$	Photoionization	12.00-21.00 eV	Ex	123
$h\nu + \text{F}^{-1+}$	Photodetachment	1.39-6.81 eV	Ex	181
$h\nu + \text{F}^{1+}$	Photoexcitation		Th	105
$h\nu + \text{F}^{2+}$	Photoexcitation		Th	105
$h\nu + \text{F}^{5+}$	Elastic Scattering	30.00-120.00 eV	Th	315
$h\nu + \text{F}^{5+}$	Photoionization	30.00-120.00 eV	Th	315
$h\nu + \text{F}^{6+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{Ne}$	Photoexcitation	0.67-1.60 Ry	Th	342
$h\nu + \text{Ne}$	Photoexcitation	0.85-1.20 keV	E/T	336
$h\nu + \text{Ne}$	Photoexcitation	0.10-60.00 a.u.	Th	238
$h\nu + \text{Ne}$	Photoexcitation	7.00-300.00 eV	Th	171
$h\nu + \text{Ne}$	Photoionization	0.85-1.20 keV	E/T	336
$h\nu + \text{Ne}$	Photoionization	0.60-60.00 keV	Th	335
$h\nu + \text{Ne}$	Photoionization		Th	270
$h\nu + \text{Ne}$	Photoionization	0.10-60.00 a.u.	Th	238
$h\nu + \text{Ne}$	Photoionization	1.00 keV	Th	220
$h\nu + \text{Ne}$	Photoionization	7.00-300.00 eV	Th	171
$h\nu + \text{Ne}$	Photoionization	60.00-330.00 eV	Th	163
$h\nu + \text{Ne}^{1+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ne}^{1+}$	Photoexcitation	3.54 eV	Ex	102
$h\nu + \text{Ne}^{2+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ne}^{2+}$	Photoexcitation		Th	105
$h\nu + \text{Ne}^{3+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ne}^{3+}$	Photoexcitation		Th	105
$h\nu + \text{Ne}^{4+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ne}^{5+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ne}^{6+}$	Elastic Scattering	30.00-120.00 eV	Th	315
$h\nu + \text{Ne}^{6+}$	Photoexcitation	7.00-300.00 eV	Th	171
$h\nu + \text{Ne}^{6+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ne}^{6+}$	Photoionization	30.00-120.00 eV	Th	315
$h\nu + \text{Ne}^{6+}$	Photoionization	7.00-300.00 eV	Th	171
$h\nu + \text{Ne}^{7+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ne}^{7+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{Ne}^{8+}$	Photoexcitation	7.00-300.00 eV	Th	171
$h\nu + \text{Ne}^{8+}$	Photoionization	7.00-300.00 eV	Th	171
$h\nu + \text{Na}^{-1+}$	Photodetachment	30.00-51.00 eV	Ex	196
$h\nu + \text{Na}$	Photoionization	5.00-28.00 eV	Th	240
$h\nu + \text{Na}^*$	Photoionization	1.24 MeV	E/T	239
$h\nu + \text{Na}$	Photoionization	1.24 MeV	E/T	239
$h\nu + \text{Na}$	Photoionization	20.00-300.00 eV	Th	156
$h\nu + \text{Na}$	Photoionization	40.00-140.00 eV	Th	134
$h\nu + \text{Na}^{1+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Na}^{1+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Na}^{2+}$	Photoexcitation		Th	132
$h\nu + \text{Na}^{3+}$	Photoexcitation		Th	105
$h\nu + \text{Na}^{4+}$	Photoexcitation		Th	105
$h\nu + \text{Na}^{8+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{NaH}$	Photodissociation	4.17 eV	Th	302
$h\nu + \text{Mg}$	Total Absor., Scat.	8.55-16.53 eV	E/T	288
$h\nu + \text{Mg}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Mg}$	Photoexcitation	4.35 eV	Ex	318
$h\nu + \text{Mg}$	Photoexcitation	22.10 keV	Ex	236

$h\nu + \text{Mg}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Mg}$	Photoionization	0.28-0.30 a.u.	Th	344
$h\nu + \text{Mg}$	Photoionization	4.35 eV	Ex	318
$h\nu + \text{Mg}$	Photoionization	1.55 eV	Ex	286
$h\nu + \text{Mg}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Mg}$	Photoionization	4.35 eV	Ex	209
$h\nu + \text{Mg}$	Photoionization	160.00 eV	Th	206
$h\nu + \text{Mg}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Mg}$	Photoionization	5.00-15.00 eV	Th	144
$h\nu + \text{Mg}^*$	Photoionization	5.00-15.00 eV	Th	144
$h\nu + \text{Mg}$	Photoionization	100.00-300.00 eV	Th	93
$h\nu + \text{Mg}^{1+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Mg}^{1+}$	Photoexcitation	9.92 eV	Th	120
$h\nu + \text{Mg}^{1+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Mg}^{2+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Mg}^{2+}$	Photoionization	5.80-5.90 Ry	Th	352
$h\nu + \text{Mg}^{2+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Mg}^{3+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Mg}^{4+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Mg}^{4+}$	Photoexcitation		Th	105
$h\nu + \text{Mg}^{5+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Mg}^{5+}$	Photoexcitation		Th	105
$h\nu + \text{Mg}^{6+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Mg}^{7+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Mg}^{8+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Mg}^{9+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Mg}^{9+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{Al}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Al}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Al}$	Photoexcitation	2.07-6.20 eV	E/T	108
$h\nu + \text{Al}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Al}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Al}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Al}^{1+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Al}^{1+}$	Photoexcitation	2.07-6.20 eV	E/T	108
$h\nu + \text{Al}^{1+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Al}^{2+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Al}^{2+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Al}^{3+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Al}^{3+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Al}^{4+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Al}^{5+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Al}^{5+}$	Photoexcitation		Th	105
$h\nu + \text{Al}^{6+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Al}^{6+}$	Photoexcitation		Th	105
$h\nu + \text{Al}^{6+}$	Photoionization	140.00 Ry	Th	279
$h\nu + \text{Al}^{7+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Al}^{8+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Al}^{9+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Al}^{10+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Al}^{10+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{Si}^{-1+}$	Photodetachment	1.39-6.81 eV	Ex	181
$h\nu + \text{Si}$	Total Absor., Scat.	8.00-25.00 keV	Ex	230
$h\nu + \text{Si}$	Photoionization	8.00-25.00 keV	Ex	230
$h\nu + \text{Si}^{4+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Si}^{4+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Si}^{5+}$	Photoexcitation	0.92-8.27 keV	Th	119

$h\nu + \text{Si}^{6+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Si}^{6+}$	Photoexcitation		Th	105
$h\nu + \text{Si}^{7+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Si}^{7+}$	Photoexcitation		Th	105
$h\nu + \text{Si}^{8+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Si}^{8+}$	Photoexcitation	12.40-49.59 eV	Th	111
$h\nu + \text{Si}^{9+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Si}^{10+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Si}^{11+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Si}^{11+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{P}^{3+}$	Photoexcitation		Th	355
$h\nu + \text{P}^{7+}$	Photoexcitation		Th	105
$h\nu + \text{P}^{8+}$	Photoexcitation		Th	105
$h\nu + \text{S}^{-1+}$	Photodetachment	2.02-2.02 eV	Ex	291
$h\nu + \text{S}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{S}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{S}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{S}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{S}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{S}^{1+}$	Photoionization	20.00-200.00 eV	Ex	303
$h\nu + \text{S}^{7+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{S}^{8+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{S}^{8+}$	Photoexcitation		Th	105
$h\nu + \text{S}^{9+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{S}^{9+}$	Photoexcitation		Th	105
$h\nu + \text{S}^{10+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{S}^{11+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{S}^{12+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{S}^{13+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{S}^{13+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{SO}_2^{1+}$	Photoionization	37.00-120.00 eV	Ex	122
$h\nu + \text{SO}_2^{2+}$	Photoionization	37.00-120.00 eV	Ex	122
$h\nu + \text{Cl}$	Photoexcitation	27.00 eV	Th	182
$h\nu + \text{Cl}$	Photoionization	202.00-212.00 eV	Th	131
$h\nu + \text{Cl}^{9+}$	Photoexcitation		Th	105
$h\nu + \text{Cl}^{10+}$	Photoexcitation		Th	105
$h\nu + \text{Ar}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Ar}$	Elastic Scattering	0.05-1.00 keV	Ex	250
$h\nu + \text{Ar}$	Photoexcitation	0.67-1.60 Ry	Th	342
$h\nu + \text{Ar}$	Photoexcitation	35.00-37.00 eV	Th	341
$h\nu + \text{Ar}$	Photoexcitation	3.46-6.54 keV	Ex	340
$h\nu + \text{Ar}$	Photoexcitation	321.00-330.00 eV	Ex	327
$h\nu + \text{Ar}$	Photoexcitation	7×10^{17} W/cm ²	Ex	251
$h\nu + \text{Ar}$	Photoexcitation	245.00 eV	Ex	128
$h\nu + \text{Ar}$	Photoionization	35.00-37.00 eV	Th	341
$h\nu + \text{Ar}$	Photoionization	3.46-6.54 keV	Ex	340
$h\nu + \text{Ar}$	Photoionization	0.60-60.00 keV	Th	335
$h\nu + \text{Ar}$	Photoionization	360.00 eV	Th	329
$h\nu + \text{Ar}$	Photoionization	440.00 eV	Th	328
$h\nu + \text{Ar}$	Photoionization	321.00-330.00 eV	Ex	327
$h\nu + \text{Ar}$	Photoionization	1.55 eV	Ex	289
$h\nu + \text{Ar}$	Photoionization	7.70 eV	Ex	274
$h\nu + \text{Ar}$	Photoionization		Th	270
$h\nu + \text{Ar}$	Photoionization	246.90-249.00 eV	E/T	265
$h\nu + \text{Ar}$	Photoionization	117.00-743.00 eV	Ex	256
$h\nu + \text{Ar}$	Photoionization	0.05-1.00 keV	Ex	250
$h\nu + \text{Ar}$	Photoionization	35.00-45.00 eV	Ex	248

$h\nu + \text{Ar}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Ar}$	Photoionization	$6 \cdot 10^{13}$ W/cm ²	Th	198
$h\nu + \text{Ar}$	Photoionization	4.70 W/cm ²	Ex	187
$h\nu + \text{Ar}$	Photoionization	245.00 eV	Ex	128
$h\nu + \text{Ar}^{2+}$	Photoexcitation	4.13 eV	Ex	94
$h\nu + \text{Ar}^{3+}$	Photoexcitation	4.13 eV	Ex	94
$h\nu + \text{Ar}^{7+}$	Photoionization	47.50-67.50 eV	Th	203
$h\nu + \text{Ar}^{9+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ar}^{10+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ar}^{10+}$	Photoexcitation		Th	105
$h\nu + \text{Ar}^{11+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ar}^{12+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ar}^{12+}$	Photoexcitation	8.00 Ry	Th	92
$h\nu + \text{Ar}^{13+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ar}^{14+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ar}^{15+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ar}^{15+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{K}^{-1+}$	Photodetachment	3.00-4.40 eV	E/T	287
$h\nu + \text{K}$	Photoionization	20.00-300.00 eV	Th	156
$h\nu + \text{K}^{1+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{K}^{1+}$	Photoionization	0.60-60.00 keV	Th	335
$h\nu + \text{K}^{1+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{K}^{11+}$	Photoexcitation		Th	105
$h\nu + \text{Ca}$	Elastic Scattering	1.60 μm	Ex	254
$h\nu + \text{Ca}$	Photoionization	1.60 μm	Ex	254
$h\nu + \text{Ca}$	Photoionization	10^7 - 10^8 W/cm ²	E/T	207
$h\nu + \text{Ca}$	Photoionization	160.00 eV	Th	206
$h\nu + \text{Ca}^{1+}$	Photoionization	32.80-33.50 eV	E/T	242
$h\nu + \text{Ca}^{2+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Ca}^{2+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Ca}^{2+}$	Photoionization	50.00-70.00 eV	Ex	164
$h\nu + \text{Ca}^{11+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ca}^{12+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ca}^{12+}$	Photoexcitation		Th	105
$h\nu + \text{Ca}^{13+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ca}^{14+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ca}^{15+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ca}^{16+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ca}^{17+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Ca}^{17+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{Ca}^{19+}$	Photoionization	0.00-100.00 GeV	Th	360
$h\nu + \text{Sc}$	Photoexcitation	27.00-45.00 eV	E/T	221
$h\nu + \text{Sc}$	Photoionization	351.00-410.00 eV	Ex	192
$h\nu + \text{Ti}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Ti}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Ti}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Ti}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Ti}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Ti}^{1+}$	Photoexcitation	6.49 eV	Ex	112
$h\nu + \text{Ti}^{2+}$	Total Absor., Scat.	17.00-27.00 eV	Ex	219
$h\nu + \text{Ti}^{11+}$	Photoexcitation		Th	99
$h\nu + \text{Ti}^{19+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{Cr}$	Photoionization	706.00 eV	Ex	280
$h\nu + \text{Cr}^{21+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{Mn}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Mn}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Mn}^{1+}$	Photon Collisions	15.00 eV	Th	200

$h\nu + \text{Mn}^{1+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Mn}^{6+}$	Photoexcitation		Th	107
$h\nu + \text{Fe}$	Total Absor., Scat.	10.00-230.00 eV	Ex	146
$h\nu + \text{Fe}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Fe}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Fe}$	Photoionization	127.00 eV	Ex	268
$h\nu + \text{Fe}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Fe}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Fe}$	Photoionization	6.00 Ry	Ex	186
$h\nu + \text{Fe}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Fe}^{1+}$	Photoexcitation		Th	358
$h\nu + \text{Fe}^{1+}$	Photoexcitation	10.83 eV	Ex	118
$h\nu + \text{Fe}^{1+}$	Photoexcitation	3.54-7.75 eV	Ex	101
$h\nu + \text{Fe}^{1+}$	Photoexcitation	10.00 eV	Ex	97
$h\nu + \text{Fe}^{1+}$	Photoionization	6.00 Ry	Ex	186
$h\nu + \text{Fe}^{2+}$	Photoionization	0.03-8.16 keV	Th	145
$h\nu + \text{Fe}^{3+}$	Photoionization	0.03-8.16 keV	Th	145
$h\nu + \text{Fe}^{4+}$	Photoionization	0.03-8.16 keV	Th	145
$h\nu + \text{Fe}^{5+}$	Photoionization	0.03-8.16 keV	Th	145
$h\nu + \text{Fe}^{6+}$	Photoionization	0.03-8.16 keV	Th	145
$h\nu + \text{Fe}^{7+}$	Photoexcitation		Th	107
$h\nu + \text{Fe}^{7+}$	Photoionization	0.03-8.16 keV	Th	145
$h\nu + \text{Fe}^{16+}$	Photoionization	100.00 eV	Th	277
$h\nu + \text{Fe}^{17+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Fe}^{17+}$	Photoionization	100.00 eV	Th	277
$h\nu + \text{Fe}^{18+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Fe}^{19+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Fe}^{20+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Fe}^{20+}$	Photoexcitation	8.00 Ry	Th	92
$h\nu + \text{Fe}^{21+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Fe}^{22+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Fe}^{22+}$	Photoexcitation		Th	95
$h\nu + \text{Fe}^{22+}$	Photoionization	138.00-800.00 Ry	Th	155
$h\nu + \text{Fe}^{23+}$	Photoexcitation	0.92-8.27 keV	Th	119
$h\nu + \text{Fe}^{23+}$	Photoionization	138.00-800.00 Ry	Th	155
$h\nu + \text{Fe}^{42+}$	Photoexcitation		Th	107
$h\nu + \text{Co}$	Elastic Scattering	15.00-22.00 keV	Ex	354
$h\nu + \text{Co}$	Photoionization	127.00 eV	Ex	268
$h\nu + \text{Co}^{8+}$	Photoexcitation		Th	107
$h\nu + \text{Co}^{16+}$	Photoexcitation	$0-7 \times 10^{-5}$ a.u.	Th	110
$h\nu + \text{Co}^{16+}$	Photoexcitation		Th	100
$h\nu + \text{Ni}$	Elastic Scattering	15.00-22.00 keV	Ex	354
$h\nu + \text{Ni}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Ni}^{9+}$	Photoexcitation		Th	107
$h\nu + \text{Ni}^{25+}$	Photoexcitation	20.00-680.00 Ry	Th	109
$h\nu + \text{Cu}$	Elastic Scattering	15.00-22.00 keV	Ex	354
$h\nu + \text{Cu}$	Photoexcitation		Th	356
$h\nu + \text{Cu}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Cu}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Cu}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Cu}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Cu}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Cu}^{10+}$	Photoexcitation		Th	107
$h\nu + \text{Zn}$	Elastic Scattering	15.00-22.00 keV	Ex	354
$h\nu + \text{Zn}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Zn}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Zn}$	Photoexcitation	88.00 eV	E/T	159

$h\nu + \text{Zn}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Zn}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Zn}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Zn}^{11+}$	Photoexcitation		Th	107
$h\nu + \text{Ga}$	Photoionization	3.07 eV	Ex	173
$h\nu + \text{Ga}^{12+}$	Photoexcitation		Th	107
$h\nu + \text{Ge}$	Total Absor., Scat.	8.00-25.00 keV	Ex	230
$h\nu + \text{Ge}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{Ge}$	Photoionization	8.00-25.00 keV	Ex	230
$h\nu + \text{Ge}^{13+}$	Photoexcitation		Th	107
$h\nu + \text{As}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{As}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{As}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{As}^{14+}$	Photoexcitation		Th	107
$h\nu + \text{Se}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{Se}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Se}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Se}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Se}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Se}^{15+}$	Photoexcitation		Th	107
$h\nu + \text{Br}^{16+}$	Photoexcitation		Th	107
$h\nu + \text{Kr}$	Photoexcitation	0.67-1.60 Ry	Th	342
$h\nu + \text{Kr}$	Photoionization		Th	270
$h\nu + \text{Kr}$	Photoionization	117.00-743.00 eV	Ex	256
$h\nu + \text{Kr}$	Photoionization	90.00-190.00 eV	Ex	168
$h\nu + \text{Kr}$	Photoionization		E/T	162
$h\nu + \text{Kr}$	Photoionization	0.01-10.00 keV	Th	154
$h\nu + \text{Kr}^{1+}$	Photoexcitation	2.14-2.76 eV	Ex	98
$h\nu + \text{Kr}^{17+}$	Photoexcitation		Th	107
$h\nu + \text{Rb}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{Rb}$	Photoexcitation		Th	356
$h\nu + \text{Rb}^{1+}$	Total Absor., Scat.	100.00-140.00 eV	Ex	191
$h\nu + \text{Rb}^{2+}$	Total Absor., Scat.	110.00-150.00 eV	E/T	205
$h\nu + \text{Rb}^{18+}$	Photoexcitation		Th	107
$h\nu + \text{Sr}$	Photoionization	34.00-42.00 eV	Ex	199
$h\nu + \text{Sr}$	Photoionization	25.14-25.26 eV	Ex	166
$h\nu + \text{Sr}^{19+}$	Photoexcitation		Th	107
$h\nu + \text{Y}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Y}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Y}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Y}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Y}^{20+}$	Photoexcitation		Th	107
$h\nu + \text{Zr}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Zr}$	Photoionization	6.00 keV	Ex	353
$h\nu + \text{Zr}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Zr}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Zr}^{21+}$	Photoexcitation		Th	107
$h\nu + \text{Nb}$	Elastic Scattering	15.00-22.00 keV	Ex	354
$h\nu + \text{Nb}$	Photoionization	6.00 keV	Ex	353
$h\nu + \text{Nb}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Nb}^{22+}$	Photoexcitation		Th	107
$h\nu + \text{Mo}$	Elastic Scattering	15.00-22.00 keV	Ex	354
$h\nu + \text{Mo}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Mo}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Mo}$	Photoionization	6.00 keV	Ex	353
$h\nu + \text{Mo}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Mo}$	Photoionization	88.00 eV	E/T	159

$h\nu + \text{Mo}^{23+}$	Photoexcitation		Th	107
$h\nu + \text{Tc}^{24+}$	Photoexcitation		Th	107
$h\nu + \text{Ru}^{25+}$	Photoexcitation		Th	107
$h\nu + \text{Rh}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Rh}^{26+}$	Photoexcitation		Th	107
$h\nu + \text{Pd}$	Elastic Scattering	15.00-22.00 keV	Ex	354
$h\nu + \text{Pd}$	Photoionization	6.00 keV	Ex	353
$h\nu + \text{Pd}^{27+}$	Photoexcitation		Th	107
$h\nu + \text{Ag}$	Elastic Scattering	15.00-22.00 keV	Ex	354
$h\nu + \text{Ag}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{Ag}$	Photoexcitation		Th	356
$h\nu + \text{Ag}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Ag}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Ag}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Ag}$	Photoionization	6.00 keV	Ex	353
$h\nu + \text{Ag}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Ag}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Ag}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Ag}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Ag}^{28+}$	Photoexcitation		Th	107
$h\nu + \text{Cd}$	Elastic Scattering	15.00-22.00 keV	Ex	354
$h\nu + \text{Cd}$	Photoexcitation		Th	356
$h\nu + \text{Cd}$	Photoionization	6.00 keV	Ex	353
$h\nu + \text{Cd}^{29+}$	Photoexcitation		Th	107
$h\nu + \text{In}$	Elastic Scattering	15.00-22.00 keV	Ex	354
$h\nu + \text{In}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{In}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{In}$	Photoionization	6.00 keV	Ex	353
$h\nu + \text{In}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{In}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{In}^{1+}$	Total Absor., Scat.	18.00-33.00 eV	Ex	178
$h\nu + \text{In}^{30+}$	Photoexcitation		Th	107
$h\nu + \text{Sn}^{-1+}$	Photodetachment	2.41-2.71 eV	Ex	309
$h\nu + \text{Sn}$	Elastic Scattering	15.00-22.00 keV	Ex	354
$h\nu + \text{Sn}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Sn}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Sn}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Sn}$	Photoexcitation	0.49-2.48 eV	Ex	140
$h\nu + \text{Sn}$	Photoionization	6.00 keV	Ex	353
$h\nu + \text{Sn}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Sn}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Sn}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Sn}^{1+}$	Total Absor., Scat.	23.00-33.00 eV	Ex	152
$h\nu + \text{Sn}^{2+}$	Total Absor., Scat.	23.00-33.00 eV	Ex	152
$h\nu + \text{Sn}^{31+}$	Photoexcitation		Th	107
$h\nu + \text{Sb}$	Photoionization	6.00 keV	Ex	353
$h\nu + \text{Sb}^{32+}$	Photoexcitation		Th	107
$h\nu + \text{Te}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{Te}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Te}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Te}$	Photoionization	6.00 keV	Ex	353
$h\nu + \text{Te}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Te}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Te}^{33+}$	Photoexcitation		Th	107
$h\nu + \text{I}$	Total Absor., Scat.	60.00-130.00 eV	Th	319
$h\nu + \text{I}$	Photoionization	6.00 keV	Ex	353
$h\nu + \text{I}^{1+}$	Total Absor., Scat.	60.00-130.00 eV	Th	319

$h\nu + \text{I}^{1+}$	Photoionization	40.00-150.00 eV	Th	317
$h\nu + \text{I}^{2+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{I}^{2+}$	Total Absor., Scat.	60.00-130.00 eV	Th	319
$h\nu + \text{I}^{2+}$	Photoionization	40.00-150.00 eV	Th	317
$h\nu + \text{I}^{2+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{I}^{3+}$	Total Absor., Scat.	60.00-130.00 eV	Th	319
$h\nu + \text{I}^{34+}$	Photoexcitation		Th	107
$h\nu + \text{Xe}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Xe}$	Elastic Scattering	20.00-900.00 eV	Ex	253
$h\nu + \text{Xe}$	Fluorescence	2.03-3.10 eV	Ex	267
$h\nu + \text{Xe}$	Photoexcitation	0.67-1.60 Ry	Th	342
$h\nu + \text{Xe}$	Photoexcitation	672.00 eV	E/T	185
$h\nu + \text{Xe}$	Photoionization	90.00-160.00 eV	Th	361
$h\nu + \text{Xe}$	Photoionization	15.00-200.00 eV	Ex	292
$h\nu + \text{Xe}$	Photoionization	$2 \cdot 10^{18}$ W/cm ²	Ex	290
$h\nu + \text{Xe}$	Photoionization		Th	270
$h\nu + \text{Xe}$	Photoionization	2.03-3.10 eV	Ex	267
$h\nu + \text{Xe}$	Photoionization	80.00-200.00 eV	Ex	266
$h\nu + \text{Xe}$	Photoionization	117.00-743.00 eV	Ex	256
$h\nu + \text{Xe}$	Photoionization	20.00-900.00 eV	Ex	253
$h\nu + \text{Xe}$	Photoionization	93.80 eV	Ex	252
$h\nu + \text{Xe}$	Photoionization	94.52 eV	Th	225
$h\nu + \text{Xe}$	Photoionization	700.00-800.00 eV	Ex	212
$h\nu + \text{Xe}$	Photoionization	400.00 eV	E/T	204
$h\nu + \text{Xe}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Xe}$	Photoionization	672.00 eV	E/T	185
$h\nu + \text{Xe}$	Photoionization	10.00-400.00 eV	Th	179
$h\nu + \text{Xe}^*$	Photoionization	10.00-400.00 eV	Th	179
$h\nu + \text{Xe}$	Photoionization	0.01-10.00 keV	Th	154
$h\nu + \text{Xe}$	Photoionization	4.66 eV	Th	150
$h\nu + \text{Xe}$	Photoionization	1.55-5.00 eV	Th	149
$h\nu + \text{Xe}^{1+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Xe}^{1+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Xe}^{1+}$	Photoionization	80.00-140.00 eV	Ex	158
$h\nu + \text{Xe}^{1+}$	Photoionization	50.00-130.00 eV	Ex	135
$h\nu + \text{Xe}^{2+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Xe}^{2+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Xe}^{2+}$	Photoionization	50.00-130.00 eV	Ex	135
$h\nu + \text{Xe}^{35+}$	Photoexcitation		Th	107
$h\nu + \text{Cs}$	Total Absor., Scat.		Ex	244
$h\nu + \text{Cs}$	Photoexcitation		Th	356
$h\nu + \text{Cs}$	Photoexcitation	2.93-3.90 eV	Ex	325
$h\nu + \text{Cs}$	Photoionization	6.00 keV	Ex	353
$h\nu + \text{Cs}$	Photoionization	2.93-3.90 eV	Ex	325
$h\nu + \text{Cs}$	Photoionization	1.46 eV	E/T	170
$h\nu + \text{Cs}^{1+}$	Photoionization	90.00-160.00 eV	Th	361
$h\nu + \text{Cs}^{36+}$	Photoexcitation		Th	107
$h\nu + \text{Ba}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Ba}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{Ba}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Ba}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Ba}^{1+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Ba}^{1+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Ba}^{2+}$	Photon Collisions	15.00 eV	Th	200
$h\nu + \text{Ba}^{2+}$	Photoionization	90.00-160.00 eV	Th	361
$h\nu + \text{Ba}^{2+}$	Photoionization	15.00 eV	Th	200
$h\nu + \text{Ba}^{37+}$	Photoexcitation		Th	107

$h\nu + \text{La}$	Elastic Scattering	11.18-11.31 eV	E/T	273
$h\nu + \text{La}^{1+}$	Photoexcitation	2.13-4.12 eV	Ex	115
$h\nu + \text{La}^{38+}$	Photoexcitation		Th	107
$h\nu + \text{Pr}^{1+}$	Photoexcitation	2.00-6.00 eV	Ex	351
$h\nu + \text{Nd}^{2+}$	Photoexcitation	1.75-3.78 eV	E/T	106
$h\nu + \text{Nd}^{2+}$	Photoexcitation	1.80-4.00 eV	Th	91
$h\nu + \text{Sm}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{Eu}$	Total Absor., Scat.	110.00-160.00 eV	Th	276
$h\nu + \text{Eu}$	Photoionization	53.00 eV	E/T	297
$h\nu + \text{Eu}^{1+}$	Total Absor., Scat.	110.00-160.00 eV	Th	276
$h\nu + \text{Eu}^{1+}$	Photoexcitation	16.53-34.44 eV	Ex	116
$h\nu + \text{Gd}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Gd}$	Fluorescence	4.00-10.00 keV	Ex	228
$h\nu + \text{Gd}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Gd}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Gd}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Gd}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{GdO}^{-1+}$	Photodetachment	3.50 eV	Ex	312
$h\nu + \text{Tb}$	Fluorescence	4.00-10.00 keV	Ex	228
$h\nu + \text{Dy}$	Fluorescence	4.00-10.00 keV	Ex	228
$h\nu + \text{Dy}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Dy}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Dy}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Dy}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Ho}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{Ho}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Ho}$	Fluorescence	4.00-10.00 keV	Ex	228
$h\nu + \text{Ho}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Ho}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Ho}^{2+}$	Photoexcitation	1.35-5.39 eV	Ex	104
$h\nu + \text{Er}$	Fluorescence	4.00-10.00 keV	Ex	228
$h\nu + \text{Tm}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{Tm}$	Photoexcitation	22.10 keV	Ex	236
$h\nu + \text{Tm}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{Tm}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Tm}$	Photoionization	22.10 keV	Ex	236
$h\nu + \text{Tm}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{Tm}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Yb}$	Total Absor., Scat.		Th	323
$h\nu + \text{Yb}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{Yb}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Yb}$	Fluorescence	4.00-10.00 keV	Ex	228
$h\nu + \text{Yb}$	Fluorescence	3.11 eV	Ex	210
$h\nu + \text{Yb}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{Yb}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{Yb}$	Photoionization	59.50 keV	Ex	136
$h\nu + \text{Lu}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{Lu}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{Lu}$	Photoionization	59.50 keV	Ex	136
$h\nu + \text{Hf}$	Photoionization	59.50 keV	Ex	136
$h\nu + \text{Hf}^{39+}$	Photoexcitation		Th	107
$h\nu + \text{Ta}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Ta}$	Fluorescence	59.50 keV	E/T	137
$h\nu + \text{Ta}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{Ta}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Ta}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{Ta}$	Photoionization	59.50 keV	Ex	136

$h\nu + \text{Ta}^{40+}$	Photoexcitation		Th	107
$h\nu + \text{W}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{W}$	Fluorescence	59.50 keV	E/T	137
$h\nu + \text{W}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{W}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{W}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{W}$	Photoionization	59.50 keV	Ex	136
$h\nu + \text{W}^{41+}$	Photoexcitation		Th	107
$h\nu + \text{Re}$	Fluorescence	59.50 keV	E/T	137
$h\nu + \text{Re}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{Re}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Re}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{Re}$	Photoionization	59.50 keV	Ex	136
$h\nu + \text{Os}^{43+}$	Photoexcitation		Th	107
$h\nu + \text{Ir}^{44+}$	Photoexcitation		Th	107
$h\nu + \text{Pt}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Pt}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Pt}$	Photoionization	59.50 keV	Ex	136
$h\nu + \text{Pt}^{45+}$	Photoexcitation		Th	107
$h\nu + \text{Au}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Au}$	Fluorescence	12.20-16.70 keV	Ex	343
$h\nu + \text{Au}$	Photoexcitation		Th	356
$h\nu + \text{Au}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{Au}$	Photoionization	12.20-16.70 keV	Ex	343
$h\nu + \text{Au}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Au}$	Photoionization	21.00-26.00 keV	Ex	227
$h\nu + \text{Au}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{Au}^{46+}$	Photoexcitation		Th	107
$h\nu + \text{Hg}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{Hg}$	Photoexcitation		Th	356
$h\nu + \text{Hg}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{Hg}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{Hg}^{47+}$	Photoexcitation		Th	107
$h\nu + \text{Tl}$	Elastic Scattering	22.10 keV	Ex	235
$h\nu + \text{Tl}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Tl}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{Tl}$	Photoionization	59.50 keV	Ex	231
$h\nu + \text{Tl}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{Pb}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Pb}$	Fluorescence	12.20-16.70 keV	Ex	343
$h\nu + \text{Pb}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{Pb}$	Photoionization	12.20-16.70 keV	Ex	343
$h\nu + \text{Pb}$	Photoionization	59.50 keV	Ex	231
$h\nu + \text{Pb}$	Photoionization	59.50 keV	Ex	229
$h\nu + \text{Pb}$	Photoionization	21.00-26.00 keV	Ex	227
$h\nu + \text{Pb}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{Bi}_2\text{O}_3$	Total Absor., Scat.	0.36-1.33 MeV	Ex	234
$h\nu + \text{Th}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Th}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{Th}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{Th}$	Photoionization	17.80-46.90 keV	Ex	175
$h\nu + \text{Th}^{1+}$	Photoexcitation	0.95-4.13 eV	Ex	103
$h\nu + \text{Th}^{2+}$	Photoexcitation	1.25-9.54 eV	Ex	117
$h\nu + \text{CH}_3\text{OH}$	Photodissociation	285.00-560.00 eV	Ex	222
$h\nu + \text{CH}_3\text{OH}$	Photoionization	285.00-560.00 eV	Ex	222
$h\nu + \text{perturbation}$	Photon Collisions	0.10-10.00 keV	E/T	226
$h\nu + \text{HBr}$	Total Absor., Scat.	69.00-79.00 eV	Ex	313

$h\nu + \text{HBr}$	Photoionization	69.00-79.00 eV	Ex	313
$h\nu + \text{O Seq}$	Photoexcitation		Th	105
$h\nu + \text{CS}_2$	Photoexcitation	250.00 eV	Ex	133
$h\nu + \text{CS}_2$	Photoionization	250.00 eV	Ex	133
$h\nu + \text{C}_{60}$	Photoionization	0.30-1.70 a.u.	Th	296
$h\nu + \text{C}_{60}$	Photoionization	5.00-45.00 eV	Th	275
$h\nu + \text{C}_{60}$	Photoionization	7.00-50.00 eV	Th	193
$h\nu + \text{U}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{U}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{U}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{U}$	Photoionization	17.80-46.90 keV	Ex	175
$h\nu + \text{U}^{1+}$	Photoexcitation	1.85-3.54 eV	E/T	202
$h\nu + \text{SF}_6$	Photodissociation	20.00-205.00 eV	Ex	211
$h\nu + \text{SF}_6$	Photoionization	20.00-205.00 eV	Ex	211
$h\nu + \text{Bi}^{-1+}$	Photodetachment	7.60-7.60 keV	Ex	272
$h\nu + \text{Bi}$	Elastic Scattering	88.00 keV	Ex	232
$h\nu + \text{Bi}$	Photoexcitation	5.96 keV	Ex	216
$h\nu + \text{Bi}$	Photoexcitation	88.00 eV	E/T	159
$h\nu + \text{Bi}$	Photoionization	59.50 keV	Ex	231
$h\nu + \text{Bi}$	Photoionization	5.96 keV	Ex	216
$h\nu + \text{Bi}$	Photoionization	88.00 eV	E/T	159
$h\nu + \text{Bi}^{1+}$	Photoexcitation	3.10-11.27 eV	Th	113
$h\nu + \text{Pu}$	Photoionization	0.01-10.00 keV	Th	154
$h\nu + \text{C}_2\text{H}_6$	Photodissociation	11.00-40.00 eV	Ex	201
$h\nu + \text{C}_2\text{H}_6$	Photoionization	11.00-40.00 eV	Ex	201
$h\nu + \text{S}_2$	Total Absor., Scat.	0.00-6.00 K	Th	167
$h\nu + \text{He Seq}$	Photodetachment		Th	261
$h\nu + \text{He Seq}$	Photoionization		Th	261
$h\nu + \text{C}_{20}$	Photoionization	7.00-50.00 eV	Th	193
$h\nu + \text{TiO}$	Photoexcitation		Th	96
$h\nu + \text{Na}_9^{1+}$	Photoionization	5.00 eV	Ex	172
$h\nu + \text{Na}_2$	Total Absor., Scat.	1.00-3.00 K	Th	249
$h\nu + \text{Na}_2$	Fluorescence	2.41 eV	Ex	143
$h\nu + \text{C}_6\text{H}_6$	Photodissociation	8×10^{13} W/cm ²	Ex	247
$h\nu + \text{C}_6\text{H}_6$	Photoionization	8×10^{13} W/cm ²	Ex	247
$h\nu + \text{N Seq.}$	Photoexcitation		Th	105
$h\nu + \text{Ag Seq.}$	Photoexcitation		Th	356
$h\nu + \text{Au Seq.}$	Photoexcitation		Th	356
$h\nu + \text{Hg Seq.}$	Photoexcitation		Th	356
$h\nu + \text{Cd Seq.}$	Photoexcitation		Th	356
$h\nu + \text{C}_{60}(\text{Be})$	Photoionization	160.00 eV	Th	206
$h\nu + \text{C}_{60}(\text{Mg})$	Photoionization	160.00 eV	Th	206
$h\nu + \text{C}_{60}(\text{Ca})$	Photoionization	160.00 eV	Th	206
$h\nu + \text{H} + \text{Kr}$	Photoionization	75.00-127.00 eV	Ex	259
$h\nu + \text{H} + \text{Xe}$	Photoionization	75.00-127.00 eV	Ex	259
$nh\nu + \text{H}^{-1+}$	Photoionization	4.00-180.00 eV	Th	161
$nh\nu + \text{H}$	Photoionization	200.00-500.00 V/cm	Th	310
$nh\nu + \text{H}$	Photoionization		Th	264
$nh\nu + \text{He}^{-1+}$	Photoionization	4.00-180.00 eV	Th	161
$nh\nu + \text{He}$	Photoionization	1.00-50.00 keV	Th	127
$nh\nu + \text{Ne}$	Photoexcitation	7.00-300.00 eV	Th	171
$nh\nu + \text{Ne}$	Photoionization	7.00-300.00 eV	Th	171
$nh\nu + \text{Ne}^{6+}$	Photoexcitation	7.00-300.00 eV	Th	171
$nh\nu + \text{Ne}^{6+}$	Photoionization	7.00-300.00 eV	Th	171
$nh\nu + \text{Ne}^{8+}$	Photoexcitation	7.00-300.00 eV	Th	171
$nh\nu + \text{Ne}^{8+}$	Photoionization	7.00-300.00 eV	Th	171
$nh\nu + \text{Ar}$	Photoionization		Th	198

$nh\nu + \text{Ar}^{7+}$	Photoionization	47.50-67.50 eV	Th	203
$2h\nu + \text{H}^{-1+}$	Photon Collisions		Th	271
$2h\nu + \text{H}^{-1+}$	Photodetachment		Th	271
$2h\nu + \text{H}$	Photoionization	13.78-619.90 eV	Th	176
$2h\nu + \text{H}_2$	Photodissociation	13.10-13.10 eV	Th	331
$2h\nu + \text{H}_2$	Photoionization		Th	208
$2h\nu + \text{He}$	Photoionization	12.75-150.00 eV	Th	174
$2h\nu + \text{He}^{1+}$	Photodissociation	40.60-42.00 eV	Th	332
$2h\nu + \text{Ne}$	Photoexcitation	0.10-60.00 a.u.	Th	238
$2h\nu + \text{Ne}$	Photoionization	0.10-60.00 a.u.	Th	238
$2h\nu + \text{Ne}$	Photoionization	60.00-330.00 eV	Th	163
$2h\nu + \text{Ar}$	Photoionization	4.70 W/cm ²	Ex	187
$3h\nu + \text{H}_2$	Photoionization		Th	208
$3h\nu + \text{Ca}$	Photoionization	10^7 - 10^8 W/cm ²	E/T	207
$4h\nu + \text{H}_2$	Photoionization		Th	208

2.2.2 Electron Collisions

$e + \text{H}^{-1+}$	Angular Scattering	5.60 keV	Th	418
$e + \text{H}^{-1+}$	Ionization	5.60 keV	Th	418
$e + \text{H}$	Bremsstrahlung	180.00-300.00 keV	Th	477
$e + \text{H}$	Elastic Scattering	10^9 - 10^{11}	Th	597
$e + \text{H}$	Elastic Scattering	100.00-500.00 eV	Th	572
$e + \text{H}^*$	Elastic Scattering	100.00-500.00 eV	Th	572
$e + \text{H}$	Elastic Scattering	1.00-7.00 Ry	Th	551
$e + \text{H}$	Elastic Scattering	200.00 eV	Th	506
$e + \text{H}$	Angular Scattering	$0-\infty$ eV	Th	613
$e + \text{H}$	Angular Scattering	54.40 eV	Th	609
$e + \text{H}$	Angular Scattering	40.80 eV	Th	606
$e + \text{H}$	Angular Scattering	1.00-7.00 Ry	Th	551
$e + \text{H}$	Angular Scattering	17.60-30.00 eV	Th	539
$e + \text{H}$	Angular Scattering	100.00-250.00 eV	Th	520
$e + \text{H}$	Angular Scattering	200.00 eV	Th	506
$e + \text{H}$	Angular Scattering	17.60-250.00 eV	Th	481
$e + \text{H}$	Angular Scattering	100.00 eV	Th	405
$e + \text{H}$	Recombination	500.00 eV	Th	601
$e + \text{H}$	Recombination	0.10-1.00 K	Th	515
$e + \text{H}$	Excitation	20.00 eV	Th	624
$e + \text{H}$	Excitation	$0-\infty$ eV	Th	613
$e + \text{H}$	Excitation	10^9 - 10^{11}	Th	597
$e + \text{H}$	Excitation	5.00 keV	Th	560
$e + \text{H}$	Excitation	20.00-30.00 eV	Ex	556
$e + \text{H}$	Excitation	200.00 eV	Th	506
$e + \text{H}$	Excitation	0.01-1.00 keV	E/T	426
$e + \text{H}$	Ionization	0.40-10.00 keV	Th	652
$e + \text{H}$	Ionization	20.00-40.80 eV	Th	618
$e + \text{H}$	Ionization	0.30-31.00 eV	E/T	616
$e + \text{H}$	Ionization	54.40 eV	Th	609
$e + \text{H}$	Ionization	40.80 eV	Th	606
$e + \text{H}$	Ionization	30.00 eV	E/T	580
$e + \text{H}$	Ionization	16.00-18.00 eV	Th	564
$e + \text{H}$	Ionization	15.60-54.40 eV	Th	552
$e + \text{H}$	Ionization	17.60-30.00 eV	Th	539
$e + \text{H}$	Ionization	100.00-250.00 eV	Th	520
$e + \text{H}$	Ionization	0.10-1.00 K	Th	515
$e + \text{H}$	Ionization	17.60-250.00 eV	Th	481

$e + H$	Ionization	27.20 eV	E/T	478
$e + H$	Ionization	54.40-250.00 eV	Th	465
$e + H^{1+}$	Recombination	0.10-30.00 eV	Th	683
$e + H_2$	Attachment	5.00 eV	Th	680
$e + H_2$	Attachment	3.75-5.00 eV	Ex	394
$e + H_2$	Dissociation		Th	682
$e + H_2$	Dissociation	5.00 eV	Th	680
$e + H_2$	Dissociation	100.00 eV	Th	679
$e + H_2$	Dissociation	0.10-10.00 eV	Th	678
$e + H_2$	Dissociation	200.00 eV	Th	634
$e + H_2$	Dissociation	7.50-14.50 eV	Th	416
$e + H_2$	Dissociation	3.75-5.00 eV	Ex	394
$e + H_2^*$	De-excitation	1.00-10.00 eV	Th	608
$e + H_2$	De-excitation	1.00-10.00 eV	Th	608
$e + H_2^*$	Elastic Scattering	1.00-10.00 eV	Th	608
$e + H_2$	Elastic Scattering	1.00-10.00 eV	Th	608
$e + H_2$	Elastic Scattering		Th	500
$e + H_2$	Elastic Scattering	0.50-20.00 eV	Th	468
$e + H_2^*$	Angular Scattering	1.00-10.00 eV	Th	608
$e + H_2$	Angular Scattering	1.00-10.00 eV	Th	608
$e + H_2$	Angular Scattering	1.50-100.00 eV	Th	568
$e + H_2$	Angular Scattering		Th	500
$e + H_2$	Angular Scattering	0.50-20.00 eV	Th	468
$e + H_2$	Angular Scattering	7.50-14.50 eV	Th	416
$e + H_2$	Total Scattering		Th	500
$e + H_2$	Excitation	0.10-30.00 eV	Th	683
$e + H_2$	Excitation	100.00 eV	Th	679
$e + H_2$	Excitation	0.10-10.00 eV	Th	678
$e + H_2$	Excitation	200.00 eV	Th	634
$e + H_2^*$	Excitation	1.00-10.00 eV	Th	608
$e + H_2$	Excitation	1.00-10.00 eV	Th	608
$e + H_2$	Excitation	1.50-100.00 eV	Th	568
$e + H_2$	Excitation	15.00-40.00 eV	Th	540
$e + H_2$	Excitation	7.50-14.50 eV	Th	416
$e + H_2$	Excitation	400.00 eV	Ex	396
$e + H_2$	Ionization	100.00 eV	Th	679
$e + H_2$	Ionization	0.10-10.00 eV	Th	678
$e + H_2$	Ionization		Th	517
$e + H_2$	Ionization	600.00 eV	Ex	511
$e + H_2$	Ionization	400.00 eV	Ex	396
$e + H_2$	Ionization	20.00 eV	E/T	383
$e + H_2^{1+}$	Dissociation		Th	682
$e + H_2^{1+}$	Dissociation		Th	682
$e + H_2^{1+}$	Dissociation	12.00 eV	Th	681
$e + H_2^{1+}$	Dissociation	0.10-10.00 eV	Th	678
$e + H_2^{1+}$	Dissociation	1.00-16.00 eV	Ex	612
$e + H_2^{1+}$	Dissociation	0.10-8.00 eV	Th	582
$e + H_2^{1+}$	Angular Scattering	2.00 keV	Th	622
$e + H_2^{1+}$	Recombination		Th	682
$e + H_2^{1+}$	Recombination	12.00 eV	Th	681
$e + H_2^{1+}$	Recombination	0.10-10.00 eV	Th	678
$e + H_2^{1+}$	Recombination	1.00-16.00 eV	Ex	612
$e + H_2^{1+}$	Recombination	0.10-8.00 eV	Th	582
$e + H_2^{1+}$	Excitation	0.10-10.00 eV	Th	678
$e + H_2^{1+}$	Ionization	2.00 keV	Th	622
$e + H_3^{1+}$	Dissociation		Th	682
$e + H_3^{1+}$	Dissociation	230.00-290.00 K	Ex	466

$e + H_3^{1+}$	Elastic Scattering	1.00-22.00 eV	Th	483
$e + H_3^{1+}$	Recombination	6.00 meV	Ex	627
$e + H_3^{1+}$	Recombination	230.00-290.00 K	Ex	466
$e + H_3^{1+}$	Excitation	1.00-22.00 eV	Th	483
$e + HD^{1+}$	Dissociation	12.00 eV	Th	681
$e + HD^{1+}$	Dissociation	1.00-16.00 eV	Ex	612
$e + HD^{1+}$	Dissociation	0.10-8.00 eV	Th	582
$e + HD^{1+}$	Recombination	12.00 eV	Th	681
$e + HD^{1+}$	Recombination	1.00-16.00 eV	Ex	612
$e + HD^{1+}$	Recombination	0.10-8.00 eV	Th	582
$e + H_2O$	Dissociation	300.00 eV	E/T	381
$e + H_2O$	Angular Scattering	1.00-7.80 eV	Th	430
$e + H_2O$	Excitation	1.00-7.80 eV	Th	430
$e + H_2O$	Ionization	0.02-2.00 keV	Th	587
$e + H_2O$	Ionization	0.01-1.00 keV	Th	571
$e + H_2O$	Ionization	0.01-10.00 keV	Th	385
$e + H_2O$	Ionization	20.00 eV	E/T	383
$e + H_3O^{1+}$	Dissociation	0.01-2.50 keV	Ex	516
$e + H_3O^{1+}$	Elastic Scattering	1.00-22.00 eV	Th	483
$e + H_3O^{1+}$	Recombination	0.01-2.50 keV	Ex	516
$e + H_3O^{1+}$	Excitation	0.01-2.50 keV	Ex	516
$e + H_3O^{1+}$	Excitation	1.00-22.00 eV	Th	483
$e + HD_2O^{1+}$	Dissociation	0.01-2.50 keV	Ex	516
$e + HD_2O^{1+}$	Recombination	0.01-2.50 keV	Ex	516
$e + HD_2O^{1+}$	Excitation	0.01-2.50 keV	Ex	516
$e + D$	Recombination	0.10-1.00 K	Th	515
$e + D$	Ionization	0.10-1.00 K	Th	515
$e + D_2$	Ionization	20.00 eV	E/T	383
$e + D_2^{1+}$	Dissociation	12.00 eV	Th	681
$e + D_2^{1+}$	Recombination	12.00 eV	Th	681
$e + DT$	Dissociation	200.00 eV	Th	634
$e + DT$	Excitation	200.00 eV	Th	634
$e + D_2O$	Ionization	20.00 eV	E/T	383
$e + D_3O^{1+}$	Dissociation	0.01-2.50 keV	Ex	516
$e + D_3O^{1+}$	Recombination	0.01-2.50 keV	Ex	516
$e + D_3O^{1+}$	Excitation	0.01-2.50 keV	Ex	516
$e + T_2$	Dissociation	200.00 eV	Th	634
$e + T_2$	Excitation	200.00 eV	Th	634
$e + He$	Bremsstrahlung	5.00-40.00 K	Th	555
$e + He$	Elastic Scattering	1.00-20.00 eV	Ex	372
$e + He$	Angular Scattering	64.60 eV	Th	603
$e + He$	Angular Scattering	200.00 eV	Th	510
$e + He$	Angular Scattering	601.00 eV	Ex	509
$e + He$	Angular Scattering	2.00 keV	Th	472
$e + He$	Angular Scattering	1.10 keV	Ex	422
$e + He$	Angular Scattering	5.60 keV	Th	418
$e + He$	Angular Scattering	1.00-20.00 eV	Ex	372
$e + He$	Recombination	500.00 eV	Th	601
$e + He$	Recombination	0.10-1.00 K	Th	515
$e + He$	Excitation	5.00 keV	Th	560
$e + He$	Excitation	0.05-1.40 keV	E/T	549
$e + He^*$	Excitation	1.00-40.00 Threshold	E/T	531
$e + He$	Excitation	1.00-40.00 Threshold	E/T	531
$e + He$	Excitation	200.00 eV	Th	510
$e + He$	Excitation	100.00-400.00 eV	Ex	493
$e + He$	Excitation	0.65-0.78 a.u.	Th	462
$e + He$	Excitation	0.60-1.58 keV	Th	460

$e + \text{He}$	Excitation	2.50 eV	Th	455
$e + \text{He}$	Excitation	2.00-8.00 a.u.	Th	446
$e + \text{He}$	Excitation	3.00-8.50 a.u.	E/T	410
$e + \text{He}$	Excitation	55.00-60.00 eV	E/T	408
$e + \text{He}$	Ionization	2.00 keV	Ex	626
$e + \text{He}$	Ionization	1.00 keV	Ex	605
$e + \text{He}$	Ionization	64.60 eV	Th	603
$e + \text{He}$	Ionization	2.00 keV	Ex	592
$e + \text{He}$	Ionization	10.00 Threshold	Th	559
$e + \text{He}$	Ionization	0.02-1.00 keV	Th	521
$e + \text{He}$	Ionization	0.10-1.00 K	Th	515
$e + \text{He}$	Ionization	600.00 eV	Ex	511
$e + \text{He}$	Ionization	200.00 eV	Th	510
$e + \text{He}$	Ionization	601.00 eV	Ex	509
$e + \text{He}$	Ionization	100.00-400.00 eV	Ex	493
$e + \text{He}$	Ionization	2.00 keV	Th	472
$e + \text{He}$	Ionization	0.1-5 keV; 0.30-2.00 MeV	Th	463
$e + \text{He}$	Ionization	0.60-1.58 keV	Th	460
$e + \text{He}$	Ionization	2.00-8.00 a.u.	Th	446
$e + \text{He}$	Ionization	0.50-10.00 keV	E/T	445
$e + \text{He}$	Ionization	1.10 keV	Ex	422
$e + \text{He}$	Ionization	5.60 keV	Th	418
$e + \text{He}$	Ionization	100.00-400.00 eV	Th	414
$e + \text{He}$	Ionization	25.00 eV	Th	395
$e + \text{He}^{1+}$	Recombination	0.10-1.00 K	Th	515
$e + \text{He}^{1+}$	Excitation	0.01-5.00 keV	Th	586
$e + \text{He}^{1+}$	Excitation	40.00-42.00 eV	E/T	467
$e + \text{He}^{1+}$	Excitation	50.00-175.00 eV	Th	458
$e + \text{He}^{1+}$	Ionization	5.00-500.00 eV	Th	665
$e + \text{He}^{1+}$	Ionization	0.40-10.00 keV	Th	652
$e + \text{He}^{1+}$	Ionization	0.10-1.00 K	Th	515
$e + \text{He}^{1+}$	Ionization	50.00-175.00 eV	Th	458
$e + \text{He}^{1+}$	Ionization	50.00-900.00 eV	Th	371
$e + \text{He}^{2+}$	Recombination	0.10-1.00 K	Th	515
$e + \text{He}^{2+}$	Ionization	0.10-1.00 K	Th	515
$e + \text{Li}$	Recombination	0.10-1.00 K	Th	515
$e + \text{Li}$	Excitation	25.00 eV	Th	561
$e + \text{Li}$	Excitation	5.00 keV	Th	560
$e + \text{Li}$	Ionization	0.10-1.00 K	Th	515
$e + \text{Li}^{1+}$	Angular Scattering	5.60 keV	Th	418
$e + \text{Li}^{1+}$	Recombination	100.00 K	E/T	563
$e + \text{Li}^{1+}$	Recombination	0.10-1.00 K	Th	515
$e + \text{Li}^{1+}$	Ionization	10.00 Threshold	Th	559
$e + \text{Li}^{1+}$	Ionization	0.10-1.00 K	Th	515
$e + \text{Li}^{1+}$	Ionization	0.50-10.00 keV	E/T	445
$e + \text{Li}^{1+}$	Ionization	5.60 keV	Th	418
$e + \text{Li}^{2+}$	Recombination	0.10-1.00 K	Th	515
$e + \text{Li}^{2+}$	Ionization	5.00-500.00 eV	Th	665
$e + \text{Li}^{2+}$	Ionization	0.40-10.00 keV	Th	652
$e + \text{Li}^{2+}$	Ionization	0.10-1.00 K	Th	515
$e + \text{Li}^{3+}$	Recombination	0.10-1.00 K	Th	515
$e + \text{Li}^{3+}$	Ionization	0.10-1.00 K	Th	515
$e + \text{Be}$	Excitation	5.00 keV	Th	560
$e + \text{Be}^{2+}$	Ionization	0.50-10.00 keV	E/T	445
$e + \text{Be}^{2+}$	Ionization	0.50-10.00 keV	E/T	445
$e + \text{Be}^{3+}$	Ionization	0.40-10.00 keV	Th	652
$e + \text{B}$	Ionization	0.01-4.00 keV	E/T	577

$e + B^{3+}$	Ionization	10.00 Threshold	Th	559
$e + B^{3+}$	Ionization	0.50-10.00 keV	E/T	445
$e + B^{4+}$	Ionization	0.40-10.00 keV	Th	652
$e + BO^{-1+}$	Dissociation	40.00 eV	Ex	378
$e + BO^{-1+}$	Detachment	40.00 eV	Ex	378
$e + BO^{-1+}$	Ionization	40.00 eV	Ex	378
$e + C$	Angular Scattering	25.00-40.00 eV	Th	373
$e + C$	Excitation	25.00-40.00 eV	Th	373
$e + C^{1+}$	Ionization	0.05-10.00 keV	Ex	648
$e + C^{2+}$	Excitation	12.00-21.00 eV	Ex	647
$e + C^{3+}$	Recombination	100.00 K	Th	590
$e + C^{3+}$	Recombination	8.00 eV	Ex	366
$e + C^{3+}$	Excitation	6.00-13.00 eV	Ex	646
$e + C^{3+}$	Ionization	0.05-1.00 keV	Th	671
$e + C^{4+*}$	De-excitation	0.50-1.10 MeV/amu	E/T	604
$e + C^{4+}$	De-excitation	0.50-1.10 MeV/amu	E/T	604
$e + C^{4+*}$	Angular Scattering	0.50-1.10 MeV/amu	E/T	604
$e + C^{4+}$	Angular Scattering	0.50-1.10 MeV/amu	E/T	604
$e + C^{4+}$	Ionization	0.40-7.00 keV	Th	630
$e + C^{4+}$	Ionization	10.00 Threshold	Th	559
$e + C^{4+}$	Ionization	0.50-10.00 keV	E/T	445
$e + C^{5+}$	Ionization	0.40-10.00 keV	Th	652
$e + C^{6+}$	Elastic Scattering	0.55-3.00 keV	Th	662
$e + CH$	Elastic Scattering	0.01-2.00 keV	Th	448
$e + CH$	Elastic Scattering	10.00 eV	Th	421
$e + CH$	Excitation	0.01-2.00 keV	Th	448
$e + CH$	Excitation	10.00 eV	Th	421
$e + CH$	Ionization	0.01-2.00 keV	Th	448
$e + CH_2$	Elastic Scattering	0.01-2.00 keV	Th	448
$e + CH_2$	Excitation	0.01-2.00 keV	Th	448
$e + CH_2$	Ionization	0.01-2.00 keV	Th	448
$e + CH_3$	Elastic Scattering	0.01-2.00 keV	Th	448
$e + CH_3$	Excitation	0.01-2.00 keV	Th	448
$e + CH_3$	Ionization	0.01-2.00 keV	Th	448
$e + CH_4$	Dissociation		Th	517
$e + CH_4$	Elastic Scattering	0.50-20.00 eV	Th	468
$e + CH_4$	Elastic Scattering	0.01-2.00 keV	Th	448
$e + CH_4$	Angular Scattering	0.50-20.00 eV	Th	468
$e + CH_4$	Excitation	15.00 eV	E/T	453
$e + CH_4$	Excitation	0.01-2.00 keV	Th	448
$e + CH_4$	Ionization	0.01-1.00 keV	Th	571
$e + CH_4$	Ionization		Th	517
$e + CH_4$	Ionization	0.01-2.00 keV	Th	448
$e + CH_4^{1+}$	Dissociation	0.10-30.00 eV	Th	683
$e + CH_4^{1+}$	Recombination	0.10-30.00 eV	Th	683
$e + CO$	Dissociation	2.00 keV	Ex	456
$e + CO$	Elastic Scattering	0.50-2.00 keV	Th	533
$e + CO$	Angular Scattering	0.50-2.00 keV	Th	533
$e + CO$	Angular Scattering	10.00-15.00 eV	Ex	432
$e + CO$	Angular Scattering	297.00-900.00 eV	Th	403
$e + CO$	Excitation	10.00-15.00 eV	Ex	432
$e + CO$	Excitation	297.00-900.00 eV	Th	403
$e + CO$	Ionization	2.00 keV	Ex	456
$e + CO_2$	Elastic Scattering	1.00 eV	Th	566
$e + CO_2$	Elastic Scattering	1.00 eV	Th	565
$e + CO_2$	Elastic Scattering	1.50-30.00 eV	Ex	404
$e + CO_2$	Elastic Scattering	0.01-100.00 eV	Th	399

$e + \text{CO}_2$	Angular Scattering	1.50-30.00 eV	Ex	404
$e + \text{CO}_2$	Angular Scattering	0.01-100.00 eV	Th	399
$e + \text{CO}_2$	Excitation	8.00 eV	Th	593
$e + \text{CO}_2$	Excitation	1.00 eV	Th	566
$e + \text{CO}_2$	Excitation	20.00-200.00 eV	Ex	498
$e + \text{CO}_2$	Excitation	1.50-30.00 eV	Ex	404
$e + \text{CO}_2$	Ionization	0.01-1.00 keV	Th	571
$e + \text{CO}_2^{1+}$	Dissociation	2.50 keV	Ex	402
$e + \text{CO}_2^{1+}$	Ionization	5.00 keV	Th	512
$e + \text{CO}_2^{1+}$	Ionization	2.50 keV	Ex	402
$e + \text{C}_2\text{H}_2^{1+}$	Dissociation	50.00 eV	Ex	578
$e + \text{C}_2\text{HCl}_3$	Ionization	220.00 eV	Ex	419
$e + \text{C}_2\text{HCl}_5$	Ionization	220.00 eV	Ex	419
$e + \text{C}_2\text{H}_2\text{Cl}_2$	Ionization	220.00 eV	Ex	419
$e + \text{C}_2\text{H}_2\text{Cl}_4$	Ionization	220.00 eV	Ex	419
$e + \text{C}_2\text{H}_3\text{Cl}_3$	Ionization	220.00 eV	Ex	419
$e + \text{C}_2\text{H}_4\text{Cl}_2$	Ionization	220.00 eV	Ex	419
$e + \text{C}_2\text{H}_5\text{Cl}$	Ionization	220.00 eV	Ex	419
$e + \text{C}_3\text{H}_7\text{Cl}$	Ionization	220.00 eV	Ex	419
$e + \text{C}_4\text{H}_9\text{Cl}$	Ionization	220.00 eV	Ex	419
$e + \text{CN}^{-1+}$	Dissociation	40.00 eV	Ex	378
$e + \text{CN}^{-1+}$	Detachment	60.00 eV	Ex	638
$e + \text{CN}^{-1+}$	Detachment	40.00 eV	Ex	378
$e + \text{CN}^{-1+}$	Ionization	40.00 eV	Ex	378
$e + \text{C}_2\text{H}_3\text{F}_2$	Excitation	4.20 eV	Ex	497
$e + \text{C}_2\text{Cl}_2$	Ionization	220.00 eV	Ex	419
$e + \text{C}_2\text{Cl}_4$	Ionization	220.00 eV	Ex	419
$e + \text{C}_2\text{Cl}_6$	Ionization	220.00 eV	Ex	419
$e + \text{C}_2\text{Cl}_6$	Ionization	220.00 eV	Ex	419
$e + \text{CF}_2$	Elastic Scattering	0.10-10.00 eV	Th	482
$e + \text{CF}_2$	Excitation	0.10-10.00 eV	Th	482
$e + \text{N}^{2+}$	Recombination	1.00-20.00 kK	Th	365
$e + \text{N}^{3+}$	Excitation	12.00-21.00 eV	Ex	647
$e + \text{N}^{4+}$	Recombination	1.60 eV	E/T	573
$e + \text{N}^{5+}$	Ionization	0.40-7.00 keV	Th	630
$e + \text{N}^{5+}$	Ionization	10.00 Threshold	Th	559
$e + \text{N}^{5+}$	Ionization	0.50-10.00 keV	E/T	445
$e + \text{N}^{6+}$	Ionization	0.40-10.00 keV	Th	652
$e + \text{N}_2$	Dissociation	80.00-150.00 eV	Ex	444
$e + \text{N}_2$	Elastic Scattering	0.50-2.00 keV	Th	533
$e + \text{N}_2$	Angular Scattering	0.50-2.00 keV	Th	533
$e + \text{N}_2$	Angular Scattering	15.00-50.00 eV	E/T	390
$e + \text{N}_2^*$	Angular Scattering	15.00-50.00 eV	E/T	390
$e + \text{N}_2$	Excitation	80.00-150.00 eV	Ex	444
$e + \text{N}_2$	Excitation	15.00-50.00 eV	E/T	390
$e + \text{N}_2^*$	Excitation	15.00-50.00 eV	E/T	390
$e + \text{N}_2$	Ionization	0.01-1.00 keV	Th	571
$e + \text{N}_2^{1+}$	Dissociation	2.50 keV	Ex	417
$e + \text{N}_2^{1+}$	Ionization	5.00 keV	Th	512
$e + \text{N}_2^{1+}$	Ionization	2.50 keV	Ex	417
$e + \text{NH}$	Elastic Scattering	0.01-2.00 keV	Th	448
$e + \text{NH}$	Excitation	0.01-2.00 keV	Th	448
$e + \text{NH}$	Ionization	0.01-2.00 keV	Th	448
$e + \text{NH}_2$	Elastic Scattering	0.01-2.00 keV	Th	448
$e + \text{NH}_2$	Excitation	0.01-2.00 keV	Th	448
$e + \text{NH}_2$	Ionization	0.01-2.00 keV	Th	448
$e + \text{NH}_3$	Elastic Scattering	0.01-2.00 keV	Th	448

$e + \text{NH}_3$	Excitation	0.01-2.00 keV	Th	448
$e + \text{NH}_3$	Ionization	0.01-2.00 keV	Th	448
$e + \text{NH}_3$	Ionization	1.00 keV	Ex	380
$e + \text{NO}$	Excitation	10.00-740.00 eV	Ex	602
$e + \text{NO}^{1+}$	Attachment	8.00-18.00 eV	Ex	547
$e + \text{NO}^{1+}$	Recombination	8.00-18.00 eV	Ex	547
$e + \text{N}_2\text{O}$	Elastic Scattering	20.00-800.00 eV	E/T	620
$e + \text{N}_2\text{O}$	Angular Scattering	20.00-800.00 eV	E/T	620
$e + \text{N}_2\text{O}$	Total Scattering	20.00-800.00 eV	E/T	620
$e + \text{NO}_2$	Elastic Scattering	1.00-20.00 eV	Th	450
$e + \text{NO}_2$	Ionization	200.00 eV	Ex	384
$e + \text{O}$	Elastic Scattering	2.00-30.00 eV	Th	393
$e + \text{O}^*$	Elastic Scattering	2.00-30.00 eV	Th	393
$e + \text{O}$	Angular Scattering	30.00-100.00 eV	E/T	411
$e + \text{O}$	Fluorescence	0.01-1.00 keV	Ex	412
$e + \text{O}$	Excitation	10.00-100.00 eV	Th	489
$e + \text{O}$	Excitation	0.01-1.00 keV	Ex	412
$e + \text{O}$	Excitation	30.00-100.00 eV	E/T	411
$e + \text{O}$	Excitation	2.00-30.00 eV	Th	393
$e + \text{O}^*$	Excitation	2.00-30.00 eV	Th	393
$e + \text{O}^{1+}$	Ionization	0.05-10.00 keV	Ex	648
$e + \text{O}^{2+}$	Excitation	1.80-5.35 eV	Ex	369
$e + \text{O}^{2+}$	Ionization	0.05-10.00 keV	Ex	648
$e + \text{O}^{3+}$	Ionization	0.05-10.00 keV	Ex	648
$e + \text{O}^{4+}$	Excitation	12.00-21.00 eV	Ex	647
$e + \text{O}^{4+}$	Ionization	0.05-10.00 keV	Ex	648
$e + \text{O}^{5+}$	Recombination		Ex	673
$e + \text{O}^{5+}$	Recombination	2.00-12.00 eV	E/T	617
$e + \text{O}^{5+}$	Ionization	400.00-750.00 eV	Ex	677
$e + \text{O}^{6+*}$	De-excitation	0.50-1.10 MeV/amu	E/T	604
$e + \text{O}^{6+}$	De-excitation	0.50-1.10 MeV/amu	E/T	604
$e + \text{O}^{6+*}$	Angular Scattering	0.50-1.10 MeV/amu	E/T	604
$e + \text{O}^{6+}$	Angular Scattering	0.50-1.10 MeV/amu	E/T	604
$e + \text{O}^{6+}$	Recombination	10.00 eV	E/T	575
$e + \text{O}^{6+}$	Ionization	0.40-7.00 keV	Th	630
$e + \text{O}^{7+}$	Excitation	0.58-1.16 keV	Th	486
$e + \text{O}^{7+}$	Ionization	0.40-10.00 keV	Th	652
$e + \text{O}_2$	Elastic Scattering	0.30-1.00 keV	Th	534
$e + \text{O}_2$	Angular Scattering	100.00 eV	Ex	543
$e + \text{O}_2$	Angular Scattering	0.30-1.00 keV	Th	534
$e + \text{O}_2$	Angular Scattering	20.00-100.00 eV	Ex	420
$e + \text{O}_2$	Excitation	9.00-20.00 eV	Ex	459
$e + \text{O}_2$	Excitation	20.00-100.00 eV	Ex	420
$e + \text{O}_2$	Ionization	100.00 eV	Ex	543
$e + \text{O}_2$	Ionization	20.00-100.00 eV	Ex	420
$e + \text{O}_2^{1+}$	Dissociation	0.00-3.00 eV	Ex	376
$e + \text{O}_2^{1+}$	Recombination	0.00-3.00 eV	Ex	376
$e + \text{O}_2^{1+}$	Excitation	0.00-3.00 eV	Ex	376
$e + \text{O}_3$	Dissociation	0.35-5.00 keV	E/T	505
$e + \text{O}_3$	Elastic Scattering	0.35-5.00 keV	E/T	505
$e + \text{O}_3$	Angular Scattering	0.35-5.00 keV	E/T	505
$e + \text{O}_3$	Excitation	0.35-5.00 keV	E/T	505
$e + \text{O}_3$	Ionization	0.35-5.00 keV	E/T	505
$e + \text{F}^{4+}$	Elastic Scattering	0.55-3.00 keV	Th	662
$e + \text{F}^{6+}$	Recombination	15.00 eV	Ex	653
$e + \text{F}^{7+}$	De-excitation	0.80-4.00 keV	Ex	628
$e + \text{F}^{7+*}$	De-excitation	0.50-1.10 MeV/amu	E/T	604

$e + F^{7+}$	De-excitation	0.50-1.10 MeV/amu	E/T	604
$e + F^{7+*}$	Angular Scattering	0.50-1.10 MeV/amu	E/T	604
$e + F^{7+}$	Angular Scattering	0.50-1.10 MeV/amu	E/T	604
$e + F^{8+}$	Ionization	0.40-10.00 keV	Th	652
$e + F^{9+}$	Elastic Scattering	0.55-3.00 keV	Th	662
$e + F_2^{-1+}$	Dissociation	27.00 eV	Ex	544
$e + F_2^{-1+}$	Detachment	27.00 eV	Ex	544
$e + Ne$	Bremsstrahlung	5.00-40.00 K	Th	555
$e + Ne$	Elastic Scattering	0.50-10.00 keV	Th	635
$e + Ne$	Elastic Scattering	0.01-3.00 keV	Th	535
$e + Ne^*$	Elastic Scattering	0.01-3.00 keV	Th	535
$e + Ne$	Angular Scattering	20.00-100.00 eV	Ex	623
$e + Ne$	Angular Scattering	2.70 keV	Th	570
$e + Ne$	Total Scattering	0.01-3.00 keV	Th	535
$e + Ne^*$	Total Scattering	0.01-3.00 keV	Th	535
$e + Ne$	Excitation	0.50-10.00 keV	Th	635
$e + Ne$	Excitation	20.00-100.00 eV	Ex	623
$e + Ne$	Excitation	10.00-180.00 eV	Ex	619
$e + Ne$	Excitation	225.00 eV	Th	591
$e + Ne$	Excitation	450.00 eV	Ex	558
$e + Ne^*$	Excitation	450.00 eV	Ex	558
$e + Ne$	Excitation	8.00-16.00 eV	Th	538
$e + Ne$	Ionization	0.50-10.00 keV	Th	635
$e + Ne$	Ionization	1.00 keV	Ex	605
$e + Ne$	Ionization	2.70 keV	Th	570
$e + Ne$	Ionization	0.01-3.00 keV	Th	535
$e + Ne^*$	Ionization	0.01-3.00 keV	Th	535
$e + Ne$	Ionization	0.02-1.00 keV	Th	521
$e + Ne$	Ionization	1.00 keV	Ex	484
$e + Ne$	Ionization	0.1-5 keV; 0.30-2.00 MeV	Th	463
$e + Ne^{1+}$	Excitation	60.00 eV	Th	441
$e + Ne^{2+}$	Excitation	0.00-1.00 K	Th	494
$e + Ne^{5+}$	Excitation	15.00 Ry	Th	442
$e + Ne^{7+}$	Recombination		Ex	673
$e + Ne^{7+}$	Recombination	18.00 eV	Ex	557
$e + Ne^{7+}$	Ionization	10.00-80.00 a.u.	Th	401
$e + Ne^{8+}$	Ionization	0.40-7.00 keV	Th	630
$e + Ne^{9+}$	Ionization	0.40-10.00 keV	Th	652
$e + Ne^{10+}$	Recombination	0.06-37.00 keV	Th	661
$e + Ne^{10+}$	Recombination	0.00-10.00 eV	Th	469
$e + Na$	Angular Scattering	64.00-151.00 eV	Ex	567
$e + Na$	Excitation	0.05-1.00 keV	Th	633
$e + Na$	Excitation	5.00 keV	Th	560
$e + Na$	Ionization	0.05-1.00 keV	Th	633
$e + Na$	Ionization	64.00-151.00 eV	Ex	567
$e + Na^{9+}$	Ionization	10.00 Threshold	Th	559
$e + Mg^*$	Attachment	0.20-2.00 eV	Ex	530
$e + Mg$	Attachment	0.20-2.00 eV	Ex	530
$e + Mg$	Elastic Scattering	10.00-100.00 eV	Th	641
$e + Mg$	Angular Scattering	10.00-100.00 eV	Th	641
$e + Mg$	Angular Scattering	0.40-1.50 keV	E/T	514
$e + Mg$	Angular Scattering	0.40-1.50 keV	Th	488
$e + Mg$	Excitation	5.00 keV	Th	560
$e + Mg$	Excitation	1.00 keV	Th	541
$e + Mg$	Excitation	20.00-40.00 eV	Ex	406
$e + Mg$	Ionization	0.40-1.50 keV	E/T	514
$e + Mg$	Ionization	0.40-1.50 keV	Th	488

$e + \text{Mg}^{1+}$	Recombination	100.00 K	Th	590
$e + \text{Mg}^{1+}$	Excitation	0.01-5.00 keV	Th	586
$e + \text{Al}$	Elastic Scattering	0.00-1.00 GeV	Th	519
$e + \text{Al}$	Ionization	0.01-4.00 keV	E/T	577
$e + \text{Al}^{3+}$	Ionization	5.50 keV	E/T	438
$e + \text{Al}^{4+}$	Ionization	5.50 keV	E/T	438
$e + \text{Al}^{5+}$	Ionization	5.50 keV	E/T	438
$e + \text{Al}^{6+}$	Ionization	5.50 keV	E/T	438
$e + \text{Al}^{7+}$	Ionization	5.50 keV	E/T	438
$e + \text{Al}^{12+}$	Excitation	0.01-10.00 K	Th	632
$e + \text{Si}$	Angular Scattering	25.00-40.00 eV	Th	373
$e + \text{Si}$	Excitation	25.00-40.00 eV	Th	373
$e + \text{Si}^{11+}$	Recombination	35.00 eV	Ex	655
$e + \text{S}$	Angular Scattering	0.25-3.50 Ry	Th	428
$e + \text{S}$	Excitation	0.50-5.00 Ry	Th	490
$e + \text{S}$	Excitation	0.25-3.50 Ry	Th	428
$e + \text{SH}$	Elastic Scattering	10.00 eV	Th	496
$e + \text{SH}$	Excitation	10.00 eV	Th	496
$e + \text{Cl}^{5+}$	Excitation	14.00-180.00 eV	E/T	615
$e + \text{Cl}^{5+}$	Ionization	14.00-180.00 eV	E/T	615
$e + \text{Cl}^{6+}$	Excitation	14.00-180.00 eV	E/T	615
$e + \text{Cl}^{6+}$	Ionization	14.00-180.00 eV	E/T	615
$e + \text{Cl}^{14+}$	Recombination	35.00 eV	Ex	655
$e + \text{Cl}^{14+}$	Recombination	170.00 eV	Ex	643
$e + \text{Cl}^{17+}$	Recombination	0.00-0.01 eV	Ex	675
$e + \text{Cl}_2\text{O}$	Elastic Scattering	100.00 eV	Th	415
$e + \text{Cl}_2\text{O}$	Excitation	100.00 eV	Th	415
$e + \text{Cl}_2\text{O}$	Ionization	8.00-20.00 eV	E/T	499
$e + \text{Ar}$	Bremsstrahlung	5.00-40.00 K	Th	581
$e + \text{Ar}$	Bremsstrahlung	5.00-40.00 K	Th	555
$e + \text{Ar}$	Bremsstrahlung	5.00-50.00 keV	E/T	479
$e + \text{Ar}$	Elastic Scattering	0.50-10.00 keV	Th	635
$e + \text{Ar}$	Elastic Scattering	3.00-160.00 eV	Th	464
$e + \text{Ar}$	Angular Scattering	64.60 eV	Th	603
$e + \text{Ar}$	Angular Scattering	113.50 eV	E/T	574
$e + \text{Ar}$	Angular Scattering	601.00 eV	Ex	509
$e + \text{Ar}$	Angular Scattering	561.40 eV	Ex	476
$e + \text{Ar}^*$	Angular Scattering	11.50-14.00 eV	Th	470
$e + \text{Ar}$	Angular Scattering	11.50-14.00 eV	Th	470
$e + \text{Ar}$	Angular Scattering	3.00-160.00 eV	Th	464
$e + \text{Ar}$	Excitation	0.50-10.00 keV	Th	635
$e + \text{Ar}$	Excitation	120.00 eV	Th	600
$e + \text{Ar}^*$	Excitation	120.00 eV	Th	600
$e + \text{Ar}$	Excitation	225.00 eV	Th	591
$e + \text{Ar}$	Excitation	8.00-16.00 eV	Th	538
$e + \text{Ar}^*$	Excitation	11.50-14.00 eV	Th	470
$e + \text{Ar}$	Excitation	11.50-14.00 eV	Th	470
$e + \text{Ar}$	Ionization	0.50-10.00 keV	Th	635
$e + \text{Ar}$	Ionization	1.00 keV	Ex	605
$e + \text{Ar}$	Ionization	64.60 eV	Th	603
$e + \text{Ar}$	Ionization	113.50 eV	E/T	574
$e + \text{Ar}$	Ionization	0.02-1.00 keV	Th	521
$e + \text{Ar}$	Ionization	601.00 eV	Ex	509
$e + \text{Ar}$	Ionization	2.00-113.50 eV	Th	495
$e + \text{Ar}$	Ionization	1.00 keV	Ex	484
$e + \text{Ar}$	Ionization	561.40 eV	Ex	476
$e + \text{Ar}$	Ionization	37.00-129.00 eV	Ex	457

e + Ar²⁺	Elastic Scattering	16.00 eV	Ex	669
e + Ar²⁺	Elastic Scattering	16.00 eV	Ex	644
e + Ar²⁺	Angular Scattering	16.00 eV	Ex	669
e + Ar³⁺	Elastic Scattering	16.00 eV	Ex	644
e + Ar⁷⁺	Elastic Scattering	100.00 eV	Ex	668
e + Ar⁷⁺	Elastic Scattering	100.00 eV	Ex	645
e + Ar⁷⁺	Angular Scattering	100.00 eV	Ex	668
e + Ar⁸⁺	Elastic Scattering	100.00 eV	Ex	668
e + Ar⁸⁺	Angular Scattering	100.00 eV	Ex	668
e + Ar¹¹⁺	De-excitation	0.20-3.00 keV	E/T	391
e + Ar¹¹⁺	Line Broadening	0.20-3.00 keV	E/T	391
e + Ar¹¹⁺	Excitation	0.20-3.00 keV	E/T	391
e + Ar¹²⁺	De-excitation	0.20-3.00 keV	E/T	391
e + Ar¹²⁺	Line Broadening	0.20-3.00 keV	E/T	391
e + Ar¹²⁺	Excitation	0.20-3.00 keV	E/T	391
e + Ar¹³⁺	De-excitation	0.20-3.00 keV	E/T	391
e + Ar¹³⁺	Line Broadening	0.20-3.00 keV	E/T	391
e + Ar¹³⁺	Excitation	0.20-3.00 keV	E/T	391
e + Ar¹⁴⁺	De-excitation	0.20-3.00 keV	E/T	391
e + Ar¹⁴⁺	Line Broadening	0.20-3.00 keV	E/T	391
e + Ar¹⁴⁺	Excitation	0.20-3.00 keV	E/T	391
e + Ar¹⁵⁺	De-excitation	2.24-4.10 keV	E/T	435
e + Ar¹⁵⁺	De-excitation	0.20-3.00 keV	E/T	391
e + Ar¹⁵⁺	Line Broadening	0.20-3.00 keV	E/T	391
e + Ar¹⁵⁺	Recombination	2.24-4.10 keV	E/T	435
e + Ar¹⁵⁺	Excitation	2.24-4.10 keV	E/T	435
e + Ar¹⁵⁺	Excitation	0.20-3.00 keV	E/T	391
e + Ar¹⁶⁺	Ionization	30.00 keV	Ex	650
e + Ar¹⁷⁺	Ionization	30.00 keV	Ex	650
e + K	Elastic Scattering	4.00-80.00 eV	E/T	389
e + K*	Elastic Scattering	4.00-80.00 eV	E/T	389
e + K	Angular Scattering	4.00-80.00 eV	E/T	389
e + K*	Angular Scattering	4.00-80.00 eV	E/T	389
e + K	Excitation	5.00 keV	Th	560
e + Ca	Excitation	5.00 keV	Th	560
e + Ca¹⁴⁺	Excitation	50.00-300.00 Ry	Th	640
e + Sc	Ionization	50.00 keV	E/T	522
e + Sc	Ionization	1-7 E/E_1s	E/T	427
e + Sc³⁺	Recombination	170.00 eV	Ex	643
e + Sc³⁺	Recombination	45.00 eV	E/T	610
e + Sc¹⁸⁺	Recombination	50.00 eV	Ex	670
e + Ti	Ionization	50.00 keV	E/T	522
e + Ti²⁺	Excitation	9.00-10.00 eV	Ex	598
e + Ti⁴⁺	Recombination	0.00-1.00 eV	Ex	657
e + Ti¹¹⁺	Ionization	300.00-800.00 eV	Th	503
e + Ti¹⁹⁺	Recombination		Ex	672
e + V	Ionization	50.00 keV	E/T	522
e + V	Ionization	1-7 E/E_1s	E/T	427
e + Cr	Ionization	50.00 keV	E/T	522
e + Cr	Ionization	1-7 E/E_1s	E/T	427
e + Cr¹³⁺	Ionization	0.40-1.10 keV	Th	594
e + Cr¹⁴⁺	Excitation	1.00-4.00 keV	Ex	545
e + Cr²¹⁺	Recombination	20.00 keV	Th	409
e + Cr²¹⁺	Ionization	20.00 keV	Th	409
e + Cr²²⁺	Recombination	20.00 keV	Th	409
e + Mn	Excitation	12.00-200.00 eV	Ex	525
e + Mn	Ionization	12.00-200.00 eV	Ex	525

e + Mn	Ionization	50.00 keV	E/T	522
e + Mn	Ionization	6.50-40.00 keV	Ex	507
e + Mn¹⁵⁺	Excitation	1.00-4.00 keV	Ex	545
e + Fe	Ionization	50.00 keV	E/T	522
e + Fe	Ionization	6.50-40.00 keV	Ex	507
e + Fe¹⁺	Excitation	0.00-10.00 K	Th	642
e + Fe²⁺	Excitation	2x10 ³ -2x10 ⁶ K	Th	492
e + Fe¹⁴⁺	Excitation	0.10-10.00 K	Th	471
e + Fe¹⁶⁺	Excitation	1.00-4.00 keV	Ex	545
e + Fe¹⁶⁺	Excitation	450.00 Ry	Th	367
e + Fe¹⁷⁺	Recombination	120.00 eV	Ex	666
e + Fe¹⁷⁺	Recombination	0.10-135.00 eV	Th	621
e + Fe¹⁷⁺	Recombination	100.00 eV	Th	562
e + Fe¹⁷⁺	Recombination	100.00 eV	Th	562
e + Fe¹⁸⁺	Recombination	120.00 eV	Ex	666
e + Fe¹⁸⁺	Recombination	0.00-1.00 keV	E/T	370
e + Fe¹⁸⁺	Excitation	1.00 Ry	Th	443
e + Fe¹⁸⁺	Excitation	300.00 Ry	Th	364
e + Fe¹⁹⁺	Recombination	120.00 eV	Ex	666
e + Fe¹⁹⁺	Excitation	0.10-100.00 K	Th	407
e + Fe¹⁹⁺	Excitation	290.00 Ry	Th	363
e + Fe²⁰⁺	Recombination	120.00 eV	Ex	666
e + Fe²⁰⁺	Excitation	8x10 ⁴ -8x10 ⁷ K	Th	452
e + Fe²⁰⁺	Excitation	3.00 keV	E/T	368
e + Fe²¹⁺	Recombination	120.00 eV	Ex	666
e + Fe²¹⁺	Excitation	0.10-10.00 K	Th	636
e + Fe²¹⁺	Excitation	30.00 Ry	Th	447
e + Fe²¹⁺	Excitation	3.00 keV	E/T	368
e + Fe²²⁺	Excitation	0.05-1.00 Ry	Th	537
e + Fe²²⁺	Excitation	138.00-800.00 Ry	Th	425
e + Fe²²⁺	Excitation	3.00 keV	E/T	368
e + Fe²³⁺	Excitation	138.00-800.00 Ry	Th	425
e + Fe²³⁺	Excitation	3.00 keV	E/T	368
e + Fe²⁴⁺	Recombination	4.50-8.00 keV	Ex	449
e + Fe²⁴⁺	Excitation	10 ^{5.5} -10 ⁹ K	Th	423
e + Fe²⁴⁺	Ionization	0.50-2.00 keV	Th	596
e + Fe²⁴⁺	Ionization	10.00 Threshold	Th	559
e + Fe²⁵⁺	Excitation	0.70-3.00 keV	Ex	656
e + Fe²⁵⁺	Excitation	10 ⁶ -10 ^{8.5} K	Th	475
e + Fe²⁵⁺	Ionization	10.00-50.00 keV	E/T	436
e + Co	Ionization	50.00 keV	E/T	522
e + Co¹⁷⁺	Excitation	1.00-4.00 keV	Ex	545
e + Ni	Ionization	50.00 keV	E/T	522
e + Ni	Ionization	1-7 E/E _{1s}	E/T	427
e + Ni²⁺	Excitation	5.00-60.00 K	Th	362
e + Ni⁴⁺	Excitation	0.00-10.00 K	Th	642
e + Ni¹⁰⁺	Ionization	0.20-5.00 keV	Ex	664
e + Ni¹¹⁺	Ionization	0.20-5.00 keV	Ex	664
e + Ni¹²⁺	Ionization	0.20-5.00 keV	Ex	651
e + Ni¹³⁺	Ionization	0.20-5.00 keV	Ex	664
e + Ni¹⁴⁺	Ionization	0.20-5.00 keV	Ex	651
e + Ni¹⁵⁺	Ionization	0.20-5.00 keV	Ex	664
e + Ni¹⁸⁺	Excitation	1.00-4.00 keV	Ex	545
e + Ni²⁵⁺	Recombination		Ex	672
e + Cu	Ionization	50.00 keV	E/T	522
e + Cu	Ionization	1-7 E/E _{1s}	E/T	427
e + Cu¹⁹⁺	Excitation	140.00 eV	Th	637

$e + \text{Cu}^{19+}$	Excitation	1.00-4.00 keV	Ex	545
$e + \text{Zn}$	Elastic Scattering	10.00-40.00 eV	Th	536
$e + \text{Zn}$	Angular Scattering	10.00-40.00 eV	Th	536
$e + \text{Zn}$	Excitation	17.00-23.00 eV	Ex	434
$e + \text{Zn}$	Ionization	17.00-23.00 eV	Ex	434
$e + \text{Zn}^{1+}$	Excitation	0.01-5.00 keV	Th	586
$e + \text{Zn}^{1+}$	Excitation	5.00-200.00 eV	Ex	524
$e + \text{Zn}^{21+}$	Excitation	1.00-4.00 keV	Ex	545
$e + \text{Zn}^{27+}$	Recombination	100.00 K	Th	590
$e + \text{Zn}^{27+}$	Recombination	$E \text{ inf } \hbar W_c$	Th	491
$e + \text{Ga}$	Ionization	0.01-4.00 keV	E/T	577
$e + \text{Ga}$	Ionization	12.00-34.00 keV	Ex	504
$e + \text{Ga}^{1+}$	Ionization	0.01-2.00 keV	Ex	649
$e + \text{Ga}^{1+}$	Ionization	5.50 keV	Th	542
$e + \text{Ga}^{2+}$	Ionization	5.50 keV	Th	542
$e + \text{Ga}^{3+}$	Ionization	0.01-2.00 keV	Ex	649
$e + \text{Ga}^{3+}$	Ionization	5.50 keV	Th	542
$e + \text{Ga}^{4+}$	Ionization	5.50 keV	Th	542
$e + \text{Ga}^{5+}$	Ionization	5.50 keV	Th	542
$e + \text{Ga}^{6+}$	Ionization	5.50 keV	Th	542
$e + \text{Ga}^{7+}$	Ionization	5.50 keV	Th	542
$e + \text{Ga}^{8+}$	Ionization	5.50 keV	Th	542
$e + \text{Ga}^{9+}$	Ionization	5.50 keV	Th	542
$e + \text{Ge}$	Angular Scattering	25.00-40.00 eV	Th	373
$e + \text{Ge}$	Excitation	5.00-65.00 keV	E/T	375
$e + \text{Ge}$	Excitation	25.00-40.00 eV	Th	373
$e + \text{Ge}$	Ionization	12.00-34.00 keV	Ex	504
$e + \text{Ge}$	Ionization	5.00-65.00 keV	E/T	375
$e + \text{Ge}^{1+}$	Ionization	2.00-40.00 keV	Th	487
$e + \text{Se}$	Ionization	13.00-40.00 keV	Ex	546
$e + \text{Br}^{35+}$	Excitation	1.00-4.00 keV	Ex	545
$e + \text{Kr}$	Bremsstrahlung	5.00-40.00 K	Th	555
$e + \text{Kr}$	Bremsstrahlung	5.00-50.00 keV	E/T	479
$e + \text{Kr}$	Elastic Scattering	0.50-10.00 keV	Th	635
$e + \text{Kr}$	Excitation	0.50-10.00 keV	Th	635
$e + \text{Kr}^*$	Excitation	50.00 eV	Th	611
$e + \text{Kr}$	Excitation	50.00 eV	Th	611
$e + \text{Kr}$	Excitation	225.00 eV	Th	591
$e + \text{Kr}$	Excitation	10.00-50.00 eV	E/T	579
$e + \text{Kr}$	Excitation	8.00-16.00 eV	Th	538
$e + \text{Kr}$	Ionization	0.50-10.00 keV	Th	635
$e + \text{Kr}$	Ionization	1.00 keV	Ex	605
$e + \text{Kr}$	Ionization	0.02-1.00 keV	Th	521
$e + \text{Kr}$	Ionization	1.00 keV	Ex	484
$e + \text{Kr}$	Ionization	0.1-5 keV; 0.30-2.00 MeV	Th	463
$e + \text{Kr}^{12+}$	Ionization	5.50 keV	Ex	400
$e + \text{Kr}^{13+}$	Ionization	5.50 keV	Ex	400
$e + \text{Kr}^{14+}$	Ionization	5.00 keV	Ex	424
$e + \text{Kr}^{14+}$	Ionization	5.50 keV	Ex	400
$e + \text{Kr}^{15+}$	Ionization	5.00 keV	Ex	424
$e + \text{Kr}^{15+}$	Ionization	5.50 keV	Ex	400
$e + \text{Kr}^{16+}$	Ionization	5.00 keV	Ex	424
$e + \text{Kr}^{16+}$	Ionization	5.50 keV	Ex	400
$e + \text{Kr}^{17+}$	Ionization	5.00 keV	Ex	424
$e + \text{Kr}^{17+}$	Ionization	5.50 keV	Ex	400
$e + \text{Kr}^{18+}$	Ionization	5.50 keV	Ex	400
$e + \text{Kr}^{32+}$	Recombination	8.00-10.00 keV	Ex	654

$e + \text{Kr}^{33+}$	Recombination	3.00-14.00 eV	Ex	667
$e + \text{Kr}^{33+}$	Recombination	8.00-10.00 keV	Ex	654
$e + \text{Kr}^{34+}$	Recombination	8.00-10.00 keV	Ex	654
$e + \text{Kr}^{34+}$	Recombination	4.50-14.00 eV	E/T	589
$e + \text{Kr}^{36+}$	Excitation	1.00-4.00 keV	Ex	545
$e + \text{Rb}$	Elastic Scattering	0.00-3.00 eV	Th	554
$e + \text{Rb}$	Elastic Scattering	0.01-0.50 meV	Th	461
$e + \text{Rb}$	Angular Scattering	0.00-3.00 eV	Th	554
$e + \text{Rb}$	Total Scattering	0.00-3.00 eV	Th	554
$e + \text{Rb}$	Excitation	5.00 keV	Th	560
$e + \text{Rb}^*$	Ionization	40.00-300.00 eV	Ex	625
$e + \text{Rb}$	Ionization	40.00-300.00 eV	Ex	625
$e + \text{Sr}$	Excitation	5.00 keV	Th	560
$e + \text{Sr}$	Excitation	2.00-200.00 eV	Ex	528
$e + \text{Y}$	Ionization	13.00-40.00 keV	Ex	546
$e + \text{Zr}$	Ionization	12.00-34.00 keV	Ex	504
$e + \text{Ag}$	Bremsstrahlung	180.00-300.00 keV	Th	477
$e + \text{Ag}$	Ionization	300.00 keV	Th	599
$e + \text{Ag}$	Ionization	50.00 keV	E/T	522
$e + \text{Ag}^{45+}$	Ionization	10.00 Threshold	Th	559
$e + \text{Cd}$	Elastic Scattering	16.00 eV	Ex	485
$e + \text{Cd}$	Angular Scattering	150.00 eV	Th	607
$e + \text{Cd}$	Excitation	16.00 eV	Ex	485
$e + \text{Cd}$	Ionization	150.00 eV	Th	607
$e + \text{Cd}$	Ionization	16.00 eV	Ex	485
$e + \text{Cd}^{1+}$	Excitation	5.00-50.00 eV	Th	527
$e + \text{In}$	Ionization	4.00-50.00 keV	E/T	614
$e + \text{In}$	Ionization	0.01-4.00 keV	E/T	577
$e + \text{Sn}$	Angular Scattering	25.00-40.00 eV	Th	373
$e + \text{Sn}$	Excitation	5.00-65.00 keV	E/T	375
$e + \text{Sn}$	Excitation	25.00-40.00 eV	Th	373
$e + \text{Sn}$	Ionization	4.00-50.00 keV	E/T	614
$e + \text{Sn}$	Ionization	5.00-65.00 keV	E/T	375
$e + \text{Xe}$	Bremsstrahlung	5.00-40.00 K	Th	555
$e + \text{Xe}$	Bremsstrahlung	5.00-50.00 keV	E/T	479
$e + \text{Xe}$	Elastic Scattering	10.00 eV	Th	550
$e + \text{Xe}$	Angular Scattering	10.00 eV	Th	550
$e + \text{Xe}$	Angular Scattering	1.04 keV	Ex	480
$e + \text{Xe}$	Excitation	8.00-16.00 eV	Th	538
$e + \text{Xe}$	Excitation	10.00-250.00 eV	E/T	532
$e + \text{Xe}$	Excitation	1.04 keV	Ex	480
$e + \text{Xe}$	Excitation	5.00-6.00 keV	Ex	439
$e + \text{Xe}$	Excitation	10.00-100.00 eV	Ex	398
$e + \text{Xe}$	Ionization	1.00 keV	Ex	605
$e + \text{Xe}$	Ionization	150.00-350.00 eV	Ex	583
$e + \text{Xe}$	Ionization	0.02-1.00 keV	Th	521
$e + \text{Xe}$	Ionization	1.00 keV	Ex	484
$e + \text{Xe}$	Ionization	0.1-5 keV; 0.30-2.00 MeV	Th	463
$e + \text{Xe}$	Ionization	5.00-6.00 keV	Ex	439
$e + \text{Xe}^{2+}$	Elastic Scattering	16.00 eV	Ex	669
$e + \text{Xe}^{2+}$	Angular Scattering	16.00 eV	Ex	669
$e + \text{Cs}$	Elastic Scattering	0.00-3.00 eV	Th	554
$e + \text{Cs}$	Elastic Scattering	0.01-0.50 meV	Th	461
$e + \text{Cs}$	Angular Scattering	0.00-3.00 eV	Th	554
$e + \text{Cs}$	Total Scattering	0.00-3.00 eV	Th	554
$e + \text{Cs}$	Excitation	5.00 keV	Th	560
$e + \text{Cs}^{1+}$	Elastic Scattering	10.00 eV	Th	550

$e + \text{Cs}^{1+}$	Angular Scattering	10.00 eV	Th	550
$e + \text{Ba}^*$	De-excitation	7.00-16.00 eV	Ex	440
$e + \text{Ba}$	De-excitation	7.00-16.00 eV	Ex	440
$e + \text{Ba}$	Elastic Scattering	10.00-100.00 eV	Th	641
$e + \text{Ba}$	Angular Scattering	10.00-100.00 eV	Th	641
$e + \text{Ba}$	Excitation	100.00 eV	Th	595
$e + \text{Ba}^*$	Excitation	100.00 eV	Th	595
$e + \text{Ba}$	Excitation	5.00 keV	Th	560
$e + \text{Ba}$	Excitation	8.00-200.00 eV	Ex	523
$e + \text{Ba}$	Ionization	100.00 eV	Th	595
$e + \text{Ba}^*$	Ionization	100.00 eV	Th	595
$e + \text{Ba}$	Ionization	8.00-200.00 eV	Ex	523
$e + \text{Ba}^{2+}$	Elastic Scattering	10.00 eV	Th	550
$e + \text{Ba}^{2+}$	Angular Scattering	10.00 eV	Th	550
$e + \text{La}$	Excitation	7.00-200.00 eV	Ex	526
$e + \text{La}$	Ionization	7.00-200.00 eV	Ex	526
$e + \text{Ce}$	Ionization	4.00-900.00 eV	Ex	518
$e + \text{Nd}$	Ionization	4.00-900.00 eV	Ex	518
$e + \text{Sm}$	Ionization	4.00-900.00 eV	Ex	518
$e + \text{Sm}^{1+}$	Ionization	0.01-1.00 keV	Ex	663
$e + \text{Sm}^{1+}$	Ionization	0.01-1.00 keV	E/T	576
$e + \text{Sm}^{2+}$	Ionization	0.01-1.00 keV	Ex	663
$e + \text{Sm}^{2+}$	Ionization	0.01-1.00 keV	E/T	576
$e + \text{Sm}^{3+}$	Ionization	0.01-1.00 keV	Ex	663
$e + \text{Sm}^{3+}$	Ionization	0.01-1.00 keV	E/T	576
$e + \text{Sm}^{4+}$	Ionization	0.01-1.00 keV	E/T	576
$e + \text{Sm}^{5+}$	Ionization	0.01-1.00 keV	E/T	576
$e + \text{Sm}^{6+}$	Ionization	0.01-1.00 keV	E/T	576
$e + \text{Sm}^{7+}$	Ionization	0.01-1.00 keV	E/T	576
$e + \text{Sm}^{8+}$	Ionization	0.01-1.00 keV	E/T	576
$e + \text{Sm}^{9+}$	Ionization	0.01-1.00 keV	E/T	576
$e + \text{Sm}^{10+}$	Ionization	0.01-1.00 keV	E/T	576
$e + \text{Sm}^{11+}$	Ionization	0.01-1.00 keV	E/T	576
$e + \text{Sm}^{12+}$	Ionization	0.20-1.02 keV	E/T	584
$e + \text{Sm}^{12+}$	Ionization	0.01-1.00 keV	E/T	576
$e + \text{Eu}$	Excitation	3.00-200.00 eV	Ex	529
$e + \text{Gd}$	Ionization	4.00-900.00 eV	Ex	518
$e + \text{Gd}^{36+}$	Excitation	75.00-400.00 Ry	Th	508
$e + \text{Dy}$	Ionization	4.00-900.00 eV	Ex	518
$e + \text{Er}$	Ionization	4.00-900.00 eV	Ex	518
$e + \text{Yb}$	Excitation	60.00 eV	E/T	397
$e + \text{Yb}$	Ionization	4.00-900.00 eV	Ex	518
$e + \text{WO}$	Ionization	0.01-1.00 keV	Th	374
$e + \text{WO}_2$	Ionization	0.01-1.00 keV	Th	374
$e + \text{WO}_3$	Ionization	0.01-1.00 keV	Th	374
$e + \text{Re}$	Ionization	4.00-50.00 keV	E/T	614
$e + \text{Au}$	Bremsstrahlung	5.00-50.00 keV	E/T	479
$e + \text{Au}$	Bremsstrahlung	180.00-300.00 keV	Th	477
$e + \text{Au}$	Elastic Scattering	0.00-1.00 GeV	Th	519
$e + \text{Au}^{25+}$	Recombination	0.00-1.00 eV	Ex	658
$e + \text{Au}^{48+}$	Ionization	2.00-40.00 keV	Th	487
$e + \text{Au}^{75+}$	Recombination	8.00-60.00 eV	Th	660
$e + \text{Au}^{76+}$	Recombination	8.00-60.00 eV	Th	660
$e + \text{Au}^{76+}$	Recombination	3.00-100.00 eV	Ex	659
$e + \text{Au}^{76+}$	Recombination	170.00 eV	Ex	643
$e + \text{Hg}$	Excitation	5.00 keV	Th	560
$e + \text{Hg}$	Excitation	5.50 eV	Ex	513

e + Tl	Excitation	5.00 keV	Th	560
e + Pb⁵³⁺	Recombination	0.06 eV	Th	676
e + Pb⁷⁹⁺	Recombination	3.00-100.00 eV	Ex	659
e + Fr	Elastic Scattering	0.00-3.00 eV	Th	554
e + Fr	Elastic Scattering	0.01-0.50 meV	Th	461
e + Fr	Angular Scattering	0.00-3.00 eV	Th	554
e + Fr	Total Scattering	0.00-3.00 eV	Th	554
e + Ra¹⁺	Line Broadening	5.00-50.00 K	Th	631
e + perturbation	Electron Collisions		E/T	629
e + CS₂	Dissociation	10.00 eV	Ex	548
e + CS₂[*]	Dissociation	10.00 eV	Ex	548
e + CF₄	Elastic Scattering	1.50-30.00 eV	E/T	585
e + CF₄	Ionization	0.01-1.00 keV	Th	571
e + CF₄	Ionization	1.00 keV	E/T	454
e + CF₄	Ionization	500.00 eV	Th	379
e + CCl₄	Ionization	220.00 eV	Ex	419
e + NF₃	Elastic Scattering	60.00 eV	Th	502
e + NF₃	Angular Scattering	60.00 eV	Th	502
e + U⁸⁸⁺	Recombination	170.00 eV	Ex	643
e + U⁸⁹⁺	Recombination	3.00-100.00 eV	Ex	659
e + U⁸⁹⁺	Recombination	170.00 eV	Ex	643
e + U⁹²⁺	Recombination	0.06-37.00 keV	Th	661
e + SF₆	Attachment	127.00 meV	Ex	569
e + SF₆	Ionization	0.02-1.00 keV	Ex	392
e + C₂H₄¹⁺	Dissociation	0.10-30.00 eV	Th	683
e + C₂H₄¹⁺	Recombination	0.10-30.00 eV	Th	683
e + OCS	Dissociation	10.00-400.00 eV	Ex	437
e + Bi⁸⁰⁺	Recombination	3.00-100.00 eV	Ex	659
e + Bi⁸²⁺	Recombination	3.00-100.00 eV	Ex	659
e + Bi⁸³⁺	Recombination	0.00-100.00 eV	Ex	674
e + Bi⁸³⁺	Recombination	3.00-100.00 eV	Ex	659
e + Bi⁸³⁺	Recombination	0.00-10.00 eV	Th	469
e + HF¹⁺	Dissociation	0.00-1.00 eV	Ex	553
e + HF¹⁺	Recombination	0.00-1.00 eV	Ex	553
e + O Al	Ionization	0.01-1.00 keV	Th	374
e + C₂H₆¹⁺	Dissociation	0.10-30.00 eV	Th	683
e + C₂H₆¹⁺	Recombination	0.10-30.00 eV	Th	683
e + OH	Elastic Scattering	0.01-2.00 keV	Th	448
e + OH	Excitation	0.01-2.00 keV	Th	448
e + OH	Ionization	0.01-2.00 keV	Th	448
e + CHF₃	Dissociation	120.00 eV	Ex	473
e + CHF₃	Elastic Scattering	1.50-30.00 eV	E/T	585
e + CHF₃	Fluorescence	120.00 eV	Ex	473
e + CHF₃	Ionization	500.00 eV	Th	379
e + CH₃I	Excitation	0.80 eV	Ex	474
e + CH₃Cl	Ionization	220.00 eV	Ex	419
e + C₃H₆	Elastic Scattering	1.00-15.00 eV	Th	501
e + Na₂₀	Attachment	3.00 eV	Th	588
e + Na₄₀	Attachment	3.00 eV	Th	588
e + C₃H₈¹⁺	Dissociation	0.10-30.00 eV	Th	683
e + C₃H₈¹⁺	Recombination	0.10-30.00 eV	Th	683
e + SiF₄	Angular Scattering	1.00 keV	Ex	387
e + SiF₄	Excitation	1.00 keV	Ex	387
e + Na₅₈	Attachment	3.00 eV	Th	588
e + C₆H₆	Elastic Scattering	1.10-100.00 eV	Ex	388
e + C₆H₆	Angular Scattering	1.10-100.00 eV	Ex	388
e + C₆H₆	Ionization	20.00 eV	E/T	383

$e + C_6D_6$	Ionization	20.00 eV	E/T	383
$e + C_2$	Dissociation	70.00-250.00 eV	Ex	386
$e + C_2$	Ionization	70.00-250.00 eV	Ex	386
$e + CH_2F_2$	Elastic Scattering	1.50-30.00 eV	E/T	585
$e + CH_2F_2$	Ionization	500.00 eV	Th	379
$e + HI$	Attachment	1.00 eV	Th	639
$e + HI$	Attachment	0.00-4.00 eV	E/T	433
$e + HI$	Dissociation	1.00 eV	Th	639
$e + HI$	Dissociation	0.00-4.00 eV	E/T	433
$e + C_2H^{1+}$	Dissociation	50.00 eV	Ex	578
$e + CH_3F$	Elastic Scattering	1.50-30.00 eV	E/T	585
$e + CH_3F$	Ionization	500.00 eV	Th	379
$e + CFCl_3$	Attachment	0.00-4.00 eV	E/T	433
$e + CFCl_3$	Dissociation	0.00-4.00 eV	E/T	433
$e + CF_3Cl$	Attachment	3.00 eV	Th	429
$e + CF_3Cl$	Dissociation	3.00 eV	Th	429
$e + CF_3Cl$	Excitation	3.00 eV	Th	429
$e + C_3$	Dissociation	70.00-250.00 eV	Ex	386
$e + C_3$	Ionization	70.00-250.00 eV	Ex	386
$e + Fe^{24+}$	Excitation	$10^{5.5}-10^9$ K	Th	423
$e + Al_2O$	Ionization	0.01-1.00 keV	Th	374
$e + LiH^{1+}$	Excitation	52.00-65.00 eV	Th	431
$e + H_2S_2$	Elastic Scattering	5.00 eV	Th	413
$e + H_2S_2$	Angular Scattering	5.00 eV	Th	413
$e + Si_2H_6$	Elastic Scattering	1.00-370.00 eV	Ex	451
$e + Si_2H_6$	Excitation	1.00-370.00 eV	Ex	451
$e + Si_2H_6$	Ionization	1.00-370.00 eV	Ex	451
$e + ND_3$	Ionization	1.00 keV	Ex	380
$e + C_2F_4$	Elastic Scattering	50.00 eV	Th	382
$e + C_2F_4$	Excitation	50.00 eV	Th	382
$e + C_2Cl_3F_3$	Attachment	0.00-4.00 eV	E/T	433
$e + C_2Cl_3F_3$	Dissociation	0.00-4.00 eV	E/T	433
$e + C_6F_6$	Elastic Scattering	1.10-100.00 eV	Ex	388
$e + C_6F_6$	Angular Scattering	1.10-100.00 eV	Ex	388
$e + C_4^{-1+}$	Ionization	40.00 eV	Ex	377

2.2.3 Heavy Particle Collisions

$h\nu + CH_3I$	Heavy Particle Coll.		Ex	747
$h\nu + CH_3I$	Excitation		Ex	747
$h\nu + CH_3I$	Ionization		Ex	747
$H + H$	Heavy Particle Coll.	0.00-1.00 MeV	Th	889
$H + H$	Heavy Particle Coll.		Ex	839
$H + H$	Association	0.05-10.00 eV	E/T	1027
$H + H$	Elastic Scattering		Th	926
$H^* + H^*$	Elastic Scattering		Th	926
$H + H$	Elastic Scattering		Th	867
$H + H$	Elastic Scattering		Ex	839
$H + H$	Charge Transfer	0.00-1.00 MeV	Th	889
$H^* + H^*$	Energy Transfer		Th	926
$H + H$	Energy Transfer		Th	926
$H^* + H^*$	Interaction Potentials		Th	900
$H + H$	Interaction Potentials		Th	900
$H + H$	Interaction Potentials		Th	760
$H + H$	Total Scattering	0.00-1.00 MeV	Th	889

$\text{H} + \text{H}$	Total Scattering	0.00-1.00 MeV	Th	889
$\text{H}^* + \text{H}^*$	Fluorescence		Th	926
$\text{H} + \text{H}$	Fluorescence		Th	926
$\text{H} + \text{H}$	Ionization	0.05-10.00 eV	E/T	1027
$\text{H} + \text{H}$	Ionization	1.00-100.00 MeV/amu	Th	823
$\text{H} + \text{H}_2$	Heavy Particle Coll.	0.00-1.00 MeV	Th	889
$\text{H} + \text{H}_2$	Charge Transfer	0.00-1.00 MeV	Th	889
$\text{H} + \text{H}_2$	Charge Transfer	0.01-25.00 keV	Th	706
$\text{H} + \text{H}_2$	Interchange reaction	1.50 eV	Th	780
$\text{H} + \text{H}_2$	Interchange reaction	1.39-2.20 eV	Th	709
$\text{H} + \text{H}_2$	Interchange reaction	1.64 eV	Ex	708
$\text{H} + \text{H}_2$	Interchange reaction	0.50 eV	Ex	707
$\text{H} + \text{H}_2$	Interchange reaction	1.60 eV	Th	702
$\text{H} + \text{H}_2$	Interchange reaction	0.50-1.90 eV	Th	697
$\text{H} + \text{H}_2$	Interchange reaction	0.60-1.30 eV	Th	696
$\text{H} + \text{H}_2$	Energy Transfer	2.00-7.00 km/s	Ex	759
$\text{H}^* + \text{H}_2$	Energy Transfer	2.00-7.00 km/s	Ex	759
$\text{H} + \text{H}_2$	Total Scattering	0.00-1.00 MeV	Th	889
$\text{H} + \text{H}_2$	Total Scattering	0.00-1.00 MeV	Th	889
$\text{H} + \text{H}_2$	Excitation	2.00-7.00 km/s	Ex	759
$\text{H}^* + \text{H}_2$	Excitation	2.00-7.00 km/s	Ex	759
$\text{H} + \text{HD}$	Interchange reaction	0.50 eV	Ex	707
$\text{H} + \text{D}_2$	Interchange reaction	1.39-2.20 eV	Th	709
$\text{H} + \text{D}_2$	Interchange reaction	1.64 eV	Ex	708
$\text{H} + \text{D}_2$	Interchange reaction	1.60 eV	Th	702
$\text{H} + \text{D}_2$	Interchange reaction	0.50-1.90 eV	Th	697
$\text{H} + \text{D}_2$	Interchange reaction	0.60-1.30 eV	Th	696
$\text{H} + \text{He}$	Interaction Potentials		Th	718
$\text{H} + \text{He}$	Excitation	50.00 eV	Th	877
$\text{H} + \text{Li}$	Interaction Potentials		Th	718
$\text{H} + \text{CO}$	Excitation	0.01-3.00 K	Th	686
$\text{H} + \text{N}$	Heavy Particle Coll.	0.00-1.00 MeV	Th	889
$\text{H} + \text{N}$	Charge Transfer	0.00-1.00 MeV	Th	889
$\text{H} + \text{N}$	Total Scattering	0.00-1.00 MeV	Th	889
$\text{H} + \text{N}$	Total Scattering	0.00-1.00 MeV	Th	889
$\text{H} + \text{N}_2$	Heavy Particle Coll.	0.00-1.00 MeV	Th	889
$\text{H}^* + \text{N}_2$	De-excitation	1.84 eV	Ex	929
$\text{H} + \text{N}_2$	De-excitation	1.84 eV	Ex	929
$\text{H} + \text{N}_2$	Charge Transfer	0.00-1.00 MeV	Th	889
$\text{H} + \text{N}_2$	Total Scattering	0.00-1.00 MeV	Th	889
$\text{H} + \text{N}_2$	Total Scattering	0.00-1.00 MeV	Th	889
$\text{H}^* + \text{N}_2$	Excitation	1.84 eV	Ex	929
$\text{H} + \text{N}_2$	Excitation	1.84 eV	Ex	929
$\text{H}^* + \text{O}_2$	De-excitation	1.84 eV	Ex	929
$\text{H} + \text{O}_2$	De-excitation	1.84 eV	Ex	929
$\text{H} + \text{O}_2$	Interchange reaction	9.04 keV	Th	695
$\text{H}^* + \text{O}_2$	Excitation	1.84 eV	Ex	929
$\text{H} + \text{O}_2$	Excitation	1.84 eV	Ex	929
$\text{H} + \text{F}^{-1+}$	Association	2.00 eV	Th	767
$\text{H} + \text{F}^{-1+}$	Interaction Potentials	2.00 eV	Th	767
$\text{H} + \text{F}^{-1+}$	Detachment	2.00 eV	Th	767
$\text{H} + \text{Na}$	Line Broadening	10.00 m/s	Th	753
$\text{H} + \text{Na}$	Excitation	50.00 eV	Th	877
$\text{H} + \text{SiO}$	Excitation	0.20-9.60 K	Th	703
$\text{H} + \text{Cl}^{-1+}$	Association	2.00 eV	Th	767
$\text{H} + \text{Cl}^{-1+}$	Interaction Potentials	2.00 eV	Th	767
$\text{H} + \text{Cl}^{-1+}$	Detachment	2.00 eV	Th	767

$\text{H} + \text{Ar}$	Association	10.00-100.00 eV	Ex	808
$\text{H} + \text{Ar}$	Ionization	10.00-100.00 eV	Ex	808
$\text{H} + \text{Br}^{-1+}$	Association	2.00 eV	Th	767
$\text{H} + \text{Br}^{-1+}$	Interaction Potentials	2.00 eV	Th	767
$\text{H} + \text{Br}^{-1+}$	Detachment	2.00 eV	Th	767
$\text{H} + \text{Kr}$	Association	10.00-100.00 eV	Ex	808
$\text{H} + \text{Kr}$	Ionization	10.00-100.00 eV	Ex	808
$\text{H}^* + \text{Rb}$	Interaction Potentials		Th	871
$\text{H} + \text{Rb}$	Interaction Potentials		Th	871
$\text{H} + \text{Xe}$	Association	10.00-100.00 eV	Ex	808
$\text{H} + \text{Xe}$	Ionization	10.00-100.00 eV	Ex	808
$\text{H}^{1+} + \text{H}^{-1+}$	Association	0.10-1.00 K	Th	814
$\text{H}^{1+} + \text{H}^{-1+}$	Charge Transfer	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{H}^{-1+}$	Charge Transfer		Th	1025
$\text{H}^{1+} + \text{H}^{-1+}$	Charge Transfer	0.10-1.00 K	Th	814
$\text{H}^{1+} + \text{H}^{-1+}$	Recombination	0.10-1.00 K	Th	814
$\text{H}^{1+} + \text{H}^{-1+}$	Excitation	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{H}$	Heavy Particle Coll.	0.00-1.00 MeV	Th	889
$\text{H}^{1+} + \text{H}^*$	Line Broadening	4.00-10.00 K	E/T	692
$\text{H}^{1+} + \text{H}$	Line Broadening	4.00-10.00 K	E/T	692
$\text{H}^{1+} + \text{H}$	Elastic Scattering	0.01-1.00 eV	Ex	930
$\text{H}^{1+} + \text{H}$	Charge Transfer	100.00 eV	Th	1023
$\text{H}^{1+} + \text{H}^*$	Charge Transfer	10.00-100.00 keV	Th	994
$\text{H}^{1+} + \text{H}$	Charge Transfer	10.00-100.00 keV	Th	994
$\text{H}^{1+} + \text{H}$	Charge Transfer	5.00 MeV	Th	984
$\text{H}^{1+} + \text{H}$	Charge Transfer		Th	983
$\text{H}^{1+} + \text{H}$	Charge Transfer	0.00-2.50 MeV	Th	935
$\text{H}^{1+} + \text{H}$	Charge Transfer	0.01-1.00 eV	Ex	930
$\text{H}^{1+} + \text{H}$	Charge Transfer	0.00-1.00 MeV	Th	889
$\text{H}^{1+} + \text{H}$	Charge Transfer	5.00 MeV	Th	715
$\text{H}^{1+} + \text{H}$	Charge Transfer	0.01-25.00 keV	Th	706
$\text{H}^{1+} + \text{H}$	Total Scattering	5.00 MeV	Th	984
$\text{H}^{1+} + \text{H}$	Total Scattering	0.89-2.00 a.u.	Th	891
$\text{H}^{1+} + \text{H}$	Total Scattering	0.00-1.00 MeV	Th	889
$\text{H}^{1+} + \text{H}$	Total Scattering	0.00-1.00 MeV	Th	889
$\text{H}^{1+} + \text{H}$	Total Scattering	1.00 GeV/amu	Th	751
$\text{H}^{1+} + \text{H}$	Total Scattering	48.00-114.00 keV	Th	717
$\text{H}^{1+} + \text{H}^*$	Excitation	0.00-10.00 keV	Th	934
$\text{H}^{1+} + \text{H}$	Excitation	0.00-10.00 keV	Th	934
$\text{H}^{1+} + \text{H}$	Ionization		Th	983
$\text{H}^{1+} + \text{H}$	Ionization	500.00 keV	Th	980
$\text{H}^{1+} + \text{H}$	Ionization	50.00-100.00 keV	E/T	932
$\text{H}^{1+} + \text{H}$	Ionization	1.00-25.00 keV	Th	914
$\text{H}^{1+} + \text{H}$	Ionization	0.89-2.00 a.u.	Th	891
$\text{H}^{1+} + \text{H}$	Ionization	0.00-1.00 MeV	Th	807
$\text{H}^{1+} + \text{H}$	Ionization	1.00 GeV/amu	Th	751
$\text{H}^{1+} + \text{H}$	Ionization	48.00-114.00 keV	Th	717
$\text{H}^{1+} + \text{H}$	Ionization	5.00 MeV	Th	715
$\text{H}^{1+} + \text{H}_2$	Heavy Particle Coll.	0.00-1.00 MeV	Th	889
$\text{H}^{1+} + \text{H}_2$	Dissociation	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{H}_2$	Dissociation	10.00 eV	Th	1024
$\text{H}^{1+} + \text{H}_2$	Dissociation	0.10-10.00 eV	Th	1022
$\text{H}^{1+} + \text{H}_2$	Dissociation	0.03-3.90 MeV	E/T	1021
$\text{H}^{1+} + \text{H}_2$	Dissociation	0.19-50.00 keV/amu	Ex	862
$\text{H}^{1+} + \text{H}_2$	Charge Transfer	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{H}_2$	Charge Transfer	0.10-10.00 eV	Th	1022
$\text{H}^{1+} + \text{H}_2$	Charge Transfer	0.20-20.00 keV	Ex	991

$\text{H}^{1+} + \text{H}_2$	Charge Transfer		Th	983
$\text{H}^{1+} + \text{H}_2$	Charge Transfer	0.00-1.00 MeV	Th	889
$\text{H}^{1+} + \text{H}_2$	Charge Transfer	0.01-25.00 keV	Th	706
$\text{H}^{1+} + \text{H}_2$	Interchange reaction	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{H}_2$	Interchange reaction	10.00 eV	Th	1024
$\text{H}^{1+} + \text{H}_2$	Total Scattering	0.00-1.00 MeV	Th	889
$\text{H}^{1+} + \text{H}_2$	Total Scattering	0.00-1.00 MeV	Th	889
$\text{H}^{1+} + \text{H}_2$	Excitation	10.00 eV	Th	1024
$\text{H}^{1+} + \text{H}_2$	Excitation	0.10-10.00 eV	Th	1022
$\text{H}^{1+} + \text{H}_2$	Excitation	0.20-20.00 keV	Ex	991
$\text{H}^{1+} + \text{H}_2$	Ionization		Th	983
$\text{H}^{1+} + \text{H}_2$	Ionization	50.00-100.00 keV	E/T	932
$\text{H}^{1+} + \text{H}_2$	Ionization	4.00-24.00 a.u.	Ex	712
$\text{H}^{1+} + \text{H}_2^{1+}$	Dissociation	0.10-10.00 eV	Th	1022
$\text{H}^{1+} + \text{H}_2^{1+}$	Charge Transfer	0.10-10.00 eV	Th	1022
$\text{H}^{1+} + \text{H}_2^{1+}$	Excitation	0.10-10.00 eV	Th	1022
$\text{H}^{1+} + \text{HD}$	Ionization	4.00-24.00 a.u.	Ex	712
$\text{H}^{1+} + \text{HT}$	Dissociation	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{HT}$	Charge Transfer	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{HT}$	Interchange reaction	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{H}_2\text{O}$	Dissociation	20.00-50.00 keV	Ex	928
$\text{H}^{1+} + \text{H}_2\text{O}$	Ionization	20.00-50.00 keV	Ex	928
$\text{H}^{1+} + \text{D}^{-1+}$	Association	0.10-1.00 K	Th	814
$\text{H}^{1+} + \text{D}^{-1+}$	Charge Transfer	0.10-1.00 K	Th	814
$\text{H}^{1+} + \text{D}^{-1+}$	Recombination	0.10-1.00 K	Th	814
$\text{H}^{1+} + \text{D}$	Elastic Scattering	0.01-1.00 eV	Ex	930
$\text{H}^{1+} + \text{D}$	Charge Transfer	0.01-1.00 eV	Ex	930
$\text{H}^{1+} + \text{D}_2$	Dissociation	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{D}_2$	Dissociation	0.03-3.90 MeV	E/T	1021
$\text{H}^{1+} + \text{D}_2$	Dissociation	0.19-50.00 keV/amu	Ex	862
$\text{H}^{1+} + \text{D}_2$	Charge Transfer	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{D}_2$	Interchange reaction	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{DT}$	Dissociation	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{DT}$	Charge Transfer	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{DT}$	Interchange reaction	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{T}_2$	Dissociation	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{T}_2$	Charge Transfer	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{T}_2$	Interchange reaction	0.00-10.00 keV	E/T	1026
$\text{H}^{1+} + \text{He}$	Elastic Scattering	0.10-10.00 MeV	Th	820
$\text{H}^{1+} + \text{He}$	Elastic Scattering	2.50-4.50 MeV	Ex	818
$\text{H}^{1+} + \text{He}$	Charge Transfer	0.05-1.00 MeV/amu	E/T	913
$\text{H}^{1+} + \text{He}$	Charge Transfer	2×10^6 - 1.3×10^8 cm/s	Th	728
$\text{H}^{1+} + \text{He}^*$	Charge Transfer	2×10^6 - 1.3×10^8 cm/s	Th	728
$\text{H}^{1+} + \text{He}$	Excitation	1.50-6.00 MeV/amu	Th	960
$\text{H}^{1+} + \text{He}$	Excitation	0.05-1.40 keV	E/T	857
$\text{H}^{1+} + \text{He}$	Excitation	1.00-80.00 a.u.	Th	805
$\text{H}^{1+} + \text{He}$	Excitation	100.00-150.00 keV	E/T	795
$\text{H}^{1+} + \text{He}$	Excitation	2.00 MeV	Th	775
$\text{H}^{1+} + \text{He}$	Excitation	100.00 keV	Th	770
$\text{H}^{1+} + \text{He}$	Excitation	2.00-8.00 a.u.	Th	758
$\text{H}^{1+} + \text{He}$	Excitation	2×10^6 - 1.3×10^8 cm/s	Th	728
$\text{H}^{1+} + \text{He}^*$	Excitation	2×10^6 - 1.3×10^8 cm/s	Th	728
$\text{H}^{1+} + \text{He}$	Excitation	3.00-8.50 a.u.	E/T	727
$\text{H}^{1+} + \text{He}$	Ionization	0.01-1.00 keV	Th	838
$\text{H}^{1+} + \text{He}$	Ionization	2.00 MeV	Ex	810
$\text{H}^{1+} + \text{He}$	Ionization	1.00-80.00 a.u.	Th	805
$\text{H}^{1+} + \text{He}$	Ionization	70.00-100.00 keV	E/T	799

$\text{H}^{1+} + \text{He}$	Ionization	0.20-4.00 MeV	E/T	797
$\text{H}^{1+} + \text{He}$	Ionization	100.00-150.00 keV	E/T	795
$\text{H}^{1+} + \text{He}$	Ionization	2.00 MeV	Th	775
$\text{H}^{1+} + \text{He}$	Ionization	0.30-2.00 MeV	Th	771
$\text{H}^{1+} + \text{He}$	Ionization	100.00 keV	Th	770
$\text{H}^{1+} + \text{He}$	Ionization	2.00-8.00 a.u.	Th	758
$\text{H}^{1+} + \text{Li}^{-1+}$	Association	0.10-1.00 K	Th	814
$\text{H}^{1+} + \text{Li}^{-1+}$	Charge Transfer	0.10-1.00 K	Th	814
$\text{H}^{1+} + \text{Li}^{-1+}$	Recombination	0.10-1.00 K	Th	814
$\text{H}^{1+} + \text{Li}$	Total Scattering	0.20-95.00 MeV	Th	854
$\text{H}^{1+} + \text{Li}$	Excitation	0.70-2.27 MeV	Ex	831
$\text{H}^{1+} + \text{Li}$	Ionization	0.20-95.00 MeV	Th	854
$\text{H}^{1+} + \text{Li}$	Ionization	0.70-2.27 MeV	Ex	831
$\text{H}^{1+} + \text{Li}^{2+}$	Charge Transfer	31.00-151.00 a.u.	Th	798
$\text{H}^{1+} + \text{Be}$	Elastic Scattering	0.01-10.00 GeV	Th	834
$\text{H}^{1+} + \text{Be}^{3+}$	Charge Transfer	31.00-151.00 a.u.	Th	798
$\text{H}^{1+} + \text{B}$	Elastic Scattering	0.50-3.30 MeV	Ex	824
$\text{H}^{1+} + \text{C}$	Elastic Scattering	0.01-10.00 GeV	Th	834
$\text{H}^{1+} + \text{C}$	Elastic Scattering	0.50-2.50 MeV	Ex	832
$\text{H}^{1+} + \text{C}$	Total Scattering	0.50-2.50 MeV	Ex	832
$\text{H}^{1+} + \text{C}$	Ionization	16.00-70.00 MeV	Ex	821
$\text{H}^{1+} + \text{CH}_4$	Dissociation	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{CH}_4$	Charge Transfer	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{CH}_4$	Interchange reaction	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{CO}$	Charge Transfer	1.00-14.00 keV	Ex	796
$\text{H}^{1+} + \text{N}$	Elastic Scattering	0.50-2.50 MeV	Ex	832
$\text{H}^{1+} + \text{N}$	Total Scattering	0.50-2.50 MeV	Ex	832
$\text{H}^{1+} + \text{N}_2$	Dissociation	0.06-7.00 MeV	Ex	942
$\text{H}^{1+} + \text{N}_2$	Dissociation	3.00-10.00 keV	Ex	905
$\text{H}^{1+} + \text{N}_2$	Charge Transfer	3.00-10.00 keV	Ex	905
$\text{H}^{1+} + \text{N}_2$	Fluorescence	3.00-10.00 keV	Ex	905
$\text{H}^{1+} + \text{N}_2$	Excitation	3.00-10.00 keV	Ex	905
$\text{H}^{1+} + \text{N}_2$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{H}^{1+} + \text{N}_2$	Ionization	0.06-7.00 MeV	Ex	942
$\text{H}^{1+} + \text{N}_2\text{O}$	Dissociation	3.00-10.00 keV	Ex	905
$\text{H}^{1+} + \text{N}_2\text{O}$	Charge Transfer	3.00-10.00 keV	Ex	905
$\text{H}^{1+} + \text{N}_2\text{O}$	Fluorescence	3.00-10.00 keV	Ex	905
$\text{H}^{1+} + \text{N}_2\text{O}$	Excitation	3.00-10.00 keV	Ex	905
$\text{H}^{1+} + \text{O}$	Elastic Scattering	0.50-2.50 MeV	Ex	832
$\text{H}^{1+} + \text{O}$	Total Scattering	0.50-2.50 MeV	Ex	832
$\text{H}^{1+} + \text{O}_2$	Dissociation	3.00-10.00 keV	Ex	905
$\text{H}^{1+} + \text{O}_2$	Charge Transfer	3.00-10.00 keV	Ex	905
$\text{H}^{1+} + \text{O}_2$	Fluorescence	3.00-10.00 keV	Ex	905
$\text{H}^{1+} + \text{O}_2$	Excitation	3.00-10.00 keV	Ex	905
$\text{H}^{1+} + \text{F}$	Elastic Scattering	0.70-2.80 MeV	Ex	817
$\text{H}^{1+} + \text{Ne}$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{H}^{1+} + \text{Ne}$	Ionization	2.00 MeV	Ex	810
$\text{H}^{1+} + \text{Ne}$	Ionization	0.30-2.00 MeV	Th	771
$\text{H}^{1+} + \text{Na}$	Charge Transfer	0.01-1.00 keV/amu	Th	859
$\text{H}^{1+} + \text{Na}^*$	Charge Transfer	0.01-1.00 keV/amu	Th	859
$\text{H}^{1+} + \text{Mg}$	Charge Transfer	1.00-500.00 keV	E/T	764
$\text{H}^{1+} + \text{Al}$	Elastic Scattering	0.01-10.00 GeV	Th	834
$\text{H}^{1+} + \text{Al}$	Elastic Scattering	0.50-2.50 MeV	Ex	832
$\text{H}^{1+} + \text{Al}$	Elastic Scattering	0.80-3.00 MeV	Ex	819
$\text{H}^{1+} + \text{Al}$	Total Scattering	0.50-2.50 MeV	Ex	832
$\text{H}^{1+} + \text{Al}$	Ionization		Th	825
$\text{H}^{1+} + \text{Si}$	Elastic Scattering	0.50-2.50 MeV	Ex	832

$H^{1+} + Si$	Total Scattering	0.50-2.50 MeV	Ex	832
$H^{1+} + Ar$	Excitation	0.01-1.00 MeV/amu	Ex	690
$H^{1+} + Ar$	Ionization	2.00 MeV	Ex	810
$H^{1+} + Ar$	Ionization	75.00 keV	E/T	766
$H^{1+} + Ar$	Ionization	1.00 MeV	Th	735
$H^{1+} + K$	Charge Transfer	0.01-1.00 keV/amu	Th	859
$H^{1+} + K^*$	Charge Transfer	0.01-1.00 keV/amu	Th	859
$H^{1+} + Ti$	Ionization	0.30-3.50 MeV	Th	828
$H^{1+} + Ti$	Ionization		Th	825
$H^{1+} + Fe$	Elastic Scattering	0.01-10.00 GeV	Th	834
$H^{1+} + Cu$	Ionization		Th	825
$H^{1+} + Kr$	Ionization	2.00 MeV	Ex	810
$H^{1+} + Kr$	Ionization	0.30-2.00 MeV	Th	771
$H^{1+} + Rb$	Ionization	0.30-3.50 MeV	Th	828
$H^{1+} + Ag$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Ag$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Cd$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Cd$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + In$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + In$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Sn$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Sn$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Sn$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Sn$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Sb$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Sb$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Te$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Te$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + I$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + I$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Xe$	Ionization	2.00 MeV	Ex	810
$H^{1+} + Xe$	Ionization	0.30-2.00 MeV	Th	771
$H^{1+} + Cs$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Cs$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Ba$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Ba$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + La$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + La$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Ce$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Ce$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Pr$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Pr$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Nd$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Nd$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Eu$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Eu$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Gd$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Gd$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Gd$	Ionization	0.30-3.50 MeV	Th	828
$H^{1+} + Tb$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Tb$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Tb$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Tb$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Dy$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Dy$	Ionization	0.50-3.50 MeV	Th	830
$H^{1+} + Ho$	Excitation	0.50-3.50 MeV	Th	830
$H^{1+} + Ho$	Ionization	0.50-3.50 MeV	Th	830

$\text{H}^{1+} + \text{Er}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Er}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Tm}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Tm}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Yb}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Yb}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Lu}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Lu}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Hf}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Hf}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Ta}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Ta}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{W}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{W}$	Excitation	0.30-0.70 MeV	Ex	827
$\text{H}^{1+} + \text{W}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{W}$	Ionization	0.30-3.50 MeV	Th	828
$\text{H}^{1+} + \text{W}$	Ionization	0.30-0.70 MeV	Ex	827
$\text{H}^{1+} + \text{Ir}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Ir}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Pt}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Pt}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Au}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Au}$	Excitation	0.30-0.70 MeV	Ex	827
$\text{H}^{1+} + \text{Au}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Au}$	Ionization	0.30-0.70 MeV	Ex	827
$\text{H}^{1+} + \text{Au}$	Ionization		Th	825
$\text{H}^{1+} + \text{Au}$	Ionization	16.00-70.00 MeV	Ex	821
$\text{H}^{1+} + \text{Hg}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Hg}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Tl}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Tl}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Pb}$	Elastic Scattering	0.01-10.00 GeV	Th	834
$\text{H}^{1+} + \text{Pb}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Pb}$	Excitation	0.30-0.70 MeV	Ex	827
$\text{H}^{1+} + \text{Pb}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Pb}$	Ionization	0.30-0.70 MeV	Ex	827
$\text{H}^{1+} + \text{Th}$	Excitation	0.30-0.70 MeV	Ex	827
$\text{H}^{1+} + \text{Th}$	Ionization	0.30-0.70 MeV	Ex	827
$\text{H}^{1+} + \text{perturbation}$	Excitation	1.00 MeV	E/T	826
$\text{H}^{1+} + \text{perturbation}$	Ionization	1.00 MeV	E/T	826
$\text{H}^{1+} + \text{perturbation}$	Ionization	16.00-70.00 MeV	Ex	821
$\text{H}^{1+} + \text{C}_{60}$	Dissociation	1.00-3.50 a.u.	Ex	863
$\text{H}^{1+} + \text{C}_{60}$	Energy Transfer	0.10-5.00 a.u.	Th	778
$\text{H}^{1+} + \text{C}_{60}$	Ionization	1.00-3.50 a.u.	Ex	863
$\text{H}^{1+} + \text{U}$	Elastic Scattering	0.01-10.00 GeV	Th	834
$\text{H}^{1+} + \text{U}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{U}$	Excitation	0.30-0.70 MeV	Ex	827
$\text{H}^{1+} + \text{U}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{U}$	Ionization	0.30-3.50 MeV	Th	828
$\text{H}^{1+} + \text{U}$	Ionization	0.30-0.70 MeV	Ex	827
$\text{H}^{1+} + \text{C}_2\text{H}_4$	Dissociation	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{C}_2\text{H}_4$	Charge Transfer	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{C}_2\text{H}_4$	Interchange reaction	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{Bi}$	Excitation	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Bi}$	Excitation	0.30-0.70 MeV	Ex	827
$\text{H}^{1+} + \text{Bi}$	Ionization	0.50-3.50 MeV	Th	830
$\text{H}^{1+} + \text{Bi}$	Ionization	0.30-3.50 MeV	Th	828

$\text{H}^{1+} + \text{Bi}$	Ionization	0.30-0.70 MeV	Ex	827
$\text{H}^{1+} + \text{C}_2\text{H}_6$	Dissociation	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{C}_2\text{H}_6$	Charge Transfer	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{C}_2\text{H}_6$	Interchange reaction	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{Na}_{20}$	Charge Transfer	0.04-0.16 a.u.	Th	898
$\text{H}^{1+} + \text{Na}_{20}$	Excitation	0.04-0.16 a.u.	Th	898
$\text{H}^{1+} + \text{Na}_{21}^{1+}$	Charge Transfer	0.04-0.16 a.u.	Th	898
$\text{H}^{1+} + \text{Na}_{21}^{1+}$	Excitation	0.04-0.16 a.u.	Th	898
$\text{H}^{1+} + \text{C}_3\text{H}_8$	Dissociation	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{C}_3\text{H}_8$	Charge Transfer	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{C}_3\text{H}_8$	Interchange reaction	0.10-30.00 eV	Th	1028
$\text{H}^{1+} + \text{Na}_{19}^{-1+}$	Charge Transfer	0.04-0.16 a.u.	Th	898
$\text{H}^{1+} + \text{Na}_{19}^{-1+}$	Excitation	0.04-0.16 a.u.	Th	898
$\text{H}_2 + \text{H}_2$	De-excitation	1.20 eV	Th	710
$\text{H}_2 + \text{H}_2$	Interchange reaction	5.00 eV	Th	701
$\text{H}_2 + \text{H}_2\text{O}$	Interchange reaction	5.00-20.00 K	Th	684
$\text{H}_2 + \text{D}^{1+}$	Association	0.10-1.00 K	Th	814
$\text{H}_2 + \text{D}^{1+}$	Charge Transfer	0.10-1.00 K	Th	814
$\text{H}_2 + \text{D}^{1+}$	Recombination	0.10-1.00 K	Th	814
$\text{H}_2 + \text{Li}$	Line Broadening		Th	899
$\text{H}_2 + \text{Li}$	Elastic Scattering		Th	899
$\text{H}_2 + \text{N}$	Elastic Scattering	0.10-10.00 K	Th	876
$\text{H}_2 + \text{N}$	Interaction Potentials	0.10-10.00 K	Th	876
$\text{H}_2 + \text{Na}$	Line Broadening		Th	899
$\text{H}_2 + \text{Na}$	Elastic Scattering		Th	899
$\text{H}_2 + \text{K}$	Line Broadening		Th	899
$\text{H}_2 + \text{K}$	Elastic Scattering		Th	899
$\text{H}_2 + \text{Rb}$	Line Broadening		Th	899
$\text{H}_2 + \text{Rb}$	Elastic Scattering		Th	899
$\text{H}_2 + \text{Cs}$	Line Broadening		Th	899
$\text{H}_2 + \text{Cs}$	Elastic Scattering		Th	899
$\text{H}_2 + \text{Fr}$	Line Broadening		Th	899
$\text{H}_2 + \text{Fr}$	Elastic Scattering		Th	899
$\text{H}_2 + \text{OH}$	Interchange reaction	0.50 eV	Th	704
$\text{H}_2^{1+} + \text{H}^{-1+}$	Association	0.05-10.00 eV	E/T	1027
$\text{H}_2^{1+} + \text{H}^{-1+}$	Association	0.10-1.00 K	Th	814
$\text{H}_2^{1+} + \text{H}^{-1+}$	Charge Transfer	0.10-1.00 K	Th	814
$\text{H}_2^{1+} + \text{H}^{-1+}$	Recombination	0.10-1.00 K	Th	814
$\text{H}_2^{1+} + \text{H}^{-1+}$	Ionization	0.05-10.00 eV	E/T	1027
$\text{H}_2^{1+} + \text{H}$	Dissociation	0.00-10.00 keV	E/T	1026
$\text{H}_2^{1+} + \text{H}$	Dissociation	20.00-100.00 keV	Ex	884
$\text{H}_2^{1+} + \text{H}$	Charge Transfer	0.00-10.00 keV	E/T	1026
$\text{H}_2^{1+} + \text{H}$	Charge Transfer	20.00-100.00 keV	Ex	884
$\text{H}_2^{1+} + \text{H}$	Interchange reaction	0.00-10.00 keV	E/T	1026
$\text{H}_2^{1+} + \text{H}$	Ionization	20.00-100.00 keV	Ex	884
$\text{H}_2^{1+} + \text{H}_2$	Interchange reaction		Th	1025
$\text{H}_2^{1+} + \text{H}_2$	Excitation	0.10-10.00 eV	Th	1022
$\text{H}_2^{1+} + \text{D}^{-1+}$	Association	0.05-10.00 eV	E/T	1027
$\text{H}_2^{1+} + \text{D}^{-1+}$	Ionization	0.05-10.00 eV	E/T	1027
$\text{H}_2^{1+} + \text{D}$	Dissociation	0.00-10.00 keV	E/T	1026
$\text{H}_2^{1+} + \text{D}$	Charge Transfer	0.00-10.00 keV	E/T	1026
$\text{H}_2^{1+} + \text{D}$	Interchange reaction	0.00-10.00 keV	E/T	1026
$\text{H}_2^{1+} + \text{He}$	Excitation	0.05-1.40 keV	E/T	857
$\text{H}_2^{1+} + \text{He}$	Ionization	75.00 keV	E/T	911
$\text{H}_2^{1+} + \text{He}$	Ionization	75.00 keV	Ex	842
$\text{H}_2^{1+} + \text{He}^{2+}$	Charge Transfer	6.10-21.20 keV/amu	Ex	773
$\text{H}_2^{1+} + \text{N}_2$	Dissociation	3.00-10.00 keV	Ex	905

$\text{H}_2^{1+} + \text{N}_2$	Charge Transfer	3.00-10.00 keV	Ex	905
$\text{H}_2^{1+} + \text{N}_2$	Fluorescence	3.00-10.00 keV	Ex	905
$\text{H}_2^{1+} + \text{N}_2$	Excitation	3.00-10.00 keV	Ex	905
$\text{H}_2^{1+} + \text{N}_2$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{H}_2^{1+} + \text{N}_2$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{H}_2^{1+} + \text{N}_2\text{O}$	Dissociation	3.00-10.00 keV	Ex	905
$\text{H}_2^{1+} + \text{N}_2\text{O}$	Charge Transfer	3.00-10.00 keV	Ex	905
$\text{H}_2^{1+} + \text{N}_2\text{O}$	Fluorescence	3.00-10.00 keV	Ex	905
$\text{H}_2^{1+} + \text{N}_2\text{O}$	Excitation	3.00-10.00 keV	Ex	905
$\text{H}_2^{1+} + \text{O}_2$	Dissociation	3.00-10.00 keV	Ex	905
$\text{H}_2^{1+} + \text{O}_2$	Charge Transfer	3.00-10.00 keV	Ex	905
$\text{H}_2^{1+} + \text{O}_2$	Fluorescence	3.00-10.00 keV	Ex	905
$\text{H}_2^{1+} + \text{O}_2$	Excitation	3.00-10.00 keV	Ex	905
$\text{H}_2^{1+} + \text{Ne}$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{H}_2^{1+} + \text{Ar}$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{H}_2^{1+} + \text{Ar}$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{H}_2^{1+} + \text{Ar}^{2+}$	Charge Transfer	6.10-21.20 keV/amu	Ex	773
$\text{H}_3^{1+} + \text{He}$	Excitation	0.05-1.40 keV	E/T	857
$\text{H}_3^{1+} + \text{N}_2$	Dissociation	3.00-10.00 keV	Ex	905
$\text{H}_3^{1+} + \text{N}_2$	Charge Transfer	3.00-10.00 keV	Ex	905
$\text{H}_3^{1+} + \text{N}_2$	Fluorescence	3.00-10.00 keV	Ex	905
$\text{H}_3^{1+} + \text{N}_2$	Excitation	3.00-10.00 keV	Ex	905
$\text{H}_3^{1+} + \text{N}_2\text{O}$	Dissociation	3.00-10.00 keV	Ex	905
$\text{H}_3^{1+} + \text{N}_2\text{O}$	Charge Transfer	3.00-10.00 keV	Ex	905
$\text{H}_3^{1+} + \text{N}_2\text{O}$	Fluorescence	3.00-10.00 keV	Ex	905
$\text{H}_3^{1+} + \text{N}_2\text{O}$	Excitation	3.00-10.00 keV	Ex	905
$\text{H}_3^{1+} + \text{O}_2$	Dissociation	3.00-10.00 keV	Ex	905
$\text{H}_3^{1+} + \text{O}_2$	Charge Transfer	3.00-10.00 keV	Ex	905
$\text{H}_3^{1+} + \text{O}_2$	Fluorescence	3.00-10.00 keV	Ex	905
$\text{H}_3^{1+} + \text{O}_2$	Excitation	3.00-10.00 keV	Ex	905
$\text{HD}^{1+} + \text{H}$	Dissociation	0.00-10.00 keV	E/T	1026
$\text{HD}^{1+} + \text{H}$	Charge Transfer	0.00-10.00 keV	E/T	1026
$\text{HD}^{1+} + \text{H}$	Interchange reaction	0.00-10.00 keV	E/T	1026
$\text{HD}^{1+} + \text{D}$	Dissociation	0.00-10.00 keV	E/T	1026
$\text{HD}^{1+} + \text{D}$	Charge Transfer	0.00-10.00 keV	E/T	1026
$\text{HD}^{1+} + \text{D}$	Interchange reaction	0.00-10.00 keV	E/T	1026
$\text{D} + \text{H}_2$	Interchange reaction	1.60 eV	Th	702
$\text{D} + \text{D}$	Heavy Particle Coll.		Ex	839
$\text{D} + \text{D}$	Association	0.05-10.00 eV	E/T	1027
$\text{D} + \text{D}$	Elastic Scattering		Ex	839
$\text{D} + \text{D}$	Ionization	0.05-10.00 eV	E/T	1027
$\text{D}^{1+} + \text{H}^{-1+}$	Association	0.10-1.00 K	Th	814
$\text{D}^{1+} + \text{H}^{-1+}$	Charge Transfer	0.10-1.00 K	Th	814
$\text{D}^{1+} + \text{H}^{-1+}$	Recombination	0.10-1.00 K	Th	814
$\text{D}^{1+} + \text{H}_2$	Dissociation	0.00-10.00 keV	E/T	1026
$\text{D}^{1+} + \text{H}_2$	Charge Transfer	0.00-10.00 keV	E/T	1026
$\text{D}^{1+} + \text{H}_2$	Interchange reaction	0.00-10.00 keV	E/T	1026
$\text{D}^{1+} + \text{HT}$	Dissociation	0.00-10.00 keV	E/T	1026
$\text{D}^{1+} + \text{HT}$	Charge Transfer	0.00-10.00 keV	E/T	1026
$\text{D}^{1+} + \text{HT}$	Interchange reaction	0.00-10.00 keV	E/T	1026
$\text{D}^{1+} + \text{D}^{-1+}$	Association	0.10-1.00 K	Th	814
$\text{D}^{1+} + \text{D}^{-1+}$	Charge Transfer	0.10-1.00 K	Th	814
$\text{D}^{1+} + \text{D}^{-1+}$	Recombination	0.10-1.00 K	Th	814
$\text{D}^{1+} + \text{D}_2$	Dissociation	0.00-10.00 keV	E/T	1026
$\text{D}^{1+} + \text{D}_2$	Charge Transfer	0.00-10.00 keV	E/T	1026
$\text{D}^{1+} + \text{D}_2$	Interchange reaction	0.00-10.00 keV	E/T	1026
$\text{D}^{1+} + \text{DT}$	Dissociation	0.00-10.00 keV	E/T	1026

$D^{1+} + DT$	Charge Transfer	0.00-10.00 keV	E/T	1026
$D^{1+} + DT$	Interchange reaction	0.00-10.00 keV	E/T	1026
$D^{1+} + T_2$	Dissociation	0.00-10.00 keV	E/T	1026
$D^{1+} + T_2$	Charge Transfer	0.00-10.00 keV	E/T	1026
$D^{1+} + T_2$	Interchange reaction	0.00-10.00 keV	E/T	1026
$D^{1+} + Li^{-1+}$	Association	0.10-1.00 K	Th	814
$D^{1+} + Li^{-1+}$	Charge Transfer	0.10-1.00 K	Th	814
$D^{1+} + Li^{-1+}$	Recombination	0.10-1.00 K	Th	814
$D^{1+} + O^{-1+}$	Association	0.05-10.00 eV	E/T	1027
$D^{1+} + O^{-1+}$	Ionization	0.05-10.00 eV	E/T	1027
$D_2 + OH$	Interchange reaction	0.50 eV	Th	704
$D_2^{1+} + H^{-1+}$	Association	0.05-10.00 eV	E/T	1027
$D_2^{1+} + H^{-1+}$	Ionization	0.05-10.00 eV	E/T	1027
$D_2^{1+} + H$	Dissociation	0.00-10.00 keV	E/T	1026
$D_2^{1+} + H$	Charge Transfer	0.00-10.00 keV	E/T	1026
$D_2^{1+} + H$	Interchange reaction	0.00-10.00 keV	E/T	1026
$D_2^{1+} + D^{-1+}$	Association	0.05-10.00 eV	E/T	1027
$D_2^{1+} + D^{-1+}$	Ionization	0.05-10.00 eV	E/T	1027
$D_2^{1+} + D$	Dissociation	0.00-10.00 keV	E/T	1026
$D_2^{1+} + D$	Charge Transfer	0.00-10.00 keV	E/T	1026
$D_2^{1+} + D$	Interchange reaction	0.00-10.00 keV	E/T	1026
$T^{1+} + H_2$	Dissociation	0.00-10.00 keV	E/T	1026
$T^{1+} + H_2$	Charge Transfer	0.00-10.00 keV	E/T	1026
$T^{1+} + H_2$	Interchange reaction	0.00-10.00 keV	E/T	1026
$T^{1+} + HT$	Dissociation	0.00-10.00 keV	E/T	1026
$T^{1+} + HT$	Charge Transfer	0.00-10.00 keV	E/T	1026
$T^{1+} + HT$	Interchange reaction	0.00-10.00 keV	E/T	1026
$T^{1+} + D_2$	Dissociation	0.00-10.00 keV	E/T	1026
$T^{1+} + D_2$	Charge Transfer	0.00-10.00 keV	E/T	1026
$T^{1+} + D_2$	Interchange reaction	0.00-10.00 keV	E/T	1026
$T^{1+} + DT$	Dissociation	0.00-10.00 keV	E/T	1026
$T^{1+} + DT$	Charge Transfer	0.00-10.00 keV	E/T	1026
$T^{1+} + DT$	Interchange reaction	0.00-10.00 keV	E/T	1026
$T^{1+} + T_2$	Dissociation	0.00-10.00 keV	E/T	1026
$T^{1+} + T_2$	Charge Transfer	0.00-10.00 keV	E/T	1026
$T^{1+} + T_2$	Interchange reaction	0.00-10.00 keV	E/T	1026
$H_{27}^{1+} + He$	Dissociation	60.00 keV/amu	Ex	850
$He + H^{-1+}$	Interaction Potentials	123.98 eV	Th	800
$He + H_2$	Energy Transfer	10^{-5} a.u.	Th	860
$He + He$	Association	300.00 K	Ex	719
$He + He$	De-excitation	300.00 K	Ex	719
$He + He^*$	Elastic Scattering	0.02 eV	Th	919
$He^* + He^*$	Elastic Scattering	1.00-500.00 mK	Th	873
$He + He$	Elastic Scattering	1.00-500.00 mK	Th	873
$He + He$	Elastic Scattering		Th	867
$He + He$	Energy Transfer	300.00 K	Ex	719
$He + He^*$	Interaction Potentials	0.02 eV	Th	919
$He^* + He^*$	Interaction Potentials	1.00-500.00 mK	Th	873
$He + He$	Interaction Potentials	1.00-500.00 mK	Th	873
$He + He^*$	Interaction Potentials		Th	836
$He + He$	Interaction Potentials		Th	836
$He + He$	Interaction Potentials	123.98 eV	Th	800
$He + He^*$	Excitation	0.02 eV	Th	919
$He^* + He^*$	Excitation	1.00-500.00 mK	Th	873
$He + He$	Excitation	1.00-500.00 mK	Th	873
$He + He$	Excitation	300.00 K	Ex	719
$He + Li$	Interaction Potentials	123.98 eV	Th	800

He + Li	Interaction Potentials		Th	718
He + CO	Excitation	0.00-0.07 eV	Th	687
He + O₂	Elastic Scattering	0.00-10.00 K	Th	924
He + O₂	Elastic Scattering	0.00-5.00 K	Th	910
He + O₂	Excitation	0.00-10.00 K	Th	924
He + O₂	Excitation	0.00-5.00 K	Th	910
He + Na	Interaction Potentials	123.98 eV	Th	800
He + Si₂⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex	865
He + Si₂⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex	865
He + Si₂⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex	865
He + Si₃⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex	865
He + Si₃⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex	865
He + Si₃⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex	865
He + Si₄⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex	865
He + Si₄⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex	865
He + Si₄⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex	865
He + C₂⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex	865
He + C₂⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex	865
He + C₂⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex	865
He + C₃⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex	865
He + C₃⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex	865
He + C₃⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex	865
He + He + He	Association	0.00-10.00 mK	Th	907
He + He + He	Association		Th	791
He + He + He	Interaction Potentials	0.00-10.00 mK	Th	907
He + He + He	Interaction Potentials		Th	791
He + C₄⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex	865
He + C₄⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex	865
He + C₄⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex	865
He¹⁺ + H⁻¹⁺	Association	0.05-10.00 eV	E/T	1027
He¹⁺ + H⁻¹⁺	Ionization	0.05-10.00 eV	E/T	1027
He¹⁺ + H	Ionization	0.50-3.50 MeV	Ex	841
He¹⁺ + H₂	Charge Transfer	0.25-0.50 a.u.	Ex	904
He¹⁺ + H₂	Total Scattering	0.25-0.50 a.u.	Ex	904
He¹⁺ + H₂	Ionization	0.25-0.50 a.u.	Ex	904
He¹⁺ + H₂	Ionization	0.50-3.50 MeV	Ex	841
He¹⁺ + D⁻¹⁺	Association	0.05-10.00 eV	E/T	1027
He¹⁺ + D⁻¹⁺	Ionization	0.05-10.00 eV	E/T	1027
He¹⁺ + D₂	Charge Transfer	0.25-0.50 a.u.	Ex	904
He¹⁺ + D₂	Total Scattering	0.25-0.50 a.u.	Ex	904
He¹⁺ + D₂	Ionization	0.25-0.50 a.u.	Ex	904
He¹⁺ + C	Elastic Scattering	2.00-4.80 MeV	Ex	829
He¹⁺ + C	Total Scattering	2.00-4.80 MeV	Ex	829
He¹⁺ + N	Elastic Scattering	7.50-9.80 MeV	Ex	833
He¹⁺ + N	Total Scattering	7.50-9.80 MeV	Ex	833
He¹⁺ + N₂	Dissociation	0.06-7.00 MeV	Ex	942
He¹⁺ + N₂	Dissociation	1.50-3.00 keV	Ex	765
He¹⁺ + N₂	Charge Transfer	1.50-3.00 keV	Ex	765
He¹⁺ + N₂	Charge Transfer	0.10 eV	Ex	700
He¹⁺ + N₂	Excitation	0.01-1.00 MeV/amu	Ex	690
He¹⁺ + N₂	Ionization	0.05-100.00 GeV/amu	Ex	989
He¹⁺ + N₂	Ionization	0.06-7.00 MeV	Ex	942
He¹⁺ + O₂	Dissociation	1.50-3.00 keV	Ex	765
He¹⁺ + O₂	Charge Transfer	1.50-3.00 keV	Ex	765
He¹⁺ + Ne	Excitation	0.01-1.00 MeV/amu	Ex	690
He¹⁺ + Ne	Ionization	0.00-10.00 MeV	E/T	916
He¹⁺ + Ne	Ionization	1.00-4.00 MeV	E/T	776

He¹⁺ + Ne	Ionization	1.00-4.00 MeV	E/T	776
He¹⁺ + Ar	De-excitation	6.60 keV	Ex	978
He^{1+*} + Ar	De-excitation	6.60 keV	Ex	978
He¹⁺ + Ar	Excitation	1.50-5.00 keV	E/T	745
He¹⁺ + Ar	Excitation	0.01-1.00 MeV/amu	Ex	690
He¹⁺ + Ar	Ionization	1.50-5.00 keV	E/T	745
He¹⁺ + Ni	Elastic Scattering	3.90-14.30 MeV	E/T	693
He¹⁺ + Ni	Total Scattering	3.90-14.30 MeV	E/T	693
He¹⁺ + Rb	Charge Transfer	0.01-10.00 keV/amu	Th	885
He¹⁺ + Rb	Excitation	0.01-10.00 keV/amu	Th	885
He¹⁺ + Xe	De-excitation	6.60 keV	Ex	978
He^{1+*} + Xe	De-excitation	6.60 keV	Ex	978
He¹⁺ + Ta	Ionization	20.00-80.00 MeV/amu	E/T	883
He¹⁺ + Pb	Ionization	20.00-80.00 MeV/amu	E/T	883
He¹⁺ + Th	Ionization	20.00-80.00 MeV/amu	E/T	883
He²⁺ + H[*]	Charge Transfer	10.00-100.00 keV	Th	994
He²⁺ + H	Charge Transfer	10.00-100.00 keV	Th	994
He²⁺ + H	Charge Transfer		Th	983
He²⁺ + H	Charge Transfer	0.00-2.50 MeV	Th	935
He²⁺ + H	Ionization		Th	983
He²⁺ + H	Ionization	64.00-225.00 keV/amu	Th	888
He²⁺ + H	Ionization	0.50-3.00 a.u.	Th	768
He²⁺ + H	Ionization	12.00 a.u.	Th	750
He²⁺ + H	Ionization	10.00 a.u.	Th	721
He²⁺ + H₂	Charge Transfer		Th	983
He²⁺ + H₂	Charge Transfer	0.81 a.u.	E/T	813
He²⁺ + H₂	Charge Transfer	25.00 keV/amu	Ex	792
He²⁺ + H₂	Total Scattering	25.00 keV/amu	Ex	792
He²⁺ + H₂	Ionization		Th	983
He²⁺ + H₂	Ionization	0.81 a.u.	E/T	813
He²⁺ + H₂	Ionization	25.00 keV/amu	Ex	792
He²⁺ + He	Charge Transfer	0.10-10.00 MeV	Th	941
He²⁺ + He	Charge Transfer	0.05-1.00 MeV/amu	E/T	913
He²⁺ + He	Charge Transfer	1.36-400.00 eV/amu	Th	861
He²⁺ + He	Charge Transfer	0.81 a.u.	E/T	813
He²⁺ + He	Charge Transfer	25.00 keV/amu	Ex	792
He²⁺ + He	Charge Transfer	100.00-300.00 keV	E/T	756
He²⁺ + He	Total Scattering	25.00 keV/amu	Ex	792
He²⁺ + He	Excitation	1.36-400.00 eV/amu	Th	861
He²⁺ + He	Ionization	0.81 a.u.	E/T	813
He²⁺ + He	Ionization	25.00 keV/amu	Ex	792
He²⁺ + He	Ionization	100.00-300.00 keV	E/T	756
He²⁺ + He¹⁺	Charge Transfer	1.80-14.80 keV	E/T	752
He²⁺ + Li	Total Scattering	0.20-95.00 MeV	Th	854
He²⁺ + Li	Ionization	0.20-95.00 MeV	Th	854
He²⁺ + B²⁺	Ionization	10.00-256.00 keV	Ex	1010
He²⁺ + B²⁺	Ionization	10.00-256.00 keV	Ex	1010
He²⁺ + CO	Dissociation	4.00-11.00 keV/amu	Ex	946
He²⁺ + CO	Dissociation	0.20-1.20 keV/amu	Ex	741
He²⁺ + CO	Charge Transfer	4.00-11.00 keV/amu	Ex	946
He²⁺ + CO	Charge Transfer	0.30-1.30 eV/amu	Ex	944
He²⁺ + CO	Charge Transfer	1.00 keV/amu	Ex	943
He²⁺ + CO	Charge Transfer	1.00-14.00 keV	Ex	796
He²⁺ + CO	Charge Transfer	14.00-70.00 keV	Ex	774
He²⁺ + CO	Charge Transfer	0.20-1.20 keV/amu	Ex	741
He²⁺ + CO	Ionization	14.00-70.00 keV	Ex	774
He²⁺ + N⁴⁺	Charge Transfer	8.00-200.00 keV	Ex	950

He²⁺ + N⁴⁺	Charge Transfer	8.00-200.00 keV	E/T	782
He²⁺ + N⁴⁺	Total Scattering	8.00-200.00 keV	E/T	782
He²⁺ + N₂	Charge Transfer	0.30-1.30 eV/amu	Ex	944
He²⁺ + N₂	Charge Transfer	1.00 keV/amu	Ex	943
He²⁺ + O⁵⁺	Charge Transfer	8.00-200.00 keV	Ex	950
He²⁺ + O₂	Dissociation	0.10-1.00 keV	Ex	920
He²⁺ + O₂	Charge Transfer	0.30-1.30 eV/amu	Ex	944
He²⁺ + O₂	Charge Transfer	1.00 keV/amu	Ex	943
He²⁺ + O₂	Charge Transfer	0.10-1.00 keV	Ex	920
He²⁺ + Ne	Charge Transfer	0.30-1.30 eV/amu	Ex	944
He²⁺ + Ne	Excitation	0.01-1.00 MeV/amu	Ex	690
He²⁺ + Ba	Charge Transfer	20.00-40.00 keV	Ex	882
He²⁺ + Ba	Excitation	20.00-40.00 keV	Ex	882
He²⁺ + Pb	Ionization	20.00-80.00 MeV/amu	E/T	883
He²⁺ + C₆₀	Dissociation	0.20-0.25 a.u.	E/T	849
He₂ + H⁻¹⁺	Interaction Potentials	123.98 eV	Th	800
He₂ + Li	Interaction Potentials	123.98 eV	Th	800
He₂ + Na	Interaction Potentials	123.98 eV	Th	800
HeH¹⁺ + He	Dissociation	5.00-400.00 keV	Ex	915
HeH¹⁺ + He	Excitation	5.00-400.00 keV	Ex	915
Li + H	Interaction Potentials		Th	760
Li* + He	Interaction Potentials	720.00 K	E/T	809
Li + He	Interaction Potentials	720.00 K	E/T	809
Li + He	Interaction Potentials	0.50-0.99 eV	Th	725
Li* + He	Fluorescence	720.00 K	E/T	809
Li + He	Fluorescence	720.00 K	E/T	809
Li* + Li	Energy Transfer		E/T	688
Li + Li	Energy Transfer		E/T	688
Li + Cd	Excitation	965.00 K	Ex	730
Li¹⁺ + H⁻¹⁺	Association	0.10-1.00 K	Th	814
Li¹⁺ + H⁻¹⁺	Charge Transfer	0.10-1.00 K	Th	814
Li¹⁺ + H⁻¹⁺	Recombination	0.10-1.00 K	Th	814
Li¹⁺ + H₂	Charge Transfer		Th	948
Li¹⁺ + D⁻¹⁺	Association	0.10-1.00 K	Th	814
Li¹⁺ + D⁻¹⁺	Charge Transfer	0.10-1.00 K	Th	814
Li¹⁺ + D⁻¹⁺	Recombination	0.10-1.00 K	Th	814
Li¹⁺ + He	Ionization	1.00-16.00 MeV	Th	1009
Li¹⁺ + B⁵⁺	Charge Transfer	0.01-50.00 keV/amu	Th	1014
Li¹⁺ + B⁵⁺	Excitation	0.01-50.00 keV/amu	Th	1014
Li¹⁺ + C⁶⁺	Charge Transfer	0.01-50.00 keV/amu	Th	1014
Li¹⁺ + C⁶⁺	Excitation	0.01-50.00 keV/amu	Th	1014
Li¹⁺ + N⁵⁺	Charge Transfer	0.01-50.00 keV/amu	Th	1014
Li¹⁺ + N⁵⁺	Excitation	0.01-50.00 keV/amu	Th	1014
Li¹⁺ + O⁶⁺	Charge Transfer	0.01-50.00 keV/amu	Th	1014
Li¹⁺ + O⁶⁺	Charge Transfer	0.01-50.00 keV/amu	Th	1014
Li¹⁺ + O⁶⁺	Excitation	0.01-50.00 keV/amu	Th	1014
Li¹⁺ + Na	Charge Transfer	1.00 keV	E/T	789
Li¹⁺ + Na	Charge Transfer	0.10-0.40 a.u.	E/T	788
Li¹⁺ + Na	Total Scattering	1.00 keV	E/T	789
Li²⁺ + He	Charge Transfer	0.05-1.00 MeV/amu	E/T	913
Li²⁺ + He	Ionization	1.00-16.00 MeV	Th	1009
Li²⁺ + Be¹⁺	Charge Transfer	0.01-50.00 keV/amu	Th	1014
Li²⁺ + Be¹⁺	Excitation	0.01-50.00 keV/amu	Th	1014
Li³⁺ + H*	Charge Transfer	10.00-100.00 keV	Th	994
Li³⁺ + H	Charge Transfer	10.00-100.00 keV	Th	994
Li³⁺ + H	Charge Transfer		Th	983
Li³⁺ + H	Ionization		Th	983

Li³⁺ + H₂	Charge Transfer		Th	983
Li³⁺ + H₂	Ionization		Th	983
Li³⁺ + He	Charge Transfer	0.05-1.00 MeV/amu	E/T	913
Li³⁺ + He	Charge Transfer	0.05-5.00 MeV/amu	Th	855
Li³⁺ + He	Excitation	1.50 MeV/amu	Th	982
Li³⁺ + He	Ionization	0.05-5.00 MeV/amu	Th	855
Be + Be	Interaction Potentials		Th	887
Be + Be	Interaction Potentials		Th	886
Be²⁺ + He	Charge Transfer	0.05-1.00 MeV/amu	E/T	913
Be⁴⁺ + H	Charge Transfer	31.00-151.00 a.u.	Th	798
Be⁴⁺ + H	Charge Transfer	15.00-30.00 a.u.	Th	739
Be⁴⁺ + He	Excitation	1.50 MeV/amu	Th	982
B + H	Interaction Potentials		Th	760
B + Cl	Interaction Potentials	0.40 a ₀	Th	744
B¹⁺ + He	Charge Transfer	0.03-20.00 keV/amu	Th	1008
B¹⁺ + He	Excitation	0.03-20.00 keV/amu	Th	1008
B^{2+*} + H₂	Charge Transfer	4.00 MeV	Ex	892
B²⁺ + H₂	Charge Transfer	4.00 MeV	Ex	892
B^{2+*} + H₂	Excitation	4.00 MeV	Ex	892
B^{2+*} + H₂	Excitation	4.00 MeV	Ex	892
B²⁺ + H₂	Excitation	4.00 MeV	Ex	892
B²⁺ + He	Charge Transfer	0.03-20.00 keV/amu	Th	1008
B²⁺ + He	Charge Transfer	0.05-1.00 MeV/amu	E/T	913
B²⁺ + He	Excitation	0.03-20.00 keV/amu	Th	1008
B^{2+*} + B²⁺	Excitation	4.00 MeV	Ex	892
B²⁺ + C₆₀	Dissociation	0.20-0.25 a.u.	E/T	849
B³⁺ + H₂	Charge Transfer	0.85-9.00 MeV	E/T	878
B³⁺ + H₂	Ionization	4.00-4.50 MeV	Ex	923
B³⁺ + He	Charge Transfer	0.03-20.00 keV/amu	Th	1008
B³⁺ + He	Charge Transfer	0.85-9.00 MeV	E/T	878
B³⁺ + He	Excitation	0.03-20.00 keV/amu	Th	1008
B³⁺ + N₂	Excitation	0.85-9.00 MeV	E/T	878
B³⁺ + C₆₀	Dissociation	0.20-0.25 a.u.	E/T	849
B⁴⁺ + He	Charge Transfer	0.03-20.00 keV/amu	Th	1008
B⁴⁺ + He	Excitation	0.03-20.00 keV/amu	Th	1008
B⁵⁺ + He	Charge Transfer	0.03-20.00 keV/amu	Th	1008
B⁵⁺ + He	Excitation	0.03-20.00 keV/amu	Th	1008
B⁵⁺ + He	Excitation	1.50 MeV/amu	Th	982
C* + H₂	Interchange reaction	12.00 kcal/mol	Th	698
C + H₂	Interchange reaction	12.00 kcal/mol	Th	698
C + He	Ionization	0.10-0.15 MeV/amu	Th	755
C + He	Ionization	0.10-0.15 MeV/amu	Th	755
C + OH₂¹⁺	Interaction Potentials		Th	835
C¹⁺ + H	Charge Transfer	10.00-200.00 keV/amu	E/T	763
C¹⁺ + H	Ionization	10.00-200.00 keV/amu	E/T	763
C¹⁺ + D⁻¹⁺	Association	0.05-10.00 eV	E/T	1027
C¹⁺ + D⁻¹⁺	Ionization	0.05-10.00 eV	E/T	1027
C¹⁺ + He	Ionization	150.00 keV/amu	Ex	958
C¹⁺ + C	Ionization	16.00-70.00 MeV	Ex	821
C¹⁺ + O⁻¹⁺	Association	0.05-10.00 eV	E/T	1027
C¹⁺ + O⁻¹⁺	Ionization	0.05-10.00 eV	E/T	1027
C¹⁺ + Ne	Ionization	0.02-2.00 keV	E/T	1017
C¹⁺ + Ne	Ionization	0.02-2.00 keV	E/T	1017
C¹⁺ + Ne	Ionization	150.00 keV/amu	Ex	958
C¹⁺ + Xe	Ionization	150.00-233.00 keV/amu	Ex	933
C¹⁺ + Au	Ionization	16.00-70.00 MeV	Ex	821
C¹⁺ + perturbation	Ionization	16.00-70.00 MeV	Ex	821

$C^{2+} + H$	Charge Transfer	1.50-6.00 keV	Ex	1020
$C^{2+} + H$	Charge Transfer	0.50-20.00 keV	Th	1005
$C^{2+} + H$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$C^{2+} + H$	Ionization	10.00-200.00 keV/amu	E/T	763
$C^{2+} + H_2$	Charge Transfer	0.50-20.00 keV	Th	1005
$C^{2+} + H_2$	Charge Transfer	0.00-1.00 MeV/amu	Ex	998
$C^{2+} + H_2$	Charge Transfer	0.20-20.00 keV	Ex	991
$C^{2+} + H_2$	Charge Transfer	0.05-2.50 keV/amu	Th	947
$C^{2+} + H_2$	Charge Transfer	4.00 keV	Ex	938
$C^{2+} + H_2$	Excitation	0.20-20.00 keV	Ex	991
$C^{2+} + He$	Charge Transfer	0.00-1.00 MeV/amu	Ex	998
$C^{2+} + He$	Charge Transfer	4.00 keV	Ex	938
$C^{2+} + He$	Charge Transfer	0.05-1.00 MeV/amu	E/T	913
$C^{2+} + Li$	Charge Transfer	18.00-27.00 keV	Ex	1007
$C^{2+} + Li$	Excitation	18.00-27.00 keV	Ex	1007
$C^{2+} + Au$	Excitation	4.00-12.00 MeV	E/T	822
$C^{2+} + Au$	Ionization	4.00-12.00 MeV	E/T	822
$C^{2+} + Pb$	Excitation	4.00-12.00 MeV	E/T	822
$C^{2+} + Pb$	Ionization	4.00-12.00 MeV	E/T	822
$C^{2+} + C_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$C^{3+} + H$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$C^{3+} + H$	Ionization	0.50-3.50 MeV	Ex	841
$C^{3+} + H$	Ionization	10.00-200.00 keV/amu	E/T	763
$C^{3+} + H_2$	Charge Transfer	0.00-1.00 MeV/amu	Ex	998
$C^{3+} + H_2$	Charge Transfer	0.05-2.50 keV/amu	Th	947
$C^{3+} + H_2$	Ionization	0.50-3.50 MeV	Ex	841
$C^{3+} + He$	Charge Transfer	0.00-1.00 MeV/amu	Ex	998
$C^{3+} + He$	Excitation	0.50-2.00 MeV/amu	Ex	995
$C^{3+} + He$	Ionization	0.50-2.00 MeV/amu	Ex	995
$C^{3+} + He^{2+}$	Charge Transfer	1.00-100.00 keV	Th	953
$C^{3+} + He^{2+}$	Excitation	1.00-100.00 keV	Th	953
$C^{3+} + He^{2+}$	Ionization	1.00-100.00 keV	Th	953
$C^{3+} + Ta$	Ionization	20.00-80.00 MeV/amu	E/T	883
$C^{3+} + Au$	Excitation	4.00-12.00 MeV	E/T	822
$C^{3+} + Au$	Ionization	4.00-12.00 MeV	E/T	822
$C^{3+} + Pb$	Excitation	4.00-12.00 MeV	E/T	822
$C^{3+} + Pb$	Ionization	20.00-80.00 MeV/amu	E/T	883
$C^{3+} + Pb$	Ionization	4.00-12.00 MeV	E/T	822
$C^{3+} + Th$	Ionization	20.00-80.00 MeV/amu	E/T	883
$C^{3+} + perturbation$	Ionization	3.00 MeV	Th	977
$C^{3+} + C_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$C^{4+} + H$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$C^{4+} + H$	Ionization	10.00-200.00 keV/amu	E/T	763
$C^{4+*} + H_2$	De-excitation	0.50-1.10 MeV/amu	E/T	903
$C^{4+} + H_2$	De-excitation	0.50-1.10 MeV/amu	E/T	903
$C^{4+} + H_2$	Charge Transfer	0.05-60.00 keV/amu	Th	1006
$C^{4+} + H_2$	Charge Transfer	0.00-1.00 MeV/amu	Ex	998
$C^{4+} + H_2$	Charge Transfer	0.05-2.50 keV/amu	Th	947
$C^{4+*} + H_2$	Total Scattering	0.50-1.10 MeV/amu	E/T	903
$C^{4+} + H_2$	Total Scattering	0.50-1.10 MeV/amu	E/T	903
$C^{4+} + He$	Charge Transfer	270.00-470.00 eV	Ex	999
$C^{4+} + He$	Charge Transfer	0.00-1.00 MeV/amu	Ex	998
$C^{4+} + He$	Excitation	1.50-6.00 MeV/amu	Th	960
$C^{4+} + Ne$	Charge Transfer	0.02-2.00 MeV/amu	Th	856
$C^{4+} + Ne$	Ionization	0.02-2.00 MeV/amu	Th	856
$C^{4+} + Au$	Excitation	4.00-12.00 MeV	E/T	822
$C^{4+} + Au$	Ionization	4.00-12.00 MeV	E/T	822

$C^{4+} + Pb$	Excitation	4.00-12.00 MeV	E/T	822
$C^{4+} + Pb$	Ionization	4.00-12.00 MeV	E/T	822
$C^{5+} + H$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$C^{5+} + H$	Ionization	10.00-200.00 keV/amu	E/T	763
$C^{5+} + H_2$	Ionization	6.70-21.80 MeV	Ex	996
$C^{5+} + He$	Charge Transfer	0.50-50.00 keV/amu	Ex	967
$C^{5+} + He$	Excitation	1.50-6.00 MeV/amu	Th	960
$C^{5+} + He$	Ionization	0.05-100.00 GeV/amu	Ex	989
$C^{6+} + H$	Charge Transfer		Th	983
$C^{6+} + H$	Ionization		Th	983
$C^{6+} + H$	Ionization	2.50 MeV/amu	Ex	956
$C^{6+} + H_2$	Dissociation	0.00-1.00 MeV/amu	Th	936
$C^{6+} + H_2$	Charge Transfer		Th	983
$C^{6+} + H_2$	Charge Transfer	0.00-1.00 MeV/amu	Th	936
$C^{6+} + H_2$	Ionization		Th	983
$C^{6+} + HD$	Dissociation	0.00-1.00 MeV/amu	Th	936
$C^{6+} + HD$	Charge Transfer	0.00-1.00 MeV/amu	Th	936
$C^{6+} + H_2O$	Charge Transfer		Th	990
$C^{6+} + He$	Total Scattering	100.00 MeV/amu	Th	802
$C^{6+} + He^*$	Total Scattering	100.00 MeV/amu	Th	802
$C^{6+} + He$	Excitation	1.50 MeV/amu	Th	982
$C^{6+} + He$	Excitation	1.50-6.00 MeV/amu	Th	960
$C^{6+} + He$	Ionization	0.00-1.00 GeV/amu	Th	987
$C^{6+} + He$	Ionization		Th	963
$C^{6+} + He$	Ionization	100.00 MeV/amu	Ex	961
$C^{6+} + He$	Ionization	100.00 MeV/amu	Th	802
$C^{6+} + He^*$	Ionization	100.00 MeV/amu	Th	802
$C^{6+} + He$	Ionization	3.60-100.00 MeV/amu	Th	779
$C^{6+} + He$	Ionization	100.00 MeV/amu	E/T	772
$C^{6+} + He$	Ionization	100.00 MeV/amu	Th	762
$C^{6+} + Rb$	Charge Transfer		Ex	1019
$C^{6+} + Pb$	Ionization	20.00-80.00 MeV/amu	E/T	883
$CO + H_2$	Energy Transfer	6.00-100.00 K	Th	731
$CO + H_2$	Excitation	6.00-100.00 K	Th	731
$N^{1+} + H$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$N^{1+} + H$	Ionization	10.00-200.00 keV/amu	E/T	763
$N^{1+} + O^{-1+}$	Association	0.05-10.00 eV	E/T	1027
$N^{1+} + O^{-1+}$	Ionization	0.05-10.00 eV	E/T	1027
$N^{2+} + H$	Charge Transfer	1.50-6.00 keV	Ex	1020
$N^{2+} + H$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$N^{2+} + H$	Charge Transfer	0.80-6.00 keV	Ex	711
$N^{2+} + H$	Ionization	10.00-200.00 keV/amu	E/T	763
$N^{2+} + H_2$	Charge Transfer	4.00 keV	Ex	938
$N^{2+} + He$	Charge Transfer	4.00 keV	Ex	938
$N^{2+} + C_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$N^{3+} + H$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$N^{3+} + H$	Ionization	10.00-200.00 keV/amu	E/T	763
$N^{3+} + Li$	Charge Transfer	18.00-27.00 keV	Ex	1007
$N^{3+} + Li$	Excitation	18.00-27.00 keV	Ex	1007
$N^{3+} + C_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$N^{4+} + H$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$N^{4+} + H$	Ionization	10.00-200.00 keV/amu	E/T	763
$N^{4+} + H_2O$	Charge Transfer		Th	990
$N^{4+} + He$	Charge Transfer	1.00-50.00 keV	Th	875
$N^{4+} + He^{2+}$	Charge Transfer	1.00-100.00 keV	Th	953
$N^{4+} + He^{2+}$	Excitation	1.00-100.00 keV	Th	953
$N^{4+} + He^{2+}$	Ionization	1.00-100.00 keV	Th	953

$\text{N}^{4+} + \text{Li}$	Charge Transfer	18.00-27.00 keV	Ex	1007
$\text{N}^{4+} + \text{Li}$	Excitation	18.00-27.00 keV	Ex	1007
$\text{N}^{5+} + \text{H}$	Charge Transfer	0.00-0.05 eV/amu	Th	1013
$\text{N}^{5+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$\text{N}^{5+} + \text{H}$	Ionization	10.00-200.00 keV/amu	E/T	763
$\text{N}^{5+} + \text{H}_2$	Charge Transfer	0.05-60.00 keV/amu	Th	1006
$\text{N}^{5+} + \text{H}_2$	Charge Transfer		Th	948
$\text{N}^{6+} + \text{H}_2$	Ionization	6.70-21.80 MeV	Ex	996
$\text{N}^{7+} + \text{H}_2\text{O}$	Charge Transfer		Th	990
$\text{N}^{7+} + \text{He}$	Excitation	1.50 MeV/amu	Th	982
$\text{N}^{7+} + \text{Li}$	Total Scattering	0.20-95.00 MeV	Th	854
$\text{N}^{7+} + \text{Li}$	Excitation	10.00-95.00 MeV/amu	Ex	970
$\text{N}^{7+} + \text{Li}$	Ionization	10.00-95.00 MeV/amu	Ex	970
$\text{N}^{7+} + \text{Li}$	Ionization	0.20-95.00 MeV	Th	854
$\text{N}^{7+} + \text{Ne}$	Charge Transfer	105.00 keV	Ex	858
$\text{N}^{7+} + \text{Ne}$	Ionization	105.00 keV	Ex	858
$\text{N}^{7+} + \text{Ar}$	Charge Transfer	70.00 keV	Ex	939
$\text{N}^{7+} + \text{Ti}$	Ionization	50.00-500.00 MeV	Th	979
$\text{N}_2 + \text{N}$	Elastic Scattering	0.10-10.00 K	Th	876
$\text{N}_2 + \text{N}$	Interaction Potentials	0.10-10.00 K	Th	876
$\text{N}_2 + \text{NO}$	Line Broadening	163.00-299.00 K	Th	847
$\text{N}_2^{1+} + \text{N}_2$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{N}_2^{1+} + \text{Ne}$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{N}_2^{1+} + \text{Ar}$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{NO}^{1+} + \text{He}$	Elastic Scattering	300.00 K	Th	844
$\text{NO}^{1+} + \text{He}$	Excitation	300.00 K	Th	844
$\text{O} + \text{H}_2$	Interchange reaction	0.50 eV	Th	705
$\text{O} + \text{O}$	Interaction Potentials	22.70-24.80 eV	E/T	837
$\text{O} + \text{O}^{1+}$	Interaction Potentials	22.70-24.80 eV	E/T	837
$\text{O} + \text{OH}_2^{1+}$	Interaction Potentials		Th	835
$\text{O}^{1+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$\text{O}^{1+} + \text{H}$	Charge Transfer	5.00-500.00 keV/amu	Th	732
$\text{O}^{1+} + \text{H}$	Ionization	10.00-200.00 keV/amu	E/T	763
$\text{O}^{1+} + \text{H}_2$	Charge Transfer	0.20-4.50 keV	E/T	754
$\text{O}^{1+} + \text{H}_2\text{O}$	Charge Transfer	0.50-5.00 keV	Ex	723
$\text{O}^{1+} + \text{D}^{-1+}$	Association	0.05-10.00 eV	E/T	1027
$\text{O}^{1+} + \text{D}^{-1+}$	Ionization	0.05-10.00 eV	E/T	1027
$\text{O}^{1+} + \text{CH}_4$	Charge Transfer	0.20-4.50 keV	E/T	754
$\text{O}^{1+} + \text{CO}$	Charge Transfer	0.20-4.50 keV	E/T	754
$\text{O}^{1+} + \text{CO}$	Charge Transfer	0.50-5.00 keV	Ex	723
$\text{O}^{1+} + \text{CO}_2$	Charge Transfer	0.20-4.50 keV	E/T	754
$\text{O}^{1+} + \text{C}_2\text{H}_2$	Charge Transfer	0.20-4.50 keV	E/T	754
$\text{O}^{1+} + \text{O}^{-1+}$	Association	0.05-10.00 eV	E/T	1027
$\text{O}^{1+} + \text{O}^{-1+}$	Ionization	0.05-10.00 eV	E/T	1027
$\text{O}^{1+} + \text{C}_2\text{H}_6$	Charge Transfer	0.20-4.50 keV	E/T	754
$\text{O}^{1+} + \text{C}_3\text{H}_8$	Charge Transfer	0.20-4.50 keV	E/T	754
$\text{O}^{2+} + \text{H}$	Charge Transfer	1.50-6.00 keV	Ex	1020
$\text{O}^{2+} + \text{H}$	Charge Transfer	0.50-20.00 keV	Th	1005
$\text{O}^{2+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$\text{O}^{2+} + \text{H}$	Ionization	10.00-200.00 keV/amu	E/T	763
$\text{O}^{2+} + \text{H}_2$	Charge Transfer	0.50-20.00 keV	Th	1005
$\text{O}^{2+} + \text{H}_2$	Charge Transfer	4.00 keV	Ex	938
$\text{O}^{2+} + \text{H}_2$	Charge Transfer	188.00-304.00 eV/amu	Ex	846
$\text{O}^{2+} + \text{He}$	Charge Transfer	4.00 keV	Ex	965
$\text{O}^{2+} + \text{He}$	Charge Transfer	4.00 keV	Ex	938
$\text{O}^{2+} + \text{He}$	Charge Transfer	0.05-1.00 MeV/amu	E/T	913
$\text{O}^{2+} + \text{CO}$	Charge Transfer	188.00-304.00 eV/amu	Ex	846

$O^{2+} + Ne$	Charge Transfer	4.00 keV	Ex	965
$O^{2+} + Ar$	Charge Transfer	4.00 keV	Ex	965
$O^{2+} + C_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$O^{3+} + H$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$O^{3+} + H$	Ionization	10.00-200.00 keV/amu	E/T	763
$O^{3+} + H_2$	Charge Transfer	188.00-304.00 eV/amu	Ex	846
$O^{3+} + Li$	Charge Transfer	18.00-27.00 keV	Ex	1007
$O^{3+} + Li$	Excitation	18.00-27.00 keV	Ex	1007
$O^{3+} + CO$	Charge Transfer	188.00-304.00 eV/amu	Ex	846
$O^{3+} + C_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$O^{4+} + H$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$O^{4+} + H$	Ionization	10.00-200.00 keV/amu	E/T	763
$O^{4+} + CO$	Charge Transfer	6.80-8.50 keV	Ex	685
$O^{4+} + Ta$	Ionization	20.00-80.00 MeV/amu	E/T	883
$O^{4+} + Pb$	Ionization	20.00-80.00 MeV/amu	E/T	883
$O^{4+} + Th$	Ionization	20.00-80.00 MeV/amu	E/T	883
$O^{5+} + H$	Charge Transfer	10.00-200.00 keV/amu	E/T	763
$O^{5+} + H$	Ionization	10.00-200.00 keV/amu	E/T	763
$O^{5+} + H_2$	Dissociation	0.50-105.00 keV	E/T	784
$O^{5+} + H_2$	Charge Transfer	0.50-105.00 keV	E/T	784
$O^{5+} + H_2O$	Charge Transfer		Th	990
$O^{5+} + CO$	Charge Transfer	6.80-8.50 keV	Ex	685
$O^{5+} + \text{perturbation}$	Ionization	3.00 MeV	Th	977
$O^{6+*} + H_2$	De-excitation	0.50-1.10 MeV/amu	E/T	903
$O^{6+} + H_2$	De-excitation	0.50-1.10 MeV/amu	E/T	903
$O^{6+} + H_2$	Charge Transfer	60.00-120.00 keV	Ex	968
$O^{6+*} + H_2$	Total Scattering	0.50-1.10 MeV/amu	E/T	903
$O^{6+} + H_2$	Total Scattering	0.50-1.10 MeV/amu	E/T	903
$O^{6+} + H_2$	Excitation	60.00-120.00 keV	Ex	968
$O^{6+} + He$	Charge Transfer	60.00-120.00 keV	Ex	968
$O^{6+} + He$	Excitation	60.00-120.00 keV	Ex	968
$O^{6+} + N_2$	Charge Transfer	60.00-120.00 keV	Ex	968
$O^{6+} + N_2$	Excitation	60.00-120.00 keV	Ex	968
$O^{6+} + O_2$	Charge Transfer	60.00-120.00 keV	Ex	968
$O^{6+} + O_2$	Excitation	60.00-120.00 keV	Ex	968
$O^{6+} + Ne$	Charge Transfer	60.00-120.00 keV	Ex	968
$O^{6+} + Ne$	Excitation	60.00-120.00 keV	Ex	968
$O^{6+} + Ar$	Charge Transfer	60.00-120.00 keV	Ex	968
$O^{6+} + Ar$	Excitation	60.00-120.00 keV	Ex	968
$O^{6+} + Kr$	Charge Transfer	60.00-120.00 keV	Ex	968
$O^{6+} + Kr$	Excitation	60.00-120.00 keV	Ex	968
$O^{6+} + Xe$	Charge Transfer	60.00-120.00 keV	Ex	968
$O^{6+} + Xe$	Excitation	60.00-120.00 keV	Ex	968
$O^{7+} + H_2$	Ionization	6.70-21.80 MeV	Ex	996
$O^{7+} + H_2O$	Charge Transfer		Th	990
$O^{7+} + C$	Ionization	24.00-60.00 MeV	E/T	971
$O^{7+} + CO$	Dissociation	4.00-11.00 keV/amu	Ex	946
$O^{7+} + CO$	Charge Transfer	4.00-11.00 keV/amu	Ex	946
$O^{7+} + CO$	Charge Transfer	14.00-70.00 keV	Ex	774
$O^{7+} + CO$	Ionization	14.00-70.00 keV	Ex	774
$O^{8+} + H_2O$	Charge Transfer		Th	990
$O^{8+} + He$	Excitation	1.50 MeV/amu	Th	982
$O^{8+} + Pb$	Ionization	20.00-80.00 MeV/amu	E/T	883
$O_2 + NO$	Line Broadening	163.00-299.00 K	Th	847
$O_2 + O$	Elastic Scattering	0.10-10.00 K	Th	876
$O_2 + O$	Interaction Potentials	0.10-10.00 K	Th	876
$O_2 + O_2$	Elastic Scattering	1.00 K	Th	879

$\text{O}_2 + \text{O}_2$	Interaction Potentials	1.00 K	Th	879
$\text{O}_2 + \text{O}_2$	Excitation	1.00 K	Th	879
$\text{F} + \text{H}$	Interaction Potentials		Th	760
$\text{F} + \text{H}_2$	Association	0.00-0.30 eV	Th	794
$\text{F} + \text{D}_2$	Association	0.00-0.30 eV	Th	794
$\text{F}^{2+} + \text{C}_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$\text{F}^{3+} + \text{C}_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$\text{F}^{7+*} + \text{H}_2$	De-excitation	0.50-1.10 MeV/amu	E/T	903
$\text{F}^{7+} + \text{H}_2$	De-excitation	0.50-1.10 MeV/amu	E/T	903
$\text{F}^{7+*} + \text{H}_2$	Total Scattering	0.50-1.10 MeV/amu	E/T	903
$\text{F}^{7+} + \text{H}_2$	Total Scattering	0.50-1.10 MeV/amu	E/T	903
$\text{F}^{7+} + \text{He}$	Excitation	1.50-6.00 MeV/amu	Th	960
$\text{F}^{7+} + \text{Ar}$	Charge Transfer	70.00 keV	Ex	939
$\text{F}^{8+} + \text{H}_2$	Ionization	6.70-21.80 MeV	Ex	996
$\text{F}^{8+} + \text{He}$	Excitation	1.50-6.00 MeV/amu	Th	960
$\text{F}^{8+} + \text{C}$	Ionization	24.00-60.00 MeV	E/T	971
$\text{F}^{8+} + \text{Ne}$	Charge Transfer	0.75-1.10 MeV/amu	Ex	1003
$\text{F}^{9+} + \text{He}$	Excitation	1.50 MeV/amu	Th	982
$\text{F}^{9+} + \text{He}$	Excitation	1.50-6.00 MeV/amu	Th	960
$\text{F}^{9+} + \text{He}$	Ionization	0.35-1.50 MeV/amu	Ex	955
$\text{F}^{9+} + \text{Ne}$	Ionization	1.00 MeV/amu	Th	981
$\text{F}^{9+} + \text{Ne}$	Ionization	0.35-1.50 MeV/amu	Ex	955
$\text{F}^{9+} + \text{Ar}$	Ionization	0.35-1.50 MeV/amu	Ex	955
$\text{Ne} + \text{He}$	Ionization	0.10-0.15 MeV/amu	Th	755
$\text{Ne} + \text{He}$	Ionization	0.10-0.15 MeV/amu	Th	755
$\text{Ne} + \text{Ne}$	Energy Transfer	1.00-10.00 Torr	Ex	722
$\text{Ne} + \text{Si}_2^{-1+}$	Dissociation	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{Si}_2^{-1+}$	Detachment	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{Si}_2^{-1+}$	Ionization	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{Si}_3^{-1+}$	Dissociation	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{Si}_3^{-1+}$	Detachment	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{Si}_3^{-1+}$	Ionization	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{Si}_4^{-1+}$	Dissociation	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{Si}_4^{-1+}$	Detachment	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{Si}_4^{-1+}$	Ionization	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{Ar}$	Association	0.01-1.00 keV	Th	757
$\text{Ne}^* + \text{Ar}$	Association	0.01-1.00 keV	Th	757
$\text{Ne} + \text{Ar}$	Ionization	0.01-1.00 keV	Th	757
$\text{Ne}^* + \text{Ar}$	Ionization	0.01-1.00 keV	Th	757
$\text{Ne} + \text{C}_2^{-1+}$	Dissociation	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{C}_2^{-1+}$	Detachment	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{C}_2^{-1+}$	Ionization	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{C}_3^{-1+}$	Dissociation	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{C}_3^{-1+}$	Detachment	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{C}_3^{-1+}$	Ionization	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{C}_4^{-1+}$	Dissociation	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{C}_4^{-1+}$	Detachment	0.10-1.20 a.u.	Ex	865
$\text{Ne} + \text{C}_4^{-1+}$	Ionization	0.10-1.20 a.u.	Ex	865
$\text{Ne}^{1+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Ne}^{1+} + \text{N}_2$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{Ne}^{1+} + \text{Ne}$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{Ne}^{1+} + \text{Ar}$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{Ne}^{2+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Ne}^{2+} + \text{Ne}^{1+}$	Charge Transfer	1.80-14.80 keV	E/T	752
$\text{Ne}^{2+} + \text{C}_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$\text{Ne}^{3+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Ne}^{3+} + \text{N}_2$	Charge Transfer	4.75-6.00 keV/amu	Ex	964

$\text{Ne}^{3+} + \text{O}_2$	Charge Transfer	4.75-6.00 keV/amu	Ex	964
$\text{Ne}^{3+} + \text{C}_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$\text{Ne}^{4+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Ne}^{4+} + \text{N}_2$	Charge Transfer	4.75-6.00 keV/amu	Ex	964
$\text{Ne}^{4+} + \text{O}_2$	Charge Transfer	4.75-6.00 keV/amu	Ex	964
$\text{Ne}^{5+} + \text{Ta}$	Ionization	20.00-80.00 MeV/amu	E/T	883
$\text{Ne}^{5+} + \text{Pb}$	Ionization	20.00-80.00 MeV/amu	E/T	883
$\text{Ne}^{5+} + \text{Th}$	Ionization	20.00-80.00 MeV/amu	E/T	883
$\text{Ne}^{7+} + \text{He}$	Charge Transfer	56.00-72.00 keV	E/T	785
$\text{Ne}^{8+} + \text{He}$	Charge Transfer	80.00 keV	Ex	925
$\text{Ne}^{8+} + \text{He}$	Charge Transfer	56.00-72.00 keV	E/T	785
$\text{Ne}^{8+} + \text{He}$	Charge Transfer	80.00 keV	Ex	738
$\text{Ne}^{8+} + \text{Ne}$	Charge Transfer	80.00 keV	Ex	738
$\text{Ne}^{8+} + \text{Ar}$	Charge Transfer	80.00 keV	Ex	738
$\text{Ne}^{9+} + \text{H}_2\text{O}$	Charge Transfer		Th	990
$\text{Ne}^{10+} + \text{H}$	Charge Transfer	0.00-100.00 keV/amu	Th	737
$\text{Ne}^{10+} + \text{He}$	Charge Transfer	50.00-150.00 keV	E/T	733
$\text{Ne}^{10+} + \text{He}$	Ionization	0.05-100.00 GeV/amu	Ex	989
$\text{Na} + \text{H}$	Elastic Scattering	0.00-2.72 eV	Th	852
$\text{Na} + \text{He}$	Heavy Particle Coll.	0.05 eV	Th	804
$\text{Na} + \text{He}$	Line Broadening	0.05 eV	Th	804
$\text{Na} + \text{He}$	Excitation	0.05 eV	Th	804
$\text{Na} + \text{Ne}$	Heavy Particle Coll.	0.05 eV	Th	804
$\text{Na} + \text{Ne}$	Line Broadening	0.05 eV	Th	804
$\text{Na} + \text{Ne}$	Excitation	0.05 eV	Th	804
$\text{Na} + \text{Na}$	Association	663.00-723.00 K	Ex	720
$\text{Na} + \text{Na}$	Energy Transfer	0.30-2.20 K	Th	897
$\text{Na}^* + \text{Na}$	Energy Transfer		E/T	688
$\text{Na} + \text{Na}$	Energy Transfer		E/T	688
$\text{Na} + \text{Ar}$	Heavy Particle Coll.	0.05 eV	Th	804
$\text{Na} + \text{Ar}$	Line Broadening	0.05 eV	Th	804
$\text{Na} + \text{Ar}$	Excitation	0.05 eV	Th	804
$\text{Na} + \text{K}$	Interaction Potentials		Th	749
$\text{Na} + \text{Kr}$	Heavy Particle Coll.	0.05 eV	Th	804
$\text{Na} + \text{Kr}$	Line Broadening	0.05 eV	Th	804
$\text{Na} + \text{Kr}$	Excitation	0.05 eV	Th	804
$\text{Na}^* + \text{Rb}$	Energy Transfer		E/T	688
$\text{Na} + \text{Rb}$	Energy Transfer		E/T	688
$\text{Na} + \text{I}$	Charge Transfer	5.00-87.00 eV	E/T	783
$\text{Na} + \text{Xe}$	Heavy Particle Coll.	0.05 eV	Th	804
$\text{Na} + \text{Xe}$	Line Broadening	0.05 eV	Th	804
$\text{Na} + \text{Xe}$	Excitation	0.05 eV	Th	804
$\text{Na}^{1+} + \text{Li}^*$	Charge Transfer	7.5×10^4 - 1.85×10^5 m/s	Ex	761
$\text{Na}^{1+} + \text{Li}$	Charge Transfer	7.5×10^4 - 1.85×10^5 m/s	Ex	761
$\text{Na}^{1+} + \text{Na}^*$	Charge Transfer	0.03 a.u.	Th	872
$\text{Na}^{1+} + \text{Na}$	Charge Transfer	0.03 a.u.	Th	872
$\text{Na}^{1+} + \text{Na}^*$	Ionization	0.03 a.u.	Th	872
$\text{Na}^{1+} + \text{Na}$	Ionization	0.03 a.u.	Th	872
$\text{Na}^{2+} + \text{C}_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$\text{Na}^{3+} + \text{C}_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$\text{Mg} + \text{Ne}$	Excitation		Th	922
$\text{Mg} + \text{Mg}$	Elastic Scattering		Th	906
$\text{Mg} + \text{Mg}$	Interaction Potentials		Th	906
$\text{Mg} + \text{Mg}$	Interaction Potentials		Th	887
$\text{Mg} + \text{Mg}$	Interaction Potentials		Th	886
$\text{Mg}^{2+} + \text{He}$	Charge Transfer	0.05-1.00 MeV/amu	E/T	913
$\text{Mg}^{4+} + \text{Mg}^{9+}$	Charge Transfer	0.00-3.00 MeV/amu	Ex	743

Al²⁺ + He	Charge Transfer	0.00-1.00 MeV/amu	Th	869
Si²⁺ + He	Charge Transfer	0.05-1.00 MeV/amu	E/T	913
Si³⁺ + He	Charge Transfer	1.58-250.00 eV/amu	Th	714
Si³⁺ + Rb	Charge Transfer	12.00 keV	Ex	880
Si⁴⁺ + He	Charge Transfer	0.01-10.00 keV/amu	Th	1001
Si⁴⁺ + He	Charge Transfer	0.00-60.00 keV	Th	840
Si⁴⁺ + He	Excitation	0.01-10.00 keV/amu	Th	1001
Si⁸⁺ + Yb	Charge Transfer	2.00-4.50 MeV/amu	Ex	974
Si⁸⁺ + Yb	Ionization	2.00-4.50 MeV/amu	Ex	974
Si⁸⁺ + C₆H₆	Dissociation		Ex	843
Si⁸⁺ + C₆H₆	Ionization		Ex	843
Si¹³⁺ + H₂	Charge Transfer	1.00-100.00 keV/amu	E/T	917
Si¹³⁺ + H₂	Charge Transfer	1.00-70.00 keV/amu	E/T	874
Si¹³⁺ + D₂	Charge Transfer	1.00-100.00 keV/amu	E/T	917
Si¹³⁺ + D₂	Charge Transfer	1.00-70.00 keV/amu	E/T	874
Si¹³⁺ + He	Charge Transfer	1.00-100.00 keV/amu	E/T	917
Si¹³⁺ + He	Charge Transfer	1.00-70.00 keV/amu	E/T	874
Si¹³⁺ + CH₄	Charge Transfer	1.00-100.00 keV/amu	E/T	917
Si¹³⁺ + CH₄	Charge Transfer	1.00-70.00 keV/amu	E/T	874
Si¹³⁺ + CO	Charge Transfer	1.00-100.00 keV/amu	E/T	917
Si¹³⁺ + CO	Charge Transfer	1.00-70.00 keV/amu	E/T	874
Si¹³⁺ + CO₂	Charge Transfer	1.00-100.00 keV/amu	E/T	917
Si¹³⁺ + CO₂	Charge Transfer	1.00-70.00 keV/amu	E/T	874
Si¹³⁺ + N₂	Charge Transfer	1.00-100.00 keV/amu	E/T	917
Si¹³⁺ + N₂	Charge Transfer	1.00-70.00 keV/amu	E/T	874
Si¹³⁺ + O₂	Charge Transfer	1.00-70.00 keV/amu	E/T	874
Si¹³⁺ + Ne	Charge Transfer	1.00-100.00 keV/amu	E/T	917
Si¹³⁺ + Ne	Charge Transfer	1.00-70.00 keV/amu	E/T	874
Si¹³⁺ + Ar	Charge Transfer	1.00-100.00 keV/amu	E/T	917
Si¹³⁺ + Ar	Charge Transfer	1.00-100.00 keV/amu	E/T	917
Si¹³⁺ + Ar	Charge Transfer	1.00-70.00 keV/amu	E/T	874
Si¹⁴⁺ + He	Excitation	120.00 MeV	Ex	975
Si¹⁴⁺ + N₂	Excitation	120.00 MeV	Ex	975
Si¹⁴⁺ + Ne	Excitation	120.00 MeV	Ex	975
Si¹⁴⁺ + Ar	Excitation	120.00 MeV	Ex	975
Si¹⁴⁺ + Xe	Excitation	120.00 MeV	Ex	975
S + C₆₀	Dissociation	2.00 MeV	Ex	866
S + C₆₀	Charge Transfer	2.00 MeV	Ex	866
S + C₆₀	Ionization	2.00 MeV	Ex	866
S¹⁺ + C₆₀	Dissociation	2.00 MeV	Ex	866
S¹⁺ + C₆₀	Charge Transfer	2.00 MeV	Ex	866
S¹⁺ + C₆₀	Ionization	2.00 MeV	Ex	866
S²⁺ + C₆₀	Dissociation	2.00 MeV	Ex	866
S²⁺ + C₆₀	Dissociation	0.20-0.25 a.u.	E/T	849
S²⁺ + C₆₀	Charge Transfer	2.00 MeV	Ex	866
S²⁺ + C₆₀	Ionization	2.00 MeV	Ex	866
S³⁺ + C₆₀	Dissociation	0.20-0.25 a.u.	E/T	849
S⁴⁺ + H	Charge Transfer	0.00-10.00 MeV/amu	Th	726
S⁴⁺ + C₆₀	Dissociation	2.00 MeV	Ex	866
S⁴⁺ + C₆₀	Charge Transfer	2.00 MeV	Ex	866
S⁴⁺ + C₆₀	Ionization	2.00 MeV	Ex	866
S¹²⁺ + He	Excitation	64.00 MeV	E/T	909
S¹²⁺ + He	Ionization	64.00 MeV	E/T	909
S¹²⁺ + C	Excitation	64.00 MeV	E/T	909
S¹²⁺ + C	Ionization	64.00 MeV	E/T	909
S¹⁵⁺ + H₂	Charge Transfer	1.00-100.00 keV/amu	E/T	917
S¹⁵⁺ + H₂	Charge Transfer	1.00-70.00 keV/amu	E/T	874

$\text{S}^{15+} + \text{D}_2$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{S}^{15+} + \text{D}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{S}^{15+} + \text{He}$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{S}^{15+} + \text{He}$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{S}^{15+} + \text{CH}_4$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{S}^{15+} + \text{CH}_4$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{S}^{15+} + \text{CO}$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{S}^{15+} + \text{CO}$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{S}^{15+} + \text{CO}_2$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{S}^{15+} + \text{CO}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{S}^{15+} + \text{N}_2$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{S}^{15+} + \text{N}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{S}^{15+} + \text{O}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{S}^{15+} + \text{Ne}$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{S}^{15+} + \text{Ne}$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{S}^{15+} + \text{Al}$	Ionization	33.00 TeV	Th	729
$\text{S}^{15+} + \text{Ar}$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{S}^{15+} + \text{Ar}$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{S}^{15+} + \text{Ar}$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{Cl} + \text{H}_2$	Interchange reaction	0.10-0.40 eV	Th	699
$\text{Cl}^{2+} + \text{C}_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$\text{Cl}^{3+} + \text{C}_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$\text{Ar} + \text{H}_2$	Energy Transfer		Th	895
$\text{Ar} + \text{H}_2$	Interaction Potentials		Th	895
$\text{Ar} + \text{H}_2$	Excitation		Th	895
$\text{Ar} + \text{Si}_2^{-1+}$	Dissociation	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{Si}_2^{-1+}$	Detachment	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{Si}_2^{-1+}$	Ionization	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{Si}_3^{-1+}$	Dissociation	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{Si}_3^{-1+}$	Detachment	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{Si}_3^{-1+}$	Ionization	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{Si}_4^{-1+}$	Dissociation	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{Si}_4^{-1+}$	Detachment	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{Si}_4^{-1+}$	Ionization	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{C}_2^{-1+}$	Dissociation	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{C}_2^{-1+}$	Detachment	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{C}_2^{-1+}$	Ionization	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{C}_3^{-1+}$	Dissociation	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{C}_3^{-1+}$	Detachment	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{C}_3^{-1+}$	Ionization	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{C}_4^{-1+}$	Dissociation	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{C}_4^{-1+}$	Detachment	0.10-1.20 a.u.	Ex	865
$\text{Ar} + \text{C}_4^{-1+}$	Ionization	0.10-1.20 a.u.	Ex	865
$\text{Ar}^{1+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Ar}^{1+} + \text{N}_2$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{Ar}^{1+} + \text{Ne}$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{Ar}^{1+} + \text{Ne}$	Ionization	1.50-5.00 keV	Ex	716
$\text{Ar}^{1+} + \text{Ar}$	Excitation	0.01-1.00 MeV/amu	Ex	690
$\text{Ar}^{1+} + \text{Ar}$	Ionization	1.50-5.00 keV	Ex	716
$\text{Ar}^{1+} + \text{Kr}$	Ionization	1.50-5.00 keV	Ex	716
$\text{Ar}^{1+} + \text{Xe}$	Ionization	1.50-5.00 keV	Ex	716
$\text{Ar}^{2+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Ar}^{2+} + \text{Ar}^{1+}$	Charge Transfer	1.80-14.80 keV	E/T	752
$\text{Ar}^{2+} + \text{C}_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$\text{Ar}^{3+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Ar}^{3+} + \text{C}_{60}$	Dissociation	0.20-0.25 a.u.	E/T	849
$\text{Ar}^{4+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952

$\text{Ar}^{4+} + \text{Ar}^{4+}$	Charge Transfer	10.00-60.00 keV	Ex	748
$\text{Ar}^{4+} + \text{Ar}^{4+}$	Ionization	10.00-60.00 keV	Ex	748
$\text{Ar}^{5+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Ar}^{6+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Ar}^{6+} + \text{He}^{1+}$	Charge Transfer	1.90 keV	Ex	988
$\text{Ar}^{6+} + \text{He}^{1+}$	Excitation	1.90 keV	Ex	988
$\text{Ar}^{6+} + \text{N}_2$	Charge Transfer		Th	949
$\text{Ar}^{7+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Ar}^{7+} + \text{N}_2$	Charge Transfer		Th	949
$\text{Ar}^{8+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Ar}^{8+} + \text{H}_2$	Charge Transfer	10.00 keV/q	E/T	848
$\text{Ar}^{8+*} + \text{H}_2$	Charge Transfer	10.00 keV/q	E/T	848
$\text{Ar}^{8+} + \text{CO}_2$	Dissociation	120.00 keV	Ex	937
$\text{Ar}^{8+} + \text{CO}_2$	Charge Transfer	120.00 keV	Ex	937
$\text{Ar}^{8+} + \text{CO}_2$	Ionization	120.00 keV	Ex	937
$\text{Ar}^{8+} + \text{N}_2$	Charge Transfer		Th	949
$\text{Ar}^{8+} + \text{N}_2\text{O}$	Dissociation	120.00 keV	Ex	937
$\text{Ar}^{8+} + \text{N}_2\text{O}$	Charge Transfer	120.00 keV	Ex	937
$\text{Ar}^{8+} + \text{N}_2\text{O}$	Ionization	120.00 keV	Ex	937
$\text{Ar}^{8+} + \text{Ar}$	Charge Transfer	80.00-240.00 keV	Ex	969
$\text{Ar}^{8+} + \text{Cs}$	Interaction Potentials	0.40-4.00 keV/amu	E/T	896
$\text{Ar}^{8+} + \text{Cs}$	Excitation	0.40-4.00 keV/amu	E/T	896
$\text{Ar}^{8+} + \text{CS}_2$	Dissociation	120.00 keV	Ex	868
$\text{Ar}^{8+} + \text{C}_{60}$	Dissociation	56.00 keV	Ex	864
$\text{Ar}^{9+} + \text{N}_2$	Charge Transfer		Th	949
$\text{Ar}^{9+} + \text{Ar}$	Charge Transfer	80.00-240.00 keV	Ex	969
$\text{Ar}^{10+} + \text{N}_2$	Charge Transfer		Th	949
$\text{Ar}^{10+} + \text{Ar}$	Charge Transfer	80.00-240.00 keV	Ex	969
$\text{Ar}^{11+} + \text{Ar}$	Charge Transfer	80.00-240.00 keV	Ex	969
$\text{Ar}^{11+} + \text{Ar}$	Charge Transfer	80.00-240.00 keV	Ex	969
$\text{Ar}^{12+} + \text{Ar}$	Charge Transfer	80.00-240.00 keV	Ex	969
$\text{Ar}^{14+} + \text{H}^{-1+}$	Detachment	1.00-2.00 MeV/amu	Ex	951
$\text{Ar}^{17+} + \text{H}$	Fluorescence	0.80-11.00 eV/amu	E/T	927
$\text{Ar}^{17+} + \text{H}_2$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{Ar}^{17+} + \text{H}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{Ar}^{17+} + \text{D}_2$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{Ar}^{17+} + \text{D}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{Ar}^{17+} + \text{He}$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{Ar}^{17+} + \text{He}$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{Ar}^{17+} + \text{C}$	Charge Transfer	390.00 MeV/amu	Th	992
$\text{Ar}^{17+} + \text{CH}_4$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{Ar}^{17+} + \text{CH}_4$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{Ar}^{17+} + \text{CO}$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{Ar}^{17+} + \text{CO}$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{Ar}^{17+} + \text{CO}_2$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{Ar}^{17+} + \text{CO}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{Ar}^{17+} + \text{N}_2$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{Ar}^{17+} + \text{N}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{Ar}^{17+} + \text{O}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{Ar}^{17+} + \text{Ne}$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{Ar}^{17+} + \text{Ne}$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{Ar}^{17+} + \text{Ar}$	Charge Transfer	1.00-100.00 keV/amu	E/T	917
$\text{Ar}^{17+} + \text{Ar}$	Charge Transfer	1.00-70.00 keV/amu	E/T	874
$\text{Ar}^{17+} + \text{Ar}$	Fluorescence	0.80-11.00 eV/amu	E/T	927
$\text{Ar}^{17+} + \text{Ar Seq.}$	Fluorescence	0.80-11.00 eV/amu	E/T	927
$\text{Ar}^{18+} + \text{H}$	Charge Transfer	0.00-100.00 keV/amu	Th	737
$\text{Ar}^{18+} + \text{Li}$	Total Scattering	0.20-95.00 MeV	Th	854

Ar¹⁸⁺ + Li	Excitation	10.00-95.00 MeV/amu	Ex	970
Ar¹⁸⁺ + Li	Ionization	10.00-95.00 MeV/amu	Ex	970
Ar¹⁸⁺ + Li	Ionization	0.20-95.00 MeV	Th	854
Ar¹⁸⁺ + C	Charge Transfer	0.00-1.00 GeV/amu	Th	912
K + H	Elastic Scattering	0.00-2.72 eV	Th	852
K + O₂	Charge Transfer	5.00-87.00 eV	E/T	783
K* + Na	Energy Transfer		E/T	688
K + Na	Energy Transfer		E/T	688
K + K	Line Broadening	0.02 eV	Th	803
K* + K	Energy Transfer		E/T	688
K + K	Energy Transfer		E/T	688
K + Rb	Line Broadening	0.02 eV	Th	803
K* + Rb	Energy Transfer		E/T	688
K + Rb	Energy Transfer		E/T	688
K + SnCl₄	Charge Transfer	5.00-87.00 eV	E/T	783
K + CCl₄	Charge Transfer	5.00-87.00 eV	E/T	783
K + CF₃Br	Charge Transfer	5.00-87.00 eV	E/T	783
K³⁺ + C	Excitation	12.80 MeV	Ex	736
K³⁺ + C	Ionization	12.80 MeV	Ex	736
Ca + He	Excitation	2.61-2.78 eV	Th	724
Ca* + He	Excitation	2.61-2.78 eV	Th	724
Ca + Ca	Interaction Potentials		Th	886
Ca¹⁸⁺ + He	Excitation	8.00-40.00 MeV/amu	E/T	976
Ca¹⁸⁺ + N₂	Excitation	8.00-40.00 MeV/amu	E/T	976
Ca¹⁸⁺ + O₂	Excitation	8.00-40.00 MeV/amu	E/T	976
Ca¹⁸⁺ + Ne	Excitation	8.00-40.00 MeV/amu	E/T	976
Ca¹⁹⁺ + H₂	Charge Transfer	100.00-400.00 MeV	Th	954
Ca¹⁹⁺ + H₂	Excitation	100.00-400.00 MeV	Th	954
Ti¹⁺ + O	Interaction Potentials	2.00-5.00 a ₀	Th	769
Ti¹⁺ + O¹⁺	Interaction Potentials	2.00-5.00 a ₀	Th	769
Fe¹⁺ + Cu	Ionization	0.10-1.50 MeV/amu	Ex	972
Fe²⁶⁺ + H	Charge Transfer	0.00-100.00 keV/amu	Th	737
Co¹⁺ + Cu	Ionization	0.10-1.50 MeV/amu	Ex	972
Co³⁺ + N₂	Charge Transfer	5.60 eV	Ex	793
Co³⁺ + Ar	Charge Transfer	5.60 eV	Ex	793
Ni¹⁺ + Cu	Ionization	0.10-1.50 MeV/amu	Ex	972
Ni¹⁹⁺ + C	Ionization	45.00 MeV/amu	Ex	845
Ni¹⁹⁺ + Al	Ionization	45.00 MeV/amu	Ex	845
Ni¹⁹⁺ + Au	Ionization	45.00 MeV/amu	Ex	845
Ni²⁶⁺ + He	Ionization	0.05-100.00 GeV/amu	Ex	989
Ni²⁸⁺ + C	Ionization	45.00 MeV/amu	Ex	845
Ni²⁸⁺ + C	Ionization	45.00 MeV/amu	E/T	740
Ni²⁸⁺ + Al	Ionization	45.00 MeV/amu	Ex	845
Ni²⁸⁺ + Ni	Ionization	45.00 MeV/amu	Ex	845
Ni²⁸⁺ + Ag	Ionization	45.00 MeV/amu	Ex	845
Ni²⁸⁺ + Au	Ionization	45.00 MeV/amu	Ex	845
Cu + Bi	Ionization	0.10-1.62 MeV/amu	Ex	973
Cu + Bi	Ionization	0.10-1.62 MeV/amu	Ex	973
Cu¹⁺ + Cu	Ionization	0.10-1.50 MeV/amu	Ex	972
Se²⁸⁺ + He	Ionization	0.05-100.00 GeV/amu	Ex	989
Se²⁸⁺ + He	Ionization	0.00-1.00 GeV/amu	Th	987
Kr⁴⁺ + Kr⁴⁺	Charge Transfer	10.00-60.00 keV	Ex	748
Kr⁴⁺ + Kr⁴⁺	Ionization	10.00-60.00 keV	Ex	748
Kr⁷⁺ + CO	Charge Transfer	0.30-1.30 eV/amu	Ex	944
Kr⁷⁺ + N₂	Charge Transfer	0.30-1.30 eV/amu	Ex	944
Kr⁷⁺ + O₂	Charge Transfer	0.30-1.30 eV/amu	Ex	944
Kr⁷⁺ + Ne	Charge Transfer	0.30-1.30 eV/amu	Ex	944

Kr⁸⁺ + Li	Charge Transfer	0.10-0.30 keV/amu	Ex	966
Kr⁸⁺ + Li	Excitation	0.10-0.30 keV/amu	Ex	966
Kr⁸⁺ + CO	Charge Transfer	0.30-1.30 eV/amu	Ex	944
Kr⁸⁺ + N₂	Dissociation	19.00-171.00 eV/amu	Ex	890
Kr⁸⁺ + N₂	Charge Transfer	5.00-200.00 eV/amu	Ex	1000
Kr⁸⁺ + N₂	Charge Transfer	0.30-1.30 eV/amu	Ex	944
Kr⁸⁺ + O₂	Charge Transfer	0.30-1.30 eV/amu	Ex	944
Kr⁸⁺ + Ne	Charge Transfer	0.30-1.30 eV/amu	Ex	944
Kr⁹⁺ + CO	Charge Transfer	0.30-1.30 eV/amu	Ex	944
Kr⁹⁺ + N₂	Charge Transfer	0.30-1.30 eV/amu	Ex	944
Kr⁹⁺ + O₂	Charge Transfer	0.30-1.30 eV/amu	Ex	944
Kr⁹⁺ + Ne	Charge Transfer	0.30-1.30 eV/amu	Ex	944
Kr²⁷⁺ + He	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁷⁺ + CH₄	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁷⁺ + N₂	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁷⁺ + Ne	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁷⁺ + Ar	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁸⁺ + He	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁸⁺ + CH₄	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁸⁺ + N₂	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁸⁺ + Ne	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁸⁺ + Ar	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁹⁺ + He	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁹⁺ + CH₄	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁹⁺ + N₂	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁹⁺ + Ne	Charge Transfer	2.00 keV/amu	E/T	901
Kr²⁹⁺ + Ar	Charge Transfer	2.00 keV/amu	E/T	901
Kr³⁰⁺ + He	Charge Transfer	2.00 keV/amu	E/T	901
Kr³⁰⁺ + CH₄	Charge Transfer	2.00 keV/amu	E/T	901
Kr³⁰⁺ + N₂	Charge Transfer	2.00 keV/amu	E/T	901
Kr³⁰⁺ + Ne	Charge Transfer	2.00 keV/amu	E/T	901
Kr³⁰⁺ + Ar	Charge Transfer	2.00 keV/amu	E/T	901
Kr³¹⁺ + He	Charge Transfer	2.00 keV/amu	E/T	901
Kr³¹⁺ + CH₄	Charge Transfer	2.00 keV/amu	E/T	901
Kr³¹⁺ + N₂	Charge Transfer	2.00 keV/amu	E/T	901
Kr³¹⁺ + Ne	Charge Transfer	2.00 keV/amu	E/T	901
Kr³¹⁺ + Ar	Charge Transfer	2.00 keV/amu	E/T	901
Kr³²⁺ + He	Charge Transfer	2.00 keV/amu	E/T	901
Kr³²⁺ + CH₄	Charge Transfer	2.00 keV/amu	E/T	901
Kr³²⁺ + N₂	Charge Transfer	2.00 keV/amu	E/T	901
Kr³²⁺ + Ne	Charge Transfer	2.00 keV/amu	E/T	901
Kr³²⁺ + Ar	Charge Transfer	2.00 keV/amu	E/T	901
Kr³³⁺ + He	Charge Transfer	2.00 keV/amu	E/T	901
Kr³³⁺ + CH₄	Charge Transfer	2.00 keV/amu	E/T	901
Kr³³⁺ + N₂	Charge Transfer	2.00 keV/amu	E/T	901
Kr³³⁺ + Ne	Charge Transfer	2.00 keV/amu	E/T	901
Kr³³⁺ + Ar	Charge Transfer	2.00 keV/amu	E/T	901
Kr³⁴⁺ + H₂	Ionization	60.00 meV/amu	Ex	931
Kr³⁶⁺ + H	Charge Transfer	0.00-100.00 keV/amu	Th	737
Kr³⁶⁺ + C	Charge Transfer	0.00-1.00 GeV/amu	Th	912
Rb + H	Elastic Scattering	0.00-2.72 eV	Th	852
Rb + H	Interaction Potentials		Th	902
Rb + He	Heavy Particle Coll.	0.05 eV	Th	804
Rb + He	Line Broadening	0.05 eV	Th	804
Rb + He	Excitation	0.05 eV	Th	804
Rb + Ne	Heavy Particle Coll.	0.05 eV	Th	804
Rb + Ne	Line Broadening	0.05 eV	Th	804

Rb + Ne	Excitation	0.05 eV	Th	804
Rb + Ar	Heavy Particle Coll.	0.05 eV	Th	804
Rb + Ar	Line Broadening	0.05 eV	Th	804
Rb + Ar	Excitation	0.05 eV	Th	804
Rb + Kr	Heavy Particle Coll.	0.05 eV	Th	804
Rb + Kr	Line Broadening	0.05 eV	Th	804
Rb + Kr	Excitation	0.05 eV	Th	804
Rb + Rb	Line Broadening	0.02 eV	Th	803
Rb + Rb	Elastic Scattering	0.00 K	Th	851
Rb* + Rb	Energy Transfer		E/T	688
Rb + Rb	Energy Transfer		E/T	688
Rb* + Rb	Interaction Potentials		Th	871
Rb + Rb	Interaction Potentials		Th	871
Rb* + Rb	Interaction Potentials		Th	812
Rb + Rb	Interaction Potentials		Th	812
Rb* + Rb	Interaction Potentials		Th	811
Rb + Rb	Interaction Potentials		Th	811
Rb + Rb	Excitation	3.00-3.40 V/cm	Ex	921
Rb* + Rb*	Excitation	3.00-3.40 V/cm	Ex	921
Rb + Xe	Heavy Particle Coll.	0.05 eV	Th	804
Rb + Xe	Line Broadening	0.05 eV	Th	804
Rb + Xe	Excitation	0.05 eV	Th	804
Rb¹⁺ + Cs	Interaction Potentials	6.00-60.00 a ₀	Th	742
Sr + Sr	Interaction Potentials		Th	886
I²³⁺ + He	Ionization	0.35-1.50 MeV/amu	Ex	955
I²³⁺ + Ne	Ionization	0.35-1.50 MeV/amu	Ex	955
I²³⁺ + Ar	Ionization	0.35-1.50 MeV/amu	Ex	955
Xe + H	Ionization	1.00-100.00 MeV/amu	Th	823
Xe + He	Ionization	1.00-100.00 MeV/amu	Th	823
Xe + Li	Ionization	1.00-100.00 MeV/amu	Th	823
Xe + Be	Ionization	1.00-100.00 MeV/amu	Th	823
Xe + N	Ionization	1.00-100.00 MeV/amu	Th	823
Xe + F	Ionization	1.00-100.00 MeV/amu	Th	823
Xe + Ar	Ionization	1.00-100.00 MeV/amu	Th	823
Xe + Kr	Energy Transfer		Ex	787
Xe + Kr₂	Energy Transfer		Ex	787
Xe + Xe	Ionization	1.00-100.00 MeV/amu	Th	823
Xe¹⁺ + H⁻¹⁺	Detachment	200.00 keV	Th	952
Xe¹⁺ + BeF₂	Ionization	2.60-8.40 GeV	Th	816
Xe¹⁺ + N₂	Ionization	2.00-20.00 MeV/amu	Ex	786
Xe¹⁺ + N₂	Ionization	2.00-20.00 MeV/amu	Ex	786
Xe¹⁺ + Xe	Charge Transfer	1.00-300.00 eV	E/T	694
Xe¹⁺ + Xe	Interaction Potentials	1.00-300.00 eV	E/T	694
Xe²⁺ + H⁻¹⁺	Detachment	200.00 keV	Th	952
Xe²⁺ + BeF₂	Ionization	2.60-8.40 GeV	Th	816
Xe²⁺ + Rb	Charge Transfer		Ex	1019
Xe²⁺ + Xe	Charge Transfer	1.00-300.00 eV	E/T	694
Xe²⁺ + Xe	Interaction Potentials	1.00-300.00 eV	E/T	694
Xe³⁺ + H⁻¹⁺	Detachment	200.00 keV	Th	952
Xe³⁺ + BeF₂	Ionization	2.60-8.40 GeV	Th	816
Xe⁴⁺ + H⁻¹⁺	Detachment	200.00 keV	Th	952
Xe⁴⁺ + BeF₂	Ionization	2.60-8.40 GeV	Th	816
Xe⁴⁺ + Rb	Charge Transfer		Ex	1019
Xe⁴⁺ + Xe⁴⁺	Charge Transfer	2.00-70.00 keV	Ex	815
Xe⁴⁺ + Xe⁴⁺	Charge Transfer	10.00-60.00 keV	Ex	748
Xe⁴⁺ + Xe⁴⁺	Ionization	10.00-60.00 keV	Ex	748
Xe⁵⁺ + H⁻¹⁺	Detachment	200.00 keV	Th	952

$\text{Xe}^{5+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Xe}^{6+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Xe}^{6+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Xe}^{7+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Xe}^{7+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Xe}^{8+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th	952
$\text{Xe}^{8+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Xe}^{8+} + \text{N}_2$	Ionization	2.00-20.00 MeV/amu	Ex	786
$\text{Xe}^{8+} + \text{N}_2$	Ionization	2.00-20.00 MeV/amu	Ex	786
$\text{Xe}^{8+} + \text{Rb}$	Charge Transfer		Ex	1019
$\text{Xe}^{9+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Xe}^{10+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Xe}^{11+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Xe}^{12+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Xe}^{17+} + \text{H}_2\text{O}$	Dissociation	5.90 MeV/amu	Ex	777
$\text{Xe}^{17+} + \text{H}_2\text{O}$	Ionization	5.90 MeV/amu	Ex	777
$\text{Xe}^{18+} + \text{H}_2\text{O}$	Dissociation	5.90 MeV/amu	Ex	777
$\text{Xe}^{18+} + \text{H}_2\text{O}$	Ionization	5.90 MeV/amu	Ex	777
$\text{Xe}^{18+} + \text{N}_2$	Ionization	2.00-20.00 MeV/amu	Ex	786
$\text{Xe}^{18+} + \text{N}_2$	Ionization	2.00-20.00 MeV/amu	Ex	786
$\text{Xe}^{18+} + \text{O}_2$	Dissociation	5.90 MeV/amu	Ex	993
$\text{Xe}^{18+} + \text{O}_2$	Ionization	5.90 MeV/amu	Ex	993
$\text{Xe}^{23+} + \text{H}_2$	Charge Transfer	0.00-2.60 keV/amu	Th	713
$\text{Xe}^{23+} + \text{H}_2$	Total Scattering	0.00-2.60 keV/amu	Th	713
$\text{Xe}^{26+} + \text{H}_2$	Dissociation	0.03-3.90 MeV	E/T	1021
$\text{Xe}^{26+} + \text{H}_2$	Dissociation	0.19-50.00 keV/amu	Ex	862
$\text{Xe}^{26+} + \text{D}_2$	Dissociation	0.03-3.90 MeV	E/T	1021
$\text{Xe}^{26+} + \text{D}_2$	Dissociation	0.19-50.00 keV/amu	Ex	862
$\text{Xe}^{26+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{27+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{28+} + \text{Na}$	Ionization	560.00 keV	Ex	801
$\text{Xe}^{28+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{28+} + \text{Na}_n$	Dissociation	560.00 keV	Ex	801
$\text{Xe}^{28+} + \text{Na}_n$	Ionization	560.00 keV	Ex	801
$\text{Xe}^{29+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{30+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{31+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{32+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{32+} + \text{Rb}$	Charge Transfer		Ex	1019
$\text{Xe}^{33+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{34+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{35+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{36+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{37+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{38+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{39+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{40+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{40+} + \text{Rb}$	Charge Transfer		Ex	1019
$\text{Xe}^{40+} + \text{Xe}$	Excitation	3.60-5.88 MeV	Th	746
$\text{Xe}^{40+} + \text{Xe}$	Ionization	3.60-5.88 MeV	Th	746
$\text{Xe}^{40+} + \text{Xe}$	Ionization	3.60-5.88 MeV	Th	746
$\text{Xe}^{41+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{42+} + \text{Ar}$	Charge Transfer	0.74 keV/amu	Ex	689
$\text{Xe}^{43+} + \text{H}_2\text{O}$	Dissociation	5.90 MeV/amu	Ex	777
$\text{Xe}^{43+} + \text{H}_2\text{O}$	Ionization	5.90 MeV/amu	Ex	777
$\text{Xe}^{43+} + \text{O}_2$	Dissociation	5.90 MeV/amu	Ex	993
$\text{Xe}^{43+} + \text{O}_2$	Ionization	5.90 MeV/amu	Ex	993

Xe⁴³⁺ + Ar	Charge Transfer	0.74 keV/amu	Ex	689
Xe⁴⁴⁺ + CO	Dissociation	6.70 MeV/amu	Ex	945
Xe⁴⁴⁺ + CO	Ionization	6.70 MeV/amu	Ex	945
Xe⁵⁴⁺ + H	Charge Transfer	0.00-100.00 keV	E/T	940
Xe⁵⁴⁺ + H	Charge Transfer	0.00-100.00 keV/amu	Th	737
Xe⁵⁴⁺ + H	Excitation	0.00-100.00 keV	E/T	940
Xe⁵⁴⁺ + C	Charge Transfer	0.00-1.00 GeV/amu	Th	912
Cs + H	Elastic Scattering	0.00-2.72 eV	Th	852
Cs + He	Line Broadening	294.00 K	Ex	894
Cs + N₂	Line Broadening	294.00 K	Ex	894
Cs + O₂	Charge Transfer	5.00-87.00 eV	E/T	783
Cs + Ar	Charge Transfer	5.00-87.00 eV	E/T	783
Cs + Cs	Association		Th	918
Cs + Cs	Association	0.13 mK	Ex	881
Cs* + Cs	Energy Transfer		E/T	688
Cs + Cs	Energy Transfer		E/T	688
Cs¹⁺ + Rb	Interaction Potentials	6.00-60.00 a ₀	Th	742
Ba + Ar	Total Scattering	0.50 eV	Th	734
Ba + Ar	Excitation	0.50 eV	Th	734
Ba + Ba	Interaction Potentials		Th	886
Dy⁶⁶⁺ + C	Charge Transfer	0.00-1.00 GeV/amu	Th	912
Ta³⁵⁺ + N₂	Charge Transfer	240.00-400.00 keV	Ex	1016
Ta³⁷⁺ + N₂	Charge Transfer	240.00-400.00 keV	Ex	1016
Ta⁴⁰⁺ + N₂	Charge Transfer	240.00-400.00 keV	Ex	1016
Ta⁴⁴⁺ + N₂	Charge Transfer	240.00-400.00 keV	Ex	1016
Ta⁴⁷⁺ + N₂	Charge Transfer	240.00-400.00 keV	Ex	1016
Au⁵²⁺ + H₂	Ionization	1.00-100.00 MeV/amu	Th	823
Au⁵²⁺ + N₂	Ionization	1.00-100.00 MeV/amu	Th	823
Au⁵³⁺ + He	Ionization	3.60 eV	Ex	1015
Au⁵³⁺ + He	Ionization	0.05-100.00 GeV/amu	Ex	989
Au⁵³⁺ + He	Ionization	3.60 MeV/amu	Ex	957
Au⁵³⁺ + He	Ionization	3.60 MeV/amu	Ex	790
Au⁵³⁺ + He	Ionization	3.60 MeV/amu	Th	781
Au⁵³⁺ + He	Ionization	3.60-100.00 MeV/amu	Th	779
Au⁵³⁺ + Ne	Total Scattering	3.60 MeV/amu	Ex	908
Au⁵³⁺ + Ne	Ionization	3.60 MeV/amu	Ex	1018
Au⁵³⁺ + Ne	Ionization	3.60 MeV/amu	Th	1002
Au⁵³⁺ + Ne	Ionization	3.60 MeV/amu	Ex	908
Au⁵³⁺ + Ne	Ionization	3.60 MeV/amu	Th	781
Au⁵³⁺ + Ar	Total Scattering	3.60 MeV/amu	Ex	908
Au⁵³⁺ + Ar	Ionization	3.60 MeV/amu	Ex	1018
Au⁵³⁺ + Ar	Ionization	3.60 MeV/amu	Th	1002
Au⁵³⁺ + Ar	Ionization	3.60 MeV/amu	Ex	908
Au⁷⁸⁺ + C	Ionization	0.22-11.00 GeV/amu	Th	997
Au⁷⁸⁺ + Al	Ionization	0.22-11.00 GeV/amu	Th	997
Au⁷⁸⁺ + Ni	Ionization	0.22-11.00 GeV/amu	Th	997
Au⁷⁸⁺ + Cu	Ionization	0.22-11.00 GeV/amu	Th	997
Au⁷⁸⁺ + Ag	Ionization	0.22-11.00 GeV/amu	Th	997
Au⁷⁸⁺ + Au	Ionization	0.22-11.00 GeV/amu	Th	997
Au⁷⁹⁺ + C	Charge Transfer	0.00-1.00 GeV/amu	Th	912
Au⁷⁹⁺ + U⁹¹⁺	Ionization	100.00 MeV/amu	Th	691
Pb + H	Ionization	1.00-100.00 MeV/amu	Th	823
Pb + He	Ionization	1.00-100.00 MeV/amu	Th	823
Pb + Li	Ionization	1.00-100.00 MeV/amu	Th	823
Pb + Be	Ionization	1.00-100.00 MeV/amu	Th	823
Pb + N	Ionization	1.00-100.00 MeV/amu	Th	823
Pb + F	Ionization	1.00-100.00 MeV/amu	Th	823

Pb + Ar	Ionization	1.00-100.00 MeV/amu	Th	823
Pb + Xe	Ionization	1.00-100.00 MeV/amu	Th	823
Pb⁴⁺ + Pb⁴⁺	Charge Transfer	10.00-60.00 keV	Ex	748
Pb⁴⁺ + Pb⁴⁺	Ionization	10.00-60.00 keV	Ex	748
Pb⁸¹⁺ + Al	Ionization	33.00 TeV	Th	729
Pb⁸²⁺ + C	Charge Transfer	0.00-1.00 GeV/amu	Th	912
perturbation + He	Ionization		Th	806
C₆₀⁻¹⁺ + Ar	Dissociation	45.00 keV	Ex	870
U¹⁺ + H	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁺ + He	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁺ + Li	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁺ + Be	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁺ + N	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁺ + F	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁺ + Ar	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁺ + Xe	Ionization	1.00-100.00 MeV/amu	Th	823
U⁴⁺ + H	Ionization	1.00-100.00 MeV/amu	Th	823
U⁴⁺ + He	Ionization	1.00-100.00 MeV/amu	Th	823
U⁴⁺ + Li	Ionization	1.00-100.00 MeV/amu	Th	823
U⁴⁺ + Be	Ionization	1.00-100.00 MeV/amu	Th	823
U⁴⁺ + N	Ionization	1.00-100.00 MeV/amu	Th	823
U⁴⁺ + F	Ionization	1.00-100.00 MeV/amu	Th	823
U⁴⁺ + Ar	Ionization	1.00-100.00 MeV/amu	Th	823
U⁴⁺ + Xe	Ionization	1.00-100.00 MeV/amu	Th	823
U⁷⁺ + H	Ionization	1.00-100.00 MeV/amu	Th	823
U⁷⁺ + He	Ionization	1.00-100.00 MeV/amu	Th	823
U⁷⁺ + Li	Ionization	1.00-100.00 MeV/amu	Th	823
U⁷⁺ + Be	Ionization	1.00-100.00 MeV/amu	Th	823
U⁷⁺ + N	Ionization	1.00-100.00 MeV/amu	Th	823
U⁷⁺ + F	Ionization	1.00-100.00 MeV/amu	Th	823
U⁷⁺ + Ar	Ionization	1.00-100.00 MeV/amu	Th	823
U⁷⁺ + Xe	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁰⁺ + H	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁰⁺ + H₂	Ionization	2.60-8.40 GeV	Th	816
U¹⁰⁺ + He	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁰⁺ + Li	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁰⁺ + Be	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁰⁺ + N	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁰⁺ + N₂	Ionization	2.60-8.40 GeV	Th	816
U¹⁰⁺ + F	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁰⁺ + Ar	Ionization	1.00-100.00 MeV/amu	Th	823
U¹⁰⁺ + Xe	Ionization	1.00-100.00 MeV/amu	Th	823
U²⁸⁺ + H	Ionization	1.00-100.00 MeV/amu	Th	823
U²⁸⁺ + He	Ionization	1.00-100.00 MeV/amu	Th	823
U²⁸⁺ + Li	Ionization	1.00-100.00 MeV/amu	Th	823
U²⁸⁺ + Be	Ionization	1.00-100.00 MeV/amu	Th	823
U²⁸⁺ + N	Ionization	1.00-100.00 MeV/amu	Th	823
U²⁸⁺ + F	Ionization	1.00-100.00 MeV/amu	Th	823
U²⁸⁺ + Ar	Ionization	1.00-100.00 MeV/amu	Th	823
U²⁸⁺ + Xe	Excitation	3.60-5.88 MeV	Th	746
U²⁸⁺ + Xe	Ionization	1.00-100.00 MeV/amu	Th	823
U²⁸⁺ + Xe	Ionization	3.60-5.88 MeV	Th	746
U²⁸⁺ + Xe	Ionization	3.60-5.88 MeV	Th	746
U²⁹⁺ + Ne	Excitation	3.60-5.88 MeV	Th	746
U²⁹⁺ + Ne	Ionization	3.60-5.88 MeV	Th	746
U²⁹⁺ + Ne	Ionization	3.60-5.88 MeV	Th	746
U⁹⁰⁺ + N₂	Charge Transfer	223.00 MeV/amu	Ex	1004

$\text{U}^{90+} + \text{N}_2$	Charge Transfer	223.00 MeV/amu	E/T	853
$\text{U}^{90+} + \text{Ar}$	Charge Transfer	223.00 MeV/amu	Ex	1004
$\text{U}^{90+} + \text{Ar}$	Charge Transfer	223.00 MeV/amu	Ex	985
$\text{U}^{90+} + \text{Ar}$	Charge Transfer	223.00 MeV/amu	E/T	853
$\text{U}^{90+} + \text{Ar}$	Excitation	223.00 MeV/amu	Ex	985
$\text{U}^{90+} + \text{Kr}$	Charge Transfer	223.00 MeV/amu	Ex	1004
$\text{U}^{90+} + \text{Kr}$	Charge Transfer	223.00 MeV/amu	Ex	985
$\text{U}^{90+} + \text{Kr}$	Charge Transfer	223.00 MeV/amu	E/T	853
$\text{U}^{90+} + \text{Kr}$	Excitation	223.00 MeV/amu	Ex	985
$\text{U}^{90+} + \text{Xe}$	Charge Transfer	223.00 MeV/amu	Ex	1004
$\text{U}^{90+} + \text{Xe}$	Charge Transfer	223.00 MeV/amu	Ex	985
$\text{U}^{90+} + \text{Xe}$	Charge Transfer	223.00 MeV/amu	E/T	853
$\text{U}^{90+} + \text{Xe}$	Excitation	223.00 MeV/amu	Ex	985
$\text{U}^{92+} + \text{He}$	Ionization	0.00-1.00 GeV/amu	Th	987
$\text{U}^{92+} + \text{He}$	Ionization	1.00 GeV/amu	Ex	962
$\text{U}^{92+} + \text{He}$	Ionization	1.00 GeV/amu	E/T	893
$\text{U}^{92+} + \text{C}$	Charge Transfer	0.00-1.00 GeV/amu	Th	912
$\text{U}^{92+} + \text{N}_2$	Charge Transfer	88.00-310.00 MeV/amu	Ex	1012
$\text{U}^{92+} + \text{N}_2$	Charge Transfer	286.00 MeV/amu	Ex	1011
$\text{U}^{92+} + \text{Ne}$	Ionization	1.00 GeV/amu	Ex	962
$\text{U}^{92+} + \text{Ar}$	Charge Transfer	286.00 MeV/amu	Ex	1011
$\text{U}^{92+} + \text{Pb}$	Fluorescence	3.00-100.00 MeV/amu	Th	986
$\text{U}^{92+} + \text{Pb}$	Excitation	3.00-100.00 MeV/amu	Th	986
$\text{Bi}^{1+} + \text{H}$	Ionization	1.00-100.00 MeV/amu	Th	823
$\text{Bi}^{1+} + \text{He}$	Ionization	1.00-100.00 MeV/amu	Th	823
$\text{Bi}^{1+} + \text{Li}$	Ionization	1.00-100.00 MeV/amu	Th	823
$\text{Bi}^{1+} + \text{Be}$	Ionization	1.00-100.00 MeV/amu	Th	823
$\text{Bi}^{1+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Bi}^{1+} + \text{N}$	Ionization	1.00-100.00 MeV/amu	Th	823
$\text{Bi}^{1+} + \text{F}$	Ionization	1.00-100.00 MeV/amu	Th	823
$\text{Bi}^{1+} + \text{Ar}$	Ionization	1.00-100.00 MeV/amu	Th	823
$\text{Bi}^{1+} + \text{Xe}$	Ionization	1.00-100.00 MeV/amu	Th	823
$\text{Bi}^{2+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Bi}^{3+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Bi}^{4+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Bi}^{4+} + \text{Bi}^{4+}$	Charge Transfer	2.00-70.00 keV	Ex	815
$\text{Bi}^{4+} + \text{Bi}^{4+}$	Charge Transfer	10.00-60.00 keV	Ex	748
$\text{Bi}^{4+} + \text{Bi}^{4+}$	Ionization	10.00-60.00 keV	Ex	748
$\text{Bi}^{5+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Bi}^{6+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Bi}^{7+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Bi}^{8+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Bi}^{9+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Bi}^{10+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Bi}^{11+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Bi}^{12+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th	816
$\text{Bi}^{25+} + \text{N}_2$	Dissociation	0.06-7.00 MeV	Ex	942
$\text{Bi}^{25+} + \text{N}_2$	Ionization	0.06-7.00 MeV	Ex	942
$\text{Bi}^{26+} + \text{He}$	Ionization	1.40-3.60 MeV/amu	Ex	959
$\text{Bi}^{57+} + \text{N}_2$	Dissociation	0.06-7.00 MeV	Ex	942
$\text{Bi}^{57+} + \text{N}_2$	Ionization	0.06-7.00 MeV	Ex	942

2.3 Surface Interactions

$h\nu + \text{perturbation}$	Surface Interactions	59.50 keV	E/T	1082
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e + H₂O	Surface Interactions	4.00-20.00 keV	Ex	1085
e + Be	Second. Elect. Emission	0.05-4.50 keV	Ex	1141
e + Be	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + C	Surface Interactions	17.00 MeV	Ex	1228
e + C	Second. Elect. Emission	4.00 keV	Th	1165
e + C	Second. Elect. Emission	4.00 keV	Th	1165
e + C	Second. Elect. Emission	5.00-20.00 eV	Ex	1037
e + C	Second. Elect. Emission	3.00 keV	Ex	1034
e + C	Second. Elect. Emission	0.50-15.00 eV	E/T	1032
e + C + Cs	Second. Elect. Emission	3.00 keV	Ex	1034
e + Mg	Second. Elect. Emission	0.05-4.50 keV	Ex	1141
e + Al	Reflection	0.00-1.00 GeV	Th	1108
e + Al	Second. Elect. Emission	3.00 keV; 3.00 MeV	Ex	1184
e + Al	Second. Elect. Emission	0.05-4.50 keV	Ex	1141
e + Al₂O₃	Second. Elect. Emission	3.00 keV; 3.00 MeV	Ex	1184
e + Si	Second. Elect. Emission	3.00 keV	Th	1099
e + Si	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + SiO₂	Second. Elect. Emission	3.00 keV	Th	1099
e + K	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + V	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + Cr	Second. Elect. Emission	4.00-25.00 keV	Th	1294
e + Fe	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + Ni	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + Cu	Second. Elect. Emission	3.00 keV; 3.00 MeV	Ex	1184
e + Cu	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + Rb	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + Nb	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + Mo	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + Ag	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + Cs	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + CeO₂	Second. Elect. Emission	3.00 keV; 3.00 MeV	Ex	1184
e + Eu	Desorption	100.00 eV	Ex	1092
e + Ta	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + W	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + Ir	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + Pt	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + Au	Reflection	20.00-100.00 keV	Ex	1145
e + Au	Reflection	0.00-1.00 GeV	Th	1108
e + Au	Second. Elect. Emission	0.10-2.00 keV	Th	1033
e + MgO	Second. Elect. Emission	1.00-1.50 keV	Ex	1031
e + CaF₂	Second. Elect. Emission	3.00 keV; 3.00 MeV	Ex	1184
e + H + Si	Desorption	12.00 eV	Ex	1301
e + H + Si	Desorption	50.00-300.00 eV	Ex	1216
e + D + C	Desorption	5.00-35.00 eV	Ex	1227
e + H₂O + Ar	Desorption	100.00-500.00 eV	Ex	1172
e + D₂O + Ar	Desorption	1.00 keV	Ex	1317
e + D₂O + Kr	Desorption	1.00 keV	Ex	1317
e + (D + Si)	Desorption	50.00-300.00 eV	Ex	1216
e + H + C	Desorption	5.00-45.00 eV	Ex	1289
e + H + C	Desorption	7.00-18.00 eV	Ex	1226
e + H + C	Desorption	2.00-45.00 eV	Ex	1217
e + H + C	Desorption	7.00-18.00 eV	Ex	1129
e + H + C	Second. Elect. Emission	3.00 keV	Ex	1034
H⁻¹⁺ + Al	Neutraliz., Ioniz., Dissoc.		Th	1314
H⁻¹⁺ + Ag	Surface Interactions	0.50-15.00 keV	Ex	1322
H + Al	Adsorption, Desorption	100.00 keV	Th	1208
H + Al	Neutraliz., Ioniz., Dissoc.	100.00 keV	Th	1208

H + Si	Chemical Reactions	5.00-8.00 keV	Ex	1036
H + Si	Surface Interactions	5.00-8.00 keV	Ex	1036
H + V	Trapping, Detrapping		Th	1271
H + Fe	Reflection	2.00-50.00 keV	Th	1114
H + Fe	Trapping, Detrapping		Ex	1073
H + FeTi	Trapping, Detrapping		Th	1271
H + Ni	Trapping, Detrapping		Th	1271
H + Cu	Adsorption, Desorption		Th	1030
H + Cu	Reflection	2.00-50.00 keV	Th	1114
H + Cu	Trapping, Detrapping		Th	1271
H + Nb	Trapping, Detrapping		Th	1271
H + Nb	Trapping, Detrapping	0.30 eV	Ex	1269
H + Pd	Adsorption, Desorption		Th	1030
H + Pd	Trapping, Detrapping		Th	1272
H + Sn	Adsorption, Desorption	1.30 K	Ex	1296
H + Sn	Trapping, Detrapping	1.30 K	Ex	1296
H + Ta	Trapping, Detrapping		Th	1271
H + Pt	Adsorption, Desorption	1.30 K	Ex	1296
H + Pt	Adsorption, Desorption		Th	1030
H + Pt	Trapping, Detrapping	1.30 K	Ex	1296
H + Au	Reflection	2.00-50.00 keV	Th	1114
H + LiF	Reflection	350.00-800.00 eV	Ex	1232
H + LiF	Second. Elect. Emission	350.00-800.00 eV	Ex	1232
H + LiF	Second. Elect. Emission	0.30-1.50 keV	Ex	1185
H + LiF	Second. Elect. Emission	1.00-20.00 keV	Ex	1138
H + NiTi	Trapping, Detrapping		Th	1271
H + (D + Si)	Desorption		Ex	1230
H + SS	Trapping, Detrapping		Ex	1073
H⁺ + H₂O	Reflection	100.00-500.00 eV	Ex	1172
H⁺ + Li	Chemical Reactions	0.10-15.00 keV	Ex	1075
H⁺ + Li	Desorption	0.10-15.00 keV	Ex	1075
H⁺ + Li	Reflection		Th	1239
H⁺ + Li	Neutraliz., Ioniz., Dissoc.		Th	1239
H⁺ + Li	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex	1075
H⁺ + Li	Trapping, Detrapping	0.10-15.00 keV	Ex	1075
H⁺ + Be	Chemical Reactions	0.10-15.00 keV	Ex	1075
H⁺ + Be	Desorption	0.10-15.00 keV	Ex	1075
H⁺ + Be	Surface Interactions	5.00-20.00 keV	Ex	1191
H⁺ + Be	Reflection	5.00-20.00 keV	Ex	1191
H⁺ + Be	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex	1075
H⁺ + Be	Trapping, Detrapping	0.10-15.00 keV	Ex	1075
H⁺ + B	Chemical Reactions	0.70-5.00 keV	Ex	1067
H⁺ + B	Desorption	0.70-5.00 keV	Ex	1067
H⁺ + B	Sputtering	0.70-5.00 keV	Ex	1067
H⁺ + B	Sputtering	0.70-5.00 keV	Ex	1067
H⁺ + B	Trapping, Detrapping	0.70-5.00 keV	Ex	1067
H⁺ + C	Chemical Reactions	0.10-15.00 keV	Ex	1075
H⁺ + C	Chemical Reactions	0.70-5.00 keV	Ex	1067
H⁺ + C	Chemical Reactions	1.00-10.00 eV	Th	1052
H⁺ + C	Desorption	0.10-15.00 keV	Ex	1075
H⁺ + C	Desorption	0.70-5.00 keV	Ex	1067
H⁺ + C	Second. Elect. Emission	0.10-30.00 keV	Ex	1311
H⁺ + C	Second. Elect. Emission	0.20-9.20 MeV	E/T	1182
H⁺ + C	Second. Elect. Emission	0.10-5.00 keV	Ex	1181
H⁺ + C	Second. Elect. Emission	40.00-240.00 keV	Th	1166
H⁺ + C	Second. Elect. Emission	1.00-2.00 MeV	Ex	1160
H⁺ + C	Second. Elect. Emission	0.04-2.00 MeV	Ex	1159

$H^+ + C$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex	1075
$H^+ + C$	Sputtering	1.00-35.00 eV	Th	1224
$H^+ + C$	Sputtering	0.70-5.00 keV	Ex	1067
$H^+ + C$	Sputtering	0.70-5.00 keV	Ex	1067
$H^+ + C$	Sputtering	1.00-10.00 eV	Th	1052
$H^+ + C$	Trapping, Detrapping	0.10-15.00 keV	Ex	1075
$H^+ + C$	Trapping, Detrapping	0.70-5.00 keV	Ex	1067
$H^+ + CO$	Reflection	100.00-500.00 eV	Ex	1172
$H^+ + O_2$	Chemical Reactions	100.00 keV	Ex	1197
$H^+ + O_2$	Sputtering	100.00 keV	Ex	1197
$H^+ + Mg$	Reflection		Th	1239
$H^+ + Mg$	Neutraliz., Ioniz., Dissoc.		Th	1239
$H^+ + Al$	Adsorption, Desorption	100.00 keV	Th	1208
$H^+ + Al$	Reflection	700.00 keV	Th	1211
$H^+ + Al$	Second. Elect. Emission	700.00 keV	Th	1211
$H^+ + Al$	Second. Elect. Emission	25.00-50.00 keV	Th	1170
$H^+ + Al$	Second. Elect. Emission	3.00-10.00 keV	Th	1128
$H^+ + Al$	Second. Elect. Emission	4.00 keV	Th	1122
$H^+ + Al$	Neutraliz., Ioniz., Dissoc.	100.00 keV	Th	1208
$H^+ + Al$	Trapping, Detrapping	200.00-700.00 keV	Ex	1074
$H^+ + Al_2O_3$	Surface Interactions	0.40-3.00 MeV	Ex	1156
$H^+ + Si$	Reflection	50.00-340.00 keV	Ex	1174
$H^+ + SiO_2$	Surface Interactions	0.40-3.00 MeV	Ex	1156
$H^+ + Cl$	Neutraliz., Ioniz., Dissoc.	1.00-4.00 keV	Ex	1140
$H^+ + Ar$	Reflection	10.00-500.00 eV	Ex	1320
$H^+ + Ar$	Reflection	10.00-500.00 eV	Ex	1304
$H^+ + Ar$	Reflection	0.10-2.00 keV	Ex	1221
$H^+ + Ar$	Reflection	100.00-500.00 eV	Ex	1172
$H^+ + Ar$	Neutraliz., Ioniz., Dissoc.	10.00-500.00 eV	Ex	1320
$H^+ + Ar$	Sputtering	0.10-2.00 keV	Ex	1221
$H^+ + TiN$	Second. Elect. Emission	28.00-182.00 MeV	Ex	1093
$H^+ + Cr$	Second. Elect. Emission	4.00-25.00 keV	Th	1294
$H^+ + Ni$	Reflection	25.00-80.00 keV	Th	1190
$H^+ + Cu$	Reflection	8.00-25.00 keV	Th	1180
$H^+ + Cu$	Second. Elect. Emission	4.00 keV	Th	1122
$H^+ + Ga$	Chemical Reactions	0.10-15.00 keV	Ex	1075
$H^+ + Ga$	Desorption	0.10-15.00 keV	Ex	1075
$H^+ + Ga$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex	1075
$H^+ + Ga$	Trapping, Detrapping	0.10-15.00 keV	Ex	1075
$H^+ + Kr$	Reflection	10.00-500.00 eV	Ex	1320
$H^+ + Kr$	Reflection	10.00-500.00 eV	Ex	1304
$H^+ + Kr$	Reflection	0.10-2.00 keV	Ex	1221
$H^+ + Kr$	Reflection	100.00-500.00 eV	Ex	1172
$H^+ + Kr$	Neutraliz., Ioniz., Dissoc.	10.00-500.00 eV	Ex	1320
$H^+ + Kr$	Sputtering	0.10-2.00 keV	Ex	1221
$H^+ + Nb_2O_5$	Surface Interactions	0.40-3.00 MeV	Ex	1156
$H^+ + Ag$	Surface Interactions	0.50-15.00 keV	Ex	1322
$H^+ + Ag$	Neutraliz., Ioniz., Dissoc.	1.00-4.00 keV	Ex	1140
$H^+ + In$	Reflection		Th	1239
$H^+ + In$	Neutraliz., Ioniz., Dissoc.		Th	1239
$H^+ + Xe$	Reflection	10.00-500.00 eV	Ex	1320
$H^+ + Xe$	Reflection	10.00-500.00 eV	Ex	1304
$H^+ + Xe$	Reflection	0.10-2.00 keV	Ex	1221
$H^+ + Xe$	Reflection	100.00-500.00 eV	Ex	1172
$H^+ + Xe$	Neutraliz., Ioniz., Dissoc.	10.00-500.00 eV	Ex	1320
$H^+ + Xe$	Sputtering	0.10-2.00 keV	Ex	1221
$H^+ + BaZrO_3$	Reflection	0.50-3.00 keV	Ex	1104

$H^+ + W$	Chemical Reactions	0.10-15.00 keV	Ex	1075
$H^+ + W$	Chemical Reactions	2.40-3.00 keV	Ex	1047
$H^+ + W$	Desorption	0.10-15.00 keV	Ex	1075
$H^+ + W$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex	1075
$H^+ + W$	Sputtering	2.40-3.00 keV	Ex	1047
$H^+ + W$	Trapping, Detrapping	1.00 keV	E/T	1275
$H^+ + W$	Trapping, Detrapping	800.00 MeV	Ex	1268
$H^+ + W$	Trapping, Detrapping	0.10-15.00 keV	Ex	1075
$H^+ + Au$	Reflection		Th	1239
$H^+ + Au$	Second. Elect. Emission	0.20-3.00 MeV	Ex	1183
$H^+ + Au$	Second. Elect. Emission	3.00-10.00 keV	Th	1128
$H^+ + Au$	Neutraliz., Ioniz., Dissoc.		Th	1239
$H^+ + PbWO_4$	Surface Interactions	0.90 MeV	Th	1117
$H^+ + LiF$	Reflection	2.00 keV	Ex	1253
$H^+ + LiF$	Reflection	100.00-500.00 eV	Th	1223
$H^+ + LiF$	Second. Elect. Emission	2.00 keV	Ex	1253
$H^+ + SnTe$	Reflection	0.50 MeV/amu	Ex	1188
$H^+ + SnTe$	Second. Elect. Emission	0.50 MeV/amu	Ex	1188
$H^+ + MgO$	Reflection	0.09-3.00 keV	Ex	1164
$H^+ + CsI$	Surface Interactions	20.00 MeV	Th	1203
$H^+ + KCl$	Reflection	0.50 MeV/amu	Ex	1188
$H^+ + KCl$	Second. Elect. Emission	0.50 MeV/amu	Ex	1188
$H^+ + O + Ti$	Desorption	30.00-60.00 eV	Th	1078
$H^+ + SrCeYbO$	Second. Elect. Emission	1.00-100.00 keV	Ex	1238
$H^+ + LiO_2$	Surface Interactions	0.40-3.00 MeV	Ex	1156
$H^+ + SS$	Second. Elect. Emission	28.00-182.00 MeV	Ex	1093
$H_2 + C$	Trapping, Detrapping	1.00 K	Ex	1042
$H_2 + Si$	Adsorption, Desorption	300.00 K	Ex	1229
$H_2 + Si$	Adsorption, Desorption	0.30 eV	Th	1083
$H_2 + Si$	Desorption	0.30 eV	Th	1083
$H_2 + Si$	Neutraliz., Ioniz., Dissoc.	300.00 K	Ex	1229
$H_2 + Si$	Neutraliz., Ioniz., Dissoc.	0.30 eV	Th	1083
$H_2 + Si$	Trapping, Detrapping	300.00 K	Ex	1229
$H_2 + V$	Adsorption, Desorption	88.00 meV	Ex	1326
$H_2 + Cu$	Adsorption, Desorption	0.05 eV	Th	1310
$H_2 + Cu$	Reflection	0.50-1.50 eV	Th	1312
$H_2 + Cu$	Reflection	50.00-450.00 meV	Th	1288
$H_2 + Cu$	Reflection	32.00-46.00 meV	E/T	1231
$H_2 + Cu$	Neutraliz., Ioniz., Dissoc.	0.05 eV	Th	1310
$H_2 + Cu_3Pt$	Adsorption, Desorption	7.60 meV	Th	1299
$H_2 + Cu_3Pt$	Neutraliz., Ioniz., Dissoc.	7.60 meV	Th	1299
$H_2 + Mo$	Adsorption, Desorption	300.00 K	Th	1306
$H_2 + Mo$	Neutraliz., Ioniz., Dissoc.	300.00 K	Th	1306
$H_2 + Pd$	Adsorption, Desorption	0.05 eV	Th	1310
$H_2 + Pd$	Neutraliz., Ioniz., Dissoc.	0.05 eV	Th	1310
$H_2 + BaZrO_3$	Reflection	0.50-3.00 keV	Ex	1104
$H_2 + W$	Adsorption, Desorption	300.00 K	Th	1306
$H_2 + W$	Adsorption, Desorption	300.00 K	Ex	1279
$H_2 + W$	Neutraliz., Ioniz., Dissoc.	300.00 K	Th	1306
$H_2^+ + Be$	Surface Interactions	5.00-20.00 keV	Ex	1191
$H_2^+ + Be$	Reflection	5.00-20.00 keV	Ex	1191
$H_2^+ + C$	Second. Elect. Emission	0.10-5.00 keV	Ex	1181
$H_2^+ + C$	Second. Elect. Emission	40.00-240.00 keV	Th	1166
$H_2^+ + Al_2O_3$	Surface Interactions	0.40-3.00 MeV	Ex	1156
$H_2^+ + SiO_2$	Surface Interactions	0.40-3.00 MeV	Ex	1156
$H_2^+ + Nb_2O_5$	Surface Interactions	0.40-3.00 MeV	Ex	1156
$H_2^+ + BaZrO_3$	Reflection	0.50-3.00 keV	Ex	1104

$\text{H}_2^+ + \text{Au}$	Second. Elect. Emission	0.20-3.00 MeV	Ex	1183
$\text{H}_2^+ + \text{LiF}$	Reflection	0.60-4.00 keV	Ex	1219
$\text{H}_2^+ + \text{LiF}$	Neutraliz., Ioniz., Dissoc.	0.60-4.00 keV	Ex	1219
$\text{H}_2^+ + \text{MgO}$	Reflection	0.09-3.00 keV	Ex	1164
$\text{H}_2^+ + \text{SrCeYbO}$	Second. Elect. Emission	1.00-100.00 keV	Ex	1238
$\text{H}_2^+ + \text{LiO}_2$	Surface Interactions	0.40-3.00 MeV	Ex	1156
$\text{H}_3^+ + \text{Be}$	Surface Interactions	5.00-20.00 keV	Ex	1191
$\text{H}_3^+ + \text{Be}$	Reflection	5.00-20.00 keV	Ex	1191
$\text{H}_3^+ + \text{C}$	Second. Elect. Emission	0.10-5.00 keV	Ex	1181
$\text{H}_3^+ + \text{C}$	Second. Elect. Emission	40.00-240.00 keV	Th	1166
$\text{H}_3^+ + \text{Au}$	Second. Elect. Emission	0.20-3.00 MeV	Ex	1183
$\text{H}_3^+ + \text{SrCeYbO}$	Second. Elect. Emission	1.00-100.00 keV	Ex	1238
$\text{D} + \text{Li}$	Sputtering	0.01-5.00 keV	Th	1058
$\text{D} + \text{Li}$	Trapping, Detrapping	0.01-5.00 keV	Th	1058
$\text{D} + \text{Be}$	Sputtering	100.00 eV	Th	1045
$\text{D} + \text{C}$	Chemical Reactions	0.03-1.00 keV	Ex	1065
$\text{D} + \text{C}$	Chemical Reactions	400.00 eV	Ex	1054
$\text{D} + \text{C}$	Chemical Reactions	15.00-50.00 eV	Th	1046
$\text{D} + \text{C}$	Desorption	15.00-50.00 eV	Th	1046
$\text{D} + \text{C}$	Sputtering	0.03-1.00 keV	Ex	1065
$\text{D} + \text{C}$	Sputtering	0.03-1.00 keV	Ex	1065
$\text{D} + \text{C}$	Sputtering	400.00 eV	Ex	1054
$\text{D} + \text{C}$	Sputtering	400.00 eV	Ex	1054
$\text{D} + \text{C}$	Sputtering	15.00-50.00 eV	Th	1046
$\text{D} + \text{C}$	Trapping, Detrapping	0.03-1.00 keV	Ex	1065
$\text{D} + \text{C}$	Trapping, Detrapping	0.50 keV	Ex	1060
$\text{D} + \text{C}$	Trapping, Detrapping	400.00 eV	Ex	1054
$\text{D} + \text{C} + \text{W}$	Trapping, Detrapping	10.00-100.00 keV	Ex	1039
$\text{D} + \text{SiC}$	Chemical Reactions	0.03-1.00 keV	Ex	1065
$\text{D} + \text{SiC}$	Sputtering	0.03-1.00 keV	Ex	1065
$\text{D} + \text{SiC}$	Sputtering	0.03-1.00 keV	Ex	1065
$\text{D} + \text{SiC}$	Sputtering	0.01-10.00 keV	Ex	1061
$\text{D} + \text{SiC}$	Sputtering	0.01-10.00 keV	Ex	1061
$\text{D} + \text{SiC}$	Trapping, Detrapping	0.03-1.00 keV	Ex	1065
$\text{D} + \text{TiC}$	Chemical Reactions	0.03-1.00 keV	Ex	1065
$\text{D} + \text{TiC}$	Sputtering	0.03-1.00 keV	Ex	1065
$\text{D} + \text{TiC}$	Sputtering	0.03-1.00 keV	Ex	1065
$\text{D} + \text{TiC}$	Trapping, Detrapping	0.03-1.00 keV	Ex	1065
$\text{D} + \text{V}_8\text{C}_7$	Chemical Reactions	0.03-1.00 keV	Ex	1065
$\text{D} + \text{V}_8\text{C}_7$	Sputtering	0.03-1.00 keV	Ex	1065
$\text{D} + \text{V}_8\text{C}_7$	Sputtering	0.03-1.00 keV	Ex	1065
$\text{D} + \text{V}_8\text{C}_7$	Trapping, Detrapping	0.03-1.00 keV	Ex	1065
$\text{D} + \text{Fe}$	Reflection	2.00-50.00 keV	Th	1114
$\text{D} + \text{Cu}$	Reflection	2.00-50.00 keV	Th	1114
$\text{D} + \text{Ga}$	Sputtering	0.01-5.00 keV	Th	1058
$\text{D} + \text{Mo}$	Trapping, Detrapping	1.00-10.00 keV	Ex	1041
$\text{D} + \text{Sn}$	Adsorption, Desorption	1.30 K	Ex	1296
$\text{D} + \text{Sn}$	Sputtering	0.01-5.00 keV	Th	1058
$\text{D} + \text{Sn}$	Trapping, Detrapping	1.30 K	Ex	1296
$\text{D} + \text{Sn}$	Trapping, Detrapping	0.01-5.00 keV	Th	1058
$\text{D} + \text{W}$	Trapping, Detrapping	0.50 keV	Ex	1060
$\text{D} + \text{W}$	Trapping, Detrapping	1.00-10.00 keV	Ex	1041
$\text{D} + \text{W}$	Trapping, Detrapping	10.00-100.00 keV	Ex	1039
$\text{D} + \text{WC}$	Chemical Reactions	0.03-1.00 keV	Ex	1065
$\text{D} + \text{WC}$	Sputtering	0.03-1.00 keV	Ex	1065
$\text{D} + \text{WC}$	Sputtering	0.03-1.00 keV	Ex	1065
$\text{D} + \text{WC}$	Trapping, Detrapping	0.03-1.00 keV	Ex	1065

D + WC	Trapping, Detrapping	10.00-100.00 keV	Ex	1039
D + W₂C	Trapping, Detrapping	0.50 keV	Ex	1060
D + Pt	Adsorption, Desorption	1.30 K	Ex	1296
D + Pt	Trapping, Detrapping	1.30 K	Ex	1296
D + Au	Reflection	2.00-50.00 keV	Th	1114
D + ZrC	Chemical Reactions	0.03-1.00 keV	Ex	1065
D + ZrC	Sputtering	0.03-1.00 keV	Ex	1065
D + ZrC	Sputtering	0.03-1.00 keV	Ex	1065
D + ZrC	Trapping, Detrapping	0.03-1.00 keV	Ex	1065
D⁺ + Li	Chemical Reactions	0.10-15.00 keV	Ex	1075
D⁺ + Li	Desorption	0.10-15.00 keV	Ex	1075
D⁺ + Li	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex	1075
D⁺ + Li	Sputtering	75.00-200.00 eV	Th	1071
D⁺ + Li	Sputtering	0.03-4.00 keV	Th	1057
D⁺ + Li	Sputtering	0.20-1.00 keV	E/T	1056
D⁺ + Li	Trapping, Detrapping	0.10-15.00 keV	Ex	1075
D⁺ + Be	Chemical Reactions	0.10-15.00 keV	Ex	1075
D⁺ + Be	Desorption	0.10-15.00 keV	Ex	1075
D⁺ + Be	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex	1075
D⁺ + Be	Trapping, Detrapping		Ex	1274
D⁺ + Be	Trapping, Detrapping	1.80-8.00 keV	Ex	1273
D⁺ + Be	Trapping, Detrapping	0.10-15.00 keV	Ex	1075
D⁺ + BeO	Trapping, Detrapping	1.80-8.00 keV	Ex	1273
D⁺ + C	Chemical Reactions	20.00-300.00 eV	E/T	1256
D⁺ + C	Chemical Reactions	9.00 eV	Ex	1255
D⁺ + C	Chemical Reactions	0.10-15.00 keV	Ex	1075
D⁺ + C	Chemical Reactions	50.00-200.00 eV	Ex	1068
D⁺ + C	Chemical Reactions	0.03-1.00 keV	Ex	1055
D⁺ + C	Chemical Reactions	400.00 eV	Ex	1054
D⁺ + C	Chemical Reactions	1.00-10.00 eV	Th	1052
D⁺ + C	Desorption	0.10-15.00 keV	Ex	1075
D⁺ + C	Desorption	50.00-200.00 eV	Ex	1068
D⁺ + C	Desorption	0.03-1.00 keV	Ex	1055
D⁺ + C	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex	1075
D⁺ + C	Sputtering	20.00-300.00 eV	E/T	1256
D⁺ + C	Sputtering	9.00 eV	Ex	1255
D⁺ + C	Sputtering	50.00-200.00 eV	Ex	1068
D⁺ + C	Sputtering	50.00-200.00 eV	Ex	1068
D⁺ + C	Sputtering	400.00 eV	Ex	1054
D⁺ + C	Sputtering	400.00 eV	Ex	1054
D⁺ + C	Sputtering	1.00-10.00 eV	Th	1052
D⁺ + C	Trapping, Detrapping	8.00 keV	Ex	1105
D⁺ + C	Trapping, Detrapping	0.10-15.00 keV	Ex	1075
D⁺ + C	Trapping, Detrapping	50.00-200.00 eV	Ex	1068
D⁺ + C	Trapping, Detrapping	400.00 eV	Ex	1054
D⁺ + Al	Trapping, Detrapping	200.00-700.00 keV	Ex	1074
D⁺ + Si	Reflection	0.50-3.00 keV	Ex	1049
D⁺ + Fe	Reflection		Th	1062
D⁺ + Fe	Trapping, Detrapping		E/T	1267
D⁺ + Ni	Reflection		Th	1062
D⁺ + Ga	Chemical Reactions	0.10-15.00 keV	Ex	1075
D⁺ + Ga	Desorption	0.10-15.00 keV	Ex	1075
D⁺ + Ga	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex	1075
D⁺ + Ga	Sputtering	75.00-200.00 eV	Th	1071
D⁺ + Ga	Trapping, Detrapping	0.10-15.00 keV	Ex	1075
D⁺ + Nb	Adsorption, Desorption	2.00-200.00 eV	Ex	1066
D⁺ + Nb	Trapping, Detrapping	2.00-200.00 eV	Ex	1066

D⁺ + Nb	Trapping, Detrapping	5.00-120.00 eV	Ex	1048
D⁺ + Pd	Reflection		Th	1062
D⁺ + W	Chemical Reactions	0.10-15.00 keV	Ex	1075
D⁺ + W	Desorption	0.10-15.00 keV	Ex	1075
D⁺ + W	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex	1075
D⁺ + W	Trapping, Detrapping	1.00 keV	E/T	1275
D⁺ + W	Trapping, Detrapping	1.80-8.00 keV	Ex	1273
D⁺ + W	Trapping, Detrapping	6.00 keV	Ex	1270
D⁺ + W	Trapping, Detrapping	0.10-15.00 keV	Ex	1075
D⁺ + W	Trapping, Detrapping	100.00 eV	Ex	1063
D⁺ + W	Trapping, Detrapping	1.00 keV	Ex	1050
D⁺ + NaCl	Reflection	2.00-10.00 keV	Th	1150
D⁺ + O + Ti	Desorption	30.00-60.00 eV	Th	1078
D⁺ + SS	Reflection		Th	1062
D⁺ + SS	Trapping, Detrapping		E/T	1267
D₂ + Si	Adsorption, Desorption	0.30 eV	Th	1083
D₂ + Si	Desorption	0.30 eV	Th	1083
D₂ + Si	Neutraliz., Ioniz., Dissoc.	0.30 eV	Th	1083
D₂ + V	Adsorption, Desorption	88.00 meV	Ex	1326
D₂ + V	Desorption	300.00 K	Ex	1285
D₂ + V	Reflection	300.00 K	Ex	1285
D₂ + V	Neutraliz., Ioniz., Dissoc.	300.00 K	Ex	1285
D₂ + Cu	Adsorption, Desorption	0.05 eV	Th	1310
D₂ + Cu	Reflection	32.00-46.00 meV	E/T	1231
D₂ + Cu	Neutraliz., Ioniz., Dissoc.	0.05 eV	Th	1310
D₂ + Pd	Adsorption, Desorption	0.05 eV	Th	1310
D₂ + Pd	Neutraliz., Ioniz., Dissoc.	0.05 eV	Th	1310
D₂ + W	Adsorption, Desorption	300.00 K	Ex	1279
D₂⁺ + Mo	Trapping, Detrapping	10.00 keV	Ex	1266
D₂⁺ + W	Trapping, Detrapping	10.00 keV	Ex	1266
D₃⁺ + C	Sputtering	5.00 keV	Ex	1040
D₃⁺ + C	Trapping, Detrapping	1.50 keV	Ex	1044
D₃⁺ + C	Trapping, Detrapping	5.00 keV	Ex	1040
D₃⁺ + Si	Desorption	3.00 keV	Ex	1043
D₃⁺ + Si	Trapping, Detrapping	3.00 keV	Ex	1043
D₃⁺ + W	Trapping, Detrapping	1.50 keV	Ex	1072
D₃⁺ + W	Trapping, Detrapping	1.50 keV	Ex	1044
T + Li	Sputtering	0.01-5.00 keV	Th	1058
T + Li	Trapping, Detrapping	0.01-5.00 keV	Th	1058
T + Be	Trapping, Detrapping		Ex	1059
T + Ga	Sputtering	0.01-5.00 keV	Th	1058
T + Sn	Trapping, Detrapping	0.01-5.00 keV	Th	1058
T⁺ + Be	Trapping, Detrapping		Ex	1274
T⁺ + C	Chemical Reactions	1.00-10.00 eV	Th	1052
T⁺ + C	Sputtering	1.00-10.00 eV	Th	1052
T⁺ + W	Trapping, Detrapping	100.00 eV	Ex	1063
T⁺ + O + Ti	Desorption	30.00-60.00 eV	Th	1078
He + Li	Sputtering	0.01-5.00 keV	Th	1058
He + Be	Sputtering	100.00 eV	Th	1045
He + C	Reflection	0.50-3.00 keV	Ex	1171
He + C₂H₂ + Cu	Reflection	1.00 eV	Th	1215
He + Si	Chemical Reactions	5.00-8.00 keV	Ex	1036
He + Si	Surface Interactions	5.00-8.00 keV	Ex	1036
He + Si	Reflection	0.50-3.00 keV	Ex	1171
He + SiO₂	Adsorption, Desorption	300.00 K	Ex	1096
He + Ti	Adsorption, Desorption	300.00 K	Ex	1096
He + Fe	Reflection	15.00 keV	Th	1118

He + Fe	Reflection	2.00-50.00 keV	Th	1114
He + Fe	Trapping, Detrapping		Ex	1073
He + Cu	Reflection	32.00-46.00 meV	E/T	1231
He + Cu	Reflection	15.00-75.00 meV	E/T	1225
He + Cu	Reflection	2.00-50.00 keV	Th	1114
He + Ga	Sputtering	0.01-5.00 keV	Th	1058
He + Rh	Adsorption, Desorption		E/T	1087
He + Rh	Surface Interactions		E/T	1087
He + Rh	Reflection		Th	1283
He + Rh	Reflection		E/T	1087
He + Rh	Neutraliz., Ioniz., Dissoc.		E/T	1087
He + Ag	Adsorption, Desorption	300.00 K	Ex	1096
He + Ag	Surface Interactions	0.50-15.00 keV	Ex	1322
He + Ag	Reflection	0.50-3.00 keV	Ex	1171
He + Sn	Reflection	0.50-3.00 keV	Ex	1171
He + Sb	Reflection	0.50-3.00 keV	Ex	1171
He + Xe + Cu	Adsorption, Desorption	45.00 meV	Th	1086
He + Xe + Cu	Reflection	45.00 meV	Th	1086
He + Ba	Sputtering	0.25-2.50 keV	Th	1284
He + W	Adsorption, Desorption		E/T	1087
He + W	Surface Interactions		E/T	1087
He + W	Reflection		E/T	1087
He + W	Neutraliz., Ioniz., Dissoc.		E/T	1087
He + Au	Reflection	2.00-50.00 keV	Th	1114
He + Pb	Reflection	0.50-3.00 keV	Ex	1171
He + Bi	Reflection	0.50-3.00 keV	Ex	1171
He + Kr + Pt	Reflection	20.00-83.00 meV	E/T	1088
He + CO + Cu	Reflection	1.00 eV	Th	1215
He + CO + Cu	Reflection	20.00 meV	Th	1089
He + CO + Cu	Reflection	20.00-83.00 meV	E/T	1088
He + CO + Pt	Reflection	20.00-83.00 meV	E/T	1088
He + SS	Trapping, Detrapping		Ex	1073
He⁺ + D	Sputtering	4.00-10.00 keV	Ex	1123
He⁺ + Li	Sputtering	0.20-1.00 keV	E/T	1056
He⁺ + Be	Surface Interactions	5.00-20.00 keV	Ex	1191
He⁺ + Be	Reflection	5.00-20.00 keV	Ex	1191
He⁺ + Be	Second. Elect. Emission	0.05-4.50 keV	Ex	1141
He⁺ + C	Chemical Reactions	0.50-5.00 keV	Ex	1137
He⁺ + C	Reflection	0.50-3.00 keV	Ex	1171
He⁺ + C	Second. Elect. Emission	0.50-3.50 keV	Th	1163
He⁺ + C	Second. Elect. Emission	0.04-2.00 MeV	Ex	1159
He⁺ + O₂	Sputtering	2.00 MeV	Th	1121
He⁺ + Mg	Second. Elect. Emission	0.05-4.50 keV	Ex	1141
He⁺ + Al	Reflection	2.00-8.00 keV	Ex	1264
He⁺ + Al	Reflection	1.00-3.00 keV	Ex	1161
He⁺ + Al	Reflection	0.50-2.00 keV	E/T	1132
He⁺ + Al	Reflection	0.50-2.00 keV	E/T	1132
He⁺ + Al	Second. Elect. Emission	2.00-8.00 keV	Ex	1264
He⁺ + Al	Second. Elect. Emission	16.00-500.00 eV	Ex	1187
He⁺ + Al	Second. Elect. Emission	0.50-3.50 keV	Th	1163
He⁺ + Al	Second. Elect. Emission	0.05-4.50 keV	Ex	1141
He⁺ + Al	Neutraliz., Ioniz., Dissoc.	0.10-3.00 keV	Th	1207
He⁺ + Al	Neutraliz., Ioniz., Dissoc.	16.00-500.00 eV	Ex	1187
He⁺ + Si	Reflection	5.00 keV	Ex	1303
He⁺ + Si	Reflection	0.50-3.00 keV	Ex	1171
He⁺ + Si	Reflection	0.50-3.00 keV	Ex	1049
He⁺ + SiO	Chemical Reactions	0.50-5.00 keV	Ex	1154

He⁺ + SiO₂	Chemical Reactions	0.50-5.00 keV	Ex	1154
He⁺ + Cl	Reflection	1.00-4.00 keV	Ex	1140
He⁺ + Ca	Reflection	1.00-3.00 keV	Ex	1161
He⁺ + Ti	Chemical Reactions	0.50-5.00 keV	Ex	1137
He⁺ + TiO₂	Reflection	0.50-2.00 keV	E/T	1132
He⁺ + TiO₂	Reflection	0.50-2.00 keV	E/T	1132
He⁺ + Fe₃O₄	Reflection	5.00-6.50 keV	Ex	1167
He⁺ + Ni	Reflection	4.00 keV	Ex	1168
He⁺ + Ni	Reflection	0.50-2.00 keV	E/T	1132
He⁺ + Ni	Reflection	0.50-2.00 keV	E/T	1132
He⁺ + NiSi₂	Reflection	1.80 keV	Ex	1325
He⁺ + Cu	Reflection	1.00-3.00 keV	Ex	1161
He⁺ + Cu	Reflection	3.00 keV	E/T	1136
He⁺ + Cu	Reflection	0.50-2.00 keV	E/T	1132
He⁺ + Cu	Reflection	0.50-2.00 keV	E/T	1132
He⁺ + Cu	Second. Elect. Emission	16.00-500.00 eV	Ex	1187
He⁺ + Cu	Second. Elect. Emission	0.50-3.50 keV	Th	1163
He⁺ + Cu	Neutraliz., Ioniz., Dissoc.	16.00-500.00 eV	Ex	1187
He⁺ + Rb	Reflection	0.50-2.00 keV	E/T	1132
He⁺ + Rb	Reflection	0.50-2.00 keV	E/T	1132
He⁺ + Pd	Neutraliz., Ioniz., Dissoc.	0.10-3.00 keV	Th	1207
He⁺ + Ag	Surface Interactions	0.50-15.00 keV	Ex	1322
He⁺ + Ag	Reflection	0.50-3.00 keV	Ex	1171
He⁺ + Ag	Reflection	1.00-4.00 keV	Ex	1140
He⁺ + Sn	Reflection	0.50-3.00 keV	Ex	1171
He⁺ + Sb	Reflection	0.50-3.00 keV	Ex	1171
He⁺ + Ba	Reflection	2.00-5.00 keV	Ex	1234
He⁺ + Ba	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex	1234
He⁺ + W	Reflection	2.00-5.00 keV	Ex	1234
He⁺ + W	Reflection	0.50-5.00 keV	Th	1051
He⁺ + W	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex	1234
He⁺ + W	Trapping, Detrapping	0.50-5.00 keV	Th	1051
He⁺ + Re	Reflection	2.00-5.00 keV	Ex	1234
He⁺ + Re	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex	1234
He⁺ + Au	Reflection	0.50-2.00 keV	E/T	1132
He⁺ + Au	Reflection	0.50-2.00 keV	E/T	1132
He⁺ + Au	Second. Elect. Emission	16.00-500.00 eV	Ex	1187
He⁺ + Au	Second. Elect. Emission	0.20-3.00 MeV	Ex	1183
He⁺ + Au	Second. Elect. Emission	3.00-10.00 keV	Th	1128
He⁺ + Au	Neutraliz., Ioniz., Dissoc.	16.00-500.00 eV	Ex	1187
He⁺ + Pb	Reflection	0.50-3.00 keV	Ex	1171
He⁺ + LiF	Reflection	100.00-500.00 eV	Th	1223
He⁺ + MgO	Reflection	1.80 keV	Ex	1325
He⁺ + MgO	Second. Elect. Emission	0.06-1.00 keV	Ex	1100
He⁺ + MgO	Second. Elect. Emission	200.00 eV	Ex	1038
He⁺ + Bi	Reflection	0.50-3.00 keV	Ex	1171
He⁺ + CsI	Surface Interactions	20.00 MeV	Th	1203
He⁺ + CO + Cu	Chemical Reactions	40.30 meV	E/T	1222
He⁺ + CO + Cu	Reflection	40.30 meV	E/T	1222
He⁺ + CO + Pt	Chemical Reactions	40.30 meV	E/T	1222
He⁺ + CO + Pt	Reflection	40.30 meV	E/T	1222
He⁺ + KI	Reflection	1.80 keV	Ex	1325
He²⁺ + Al	Second. Elect. Emission	3.00 keV; 3.00 MeV	Ex	1184
He²⁺ + Al₂O₃	Second. Elect. Emission	3.00 keV; 3.00 MeV	Ex	1184
He²⁺ + Cu	Second. Elect. Emission	3.00 keV; 3.00 MeV	Ex	1184
He²⁺ + Ag	Surface Interactions	0.50-15.00 keV	Ex	1322
He²⁺ + CeO₂	Second. Elect. Emission	3.00 keV; 3.00 MeV	Ex	1184

He²⁺ + SnTe	Reflection	0.50 MeV/amu	Ex	1188
He²⁺ + SnTe	Second. Elect. Emission	0.50 MeV/amu	Ex	1188
He²⁺ + KCl	Reflection	0.50 MeV/amu	Ex	1188
He²⁺ + KCl	Second. Elect. Emission	0.50 MeV/amu	Ex	1188
He²⁺ + CaF₂	Second. Elect. Emission	3.00 keV; 3.00 MeV	Ex	1184
HeH⁺ + C	Second. Elect. Emission	40.00-240.00 keV	Th	1166
HeH⁺ + Au	Second. Elect. Emission	0.20-3.00 MeV	Ex	1183
Li + Li	Sputtering	0.01-5.00 keV	Th	1058
Li + Ga	Sputtering	0.01-5.00 keV	Th	1058
Li⁺ + Li	Reflection	0.00-1.00 keV	Th	1179
Li⁺ + Li	Sputtering	75.00-200.00 eV	Th	1071
Li⁺ + Li	Sputtering	0.03-4.00 keV	Th	1057
Li⁺ + Li	Sputtering	0.20-1.00 keV	E/T	1056
Li⁺ + C	Reflection	1.70-5.50 MeV	Ex	1146
Li⁺ + Ni	Reflection	4.00 keV	Ex	1168
Li⁺ + Ni	Reflection	4.00 keV	E/T	1148
Li⁺ + Au	Reflection	1.00-6.00 MeV	Ex	1155
Li²⁺ + SnTe	Reflection	0.50 MeV/amu	Ex	1188
Li²⁺ + SnTe	Second. Elect. Emission	0.50 MeV/amu	Ex	1188
Li²⁺ + KCl	Reflection	0.50 MeV/amu	Ex	1188
Li²⁺ + KCl	Second. Elect. Emission	0.50 MeV/amu	Ex	1188
Be⁺ + Be	Reflection	0.00-1.00 keV	Th	1179
Be⁺ + Cu	Sputtering	1.00 keV	Th	1029
Be⁺ + Cu	Sputtering	1.00 keV	Th	1029
B + Si	Adsorption, Desorption	300.00 K	Ex	1094
B⁺ + B	Reflection	0.00-1.00 keV	Th	1179
C + Be	Chemical Reactions	300.00 K	Ex	1070
C + W	Trapping, Detrapping		E/T	1077
C + MgO	Reflection	0.09-3.00 keV	Ex	1164
C⁺ + Be	Sputtering	3.00-5.00 keV	Ex	1069
C⁺ + Be	Sputtering	3.00-5.00 keV	Ex	1069
C⁺ + Be	Trapping, Detrapping	3.00-5.00 keV	Ex	1069
C⁺ + C	Reflection	0.00-1.00 keV	Th	1179
C⁺ + C	Second. Elect. Emission	0.10-30.00 keV	Ex	1311
C⁺ + C	Second. Elect. Emission	0.10-5.00 keV	Ex	1181
C⁺ + W	Chemical Reactions	2.40 keV	Th	1053
C⁺ + W	Chemical Reactions	2.40-3.00 keV	Ex	1047
C⁺ + W	Sputtering	2.40 keV	Th	1053
C⁺ + W	Sputtering	2.40-3.00 keV	Ex	1047
C⁺ + Au	Second. Elect. Emission	5.00 keV/amu	Ex	1246
C⁺ + Au	Second. Elect. Emission	0.10-30.00 keV	Th	1213
C⁺ + Au	Second. Elect. Emission	0.20-3.00 MeV	Ex	1183
C⁺ + Au	Second. Elect. Emission	3.00-10.00 keV	Th	1128
C⁺ + MgO	Reflection	0.09-3.00 keV	Ex	1164
C⁺ + CsI	Surface Interactions	20.00 MeV	Th	1203
C²⁺ + Au	Second. Elect. Emission	5.00 keV/amu	Ex	1246
C⁴⁺ + Al	Second. Elect. Emission	0.01-1.00 keV	Th	1298
C⁵⁺ + Al	Second. Elect. Emission	0.01-1.00 keV	Th	1298
C⁶⁺ + C	Second. Elect. Emission	9.00 MeV/amu	Ex	1237
C⁶⁺ + C + N	Desorption	6.00-13.00 MeV/amu	Ex	1110
CH₃⁺ + W	Chemical Reactions	2.40-3.00 keV	Ex	1047
CH₃⁺ + W	Sputtering	2.40-3.00 keV	Ex	1047
CH₄ + Ni	Adsorption, Desorption	300.00 K	Ex	1305
CH₄ + Ni	Neutraliz., Ioniz., Dissoc.	300.00 K	Ex	1305
CH₄ + Ru	Adsorption, Desorption	300.00 K	Ex	1305
CH₄ + Ru	Neutraliz., Ioniz., Dissoc.	300.00 K	Ex	1305
CH₄ + Pt	Adsorption, Desorption	100.00-600.00 meV	Ex	1316

CH₄ + Pt	Neutraliz., Ioniz., Dissoc.	100.00-600.00 meV	Ex	1316
CH₄ + LiF	Reflection	200.00-800.00 meV	Ex	1095
CO + V	Adsorption, Desorption	88.00 meV	Ex	1326
CO + Cu	Adsorption, Desorption	1.50 eV	Th	1281
CO + Cu	Neutraliz., Ioniz., Dissoc.	300.00 K	Ex	1287
CO + Ru	Reflection	300.00 K	Th	1293
CO⁺ + Be	Sputtering	3.00-5.00 keV	Ex	1069
CO⁺ + Be	Sputtering	3.00-5.00 keV	Ex	1069
CO⁺ + Be	Trapping, Detrapping	3.00-5.00 keV	Ex	1069
CO₂ + Pd	Adsorption, Desorption	8.50-38.00 kJ/mol	Ex	1307
CO₂ + Pd	Neutraliz., Ioniz., Dissoc.	8.50-38.00 kJ/mol	Ex	1307
CO₂ + Pt	Adsorption, Desorption	8.50-38.00 kJ/mol	Ex	1307
CO₂ + Pt	Neutraliz., Ioniz., Dissoc.	8.50-38.00 kJ/mol	Ex	1307
C₂H₂ + LiF	Reflection	242.00 meV	Th	1175
C₂H₂ + LiF	Reflection	242.00 meV	Th	1175
CF₂⁺ + Cu	Sputtering	1.80-3.60 keV	Ex	1204
N⁺ + C	Second. Elect. Emission	15.00-34.00 keV	Ex	1330
N⁺ + C	Second. Elect. Emission	0.10-30.00 keV	Ex	1311
N⁺ + C	Second. Elect. Emission	0.10-5.00 keV	Ex	1181
N⁺ + C	Sputtering	100.00-800.00 eV	Ex	1147
N⁺ + Al	Chemical Reactions	1.60 keV	Ex	1149
N⁺ + Al	Reflection	5.00-50.00 keV	Ex	1309
N⁺ + Al	Second. Elect. Emission	5.00-50.00 keV	Ex	1309
N⁺ + Al	Sputtering	5.00-50.00 keV	Ex	1309
N⁺ + K	Reflection	5.00-50.00 keV	Ex	1309
N⁺ + K	Second. Elect. Emission	5.00-50.00 keV	Ex	1309
N⁺ + K	Sputtering	5.00-50.00 keV	Ex	1309
N⁺ + Ti	Sputtering	400.00-700.00 eV	Ex	1090
N⁺ + Ti	Sputtering	400.00-700.00 eV	Ex	1090
N⁺ + TiN	Sputtering	400.00-700.00 eV	Ex	1090
N⁺ + TiN	Sputtering	400.00-700.00 eV	Ex	1090
N⁺ + Cr	Second. Elect. Emission	15.00-34.00 keV	Ex	1330
N⁺ + Fe	Second. Elect. Emission	150.00 keV	Ex	1192
N⁺ + Cu	Sputtering	1.80-3.60 keV	Ex	1204
N⁺ + Au	Chemical Reactions	0.50-2.00 keV	Ex	1321
N⁺ + Au	Second. Elect. Emission	15.00-34.00 keV	Ex	1330
N⁺ + Au	Second. Elect. Emission	5.00 keV/amu	Ex	1246
N⁺ + Au	Second. Elect. Emission	0.10-30.00 keV	Th	1213
N⁺ + Au	Second. Elect. Emission	0.20-3.00 MeV	Ex	1183
N²⁺ + Fe	Second. Elect. Emission	150.00 keV	Ex	1192
N²⁺ + Au	Second. Elect. Emission	5.00 keV/amu	Ex	1246
N³⁺ + Au	Second. Elect. Emission	5.00 keV/amu	Ex	1246
N⁴⁺ + Fe	Second. Elect. Emission	150.00 keV	Ex	1192
N⁵⁺ + Fe	Second. Elect. Emission	150.00 keV	Ex	1192
N⁶⁺ + Al	Reflection	70.00 eV	Th	1241
N⁶⁺ + Al	Second. Elect. Emission	0.01-1.00 keV	Th	1298
N⁶⁺ + Al	Neutraliz., Ioniz., Dissoc.	70.00 eV	Th	1241
N⁶⁺ + Fe	Second. Elect. Emission	150.00 keV	Ex	1192
N⁶⁺ + Ni	Reflection	2.10 keV/amu	Th	1210
N₂ + Fe	Neutraliz., Ioniz., Dissoc.		Th	1295
N₂ + Ni	Adsorption, Desorption	300.00 K	Th	1280
N₂ + Ni	Neutraliz., Ioniz., Dissoc.	300.00 K	Th	1280
N₂ + Cu	Adsorption, Desorption	300.00 K	Th	1280
N₂ + Cu	Neutraliz., Ioniz., Dissoc.	300.00 K	Th	1280
N₂ + Ru	Neutraliz., Ioniz., Dissoc.		Th	1295
N₂ + Pd	Adsorption, Desorption	300.00 K	Th	1280
N₂ + Pd	Neutraliz., Ioniz., Dissoc.	300.00 K	Th	1280

$\text{N}_2 + \text{Ag}$	Adsorption, Desorption	300.00 K	Th	1280
$\text{N}_2 + \text{Ag}$	Neutraliz., Ioniz., Dissoc.	300.00 K	Th	1280
$\text{N}_2 + \text{Pt}$	Adsorption, Desorption	300.00 K	Th	1280
$\text{N}_2 + \text{Pt}$	Reflection	1.00-2.00 keV	Ex	1130
$\text{N}_2 + \text{Pt}$	Neutraliz., Ioniz., Dissoc.	300.00 K	Th	1280
$\text{N}_2 + \text{Pt}$	Neutraliz., Ioniz., Dissoc.	1.00-2.00 keV	Ex	1130
$\text{N}_2 + \text{Au}$	Adsorption, Desorption	300.00 K	Th	1280
$\text{N}_2 + \text{Au}$	Neutraliz., Ioniz., Dissoc.	300.00 K	Th	1280
$\text{N}_2^+ + \text{C}$	Chemical Reactions	5.00-800.00 eV	Ex	1292
$\text{N}_2^+ + \text{C}$	Desorption	5.00-800.00 eV	Ex	1292
$\text{N}_2^+ + \text{C}$	Second. Elect. Emission	15.00-34.00 keV	Ex	1330
$\text{N}_2^+ + \text{C}$	Second. Elect. Emission	30.00 keV	Ex	1079
$\text{N}_2^+ + \text{C}$	Sputtering	5.00-800.00 eV	Ex	1292
$\text{N}_2^+ + \text{C}$	Sputtering	100.00-800.00 eV	Ex	1147
$\text{N}_2^+ + \text{C}$	Sputtering	30.00 keV	Ex	1079
$\text{N}_2^+ + \text{SiO}$	Chemical Reactions	0.50-5.00 keV	Ex	1154
$\text{N}_2^+ + \text{SiO}_2$	Chemical Reactions	0.50-5.00 keV	Ex	1154
$\text{N}_2^+ + \text{Cr}$	Second. Elect. Emission	15.00-34.00 keV	Ex	1330
$\text{N}_2^+ + \text{Au}$	Second. Elect. Emission	15.00-34.00 keV	Ex	1330
$\text{NO} + \text{Pd}$	Adsorption, Desorption	300.00 K	Ex	1323
$\text{NO} + \text{Pd}$	Neutraliz., Ioniz., Dissoc.	300.00 K	Ex	1323
$\text{O} + \text{Si}$	Sputtering	5.00 keV	Th	1035
$\text{O} + \text{Cu}$	Adsorption, Desorption	5.00-20.00 keV	Ex	1291
$\text{O} + \text{Cu}$	Adsorption, Desorption	600.00 eV	E/T	1214
$\text{O} + \text{Cu}$	Reflection	600.00 eV	E/T	1214
$\text{O} + \text{Cu}$	Trapping, Detrapping	600.00 eV	E/T	1214
$\text{O} + \text{BaZrO}_3$	Reflection	0.50-3.00 keV	Ex	1104
$\text{O} + \text{MgO}$	Reflection	0.09-3.00 keV	Ex	1164
$\text{O}^+ + \text{B}$	Chemical Reactions	0.70-5.00 keV	Ex	1067
$\text{O}^+ + \text{B}$	Desorption	0.70-5.00 keV	Ex	1067
$\text{O}^+ + \text{B}$	Sputtering	0.70-5.00 keV	Ex	1067
$\text{O}^+ + \text{B}$	Sputtering	0.70-5.00 keV	Ex	1067
$\text{O}^+ + \text{B}$	Trapping, Detrapping	0.70-5.00 keV	Ex	1067
$\text{O}^+ + \text{C}$	Chemical Reactions	0.70-5.00 keV	Ex	1067
$\text{O}^+ + \text{C}$	Desorption	0.70-5.00 keV	Ex	1067
$\text{O}^+ + \text{C}$	Second. Elect. Emission	0.10-30.00 keV	Ex	1311
$\text{O}^+ + \text{C}$	Second. Elect. Emission	0.10-5.00 keV	Ex	1181
$\text{O}^+ + \text{C}$	Sputtering	0.70-5.00 keV	Ex	1067
$\text{O}^+ + \text{C}$	Sputtering	0.70-5.00 keV	Ex	1067
$\text{O}^+ + \text{C}$	Trapping, Detrapping	0.70-5.00 keV	Ex	1067
$\text{O}^+ + \text{Al}$	Reflection	5.00-50.00 keV	Ex	1309
$\text{O}^+ + \text{Al}$	Second. Elect. Emission	5.00-50.00 keV	Ex	1309
$\text{O}^+ + \text{Al}$	Second. Elect. Emission	0.60 a.u.	Ex	1209
$\text{O}^+ + \text{Al}$	Sputtering	5.00-50.00 keV	Ex	1309
$\text{O}^+ + \text{Si}$	Reflection	10.00-150.00 eV	Ex	1133
$\text{O}^+ + \text{Si}$	Reflection	10.00-150.00 eV	Ex	1133
$\text{O}^+ + \text{Si}$	Sputtering	10.00-150.00 eV	Ex	1133
$\text{O}^+ + \text{SiO}$	Reflection	10.00-150.00 eV	Ex	1133
$\text{O}^+ + \text{SiO}$	Reflection	10.00-150.00 eV	Ex	1133
$\text{O}^+ + \text{SiO}$	Sputtering	10.00-150.00 eV	Ex	1133
$\text{O}^+ + \text{K}$	Reflection	5.00-50.00 keV	Ex	1309
$\text{O}^+ + \text{K}$	Second. Elect. Emission	5.00-50.00 keV	Ex	1309
$\text{O}^+ + \text{K}$	Sputtering	5.00-50.00 keV	Ex	1309
$\text{O}^+ + \text{TiN}$	Second. Elect. Emission	28.00-182.00 MeV	Ex	1093
$\text{O}^+ + \text{BaZrO}_3$	Reflection	0.50-3.00 keV	Ex	1104
$\text{O}^+ + \text{Au}$	Second. Elect. Emission	5.00 keV/amu	Ex	1246
$\text{O}^+ + \text{Au}$	Second. Elect. Emission	0.10-30.00 keV	Th	1213

$O^+ + Au$	Second. Elect. Emission	0.20-3.00 MeV	Ex	1183
$O^+ + MgO$	Reflection	0.09-3.00 keV	Ex	1164
$O^+ + NaCl$	Reflection	2.00-10.00 keV	Th	1150
$O^+ + SS$	Second. Elect. Emission	28.00-182.00 MeV	Ex	1093
$O^{2+} + Al$	Second. Elect. Emission	0.60 a.u.	Ex	1209
$O^{2+} + Au$	Second. Elect. Emission	5.00 keV/amu	Ex	1246
$O^{2+} + LiF$	Reflection	2.00 keV	Ex	1253
$O^{2+} + LiF$	Reflection	10.00 keV	Ex	1244
$O^{2+} + LiF$	Second. Elect. Emission	2.00 keV	Ex	1253
$O^{2+} + LiF$	Second. Elect. Emission	10.00 keV	Ex	1244
$O^{3+} + Al$	Second. Elect. Emission	0.60 a.u.	Ex	1209
$O^{3+} + Au$	Second. Elect. Emission	5.00 keV/amu	Ex	1246
$O^{3+} + LiF$	Reflection	2.00 keV	Ex	1253
$O^{3+} + LiF$	Reflection	10.00 keV	Ex	1244
$O^{3+} + LiF$	Second. Elect. Emission	2.00 keV	Ex	1253
$O^{3+} + LiF$	Second. Elect. Emission	10.00 keV	Ex	1244
$O^{4+} + Al$	Second. Elect. Emission	0.60 a.u.	Ex	1209
$O^{5+} + Al$	Second. Elect. Emission	0.60 a.u.	Ex	1209
$O^{5+} + LiF$	Reflection	2.00 keV	Ex	1253
$O^{5+} + LiF$	Reflection	10.00 keV	Ex	1244
$O^{5+} + LiF$	Second. Elect. Emission	2.00 keV	Ex	1253
$O^{5+} + LiF$	Second. Elect. Emission	10.00 keV	Ex	1244
$O^{6+} + Al$	Second. Elect. Emission	0.01-1.00 keV	Th	1298
$O^{6+} + Al$	Second. Elect. Emission	78.00-91.00 eV	Ex	1240
$O^{6+} + Al$	Second. Elect. Emission	0.60 a.u.	Ex	1209
$O^{6+} + Si$	Second. Elect. Emission	78.00-91.00 eV	Ex	1240
$O^{6+} + Au$	Reflection	2.50 keV	Ex	1242
$O^{6+} + LiF$	Reflection	2.00 keV	Ex	1253
$O^{6+} + LiF$	Reflection	10.00 keV	Ex	1244
$O^{6+} + LiF$	Second. Elect. Emission	2.00 keV	Ex	1253
$O^{6+} + LiF$	Second. Elect. Emission	10.00 keV	Ex	1244
$O^{7+} + Al$	Second. Elect. Emission	0.01-1.00 keV	Th	1298
$O^{7+} + Al$	Second. Elect. Emission	78.00-91.00 eV	Ex	1240
$O^{7+} + Al$	Second. Elect. Emission	0.60 a.u.	Ex	1209
$O^{7+} + Si$	Second. Elect. Emission	78.00-91.00 eV	Ex	1240
$O^{7+} + Au$	Second. Elect. Emission	3.60-6.15 keV	Ex	1252
$O^{7+} + LiF$	Second. Elect. Emission	3.60-6.15 keV	Ex	1252
$O_2 + Al$	Adsorption, Desorption	10.00-20.00 keV	Ex	1276
$O_2 + Cu$	Neutraliz., Ioniz., Dissoc.		Th	1300
$O_2 + Pd$	Adsorption, Desorption	300.00 K	Ex	1286
$O_2 + Pd$	Desorption	300.00 K	Ex	1286
$O_2 + Pd$	Neutraliz., Ioniz., Dissoc.	300.00 K	Ex	1286
$O_2 + Ag$	Neutraliz., Ioniz., Dissoc.	300.00 K	Th	1278
$O_2 + Ag$	Neutraliz., Ioniz., Dissoc.	40.00-200.00 K	Ex	1084
$O_2 + BaZrO_3$	Reflection	0.50-3.00 keV	Ex	1104
$O_2 + Au$	Adsorption, Desorption	300.00 K	Ex	1318
$O_2 + MgO$	Reflection	0.09-3.00 keV	Ex	1164
$O_2 + MgO$	Reflection	0.09-3.00 keV	Ex	1164
$O_2 + Cs + Ag$	Neutraliz., Ioniz., Dissoc.	300.00 K	Th	1278
$O_2^+ + Al$	Sputtering	5.50 keV	Ex	1091
$O_2^+ + Si$	Sputtering	5.50 keV	Ex	1091
$O_2^+ + SiO_2$	Sputtering	5.50 keV	Ex	1091
$O_2^+ + Ti$	Sputtering	5.50 keV	Ex	1091
$O_2^+ + TiSi_2$	Sputtering	5.50 keV	Ex	1091
$O_2^+ + FeS_2$	Sputtering	6.50-10.00 keV	E/T	1152
$O_2^+ + Co$	Sputtering	5.50 keV	Ex	1091
$O_2^+ + Cu$	Sputtering	5.50 keV	Ex	1091

$\text{O}_2^+ + \text{BaZrO}_3$	Reflection	0.50-3.00 keV	Ex	1104
$\text{O}_2^+ + \text{Ta}$	Sputtering	5.50 keV	Ex	1091
$\text{O}_2^+ + \text{W}$	Sputtering	5.50 keV	Ex	1091
$\text{O}_2^+ + \text{Pt}$	Sputtering	5.50 keV	Ex	1091
$\text{O}_2^+ + \text{Au}$	Second. Elect. Emission	0.20-3.00 MeV	Ex	1183
$\text{O}_2^+ + \text{PbS}$	Sputtering	6.50-10.00 keV	E/T	1152
$\text{O}_2^+ + \text{MgO}$	Reflection	0.09-3.00 keV	Ex	1164
$\text{F} + \text{LiF}$	Reflection		Th	1218
$\text{F} + \text{LiF}$	Neutraliz., Ioniz., Dissoc.		Th	1218
$\text{F}^+ + \text{NaCl}$	Reflection	2.00-10.00 keV	Th	1150
$\text{F}^{5+} + \text{C}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{5+} + \text{Al}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{5+} + \text{Au}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{6+} + \text{C}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{6+} + \text{Al}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{6+} + \text{Au}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{7+} + \text{C}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{7+} + \text{Al}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{7+} + \text{Au}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{8+} + \text{C}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{8+} + \text{Al}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{8+} + \text{Au}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{9+} + \text{C}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{9+} + \text{Al}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}^{9+} + \text{Au}$	Second. Elect. Emission	1.50-2.00 MeV/amu	Ex	1186
$\text{F}_2 + \text{Si}$	Neutraliz., Ioniz., Dissoc.	300.00 K	Ex	1324
$\text{Ne} + \text{C}_2\text{H}_2 + \text{Cu}$	Reflection	1.00 eV	Th	1215
$\text{Ne} + \text{SiO}_2$	Adsorption, Desorption	300.00 K	Ex	1096
$\text{Ne} + \text{Ti}$	Adsorption, Desorption	300.00 K	Ex	1096
$\text{Ne} + \text{Cu}$	Reflection	32.00-46.00 meV	E/T	1231
$\text{Ne} + \text{Ag}$	Adsorption, Desorption	300.00 K	Ex	1096
$\text{Ne} + \text{CO} + \text{Cu}$	Reflection	1.00 eV	Th	1215
$\text{Ne}^+ + \text{Be}$	Surface Interactions	5.00-20.00 keV	Ex	1191
$\text{Ne}^+ + \text{Be}$	Reflection	5.00-20.00 keV	Ex	1191
$\text{Ne}^+ + \text{Be}$	Second. Elect. Emission	0.05-4.50 keV	Ex	1141
$\text{Ne}^+ + \text{C}$	Sputtering	100.00-800.00 eV	Ex	1147
$\text{Ne}^+ + \text{Mg}$	Second. Elect. Emission	0.05-4.50 keV	Ex	1141
$\text{Ne}^+ + \text{Al}$	Surface Interactions	5.00-20.00 keV	Ex	1157
$\text{Ne}^+ + \text{Al}$	Surface Interactions	5.00-20.00 keV	Ex	1157
$\text{Ne}^+ + \text{Al}$	Reflection	5.00-50.00 keV	Ex	1309
$\text{Ne}^+ + \text{Al}$	Reflection	3.00 keV	Ex	1302
$\text{Ne}^+ + \text{Al}$	Reflection	3.00 keV	Ex	1302
$\text{Ne}^+ + \text{Al}$	Reflection	3.00-50.00 keV	Ex	1277
$\text{Ne}^+ + \text{Al}$	Reflection	2.00-8.00 keV	Ex	1264
$\text{Ne}^+ + \text{Al}$	Reflection	0.50-2.00 keV	E/T	1132
$\text{Ne}^+ + \text{Al}$	Reflection	0.50-2.00 keV	E/T	1132
$\text{Ne}^+ + \text{Al}$	Second. Elect. Emission	5.00-50.00 keV	Ex	1309
$\text{Ne}^+ + \text{Al}$	Second. Elect. Emission	3.00-50.00 keV	Ex	1277
$\text{Ne}^+ + \text{Al}$	Second. Elect. Emission	2.00-8.00 keV	Ex	1264
$\text{Ne}^+ + \text{Al}$	Second. Elect. Emission	0.10-10.00 keV	E/T	1258
$\text{Ne}^+ + \text{Al}$	Second. Elect. Emission	5.00 keV	Ex	1142
$\text{Ne}^+ + \text{Al}$	Second. Elect. Emission	0.05-4.50 keV	Ex	1141
$\text{Ne}^+ + \text{Al}$	Second. Elect. Emission	3.00-10.00 keV	Th	1128
$\text{Ne}^+ + \text{Al}$	Sputtering	5.00-50.00 keV	Ex	1309
$\text{Ne}^+ + \text{Al}$	Sputtering	5.00-20.00 keV	Ex	1157
$\text{Ne}^+ + \text{Al}$	Sputtering	5.00-20.00 keV	Ex	1157
$\text{Ne}^+ + \text{Si}$	Surface Interactions	0.10-300.00 keV	Ex	1308

Ne⁺ + Si	Sputtering	0.10-300.00 keV	Ex	1308
Ne⁺ + Cl	Neutraliz., Ioniz., Dissoc.	1.00-4.00 keV	Ex	1140
Ne⁺ + K	Reflection	5.00-50.00 keV	Ex	1309
Ne⁺ + K	Second. Elect. Emission	5.00-50.00 keV	Ex	1309
Ne⁺ + K	Sputtering	5.00-50.00 keV	Ex	1309
Ne⁺ + TiO₂	Reflection	0.50-2.00 keV	E/T	1132
Ne⁺ + TiO₂	Reflection	0.50-2.00 keV	E/T	1132
Ne⁺ + Ni	Reflection	4.00 keV	Ex	1168
Ne⁺ + Ni	Reflection	0.50-2.00 keV	E/T	1132
Ne⁺ + Ni	Reflection	0.50-2.00 keV	E/T	1132
Ne⁺ + Ni	Sputtering	10.00 keV	E/T	1327
Ne⁺ + Cu	Surface Interactions	5.00-20.00 keV	Ex	1157
Ne⁺ + Cu	Surface Interactions	5.00-20.00 keV	Ex	1157
Ne⁺ + Cu	Reflection	3.00 keV	E/T	1136
Ne⁺ + Cu	Reflection	0.50-2.00 keV	E/T	1132
Ne⁺ + Cu	Reflection	0.50-2.00 keV	E/T	1132
Ne⁺ + Cu	Sputtering	5.00-20.00 keV	Ex	1291
Ne⁺ + Cu	Sputtering	5.00-20.00 keV	Ex	1291
Ne⁺ + Cu	Sputtering	5.00-20.00 keV	Ex	1157
Ne⁺ + Cu	Sputtering	5.00-20.00 keV	Ex	1157
Ne⁺ + Cu	Sputtering	1.00 keV	Th	1029
Ne⁺ + Cu	Sputtering	1.00 keV	Th	1029
Ne⁺ + Rb	Reflection	0.50-2.00 keV	E/T	1132
Ne⁺ + Rb	Reflection	0.50-2.00 keV	E/T	1132
Ne⁺ + Ag	Neutraliz., Ioniz., Dissoc.	1.00-4.00 keV	Ex	1140
Ne⁺ + Ba	Reflection	2.00-5.00 keV	Ex	1234
Ne⁺ + Ba	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex	1234
Ne⁺ + W	Reflection	2.00-5.00 keV	Ex	1234
Ne⁺ + W	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex	1234
Ne⁺ + Re	Reflection	2.00-5.00 keV	Ex	1234
Ne⁺ + Re	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex	1234
Ne⁺ + Pt	Reflection	40.00-140.00 eV	Ex	1144
Ne⁺ + Au	Reflection	40.00-140.00 eV	Ex	1144
Ne⁺ + Au	Reflection	0.50-2.00 keV	E/T	1132
Ne⁺ + Au	Reflection	0.50-2.00 keV	E/T	1132
Ne⁺ + Au	Second. Elect. Emission	5.00 keV/amu	Ex	1246
Ne⁺ + Au	Second. Elect. Emission	0.10-30.00 keV	Th	1213
Ne⁺ + Au	Second. Elect. Emission	3.00-10.00 keV	Th	1128
Ne⁺ + LiF	Reflection	2.00 keV	Ex	1162
Ne⁺ + LiF	Second. Elect. Emission	2.00 keV	Ex	1162
Ne⁺ + LiF	Neutraliz., Ioniz., Dissoc.	2.00 keV	Ex	1162
Ne⁺ + MgO	Second. Elect. Emission	0.06-1.00 keV	Ex	1100
Ne⁺ + O + Al	Desorption	5.00-20.00 keV	Ex	1157
Ne⁺ + O + Cu	Desorption	5.00-20.00 keV	Ex	1157
Ne⁺ + KBr	Reflection	3.00 keV	Ex	1302
Ne⁺ + KBr	Reflection	3.00 keV	Ex	1302
Ne²⁺ + Al	Reflection	2.00-8.00 keV	Ex	1264
Ne²⁺ + Al	Second. Elect. Emission	2.00-8.00 keV	Ex	1264
Ne²⁺ + Al	Second. Elect. Emission	0.10-10.00 keV	E/T	1258
Ne²⁺ + Au	Second. Elect. Emission	5.00 keV/amu	Ex	1246
Ne³⁺ + Al	Reflection	2.00-8.00 keV	Ex	1264
Ne³⁺ + Al	Second. Elect. Emission	2.00-8.00 keV	Ex	1264
Ne³⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T	1258
Ne³⁺ + Au	Second. Elect. Emission	5.00 keV/amu	Ex	1246
Ne⁴⁺ + Al	Reflection	2.00-8.00 keV	Ex	1264
Ne⁴⁺ + Al	Second. Elect. Emission	2.00-8.00 keV	Ex	1264
Ne⁴⁺ + Al	Second. Elect. Emission	1.00-4.00 keV	Ex	1177

Ne⁴⁺ + Al	Second. Elect. Emission	1.00-4.00 keV	Ex	1143
Ne⁴⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T	1258
Ne⁵⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T	1258
Ne⁶⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T	1258
Ne⁷⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T	1258
Ne⁸⁺ + Al	Second. Elect. Emission	0.01-1.00 keV	Th	1298
Ne⁸⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T	1258
Ne⁹⁺ + Al	Second. Elect. Emission	0.01-1.00 keV	Th	1298
Ne⁹⁺ + Al	Second. Elect. Emission	0.14-4.50 keV	Th	1251
Ne⁹⁺ + Al	Second. Elect. Emission	78.00-91.00 eV	Ex	1240
Ne⁹⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T	1258
Ne¹⁰⁺ + Ni	Reflection	2.10 keV/amu	Th	1210
Ne¹⁰⁺ + LiF	Neutraliz., Ioniz., Dissoc.	1.00 a.u.	Th	1139
Ne¹⁹⁺ + C	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ne¹⁹⁺ + Al	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ne¹⁹⁺ + Ni	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ne¹⁹⁺ + Ag	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ne¹⁹⁺ + Au	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ne²⁸⁺ + C	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ne²⁸⁺ + Al	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ne²⁸⁺ + Ni	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ne²⁸⁺ + Ag	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ne²⁸⁺ + Au	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Na + Cu	Adsorption, Desorption	600.00 eV	E/T	1214
Na + Cu	Reflection	600.00 eV	E/T	1214
Na + Cu	Trapping, Detrapping	600.00 eV	E/T	1214
Na⁺ + Na + Ru	Second. Elect. Emission	0.12-1.62 keV	Ex	1189
Na⁺ + Cl + Ru	Second. Elect. Emission	0.12-1.62 keV	Ex	1189
Na⁺ + Ni	Reflection	4.00 keV	Ex	1168
Na⁺ + Ru	Second. Elect. Emission	0.12-1.62 keV	Ex	1189
Na⁺ + I + Ru	Second. Elect. Emission	0.12-1.62 keV	Ex	1189
Na⁺ + NaCl	Reflection	2.00-10.00 keV	Th	1150
Al⁺ + Al	Adsorption, Desorption	25.00-150.00 eV	Th	1098
Al⁺ + Al	Sputtering	25.00-150.00 eV	Th	1098
Al⁺ + Si	Sputtering	1.50-3.00 keV	Th	1313
Al⁺ + Si	Sputtering	1.50-3.00 keV	Th	1313
Al₂⁺ + Al	Sputtering	0.20-1.00 keV	Th	1200
Al₂⁺ + Si	Sputtering	1.50-3.00 keV	Th	1313
Al₂⁺ + Si	Sputtering	1.50-3.00 keV	Th	1313
Al₂⁺ + Ni₃Al	Sputtering	0.20-1.00 keV	Th	1200
Si⁺ + Al	Sputtering	0.50-5.00 MeV	Ex	1194
Si⁺ + Si	Reflection	0.00-1.00 keV	Th	1179
Si⁺ + Si	Sputtering	0.50-5.00 MeV	Ex	1194
Si⁺ + GaAs	Sputtering	0.50-5.00 MeV	Ex	1194
Si⁺ + GaP	Sputtering	0.50-5.00 MeV	Ex	1194
P + Si	Adsorption, Desorption	300.00 K	Ex	1094
S⁷⁺ + Au	Sputtering	80.00-200.00 MeV	Ex	1076
Cl⁺ + Al	Sputtering	50.00-600.00 keV	Ex	1263
Cl²⁺ + Al	Sputtering	50.00-600.00 keV	Ex	1263
Cl³⁺ + Al	Sputtering	50.00-600.00 keV	Ex	1263
Cl⁴⁺ + Al	Sputtering	50.00-600.00 keV	Ex	1263
Cl⁵⁺ + Al	Sputtering	50.00-600.00 keV	Ex	1263
Cl⁶⁺ + Al	Sputtering	50.00-600.00 keV	Ex	1263
Cl⁷⁺ + Al	Sputtering	50.00-600.00 keV	Ex	1263
Cl⁸⁺ + Al	Sputtering	50.00-600.00 keV	Ex	1263
Cl⁹⁺ + Al	Sputtering	50.00-600.00 keV	Ex	1263
Cl¹⁰⁺ + Al	Sputtering	50.00-600.00 keV	Ex	1263

Cl₂ + Si	Neutraliz., Ioniz., Dissoc.	300.00 K	Ex	1324
Ar + Si	Sputtering	11.00 keV	Ex	1126
Ar + SiO₂	Adsorption, Desorption	300.00 K	Ex	1096
Ar + Ti	Adsorption, Desorption	300.00 K	Ex	1096
Ar + Cu	Reflection	32.00-46.00 meV	E/T	1231
Ar + Ag	Adsorption, Desorption	300.00 K	Ex	1096
Ar + Ba	Sputtering	0.25-2.50 keV	Th	1284
Ar + H₂ + Al	Desorption	570.00 keV	Ex	1196
Ar + H₂ + Al	Sputtering	570.00 keV	Ex	1196
Ar⁺ + Be	Second. Elect. Emission	0.05-4.50 keV	Ex	1141
Ar⁺ + C	Chemical Reactions	0.50-5.00 keV	Ex	1137
Ar⁺ + C	Second. Elect. Emission	0.04-2.00 MeV	Ex	1159
Ar⁺ + Mg	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Mg	Second. Elect. Emission	0.05-4.50 keV	Ex	1141
Ar⁺ + Al	Surface Interactions	5.00-20.00 keV	Ex	1157
Ar⁺ + Al	Surface Interactions	5.00-20.00 keV	Ex	1157
Ar⁺ + Al	Reflection	5.00-50.00 keV	Ex	1309
Ar⁺ + Al	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Al	Reflection	0.50-2.00 keV	E/T	1132
Ar⁺ + Al	Reflection	0.50-2.00 keV	E/T	1132
Ar⁺ + Al	Second. Elect. Emission	5.00-50.00 keV	Ex	1309
Ar⁺ + Al	Second. Elect. Emission	5.00 keV	Ex	1142
Ar⁺ + Al	Second. Elect. Emission	0.05-4.50 keV	Ex	1141
Ar⁺ + Al	Neutraliz., Ioniz., Dissoc.	40.00 keV	Ex	1319
Ar⁺ + Al	Sputtering	40.00 keV	Ex	1319
Ar⁺ + Al	Sputtering	5.00-50.00 keV	Ex	1309
Ar⁺ + Al	Sputtering	5.00-20.00 keV	Ex	1157
Ar⁺ + Al	Sputtering	5.00-20.00 keV	Ex	1157
Ar⁺ + Al	Sputtering	5.00-20.00 keV	Ex	1157
Ar⁺ + Al	Sputtering	200.00-500.00 eV	Ex	1112
Ar⁺ + Al	Sputtering	0.05-1.00 keV	Th	1097
Ar⁺ + Al₂O₃	Sputtering	0.10-1.50 keV	Ex	1127
Ar⁺ + Si	Surface Interactions	0.10-300.00 keV	Ex	1308
Ar⁺ + Si	Sputtering	0.10-300.00 keV	Ex	1308
Ar⁺ + Si	Sputtering	0.50-5.00 keV	Ex	1193
Ar⁺ + Si	Sputtering	30.00-500.00 eV	Th	1119
Ar⁺ + Si	Sputtering	0.05-1.00 keV	Th	1097
Ar⁺ + SiO	Chemical Reactions	0.50-5.00 keV	Ex	1154
Ar⁺ + SiO₂	Chemical Reactions	0.50-5.00 keV	Ex	1154
Ar⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T	1258
Ar⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T	1258
Ar⁺ + Cl	Neutraliz., Ioniz., Dissoc.	1.00-4.00 keV	Ex	1140
Ar⁺ + Ar	Reflection	0.10-2.00 keV	Ex	1221
Ar⁺ + Ar	Sputtering	0.10-2.00 keV	Ex	1221
Ar⁺ + K	Reflection	5.00-50.00 keV	Ex	1309
Ar⁺ + K	Second. Elect. Emission	5.00-50.00 keV	Ex	1309
Ar⁺ + K	Sputtering	5.00-50.00 keV	Ex	1309
Ar⁺ + CaCeF₂	Sputtering	0.50-5.00 keV	Ex	1153
Ar⁺ + Ti	Chemical Reactions	0.50-5.00 keV	Ex	1137
Ar⁺ + Ti	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Ti	Sputtering	0.05-1.00 keV	Th	1097
Ar⁺ + Ti	Sputtering	400.00-700.00 eV	Ex	1090
Ar⁺ + Ti	Sputtering	400.00-700.00 eV	Ex	1090
Ar⁺ + TiN	Sputtering	400.00-700.00 eV	Ex	1090
Ar⁺ + TiN	Sputtering	400.00-700.00 eV	Ex	1090
Ar⁺ + TiO₂	Reflection	0.50-2.00 keV	E/T	1132
Ar⁺ + TiO₂	Reflection	0.50-2.00 keV	E/T	1132
Ar⁺ + V	Reflection	43.00-95.00 MeV	Ex	1262

Ar⁺ + V	Sputtering	0.05-1.00 keV	Th	1097
Ar⁺ + Cr	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Cr	Sputtering	0.05-1.00 keV	Th	1097
Ar⁺ + Fe	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Fe	Sputtering		Th	1111
Ar⁺ + Fe	Sputtering	0.60-1.00 keV	E/T	1107
Ar⁺ + Fe	Sputtering	0.05-1.00 keV	Th	1097
Ar⁺ + Co	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Co	Sputtering	3.00-15.00 keV	Ex	1125
Ar⁺ + Ni	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Ni	Reflection	25.00-80.00 keV	Th	1190
Ar⁺ + Ni	Reflection	0.50-2.00 keV	E/T	1132
Ar⁺ + Ni	Reflection	0.50-2.00 keV	E/T	1132
Ar⁺ + Ni	Sputtering	20.00 keV	Th	1328
Ar⁺ + Ni	Sputtering	3.00-15.00 keV	Ex	1125
Ar⁺ + Ni	Sputtering	0.05-1.00 keV	Th	1097
Ar⁺ + Cu	Surface Interactions	0.10-300.00 keV	Ex	1308
Ar⁺ + Cu	Surface Interactions	5.00-20.00 keV	Ex	1157
Ar⁺ + Cu	Surface Interactions	5.00-20.00 keV	Ex	1157
Ar⁺ + Cu	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Cu	Reflection	3.00 keV	E/T	1136
Ar⁺ + Cu	Reflection	0.50-2.00 keV	E/T	1132
Ar⁺ + Cu	Reflection	0.50-2.00 keV	E/T	1132
Ar⁺ + Cu	Reflection	5.00 keV	Th	1115
Ar⁺ + Cu	Second. Elect. Emission	2.40-125.00 eV/amu	Ex	1247
Ar⁺ + Cu	Sputtering	0.10-300.00 keV	Ex	1308
Ar⁺ + Cu	Sputtering	5.00-20.00 keV	Ex	1291
Ar⁺ + Cu	Sputtering	5.00-20.00 keV	Ex	1291
Ar⁺ + Cu	Sputtering	400.00-800.00 eV	E/T	1236
Ar⁺ + Cu	Sputtering	5.00 keV	Th	1205
Ar⁺ + Cu	Sputtering	1.80-3.60 keV	Ex	1204
Ar⁺ + Cu	Sputtering	3.00 keV	Th	1202
Ar⁺ + Cu	Sputtering	5.00-20.00 keV	Ex	1157
Ar⁺ + Cu	Sputtering	5.00-20.00 keV	Ex	1157
Ar⁺ + Cu	Sputtering	3.00-15.00 keV	Ex	1125
Ar⁺ + Cu	Sputtering	0.60-8.00 keV	Th	1120
Ar⁺ + Cu	Sputtering	5.00 keV	Th	1115
Ar⁺ + Cu	Sputtering	0.05-1.00 keV	Th	1097
Ar⁺ + Cu	Sputtering	1.00 keV	Th	1029
Ar⁺ + Cu	Sputtering	1.00 keV	Th	1029
Ar⁺ + Cu + Ni	Chemical Reactions	5.00 keV	Ex	1282
Ar⁺ + Cu + Ni	Desorption	5.00 keV	Ex	1282
Ar⁺ + Cu + Ni	Sputtering	5.00 keV	Ex	1282
Ar⁺ + Zn	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Ge	Sputtering	0.50-5.00 keV	Ex	1193
Ar⁺ + Ge	Sputtering	0.05-100.00 keV	Th	1151
Ar⁺ + Ge	Sputtering	0.05-1.00 keV	Th	1097
Ar⁺ + Kr	Reflection	0.10-2.00 keV	Ex	1221
Ar⁺ + Kr	Sputtering	0.10-2.00 keV	Ex	1221
Ar⁺ + Rb	Reflection	0.50-2.00 keV	E/T	1132
Ar⁺ + Rb	Reflection	0.50-2.00 keV	E/T	1132
Ar⁺ + Rb	Sputtering	0.60-8.00 keV	Th	1120
Ar⁺ + Sr	Sputtering	3.00-15.00 keV	Ex	1125
Ar⁺ + Y	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Zr	Sputtering	0.05-1.00 keV	Th	1097
Ar⁺ + Nb	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Nb	Sputtering		Th	1111

Ar⁺ + Mo	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Rh	Sputtering	0.05-1.00 keV	Th	1097
Ar⁺ + Ag	Neutraliz., Ioniz., Dissoc.	1.00-4.00 keV	Ex	1140
Ar⁺ + Ag	Sputtering	5.00-15.00 keV	E/T	1235
Ar⁺ + Ag	Sputtering	3.00-15.00 keV	Ex	1125
Ar⁺ + Ag	Sputtering		Th	1111
Ar⁺ + Sn	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Sn	Sputtering	3.00 keV	Ex	1116
Ar⁺ + Xe	Reflection	0.10-2.00 keV	Ex	1221
Ar⁺ + Xe	Sputtering	0.10-2.00 keV	Ex	1221
Ar⁺ + Cs	Sputtering	0.60-8.00 keV	Th	1120
Ar⁺ + Ba	Reflection	2.00-5.00 keV	Ex	1234
Ar⁺ + Ba	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex	1234
Ar⁺ + Nd	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Tb	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Ho	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Ta	Reflection	43.00-95.00 MeV	Ex	1262
Ar⁺ + Ta	Sputtering		Th	1111
Ar⁺ + W	Reflection	2.00-5.00 keV	Ex	1234
Ar⁺ + W	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex	1234
Ar⁺ + W	Sputtering	0.60-8.00 keV	Th	1120
Ar⁺ + W	Sputtering	0.05-1.00 keV	Th	1097
Ar⁺ + Re	Reflection	2.00-5.00 keV	Ex	1234
Ar⁺ + Re	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex	1234
Ar⁺ + Pt	Sputtering	0.20-50.00 keV	Th	1106
Ar⁺ + Au	Reflection	0.50-2.00 keV	E/T	1132
Ar⁺ + Au	Reflection	0.50-2.00 keV	E/T	1132
Ar⁺ + Au	Sputtering	0.10-1.50 keV	Ex	1127
Ar⁺ + Au	Sputtering	0.60-8.00 keV	Th	1120
Ar⁺ + Pb	Sputtering	3.00 keV	Th	1202
Ar⁺ + perturbation	Reflection	50.00-500.00 eV	Th	1113
Ar⁺ + perturbation	Sputtering	0.05-100.00 keV	Th	1151
Ar⁺ + perturbation	Sputtering	50.00-500.00 eV	Th	1113
Ar⁺ + perturbation	Sputtering	0.60-1.00 keV	E/T	1107
Ar⁺ + GaAs	Sputtering	5.00 keV	Ex	1173
Ar⁺ + CsI	Reflection	3.00-30.00 keV	Ex	1176
Ar⁺ + O + Al	Desorption	10.00-20.00 keV	Ex	1276
Ar⁺ + O + Al	Desorption	5.00-20.00 keV	Ex	1157
Ar⁺ + O + Al	Sputtering	10.00-20.00 keV	Ex	1276
Ar⁺ + O + Cu	Desorption	5.00-20.00 keV	Ex	1157
Ar⁺ + CaF₂	Sputtering	0.50-5.00 keV	Ex	1153
Ar⁺ + SrCeYbO	Second. Elect. Emission	1.00-100.00 keV	Ex	1238
Ar²⁺ + Cu	Second. Elect. Emission	2.40-125.00 eV/amu	Ex	1247
Ar²⁺ + Au	Reflection	2.40-35.00 keV	Ex	1259
Ar²⁺ + LiF	Second. Elect. Emission	450.00-900.00 eV/amu	Ex	1257
Ar²⁺ + CsI	Reflection	3.00-30.00 keV	Ex	1176
Ar³⁺ + Al₂O₃	Sputtering	0.10-1.50 keV	Ex	1127
Ar³⁺ + Au	Reflection	2.40-35.00 keV	Ex	1259
Ar³⁺ + Au	Sputtering	0.10-1.50 keV	Ex	1127
Ar³⁺ + CsI	Reflection	3.00-30.00 keV	Ex	1176
Ar⁴⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T	1258
Ar⁴⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T	1258
Ar⁴⁺ + Au	Reflection	2.40-35.00 keV	Ex	1259
Ar⁴⁺ + CsI	Reflection	3.00-30.00 keV	Ex	1176
Ar⁵⁺ + Au	Reflection	2.40-35.00 keV	Ex	1259
Ar⁵⁺ + CsI	Reflection	3.00-30.00 keV	Ex	1176
Ar⁶⁺ + Au	Reflection	2.40-35.00 keV	Ex	1259

Ar⁶⁺ + Au	Reflection	4.00 keV	Ex	1243
Ar⁶⁺ + Au	Second. Elect. Emission	0.45 keV/amu	Ex	1254
Ar⁶⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex	1243
Ar⁶⁺ + CsI	Reflection	3.00-30.00 keV	Ex	1176
Ar⁷⁺ + Au	Reflection	2.00-8.00 keV	Ex	1261
Ar⁷⁺ + Au	Reflection	2.40-35.00 keV	Ex	1259
Ar⁷⁺ + Au	Reflection	4.00 keV	Ex	1243
Ar⁷⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex	1243
Ar⁷⁺ + CsI	Reflection	3.00-30.00 keV	Ex	1176
Ar⁸⁺ + Al	Second. Elect. Emission	0.01-1.00 keV	Th	1298
Ar⁸⁺ + Al₂O₃	Sputtering	0.10-1.50 keV	Ex	1127
Ar⁸⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T	1258
Ar⁸⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T	1258
Ar⁸⁺ + Au	Reflection	2.00-8.00 keV	Ex	1261
Ar⁸⁺ + Au	Reflection	2.40-35.00 keV	Ex	1259
Ar⁸⁺ + Au	Reflection	4.00 keV	Ex	1243
Ar⁸⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex	1243
Ar⁸⁺ + Au	Sputtering	0.10-1.50 keV	Ex	1127
Ar⁸⁺ + LiF	Second. Elect. Emission	450.00-900.00 eV/amu	Ex	1257
Ar⁸⁺ + CsI	Reflection	3.00-30.00 keV	Ex	1176
Ar⁹⁺ + Al	Second. Elect. Emission	0.01-1.00 keV	Th	1298
Ar⁹⁺ + Al₂O₃	Sputtering	0.10-1.50 keV	Ex	1127
Ar⁹⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T	1258
Ar⁹⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T	1258
Ar⁹⁺ + Au	Reflection	2.00-8.00 keV	Ex	1261
Ar⁹⁺ + Au	Reflection	2.40-35.00 keV	Ex	1259
Ar⁹⁺ + Au	Reflection	4.00 keV	Ex	1243
Ar⁹⁺ + Au	Reflection	20.00 keV	Ex	1178
Ar⁹⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex	1243
Ar⁹⁺ + Au	Sputtering	0.10-1.50 keV	Ex	1127
Ar⁹⁺ + LiF	Second. Elect. Emission	450.00-900.00 eV/amu	Ex	1257
Ar⁹⁺ + CsI	Reflection	3.00-30.00 keV	Ex	1176
Ar¹⁰⁺ + Au	Reflection	2.00-8.00 keV	Ex	1261
Ar¹⁰⁺ + Au	Reflection	2.40-35.00 keV	Ex	1259
Ar¹⁰⁺ + Au	Reflection	4.00 keV	Ex	1243
Ar¹⁰⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex	1243
Ar¹⁰⁺ + CsI	Reflection	3.00-30.00 keV	Ex	1176
Ar¹¹⁺ + Au	Reflection	2.00-8.00 keV	Ex	1261
Ar¹¹⁺ + Au	Reflection	2.40-35.00 keV	Ex	1259
Ar¹¹⁺ + Au	Reflection	4.00 keV	Ex	1243
Ar¹¹⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex	1243
Ar¹¹⁺ + CsI	Reflection	3.00-30.00 keV	Ex	1176
Ar¹²⁺ + Au	Reflection	2.00-8.00 keV	Ex	1261
Ar¹²⁺ + Au	Reflection	2.40-35.00 keV	Ex	1259
Ar¹²⁺ + Au	Reflection	4.00 keV	Ex	1243
Ar¹²⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex	1243
Ar¹³⁺ + Au	Reflection	2.00-8.00 keV	Ex	1261
Ar¹³⁺ + Au	Reflection	2.40-35.00 keV	Ex	1259
Ar¹³⁺ + Au	Reflection	4.00 keV	Ex	1243
Ar¹³⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex	1243
Ar¹⁷⁺ + C	Second. Elect. Emission	390.00 MeV/amu	Ex	1248
Ar¹⁷⁺ + C + N	Desorption	6.00-13.00 MeV/amu	Ex	1110
Ar¹⁷⁺ + SiO₂	Surface Interactions	130.00-200.00 keV	Ex	1080
Ar¹⁷⁺ + N₂ + C	Desorption	6.00-13.00 MeV/amu	Ex	1260
Ar¹⁸⁺ + C	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ar¹⁸⁺ + C	Second. Elect. Emission	13.60-93.00 MeV/amu	Th	1249
Ar¹⁸⁺ + Al	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265

Ar¹⁸⁺ + Ni	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ar¹⁸⁺ + Ag	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ar¹⁸⁺ + Au	Second. Elect. Emission	45.00-95.00 MeV/amu	Ex	1265
Ca²⁰⁺ + C	Second. Elect. Emission	9.00 MeV/amu	Ex	1237
V + Si	Sputtering	30.00-50.00 keV	Ex	1103
Fe⁺ + Au	Reflection	1.00-6.00 MeV	Ex	1155
Fe⁺ + NaCl	Reflection	2.00-10.00 keV	Th	1150
Co + Si	Sputtering	30.00-50.00 keV	Ex	1103
Co⁺ + Au	Second. Elect. Emission	0.20-3.00 MeV	Ex	1183
Ni + Si	Sputtering	30.00-50.00 keV	Ex	1103
Ni⁺ + SiO₂	Sputtering	89.00 MeV	Ex	1201
Ni⁺ + Ni	Adsorption, Desorption	25.00-150.00 eV	Th	1098
Ni⁺ + Ni	Reflection	0.00-1.00 keV	Th	1179
Ni⁺ + Ni	Sputtering	25.00-150.00 eV	Th	1098
Ni⁶⁺ + Au	Sputtering	80.00-200.00 MeV	Ex	1076
Ni¹⁹⁺ + C	Second. Elect. Emission	45.00 MeV/amu	Ex	1206
Ni¹⁹⁺ + Al	Second. Elect. Emission	45.00 MeV/amu	Ex	1206
Ni¹⁹⁺ + Au	Second. Elect. Emission	45.00 MeV/amu	Ex	1206
Ni²⁴⁺ + C + N	Desorption	6.00-13.00 MeV/amu	Ex	1110
Ni²⁸⁺ + C	Second. Elect. Emission	45.00 MeV/amu	Ex	1206
Ni²⁸⁺ + Al	Second. Elect. Emission	45.00 MeV/amu	Ex	1206
Ni²⁸⁺ + Ni	Second. Elect. Emission	45.00 MeV/amu	Ex	1206
Ni²⁸⁺ + Ag	Second. Elect. Emission	45.00 MeV/amu	Ex	1206
Ni²⁸⁺ + Au	Second. Elect. Emission	45.00 MeV/amu	Ex	1206
Cu⁻¹⁺ + Al₂O₃	Reflection	60.00 keV	Ex	1109
Cu⁻¹⁺ + Al₂O₃	Sputtering	60.00 keV	Ex	1109
Cu⁻¹⁺ + MgO	Reflection	60.00 keV	Ex	1109
Cu⁻¹⁺ + MgO	Sputtering	60.00 keV	Ex	1109
Cu⁺ + MgAl₂O₃	Desorption	60.00 keV	Ex	1158
Cu⁺ + Cu	Sputtering	1.00 keV	Th	1029
Cu⁺ + Cu	Sputtering	1.00 keV	Th	1029
Cu⁺ + MgO	Desorption	60.00 keV	Ex	1158
Cu⁺ + LiNbO₃	Desorption	60.00 keV	Ex	1158
Ga⁺ + Ga	Sputtering	75.00-200.00 eV	Th	1071
Ge²⁸⁺ + C + N	Desorption	6.00-13.00 MeV/amu	Ex	1110
Kr + SiO₂	Adsorption, Desorption	300.00 K	Ex	1096
Kr + Ti	Adsorption, Desorption	300.00 K	Ex	1096
Kr + Cu	Reflection	32.00-46.00 meV	E/T	1231
Kr + Ag	Adsorption, Desorption	300.00 K	Ex	1096
Kr⁺ + Be	Surface Interactions	5.00-20.00 keV	Ex	1191
Kr⁺ + Be	Reflection	5.00-20.00 keV	Ex	1191
Kr⁺ + Si	Surface Interactions	0.10-300.00 keV	Ex	1308
Kr⁺ + Si	Sputtering	0.10-300.00 keV	Ex	1308
Kr⁺ + Ni	Sputtering	0.20-1.40 GeV	Ex	1329
Kr⁺ + Cu	Surface Interactions	0.10-300.00 keV	Ex	1308
Kr⁺ + Cu	Surface Interactions	10.00 MeV/amu	E/T	1081
Kr⁺ + Cu	Reflection	3.00 keV	E/T	1136
Kr⁺ + Cu	Reflection	5.00 keV	Th	1115
Kr⁺ + Cu	Second. Elect. Emission	2.40-125.00 eV/amu	Ex	1247
Kr⁺ + Cu	Sputtering	0.10-300.00 keV	Ex	1308
Kr⁺ + Cu	Sputtering	5.00 keV	Th	1115
Kr⁺ + Au	Sputtering	0.20-1.40 GeV	Ex	1329
Kr⁺ + GaAs	Sputtering	5.00 keV	Ex	1173
Kr²⁺ + Cu	Second. Elect. Emission	2.40-125.00 eV/amu	Ex	1247
Rb⁺ + Cu	Reflection	10.00-250.00 eV	Ex	1131
Rb⁺ + Cu	Reflection	10.00-250.00 eV	Ex	1131
Mo⁺ + Mo	Reflection	0.00-1.00 keV	Th	1179

Mo³⁹⁺ + C	Second. Elect. Emission	9.00 MeV/amu	Ex	1237
Pd + MoS₂	Adsorption, Desorption		Th	1315
Ag⁺ + Ag	Sputtering	21.00 keV	Ex	1198
Ag₂⁺ + Ag	Sputtering	21.00 keV	Ex	1198
Ag₃⁺ + Ag	Sputtering	21.00 keV	Ex	1198
I⁹⁺ + Au	Sputtering	80.00-200.00 MeV	Ex	1076
I¹²⁺ + Au	Sputtering	80.00-200.00 MeV	Ex	1076
Xe⁺ + Al	Sputtering	200.00-500.00 eV	Ex	1112
Xe⁺ + Si	Surface Interactions	0.10-300.00 keV	Ex	1308
Xe⁺ + Si	Sputtering	0.10-300.00 keV	Ex	1308
Xe⁺ + Cu	Surface Interactions	10.00 MeV/amu	E/T	1081
Xe⁺ + Cu	Reflection	2.00-10.00 keV	Ex	1245
Xe⁺ + Cu	Reflection	3.00 keV	E/T	1136
Xe⁺ + Cu	Reflection	5.00 keV	Th	1115
Xe⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex	1245
Xe⁺ + Cu	Sputtering	0.60-8.00 keV	Th	1120
Xe⁺ + Cu	Sputtering	5.00 keV	Th	1115
Xe⁺ + Cu	Sputtering	1.00 keV	Th	1029
Xe⁺ + Cu	Sputtering	1.00 keV	Th	1029
Xe⁺ + Rb	Sputtering	0.60-8.00 keV	Th	1120
Xe⁺ + In	Sputtering	15.00 keV	Ex	1199
Xe⁺ + Cs	Sputtering	0.60-8.00 keV	Th	1120
Xe⁺ + W	Sputtering	0.60-8.00 keV	Th	1120
Xe⁺ + Au	Second. Elect. Emission	0.10-30.00 keV	Th	1213
Xe⁺ + Au	Second. Elect. Emission	3.00-10.00 keV	Th	1128
Xe⁺ + Au	Sputtering	0.60-8.00 keV	Th	1120
Xe²⁺ + Cu	Reflection	2.00-10.00 keV	Ex	1245
Xe²⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex	1245
Xe³⁺ + Cu	Reflection	2.00-10.00 keV	Ex	1245
Xe³⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex	1245
Xe⁴⁺ + Cu	Reflection	2.00-10.00 keV	Ex	1245
Xe⁴⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex	1245
Xe⁵⁺ + Cu	Reflection	2.00-10.00 keV	Ex	1245
Xe⁵⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex	1245
Xe⁶⁺ + Cu	Reflection	2.00-10.00 keV	Ex	1245
Xe⁶⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex	1245
Xe⁷⁺ + C	Sputtering	700.00 eV	Ex	1250
Xe⁷⁺ + Cu	Reflection	2.00-10.00 keV	Ex	1245
Xe⁷⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex	1245
Xe⁸⁺ + Cu	Reflection	2.00-10.00 keV	Ex	1245
Xe⁸⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex	1245
Xe⁹⁺ + Al₂O₃	Sputtering	0.10-1.50 keV	Ex	1127
Xe⁹⁺ + Cu	Reflection	2.00-10.00 keV	Ex	1245
Xe⁹⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex	1245
Xe⁹⁺ + Au	Sputtering	0.10-1.50 keV	Ex	1127
Xe¹⁰⁺ + Cu	Reflection	2.00-10.00 keV	Ex	1245
Xe¹⁰⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex	1245
Xe¹⁴⁺ + Al₂O₃	Sputtering	0.10-1.50 keV	Ex	1127
Xe¹⁴⁺ + Au	Sputtering	0.10-1.50 keV	Ex	1127
Xe¹⁵⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁵⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁵⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T	1258
Xe¹⁵⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T	1258
Xe¹⁵⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁵⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁶⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁶⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124

Xe¹⁶⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁶⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁷⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁷⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁷⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁷⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁷⁺ + Au	Neutraliz., Ioniz., Dissoc.		Ex	1169
Xe¹⁸⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁸⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁸⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁸⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁹⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁹⁺ + Al₂O₃	Sputtering	0.10-1.50 keV	Ex	1127
Xe¹⁹⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁹⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁹⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe¹⁹⁺ + Au	Sputtering	0.10-1.50 keV	Ex	1127
Xe²⁰⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁰⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁰⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T	1258
Xe²⁰⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T	1258
Xe²⁰⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁰⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁰⁺ + Au	Neutraliz., Ioniz., Dissoc.		Ex	1169
Xe²¹⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²¹⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²¹⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²¹⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²²⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²²⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²²⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²²⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²³⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²³⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²³⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²³⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁴⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁴⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁴⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁴⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁵⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁵⁺ + Al₂O₃	Sputtering	0.10-1.50 keV	Ex	1127
Xe²⁵⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁵⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T	1258
Xe²⁵⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T	1258
Xe²⁵⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁵⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁵⁺ + Au	Sputtering	0.10-1.50 keV	Ex	1127
Xe²⁶⁺ + C	Surface Interactions	182.00-441.00 keV	Ex	1212
Xe²⁶⁺ + C	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Xe²⁶⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁶⁺ + Si	Surface Interactions	182.00-441.00 keV	Ex	1212
Xe²⁶⁺ + Si	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Xe²⁶⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁶⁺ + SiO₂	Surface Interactions	182.00-441.00 keV	Ex	1212
Xe²⁶⁺ + SiO₂	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Xe²⁶⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124

Xe²⁶⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁶⁺ + Ag	Surface Interactions	182.00-441.00 keV	Ex	1212
Xe²⁶⁺ + Ag	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Xe²⁶⁺ + Au	Surface Interactions	182.00-441.00 keV	Ex	1212
Xe²⁶⁺ + Au	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Xe²⁷⁺ + C	Surface Interactions	182.00-441.00 keV	Ex	1212
Xe²⁷⁺ + C	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Xe²⁷⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁷⁺ + Si	Surface Interactions	182.00-441.00 keV	Ex	1212
Xe²⁷⁺ + Si	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Xe²⁷⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁷⁺ + SiO₂	Surface Interactions	182.00-441.00 keV	Ex	1212
Xe²⁷⁺ + SiO₂	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Xe²⁷⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁷⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁷⁺ + Ag	Surface Interactions	182.00-441.00 keV	Ex	1212
Xe²⁷⁺ + Ag	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Xe²⁷⁺ + Au	Surface Interactions	182.00-441.00 keV	Ex	1212
Xe²⁷⁺ + Au	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Xe²⁸⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁸⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁸⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁸⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁹⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁹⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁹⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe²⁹⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁰⁺ + C	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁰⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁰⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁰⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁰⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³¹⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³¹⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³¹⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³¹⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³²⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³²⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³²⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³²⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³³⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³³⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³³⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³³⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁴⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁴⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁴⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁴⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁵⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁵⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁵⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁵⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁶⁺ + C	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁶⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁶⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁶⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁶⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124

Xe³⁷⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁷⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁷⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁷⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁸⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁸⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁸⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁸⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁹⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁹⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁹⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe³⁹⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴⁰⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴⁰⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴⁰⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴⁰⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴¹⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴¹⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴¹⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴¹⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴²⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴²⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴²⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴²⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴³⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴³⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴³⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴³⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴⁴⁺ + C	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴⁴⁺ + C + N	Desorption	6.00-13.00 MeV/amu	Ex	1110
Xe⁴⁴⁺ + Al	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴⁴⁺ + Si	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴⁴⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex	1124
Xe⁴⁴⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex	1124
Cs⁺ + D₂O	Chemical Reactions	30.00 eV	Ex	1134
Cs⁺ + D₂O	Reflection	30.00 eV	Ex	1134
Cs⁺ + D₂O	Sputtering	30.00 eV	Ex	1134
Cs⁺ + C	Sputtering	14.50 keV	Ex	1220
Cs⁺ + NH₃	Chemical Reactions	30.00 eV	Ex	1134
Cs⁺ + NH₃	Reflection	30.00 eV	Ex	1134
Cs⁺ + NH₃	Sputtering	30.00 eV	Ex	1134
Cs⁺ + Al	Sputtering	5.50 keV	Ex	1091
Cs⁺ + Si	Sputtering	5.50 keV	Ex	1091
Cs⁺ + Si₃N₄	Sputtering	5.50 keV	Ex	1091
Cs⁺ + SiO₂	Sputtering	5.50 keV	Ex	1091
Cs⁺ + Ti	Sputtering	5.50 keV	Ex	1091
Cs⁺ + FeS₂	Sputtering	6.50-10.00 keV	E/T	1152
Cs⁺ + CoSi₂	Sputtering	5.50 keV	Ex	1091
Cs⁺ + Cu	Sputtering	5.50 keV	Ex	1091
Cs⁺ + Ta	Sputtering	5.50 keV	Ex	1091
Cs⁺ + W	Sputtering	5.50 keV	Ex	1091
Cs⁺ + WSi₂	Sputtering	5.50 keV	Ex	1091
Cs⁺ + Pt	Reflection	25.00-100.00 eV	Th	1297
Cs⁺ + Pt	Reflection	5.00-100.00 eV	Th	1135
Cs⁺ + Au	Reflection	1.00-6.00 MeV	Ex	1155
Cs⁺ + PbS	Sputtering	6.50-10.00 keV	E/T	1152
Cs⁺ + HCl	Chemical Reactions	30.00 eV	Ex	1134

Cs⁺ + HCl	Reflection	30.00 eV	Ex	1134
Cs⁺ + HCl	Sputtering	30.00 eV	Ex	1134
Ho³⁹⁺ + C	Surface Interactions	182.00-441.00 keV	Ex	1212
Ho³⁹⁺ + C	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Ho³⁹⁺ + Si	Surface Interactions	182.00-441.00 keV	Ex	1212
Ho³⁹⁺ + Si	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Ho³⁹⁺ + SiO₂	Surface Interactions	182.00-441.00 keV	Ex	1212
Ho³⁹⁺ + SiO₂	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Ho³⁹⁺ + Ag	Surface Interactions	182.00-441.00 keV	Ex	1212
Ho³⁹⁺ + Ag	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Ho³⁹⁺ + Au	Surface Interactions	182.00-441.00 keV	Ex	1212
Ho³⁹⁺ + Au	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Ho⁴⁰⁺ + C	Surface Interactions	182.00-441.00 keV	Ex	1212
Ho⁴⁰⁺ + C	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Ho⁴⁰⁺ + Si	Surface Interactions	182.00-441.00 keV	Ex	1212
Ho⁴⁰⁺ + Si	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Ho⁴⁰⁺ + SiO₂	Surface Interactions	182.00-441.00 keV	Ex	1212
Ho⁴⁰⁺ + SiO₂	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Ho⁴⁰⁺ + Ag	Surface Interactions	182.00-441.00 keV	Ex	1212
Ho⁴⁰⁺ + Ag	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Ho⁴⁰⁺ + Au	Surface Interactions	182.00-441.00 keV	Ex	1212
Ho⁴⁰⁺ + Au	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Er + Si	Sputtering	30.00-50.00 keV	Ex	1103
Ta¹¹⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta¹²⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta¹³⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta¹⁴⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta¹⁵⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta¹⁶⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta¹⁷⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta¹⁸⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta¹⁹⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta²⁰⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta²¹⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta²²⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta²³⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta²⁴⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta²⁵⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta²⁶⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta²⁷⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta²⁸⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta²⁹⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta³⁰⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta³¹⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta³²⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta³³⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta³⁴⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta³⁵⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta³⁶⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta³⁷⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta³⁸⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta³⁹⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta⁴⁰⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta⁴¹⁺ + Au	Second. Elect. Emission	0.17-6.00 MeV	Ex	1102
Ta⁵⁴⁺ + C	Second. Elect. Emission	6.00-13.00 MeV/amu	Ex	1110
Ta⁵⁴⁺ + C + N	Desorption	6.00-13.00 MeV/amu	Ex	1110
W⁺ + Be	Sputtering	0.00-1.00 MeV	E/T	1101

W⁺ + C	Chemical Reactions	100.00 eV	Ex	1064
W⁺ + C	Sputtering	0.00-1.00 MeV	E/T	1101
W⁺ + C	Sputtering	100.00 eV	Ex	1064
W⁺ + Si	Sputtering	0.00-1.00 MeV	E/T	1101
W⁺ + W	Reflection	0.00-1.00 keV	Th	1179
Au⁻¹⁺ + Nb	Sputtering	6.00-18.00 keV	Th	1290
Au⁻¹⁺ + Ta	Sputtering	6.00-18.00 keV	Th	1290
Au⁺ + Si	Sputtering	1.50-3.00 keV	Th	1313
Au⁺ + Si	Sputtering	1.50-3.00 keV	Th	1313
Au⁺ + Ti	Sputtering	0.20-1.40 GeV	Ex	1329
Au⁺ + TiN	Second. Elect. Emission	28.00-182.00 MeV	Ex	1093
Au⁺ + Cu	Sputtering	100.00-300.00 MeV	Ex	1195
Au⁺ + Cu	Sputtering	1.00 keV	Th	1029
Au⁺ + Cu	Sputtering	1.00 keV	Th	1029
Au⁺ + Zr	Sputtering	0.20-1.40 GeV	Ex	1329
Au⁺ + Ag	Sputtering	0.02-5.00 MeV	Ex	1233
Au⁺ + Au	Second. Elect. Emission	0.10-30.00 keV	Th	1213
Au⁺ + Au	Second. Elect. Emission	3.00-10.00 keV	Th	1128
Au⁺ + Au	Sputtering	0.20-1.40 GeV	Ex	1329
Au⁺ + Au	Sputtering	0.02-5.00 MeV	Ex	1233
Au⁺ + Au	Sputtering	100.00-300.00 MeV	Ex	1195
Au⁺ + SS	Second. Elect. Emission	28.00-182.00 MeV	Ex	1093
Au⁵¹⁺ + C	Surface Interactions	182.00-441.00 keV	Ex	1212
Au⁵¹⁺ + C	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Au⁵¹⁺ + Si	Surface Interactions	182.00-441.00 keV	Ex	1212
Au⁵¹⁺ + Si	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Au⁵¹⁺ + SiO₂	Surface Interactions	182.00-441.00 keV	Ex	1212
Au⁵¹⁺ + SiO₂	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Au⁵¹⁺ + Ag	Surface Interactions	182.00-441.00 keV	Ex	1212
Au⁵¹⁺ + Ag	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Au⁵¹⁺ + Au	Surface Interactions	182.00-441.00 keV	Ex	1212
Au⁵¹⁺ + Au	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Au⁵²⁺ + C	Surface Interactions	182.00-441.00 keV	Ex	1212
Au⁵²⁺ + C	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Au⁵²⁺ + Si	Surface Interactions	182.00-441.00 keV	Ex	1212
Au⁵²⁺ + Si	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Au⁵²⁺ + SiO₂	Surface Interactions	182.00-441.00 keV	Ex	1212
Au⁵²⁺ + SiO₂	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Au⁵²⁺ + Ag	Surface Interactions	182.00-441.00 keV	Ex	1212
Au⁵²⁺ + Ag	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Au⁵²⁺ + Au	Surface Interactions	182.00-441.00 keV	Ex	1212
Au⁵²⁺ + Au	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Th⁶²⁺ + C	Surface Interactions	182.00-441.00 keV	Ex	1212
Th⁶²⁺ + C	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Th⁶²⁺ + Si	Surface Interactions	182.00-441.00 keV	Ex	1212
Th⁶²⁺ + Si	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Th⁶²⁺ + SiO₂	Surface Interactions	182.00-441.00 keV	Ex	1212
Th⁶²⁺ + SiO₂	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Th⁶²⁺ + Ag	Surface Interactions	182.00-441.00 keV	Ex	1212
Th⁶²⁺ + Ag	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Th⁶²⁺ + Au	Surface Interactions	182.00-441.00 keV	Ex	1212
Th⁶²⁺ + Au	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Th⁶³⁺ + C	Surface Interactions	182.00-441.00 keV	Ex	1212
Th⁶³⁺ + C	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Th⁶³⁺ + Si	Surface Interactions	182.00-441.00 keV	Ex	1212
Th⁶³⁺ + Si	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Th⁶³⁺ + SiO₂	Surface Interactions	182.00-441.00 keV	Ex	1212

Th⁶³⁺ + SiO₂	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Th⁶³⁺ + Ag	Surface Interactions	182.00-441.00 keV	Ex	1212
Th⁶³⁺ + Ag	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
Th⁶³⁺ + Au	Surface Interactions	182.00-441.00 keV	Ex	1212
Th⁶³⁺ + Au	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex	1212
U⁺ + Au	Sputtering	0.20-1.40 GeV	Ex	1329
Bi⁺ + Cu	Surface Interactions	10.00 MeV/amu	E/T	1081
C₂H₆ + LiF	Reflection	200.00-800.00 meV	Ex	1095
Au₂⁻¹⁺ + Nb	Sputtering	6.00-18.00 keV	Th	1290
Au₂⁻¹⁺ + Ta	Sputtering	6.00-18.00 keV	Th	1290
Au₂⁺ + Si	Sputtering	1.50-3.00 keV	Th	1313
Au₂⁺ + Si	Sputtering	1.50-3.00 keV	Th	1313
Au₂⁺ + Ag	Sputtering	0.02-5.00 MeV	Ex	1233
Au₂⁺ + Au	Sputtering	0.02-5.00 MeV	Ex	1233
Au₃⁻¹⁺ + Nb	Sputtering	6.00-18.00 keV	Th	1290
Au₃⁻¹⁺ + Ta	Sputtering	6.00-18.00 keV	Th	1290

2.4 Data Collection, Bibliography, Progress Report

e + H⁻¹⁺	Data Coll., Biblio., Progress Report	0.10-10.00 eV	Th	1333
e + H⁻¹⁺	Data Coll., Biblio., Progress Report	0.10-10.00 eV	Th	1333
e + H₂	Data Coll., Biblio., Progress Report	100.00 eV	Th	1334
e + H₂¹⁺	Data Coll., Biblio., Progress Report	12.00 eV	Th	1335
e + H₂¹⁺	Data Coll., Biblio., Progress Report	0.10-10.00 eV	Th	1333
e + H₂¹⁺	Data Coll., Biblio., Progress Report	0.10-10.00 eV	Th	1333
e + HD¹⁺	Data Coll., Biblio., Progress Report	12.00 eV	Th	1335
e + D₂¹⁺	Data Coll., Biblio., Progress Report	12.00 eV	Th	1335
H¹⁺ + H₂	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H¹⁺ + H₂	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H¹⁺ + HT	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H¹⁺ + HT	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H¹⁺ + D₂	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H¹⁺ + D₂	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H¹⁺ + DT	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H¹⁺ + DT	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H¹⁺ + T₂	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H¹⁺ + T₂	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H¹⁺ + Li	Data Coll., Biblio., Progress Report	0.10-15.00 keV	Ex	1332
H¹⁺ + Be	Data Coll., Biblio., Progress Report	0.10-15.00 keV	Ex	1332
H¹⁺ + C	Data Coll., Biblio., Progress Report	0.10-15.00 keV	Ex	1332
H¹⁺ + Ga	Data Coll., Biblio., Progress Report	0.10-15.00 keV	Ex	1332
H¹⁺ + W	Data Coll., Biblio., Progress Report	0.10-15.00 keV	Ex	1332
H₂¹⁺ + H	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H₂¹⁺ + H	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H₂¹⁺ + D	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
H₂¹⁺ + D	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
HD¹⁺ + H	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
HD¹⁺ + H	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
HD¹⁺ + D	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
HD¹⁺ + D	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
D¹⁺ + H₂	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
D¹⁺ + H₂	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
D¹⁺ + HT	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
D¹⁺ + HT	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
D¹⁺ + D₂	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336

$D^{1+} + D_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$D^{1+} + DT$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$D^{1+} + DT$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$D^{1+} + T_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$D^{1+} + T_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$D^{1+} + Li$	Data Coll., Biblio., Progress Report	0.10-15.00 keV	Ex	1332
$D^{1+} + Be$	Data Coll., Biblio., Progress Report	0.10-15.00 keV	Ex	1332
$D^{1+} + C$	Data Coll., Biblio., Progress Report	0.10-15.00 keV	Ex	1332
$D^{1+} + Ga$	Data Coll., Biblio., Progress Report	0.10-15.00 keV	Ex	1332
$D^{1+} + W$	Data Coll., Biblio., Progress Report	0.10-15.00 keV	Ex	1332
$D_2^{1+} + H$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$D_2^{1+} + H$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$D_2^{1+} + D$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$D_2^{1+} + D$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$T^{1+} + H_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$T^{1+} + H_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$T^{1+} + HT$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$T^{1+} + HT$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$T^{1+} + D_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$T^{1+} + D_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$T^{1+} + DT$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$T^{1+} + DT$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$T^{1+} + T_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
$T^{1+} + T_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T	1336
perturbation¹⁺	Data Coll., Biblio., Progress Report		Th	1331

2.5 Fusion Research of General Interest

$h\nu + H^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$h\nu + H$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$h\nu + D^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$h\nu + D$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$h\nu + He$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$h\nu + He^{1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$h\nu + Li^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$h\nu + Li$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$h\nu + Li^{1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$h\nu + Li^{2+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$e + H$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$e + D$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$e + He$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$e + He^{1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$e + He^{2+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$e + Li$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$e + Li^{1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$e + Li^{2+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$e + Li^{3+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$H^{1+} + H^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$H^{1+} + D^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$H^{1+} + Li^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$H_2 + D^{1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$H_2^{1+} + H^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$D^{1+} + H^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$D^{1+} + D^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$D^{1+} + Li^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337

$\text{Li}^{1+} + \text{H}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337
$\text{Li}^{1+} + \text{D}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th	1337

2.6 Particle Beam-Matter interaction

$\text{e} + \text{H}_2\text{O}$	Particle Beam-Matter interaction	0.01-10.00 keV	Th	1403
$\text{e} + \text{H}_2\text{O}$	Particle Beam-Matter interaction	0.01-10.00 keV	Th	1403
$\text{e} + \text{H}_2\text{O}$	Particle Beam-Matter interaction	10.00-44.00 MeV	Th	1357
$\text{e} + \text{Be}$	Particle Beam-Matter interaction	10.00-44.00 MeV	Th	1357
$\text{e} + \text{B}^{1+}$	Particle Beam-Matter interaction		Th	1426
$\text{e} + \text{C}$	Particle Beam-Matter interaction	10.00-44.00 MeV	Th	1357
$\text{e} + \text{C}^{1+}$	Particle Beam-Matter interaction	3.60-11.40 MeV/amu	Ex	1351
$\text{e} + \text{O}^{2+}$	Particle Beam-Matter interaction	0.10-0.80 MeV/amu	Ex	1349
$\text{e} + \text{Al}$	Particle Beam-Matter interaction	1.00-50.00 keV	Th	1376
$\text{e} + \text{Al}$	Particle Beam-Matter interaction	10.00-44.00 MeV	Th	1357
$\text{e} + \text{Cl}^{7+}$	Particle Beam-Matter interaction	0.06-1.03 MeV	Ex	1352
$\text{e} + \text{Fe}^{21+}$	Particle Beam-Matter interaction	6.00 MeV/amu	Ex	1350
$\text{e} + \text{Fe}^{25+}$	Particle Beam-Matter interaction	6.00 MeV/amu	Ex	1350
$\text{e} + \text{Cu}$	Particle Beam-Matter interaction	1.00-50.00 keV	Th	1376
$\text{e} + \text{Cu}$	Particle Beam-Matter interaction	10.00-44.00 MeV	Th	1357
$\text{e} + \text{Kr}^{1+}$	Particle Beam-Matter interaction	3.60-11.40 MeV/amu	Ex	1351
$\text{e} + \text{Au}$	Particle Beam-Matter interaction	1.00-50.00 keV	Th	1376
$\text{e} + \text{Pb}$	Particle Beam-Matter interaction	10.00-44.00 MeV	Th	1357
$\text{e} + \text{Pb}^{1+}$	Particle Beam-Matter interaction	3.60-11.40 MeV/amu	Ex	1351
$\text{H} + \text{H}$	Particle Beam-Matter interaction	5.00-60.00 keV	Ex	1389
$\text{H} + \text{He}$	Particle Beam-Matter interaction	5.00-60.00 keV	Ex	1389
$\text{H} + \text{C}$	Particle Beam-Matter interaction	2.50 MeV	Ex	1405
$\text{H} + \text{C}$	Particle Beam-Matter interaction	2.50 MeV	Ex	1405
$\text{H} + \text{C}$	Particle Beam-Matter interaction	0.00-10.00 MeV	Th	1397
$\text{H} + \text{Mg}$	Particle Beam-Matter interaction	10.00-600.00 keV	Th	1371
$\text{H} + \text{Al}$	Particle Beam-Matter interaction	0.00-10.00 MeV	Th	1397
$\text{H} + \text{Al}$	Particle Beam-Matter interaction		Th	1393
$\text{H} + \text{Al}$	Particle Beam-Matter interaction	1.00-100.00 keV	Th	1388
$\text{H} + \text{InP}$	Particle Beam-Matter interaction	0.30-2.50 MeV	Ex	1339
$\text{H} + \text{GaN}$	Particle Beam-Matter interaction	0.30-2.50 MeV	Ex	1339
$\text{H}^{1+} + \text{H}$	Particle Beam-Matter interaction	0.00-3.60 MeV	Th	1372
$\text{H}^{1+} + \text{H}$	Particle Beam-Matter interaction	0.00-100.00 MeV/amu	Th	1348
$\text{H}^{1+} + \text{B}$	Particle Beam-Matter interaction	0.70-5.00 keV	Ex	1343
$\text{H}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.00-3.00 MeV	Ex	1408
$\text{H}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.00-3.00 MeV	Ex	1408
$\text{H}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.20-9.20 MeV	E/T	1400
$\text{H}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.00-10.00 MeV	Th	1397
$\text{H}^{1+} + \text{C}$	Particle Beam-Matter interaction	10.00-200.00 keV	Ex	1367
$\text{H}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.00-100.00 MeV/amu	Th	1348
$\text{H}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.70-5.00 keV	Ex	1343
$\text{H}^{1+} + \text{O}$	Particle Beam-Matter interaction	0.00-100.00 MeV/amu	Th	1348
$\text{H}^{1+} + \text{O}_2$	Particle Beam-Matter interaction	5.00-100.00 MeV	Th	1410
$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	0.30-10.00 MeV	E/T	1420
$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	0.01-1.00 MeV	E/T	1419
$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	5.00-100.00 MeV	Th	1410
$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	0.00-3.00 MeV	Ex	1408
$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	0.00-3.00 MeV	Ex	1408
$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	0.00-10.00 MeV	Th	1397
$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	1.00-100.00 keV	Th	1388
$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	700.00 keV	Th	1370

$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	10.00-200.00 keV	Ex	1367
$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	2.50-25.00 keV	Th	1363
$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	100.00 keV	Th	1359
$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	100.00 keV	Th	1359
$\text{H}^{1+} + \text{Al}_2\text{O}_3$	Particle Beam-Matter interaction	80.00 a.u.	Th	1413
$\text{H}^{1+} + \text{Al}_2\text{O}_3$	Particle Beam-Matter interaction	0.20-5.00 a.u.	E/T	1412
$\text{H}^{1+} + \text{Al}_2\text{O}_3$	Particle Beam-Matter interaction	0.00-1.00 MeV	Ex	1384
$\text{H}^{1+} + \text{Si}$	Particle Beam-Matter interaction	0.30-10.00 MeV	E/T	1420
$\text{H}^{1+} + \text{Si}$	Particle Beam-Matter interaction	0.01-1.00 MeV	E/T	1419
$\text{H}^{1+} + \text{Si}$	Particle Beam-Matter interaction	0.00-3.00 MeV	Ex	1408
$\text{H}^{1+} + \text{Si}$	Particle Beam-Matter interaction	0.00-3.00 MeV	Ex	1408
$\text{H}^{1+} + \text{Si}$	Particle Beam-Matter interaction	1.00-12.00 MeV	Th	1407
$\text{H}^{1+} + \text{Si}$	Particle Beam-Matter interaction	2.00-200.00 keV	Ex	1406
$\text{H}^{1+} + \text{Si}$	Particle Beam-Matter interaction	2.00-200.00 keV	Ex	1406
$\text{H}^{1+} + \text{SiO}_2$	Particle Beam-Matter interaction	0.20-5.00 a.u.	E/T	1412
$\text{H}^{1+} + \text{SiO}_2$	Particle Beam-Matter interaction	0.00-1.00 MeV	Ex	1384
$\text{H}^{1+} + \text{Mn}$	Particle Beam-Matter interaction	10.00-200.00 keV	Ex	1367
$\text{H}^{1+} + \text{Ni}$	Particle Beam-Matter interaction	0.00-3.00 MeV	Ex	1408
$\text{H}^{1+} + \text{Ni}$	Particle Beam-Matter interaction	0.00-3.00 MeV	Ex	1408
$\text{H}^{1+} + \text{Cu}$	Particle Beam-Matter interaction	8.00-25.00 keV	Th	1399
$\text{H}^{1+} + \text{Cu}$	Particle Beam-Matter interaction	10.00-200.00 keV	Ex	1367
$\text{H}^{1+} + \text{Zn}$	Particle Beam-Matter interaction	0.01-1.00 MeV	E/T	1419
$\text{H}^{1+} + \text{Zn}$	Particle Beam-Matter interaction	10.00-200.00 keV	Ex	1367
$\text{H}^{1+} + \text{Se}$	Particle Beam-Matter interaction	10.00-200.00 keV	Ex	1367
$\text{H}^{1+} + \text{Rb}$	Particle Beam-Matter interaction	0.00-1.00 MeV	Th	1394
$\text{H}^{1+} + \text{Rb}$	Particle Beam-Matter interaction	0.00-1.00 MeV	Th	1394
$\text{H}^{1+} + \text{Sr}$	Particle Beam-Matter interaction	0.00-1.00 MeV	Th	1394
$\text{H}^{1+} + \text{Sr}$	Particle Beam-Matter interaction	0.00-1.00 MeV	Th	1394
$\text{H}^{1+} + \text{Ag}$	Particle Beam-Matter interaction	80.00 a.u.	Th	1413
$\text{H}^{1+} + \text{Ag}$	Particle Beam-Matter interaction	10.00-200.00 keV	Ex	1367
$\text{H}^{1+} + \text{Sb}$	Particle Beam-Matter interaction	10.00-200.00 keV	Ex	1367
$\text{H}^{1+} + \text{Au}$	Particle Beam-Matter interaction	0.01-1.00 MeV	E/T	1419
$\text{H}^{1+} + \text{Au}$	Particle Beam-Matter interaction	0.00-3.00 MeV	Ex	1408
$\text{H}^{1+} + \text{Au}$	Particle Beam-Matter interaction	0.00-3.00 MeV	Ex	1408
$\text{H}^{1+} + \text{Au}$	Particle Beam-Matter interaction	2.50-25.00 keV	Th	1396
$\text{H}^{1+} + \text{Au}$	Particle Beam-Matter interaction	2.50-25.00 keV	Th	1396
$\text{H}^{1+} + \text{Au}$	Particle Beam-Matter interaction	10.00-200.00 keV	Ex	1367
$\text{H}^{1+} + \text{C}_{60}$	Particle Beam-Matter interaction	0.10-5.00 a.u.	Th	1347
$\text{H}^{1+} + \text{Bi}$	Particle Beam-Matter interaction	10.00-200.00 keV	Ex	1367
$\text{H}^{1+} + \text{ZrO}_2$	Particle Beam-Matter interaction	0.00-1.00 MeV	Ex	1384
$\text{H}_2^{1+} + \text{Al}$	Particle Beam-Matter interaction	25.00-100.00 keV/amu	Ex	1390
$\text{H}_2^{1+} + \text{Al}$	Particle Beam-Matter interaction	25.00-100.00 keV/amu	Ex	1390
$\text{H}_2^{1+} + \text{Si}$	Particle Beam-Matter interaction	0.60-2.10 MeV	Ex	1381
$\text{H}_3^{1+} + \text{Si}$	Particle Beam-Matter interaction	0.60-2.10 MeV	Ex	1381
$\text{D} + \text{C} + \text{W}$	Particle Beam-Matter interaction	10.00-100.00 keV	Ex	1341
$\text{D} + \text{W}$	Particle Beam-Matter interaction	10.00-100.00 keV	Ex	1341
$\text{D} + \text{WC}$	Particle Beam-Matter interaction	10.00-100.00 keV	Ex	1341
$\text{D}^{1+} + \text{Be}$	Particle Beam-Matter interaction	1.80-8.00 keV	Ex	1434
$\text{D}^{1+} + \text{BeO}$	Particle Beam-Matter interaction	1.80-8.00 keV	Ex	1434
$\text{D}^{1+} + \text{W}$	Particle Beam-Matter interaction	1.80-8.00 keV	Ex	1434
$\text{D}^{1+} + \text{Au}$	Particle Beam-Matter interaction	2.50-25.00 keV	Th	1396
$\text{D}^{1+} + \text{Au}$	Particle Beam-Matter interaction	2.50-25.00 keV	Th	1396
$\text{D}_3^{1+} + \text{W}$	Particle Beam-Matter interaction	1.50 keV	Ex	1344
$\text{He} + \text{C}$	Particle Beam-Matter interaction	0.00-10.00 MeV	Th	1397
$\text{He} + \text{Al}$	Particle Beam-Matter interaction	0.00-10.00 MeV	Th	1397
$\text{He} + \text{Al}$	Particle Beam-Matter interaction		Th	1393
$\text{He}^{1+} + \text{C}$	Particle Beam-Matter interaction	8.00-80.00 keV	Ex	1423

He¹⁺ + C	Particle Beam-Matter interaction	32.00 MeV	Th	1398
He¹⁺ + C	Particle Beam-Matter interaction	0.00-10.00 MeV	Th	1397
He¹⁺ + C	Particle Beam-Matter interaction	100.00-800.00 keV/amu	Ex	1380
He¹⁺ + C	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th	1361
He¹⁺ + Al	Particle Beam-Matter interaction	0.00-10.00 MeV	Th	1397
He¹⁺ + Al₂O₃	Particle Beam-Matter interaction	0.20-5.00 a.u.	E/T	1412
He¹⁺ + Si	Particle Beam-Matter interaction	0.20-9.00 MeV	Ex	1425
He¹⁺ + Si	Particle Beam-Matter interaction	1.00-12.00 MeV	Th	1407
He¹⁺ + Si	Particle Beam-Matter interaction	0.16-3.30 MeV	E/T	1401
He¹⁺ + Si	Particle Beam-Matter interaction	1.47-1.78 MeV	Th	1385
He¹⁺ + SiO₂	Particle Beam-Matter interaction	0.20-5.00 a.u.	E/T	1412
He¹⁺ + Nb	Particle Beam-Matter interaction	0.40-2.80 MeV	Ex	1409
He²⁺ + H	Particle Beam-Matter interaction	0.00-100.00 MeV/amu	Th	1348
He²⁺ + C	Particle Beam-Matter interaction	32.00 MeV	Th	1398
He²⁺ + C	Particle Beam-Matter interaction	0.00-10.00 MeV	Th	1397
He²⁺ + C	Particle Beam-Matter interaction	0.00-100.00 MeV/amu	Th	1348
He²⁺ + O	Particle Beam-Matter interaction	0.00-100.00 MeV/amu	Th	1348
He²⁺ + Al	Particle Beam-Matter interaction	0.00-10.00 MeV	Th	1397
Li¹⁺ + Be	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + C	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
Li¹⁺ + C	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + N	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + O	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Ne	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Al	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Si	Particle Beam-Matter interaction	0.20-9.00 MeV	Ex	1425
Li¹⁺ + Si	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Si	Particle Beam-Matter interaction	0.28-8.50 MeV	Ex	1368
Li¹⁺ + Si	Particle Beam-Matter interaction	0.28-8.50 MeV	Ex	1368
Li¹⁺ + Si	Particle Beam-Matter interaction	0.28-8.50 MeV	Ex	1368
Li¹⁺ + Ar	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Ti	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Cu	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Kr	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Ag	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Sn	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Xe	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Pt	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Au	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + Pb	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li¹⁺ + U	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Li²⁺ + C	Particle Beam-Matter interaction	63.40 MeV	Th	1428
Be¹⁺ + Be	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + C	Particle Beam-Matter interaction	100.00-800.00 keV/amu	Ex	1380
Be¹⁺ + C	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
Be¹⁺ + C	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + C	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th	1361
Be¹⁺ + C	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th	1361
Be¹⁺ + N	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + O	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + Ne	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + Al	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + Si	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + Ar	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + Ti	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + Cu	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + Kr	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369

Be¹⁺ + Ag	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + Sn	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + Xe	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + Pt	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + Au	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + Pb	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Be¹⁺ + U	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Be	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + C	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
B¹⁺ + C	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + N	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + O	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Ne	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Al	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Si	Particle Beam-Matter interaction	4.00 MeV	Th	1378
B¹⁺ + Si	Particle Beam-Matter interaction	4.00 MeV	Th	1378
B¹⁺ + Si	Particle Beam-Matter interaction	4.00 MeV	Th	1378
B¹⁺ + Si	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Ar	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Ti	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Cu	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Kr	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Ag	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Sn	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Xe	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Pt	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Au	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + Pb	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B¹⁺ + U	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
B²⁺ + C	Particle Beam-Matter interaction	0.85-9.00 MeV	E/T	1416
B³⁺ + C	Particle Beam-Matter interaction	0.50-2.00 MeV/amu	Ex	1421
B₃¹⁺ + Si	Particle Beam-Matter interaction	4.00 MeV	Th	1378
B₃¹⁺ + Si	Particle Beam-Matter interaction	4.00 MeV	Th	1378
B₃¹⁺ + Si	Particle Beam-Matter interaction	4.00 MeV	Th	1378
C + Al	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
C + Ni	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
C + Ag	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
C + Au	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
C¹⁺ + H	Particle Beam-Matter interaction	350.00 keV/amu	Ex	1340
C¹⁺ + Li	Particle Beam-Matter interaction	350.00 keV/amu	Ex	1340
C¹⁺ + Be	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
C¹⁺ + C	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th	1431
C¹⁺ + C	Particle Beam-Matter interaction	100.00-800.00 keV/amu	Ex	1380
C¹⁺ + C	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
C¹⁺ + C	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
C¹⁺ + C	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
C¹⁺ + N	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
C¹⁺ + O	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
C¹⁺ + Ne	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
C¹⁺ + Al	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
C¹⁺ + Al	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
C¹⁺ + Si	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
C¹⁺ + Ar	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
C¹⁺ + Ti	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
C¹⁺ + Ni	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
C¹⁺ + Cu	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
C¹⁺ + Cu	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360

$C^{1+} + Kr$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$C^{1+} + Ag$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$C^{1+} + Ag$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
$C^{1+} + Sn$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$C^{1+} + Xe$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$C^{1+} + Ta$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
$C^{1+} + Pt$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$C^{1+} + Au$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$C^{1+} + Au$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
$C^{1+} + Pb$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$C^{1+} + U$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$C^{4+} + C$	Particle Beam-Matter interaction	0.50-2.00 MeV/amu	Ex	1421
$N + Al$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
$N + Ni$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
$N + Ag$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
$N + Au$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
$N^{1+} + Be$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + C$	Particle Beam-Matter interaction	15.00-34.00 keV	Ex	1435
$N^{1+} + C$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
$N^{1+} + C$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + N$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + O$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + Ne$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + Al$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + Al_2O_3$	Particle Beam-Matter interaction	0.20-5.00 a.u.	E/T	1412
$N^{1+} + Si$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + SiO_2$	Particle Beam-Matter interaction	0.20-5.00 a.u.	E/T	1412
$N^{1+} + Ar$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + Ti$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + Cu$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + Kr$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + Ag$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + Sn$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + Xe$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + Pt$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + Au$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + Pb$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{1+} + U$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$N^{5+} + C$	Particle Beam-Matter interaction	0.50-2.00 MeV/amu	Ex	1421
$N_2^{1+} + Al$	Particle Beam-Matter interaction		Th	1392
$O + Al$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
$O + Ni$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
$O + Ag$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
$O + Au$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
$O^{1+} + H$	Particle Beam-Matter interaction	350.00 keV/amu	Ex	1340
$O^{1+} + Li$	Particle Beam-Matter interaction	350.00 keV/amu	Ex	1340
$O^{1+} + Be$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + B$	Particle Beam-Matter interaction	0.70-5.00 keV	Ex	1343
$O^{1+} + C$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th	1431
$O^{1+} + C$	Particle Beam-Matter interaction	5.00 MeV	Th	1411
$O^{1+} + C$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
$O^{1+} + C$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + C$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th	1361
$O^{1+} + C$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th	1361
$O^{1+} + C$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
$O^{1+} + C$	Particle Beam-Matter interaction	0.70-5.00 keV	Ex	1343
$O^{1+} + N$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369

$O^{1+} + O$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Ne$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Al$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th	1431
$O^{1+} + Al$	Particle Beam-Matter interaction		Th	1395
$O^{1+} + Al$	Particle Beam-Matter interaction		Th	1395
$O^{1+} + Al$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Al$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th	1361
$O^{1+} + Al$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
$O^{1+} + Al$	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex	1355
$O^{1+} + Si$	Particle Beam-Matter interaction	0.30-13.50 MeV	Ex	1382
$O^{1+} + Si$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Si$	Particle Beam-Matter interaction	25.00-200.00 keV	Ex	1366
$O^{1+} + Si$	Particle Beam-Matter interaction	25.00-200.00 keV	Ex	1366
$O^{1+} + SiO_2$	Particle Beam-Matter interaction	25.00-200.00 keV	Ex	1366
$O^{1+} + SiO_2$	Particle Beam-Matter interaction	25.00-200.00 keV	Ex	1366
$O^{1+} + Ar$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Ti$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Ti$	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex	1355
$O^{1+} + Ni$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
$O^{1+} + Ni$	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex	1355
$O^{1+} + Cu$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Cu$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
$O^{1+} + Kr$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Ag$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Ag$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
$O^{1+} + Sn$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Xe$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Ta$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
$O^{1+} + Ta$	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex	1355
$O^{1+} + Pt$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Au$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + Au$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
$O^{1+} + Pb$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{1+} + U$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$O^{6+} + C$	Particle Beam-Matter interaction	0.50-2.00 MeV/amu	Ex	1421
$O_2^{-1+} + C$	Particle Beam-Matter interaction	5.00 MeV	Th	1411
$O_2^{1+} + C$	Particle Beam-Matter interaction	5.00 MeV	Th	1411
$F + Al$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
$F + Ni$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
$F + Ag$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
$F + Au$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
$F^{1+} + H$	Particle Beam-Matter interaction	350.00 keV/amu	Ex	1340
$F^{1+} + Li$	Particle Beam-Matter interaction	350.00 keV/amu	Ex	1340
$F^{1+} + C$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
$F^{1+} + N$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$F^{1+} + O$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$F^{1+} + Ne$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$F^{1+} + Ar$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$F^{1+} + Kr$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$F^{1+} + SnO_2$	Particle Beam-Matter interaction	50.00-180.00 keV	Ex	1377
$F^{1+} + SnO_2$	Particle Beam-Matter interaction	50.00-180.00 keV	Ex	1377
$F^{1+} + SnO_2$	Particle Beam-Matter interaction	50.00-180.00 keV	Ex	1377
$F^{1+} + Xe$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
$F^{1+} + LiNbO_3$	Particle Beam-Matter interaction	50.00-330.00 keV	Ex	1358
$F^{1+} + LiNbO_3$	Particle Beam-Matter interaction	50.00-330.00 keV	Ex	1358
$F^{7+} + C$	Particle Beam-Matter interaction	0.50-2.00 MeV/amu	Ex	1421
$Ne + Al$	Particle Beam-Matter interaction	0.82 a.u.	Th	1415

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Mg + Ag	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
Mg + Au	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
Mg¹⁺ + Be	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + C	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
Mg¹⁺ + C	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + N	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + O	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Ne	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Al	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Si	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Ar	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Ti	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Cu	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Kr	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Ag	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Sn	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Xe	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Pt	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Au	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + Pb	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Mg¹⁺ + U	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Al + Al	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
Al + Ni	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
Al + Ag	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
Al + Au	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
Al¹⁺ + Be	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Al¹⁺ + C	Particle Beam-Matter interaction	100.00-800.00 keV/amu	Ex	1380
Al¹⁺ + C	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
Al¹⁺ + C	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Al¹⁺ + C	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Al¹⁺ + Al	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Al¹⁺ + Si	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Al¹⁺ + Ar	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Al¹⁺ + Ti	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Al¹⁺ + Ni	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Al¹⁺ + Cu	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Al¹⁺ + Cu	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Al¹⁺ + Ag	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Al¹⁺ + Ag	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Al¹⁺ + Sn	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Al¹⁺ + Ta	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Al¹⁺ + Pt	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Al¹⁺ + Au	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Al¹⁺ + Au	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Al¹⁺ + Pb	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Al¹⁺ + U	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Si + Al	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
Si + Ni	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
Si + Ag	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
Si + Au	Particle Beam-Matter interaction	0.82 a.u.	Th	1415
Si¹⁺ + Be	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Si¹⁺ + C	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
Si¹⁺ + C	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Si¹⁺ + Al	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Si¹⁺ + Si	Particle Beam-Matter interaction	100.00 eV	Th	1424
Si¹⁺ + Si	Particle Beam-Matter interaction	0.10-3.30 MeV/amu	Ex	1383
Si¹⁺ + Si	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369

Ar¹⁺ + Au	Particle Beam-Matter interaction	1.00-25.00 MeV	E/T	1374
Ar¹⁺ + Au	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Ar¹⁺ + Pb	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Ar¹⁺ + U	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th	1369
Ar¹⁷⁺ + C	Particle Beam-Matter interaction	390.00 MeV/amu	Ex	1427
Ar¹⁷⁺ + Si	Particle Beam-Matter interaction	1.60-1.90 GeV/amu	Ex	1429
Ar¹⁸⁺ + C	Particle Beam-Matter interaction	13.60 MeV/amu	E/T	1430
Ar¹⁸⁺ + C	Particle Beam-Matter interaction	13.60 MeV/amu	E/T	1430
Ar¹⁸⁺ + Si	Particle Beam-Matter interaction	1.60-1.90 GeV/amu	Ex	1429
Cr¹⁺ + C	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
Mn¹⁺ + C	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
Fe¹⁺ + C	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex	1375
Fe¹⁺ + Au	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Fe¹⁺ + Au	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Fe¹⁺ + Bi	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Fe¹⁺ + Bi	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Co¹⁺ + Au	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Co¹⁺ + Au	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Co¹⁺ + Bi	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Co¹⁺ + Bi	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Ni¹⁺ + C	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th	1431
Ni¹⁺ + Al	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex	1355
Ni¹⁺ + Ti	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex	1355
Ni¹⁺ + Ni	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex	1355
Ni¹⁺ + Ta	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex	1355
Ni¹⁺ + Au	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Ni¹⁺ + Au	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Ni¹⁺ + Bi	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Ni¹⁺ + Bi	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Ni⁶⁺ + Au	Particle Beam-Matter interaction	80.00-200.00 MeV	Ex	1345
Ni²⁸⁺ + C	Particle Beam-Matter interaction	45.00 MeV/amu	E/T	1346
Cu¹⁺ + C	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Cu¹⁺ + Al	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Cu¹⁺ + Ni	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Cu¹⁺ + Cu	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Cu¹⁺ + Ag	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Cu¹⁺ + Ta	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Cu¹⁺ + Au	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Cu¹⁺ + Au	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Cu¹⁺ + Au	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex	1360
Cu¹⁺ + Bi	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
Cu¹⁺ + Bi	Particle Beam-Matter interaction	0.10-1.50 MeV/amu	Ex	1387
As¹⁺ + Si	Particle Beam-Matter interaction	100.00 keV	Th	1364
As¹⁺ + Si	Particle Beam-Matter interaction	100.00 keV	Th	1364
Kr³⁵⁺	Particle Beam-Matter interaction	60.00 MeV/amu	Th	1418
Kr³⁵⁺ + C	Particle Beam-Matter interaction	33.00-60.00 MeV/amu	Ex	1432
Kr³⁵⁺ + C	Particle Beam-Matter interaction	60.00 MeV/amu	Th	1418
Kr³⁵⁺ + C	Particle Beam-Matter interaction	60.00 MeV/amu	Th	1418
Kr³⁵⁺ + C	Particle Beam-Matter interaction	60.00 MeV/amu	Th	1418
Kr³⁵⁺ + C	Particle Beam-Matter interaction	60.00 MeV/amu	E/T	1404
Kr³⁶⁺ + C	Particle Beam-Matter interaction	33.00-60.00 MeV/amu	Ex	1432
Sn¹⁺ + SiO₂	Particle Beam-Matter interaction	1.35-3.60 MeV	E/T	1373
Sn¹⁺ + SiO₂	Particle Beam-Matter interaction	1.35-3.60 MeV	E/T	1373
Sb¹⁺ + SiO₂	Particle Beam-Matter interaction	1.35-3.60 MeV	E/T	1373
Sb¹⁺ + SiO₂	Particle Beam-Matter interaction	1.35-3.60 MeV	E/T	1373
I⁹⁺ + Au	Particle Beam-Matter interaction	80.00-200.00 MeV	Ex	1345
I¹²⁺ + Au	Particle Beam-Matter interaction	80.00-200.00 MeV	Ex	1345

Xe¹⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Xe¹⁺ + C	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th	1361
Xe¹⁺ + C	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th	1361
Xe²⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Xe³⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Xe⁴⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Xe⁵⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Xe⁶⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Xe⁷⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Xe⁸⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Xe⁹⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Xe¹⁰⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Xe¹¹⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Xe¹²⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
W¹⁺ + C	Particle Beam-Matter interaction	100.00 eV	Ex	1342
Au¹⁺ + Cu	Particle Beam-Matter interaction	300.00 keV	E/T	1422
Pb⁸¹⁺ + C	Particle Beam-Matter interaction	46.00 MeV/amu	Ex	1433
Pb⁸²⁺ + Si	Particle Beam-Matter interaction	160.00 GeV/amu	Ex	1414
Bi₂¹⁺ + Si	Particle Beam-Matter interaction	0.50-1.00 MeV	Ex	1338
perturbation¹⁺ + C	Particle Beam-Matter interaction	5.00 MeV/amu	Th	1365
perturbation¹⁺ + C	Particle Beam-Matter interaction	5.00 MeV/amu	Th	1365
U¹⁰⁺ + H₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
U¹⁰⁺ + N₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
U⁹¹⁺ + Be	Particle Beam-Matter interaction	0.20-1.00 GeV/amu	E/T	1386
U⁹¹⁺ + Be	Particle Beam-Matter interaction	0.20-1.00 GeV/amu	E/T	1386
U⁹¹⁺ + Al	Particle Beam-Matter interaction	0.20-1.00 GeV/amu	E/T	1386
U⁹¹⁺ + Al	Particle Beam-Matter interaction	0.20-1.00 GeV/amu	E/T	1386
U⁹¹⁺ + Pb	Particle Beam-Matter interaction	0.20-1.00 GeV/amu	E/T	1386
U⁹¹⁺ + Pb	Particle Beam-Matter interaction	0.20-1.00 GeV/amu	E/T	1386
Bi¹⁺ + LiB₃O₅	Particle Beam-Matter interaction	100.00-350.00 keV	Ex	1362
Bi¹⁺ + LiB₃O₅	Particle Beam-Matter interaction	100.00-350.00 keV	Ex	1362
Bi¹⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Bi¹⁺ + Si	Particle Beam-Matter interaction	0.50-1.00 MeV	Ex	1338
Bi²⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Bi³⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Bi⁴⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Bi⁵⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Bi⁶⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Bi⁷⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Bi⁸⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Bi⁹⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Bi¹⁰⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Bi¹¹⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Bi¹²⁺ + BeF₂	Particle Beam-Matter interaction	2.60-8.40 GeV	Th	1354
Na₂₀ + Al	Particle Beam-Matter interaction	2.00-5.00 a.u.	Th	1417
Na₁₀ + Al	Particle Beam-Matter interaction	2.00-5.00 a.u.	Th	1417
Na₃₀ + Al	Particle Beam-Matter interaction	2.00-5.00 a.u.	Th	1417
Na₅₀ + Al	Particle Beam-Matter interaction	2.00-5.00 a.u.	Th	1417
Na₁₀₀ + Al	Particle Beam-Matter interaction	2.00-5.00 a.u.	Th	1417
Na₂₀₀ + Al	Particle Beam-Matter interaction	2.00-5.00 a.u.	Th	1417

2.7 Interactions of Atomic Particles with Fields

e + H	Inter. of Atomic part. with Fields	500.00 eV	Th	1496
e + H	Inter. of Atomic part. with Fields	10 ⁹ -10 ¹¹ W/cm ²	Th	1495

$e + H^*$	Inter. of Atomic part. with Fields	100.00-500.00 eV	Th	1484
$e + H$	Inter. of Atomic part. with Fields	100.00-500.00 eV	Th	1484
$e + H$	Inter. of Atomic part. with Fields	200.00 eV	Th	1474
$e + H$	Inter. of Atomic part. with Fields	200.00 eV	Th	1459
$e + H$	Inter. of Atomic part. with Fields	100.00 eV	Th	1448
$e + He$	Inter. of Atomic part. with Fields	500.00 eV	Th	1496
$e + He$	Inter. of Atomic part. with Fields	0.65-0.78 a.u.	Th	1460
$e + He$	Inter. of Atomic part. with Fields	1.00-20.00 eV	Ex	1441
$e + O^{5+}$	Inter. of Atomic part. with Fields		Ex	1510
$e + O^{5+}$	Inter. of Atomic part. with Fields	2.00-12.00 eV	E/T	1500
$e + Ne^{7+}$	Inter. of Atomic part. with Fields		Ex	1510
$e + Ne^{7+}$	Inter. of Atomic part. with Fields	18.00 eV	Ex	1481
$e + Ti^{19+}$	Inter. of Atomic part. with Fields		Ex	1509
$e + Ni^{25+}$	Inter. of Atomic part. with Fields		Ex	1509
$e + Ge^{1+}$	Inter. of Atomic part. with Fields	1.00-10.00 keV	Th	1467
$e + Zr^{1+}$	Inter. of Atomic part. with Fields	10.00 K	Th	1437
$e + Zr^{2+}$	Inter. of Atomic part. with Fields	10.00 K	Th	1437
$e + Au^{25+}$	Inter. of Atomic part. with Fields	0.00-1.00 eV	Ex	1508
$e + Au^{48+}$	Inter. of Atomic part. with Fields	1.00-10.00 keV	Th	1467
$e + Bi^{83+}$	Inter. of Atomic part. with Fields	0.00-100.00 eV	Ex	1511
H^{-1+}	Inter. of Atomic part. with Fields		Th	1473
H	Inter. of Atomic part. with Fields		E/T	1502
H	Inter. of Atomic part. with Fields	3.40 eV	E/T	1501
H	Inter. of Atomic part. with Fields	200.00-500.00 V/cm	Th	1493
H	Inter. of Atomic part. with Fields		Th	1492
H	Inter. of Atomic part. with Fields	10^{12} - 10^{15} W/cm ²	Th	1491
H	Inter. of Atomic part. with Fields		Th	1487
H	Inter. of Atomic part. with Fields		Th	1480
H	Inter. of Atomic part. with Fields	5.00 eV	Th	1475
H	Inter. of Atomic part. with Fields		Th	1469
H^*	Inter. of Atomic part. with Fields		Th	1469
H	Inter. of Atomic part. with Fields		Th	1466
H	Inter. of Atomic part. with Fields		Th	1451
$H + H$	Inter. of Atomic part. with Fields		Th	1480
$H^{1+} + H$	Inter. of Atomic part. with Fields	0.00-1.00 MeV	Th	1472
H_2	Inter. of Atomic part. with Fields	13.10-13.10 eV	Th	1497
H_2^{1+}	Inter. of Atomic part. with Fields		Th	1476
H_2^{1+}	Inter. of Atomic part. with Fields	.	Th	1451
H_3	Inter. of Atomic part. with Fields	3.10-6.20 eV	Ex	1478
H_3^{1+}	Inter. of Atomic part. with Fields		Th	1486
HD_2	Inter. of Atomic part. with Fields	3.10-6.20 eV	Ex	1478
D_2^{1+}	Inter. of Atomic part. with Fields		Th	1476
D_3	Inter. of Atomic part. with Fields	3.10-6.20 eV	Ex	1478
He^{-1+}	Inter. of Atomic part. with Fields		Th	1485
He	Inter. of Atomic part. with Fields		Th	1494
He	Inter. of Atomic part. with Fields		Th	1473
He	Inter. of Atomic part. with Fields		Th	1471
He	Inter. of Atomic part. with Fields	0.65-0.78 a.u.	Th	1460
He	Inter. of Atomic part. with Fields	30.00 eV	E/T	1456
He	Inter. of Atomic part. with Fields	0.7×10^{-5} a.u.	Th	1443
He	Inter. of Atomic part. with Fields	65.00-72.00 eV	Th	1442
$He + He$	Inter. of Atomic part. with Fields	12.00 keV	E/T	1449
$He + O_2$	Inter. of Atomic part. with Fields	0.00-5.00 K	Th	1499
He^{1+}	Inter. of Atomic part. with Fields	40.60-42.00 eV	Th	1498
He^{1+}	Inter. of Atomic part. with Fields		Th	1492
$He^{2+} + H$	Inter. of Atomic part. with Fields	12.00 a.u.	Th	1454
$He^{2+} + H$	Inter. of Atomic part. with Fields	10.00 a.u.	Th	1445

He₂	Inter. of Atomic part. with Fields		Th	1483
Li	Inter. of Atomic part. with Fields		Ex	1470
Li*	Inter. of Atomic part. with Fields		Th	1446
Li	Inter. of Atomic part. with Fields		Th	1446
Li²⁺	Inter. of Atomic part. with Fields		Th	1492
B	Inter. of Atomic part. with Fields		Th	1447
B*	Inter. of Atomic part. with Fields		Th	1447
B¹⁺	Inter. of Atomic part. with Fields		Th	1447
B^{1+*}	Inter. of Atomic part. with Fields		Th	1447
N₂	Inter. of Atomic part. with Fields	1.17-1.55 eV	Th	1490
N₂	Inter. of Atomic part. with Fields		Ex	1450
O²⁺	Inter. of Atomic part. with Fields	17.00-54.00 K	Ex	1439
Na + Na	Inter. of Atomic part. with Fields	663.00-723.00 K	Ex	1444
Mg	Inter. of Atomic part. with Fields	1.55 eV	Ex	1488
Mg + Ne	Inter. of Atomic part. with Fields		Th	1507
Si²⁺	Inter. of Atomic part. with Fields	1.66-3.26 eV	Ex	1436
S³⁺	Inter. of Atomic part. with Fields	4.00 eV	Ex	1440
Ar	Inter. of Atomic part. with Fields		Th	1473
Ar	Inter. of Atomic part. with Fields	6 10 ¹³ W/cm ²	Th	1461
Ar³⁺	Inter. of Atomic part. with Fields	3.10-4.96 eV	Ex	1438
Ca + He	Inter. of Atomic part. with Fields	0.00-1.00 K	E/T	1468
Kr	Inter. of Atomic part. with Fields		E/T	1455
Kr¹⁺	Inter. of Atomic part. with Fields	16.00-24.50 K	Ex	1452
Rb + Rb	Inter. of Atomic part. with Fields	3.00-3.40 V/cm	Ex	1504
Rb* + Rb*	Inter. of Atomic part. with Fields	3.00-3.40 V/cm	Ex	1504
Rb²⁺	Inter. of Atomic part. with Fields	110.00-150.00 eV	E/T	1464
Sr	Inter. of Atomic part. with Fields		Ex	1465
Sr*	Inter. of Atomic part. with Fields		Ex	1465
Sr* + He	Inter. of Atomic part. with Fields	1.03 K	Ex	1458
Sr + He	Inter. of Atomic part. with Fields	1.03 K	Ex	1458
Sr* + Ar	Inter. of Atomic part. with Fields	1.03 K	Ex	1458
Sr + Ar	Inter. of Atomic part. with Fields	1.03 K	Ex	1458
Sr* + Xe	Inter. of Atomic part. with Fields	1.03 K	Ex	1458
Sr + Xe	Inter. of Atomic part. with Fields	1.03 K	Ex	1458
I	Inter. of Atomic part. with Fields		Ex	1462
Xe	Inter. of Atomic part. with Fields	2.03-3.10 eV	Ex	1479
Xe	Inter. of Atomic part. with Fields		Th	1473
Cs	Inter. of Atomic part. with Fields		Ex	1477
Cs	Inter. of Atomic part. with Fields	1.46 eV	E/T	1457
Cs + Cs	Inter. of Atomic part. with Fields		Th	1503
Cs + Cs	Inter. of Atomic part. with Fields	0.13 mK	Ex	1489
Ba	Inter. of Atomic part. with Fields		Ex	1482
Ba¹⁺	Inter. of Atomic part. with Fields		Ex	1505
Pb¹⁺	Inter. of Atomic part. with Fields	11.00-24.00 K	E/T	1463
I₂	Inter. of Atomic part. with Fields		Ex	1462
Na₂	Inter. of Atomic part. with Fields		Ex	1453
HCN	Inter. of Atomic part. with Fields	0.06-0.17 eV	Th	1506

3 BIBLIOGRAPHY

3.1 Structure and Spectra

1. E. Charro, I. Martin, D. Bielinska-Waz
Electric quadrupole transitions in Ni XVIII.
Astron. Astrophys. Suppl. Ser. **146**, 49 (2000)
Transition probabil., Oscill. Streng **Ni XVIII** Th

2. G. X. Chen, A. K. Pradhan
Atomic data from the Iron Project. XLIV. Transition probabilities and line ratios for Fe VI with fluorescent excitation in planetary nebulae.
Astron. Astrophys. Suppl. Ser. **147**, 11 (2000)
Transition probabil., Oscill. Streng **Fe VI** Th

3. J. A. Tully, M. C. Chidichimo
Oscillator strengths between fine structure levels of Fe XXIII.
Astron. Astrophys. **365**, 66 (2001)
Transition probabil., Oscill. Streng **Fe XXIII** Th

4. A. M. Binello, E. Landi, H. E. Mason, P. J. Storey, J. W. Brosius
A comparison between theoretical and solar Fe XII UV line intensity ratios.
Astron. Astrophys. **370**, 071 (2001)
Transition probabil., Oscill. Streng **Fe XII** Th

5. H. Karlsson, C. M. Sikström, S. Johansson, Z. S. Li, H. Lundberg
The FERRUM project: Experimental f-values for 4p-5s transitions in Fe II.
Astron. Astrophys. **371**, 60 (2001)
Transition probabil., Oscill. Streng **Fe II** Ex

6. F. Rodriguez, J. A. Aparicio, A. de Castro, J. A. del Val, V. R. Gonzalez, S. Mar
Measurement of several transition probabilities in singly-ionized krypton.
Astron. Astrophys. **372**, 38 (2001)
Transition probabil., Oscill. Streng **Kr II** Ex

7. E. Charro, I. Martin
Regularities along spectral series in forbidden transitions of TiII+.
Astron. Astrophys. **373**, 20 (2001)
Transition probabil., Oscill. Streng **Ti XII** Th

8. E. Charro, I. Martin
Relativistic quantum defect orbital study of forbidden transitions in Co16+.
Astron. Astrophys. **376**, 106 (2001)
Transition probabil., Oscill. Streng **Co XVII** Th

9. J. C. Pickering, S. Johansson, P. L. Smith
The FERRUM project: Branching ratios and atomic transition probabilities of Fe II transitions from the 3d6(a3F)4p subconfiguration in the visible to VUV spectral region.
Astron. Astrophys. **377**, 61 (2001)
Transition probabil., Oscill. Streng **Fe II** Ex

10. G. I. Tachiev, C. Froese Fischer
Breit-Pauli energy levels and transition rates for nitrogen-like and oxygen-like sequences.
Astron. Astrophys. **385**, 16 (2002)

- | | | |
|--------------------------------------|---------------------|----|
| Transition probabil., Oscill. Streng | N I Z= 7, 14 | Th |
| Transition probabil., Oscill. Streng | O I Z= 8, 14 | Th |
11. V. Vujnovic, K. Blagoev, C. Fuerboeck, T. Neger, H. Jaeger
Absolute transition probabilities of Al I and Al II spectral lines and intensity ratios within multiplets.
Astron. Astrophys. **388**, 04 (2002)

Transition probabil., Oscill. Streng	Al I	Ex
Transition probabil., Oscill. Streng	Al II	Ex

 12. S. N. Nahar
Relativistic fine structure oscillator strengths for Li-like ions: C IV-Si XII, S XIV, Ar XVI, Ca XVIII, Ti XX, Cr XXII, and Ni XXVI.
Astron. Astrophys. **389**, 16 (2002)

Transition probabil., Oscill. Streng	Li I Z= 6, 24	Th
--------------------------------------	----------------------	----

 13. S. N. Nahar
Fine structure radiative transitions in C II and C III using the Breit-Pauli R-matrix method.

At. Data Nucl. Data Tables **80**, 05 (2002)

Transition probabil., Oscill. Streng	C II	Th
Transition probabil., Oscill. Streng	C III	Th

 14. J. C. Pickering, A. P. Thorne, R. Perez
Oscillator strengths of transitions in Ti II in the visible and ultraviolet regions.
Astrophys. J. Suppl. Ser. **132**, 03 (2001)

Transition probabil., Oscill. Streng	Ti II	Ex
--------------------------------------	--------------	----

 15. K. M. Aggarwal, F. P. Keenan, A. Z. Msezane
Oscillator strengths for transitions in C-like ions between F IV and Ar XIII.
Astrophys. J. Suppl. Ser. **136**, 63 (2001)

Transition probabil., Oscill. Streng	C I Z= 9, 18	Th
--------------------------------------	---------------------	----

 16. S. N. Nahar, M. A. Bautista
Electron-ion recombination rate coefficients and photoionization cross sections for astrophysically abundant elements. VI. Ni II.
Astrophys. J. Suppl. Ser. **137**, 01 (2001)

Transition probabil., Oscill. Streng	Ni III	Th
--------------------------------------	---------------	----

 17. N. C. Deb, G. P. Gupta, A. Z. Msezane
Oscillator strengths and radiative rates for allowed and intercombination transitions among the lowest 54 levels of Fe X.
Astrophys. J. Suppl. Ser. **141**, 47 (2002)

Transition probabil., Oscill. Streng	Fe X	Th
--------------------------------------	-------------	----

 18. T. Brage, P. G. Judge, P. Jansson, D. P. Edwards
Spectral lines for polarization measurements of the coronal magnetic field. III. Atomic data for Si IX.
Astrophys. J. **540**, 114 (2000)

Transition probabil., Oscill. Streng	Si IX	Th
--------------------------------------	--------------	----

 19. C. Lavin, E. Olalla, I. Martin
Intensities for transitions involving highly excited states of N II: A relativistic treatment.
Astrophys. J. **543**, 051 (2000)

Transition probabil., Oscill. Streng	N II	Th
--------------------------------------	-------------	----

20. J. C. Howk, K. R. Sembach, K. C. Roth, J. W. Kruk
Empirical verification of the Fe II oscillator strengths in the FUSE bandpass.
 Astrophys. J. **544**, 67 (2000)
 Transition probabil., Oscill. Streng **Fe II** Ex

21. L. M. Wiese, J. A. Fedchak, J. E. Lawler
Absorption f-values of Ti II vacuum ultraviolet resonance transitions.
 Astrophys. J. **547**, 178 (2001)
 Transition probabil., Oscill. Streng **Ti II** Ex

22. S. R. Federman, J. Zsargo
Atomic physics with the Goddard high resolution spectrograph on the Hubble Space Telescope. V. Oscillator strengths for neutral carbon lines below 1200 Å.
 Astrophys. J. **555**, 020 (2001)
 Transition probabil., Oscill. Streng **C I** Ex

23. L. M. Wiese, G. A. Bonvallet, J. E. Lawler
Laboratory measurement of the Fe II 114.4938 nanometer oscillator strength.
 Astrophys. J. **569**, 032 (2002)
 Transition probabil., Oscill. Streng **Fe II** Ex

24. I. V. L. Costa, G. H. Cavalcanti, A. G. Trigueiros
Weighted oscillator strengths and lifetimes for the neutral oxygen spectrum, O I.
 Braz. J. Phys. **31**, 8 (2001)
 Transition probabil., Oscill. Streng **O I** Th

25. G. Tachiev, C. Froese Fischer
Breit-Pauli energy levels and transition rates for the carbonlike sequence.
 Can. J. Phys. **79**, 55 (2001)
 Transition probabil., Oscill. Streng **C I Z= 7, 15** Th

26. B. Saha, A. K. Das, P. K. Mukherjee
Radiative transitions in highly ionized silicon-like ions.
 Eur. Phys. J. D **14**, 3 (2001)
 Transition probabil., Oscill. Streng **Si I Z= 25, 36** Th

27. C. Z. Dong, S. Fritzsche, B. Fricke
Theoretical investigations on the 3d94p - 3d10 spectrum of Cu II.
 J. Electron. Spectrosc. Relat. Phenom. **114-116**, 57 (2001)
 Transition probabil., Oscill. Streng **Cu II** Th

28. N.-W. Zheng, T. Wang, D.-X. Ma, T. Zhou
Calculation of the transition probability for C (I-IV).
 J. Opt. Soc. Am. B **18**, 395 (2001)
 Transition probabil., Oscill. Streng **C I** Th
 Transition probabil., Oscill. Streng **C II** Th
 Transition probabil., Oscill. Streng **C III** Th
 Transition probabil., Oscill. Streng **C IV** Th

29. I. Murakami, U. I. Safronova, T. Kato
Dielectronic recombination rate coefficients to excited states of Ne VII from Ne VIII.
 J. Phys. B **32**, 331 (1999)
 Transition probabil., Oscill. Streng **Ne VII** Th

30. Z. S. Li, H. Lundberg, U. Berzinsh, S. Johansson, S. Svanberg
The FERRUM project: radiative lifetimes of the $3d5(6S)4s4p(3P)^y 6Po$ states of Fe II measured with time-resolved vacuum ultraviolet laser spectroscopy.
 J. Phys. B **33**, 593 (2000)
- | | | |
|--------------------------------------|-------|----|
| Transition probabil., Oscill. Streng | C I | Ex |
| Transition probabil., Oscill. Streng | Fe II | Ex |
31. J. E. Rice, K. B. Fournier, J. A. Goetz, E. S. Marmar, J. L. Terry
X-ray observations of $2l-nl'$ transitions and configuration-interaction effects from Kr, Mo, Nb, and Zr in near neon-like charge states from tokamak plasmas.
 J. Phys. B **33**, 435 (2000)
- | | | |
|--------------------------------------|-----------|----|
| Transition probabil., Oscill. Streng | Kr XXV | Th |
| Transition probabil., Oscill. Streng | Kr XXVI | Th |
| Transition probabil., Oscill. Streng | Kr XXVII | Th |
| Transition probabil., Oscill. Streng | Kr XXVIII | Th |
| Transition probabil., Oscill. Streng | Zr XXXI | Th |
| Transition probabil., Oscill. Streng | Nb XXXII | Th |
| Transition probabil., Oscill. Streng | Mo XXXIII | Th |
32. E. Charro, D. Bielinska-Waz, I. Martin
Line strengths for E2 transitions in Fe XVI.
 J. Phys. B **33**, 855 (2000)
- | | | |
|--------------------------------------|--------|----|
| Transition probabil., Oscill. Streng | Fe XVI | Th |
|--------------------------------------|--------|----|
33. K. A. Berrington, J. C. Pelan, J. A. Waldock
Oscillator strength for $3s23p5-3s3p6$ in Cl-like ions.
 J. Phys. B **34**, 419 (2001)
- | | | |
|--------------------------------------|----------------|----|
| Transition probabil., Oscill. Streng | Cl I Z= 18, 29 | Th |
|--------------------------------------|----------------|----|
34. Y. Zou, C. Froese Fischer
Multiconfiguration Dirac-Hartree-Fock calculations of the forbidden transitions between $3s2 1S0$, $3s3p 3P0,1,2$, $1P1$ states for Mg-like ions.
 J. Phys. B **34**, 15 (2001)
- | | | |
|--------------------------------------|----------------|----|
| Transition probabil., Oscill. Streng | Mg I Z= 13, 16 | Th |
|--------------------------------------|----------------|----|
35. C. M. Sikström, H. Pihlmark, H. Nilsson, U. Litzen, S. Johansson, Z. S. Li, H. Lundberg
Experimental Mo II oscillator strengths.
 J. Phys. B **34**, 77 (2001)
- | | | |
|--------------------------------------|-------|-----|
| Transition probabil., Oscill. Streng | Mo II | E/T |
| Transition probabil., Oscill. Streng | Mo II | E/T |
36. J. A. del Val, J. A. Aparicio, V. R. Gonzalez, S. Mar
Transition probability measurement of several O II spectral lines.
 J. Phys. B **34**, 531 (2001)
- | | | |
|--------------------------------------|------|----|
| Transition probabil., Oscill. Streng | O II | Ex |
|--------------------------------------|------|----|
37. E. Charro, S. Lopez-Ferrero, I. Martin
Forbidden emission coefficients for intraconfiguration transitions $2p3/2 \rightarrow 2p1/2$ along the boron sequence.
 J. Phys. B **34**, 243 (2001)
- | | | |
|--------------------------------------|--------------|----|
| Transition probabil., Oscill. Streng | B I Z= 5, 82 | Th |
|--------------------------------------|--------------|----|
38. G. P. Gupta, A. Z. Msezane
Fine-structure energy levels and lifetimes in Al-like iron and nickel.
 J. Phys. B **34**, 217 (2001)

- | | | |
|--------------------------------------|---------------|----|
| Transition probabil., Oscill. Streng | Fe XIV | Th |
| Transition probabil., Oscill. Streng | Ni XVI | Th |
39. A. de Castro, J. A. Aparicio, J. A. del Val, V. R. Gonzalez, S. Mar
Measurement of Stark broadening and shift constants of singly ionized krypton lines.
J. Phys. B **34**, 275 (2001)
- | | | |
|--------------------------------------|--------------|----|
| Transition probabil., Oscill. Streng | Kr II | Th |
|--------------------------------------|--------------|----|
40. E. Charro, I. Martin
E2 transitions in Ti XII. Relativistic calculations.
J. Phys. B **34**, 13 (2001)
- | | | |
|--------------------------------------|---------------|----|
| Transition probabil., Oscill. Streng | Ti XII | Th |
|--------------------------------------|---------------|----|
41. P. L. Norquist, D. R. Beck
Ab initio lifetimes, Lande g-values and hyperfine structure for Ta II states.
J. Phys. B **34**, 107 (2001)
- | | | |
|--------------------------------------|--------------|----|
| Transition probabil., Oscill. Streng | Ta II | Th |
|--------------------------------------|--------------|----|
42. C. J. Zeippen, E. Biemont, E. Traebert
Calculated transition probabilities in highly charged Ti-like ions.
J. Phys. B **34**, 941 (2001)
- | | | |
|--------------------------------------|-----------------------|----|
| Transition probabil., Oscill. Streng | Ti I Z= 42, 83 | Th |
|--------------------------------------|-----------------------|----|
43. O. Zatsarinny, S. S. Tayal
Low-energy electron collisions with atomic oxygen: R-matrix calculation with non-orthogonal orbitals.
J. Phys. B **34**, 299 (2001)
- | | | |
|--------------------------------------|------------|----|
| Transition probabil., Oscill. Streng | O I | Th |
|--------------------------------------|------------|----|
44. C. Froese Fischer, P. Jönsson, M. Godefroid
Non-relativistic variational calculations of atomic properties in Li-like ions: Li I to O VI.
J. Phys. B **34**, 079 (2001)
- | | | |
|--------------------------------------|-------------|----|
| Transition probabil., Oscill. Streng | Li I | Th |
|--------------------------------------|-------------|----|
45. O. Zatsarinny, C. Froese Fischer
Oscillator strengths for transitions to high-lying excited states of carbon.
J. Phys. B **35**, 669 (2002)
- | | | |
|--------------------------------------|------------|----|
| Transition probabil., Oscill. Streng | C I | Th |
|--------------------------------------|------------|----|
46. E. Trabert, G. Gwinner, A. Wolf, E. J. Knystautas, H.-P. Garnir, X. Tordoir
M1/E2 transition rates in Fe X through Fe XIII measured at a heavy-ion storage ring.
J. Phys. B **35**, 71 (2002)
- | | | |
|--------------------------------------|----------------|----|
| Transition probabil., Oscill. Streng | Fe X | Ex |
| Transition probabil., Oscill. Streng | Fe XI | Ex |
| Transition probabil., Oscill. Streng | Fe XII | Ex |
| Transition probabil., Oscill. Streng | Fe XIII | Ex |
| Transition probabil., Oscill. Streng | Fe XIV | Ex |
47. P. Quinet
Investigation of configuration interaction and core-polarization effects in singly ionized molybdenum (Mo II).
J. Phys. B **35**, 9 (2002)
- | | | |
|--------------------------------------|--------------|----|
| Transition probabil., Oscill. Streng | Mo II | Th |
|--------------------------------------|--------------|----|

48. G. Correge, A. Hibbert
Intercombination lines in C II, N III, and O IV.
J. Phys. B **35**, 211 (2002)

Transition probabil., Oscill. Streng	C II	Th
Transition probabil., Oscill. Streng	N III	Th
Transition probabil., Oscill. Streng	O IV	Th

49. N. W. Zheng, T. Wang, T. Zhou, D. X. Ma
Theoretical study of transition probability for oxygen atom and ions.
J. Phys. Soc. Jpn. **71**, 672 (2002)

Transition probabil., Oscill. Streng	O I - O VI	Th
--------------------------------------	------------	----

50. P. Matheron, A. Escarguel, R. Redon, A. Lesage, J. Richou
Si II transition probabilities measurements in a laser induced plasma.
J. Quant. Spectrosc. Radiat. Transfer **69**, 35 (2001)

Transition probabil., Oscill. Streng	Si II	Ex
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51. O. Renner, F. B. Rosmej, E. Krousky, P. Sondhauss, M. P. Kalachnikov, P. V. Nickles, I. Uschmann, E. Foerster
Aluminum Lyman alpha group formation at high-intensity, high-energy laser-matter interaction.
J. Quant. Spectrosc. Radiat. Transfer **71**, 23 (2001)

Transition probabil., Oscill. Streng	Al XII	Th
Transition probabil., Oscill. Streng	Al XIII	Th

52. L. H. Coutinho, A. G. Trigueiros
Weighted oscillator strengths and lifetimes for the Si XII and Si XIII spectra.
J. Quant. Spectrosc. Radiat. Transfer **72**, 85 (2002)

Transition probabil., Oscill. Streng	Si XII	Th
Transition probabil., Oscill. Streng	Si XIII	Th

53. L. H. Coutinho, A. G. Trigueiros
Weighted oscillator strengths and lifetimes for the Si I spectrum.
J. Quant. Spectrosc. Radiat. Transfer **75**, 57 (2002)

Transition probabil., Oscill. Streng	Si I	Th
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54. C.-Z. Dong, S. Fritzsche, L.-Y. Xie
Energy levels and transition probabilities for possible x-ray laser lines of highly charged Ni-like ions.
J. Quant. Spectrosc. Radiat. Transfer **76**, 47 (2003)

Transition probabil., Oscill. Streng	Ni I Z= 74, 84	Th
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55. T. Brage, J. Fleming, R. Hutton
A review of intercombination lines in beryllium-like ions.
Mol. Phys. **98**, 057 (2000)

Transition probabil., Oscill. Streng	Be I Z= 6, 8	Th
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56. M. P. Donnelly, A. Hibbert
Sextet transitions in Fe II.
Mon. Not. R. Astron. Soc. **321**, 47 (2001)

Transition probabil., Oscill. Streng	Fe II	Th
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57. A. V. Loginov, V. I. Tuchkin
Radiative constants in the spectra of ions of the erbium isoelectronic sequence.
Opt. Spectrosc. **90**, 31 (2001)

- | | | | |
|--|--------------------------------------|----------------|----|
| | Transition probabil., Oscill. Streng | Er I Z= 70, 73 | Th |
|--|--------------------------------------|----------------|----|
58. A. V. Loginov, V. I. Tuchkin
Radiative constants in the spectra of ions of the krypton isoelectronic sequence.
 Opt. Spectrosc. **91**, 65 (2001)
 Transition probabil., Oscill. Streng Kr I Z= 37, 42 Th
59. S. J. Smith, A. Chutjian, J. B. Greenwood
Lifetimes of the 2s22p 2Po - 2s2p2 4P intercombination transitions of C+.
 Phys. Rev. A **60**, 569 (1999)
 Transition probabil., Oscill. Streng C II Ex
60. N. C. Deb, G. P. Gupta, A. Z. Msezane
Correlation effects on fine-structure energy levels and oscillator strengths in Fe X.
 Phys. Rev. A **60**, 569 (1999)
 Transition probabil., Oscill. Streng Fe X Th
61. Y. Zou, C. Froese Fischer
Multiconfiguration Dirac-Hartree-Fock optimization strategies for 3s2 1S0-3s3p 3P1 transition rates for Al+ - S4+.
 Phys. Rev. A **62**, 62505 (2000)
 Transition probabil., Oscill. Streng Mg I Z= 13, 92 Th
62. N. Sewraj, J. P. Gardou, Y. Salamero, P. Millet
Radiation trapping of the 3P1 - 1S0 resonant transitions of xenon and krypton in Xe-Kr, Xe-Ar, and Kr-Ar mixtures: Kinetic analysis and determination of the van der Waals broadening coefficients.
 Phys. Rev. A **62**, 52721 (2000)
 Transition probabil., Oscill. Streng Kr I Ex
 Transition probabil., Oscill. Streng Xe I Ex
63. S. N. Nahar, A. K. Pradhan, H. L. Zhang
K-shell dielectronic resonances in photoabsorption: Differential oscillator strengths for Li-like C IV, O VI, and Fe XXIV.
 Phys. Rev. A **63**, 60701 (2001)
 Transition probabil., Oscill. Streng C IV Th
 Transition probabil., Oscill. Streng O VI Th
 Transition probabil., Oscill. Streng Fe XXIV Th
64. Y. Ishikawa, M. J. Vilkas
Relativistic multireference many-body perturbation-theory calculations of the magnetic-dipole and electric-quadrupole transition probabilities of ions in the silicon isoelectronic sequence.
 Phys. Rev. A **63**, 42506 (2001)
 Transition probabil., Oscill. Streng Si I Z= 26, 54 Th
65. H. Lundberg, Z. S. Li, P. Jönsson
Experimental and theoretical investigations of radiative lifetimes in the s and d sequences of neutral boron.
 Phys. Rev. A **63**, 32505 (2001)
 Transition probabil., Oscill. Streng B I E/T
 Transition probabil., Oscill. Streng B I E/T
66. S. M. O'Malley, D. R. Beck, D. P. Oros
Oscillator strengths, Lande g values, and hyperfine structure for 3d4 J=0-3d34p J=1 transitions in Fe V.
 Phys. Rev. A **63**, 32501 (2001)

- | | | | |
|--|--------------------------------------|------|----|
| | Transition probabil., Oscill. Streng | Fe V | Th |
|--|--------------------------------------|------|----|
67. D. C. Griffin, D. M. Mitnik, M. S. Pindzola
Effects of LS term dependence in He-like ions.
 Phys. Rev. A **63**, 14702 (2001)
 Transition probabil., Oscill. Streng He I Z= 3, 12 Th
68. R. Schnabel, M. Kock
Time-resolved nonlinear laser-induced fluorescence technique for a combined lifetime and branching-fraction measurement.
 Phys. Rev. A **63**, 12519 (2000)
 Transition probabil., Oscill. Streng Fe II Ex
69. E. Träbert, P. Beiersdorfer, G. V. Brown, H. Chen, D. B. Thorn, E. Biemont
Experimental M1 transition rates in highly charged Kr ions.
 Phys. Rev. A **64**, 42511 (2001)
 Transition probabil., Oscill. Streng Kr XVII-XIX E/T
 Transition probabil., Oscill. Streng Kr XXII-XXIII E/T
70. M. H. Chen, K. T. Cheng, W. R. Johnson
Large-scale relativistic configuration-interaction calculation of the 2s2 1S0 - 2s2p 3P1 inter-combination transition in C III.
 Phys. Rev. A **64**, 42507 (2001)
 Transition probabil., Oscill. Streng C III Th
71. E. Trabert, P. Beiersdorfer, G. V. Brown, H. Chen, E. H. Pinnington, D. B. Thorn
Experimental M1 transition rates in K XI, K XV, and K XVI.
 Phys. Rev. A **64**, 34501 (2001)
 Transition probabil., Oscill. Streng K XI Ex
 Transition probabil., Oscill. Streng K XV Ex
 Transition probabil., Oscill. Streng K XVI Ex
72. H. L. Zhang, S. N. Nahar, A. K. Pradhan
Relativistic close-coupling calculations for photoionization and recombination of Ne-like Fe XVII.
 Phys. Rev. A **64**, 32719 (2001)
 Transition probabil., Oscill. Streng Fe XVIII Th
73. J.-L. Zeng, J.-M. Yuan, Q.-S. Lu
Detailed-term-accounting-approximation calculations of the radiative opacity of laser-produced Al plasmas.
 Phys. Rev. D **64**, 66412 (2001)
 Transition probabil., Oscill. Streng Al V Th
 Transition probabil., Oscill. Streng Al VI Th
74. I. Kink, L. Engström
Spectroscopic investigations of the 2p23 configurations in Si VIII and S X.
 Phys. Scr. **59**, 55 (1999)
 Transition probabil., Oscill. Streng Si VIII Th
 Transition probabil., Oscill. Streng S X Th
75. I. Kink, L. Engström, P. M. R. Rao
Experimental study of configuration mixing effects on the lifetimes of 1s22s6 levels in Be-like O.
 Phys. Scr. **60**, 22 (1999)

- | | Transition probabil., Oscill. Streng | O V | E/T |
|-----|---|----------------|-----|
| 76. | N. J. Wilson, A. Hibbert, K. L. Bell
Oscillator strengths for K III, Ca IV and Sc V.
Phys. Scr. 61 , 03 (2000) | | |
| | Transition probabil., Oscill. Streng | K III | Th |
| | Transition probabil., Oscill. Streng | Ca IV | Th |
| | Transition probabil., Oscill. Streng | Sc V | Th |
| 77. | M. Schultz-Johanning, R. Kling, R. Schnabel, M. Kock, Z. Li, H. Lundberg, S. Johansson
Lifetimes, branching fractions, and oscillator strengths of doubly ionized tungsten.
Phys. Scr. 63 , 67 (2001) | | |
| | Transition probabil., Oscill. Streng | W III | Ex |
| 78. | A. Sreckovic, V. Drincic, S. Bukvic, S. Djenize
Stark broadening parameters and transition probabilities in the O II spectrum.
Phys. Scr. 63 , 06 (2001) | | |
| | Transition probabil., Oscill. Streng | O II | Ex |
| 79. | U. Feldman, R. Doron, M. Klapisch, A. Bar-Shalom
Intensity vs. electron density of the ultraviolet M1 transition in Xe32+, Gd42+, W52+, Bi61+, and U70+ (Ti-like ions).
Phys. Scr. 63 , 84 (2001) | | |
| | Transition probabil., Oscill. Streng | Ti I Z= 54, 92 | Th |
| 80. | A. E. Kingston, A. Hibbert
The calculation of the line strengths for magnetic dipole transitions between the 2s2, 2s2p and 2p2 states in Be-like ions.
Phys. Scr. 64 , 8 (2001) | | |
| | Transition probabil., Oscill. Streng | Be I Z= 5, 36 | Th |
| 81. | C. Blancard, M. Cornille, J. Dubau
Radiative and collisional atomic data for neon-like copper.
Phys. Scr. 64 , 52 (2001) | | |
| | Transition probabil., Oscill. Streng | Cu XX | Th |
| 82. | A. Baclawski, T. Wujec, J. Musielok
Measurements of spectral line strengths within some C I multiplets belonging to the 3p-3d and 3p-4s transition arrays.
Phys. Scr. 64 , 14 (2001) | | |
| | Transition probabil., Oscill. Streng | C I | Ex |
| 83. | N. C. Deb, A. Z. Msezane
Fine-structure energy levels, oscillator strengths and transition probabilities in Ni XVI.
Phys. Scr. 64 , 12 (2001) | | |
| | Transition probabil., Oscill. Streng | Ni XVI | Th |
| 84. | H.-S. Chou
Comments on "Relativistic many-body calculations of transition probabilities for the 2122[LSJ]-2324[L'S'J'] lines in the Be-like ions".
Phys. Scr. 64 , 40 (2001) | | |
| | Transition probabil., Oscill. Streng | Be I Z= 4, 14 | Th |
| 85. | A. Sreckovic, S. Djenize, S. Bukvic
Measured transition probabilities in the O II higher multiplets.
Phys. Scr. 65 , 59 (2002) | | |

- | | | | |
|--|--------------------------------------|-------------|----|
| | Transition probabil., Oscill. Streng | O II | Ex |
|--|--------------------------------------|-------------|----|
86. A. Baclawski, T. Wujec, J. Musielok
Relative transition probability measurements for prominent infrared spectral lines of N I.
 Phys. Scr. **65**, 8 (2002)
 Transition probabil., Oscill. Streng **N I** Ex
87. Y. Ishikawa, M. J. Vilkas
Relativistic multireference Moeller-Plesset perturbation theory calculations on the term energy and lifetime of the 5So2 state in siliconlike ions with Z=28-79.
 Phys. Scr. **65**, 19 (2002)
 Transition probabil., Oscill. Streng **Si I Z= 28, 79** Th
88. K. L. Bell
Photoionization of ions of astrophysical interest: Theoretical survey.
 Phys. Scr. **T100**, 4 (2002)
 Transition probabil., Oscill. Streng **N IV** Th
 Transition probabil., Oscill. Streng **O V** Th
89. C. Z. Dong, S. Fritzsche, B. Fricke, W.-D. Sepp
Ab-initio calculations for forbidden M1 transitions in Ar13+ and Ar14+ ions.
 Phys. Scr. **T92**, 94 (2001)
 Transition probabil., Oscill. Streng **Ar XIV** Th
 Transition probabil., Oscill. Streng **Ar XV** Th
90. S. Mar, C. Perez, V. R. Gonzalez, M. A. Gigosos, J. A. del Val, I. de la Rosa, J. A. Aparicio
Experimental transition probabilities in NII lines.
 Astron. Astrophys. Suppl. Ser. **144**, 509 (2000)
 $h\nu + N^{1+}$ Photoexcitation 1.77-3.26 eV Ex
91. D. J. Bord
Ab initio calculations of oscillator strengths and Lande factors for Nd III.
 Astron. Astrophys. Suppl. Ser. **144**, 517 (2000)
 $h\nu + Nd^{2+}$ Photoexcitation 1.80-4.00 eV Th
92. S. N. Nahar
Atomic data from the Iron Project. XLV. Relativistic transition probabilities for carbon-like Ar XIII and Fe XXI using Breit-Pauli R-matrix method.
 Astron. Astrophys. Suppl. Ser. **147**, 253 (2000)
 $h\nu + Ar^{12+}$ Photoexcitation 8.00 Ry Th
 $h\nu + Fe^{20+}$ Photoexcitation 8.00 Ry Th
93. A. G. Kochur, D. Petrini, E. P. Da Silva
2s-photoionisation of atomic magnesium: Shake processes and Coster-Kronig radiationless decay.
 Astron. Astrophys. **365**, 248 (2001)
 $h\nu + Mg$ Photoionization 100.00-300.00 eV Th
94. S. Djenize, S. Bukvic
Transition probabilities of several transitions in the Ar III and Ar IV spectra.
 Astron. Astrophys. **365**, 252 (2001)
 $h\nu + Ar^{2+}$ Photoexcitation 4.13 eV Ex
 $h\nu + Ar^{3+}$ Photoexcitation 4.13 eV Ex
95. J. A. Tully, M. C. Chidichimo
Oscillator strengths between fine structure levels of Fe XXIII.
 Astron. Astrophys. **365**, 266 (2001)
 $h\nu + Fe^{22+}$ Photoexcitation Th

3.2 Atomic and Molecular Collisions

3.2.1 Photon Collisions

96. N. V. Dobrodey
Radiative transitions in TiO: Ab initio oscillator strengths and lifetimes for low-lying electronic states.
Astron. Astrophys. **365**, 642 (2001)
 $h\nu + \text{TiO}$ Photoexcitation Th
97. H. O. Karlsson, C. M. Sikstrom, S. Johansson, Z. S. Li, H. Lundberg
The FERRUM project: Experimental f-values for 4p-5s transitions in Fe II.
Astron. Astrophys. **371**, 360 (2001)
 $h\nu + \text{Fe}^{1+}$ Photoexcitation 10.00 eV Ex
98. F. Rodriguez, J. A. Aparicio, A. de Castro, J. A. del Val, V. R. Gonzalez, S. Mar
Measurement of several transition probabilities in singly-ionized krypton.
Astron. Astrophys. **372**, 338 (2001)
 $h\nu + \text{Kr}^{1+}$ Photoexcitation 2.14-2.76 eV Ex
99. E. Charro, I. Martin
Regularities along spectral series in forbidden transitions of Ti¹¹⁺.
Astron. Astrophys. **373**, 720 (2001)
 $h\nu + \text{Ti}^{11+}$ Photoexcitation Th
100. E. Charro, I. Martin
Relativistic quantum defect orbital study of forbidden transitions in Co¹⁶⁺.
Astron. Astrophys. **376**, 1106 (2001)
 $h\nu + \text{Co}^{16+}$ Photoexcitation Th
101. J. C. Pickering, S. Johansson, P. L. Smith
The FERRUM project: Branching ratios and atomic transition probabilities of Fe II transitions from the 3d⁶(a³F)4p subconfiguration in the visible to VUV spectral region.
Astron. Astrophys. **377**, 361 (2001)
 $h\nu + \text{Fe}^{1+}$ Photoexcitation 3.54-7.75 eV Ex
102. S. Djenize, V. Milosavljevic, M. S. Dimitrijevic
Stark shifts and transition probabilities in the Ne II spectrum.
Astron. Astrophys. **382**, 359 (2002)
 $h\nu + \text{Ne}^{1+}$ Photoexcitation 3.54 eV Ex
103. H. Nilsson, Z. G. Zhang, H. Lundberg, S. Johansson, B. Nordstroem
Experimental oscillator strengths in Th II.
Astron. Astrophys. **382**, 368 (2002)
 $h\nu + \text{Th}^{1+}$ Photoexcitation 0.95-4.13 eV Ex
104. Z. G. Zhang, G. Somesfalean, S. Svanberg, P. Palmeri, P. Quinet, E. Biemont
Radiative lifetime measurements and oscillator strengths of astrophysical interest in Ho III.
Astron. Astrophys. **384**, 364 (2002)
 $h\nu + \text{Ho}^{2+}$ Photoexcitation 1.35-5.39 eV Ex
105. G. I. Tachiev, C. Froese-Fischer
Breit-Pauli energy levels and transition rates for nitrogen-like and oxygen-like sequences.
Astron. Astrophys. **385**, 716 (2002)

$h\nu + \text{N}$	Photoexcitation	Th
$h\nu + \text{O}$	Photoexcitation	Th
$h\nu + \text{O}^{1+}$	Photoexcitation	Th
$h\nu + \text{F}^{1+}$	Photoexcitation	Th
$h\nu + \text{F}^{2+}$	Photoexcitation	Th
$h\nu + \text{Ne}^{2+}$	Photoexcitation	Th
$h\nu + \text{Ne}^{3+}$	Photoexcitation	Th
$h\nu + \text{Na}^{3+}$	Photoexcitation	Th
$h\nu + \text{Na}^{4+}$	Photoexcitation	Th
$h\nu + \text{Mg}^{4+}$	Photoexcitation	Th
$h\nu + \text{Mg}^{5+}$	Photoexcitation	Th
$h\nu + \text{Al}^{5+}$	Photoexcitation	Th
$h\nu + \text{Al}^{6+}$	Photoexcitation	Th
$h\nu + \text{Si}^{6+}$	Photoexcitation	Th
$h\nu + \text{Si}^{7+}$	Photoexcitation	Th
$h\nu + \text{P}^{7+}$	Photoexcitation	Th
$h\nu + \text{P}^{8+}$	Photoexcitation	Th
$h\nu + \text{S}^{8+}$	Photoexcitation	Th
$h\nu + \text{S}^{9+}$	Photoexcitation	Th
$h\nu + \text{Cl}^{9+}$	Photoexcitation	Th
$h\nu + \text{Cl}^{10+}$	Photoexcitation	Th
$h\nu + \text{Ar}^{10+}$	Photoexcitation	Th
$h\nu + \text{K}^{11+}$	Photoexcitation	Th
$h\nu + \text{Ca}^{12+}$	Photoexcitation	Th
$h\nu + \text{O Seq}$	Photoexcitation	Th
$h\nu + \text{N Seq.}$	Photoexcitation	Th

106. Z. G. Zhang, S. Svanberg, P. Palmeri, P. Quinet, E. Biemont
Measurement of lifetimes by laser-induced fluorescence and determination of transition probabilities of astrophysical interest in Nd III.

Astron. Astrophys. **385**, 724 (2002)

$h\nu + \text{Nd}^{2+}$	Photoexcitation	1.75-3.78 eV	E/T
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107. E. Charro, Z. Curiel, I. Martin
Atomic data for M1 and E2 emission lines in the potassium isoelectronic sequence.
Astron. Astrophys. **387**, 1146 (2002)

$h\nu + \text{Mn}^{6+}$	Photoexcitation	Th
$h\nu + \text{Fe}^{7+}$	Photoexcitation	Th
$h\nu + \text{Fe}^{42+}$	Photoexcitation	Th
$h\nu + \text{Co}^{8+}$	Photoexcitation	Th
$h\nu + \text{Ni}^{9+}$	Photoexcitation	Th
$h\nu + \text{Cu}^{10+}$	Photoexcitation	Th
$h\nu + \text{Zn}^{11+}$	Photoexcitation	Th
$h\nu + \text{Ga}^{12+}$	Photoexcitation	Th
$h\nu + \text{Ge}^{13+}$	Photoexcitation	Th
$h\nu + \text{As}^{14+}$	Photoexcitation	Th
$h\nu + \text{Se}^{15+}$	Photoexcitation	Th
$h\nu + \text{Br}^{16+}$	Photoexcitation	Th
$h\nu + \text{Kr}^{17+}$	Photoexcitation	Th
$h\nu + \text{Rb}^{18+}$	Photoexcitation	Th
$h\nu + \text{Sr}^{19+}$	Photoexcitation	Th
$h\nu + \text{Y}^{20+}$	Photoexcitation	Th
$h\nu + \text{Zr}^{21+}$	Photoexcitation	Th
$h\nu + \text{Nb}^{22+}$	Photoexcitation	Th
$h\nu + \text{Mo}^{23+}$	Photoexcitation	Th
$h\nu + \text{Tc}^{24+}$	Photoexcitation	Th
$h\nu + \text{Ru}^{25+}$	Photoexcitation	Th

$h\nu + \text{Rh}^{26+}$	Photoexcitation	Th
$h\nu + \text{Pd}^{27+}$	Photoexcitation	Th
$h\nu + \text{Ag}^{28+}$	Photoexcitation	Th
$h\nu + \text{Cd}^{29+}$	Photoexcitation	Th
$h\nu + \text{In}^{30+}$	Photoexcitation	Th
$h\nu + \text{Sn}^{31+}$	Photoexcitation	Th
$h\nu + \text{Sb}^{32+}$	Photoexcitation	Th
$h\nu + \text{Te}^{33+}$	Photoexcitation	Th
$h\nu + \text{I}^{34+}$	Photoexcitation	Th
$h\nu + \text{Xe}^{35+}$	Photoexcitation	Th
$h\nu + \text{Cs}^{36+}$	Photoexcitation	Th
$h\nu + \text{Ba}^{37+}$	Photoexcitation	Th
$h\nu + \text{La}^{38+}$	Photoexcitation	Th
$h\nu + \text{Hf}^{39+}$	Photoexcitation	Th
$h\nu + \text{Ta}^{40+}$	Photoexcitation	Th
$h\nu + \text{W}^{41+}$	Photoexcitation	Th
$h\nu + \text{Os}^{43+}$	Photoexcitation	Th
$h\nu + \text{Ir}^{44+}$	Photoexcitation	Th
$h\nu + \text{Pt}^{45+}$	Photoexcitation	Th
$h\nu + \text{Au}^{46+}$	Photoexcitation	Th
$h\nu + \text{Hg}^{47+}$	Photoexcitation	Th

108. V. Vujnovic, K. Blagoev, C. Fuerboeck, T. Neger, H. Jaeger

Absolute transition probabilities of Al I and Al II spectral lines and intensity ratios within multiplets.

Astron. Astrophys. **388**, 704 (2002)

$h\nu + \text{Al}$	Photoexcitation	2.07-6.20 eV	E/T
$h\nu + \text{Al}^{1+}$	Photoexcitation	2.07-6.20 eV	E/T

109. S. N. Nahar

Relativistic fine structure oscillator strengths for Li-like ions: C IV - Si XII, S XIV, Ar XVI, Ca XVIII, Ti XX, Cr XXII, and Ni XXVI.

Astron. Astrophys. **389**, 716 (2002)

$h\nu + \text{C}^{3+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{N}^{4+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{O}^{5+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{F}^{6+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{Ne}^{7+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{Na}^{8+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{Mg}^{9+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{Al}^{10+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{Si}^{11+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{S}^{13+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{Ar}^{15+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{Ca}^{17+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{Ti}^{19+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{Cr}^{21+}$	Photoexcitation	20.00-680.00 Ry	Th
$h\nu + \text{Ni}^{25+}$	Photoexcitation	20.00-680.00 Ry	Th

110. H. Ray

Studies on the E2-transition in CoXVII.

Astron. Astrophys. **391**, 1173 (2002)

$h\nu + \text{Co}^{16+}$	Photoexcitation	Th
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111. T. Brage, P. G. Judge, P. Joensson, D. P. Edwards

Spectral lines for polarization measurements of the coronal magnetic field. III. Atomic data for Si IX.

Astrophys. J., Part 1 **540**, 1114 (2001)

	$h\nu + \text{Si}^{8+}$	Photoexcitation	12.40-49.59 eV	Th
112.	L. M. Wiese, J. A. Fedchak, J. E. Lawler Absorption f-values of Ti II vacuum ultraviolet resonance transitions. Astrophys. J., Part 1 547 , 1178 (2001)			
	$h\nu + \text{Ti}^{1+}$	Photoexcitation	6.49 eV	Ex
113.	G. M. Wahlgren, T. Brage, J. C. Brandt, J. Fleming, S. Johansson, D. S. Leckrone, C. R. Proffitt, J. Reader, C. J. Sansonetti The bismuth abundance in the HgMn stars χ Lupi and HR 7775 and improved atomic data for selected transitions of Bi I, Bi II, and Bi III. Astrophys. J., Part 1 551 , 520 (2001)			
	$h\nu + \text{Bi}^{1+}$	Photoexcitation	3.10-11.27 eV	Th
114.	S. R. Federman, J. Zsargo Atomic physics with the Goddard High Resolution Spectrograph on the Hubble Space Telescope. V. Oscillator strengths for neutral carbon lines below 1200 Å. Astrophys. J., Part 1 555 , 1020 (2001)			
	$h\nu + \text{C}$	Photoexcitation	10.33-10.78 eV	Ex
115.	J. E. Lawler, G. Bonvallet, C. Sneden Experimental radiative lifetimes, branching fractions, and oscillator strengths for La II and a new determination of the solar lanthanum abundance. Astrophys. J., Part 1 556 , 452 (2001)			
	$h\nu + \text{La}^{1+}$	Photoexcitation	2.13-4.12 eV	Ex
116.	J. E. Lawler, M. E. Wickliffe, E. A. Den Hartog, C. Sneden Improved laboratory transition parameters for Eu II and application to the solar Europium elemental and isotopic composition. Astrophys. J., Part 1 563 , 1075 (2001)			
	$h\nu + \text{Eu}^{1+}$	Photoexcitation	16.53-34.44 eV	Ex
117.	E. Biemont, P. Palmeri, P. Quinet, Z. G. Zhang, S. Svanberg Doubly ionized thorium: Laser lifetime measurements and transition probability determination of interest in cosmochronology. Astrophys. J., Part 1 567 , 1276 (2002)			
	$h\nu + \text{Th}^{2+}$	Photoexcitation	1.25-9.54 eV	Ex
118.	W. L. Wiese, G. A. Bonvallet, J. E. Lawler Laboratory measurement of the Fe II 114.4938 nanometer oscillator strength. Astrophys. J., Part 1 569 , 1032 (2002)			
	$h\nu + \text{Fe}^{1+}$	Photoexcitation	10.83 eV	Ex
119.	E. Behar, H. Netzer Inner-shell 1s-2p soft x-ray absorption lines. Astrophys. J., Part 1 570 , 165 (2002)			
	$h\nu + \text{Ne}^{1+}$	Photoexcitation	0.92-8.27 keV	Th
	$h\nu + \text{Ne}^{2+}$	Photoexcitation	0.92-8.27 keV	Th
	$h\nu + \text{Ne}^{3+}$	Photoexcitation	0.92-8.27 keV	Th
	$h\nu + \text{Ne}^{4+}$	Photoexcitation	0.92-8.27 keV	Th
	$h\nu + \text{Ne}^{5+}$	Photoexcitation	0.92-8.27 keV	Th
	$h\nu + \text{Ne}^{6+}$	Photoexcitation	0.92-8.27 keV	Th
	$h\nu + \text{Ne}^{7+}$	Photoexcitation	0.92-8.27 keV	Th
	$h\nu + \text{Mg}^{3+}$	Photoexcitation	0.92-8.27 keV	Th
	$h\nu + \text{Mg}^{4+}$	Photoexcitation	0.92-8.27 keV	Th

$h\nu + \text{Mg}^{5+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Mg}^{6+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Mg}^{7+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Mg}^{8+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Mg}^{9+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Al}^{4+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Al}^{5+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Al}^{6+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Al}^{7+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Al}^{8+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Al}^{9+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Al}^{10+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Si}^{5+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Si}^{6+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Si}^{7+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Si}^{8+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Si}^{9+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Si}^{10+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Si}^{11+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{S}^{7+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{S}^{8+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{S}^{9+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{S}^{10+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{S}^{11+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{S}^{12+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{S}^{13+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ar}^{9+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ar}^{10+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ar}^{11+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ar}^{12+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ar}^{13+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ar}^{14+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ar}^{15+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ca}^{11+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ca}^{12+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ca}^{13+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ca}^{14+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ca}^{15+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ca}^{16+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Ca}^{17+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Fe}^{17+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Fe}^{18+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Fe}^{19+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Fe}^{20+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Fe}^{21+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Fe}^{22+}$	Photoexcitation	0.92-8.27 keV	Th
$h\nu + \text{Fe}^{23+}$	Photoexcitation	0.92-8.27 keV	Th

120. S. Majumder, H. Merlitz, G. Gopakumar, B. P. Das, U. S. Mahapatra, D. Mukherjee
Accurate calculations of interstellar lines of Mg^+ using the coupled cluster approach.
 Astrophys. J., Part 1 **574**, 513 (2002)

$h\nu + \text{Mg}^{1+}$	Photoexcitation	9.92 eV	Th
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121. P. C. Lee, J. B. Nee
Detection of $\text{O}(^1\text{D})$ produced in the photodissociation of O_2 . II. Identification of the $^3\Sigma_u^-$ and $^3\Pi_u$ Rydberg states in 105-113 nm.
 J. Chem. Phys. **114**, 792 (2001)

- | | | | | |
|--|---------------------|-------------------|----------------|----|
| | $h\nu + \text{O}_2$ | Photodissociation | 10.97-11.81 eV | Ex |
|--|---------------------|-------------------|----------------|----|
122. T. Masuoka
Single- and double-photoionization cross sections of sulfur dioxide (SO_2) and ionic fragmentation of SO_2^+ and SO_2^{2+} .
J. Chem. Phys. **115**, 264 (2001)
- | | | | | |
|--|---------------------------|-----------------|-----------------|----|
| | $h\nu + \text{SO}_2^{1+}$ | Photoionization | 37.00-120.00 eV | Ex |
| | $h\nu + \text{SO}_2^{2+}$ | Photoionization | 37.00-120.00 eV | Ex |
123. A. Mocellin, K. Wiesner, F. Burmeister, O. Bjoerneholt, A. Naves de Brito
Experimental study of photoionization of ozone in the 12 to 21 eV region.
J. Chem. Phys. **115**, 5041 (2001)
- | | | | | |
|--|---------------------|-----------------|----------------|----|
| | $h\nu + \text{O}_3$ | Photoionization | 12.00-21.00 eV | Ex |
|--|---------------------|-----------------|----------------|----|
124. P. Lin, R. R. Lucchese
Theoretical studies of cross sections and photoelectron angular distributions in the valence photoionization of molecular oxygen.
J. Chem. Phys. **116**, 8863 (2002)
- | | | | | |
|--|---------------------|-----------------|----------|----|
| | $h\nu + \text{O}_2$ | Photoionization | 50.00 eV | Th |
|--|---------------------|-----------------|----------|----|
125. P. Lin, R. R. Lucchese
Total cross sections and molecular frame photoelectron angular distributions in the N 1 s photoionization of N_2 : An investigation of electron correlation effects.
J. Chem. Phys. **117**, 4348 (2002)
- | | | | | |
|--|---------------------|-----------------|------------------|----|
| | $h\nu + \text{N}_2$ | Photoionization | 410.00-450.00 eV | Th |
|--|---------------------|-----------------|------------------|----|
126. R. Wehlitz, S. B. Whitfield
Valence double photoionization of beryllium.
J. Phys. B **32**, L719 (2001)
- | | | | | |
|--|--------------------|-----------------|----------------|----|
| | $h\nu + \text{Be}$ | Photoionization | 32.00-80.00 eV | Ex |
|--|--------------------|-----------------|----------------|----|
127. E. G. Drukarev, N. B. Avdonina, R. H. Pratt
Correlation effects in the energy spectrum of fast outgoing electrons from double photoionization of helium.
J. Phys. B **34**, 1 (2001)
- | | | | | |
|--|---------------------|-----------------|----------------|----|
| | $h\nu + \text{He}$ | Photoionization | 1.00-50.00 keV | Th |
| | $nh\nu + \text{He}$ | Photoionization | 1.00-50.00 keV | Th |
128. K. Ueda, Y. Shimizu, H. Chiba, M. Kitajima, H. Tanaka, S. Fritzsche, N. M. Kabachnik
Experimental and theoretical study of the Auger cascade following $2p \rightarrow 4s$ photoexcitation in Ar.
J. Phys. B **34**, 107 (2001)
- | | | | | |
|--|--------------------|-----------------|-----------|----|
| | $h\nu + \text{Ar}$ | Photoionization | 245.00 eV | Ex |
| | $h\nu + \text{Ar}$ | Photoexcitation | 245.00 eV | Ex |
129. C. Doule, E. Hertz, L. Berguiga, R. Chaux, B. Lavorel, O. Faucher
Temporal phase control of bound-bound and bound-free two-photon transitions in NO with two time-delayed cross-polarized pulses.
J. Phys. B **34**, 1133 (2001)
- | | | | | |
|--|--------------------|-----------------|--------------|----|
| | $h\nu + \text{NO}$ | Photoionization | 2.33-2.74 eV | Ex |
|--|--------------------|-----------------|--------------|----|
130. T. K. Fang, K. T. Chung
Electric-field effects on He ground-state photoionization.
J. Phys. B **34**, 1245 (2001)
- | | | | | |
|--|--------------------|-----------------|----------------|----|
| | $h\nu + \text{He}$ | Photoionization | 65.00-72.00 eV | Th |
|--|--------------------|-----------------|----------------|----|

131. M. Martins
Photoionization of open-shell atoms: the chlorine 2p excitation.
 J. Phys. B **34**, 1321 (2001)
 $h\nu + \text{Cl}$ Photoionization 202.00-212.00 eV Th
132. K. Berrington
Oscillator strengths of Na III.
 J. Phys. B **34**, 1443 (2001)
 $h\nu + \text{Na}^{2+}$ Photoexcitation Th
133. H. Y. Wang, M. Baessler, I. Hjelte, F. Burmeister, L. Karlsson
A vibrationally resolved experimental study of the sulfur L-shell photoelectron spectrum of the CS₂ molecule.
 J. Phys. B **34**, 1745 (2001)
 $h\nu + \text{CS}_2$ Photoionization 250.00 eV Ex
 $h\nu + \text{CS}_2$ Photoexcitation 250.00 eV Ex
134. A. Kupliauskiene, N. Rakstikas, V. Tutlys
Polarization studies in the photoionization of atoms using a graphical technique.
 J. Phys. B **34**, 1783 (2001)
 $h\nu + \text{Na}$ Photoionization 40.00-140.00 eV Th
135. P. Andersen, T. Andersen, F. Folkmann, V. K. Ivanov, H. Kjeldsen, J. B. West
Absolute cross sections for the photoionization of 4d electrons in Xe⁺ and Xe²⁺ ions.
 J. Phys. B **34**, 2009 (2001)
 $h\nu + \text{Xe}^{1+}$ Photoionization 50.00-130.00 eV Ex
 $h\nu + \text{Xe}^{2+}$ Photoionization 50.00-130.00 eV Ex
136. S. Seven, K. Kocak
Angular dependence of L x-ray production cross sections in seven elements from Yb to Pt at a photon energy of 59.5 keV.
 J. Phys. B **34**, 2021 (2001)
 $h\nu + \text{Yb}$ Photoionization 59.50 keV Ex
 $h\nu + \text{Lu}$ Photoionization 59.50 keV Ex
 $h\nu + \text{Hf}$ Photoionization 59.50 keV Ex
 $h\nu + \text{Ta}$ Photoionization 59.50 keV Ex
 $h\nu + \text{W}$ Photoionization 59.50 keV Ex
 $h\nu + \text{Re}$ Photoionization 59.50 keV Ex
 $h\nu + \text{Pt}$ Photoionization 59.50 keV Ex
137. M. Ertugrul
Measurements of L_{3l}, L_{3α}, L_{3β}, L_{2β}, L_{2γ}, L_{1β}, L_{1γ}, L_β, L_γ, L_{1x}, L_{2x} and L_{3x} x-ray production cross sections and L subshell fluorescence yields for Re, W and Ta at 59.5 keV.
 J. Phys. B **34**, 2081 (2001)
 $h\nu + \text{Ta}$ Fluorescence 59.50 keV E/T
 $h\nu + \text{W}$ Fluorescence 59.50 keV E/T
 $h\nu + \text{Re}$ Fluorescence 59.50 keV E/T
138. S. S. Tayal
Photoelectron angular distributions for 2p ionization of atomic oxygen.
 J. Phys. B **34**, 2215 (2001)
 $h\nu + \text{O}$ Photoionization 50.00 eV E/T
139. J. Bauer, L. Plucinski, B. Piraux, R. M. Potvliege, M. Gajda, J. Krzywinski
Ionization of hydrogen atoms by intense vacuum ultraviolet radiation.
 J. Phys. B **34**, 2245 (2001)

	$h\nu + \text{H}$	Photoionization	17.00-50.00 eV	E/T
140.	A. Nadeem, S. A. Bhatti, N. Ahmad, M. A. Baig Two-step laser excitation of the even parity $5p_{1/2}np$ and nf $J=1,2$ Rydberg levels of neutral tin. J. Phys. B 34 , 2407 (2001)			
	$h\nu + \text{Sn}$	Photoexcitation	0.49-2.48 eV	Ex
141.	T. Grycuk, W. Behmenburg, V. Staemmler Quantum calculation of the excitation spectra of Li^*He probing interaction potentials and dipole moments. J. Phys. B 34 , 245 (2001)			
	$h\nu + \text{Li}$	Elastic Scattering	0.50-0.99 eV	Th
142.	H. Liebel, R. Mueller-Albrecht, S. Lauer, F. Vollweiler, A. Ehresmann, H. Schmoranzner Fine-structure selectivity of neutral dissociation with excitation observed in O_2. J. Phys. B 34 , 2581 (2001)			
	$h\nu + \text{O}_2$	Photoexcitation	14.60-16.20 eV	Ex
	$h\nu + \text{O}_2$	Photodissociation	14.60-16.20 eV	Ex
	$h\nu + \text{O}_2$	Fluorescence	14.60-16.20 eV	Ex
	$h\nu + \text{O}_2$	Total Absor., Scat.	14.60-16.20 eV	Ex
143.	J. J. Camacho, A. Pardo, I. P. Acin Laser-induced (5145 Å) $\text{B } ^1\Pi_u - \rightarrow ^1\Sigma_g^+$ fluorescence of Na_2. J. Phys. B 34 , 2597 (2001)			
	$h\nu + \text{Na}_2$	Fluorescence	2.41 eV	Ex
144.	D.-S. Kim Photoionization of the excited $3s3p \ ^{1,3}P^0$ states of atomic magnesium. J. Phys. B 34 , 2615 (2001)			
	$h\nu + \text{Mg}^*$	Photoionization	5.00-15.00 eV	Th
	$h\nu + \text{Mg}$	Photoionization	5.00-15.00 eV	Th
145.	K. A. Berrington, C. Ballance Inner-shell photoionization of the $3d^x$ ground state Fe ions. J. Phys. B 34 , 2697 (2001)			
	$h\nu + \text{Fe}^{2+}$	Photoionization	0.03-8.16 keV	Th
	$h\nu + \text{Fe}^{3+}$	Photoionization	0.03-8.16 keV	Th
	$h\nu + \text{Fe}^{4+}$	Photoionization	0.03-8.16 keV	Th
	$h\nu + \text{Fe}^{5+}$	Photoionization	0.03-8.16 keV	Th
	$h\nu + \text{Fe}^{6+}$	Photoionization	0.03-8.16 keV	Th
	$h\nu + \text{Fe}^{7+}$	Photoionization	0.03-8.16 keV	Th
146.	G. Pruemper, O. Gessner, B. Zimmermann, J. Viefhaus, R. Hentges, H. Kleinpoppen, U. Becker Absorption of circularly polarized VUV radiation in polarized iron vapour. J. Phys. B 34 , 2707 (2001)			
	$h\nu + \text{Fe}$	Total Absor., Scat.	10.00-230.00 eV	Ex
147.	J. Zeng, J. Yuan, Q. Lu Photoionization of O III low-lying states: autoionization resonance energies and widths of some $1s-2p$ excited states. J. Phys. B 34 , 2823 (2001)			
	$h\nu + \text{O}^{2+}$	Photoionization	39.00 eV	Th

148. A. Ehresmann, H. Liebel, M. von Kroeger, H. Schmoranzner
Dissociation of NO b $^3\Pi_{0,1,2}$ np λ $^2\Lambda$ ($v=0$) Rydberg states into O(4S)3s 3S_1) + N($^4S_{3/2}$) fragments: rotational band shapes of vibronic peaks seen in fluorescence.
J. Phys. B **34**, 2893 (2001)
 $h\nu + \text{NO}$ Photodissociation 16.27 eV Ex
149. W. A. Schroeder, T. R. Nelson, A. B. Borisov, J. W. Longworth, K. Boyer, C. K. Rhodes
An efficient, selective collisional ejection mechanism for inner-shell population inversion in laser-driven plasmas.
J. Phys. B **34**, 297 (2001)
 $h\nu + \text{Xe}$ Photoionization 1.55-5.00 eV Th
150. D.-S. Guo, R. R. Freeman, L. Gao, X. Li, P. Fu, T. Edis, A. Troha
Spin-other-orbit effect of photon modes.
J. Phys. B **34**, 2983 (2001)
 $h\nu + \text{Xe}$ Photoionization 4.66 eV Th
151. A. Ehresmann, H. Liebel, M. von Kroeger, H. Schmoranzner
Final-state selectively observed autoionization and predissociation processes in NO for $E_{ex} = 16.9\text{-}19.6$ eV.
J. Phys. B **34**, 3119 (2001)
 $h\nu + \text{NO}$ Photoionization 16.90-19.60 eV Ex
 $h\nu + \text{NO}$ Photodissociation 16.90-19.60 eV Ex
 $h\nu + \text{NO}$ Photoexcitation 16.90-19.60 eV Ex
152. G. Duffy, P. van Kampen, P. Dunne
4d -j 5p transitions in the extreme ultraviolet photoabsorption spectra of Sn II and Sn III.
J. Phys. B **34**, 3171 (2001)
 $h\nu + \text{Sn}^{1+}$ Total Absor., Scat. 23.00-33.00 eV Ex
 $h\nu + \text{Sn}^{2+}$ Total Absor., Scat. 23.00-33.00 eV Ex
153. P. Bolognesi, R. Camilloni, M. Coreno, G. Turri, J. Berakdar, A. S. Kheifets, L. Avaldi
Complementary TDCS for the photo-double ionization of He at 40 eV above the threshold in unequal energy-sharing conditions.
J. Phys. B **34**, 3193 (2001)
 $h\nu + \text{He}$ Photoionization 94.40 eV Ex
154. M. B. Trzhaskovskaya, V. K. Nikulin, V. I. Nefedov, V. G. Yarzhevsky
Relativistic photoelectron angular distribution parameters in the quadrupole approximation.
J. Phys. B **34**, 3221 (2001)
 $h\nu + \text{Kr}$ Photoionization 0.01-10.00 keV Th
 $h\nu + \text{Xe}$ Photoionization 0.01-10.00 keV Th
 $h\nu + \text{Pu}$ Photoionization 0.01-10.00 keV Th
155. C. P. Ballance, N. R. Badnell, K. A. Berrington
Inner-shell processes of Li- and Be-like Fe.
J. Phys. B **34**, 3287 (2001)
 $h\nu + \text{Fe}^{22+}$ Photoionization 138.00-800.00 Ry Th
 $h\nu + \text{Fe}^{23+}$ Photoionization 138.00-800.00 Ry Th
156. A. Kupliauskiene
On the application of relaxed-orbital and sudden perturbation approximations for the photoionization of atoms.
J. Phys. B **34**, 345 (2001)

$h\nu + \text{He}$	Photoionization	20.00-300.00 eV	Th
$h\nu + \text{Li}$	Photoionization	20.00-300.00 eV	Th
$h\nu + \text{Na}$	Photoionization	20.00-300.00 eV	Th
$h\nu + \text{K}$	Photoionization	20.00-300.00 eV	Th

157. S. F. Itza-Ortiz, A. L. Godunov, J. Wang, J. H. McGuire

Ionization-excitation of H^- and He by Compton scattering.

J. Phys. B **34**, 3477 (2001)

$h\nu + \text{H}^{-1+}$	Photoexcitation	6.00-60.00 keV	Th
$h\nu + \text{He}$	Photoexcitation	6.00-60.00 keV	Th
$h\nu + \text{H}^{-1+}$	Photoionization	6.00-60.00 keV	Th
$h\nu + \text{He}$	Photoionization	6.00-60.00 keV	Th
$h\nu + \text{H}^{-1+}$	Photodetachment	6.00-60.00 keV	Th
$h\nu + \text{He}$	Photodetachment	6.00-60.00 keV	Th

158. Y. Itoh, A. Ito, M. Kitajima, T. Koizumi, T. M. Kojima, H. Sakai, M. Sano, N. Watanabe

Absolute photoionization cross section measurements of Xe^+ ions in the 4d threshold energy region.

J. Phys. B **34**, 3493 (2001)

$h\nu + \text{Xe}^{1+}$	Photoionization	80.00-140.00 eV	Ex
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159. A. Kumar, J. S. Shahi, M. L. Garg, S. Puri, D. Mehta, N. Singh

Inelastic scattering of 88.03 keV photons by elements with $4 \leq Z \leq 83$.

J. Phys. B **34**, 3555 (2001)

$h\nu + \text{He}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Be}$	Photoionization	88.00 eV	E/T
$h\nu + \text{C}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Mg}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Al}$	Photoionization	88.00 eV	E/T
$h\nu + \text{S}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Ti}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Fe}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Cu}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Zn}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Se}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Y}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Mo}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Ag}$	Photoionization	88.00 eV	E/T
$h\nu + \text{In}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Sn}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Te}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Gd}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Dy}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Tm}$	Photoionization	88.00 eV	E/T
$h\nu + \text{Bi}$	Photoionization	88.00 eV	E/T
$h\nu + \text{He}$	Photoexcitation	88.00 eV	E/T
$h\nu + \text{Be}$	Photoexcitation	88.00 eV	E/T
$h\nu + \text{C}$	Photoexcitation	88.00 eV	E/T
$h\nu + \text{Mg}$	Photoexcitation	88.00 eV	E/T
$h\nu + \text{Al}$	Photoexcitation	88.00 eV	E/T
$h\nu + \text{S}$	Photoexcitation	88.00 eV	E/T
$h\nu + \text{Ti}$	Photoexcitation	88.00 eV	E/T
$h\nu + \text{Fe}$	Photoexcitation	88.00 eV	E/T
$h\nu + \text{Cu}$	Photoexcitation	88.00 eV	E/T
$h\nu + \text{Zn}$	Photoexcitation	88.00 eV	E/T
$h\nu + \text{Se}$	Photoexcitation	88.00 eV	E/T

- | | | | |
|--------------------|-----------------|----------|-----|
| $h\nu + \text{Y}$ | Photoexcitation | 88.00 eV | E/T |
| $h\nu + \text{Mo}$ | Photoexcitation | 88.00 eV | E/T |
| $h\nu + \text{Ag}$ | Photoexcitation | 88.00 eV | E/T |
| $h\nu + \text{In}$ | Photoexcitation | 88.00 eV | E/T |
| $h\nu + \text{Sn}$ | Photoexcitation | 88.00 eV | E/T |
| $h\nu + \text{Te}$ | Photoexcitation | 88.00 eV | E/T |
| $h\nu + \text{Gd}$ | Photoexcitation | 88.00 eV | E/T |
| $h\nu + \text{Dy}$ | Photoexcitation | 88.00 eV | E/T |
| $h\nu + \text{Tm}$ | Photoexcitation | 88.00 eV | E/T |
| $h\nu + \text{Bi}$ | Photoexcitation | 88.00 eV | E/T |
160. Th. Weber, O. Jagutzki, M. Hattass, A. Staudte, A. Nauert, L. Schmidt, M. H. Prior, A. L. Landers, A. Braeuning-Demian, H. Braeuning, C. L. Cocke, T. Osipov, I. Ali, R. Diez Muino, D. Rolles, F. J. Garcia de Abajo, C. S. Fadley, M. A. Van Hove, A. Cassimi, H. Schmidt-Boecking, R. Doerner
K-shell photoionization of CO and N₂: Is there a link between the photoelectron angular distribution and the molecular decay dynamics?
J. Phys. B **34**, 3669 (2001)
- | | | | |
|---------------------|-------------------|------------------|----|
| $h\nu + \text{CO}$ | Photodissociation | 306.40-419.30 eV | Ex |
| $h\nu + \text{N}_2$ | Photodissociation | 306.40-419.30 eV | Ex |
| $h\nu + \text{CO}$ | Photoionization | 306.40-419.30 eV | Ex |
| $h\nu + \text{N}_2$ | Photoionization | 306.40-419.30 eV | Ex |
161. T. Mercouris, C. Haritos, A. Nicolaides
Theory and computation of the rate of multiphoton two-electron ionization via the direct mechanism.
J. Phys. B **34**, 3789 (2001)
- | | | | |
|---------------------------|-----------------|----------------|----|
| $h\nu + \text{H}^{-1+}$ | Photoionization | 4.00-180.00 eV | Th |
| $h\nu + \text{He}^{-1+}$ | Photoionization | 4.00-180.00 eV | Th |
| $nh\nu + \text{H}^{-1+}$ | Photoionization | 4.00-180.00 eV | Th |
| $nh\nu + \text{He}^{-1+}$ | Photoionization | 4.00-180.00 eV | Th |
162. M. Kitajima, M. Okamoto, Y. Shimizu, H. Chiba, S. Fritzsche, N. M. Kabachnik, I. P. Sazhina, F. Koike, T. Hayaishi, H. Tanaka, Y. Sato, K. Ueda
Experimental and theoretical study of the Auger cascade following 3d - ζ 5p photoexcitation in Kr.
J. Phys. B **34**, 3829 (2001)
- | | | | |
|--------------------|-----------------|--|-----|
| $h\nu + \text{Kr}$ | Photoionization | | E/T |
|--------------------|-----------------|--|-----|
163. V. A. Kilin, D. A. Lazarev, Dm. A. Lazarev, V. M. Zelichenko, M. Ya. Amusia, K.-H. Schartner, A. Ehresmann, H. Schmoranzner
Test of a q-fractional $V^{(N-q)}$ Hartree-Fock potential for the calculation of double photoionization cross sections of neon.
J. Phys. B **34**, 3993 (2001)
- | | | | |
|---------------------|-----------------|-----------------|----|
| $h\nu + \text{Ne}$ | Photoionization | 60.00-330.00 eV | Th |
| $2h\nu + \text{Ne}$ | Photoionization | 60.00-330.00 eV | Th |
164. J. B. West, H. Kjeldsen, F. Folkmann, T. Andersen
Photoionization of doubly-charged Ca ions.
J. Phys. B **34**, 4035 (2001)
- | | | | |
|-------------------------|-----------------|----------------|----|
| $h\nu + \text{Ca}^{2+}$ | Photoionization | 50.00-70.00 eV | Ex |
|-------------------------|-----------------|----------------|----|
165. R. Kundliya, K. Batra, M. Mohan
Multiphoton ionization of atoms using the pseudostate summation technique.
J. Phys. B **34**, 4083 (2001)
- | | | | |
|-------------------|-----------------|--------------|----|
| $h\nu + \text{H}$ | Photoionization | 1.13-6.53 eV | Th |
|-------------------|-----------------|--------------|----|

166. J. B. West, K. J. Ross, H.-J. Beyer, A. De Fanis, H. Hamdy
Triple differential cross section measurements for resonant double photoionization of Sr.
 J. Phys. B **34**, 4167 (2001)
 $h\nu + \text{Sr}$ Photoionization 25.14-25.26 eV Ex
167. H. van der Heijden, J. van der Mullen
Semiclassical and quantum-mechanical descriptions of S₂ molecular radiation.
 J. Phys. B **34**, 4183 (2001)
 $h\nu + \text{S}_2$ Total Absor., Scat. 0.00-6.00 K Th
168. B. Schmidtke, T. Khalil, M. Drescher, N. Mueller, N. M. Kabachnik, U. Heinzmann
The Kr M_{4,5}N₁N_{2,3} ¹P₁ Auger decay: measurement of the transferred spin polarization and analysis of Auger amplitudes.
 J. Phys. B **34**, 4293 (2001)
 $h\nu + \text{Kr}$ Photoionization 90.00-190.00 eV Ex
169. H. Wang, R. F. Fink, M. N. Piancastelli, I. Hjelte, K. Wiesner, M. Bassler, R. Feifel, O. Bjorneholm, C. Miron, A. Giertz, F. Burmeister, S. L. Sorensen, S. Svensson
Filtering core excitation spectra: vibrationally resolved constant ionic state studies of N 1s - $\frac{1}{2}$ 2 π core-excited NO.
 J. Phys. B **34**, 4417 (2001)
 $h\nu + \text{NO}$ Photoexcitation 399.00-401.00 eV Ex
170. K. Kim, M. Kwon, H. D. Park, H. S. Moon, H. S. Rawat, K. An, J. B. Kim
Electromagnetically induced absorption spectra depending on intensities and detunings of the coupling field in Cs vapour.
 J. Phys. B **34**, 4801 (2001)
 $h\nu + \text{Cs}$ Photoionization 1.46 eV E/T
171. S. A. Novikov, A. N. Hopersky
Two-photon excitation-ionization of the 1s shell of highly charged positive atomic ions.
 J. Phys. B **34**, 4857 (2001)
 $h\nu + \text{Ne}$ Photoionization 7.00-300.00 eV Th
 $h\nu + \text{Ne}^{6+}$ Photoionization 7.00-300.00 eV Th
 $h\nu + \text{Ne}^{8+}$ Photoionization 7.00-300.00 eV Th
 $nh\nu + \text{Ne}$ Photoionization 7.00-300.00 eV Th
 $nh\nu + \text{Ne}^{6+}$ Photoionization 7.00-300.00 eV Th
 $nh\nu + \text{Ne}^{8+}$ Photoionization 7.00-300.00 eV Th
 $h\nu + \text{Ne}$ Photoexcitation 7.00-300.00 eV Th
 $h\nu + \text{Ne}^{6+}$ Photoexcitation 7.00-300.00 eV Th
 $h\nu + \text{Ne}^{8+}$ Photoexcitation 7.00-300.00 eV Th
 $nh\nu + \text{Ne}$ Photoexcitation 7.00-300.00 eV Th
 $nh\nu + \text{Ne}^{6+}$ Photoexcitation 7.00-300.00 eV Th
 $nh\nu + \text{Ne}^{8+}$ Photoexcitation 7.00-300.00 eV Th
172. A. Pohl, P.-G. Reinhard, E. Surraud
Influence of intermediate states on photoelectron spectra.
 J. Phys. B **34**, 4969 (2001)
 $h\nu + \text{Na}_9^{1+}$ Photoionization 5.00 eV Ex
173. S. Barsanti, P. Bicchi
Energy-pooling ionization (EPI) in Ga vapour: electronic detection and cross section measurement.
 J. Phys. B **34**, 5031 (2001)
 $h\nu + \text{Ga}$ Photoionization 3.07 eV Ex

174. L.A.A Nikolopoulos, P. Lambropoulos
Multichannel theory of two-photon single and double ionization of helium.
 J. Phys. B **34**, 545 (2001)
- | | | | |
|---------------------|-----------------|-----------------|----|
| $h\nu + \text{He}$ | Photoionization | 12.75-150.00 eV | Th |
| $2h\nu + \text{He}$ | Photoionization | 12.75-150.00 eV | Th |
175. A. Kumar, S. Puri, J. S. Shahi, M. L. Garg, D. Mehta, N. Singh
L x-ray production cross sections in Th and U at 17.8, 25.8 and 46.9 keV photon energies.
 J. Phys. B **34**, 613 (2001)
- | | | | |
|--------------------|-----------------|-----------------|----|
| $h\nu + \text{Th}$ | Photoionization | 17.80-46.90 keV | Ex |
| $h\nu + \text{U}$ | Photoionization | 17.80-46.90 keV | Ex |
176. A. P. Jayadevan, R. B. Thayyullathil
Two-photon ionization of atomic hydrogen above the one-photon ionization threshold.
 J. Phys. B **34**, 699 (2001)
- | | | | |
|--------------------|-----------------|-----------------|----|
| $h\nu + \text{H}$ | Photoionization | 13.78-619.90 eV | Th |
| $2h\nu + \text{H}$ | Photoionization | 13.78-619.90 eV | Th |
177. F. B. Yousif, C. Cisneros, J. de Urquijo, I. Alvarez
One-photon excitation and dissociation of both weakly bound rotational excited states and vibrational excited states of HD_2^+ and photofragment branching ratio D^+/H^+ of the final predissociative states.
 J. Phys. B **34**, 725 (2001)
- | | | | |
|---------------------------|-------------------|---------|-----|
| $h\nu + \text{H}_2^{1+}$ | Photodissociation | 1.17 eV | E/T |
| $h\nu + \text{H}_2^{1+}$ | Photoexcitation | 1.17 eV | E/T |
| $h\nu + \text{HD}_2^{1+}$ | Photodissociation | 1.17 eV | E/T |
| $h\nu + \text{HD}_2^{1+}$ | Photoexcitation | 1.17 eV | E/T |
178. G. Duffy, P. Dunne
The photoabsorption spectrum of an indium laser produced plasma.
 J. Phys. B **34**, L173 (2001)
- | | | | |
|-------------------------|---------------------|----------------|----|
| $h\nu + \text{In}^{1+}$ | Total Absor., Scat. | 18.00-33.00 eV | Ex |
|-------------------------|---------------------|----------------|----|
179. N. A. Cherepkov, S. K. Semenov
Non-dipole effects in spin polarization of photoelectrons from Xe 4p and 5p shells.
 J. Phys. B **34**, L211 (2001)
- | | | | |
|----------------------|-----------------|-----------------|----|
| $h\nu + \text{Xe}^*$ | Photoionization | 10.00-400.00 eV | Th |
| $h\nu + \text{Xe}$ | Photoionization | 10.00-400.00 eV | Th |
180. M. Terao-Dunseath, K. M. Dunseath, D. Charlo, A. Hibbert, R. J. Allan
Electron-helium scattering in a Nd-YAG laser field at collision energies near the $\text{He}(1s2l)$ thresholds.
 J. Phys. B **34**, L263 (2001)
- | | | | |
|--------------------|-----------------|----------------|----|
| $h\nu + \text{He}$ | Photoexcitation | 0.65-0.78 a.u. | Th |
|--------------------|-----------------|----------------|----|
181. C. Blondel, C. Delsart, F. Goldfarb
Electron spectrometry at the μ eV level and the electron affinities of Si and F.
 J. Phys. B **34**, L281 (2001)
- | | | | |
|--------------------------|-----------------|--------------|----|
| $h\nu + \text{F}^{-1+}$ | Photodetachment | 1.39-6.81 eV | Ex |
| $h\nu + \text{Si}^{-1+}$ | Photodetachment | 1.39-6.81 eV | Ex |
182. M. Brewczyk, K. Rzazewski
Interaction of a multi-electron atom with intense radiation in the VUV range: beyond the conventional model for high harmonic generation.
 J. Phys. B **34**, L289 (2001)

- | | | | | |
|--|--------------------|-----------------|----------|----|
| | $h\nu + \text{Cl}$ | Photoexcitation | 27.00 eV | Th |
|--|--------------------|-----------------|----------|----|
183. T. Andersen, H. Kjeldsen, H. Knudsen, F. Folkmann
Absolute cross section for photoionization of CO^+ leading to longlived metastable CO^{2+} .
J. Phys. B **34**, L327 (2001)
- | | | | | |
|--|-------------------------|-----------------|----------------|----|
| | $h\nu + \text{CO}^{1+}$ | Photoionization | 27.30-50.00 eV | Ex |
|--|-------------------------|-----------------|----------------|----|
184. H. Kjeldsen, P. Andersen, F. Folkmann, B. Kristensen, T. Andersen
Inner-shell photodetachment of Li^- .
J. Phys. B **34**, L353 (2001)
- | | | | | |
|--|--------------------------|-----------------|----------------|----|
| | $h\nu + \text{Li}^{-1+}$ | Photoionization | 56.00-70.00 eV | Ex |
| | $h\nu + \text{Li}^{-1+}$ | Photodetachment | 56.00-70.00 eV | Ex |
185. A. De Fanis, N. Saito, M. Kitajima, Y. Shimizu, K. Okada, H. Tanaka, I. Koyano, K. Ueda
High resolution measurement for the resonant Auger emission of Xe following $3d_{5/2} \rightarrow 6p$ excitation.
J. Phys. B **34**, L377 (2001)
- | | | | | |
|--|--------------------|-----------------|-----------|-----|
| | $h\nu + \text{Xe}$ | Photoionization | 672.00 eV | E/T |
| | $h\nu + \text{Xe}$ | Photoexcitation | 672.00 eV | E/T |
186. K. A. Berrington, C. Ballance
Double ionization yields from the photoionization of Fe II and Fe I.
J. Phys. B **34**, L383 (2001)
- | | | | | |
|--|-------------------------|-----------------|---------|----|
| | $h\nu + \text{Fe}$ | Photoionization | 6.00 Ry | Ex |
| | $h\nu + \text{Fe}^{1+}$ | Photoionization | 6.00 Ry | Ex |
187. M. Weckenbrock, M. Hattass, A. Czasch, O. Jagutzki, L. Schmidt, T. Weber, H. Roskos, T. Loeffler, M. Thomson, R. Doerner
Experimental evidence for electron repulsion in multiphoton double ionization.
J. Phys. B **34**, L449 (2001)
- | | | | | |
|--|---------------------|-----------------|------------------------|----|
| | $h\nu + \text{Ar}$ | Photoionization | 4.70 W/cm ² | Ex |
| | $2h\nu + \text{Ar}$ | Photoionization | 4.70 W/cm ² | Ex |
188. J. Colgan, M. S. Pindzola, F. Robicheaux
Fully quantal ($\gamma, 2e$) calculations for absolute differential cross sections of helium.
J. Phys. B **34**, L457 (2001)
- | | | | | |
|--|--------------------|-----------------|----------|----|
| | $h\nu + \text{He}$ | Photoionization | 74.40 eV | Th |
|--|--------------------|-----------------|----------|----|
189. C. Dawson, S. Cvejanovic, D. P. Secombe, T. J. Reddish, F. Maulbetsch, A. Heutz, J. Mazeau, A. S. Keifets
Helium ($\gamma, 2e$) triple differential cross sections at an excess energy of 60 eV.
J. Phys. B **34**, L525 (2001)
- | | | | | |
|--|--------------------|-----------------|-----------|----|
| | $h\nu + \text{He}$ | Photoionization | 139.00 eV | Ex |
|--|--------------------|-----------------|-----------|----|
190. H. W. Van der Hart, L. Feng
Double photoionization of excited He-like atoms.
J. Phys. B **34**, L601 (2001)
- | | | | | |
|--|-------------------------|-----------------|-----------------|----|
| | $h\nu + \text{He}$ | Photoionization | 60.00-200.00 eV | Th |
| | $h\nu + \text{Li}^{2+}$ | Photoionization | 60.00-200.00 eV | Th |
| | $h\nu + \text{Be}^{2+}$ | Photoionization | 60.00-200.00 eV | Th |
| | $h\nu + \text{C}^{4+}$ | Photoionization | 60.00-200.00 eV | Th |
| | $h\nu + \text{O}^{6+}$ | Photoionization | 60.00-200.00 eV | Th |
191. A. Neogi, E. T. Kennedy, J.-P. Mosnier, P. van Kampen, J. T. Costello, C. McGuinness, G. O'Sullivan
Vacuum-ultraviolet absorption spectrum of the Rb^+ ion in a laser-generated plasma.
J. Phys. B **34**, L651 (2001)

	$h\nu + \text{Rb}^{1+}$	Total Absor., Scat.	100.00-140.00 eV	Ex
192.	B. Obst, T. Richter, M. Martins, U. Zimmermann Photoionization of atomic scandium in the region of the 2p resonances. J. Phys. B 34 , L657 (2001)			
	$h\nu + \text{Sc}$	Photoionization	351.00-410.00 eV	Ex
193.	V. K. Ivanov, G. Yu Kashenock, R. G. Polozkov, A. V. Solov'yov Photoionization cross sections of the fullerenes C₂₀ and C₆₀ calculated in a simple spherical model. J. Phys. B 34 , L669 (2001)			
	$h\nu + \text{C}_{60}$	Photoionization	7.00-50.00 eV	Th
	$h\nu + \text{C}_{20}$	Photoionization	7.00-50.00 eV	Th
194.	J. S. Parker, L. R. Moore, K. J. Meharg, D. Dundas, K. T. Taylor Double-electron above threshold ionization of helium. J. Phys. B 34 , L69 (2001)			
	$h\nu + \text{He}$	Photoionization	0.50-2x10 ¹⁶ W/cm ²	Th
195.	J. Jimenez-Mier, S. B. Whitfield, R. Wehlitz, H. Diaz-Jimenez Core polarization effects in the decay of 1s -i np (n=2-6) resonantly excited beryllium. J. Phys. B 34 , L693 (2001)			
	$h\nu + \text{Be}$	Photodissociation	115.49-123.16 eV	Ex
	$h\nu + \text{Be}$	Photoexcitation	115.49-123.16 eV	Ex
196.	A. M. Covington, A. Aguilar, V. T. Davis, I. Alvarez, H. C. Bryant, C. Cisneros, M. Halka, D. Hanstorp, G. Hinojosa, A. S. Schlachter, J. S. Thompson, D. J. Pegg Correlated processes in inner-shell photodetachment of the Na⁻ ion. J. Phys. B 34 , L735 (2001)			
	$h\nu + \text{Na}^{-1+}$	Photodetachment	30.00-51.00 eV	Ex
197.	L. Veseth Computed photoionization cross sections of CO⁺. J. Phys. B 34 , L773 (2001)			
	$h\nu + \text{CO}^{1+}$	Photoionization	25.00-50.00 eV	Th
198.	E. Cormier, D. Garzella, P. Breger, P. Agostini, G. Cheriaux, C. LeBlanc Above-threshold ionization contrast and channel closure in argon. J. Phys. B 34 , L9 (2001)			
	$h\nu + \text{Ar}$	Photoionization		Th
	$nh\nu + \text{Ar}$	Photoionization		Th
199.	A. De Fanis, H.-J. Beyer, K. J. Ross, J. B. West Dipole matrix elements for 4p photoionization of Sr. J. Phys. B 34 , L99 (2001)			
	$h\nu + \text{Sr}$	Photoionization	34.00-42.00 eV	Ex
200.	J. B. West Photoionization of atomic ions. J. Phys. B 34 , R45 (2001)			
	$h\nu + \text{C}^{1+}$	Photon Collisions	15.00 eV	Th
	$h\nu + \text{O}^{1+}$	Photon Collisions	15.00 eV	Th
	$h\nu + \text{Na}^{1+}$	Photon Collisions	15.00 eV	Th
	$h\nu + \text{Mg}^{1+}$	Photon Collisions	15.00 eV	Th
	$h\nu + \text{Mg}^{2+}$	Photon Collisions	15.00 eV	Th

$h\nu + \text{Al}^{1+}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Al}^{2+}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Al}^{3+}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Si}^{4+}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Ar}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{K}^{1+}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Ca}^{2+}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Mn}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Mn}^{1+}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{I}^{2+}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Xe}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Xe}^{1+}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Xe}^{2+}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Ba}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Ba}^{1+}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{Ba}^{2+}$	Photon Collisions	15.00 eV	Th
$h\nu + \text{C}^{1+}$	Photoionization	15.00 eV	Th
$h\nu + \text{O}^{1+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Na}^{1+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Mg}^{1+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Mg}^{2+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Al}^{1+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Al}^{2+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Al}^{3+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Si}^{4+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Ar}$	Photoionization	15.00 eV	Th
$h\nu + \text{K}^{1+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Ca}^{2+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Mn}$	Photoionization	15.00 eV	Th
$h\nu + \text{Mn}^{1+}$	Photoionization	15.00 eV	Th
$h\nu + \text{I}^{2+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Xe}$	Photoionization	15.00 eV	Th
$h\nu + \text{Xe}^{1+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Xe}^{2+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Ba}$	Photoionization	15.00 eV	Th
$h\nu + \text{Ba}^{1+}$	Photoionization	15.00 eV	Th
$h\nu + \text{Ba}^{2+}$	Photoionization	15.00 eV	Th

201. R. A. Mackie, A. M. Sands, S.W.J. Scully, D.M.P Holland, D. A. Shaw, K. F. Dunn, C. J. Latimer
The molecular and dissociative photoionization of ethane in the inner and outer valence energy regions.
J. Phys. B **35**, 1061 (2002)

$h\nu + \text{C}_2\text{H}_6$	Photoionization	11.00-40.00 eV	Ex
$h\nu + \text{C}_2\text{H}_6$	Photodissociation	11.00-40.00 eV	Ex

202. H. Nilsson, S. Ivarsson, S. Johansson, H. Lundberg
Experimental oscillator strengths in U II of cosmological interest.
J. Phys. B **35**, 1090 (2002)

$h\nu + \text{U}^{1+}$	Photoexcitation	1.85-3.54 eV	E/T
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203. H. W. Van der Hart, L. Feng
Multiphoton ionization processes in Ar⁷⁺.
J. Phys. B **35**, 1185 (2002)

$h\nu + \text{Ar}^{7+}$	Photoionization	47.50-67.50 eV	Th
$nh\nu + \text{Ar}^{7+}$	Photoionization	47.50-67.50 eV	Th

204. D. Toffoli, M. Stener, P. Decleva
Application of the relativistic time-dependent density functional theory to the photoionization of xenon.
 J. Phys. B **35**, 1275 (2002)
 $h\nu + \text{Xe}$ Photoionization 400.00 eV E/T
205. A. Neogi, M. Martins, C. McGuinness, G. O'Sullivan, E. T. Kennedy, J.-P. Mosnier, P. van Kampen, J. T. Costello
Vacuum-ultraviolet absorption spectrum of the Rb^{2+} ion in a laser generated plasma.
 J. Phys. B **35**, 1329 (2002)
 $h\nu + \text{Rb}^{2+}$ Total Absor., Scat. 110.00-150.00 eV E/T
206. M. Stener, G. Fronzoni, D. Toffoli, P. Colavita, S. Furlan, P. Decleva
Valence and core photoemission in M@C_{60} ($\text{M} = \text{Be}, \text{Mg}, \text{Ca}$).
 J. Phys. B **35**, 1421 (2002)
 $h\nu + \text{Be}$ Photoionization 160.00 eV Th
 $h\nu + \text{Mg}$ Photoionization 160.00 eV Th
 $h\nu + \text{Ca}$ Photoionization 160.00 eV Th
 $h\nu + \text{C}_{60}(\text{Be})$ Photoionization 160.00 eV Th
 $h\nu + \text{C}_{60}(\text{Mg})$ Photoionization 160.00 eV Th
 $h\nu + \text{C}_{60}(\text{Ca})$ Photoionization 160.00 eV Th
207. A. Zawadzka, R. S. Dygdala, A. Raczyński, J. Zaremba, J. Kobus
Three-photon resonances due to autoionizing states in calcium.
 J. Phys. B **35**, 1801 (2002)
 $h\nu + \text{Ca}$ Photoionization $10^7 - 10^8 \text{ W/cm}^2$ E/T
 $3h\nu + \text{Ca}$ Photoionization $10^7 - 10^8 \text{ W/cm}^2$ E/T
208. A. Apalategui, A. Saenz
Multiphoton ionization of the hydrogen molecule H_2 .
 J. Phys. B **35**, 1909 (2002)
 $h\nu + \text{H}_2$ Photoionization Th
 $2h\nu + \text{H}_2$ Photoionization Th
 $3h\nu + \text{H}_2$ Photoionization Th
 $4h\nu + \text{H}_2$ Photoionization Th
209. D. N. Madsen, J. W. Thomsen
Measurement of absolute photo-ionization cross sections using magnesium magneto-optical traps.
 J. Phys. B **35**, 2173 (2002)
 $h\nu + \text{Mg}$ Photoionization 4.35 eV Ex
210. R. Zinkstok, E. J. van Duijn, S. Witte, W. Hogervorst
Hyperfine structure and isotope shift of transitions in Yb I using UV and deep-UV cw laser light and the angular distribution of fluorescence radiation.
 J. Phys. B **35**, 2693 (2002)
 $h\nu + \text{Yb}$ Fluorescence 3.11 eV Ex
211. S.W.J. Scully, R. A. Mackie, R. Browning, K. F. Dunn, C. J. Latimer
Negative photoion spectroscopy of SF_6 in the inner valence and S 2p energy regions.
 J. Phys. B **35**, 2703 (2002)
 $h\nu + \text{SF}_6$ Photoionization 20.00-205.00 eV Ex
 $h\nu + \text{SF}_6$ Photodissociation 20.00-205.00 eV Ex

212. Y. Tamenori, K. Okada, S. Nagaoka, T. Ibuki, S. Tanimoto, Y. Shimizu, A. Fujii, Y. Haga, H. Yoshida, H. Ohashi, I. H. Suzuki
A study of multi-charged Xe ions formed through 3d hole states using a coincidence technique.
 J. Phys. B **35**, 2799 (2002)
 $h\nu + \text{Xe}$ Photoionization 700.00-800.00 eV Ex
213. M. Forre, D. Fregenal, J. C. Day, T. Ehrenreich, J.-P. Hansen, B. Henningsen, E. Horsdal-Pedersen, L. Nyvang, O. E. Povlsen, K. Taulbjerg, I. Vogelius
Dynamics of a single Rydberg shell in time dependent external fields.
 J. Phys. B **35**, 410 (2002)
 $h\nu + \text{Li}$ Photoexcitation Ex
214. N. M. Cann, A. J. Thakkar
Quadrupole oscillator strengths for the helium isoelectronic sequence: $n\ ^1\text{S}-m\ ^1\text{D}$, $^3\text{S}-m\ ^3\text{D}$, $n\ ^1\text{P}-m\ ^1\text{P}$, and $n\ ^3\text{P}-m\ ^3\text{P}$ transitions with $n \leq 7$ and $m \leq 7$.
 J. Phys. B **35**, 421 (2002)
 $h\nu + \text{He}$ Photoexcitation Th
215. H. Bachau
Multiphoton ionization of one-electron diatomic molecules: the discretization approach for the two-centre problem.
 J. Phys. B **35**, 509 (2002)
 $h\nu + \text{H}_2^{1+}$ Photoionization 4.08-5.44 eV Th
216. M. Ertugrul, O. Simsek
Measurement of $\text{K}\beta\ 2'/\text{K}\beta\ 1'$ and $\text{K}\beta\ 2'/\text{K}\alpha\ 1$ relative intensities with ^{57}Co for heavy elements.
 J. Phys. B **35**, 601 (2002)

$h\nu + \text{Tm}$	Photoionization	5.96 keV	Ex
$h\nu + \text{Yb}$	Photoionization	5.96 keV	Ex
$h\nu + \text{Lu}$	Photoionization	5.96 keV	Ex
$h\nu + \text{Ta}$	Photoionization	5.96 keV	Ex
$h\nu + \text{W}$	Photoionization	5.96 keV	Ex
$h\nu + \text{Re}$	Photoionization	5.96 keV	Ex
$h\nu + \text{Au}$	Photoionization	5.96 keV	Ex
$h\nu + \text{Hg}$	Photoionization	5.96 keV	Ex
$h\nu + \text{Tl}$	Photoionization	5.96 keV	Ex
$h\nu + \text{Pb}$	Photoionization	5.96 keV	Ex
$h\nu + \text{Th}$	Photoionization	5.96 keV	Ex
$h\nu + \text{U}$	Photoionization	5.96 keV	Ex
$h\nu + \text{Bi}$	Photoionization	5.96 keV	Ex
$h\nu + \text{Tm}$	Photoexcitation	5.96 keV	Ex
$h\nu + \text{Yb}$	Photoexcitation	5.96 keV	Ex
$h\nu + \text{Lu}$	Photoexcitation	5.96 keV	Ex
$h\nu + \text{Ta}$	Photoexcitation	5.96 keV	Ex
$h\nu + \text{W}$	Photoexcitation	5.96 keV	Ex
$h\nu + \text{Re}$	Photoexcitation	5.96 keV	Ex
$h\nu + \text{Au}$	Photoexcitation	5.96 keV	Ex
$h\nu + \text{Hg}$	Photoexcitation	5.96 keV	Ex
$h\nu + \text{Tl}$	Photoexcitation	5.96 keV	Ex
$h\nu + \text{Pb}$	Photoexcitation	5.96 keV	Ex
$h\nu + \text{Th}$	Photoexcitation	5.96 keV	Ex
$h\nu + \text{U}$	Photoexcitation	5.96 keV	Ex
$h\nu + \text{Bi}$	Photoexcitation	5.96 keV	Ex

217. K. J. Mendham, J.W.G. Tisch, M. B. Mason, N. Hay, R. A. Smith, J. P. Marangos
Multi-keV proton energies from exploding hydrogen clusters.
 J. Phys. B **35**, 663 (2002)
 $h\nu + \text{H}_2$ Photodissociation $6 \times 10^{16} \text{ W/cm}^2$ Ex
218. H. Liebel, A. Ehresmann, H. Schmoranz, Ph. V. Demekhin, B. M. Lagutin, V. L. Sukhorukov
De-excitation dynamics of Rydberg states in O_2 : I. Total cross sections for O I fluorescence emission following predissociation of $2\sigma_u^{-1}(\text{c}^4\Sigma_u^-)\text{n}\sigma_g^3\Sigma_u^-$ states.
 J. Phys. B **35**, 895 (2002)
 $h\nu + \text{O}_2$ Fluorescence 20.50-25.00 eV E/T
 $h\nu + \text{O}_2$ Photodissociation 20.50-25.00 eV E/T
 $h\nu + \text{O}_2$ Photoexcitation 20.50-25.00 eV E/T
219. G. Duffy
The 3d photoabsorption spectrum of doubly ionized titanium.
 J. Phys. B **35**, L119 (2002)
 $h\nu + \text{Ti}^{2+}$ Total Absor., Scat. 17.00-27.00 eV Ex
220. T. Pattard
Shape-resonance-induced long-range molecular Rydberg states. H06: $h\nu + \text{O}$ A shape function for single-photon multiple ionization cross sections.
 J. Phys. B **35**, L207 (2002)
 $h\nu + \text{He}$ Photoionization 1.00 keV Th
 $h\nu + \text{Li}$ Photoionization 1.00 keV Th
 $h\nu + \text{Li}^{1+}$ Photoionization 1.00 keV Th
 $h\nu + \text{N}$ Photoionization 1.00 keV Th
 $h\nu + \text{Ne}$ Photoionization 1.00 keV Th
221. M. Martins
On the 3p - ζ 3d photoexcitation of atomic scandium.
 J. Phys. B **35**, L223 (2002)
 $h\nu + \text{Sc}$ Photoexcitation 27.00-45.00 eV E/T
222. W. C. Stolte, G. Ohrwall, M. M. Sant'Anna, I. Dominguez Lopez, L.T.N. Dang, M. N. Piancastelli, D. W. Lindle
100% site-selective fragmentation in core-hole-photoexcited methanol by anion-yield spectroscopy.
 J. Phys. B **35**, L253 (2002)
 $h\nu + \text{CH}_3\text{OH}$ Photoionization 285.00-560.00 eV Ex
 $h\nu + \text{CH}_3\text{OH}$ Photodissociation 285.00-560.00 eV Ex
223. C. A. Nicolaides, T. Mercouris, Y. Komninos
Attosecond dynamics of electron correlation in doubly excited atomic states.
 J. Phys. B **35**, L271 (2002)
 $h\nu + \text{He}^*$ Photoexcitation 1.45-1.78 a.u. Th
 $h\nu + \text{He}$ Photoexcitation 1.45-1.78 a.u. Th
224. P. A. Hatherly, J. Rius i Riu, M. Stankiewicz, F. M. Quinn, L. J. Frasinski
Dynamics of the shake-up satellites of C 1s excited carbon dioxide studied by threshold electron spectroscopy.
 J. Phys. B **35**, L77 (2002)
 $h\nu + \text{CO}_2$ Photoionization 306.00-320.00 eV Ex
 $h\nu + \text{CO}_2$ Photoexcitation 306.00-320.00 eV Ex
225. N. Scherer, H. Lorch, T. Kerkau, V. Schmidt
Exchange interference between coincident photoelectrons and Auger electrons.
 J. Phys. B **64**, L339 (2001)

- | | | | |
|--------------------|-----------------|----------|----|
| $h\nu + \text{Xe}$ | Photoionization | 94.52 eV | Th |
|--------------------|-----------------|----------|----|
226. C. T. Chantler
Detailed tabulation of atomic form factors, photoelectric absorption and scattering cross section, and mass attenuation coefficients in the vicinity of absorption edges in the soft x-ray ($Z=30-36$, $Z=60-89$, $E=0.1$ keV-10 keV), addressing convergence issues of earlier work.
 J. Phys. Chem. Ref. Data **29**, 597 (2000)
- | | | | |
|------------------------------|-------------------|----------------|-----|
| $h\nu + \text{perturbation}$ | Photon Collisions | 0.10-10.00 keV | E/T |
|------------------------------|-------------------|----------------|-----|
227. A. C. Mandal, M. Sarkar, D. M. Bhattacharya, P. Sen
Measurement of photon-induced L shell fluorescence cross-sections of gold and lead at 21.6, 23.7, and 25.8 keV.
 Nucl. Instrum. Methods Phys. Res. B **174**, 41 (2001)
- | | | | |
|--------------------|-----------------|-----------------|----|
| $h\nu + \text{Au}$ | Photoionization | 21.00-26.00 keV | Ex |
| $h\nu + \text{Pb}$ | Photoionization | 21.00-26.00 keV | Ex |
228. R. A. Barrea, E. V. Bonzi
L X-ray fluorescence cross-sections for rare earths at 10 and 11 keV with synchrotron radiation.
 Nucl. Instrum. Methods Phys. Res. B **179**, 1 (2001)
- | | | | |
|--------------------|--------------|----------------|----|
| $h\nu + \text{Gd}$ | Fluorescence | 4.00-10.00 keV | Ex |
| $h\nu + \text{Tb}$ | Fluorescence | 4.00-10.00 keV | Ex |
| $h\nu + \text{Dy}$ | Fluorescence | 4.00-10.00 keV | Ex |
| $h\nu + \text{Ho}$ | Fluorescence | 4.00-10.00 keV | Ex |
| $h\nu + \text{Er}$ | Fluorescence | 4.00-10.00 keV | Ex |
| $h\nu + \text{Yb}$ | Fluorescence | 4.00-10.00 keV | Ex |
229. J. S. Shahi, A. Kumar, D. Mehta, S. Puri, M. L. Garg, N. Singh
Inelastic scattering of 59.5 keV photons by elements with $13 \leq Z \leq 82$.
 Nucl. Instrum. Methods Phys. Res. B **179**, 15 (2001)
- | | | | |
|--------------------|-----------------|-----------|----|
| $h\nu + \text{Al}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Ti}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Fe}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Ni}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Cu}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Zn}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Zr}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Nb}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Mo}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Rh}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Ag}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Sn}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Ta}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{W}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Re}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Pt}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Au}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Pb}$ | Photoionization | 59.50 keV | Ex |
230. J. Baltazar-Rodrigues, C. Cusatis
Determination of X-ray photoelectric absorption of Ge and Si avoiding solid-state effects.
 Nucl. Instrum. Methods Phys. Res. B **179**, 325 (2001)
- | | | | |
|--------------------|---------------------|----------------|----|
| $h\nu + \text{Si}$ | Total Absor., Scat. | 8.00-25.00 keV | Ex |
| $h\nu + \text{Ge}$ | Total Absor., Scat. | 8.00-25.00 keV | Ex |
| $h\nu + \text{Si}$ | Photoionization | 8.00-25.00 keV | Ex |
| $h\nu + \text{Ge}$ | Photoionization | 8.00-25.00 keV | Ex |

231. M. Ertugrul
Measurements of L_{31} , $L_{3\alpha}$, $L_{3\beta}$, $L_{2\beta}$, $L_{2\gamma}$, $L_{1\beta}$ and $L_{1\gamma}$ X-ray production cross sections for Tl, Pb and Bi elements at 59.5 keV.
 Nucl. Instrum. Methods Phys. Res. B **179**, 459 (2001)
- | | | | |
|--------------------|-----------------|-----------|----|
| $h\nu + \text{Tl}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Pb}$ | Photoionization | 59.50 keV | Ex |
| $h\nu + \text{Bi}$ | Photoionization | 59.50 keV | Ex |
232. A. Kumar, J. S. Shahi, M. L. Garg, S. Puri, D. Mehta, N. Singh
Large-angle elastic scattering of 88.03-keV photons by elements with $30 \leq Z \leq 92$.
 Nucl. Instrum. Methods Phys. Res. B **183**, 178 (2001)
- | | | | |
|--------------------|--------------------|-----------|----|
| $h\nu + \text{Mg}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Zn}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Mo}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Sn}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Ba}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Gd}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Ho}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Yb}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Ta}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{W}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Pt}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Au}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Tl}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Pb}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Th}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{U}$ | Elastic Scattering | 88.00 keV | Ex |
| $h\nu + \text{Bi}$ | Elastic Scattering | 88.00 keV | Ex |
233. S. J. Ward, J. C. Hunnell, J. H. Macek
The effect of the polarization potential on low-energy atomic processes.
 Nucl. Instrum. Methods Phys. Res. B **192**, 54 (2002)
- | | | | |
|--------------------------|-----------------|--------------|----|
| $h\nu + \text{Li}^{-1+}$ | Photodetachment | 2.40-2.50 eV | Th |
|--------------------------|-----------------|--------------|----|
234. K. Singh, H. Singh, V. Sharma, R. Nathuram, A. Khanna, R. Kumar, S. S. Bhatti, H. S. Sahota
Gamma-ray attenuation coefficients in bismuth borate glasses.
 Nucl. Instrum. Methods Phys. Res. B **194**, 1 (2002)
- | | | | |
|--------------------------------|---------------------|---------------|----|
| $h\nu + \text{B}_2\text{O}_3$ | Total Absor., Scat. | 0.36-1.33 MeV | Ex |
| $h\nu + \text{Bi}_2\text{O}_3$ | Total Absor., Scat. | 0.36-1.33 MeV | Ex |
235. A. Kumar, J. S. Shahi, D. Mehta, N. Singh
Differential cross-section measurements for elastic scattering of 22.1 keV photons by elements with $6 \leq Z \leq 81$.
 Nucl. Instrum. Methods Phys. Res. B **194**, 105 (2002)
- | | | | |
|--------------------|--------------------|-----------|----|
| $h\nu + \text{C}$ | Elastic Scattering | 22.10 keV | Ex |
| $h\nu + \text{S}$ | Elastic Scattering | 22.10 keV | Ex |
| $h\nu + \text{Ge}$ | Elastic Scattering | 22.10 keV | Ex |
| $h\nu + \text{As}$ | Elastic Scattering | 22.10 keV | Ex |
| $h\nu + \text{Se}$ | Elastic Scattering | 22.10 keV | Ex |
| $h\nu + \text{Rb}$ | Elastic Scattering | 22.10 keV | Ex |
| $h\nu + \text{Ag}$ | Elastic Scattering | 22.10 keV | Ex |
| $h\nu + \text{Te}$ | Elastic Scattering | 22.10 keV | Ex |
| $h\nu + \text{Ba}$ | Elastic Scattering | 22.10 keV | Ex |
| $h\nu + \text{Sm}$ | Elastic Scattering | 22.10 keV | Ex |
| $h\nu + \text{Ho}$ | Elastic Scattering | 22.10 keV | Ex |
| $h\nu + \text{Tm}$ | Elastic Scattering | 22.10 keV | Ex |

$h\nu + \text{Yb}$	Elastic Scattering	22.10 keV	Ex
$h\nu + \text{Hg}$	Elastic Scattering	22.10 keV	Ex
$h\nu + \text{Tl}$	Elastic Scattering	22.10 keV	Ex

236. A. Kumar, J. S. Shahi, S. Puri, D. Mehta, N. Singh

Differential cross-section measurements for inelastic scattering of 22.1 keV photons by elements with $4 \leq Z \leq 69$.

Nucl. Instrum. Methods Phys. Res. B **194**, 99 (2002)

$h\nu + \text{Be}$	Photoionization	22.10 keV	Ex
$h\nu + \text{C}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Mg}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Al}$	Photoionization	22.10 keV	Ex
$h\nu + \text{S}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Ti}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Fe}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Cu}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Zn}$	Photoionization	22.10 keV	Ex
$h\nu + \text{As}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Se}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Y}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Zr}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Ag}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Ag}$	Photoionization	22.10 keV	Ex
$h\nu + \text{In}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Sn}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Te}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Gd}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Dy}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Ho}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Tm}$	Photoionization	22.10 keV	Ex
$h\nu + \text{Be}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{C}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Mg}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Al}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{S}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Ti}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Fe}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Cu}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Zn}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{As}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Se}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Y}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Zr}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Ag}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Ag}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{In}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Sn}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Te}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Gd}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Dy}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Ho}$	Photoexcitation	22.10 keV	Ex
$h\nu + \text{Tm}$	Photoexcitation	22.10 keV	Ex

237. E. A. Volkova, A. M. Popov, O. V. Tikhonova

Resonant multiphoton ionization of the 1s state of a hydrogen atom in a strong laser field.

Opt. Spectrosc. **88**, 1 (2000)

$h\nu + \text{H}$	Photoionization	5.00 eV	Th
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238. S. A. Novikov, A. N. Khoperskii
Two-photon excitation and ionization of inner atomic shells.
 Opt. Spectrosc. **89**, 11 (2000)

$h\nu + \text{Ne}$	Photoionization	0.10-60.00 a.u.	Th
$h\nu + \text{Ne}$	Photoexcitation	0.10-60.00 a.u.	Th
$2h\nu + \text{Ne}$	Photoionization	0.10-60.00 a.u.	Th
$2h\nu + \text{Ne}$	Photoexcitation	0.10-60.00 a.u.	Th
239. E. V. Vsevolodskii, A. A. Chernenko
Photoionization of the 4d state of the sodium atom in the field of a nanosecond pulse of a Nd:YAG laser.
 Opt. Spectrosc. **91**, 675 (2001)

$h\nu + \text{Na}$	Photoionization	1.24 MeV	E/T
$h\nu + \text{Na}^*$	Photoionization	1.24 MeV	E/T
240. H. Suno, L. Andric, T. P. Grozdanov, R. McCarroll
Iterative calculations of photoionization cross sections by using the Lanczos algorithm and the complex coordinate method in the discrete variable representation.
 Phys. Lett. A **265**, 377 (2000)

$h\nu + \text{H}$	Photoionization	5.00-28.00 eV	Th
$h\nu + \text{Li}$	Photoionization	5.00-28.00 eV	Th
$h\nu + \text{Na}$	Photoionization	5.00-28.00 eV	Th
241. H. Liebel, S. Lauer, F. Vollweiler, R. Mueller-Albrecht, A. Ehresmann, H. Schmoranzer, G. Mentzel, K.-H. Schartner, O. Wilhelm
Neutral photodissociation of O_2 Rydberg states accompanied by changes of the Rydberg electron's quantum numbers n and l.
 Phys. Lett. A **267**, 357 (2000)

$h\nu + \text{O}_2^*$	Photodissociation	22.70-24.80 eV	E/T
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242. D.-J. Jiang, J.-C. Liu, X.-D. Yang, P.-F. Lu
Resonant structure due to the $3p \rightarrow 3d$ transition in the photoionization of Ca^+ .
 Phys. Lett. A **288**, 95 (2001)

$h\nu + \text{Ca}^{1+}$	Photoionization	32.80-33.50 eV	E/T
-------------------------	-----------------	----------------	-----
243. J. Shertzer, C. H. Greene
Nonadiabatic dipole polarizabilities of H_2^+ and D_2^+ ground states.
 Phys. Rev. A **58**, 1082 (1998)

$h\nu + \text{H}_2^{1+}$	Photon Collisions		Th
$h\nu + \text{D}_2^{1+}$	Photon Collisions		Th
244. R. J. Rafac, C. E. Tanner
Measurement of the ratio of the cesium D-line transition strengths.
 Phys. Rev. A **58**, 1087 (1998)

$h\nu + \text{Cs}$	Total Absor., Scat.		Ex
--------------------	---------------------	--	----
245. D. Azinovic, R. Bruckmeier, C. Wunderlich, H. Figger, G. Theodorakopoulos, I. D. Petsalakis
Dynamics on the ground-state potential surfaces of H_3 and its isotopomers from their uv spectra.
 Phys. Rev. A **58**, 1115 (1998)

$h\nu + \text{H}_3$	Fluorescence	3.10-6.20 eV	Ex
$h\nu + \text{HD}_2$	Fluorescence	3.10-6.20 eV	Ex
$h\nu + \text{D}_3$	Fluorescence	3.10-6.20 eV	Ex
$h\nu + \text{H}_3$	Photoexcitation	3.10-6.20 eV	Ex
$h\nu + \text{HD}_2$	Photoexcitation	3.10-6.20 eV	Ex
$h\nu + \text{D}_3$	Photoexcitation	3.10-6.20 eV	Ex
$h\nu + \text{H}_3$	Photon Collisions	3.10-6.20 eV	Ex
$h\nu + \text{HD}_2$	Photon Collisions	3.10-6.20 eV	Ex
$h\nu + \text{D}_3$	Photon Collisions	3.10-6.20 eV	Ex

246. C. Cornaggia, L. Quaglia
Experimental observation of non-Coulombic states of transient multicharged molecular ions N_2^{4+} and O_2^{4+} .
 Phys. Rev. A **63**, 030702 (2001)
- | | | | |
|---------------------|-------------------|--------------------------------------|----|
| $h\nu + \text{N}_2$ | Photodissociation | $1.20\text{-}10^{15} \text{ W/cm}^2$ | Ex |
| $h\nu + \text{O}_2$ | Photodissociation | $1.20\text{-}10^{15} \text{ W/cm}^2$ | Ex |
247. D. Mathur
Irradiation of benzene molecules by ion-induced and light-induced intense fields.
 Phys. Rev. A **63**, 032502 (2001)
- | | | | |
|-------------------------------|-------------------|-----------------------------------|----|
| $h\nu + \text{C}_6\text{H}_6$ | Photoionization | $8\text{x}10^{13} \text{ W/cm}^2$ | Ex |
| $h\nu + \text{C}_6\text{H}_6$ | Photodissociation | $8\text{x}10^{13} \text{ W/cm}^2$ | Ex |
248. R.R.T. Marinho, O. Bjoernehholm, S. L. Sorensen, I. Hjelte, S. Sundin, M. Baessler, S. Svensson, A. Naves de Brito
Interference between direct and resonant channels in near-resonance photoemission in argon.
 Phys. Rev. A **63**, 032514 (2001)
- | | | | |
|--------------------|-----------------|----------------|----|
| $h\nu + \text{Ar}$ | Photoionization | 35.00-45.00 eV | Ex |
|--------------------|-----------------|----------------|----|
249. H.-K. Chung, K. Kirby, J. F. Babb
Theoretical study of the absorption spectra of the sodium dimer.
 Phys. Rev. A **63**, 032516 (2001)
- | | | | |
|----------------------|---------------------|-------------|----|
| $h\nu + \text{Na}_2$ | Total Absor., Scat. | 1.00-3.00 K | Th |
|----------------------|---------------------|-------------|----|
250. S.-M. Huttula, S. Heinasmaki, H. Aksela, J. Tulkki, A. Kivimaki, M. Jurvansuu, S. Aksela
Electron correlation effects in Auger cascades following $2p^{-1}4s$ excitations in argon.
 Phys. Rev. A **63**, 032703 (2001)
- | | | | |
|--------------------|--------------------|---------------|----|
| $h\nu + \text{Ar}$ | Photoionization | 0.05-1.00 keV | Ex |
| $h\nu + \text{Ar}$ | Elastic Scattering | 0.05-1.00 keV | Ex |
251. Jr. Abdallah, J., A. Ya Faenov, I. Yu. Skobelev, A. I. Magunov, T. A. Pikuz, T. Auguste, P. d'Oliveira, S. Hulin, P. Monot
Hot-electron influence on the x-ray emission spectra of Ar clusters heated by a high-intensity 60-fs laser pulse.
 Phys. Rev. A **63**, 032706 (2001)
- | | | | |
|--------------------|-----------------|-----------------------------------|----|
| $h\nu + \text{Ar}$ | Photoexcitation | $7\text{x}10^{17} \text{ W/cm}^2$ | Ex |
|--------------------|-----------------|-----------------------------------|----|
252. G. Snell, U. Hergenhahn, N. Mueller, M. Drescher, J. Viefhaus, U. Becker, U. Heinzmann
Study of xenon 4d, 5p, and 5s photoionization in the shape-resonance region using spin-resolved electron spectroscopy.
 Phys. Rev. A **63**, 032712 (2001)
- | | | | |
|--------------------|-----------------|----------|----|
| $h\nu + \text{Xe}$ | Photoionization | 93.80 eV | Ex |
|--------------------|-----------------|----------|----|
253. R. Sankari, A. Kivimaki, M. Huttula, H. Aksela, S. Aksela, M. Coreno, G. Turri, R. Camilloni, M. De Simone, K. C. Prince
Angular distribution in resonant Auger spectra of xenon excited below the $3d_{5/2}$ ionization threshold.
 Phys. Rev. A **63**, 032715 (2001)
- | | | | |
|--------------------|--------------------|-----------------|----|
| $h\nu + \text{Xe}$ | Photoionization | 20.00-900.00 eV | Ex |
| $h\nu + \text{Xe}$ | Elastic Scattering | 20.00-900.00 eV | Ex |
254. R. van Leeuwen, K. Vijayalakshmi, R. R. Jones
Manipulation of differential electron yields via autoionizing wave-packet control.
 Phys. Rev. A **63**, 033403 (2001)

- | | | | |
|--------------------|--------------------|--------------------|----|
| $h\nu + \text{Ca}$ | Photoionization | 1.60 μm | Ex |
| $h\nu + \text{Ca}$ | Elastic Scattering | 1.60 μm | Ex |
255. G. L. Yudin, M. Yu. Ivanov
Physics of correlated double ionization of atoms in intense laser fields: Quasistatic tunneling limit.
 Phys. Rev. A **63**, 033404 (2001)
- | | | | |
|--------------------|-----------------|--|----|
| $h\nu + \text{He}$ | Photoionization | $2\text{-}18 \times 10^{14}$ W/cm ² | Th |
|--------------------|-----------------|--|----|
256. M. Jurvansuu, A. Kivimaki, S. Aksela
Inherent lifetime widths of Ar $2p^{-1}$, Kr $3d^{-1}$, Xe $3d^{-1}$, and Xe $4d^{-1}$ states.
 Phys. Rev. A **64**, 012502 (2001)
- | | | | |
|--------------------|-----------------|------------------|----|
| $h\nu + \text{Ar}$ | Photoionization | 117.00-743.00 eV | Ex |
| $h\nu + \text{Kr}$ | Photoionization | 117.00-743.00 eV | Ex |
| $h\nu + \text{Xe}$ | Photoionization | 117.00-743.00 eV | Ex |
257. F. Gel'mukhanov, P. Salek, H. Agren
Vibrationally resolved core-photoelectron spectroscopy as an infinite-slit interferometry.
 Phys. Rev. A **64**, 012504 (2001)
- | | | | |
|--------------------|-----------------|----------------|----|
| $h\nu + \text{CO}$ | Photoionization | 2.00-20.00 keV | Th |
|--------------------|-----------------|----------------|----|
258. P. Recanatini, P. Nicolosi, P. Villoresi
 ^2P and ^4P C II photoabsorption spectra.
 Phys. Rev. A **64**, 012509 (2001)
- | | | | |
|------------------------|---------------------|----------------|----|
| $h\nu + \text{C}^{1+}$ | Photoionization | 21.75-38.74 eV | Ex |
| $h\nu + \text{C}^{1+}$ | Elastic Scattering | 21.75-38.74 eV | Ex |
| $h\nu + \text{C}^{1+}$ | Total Absor., Scat. | 21.75-38.74 eV | Ex |
259. P. Bolognesi, L. Avaldi, M.C.A Lopes, G. Dawber, G. C. King, M. A. MacDonald, C. Villani, F. Tarantelli
Direct observation of the Kr ($3d^{-1} 4p^{-1}$) and Xe ($4d^{-1} 5p^{-1}$) doubly charged ion states by threshold-photoelectron coincidence spectroscopy.
 Phys. Rev. A **64**, 012701 (2001)
- | | | | |
|------------------------|-----------------|-----------------|----|
| $\text{H} + \text{Kr}$ | Photoionization | 75.00-127.00 eV | Ex |
| $\text{H} + \text{Xe}$ | Photoionization | 75.00-127.00 eV | Ex |
260. S.-H. Lin, C.-S. Hsue, T. Chung
Auger width and branching ratios for Be-like $1s2s^2p$ $^3\text{P}^0$ and $1s2s2p^2$ ^3S , ^3P , ^3D resonances and photoionization of Be from $1s^22s2p$ $^3\text{P}^0$.
 Phys. Rev. A **64**, 012709 (2001)
- | | | | |
|----------------------|-----------------|-----------------|----|
| $h\nu + \text{Be}^*$ | Photoionization | 30.00-125.00 eV | Th |
| $h\nu + \text{Be}$ | Photoionization | 30.00-125.00 eV | Th |
261. R. Krivec, M. Ya. Amusia, V. B. Mandelzweig
Calculation of the contribution of the quasifree mechanism to the two-electron photoionization cross section.
 Phys. Rev. A **64**, 012713 (2001)
- | | | | |
|-------------------------|-----------------|--|----|
| $h\nu + \text{H}^{-1+}$ | Photodetachment | | Th |
| $h\nu + \text{He}$ | Photodetachment | | Th |
| $h\nu + \text{He Seq}$ | Photodetachment | | Th |
| $h\nu + \text{H}^{-1+}$ | Photoionization | | Th |
| $h\nu + \text{He}$ | Photoionization | | Th |
| $h\nu + \text{He Seq}$ | Photoionization | | Th |
262. H. L. Zhou, S. T. Manson, L. Vo Ky, A. Hibbert, N. Feautrier
Photodetachment of $\text{He}^- 1s2s2p$ $^4\text{P}^0$ in the region of the 1s threshold.
 Phys. Rev. A **64**, 012714 (2001)

	$h\nu + \text{He}^{-1+}$	Photodetachment	37.60-44.00 eV	Th
263.	S. L. Sorensen, R. F. Fink, R. Feifel, M. N. Piancastelli, M. Bassler, C. Miron, H. Wang, I. Hjelte, O. Bjorneholm, S. Svensson High-resolution excitation-energy-dependent study of the Auger decay of the O 1s-1π_g core-excited state in oxygen. Phys. Rev. A 64 , 012719 (2001)			
	$h\nu + \text{O}_2$	Photoionization	70.00-531.00 eV	E/T
264.	G. G. Paulus, F. Grasbon, H. Walther, R. Kopold, W. Becker Channel-closing-induced resonances in the above-threshold ionization plateau. Phys. Rev. A 64 , 021401 (2001)			
	$h\nu + \text{H}$	Photoionization		Th
	$nh\nu + \text{H}$	Photoionization		Th
265.	O. Navandin, T. W. Gorczyca, A. A. Wills, B. Langer, J. D. Bozek, N. Berrah Interference effects in the Auger decay of the Ar 2p^{-1}3d resonances. Phys. Rev. A 64 , 022505 (2001)			
	$h\nu + \text{Ar}$	Photoionization	246.90-249.00 eV	E/T
266.	O. Hemmers, S. T. Manson, M. M. Sant'Anna, P. Focke, H. Wang, I. A. Sellin, D. W. Lindle Relativistic effects on interchannel coupling in atomic photoionization: The photoelectron angular distribution of Xe 5s. Phys. Rev. A 64 , 022507 (2001)			
	$h\nu + \text{Xe}$	Photoionization	80.00-200.00 eV	Ex
267.	M. Meyer, A. Marquette, A. N. Grum-Grzhimailo, U. Kleiman, B. Lohmann Polarization analysis of fluorescence probing the alignment of Xe$^+$ ions in the resonant Auger decay of the Xe* 4d$_{5/2}^{-1}$6p photoexcited state. Phys. Rev. A 64 , 022703 (2001)			
	$h\nu + \text{Xe}$	Photoionization	2.03-3.10 eV	Ex
	$h\nu + \text{Xe}$	Fluorescence	2.03-3.10 eV	Ex
268.	K. Tiedtke, Ch. Gerth, M. Martins, P. Zimmermann Term-dependent lifetime broadening in the 3p photoelectron spectra of atomic Fe and Co. Phys. Rev. A 64 , 022705 (2001)			
	$h\nu + \text{Fe}$	Photoionization	127.00 eV	Ex
	$h\nu + \text{Co}$	Photoionization	127.00 eV	Ex
269.	W. C. Shiu, C.-S. Hsue, K. T. Chung Auger branching ratios for berylliumlike 1s2s2p^2 ^1S, ^1P, ^1D resonances and photoionization of beryllium from 1s^{2}2s2p $^1\text{P}^o$. Phys. Rev. A 64 , 022714 (2001)			
	$h\nu + \text{Be}$	Photoionization	23.00-117.00 eV	Th
270.	A. Becker, L. Plaja, P. Moreno, M. Nurhuda, F.H.M. Faisal Total ionization rates and ion yields of atoms at nonperturbative laser intensities. Phys. Rev. A 64 , 023408 (2001)			
	$h\nu + \text{H}$	Photoionization		Th
	$h\nu + \text{Ne}$	Photoionization		Th
	$h\nu + \text{Ar}$	Photoionization		Th
	$h\nu + \text{Kr}$	Photoionization		Th
	$h\nu + \text{Xe}$	Photoionization		Th

271. M. V. Frolov, N. L. Manakov, A. F. Starace
Dynamic hyperpolarizability and two-photon detachment in the presence of a strong static electric field: Application to H^- .
 Phys. Rev. A **64**, 023417 (2001)
- | | | | |
|-------------------|-------------------|--|----|
| $h\nu + H^{-1+}$ | Photon Collisions | | Th |
| $2h\nu + H^{-1+}$ | Photon Collisions | | Th |
| $h\nu + H^{-1+}$ | Photodetachment | | Th |
| $2h\nu + H^{-1+}$ | Photodetachment | | Th |
272. R. C. Bilodeau, H. K. Haugen
Electron affinity of Bi using infrared laser photodetachment threshold spectroscopy.
 Phys. Rev. A **64**, 024501 (2001)
- | | | | |
|-------------------|-----------------|---------------|----|
| $h\nu + Bi^{-1+}$ | Photodetachment | 7.60-7.60 keV | Ex |
|-------------------|-----------------|---------------|----|
273. W. Sun, P. Xue, X. P. Xie, W. Huang, C. B. Xu, Z. P. Zhong, X. Y. Xu
Atomic triply excited double Rydberg states of lanthanum investigated by selective laser excitation.
 Phys. Rev. A **64**, 031402 (2001)
- | | | | |
|-------------|--------------------|----------------|-----|
| $h\nu + La$ | Elastic Scattering | 11.18-11.31 eV | E/T |
|-------------|--------------------|----------------|-----|
274. D. Descamps, L. Roos, C. Delfin, A. L'Huillier, C.-G. Wahlstrom
Two- and three-photon ionization of rare gases using femtosecond harmonic pulses generated in a gas medium.
 Phys. Rev. A **64**, 031404 (2001)
- | | | | |
|-------------|-----------------|---------|----|
| $h\nu + Ar$ | Photoionization | 7.70 eV | Ex |
|-------------|-----------------|---------|----|
275. F. A. Gianturco, R. R. Lucchese
Cross sections and asymmetry parameters in gas-phase photoionization of C_{60} .
 Phys. Rev. A **64**, 032706 (2001)
- | | | | |
|-----------------|-----------------|---------------|----|
| $h\nu + C_{60}$ | Photoionization | 5.00-45.00 eV | Th |
|-----------------|-----------------|---------------|----|
276. X. M. Tong, D. Kato, T. Watanabe, S. Ohtani
Sharp and window resonances in the 4d photoabsorption spectrum of Eu^+ ions.
 Phys. Rev. A **64**, 032716 (2001)
- | | | | |
|------------------|---------------------|------------------|----|
| $h\nu + Eu$ | Total Absor., Scat. | 110.00-160.00 eV | Th |
| $h\nu + Eu^{1+}$ | Total Absor., Scat. | 110.00-160.00 eV | Th |
277. H. L. Zhang, S. N. Nahar, A. K. Pradhan
Relativistic close-coupling calculations for photoionization and recombination of Ne-like Fe XVII.
 Phys. Rev. A **64**, 032719 (2001)
- | | | | |
|-------------------|-----------------|-----------|----|
| $h\nu + Fe^{16+}$ | Photoionization | 100.00 eV | Th |
| $h\nu + Fe^{17+}$ | Photoionization | 100.00 eV | Th |
278. G. L. Yudin, M. Yu. Ivanov
Correlated multiphoton double ionization of helium: The role of nonadiabatic tunneling and singlet recollision.
 Phys. Rev. A **64**, 035401 (2001)
- | | | | |
|-------------|-----------------|--|----|
| $h\nu + He$ | Photoionization | $2-4 \times 10^{14}$ W/cm ² | Th |
|-------------|-----------------|--|----|
279. J. Zeng, J.-M. Yuan, Q. Lu
Photoionization for the ground state of Al VII from threshold to the K shell.
 Phys. Rev. A **64**, 042704 (2001)
- | | | | |
|------------------|-----------------|-----------|----|
| $h\nu + Al^{6+}$ | Photoionization | 140.00 Ry | Th |
|------------------|-----------------|-----------|----|

280. Ph. Wernet, J. Schulz, B. F. Sonntag, K. Godehusen, P. Zimmermann, A. N. Grum-Grzhimailo, N. M. Kabachnik, M. Martins
2p photoelectron spectra and linear alignment dichroism of atomic Cr.
 Phys. Rev. A **64**, 042707 (2001)
 $h\nu + \text{Cr}$ Photoionization 706.00 eV Ex
281. D.-S. Kim, H.-L. Zhou, S. T. Manson, S. S. Tayal
Photoionization of the excited $1s^2 2s 2p^{1,3}$ Po states of atomic beryllium.
 Phys. Rev. A **64**, 042713 (2001)
 $h\nu + \text{Be}$ Photoionization 4.00-20.00 eV Th
 $h\nu + \text{Be}^*$ Photoionization 4.00-20.00 eV Th
282. T. Pattard, J. Burgdoerfer
Half-collision model for multiple ionization by photon impact.
 Phys. Rev. A **64**, 042720 (2001)
 $h\nu + \text{He}$ Photoionization 1.50 keV Th
 $h\nu + \text{Li}$ Photoionization 1.50 keV Th
283. R. Kundliya, K. Batra, M. Mohan
Two-photon ionization using elliptically polarized light.
 Phys. Rev. A **64**, 043404 (2001)
 $h\nu + \text{H}^*$ Photoionization 1.71-13.78 eV Th
 $h\nu + \text{H}$ Photoionization 1.71-13.78 eV Th
284. I. Kawata, H. Kono, A. D. Bandrauk
Mechanism of enhanced ionization of linear H_3^+ in intense laser fields.
 Phys. Rev. A **64**, 043411 (2001)
 $h\nu + \text{H}_3^{1+}$ Photoionization Th
285. J. S. Cohen
Reexamination of over-the-barrier and tunneling ionization of the hydrogen atom in an intense field.
 Phys. Rev. A **64**, 043412 (2001)
 $h\nu + \text{H}$ Photoionization Th
286. G. D. Gillen, M. A. Walker, L. D. van Woerkom
Enhanced double ionization with circularly polarized light.
 Phys. Rev. A **64**, 043413 (2001)
 $h\nu + \text{Mg}$ Photoionization 1.55 eV Ex
287. C.-N. Liu
Photodetachment of K^- .
 Phys. Rev. A **64**, 052715 (2001)
 $h\nu + \text{K}^{-1+}$ Photodetachment 3.00-4.40 eV E/T
288. H. S. Fung, H. H. Wu, T. S. Yih, T. K. Fang, T. N. Chang
Photoabsorption of Mg above the 3p threshold.
 Phys. Rev. A **64**, 052716 (2001)
 $h\nu + \text{Mg}$ Total Absor., Scat. 8.55-16.53 eV E/T
289. E. R. Peterson, P. H. Bucksbaum
Above-threshold double-ionization spectroscopy of argon.
 Phys. Rev. A **64**, 053405 (2001)
 $h\nu + \text{Ar}$ Photoionization 1.55 eV Ex

290. M. Dammasch, M. Dorr, U. Eichmann, E. Lenz, W. Sandner
Relativistic laser-field-drift suppression of nonsequential multiple ionization.
 Phys. Rev. A **64**, 061402 (2001)
 $h\nu + \text{Xe}$ Photoionization $2 \cdot 10^{18} \text{ W/cm}^2$ Ex
291. N. D. Gibson, M. D. Gasda, K. A. Moore, D. A. Zawistowski, C. W. Walter
s-wave photodetachment from S^- ions in a static electric field.
 Phys. Rev. A **64**, 061403 (2001)
 $h\nu + \text{S}^{-1+}$ Photodetachment 2.02-2.02 eV Ex
292. B. Zimmermann, G. Snell, B. Schmidtke, J. Viefhaus, N. A. Cherepkov, B. Langer, M. Drescher, N. Mueller, U. Heinzmann, U. Becker
Interchannel interaction versus relativistic effects: Xe 5p photoionization revisited.
 Phys. Rev. A **64**, 062501 (2001)
 $h\nu + \text{Xe}$ Photoionization 15.00-200.00 eV Ex
293. S. A. Collins, A. Huetz, T. J. Reddish, D. P. Secombe, K. Soejima
Triply differential cross-section measurements in the double photoionization of D_2 and He with asymmetric kinematic conditions.
 Phys. Rev. A **64**, 062706 (2001)
 $h\nu + \text{H}_2$ Photoionization 76.10-104.00 eV Ex
 $h\nu + \text{D}_2$ Photoionization 76.10-104.00 eV Ex
 $h\nu + \text{He}$ Photoionization 76.10-104.00 eV Ex
294. A. S. Baltenkov, V. K. Dolmatov, S. T. Manson
Theory of inner-shell photoionization of fixed-in-space molecules.
 Phys. Rev. A **64**, 062707 (2001)
 $h\nu + \text{CO}$ Photodissociation 334.00 eV Th
 $h\nu + \text{CO}$ Photoionization 334.00 eV Th
295. P. Faucher, H. L. Zhou, S. Bougouffa, F. Bely-Dubau
Resonance analysis in the photoionization of excited lithium below the 1s2l and 1s3l ionization thresholds of the Li atom.
 Phys. Rev. A **64**, 062715 (2001)
 $h\nu + \text{Li}^*$ Photoionization 59.00-73.00 eV Th
 $h\nu + \text{Li}$ Photoionization 59.00-73.00 eV Th
296. D. Bauer, F. Ceccherini, A. Macchi, F. Cornolti
 C_{60} intense femtosecond laser pulses: Nonlinear dipole response and ionization.
 Phys. Rev. A **64**, 063203 (2001)
 $h\nu + \text{C}_{60}$ Photoionization 0.30-1.70 a.u. Th
297. M. Martins, K. Godehusen, Ch. Gerth, P. Zimmermann, J. Schulz, Ph. Wernet, B. Sonntag
Core-hole-induced degeneracy of the valence subshells in the 5p photoemission of atomic europium.
 Phys. Rev. A **65**, 020701 (2002)
 $h\nu + \text{Eu}$ Photoionization 53.00 eV E/T
298. R. R. Lucchese, A. Lafosse, J. C. Brenot, P. M. Guyon, J. C. Houver, M. Lebech, G. Raseev, D. Dowek
Polar and azimuthal dependence of the molecular frame photoelectron angular distributions of spatially oriented linear molecules.
 Phys. Rev. A **65**, 020702 (2002)
 $h\nu + \text{NO}$ Photoionization 25.00 eV Th

299. A. Staudte, C. L. Cocke, M. H. Prior, A. Belkacem, C. Ray, H. W. Chong, T. E. Glover, R. W. Schoenlein, U. Saalmann
Observation of a nearly isotropic, high-energy Coulomb explosion group in the fragmentation of D₂ by short laser pulses.
 Phys. Rev. A **65**, 020703 (2002)
- | | | | |
|---------------------|-------------------|---|----|
| $h\nu + \text{H}_2$ | Photodissociation | 0.65-8x10 ¹⁴ W/cm ² | Ex |
| $h\nu + \text{H}_2$ | Photoionization | 0.65-8x10 ¹⁴ W/cm ² | Ex |
| $h\nu + \text{D}_2$ | Photodissociation | 0.65-8x10 ¹⁴ W/cm ² | Ex |
| $h\nu + \text{D}_2$ | Photoionization | 0.65-8x10 ¹⁴ W/cm ² | Ex |
300. W. Chism, L. E. Reichl
Rydberg atoms in circular polarization: Classical stabilization in optical frequency fields.
 Phys. Rev. A **65**, 021404 (2002)
- | | | | |
|-------------------|-------------------|--|----|
| $h\nu + \text{H}$ | Photon Collisions | 1.43x10 ¹² -1.83x10 ¹⁵ W/cm ² | Th |
|-------------------|-------------------|--|----|
301. L.-B. Fu, J. Liu, S.-G. Chen
Correlated electron emission in laser-induced nonsequence double ionization of helium.
 Phys. Rev. A **65**, 021406 (2002)
- | | | | |
|--------------------|-----------------|--|----|
| $h\nu + \text{He}$ | Photoionization | | Th |
|--------------------|-----------------|--|----|
302. A. Bhattacharjee, K. R. Dastidar
Photodissociation of NaH.
 Phys. Rev. A **65**, 022701 (2002)
- | | | | |
|---------------------|-------------------|---------|----|
| $h\nu + \text{NaH}$ | Photodissociation | 4.17 eV | Th |
|---------------------|-------------------|---------|----|
303. B. Kristensen, T. Andersen, F. Folkmann, H. Kjeldsen, J. B. West
Photoionization of singly charged sulfur ions in the extreme-ultraviolet region: Absolute continuum cross section and resonance structures.
 Phys. Rev. A **65**, 022707 (2002)
- | | | | |
|------------------------|-----------------|-----------------|----|
| $h\nu + \text{S}^{1+}$ | Photoionization | 20.00-200.00 eV | Ex |
|------------------------|-----------------|-----------------|----|
304. A. S. Kheifets, I. Bray
Symmetrized amplitudes of the helium-atom double photoionization.
 Phys. Rev. A **65**, 022708 (2002)
- | | | | |
|--------------------|-----------------|---------------|----|
| $h\nu + \text{He}$ | Photoionization | 9.00-60.00 eV | Th |
|--------------------|-----------------|---------------|----|
305. J. Colgan, M. S. Pindzola
Double photoionization of beryllium.
 Phys. Rev. A **65**, 022709 (2002)
- | | | | |
|--------------------|-----------------|---------------|----|
| $h\nu + \text{Be}$ | Photoionization | 1.00-75.00 eV | Th |
|--------------------|-----------------|---------------|----|
306. S. Chelkowski, A. D. Bandrauk
Measuring moving nuclear wave packets using laser Coulomb-explosion imaging.
 Phys. Rev. A **65**, 023403 (2002)
- | | | | |
|--------------------------|-------------------|--|----|
| $h\nu + \text{H}_2^{1+}$ | Photodissociation | | Ex |
| $h\nu + \text{D}_2^{1+}$ | Photodissociation | | Ex |
307. L. N. Gaier, C. H. Keitel
Relativistic classical Monte Carlo simulations of stabilization of hydrogenlike ions in intense laser pulses.
 Phys. Rev. A **65**, 023406 (2002)
- | | | | |
|-------------------------|-------------------|--|----|
| $h\nu + \text{H}$ | Photoionization | | Th |
| $h\nu + \text{He}^{1+}$ | Photoionization | | Th |
| $h\nu + \text{Li}^{2+}$ | Photoionization | | Th |
| $h\nu + \text{H}$ | Photon Collisions | | Th |
| $h\nu + \text{He}^{1+}$ | Photon Collisions | | Th |
| $h\nu + \text{Li}^{2+}$ | Photon Collisions | | Th |

308. D. Dundas
Efficient grid treatment of the ionization dynamics of laser-driven H_2^+ .
 Phys. Rev. A **65**, 023408 (2002)
 $h\nu + \text{H}_2^{1+}$ Photoionization Th
309. V. T. Davis, J. Ashokkumar, J. S. Thompson
Fine-structure-resolved measurements of photoelectron angular distributions by single-photon detachment of Sn^- at visible wavelengths.
 Phys. Rev. A **65**, 024702 (2002)
 $h\nu + \text{Sn}^{-1+}$ Photodetachment 2.41-2.71 eV Ex
310. G. N. Rockwell, V. F. Hoffman, Th. Clausen, R. Bluemel
Realistic three-dimensional computations of microwave-ionization curves of hydrogen Rydberg atoms.
 Phys. Rev. A **65**, 025401 (2002)
 $h\nu + \text{H}$ Photoionization 200.00-500.00 V/cm Th
 $nh\nu + \text{H}$ Photoionization 200.00-500.00 V/cm Th
311. K. Ishikawa, K. Midorikawa
Coherent control of extreme uv absorption and photoemission by the simultaneous irradiation of ultrashort extreme uv and laser pulses.
 Phys. Rev. A **65**, 031403 (2002)
 $h\nu + \text{H}$ Total Absor., Scat. $1-20 \times 10^{12}$ W/cm² Th
 $h\nu + \text{H}$ Elastic Scattering $1-20 \times 10^{12}$ W/cm² Th
312. R. Klingeler, N. Pontius, G. Luettgens, P. S. Bechthold, M. Neeb, W. Eberhardt
Photoelectron spectroscopy of GdO^- .
 Phys. Rev. A **65**, 032502 (2002)
 $h\nu + \text{GdO}^{-1+}$ Photodetachment 3.50 eV Ex
313. R. Puettnner, Y.-F. Hu, E. Nommiste, G. M. Bancroft, S. Aksela
Angle-resolved photoabsorption spectra of core holes with strong spin-orbit interaction: Below the Br 3d thresholds in HBr.
 Phys. Rev. A **65**, 032513 (2002)
 $h\nu + \text{HBr}$ Photoionization 69.00-79.00 eV Ex
 $h\nu + \text{HBr}$ Total Absor., Scat. 69.00-79.00 eV Ex
314. M. Zitnik, K. Bucar, M. Stuhec, F. Penent, R. I. Hall, P. Lablanquie
Fluorescence of low-lying doubly photoexcited states in helium.
 Phys. Rev. A **65**, 032520 (2002)
 $h\nu + \text{He}$ Total Absor., Scat. Th
315. H. Lin, C.-S. Hsue, K. T. Chung
Auger width and branching ratios for berylliumlike $1s2s^2np\ ^1P^0$ and $1s2p^3\ ^1P^0$ resonances and photoionization of beryllium from $1s^22s^2\ ^1S$.
 Phys. Rev. A **65**, 032706 (2002)
 $h\nu + \text{Be}$ Photoionization 30.00-120.00 eV Th
 $h\nu + \text{B}^{1+}$ Photoionization 30.00-120.00 eV Th
 $h\nu + \text{C}^{2+}$ Photoionization 30.00-120.00 eV Th
 $h\nu + \text{N}^{3+}$ Photoionization 30.00-120.00 eV Th
 $h\nu + \text{O}^{4+}$ Photoionization 30.00-120.00 eV Th
 $h\nu + \text{F}^{5+}$ Photoionization 30.00-120.00 eV Th
 $h\nu + \text{Ne}^{6+}$ Photoionization 30.00-120.00 eV Th
 $h\nu + \text{Be}$ Elastic Scattering 30.00-120.00 eV Th
 $h\nu + \text{B}^{1+}$ Elastic Scattering 30.00-120.00 eV Th

- | | | | |
|-------------------------|--------------------|-----------------|----|
| $h\nu + \text{C}^{2+}$ | Elastic Scattering | 30.00-120.00 eV | Th |
| $h\nu + \text{N}^{3+}$ | Elastic Scattering | 30.00-120.00 eV | Th |
| $h\nu + \text{O}^{4+}$ | Elastic Scattering | 30.00-120.00 eV | Th |
| $h\nu + \text{F}^{5+}$ | Elastic Scattering | 30.00-120.00 eV | Th |
| $h\nu + \text{Ne}^{6+}$ | Elastic Scattering | 30.00-120.00 eV | Th |
316. P. Selles, L. Malegat, A. K. Kazansky
Ab initio calculation of the whole set of He double-photoionization cross sections.
Phys. Rev. A **65**, 032711 (2002)
- | | | | |
|--------------------|-----------------|----------|----|
| $h\nu + \text{He}$ | Photoionization | 90.00 eV | Th |
|--------------------|-----------------|----------|----|
317. M. Ya. Amusia, L. V. Chernysheva, V. K. Ivanov, S. T. Manson
Photoionization of 4d electrons in I^+ and I^{2+} .
Phys. Rev. A **65**, 032714 (2002)
- | | | | |
|------------------------|-----------------|-----------------|----|
| $h\nu + \text{I}^{1+}$ | Photoionization | 40.00-150.00 eV | Th |
| $h\nu + \text{I}^{2+}$ | Photoionization | 40.00-150.00 eV | Th |
318. W.-J. Chen, T. K. Fang, T. N. Chang, T. S. Yih, C.-K. Ni, A. H. Kung
3smd¹D to 3png¹F autoionization resonances of Mg.
Phys. Rev. A **65**, 032717 (2002)
- | | | | |
|--------------------|-----------------|---------|----|
| $h\nu + \text{Mg}$ | Photoionization | 4.35 eV | Ex |
| $h\nu + \text{Mg}$ | Photoexcitation | 4.35 eV | Ex |
319. A. T. Domondon, X. M. Tong
Photoabsorption spectra of I and its ions in the 4d region.
Phys. Rev. A **65**, 032718 (2002)
- | | | | |
|------------------------|---------------------|-----------------|----|
| $h\nu + \text{I}$ | Total Absor., Scat. | 60.00-130.00 eV | Th |
| $h\nu + \text{I}^{1+}$ | Total Absor., Scat. | 60.00-130.00 eV | Th |
| $h\nu + \text{I}^{2+}$ | Total Absor., Scat. | 60.00-130.00 eV | Th |
| $h\nu + \text{I}^{3+}$ | Total Absor., Scat. | 60.00-130.00 eV | Th |
320. S. S. Tayal
Resonant photoionization cross sections and branching ratios for atomic oxygen.
Phys. Rev. A **65**, 032724 (2002)
- | | | | |
|-------------------|-----------------|----------------|----|
| $h\nu + \text{O}$ | Photoionization | 13.00-60.00 eV | Th |
|-------------------|-----------------|----------------|----|
321. J. Colgan, M. S. Pindzola
($\gamma, 2e$) total and differential cross-section calculations for helium at various excell energies.
Phys. Rev. A **65**, 032729 (2002)
- | | | | |
|--------------------|-----------------|-----------------|----|
| $h\nu + \text{He}$ | Photoionization | 75.00-200.00 eV | Th |
|--------------------|-----------------|-----------------|----|
322. M. Lein, T. Kreibich, E.K.U. Gross, V. Engel
Strong-field ionization dynamics of a model H_2 molecule.
Phys. Rev. A **65**, 033403 (2002)
- | | | | |
|---------------------|-----------------|--------------|----|
| $h\nu + \text{H}_2$ | Photoionization | 1.57-1.61 eV | Th |
|---------------------|-----------------|--------------|----|
323. W. Huang, T. J. Morgan
Photoabsorption dynamics of doubly excited two-electron systems: Closed classical orbits.
Phys. Rev. A **65**, 033409 (2002)
- | | | | |
|--------------------|---------------------|--|----|
| $h\nu + \text{He}$ | Total Absor., Scat. | | Th |
| $h\nu + \text{Yb}$ | Total Absor., Scat. | | Th |
324. W. Becken, P. Schmelcher
Electromagnetic transitions of the helium atom in a strong magnetic field.
Phys. Rev. A **65**, 033416 (2002)

- | | | | | |
|--|--------------------|-----------------|--|----|
| | $h\nu + \text{He}$ | Photoexcitation | | Th |
|--|--------------------|-----------------|--|----|
325. S. N. Pisharody, R. R. Jones
Phase-controlled stair-step decay of autoionizing radial wave packets.
Phys. Rev. A **65**, 033418 (2002)
- | | | | | |
|--|--------------------|-----------------|--------------|----|
| | $h\nu + \text{Cs}$ | Photoionization | 2.93-3.90 eV | Ex |
| | $h\nu + \text{Cs}$ | Photoexcitation | 2.93-3.90 eV | Ex |
326. G. Turri, L. Avaldi, P. Bolognesi, R. Camilloni, M. Coreno, J. Berakdar, A. S. Kheifets, G. Stefani
Double photoionization of He at 80 eV excess energy in the equal-energy-sharing condition.
Phys. Rev. A **65**, 034702 (2002)
- | | | | | |
|--|--------------------|-----------------|-----------------|----|
| | $h\nu + \text{He}$ | Photoionization | 74.00-134.00 eV | Ex |
|--|--------------------|-----------------|-----------------|----|
327. R. Sankari, A. Kivimaeki, M. Huttula, T. Matila, H. Aksela, S. Aksela, M. Coreno, G. Turri, R. Camilloni, M. De Simone, K. C. Prince
Interference effects between 2p photoionization and resonant Auger decay channels at $2s^{-1}np$ ($n=4,5$) inner-shell resonances in Ar.
Phys. Rev. A **65**, 042702 (2002)
- | | | | | |
|--|--------------------|-----------------|------------------|----|
| | $h\nu + \text{Ar}$ | Photoionization | 321.00-330.00 eV | Ex |
| | $h\nu + \text{Ar}$ | Photoexcitation | 321.00-330.00 eV | Ex |
328. S. Ricz, A. Koeber, M. Jurvansuu, D. Varga, J. Molnar, S. Aksela
High-resolution photoelectron-Auger-electron coincidence study for the $L_{23}-M_{23}M_{23}$ transitions of argon.
Phys. Rev. A **65**, 042707 (2002)
- | | | | | |
|--|--------------------|-----------------|-----------|----|
| | $h\nu + \text{Ar}$ | Photoionization | 440.00 eV | Th |
|--|--------------------|-----------------|-----------|----|
329. S. Bruenken, Ch. Gerth, B. Kanngiesser, T. Luhmann, M. Richter, P. Zimmermann
Decay of the Ar $2s^{-1}$ and $2p^{-1}$ and Kr $3p^{-1}$ and $3d^{-1}$ hole states studied by photoelectron-ion coincidence spectroscopy.
Phys. Rev. A **65**, 042708 (2002)
- | | | | | |
|--|--------------------|-----------------|-----------|----|
| | $h\nu + \text{Ar}$ | Photoionization | 360.00 eV | Th |
|--|--------------------|-----------------|-----------|----|
330. T. Schneider, C.-N. Liu, J.-M. Rost
Intermanifold similarities in partial photoionization cross sections of helium.
Phys. Rev. A **65**, 042715 (2002)
- | | | | | |
|--|--------------------|-----------------|----------------|----|
| | $h\nu + \text{He}$ | Photoionization | 76.00-78.50 eV | Th |
|--|--------------------|-----------------|----------------|----|
331. A. Datta, S. S. Bhattacharyya, B. Kim
Effects of chirping on the dissociation dynamics of H_2 in a two-frequency laser field.
Phys. Rev. A **65**, 043404 (2002)
- | | | | | |
|--|----------------------|-------------------|----------------|----|
| | $h\nu + \text{H}_2$ | Photodissociation | 13.10-13.10 eV | Th |
| | $2h\nu + \text{H}_2$ | Photodissociation | 13.10-13.10 eV | Th |
332. K. Ishikawa, K. Midorikawa
Two-photon ionization of He^+ as a nonlinear optical effect in the soft-x-ray region.
Phys. Rev. A **65**, 043405 (2002)
- | | | | | |
|--|--------------------------|-------------------|----------------|----|
| | $h\nu + \text{He}^{1+}$ | Photodissociation | 40.60-42.00 eV | Th |
| | $2h\nu + \text{He}^{1+}$ | Photodissociation | 40.60-42.00 eV | Th |
333. R. Feifel, L. Karlsson, M. N. Piancastelli, R. F. Fink, M. Baessler, O. Bjoerneholt, K. Wiesner, C. Miron, H. Wang, A. Giertz, S. L. Sorensen, A. Naves de Brito, S. Svensson
"Hidden" vibrations in CO: Reinvestigation of resonant Auger decay for the C $1s \rightarrow \pi$ excitation.
Phys. Rev. A **65**, 052701 (2002)

- | | | | | |
|--|--------------------|-----------------|------------------|----|
| | $h\nu + \text{CO}$ | Photoionization | 286.50-288.50 eV | Ex |
| | $h\nu + \text{CO}$ | Photoexcitation | 286.50-288.50 eV | Ex |
334. S. Nahar
Relativistic photoionization cross sections for C II.
 Phys. Rev. A **65**, 052702 (2002)
- | | | | | |
|--|------------------------|-----------------|--------------|-----|
| | $h\nu + \text{C}^{1+}$ | Photoionization | 1.80-2.30 Ry | E/T |
|--|------------------------|-----------------|--------------|-----|
335. N. B. Avdonina, E. G. Drukarev, R. H. Pratt
Applicability of a nonrelativistic asymptotic description of high-energy photoionization.
 Phys. Rev. A **65**, 052705 (2002)
- | | | | | |
|--|------------------------|-----------------|----------------|----|
| | $h\nu + \text{Ne}$ | Photoionization | 0.60-60.00 keV | Th |
| | $h\nu + \text{Ar}$ | Photoionization | 0.60-60.00 keV | Th |
| | $h\nu + \text{K}^{1+}$ | Photoionization | 0.60-60.00 keV | Th |
336. T. Mukoyama, M. Uda
Electron excitation during inner-shell ionization.
 Phys. Rev. A **65**, 052706 (2002)
- | | | | | |
|--|--------------------|-----------------|---------------|-----|
| | $h\nu + \text{Ne}$ | Photoexcitation | 0.85-1.20 keV | E/T |
| | $h\nu + \text{Ne}$ | Photoionization | 0.85-1.20 keV | E/T |
337. S. A. Collins, S. Cvejanovic, C. Dawson, T. J. Reddish, D. P. Secombe, A. Huetz, L. Malegat, P. Selles, A. K. Kazansky, A. Danjo, K. Soejima, K. Okuno, A. Yagishita
Double photoionization of helium at an excess energy of 60 eV using left- and right-elliptically-polarized light.
 Phys. Rev. A **65**, 052717 (2002)
- | | | | | |
|--|--------------------|-----------------|-----------|-----|
| | $h\nu + \text{He}$ | Photoionization | 139.00 eV | E/T |
|--|--------------------|-----------------|-----------|-----|
338. S. Freund, R. Ubert, E. Floethmann, K. Welge, D. M. Wang, J. B. Delos
Absorption and recurrence spectra of hydrogen in crossed electric and magnetic fields.
 Phys. Rev. A **65**, 053408 (2002)
- | | | | | |
|--|-------------------|---------------------|---------|-----|
| | $h\nu + \text{H}$ | Total Absor., Scat. | 3.40 eV | E/T |
|--|-------------------|---------------------|---------|-----|
339. J. L. Sanz-Vicario, E. Lindroth
Resonant triply excited states in the photodetachment of $\text{He}^- 1s2s2p^4 P^o$.
 Phys. Rev. A **65**, 060703 (2002)
- | | | | | |
|--|--------------------------|-----------------|----------------|----|
| | $h\nu + \text{He}^{-1+}$ | Photodetachment | 37.00-45.00 eV | Th |
|--|--------------------------|-----------------|----------------|----|
340. P.-A. Raboud, M. Berset, J.-Cl. Dousse, Y.-P. Maillard, O. Mauron, J. Hoszowska, M. Polasik, J. Rzakiewicz
Energy-dependent KL double photoexcitation of argon.
 Phys. Rev. A **65**, 062503 (2002)
- | | | | | |
|--|--------------------|-----------------|---------------|----|
| | $h\nu + \text{Ar}$ | Photoionization | 3.46-6.54 keV | Ex |
| | $h\nu + \text{Ar}$ | Photoexcitation | 3.46-6.54 keV | Ex |
341. H. W. Van der Hart, C. H. Greene
Excitation of the $3p^4(4s,3d,4p) \text{Ar}^+$ states during Ar photoionization: Intensity, alignment, and orientation.
 Phys. Rev. A **65**, 062509 (2002)
- | | | | | |
|--|--------------------|-----------------|----------------|----|
| | $h\nu + \text{Ar}$ | Photoionization | 35.00-37.00 eV | Th |
| | $h\nu + \text{Ar}$ | Photoexcitation | 35.00-37.00 eV | Th |
342. M. Ya. Amusia, L. V. Chernysheva, Z. Felfi, A. Z. Msezane
Cross sections of discrete-level excitation of noble-gas atoms in Compton scattering.
 Phys. Rev. A **65**, 062705 (2002)

- | | | | |
|--------------------|-----------------|--------------|----|
| $h\nu + \text{Ne}$ | Photoexcitation | 0.67-1.60 Ry | Th |
| $h\nu + \text{Ar}$ | Photoexcitation | 0.67-1.60 Ry | Th |
| $h\nu + \text{Kr}$ | Photoexcitation | 0.67-1.60 Ry | Th |
| $h\nu + \text{Xe}$ | Photoexcitation | 0.67-1.60 Ry | Th |
343. H. Yamaoka, M. Oura, K. Takahiro, N. Takeshima, K. Kawatsura, M. Mizumaki, U. Kleiman, N. M. Kabachnik, T. Mukoyama
Angular distribution of Au and Pb L x rays following photoionization by synchrotron radiation.
 Phys. Rev. A **65**, 062713 (2002)
- | | | | |
|--------------------|-----------------|-----------------|----|
| $h\nu + \text{Au}$ | Fluorescence | 12.20-16.70 keV | Ex |
| $h\nu + \text{Pb}$ | Fluorescence | 12.20-16.70 keV | Ex |
| $h\nu + \text{Au}$ | Photoionization | 12.20-16.70 keV | Ex |
| $h\nu + \text{Pb}$ | Photoionization | 12.20-16.70 keV | Ex |
344. A. Reber, F. Martin, H. Bachau, R. S. Berry
Two-photon above-threshold ionization of magnesium.
 Phys. Rev. A **65**, 063413 (2002)
- | | | | |
|--------------------|-----------------|----------------|----|
| $h\nu + \text{Mg}$ | Photoionization | 0.28-0.30 a.u. | Th |
|--------------------|-----------------|----------------|----|
345. K. Sandig, H. Figger, T. W. Hansch
Dissociation dynamics of H_2^- in intense laser fields: investigation of photofragments from single vibrational levels.
 Phys. Rev. Lett. **85**, 4876 (2000)
- | | | | |
|--------------------------|-------------------|---------|----|
| $h\nu + \text{H}_2^{1+}$ | Photodissociation | 1.58 eV | Ex |
|--------------------------|-------------------|---------|----|
346. B.L.G. Bakker, D. H. Parker, W. J. Van der Zande
Observation of direct dissociative ionization in molecular hydrogen.
 Phys. Rev. Lett. **86**, 3272 (2001)
- | | | | |
|---------------------|-------------------|---------|----|
| $h\nu + \text{H}_2$ | Photodissociation | 6.42 eV | Ex |
|---------------------|-------------------|---------|----|
347. H.-L. Zhou, S. T. Manson, L. Voky, N. Feautrier, A. Hibbert
Dramatic structure in the photodetachment of inner shells of negative ions: Li^- .
 Phys. Rev. Lett. **87**, 023001 (2001)
- | | | | |
|--------------------------|-----------------|----------------|----|
| $h\nu + \text{Li}^{-1+}$ | Photodetachment | 56.00-64.00 eV | Th |
|--------------------------|-----------------|----------------|----|
348. R. Reichle, H. Helm, I. Yu. Kiyani
Photodetachment of H^- in a strong infrared laser field.
 Phys. Rev. Lett. **87**, 243001 (2001)
- | | | | |
|-------------------------|-----------------|--------------------|----|
| $h\nu + \text{H}^{-1+}$ | Photodetachment | 2.15 μm | Ex |
|-------------------------|-----------------|--------------------|----|
349. A. M. Covington, A. Aguilar, I. R. Covington, M. Gharaibeh, C. A. Shirley, R. A. Phaneuf, I. Alvarez, C. Cisneros, G. Hinojosa, J. D. Bozek, I. Dominguez, M. M. Sant'Anna, A. S. Schlachter, N. Berrah, S. N. Nahar, B. M. McLaughlin
Photoionization of metastable O^+ ions: experiment and theory.
 Phys. Rev. Lett. **87**, 243002 (2001)
- | | | | |
|------------------------|-----------------|----------------|----|
| $h\nu + \text{O}^{1+}$ | Photoionization | 30.00-35.00 eV | Ex |
|------------------------|-----------------|----------------|----|
350. N. Berrah, J. D. Bozek, A. A. Wills, G. Turri, H.-L. Zhou, S. T. Manson, G. Akerman, B. Rude, N. D. Gibson, C. W. Walter, L. Voky, A. Hibbert, S. M. Ferguson
K-shell photodetachment of Li^- : Experiment and theory.
 Phys. Rev. Lett. **87**, 253002 (2001)
- | | | | |
|--------------------------|-----------------|----------------|-----|
| $h\nu + \text{Li}^{-1+}$ | Photodetachment | 56.00-65.00 eV | E/T |
|--------------------------|-----------------|----------------|-----|

351. S. Ivarsson, U. Litzen, G. M. Wahlgren
Accurate wavelengths, oscillator strengths and hyperfine structure in selected praseodymium lines of astrophysical interest.
 Phys. Scr. **64**, 455 (2001)
 $h\nu + \text{Pr}^{1+}$ Photoexcitation 2.00-6.00 eV Ex
352. N. Singh, M. Mohan, W. Eissner
Photoionisation of ground state of Mg III using a relativistic Breit-Pauli approximation.
 Phys. Scr. **65**, 233 (2002)
 $h\nu + \text{Mg}^{2+}$ Photoionization 5.80-5.90 Ry Th
353. M. Ertugrul
Measurement of L X-ray production cross-sections at 5.96 keV and average L and M shell fluorescence yields of elements in the atomic number range 40;Z;55.
 Phys. Scr. **65**, 323 (2002)

$h\nu + \text{Zr}$	Photoionization	6.00 keV	Ex
$h\nu + \text{Nb}$	Photoionization	6.00 keV	Ex
$h\nu + \text{Mo}$	Photoionization	6.00 keV	Ex
$h\nu + \text{Pd}$	Photoionization	6.00 keV	Ex
$h\nu + \text{Ag}$	Photoionization	6.00 keV	Ex
$h\nu + \text{Cd}$	Photoionization	6.00 keV	Ex
$h\nu + \text{In}$	Photoionization	6.00 keV	Ex
$h\nu + \text{Sn}$	Photoionization	6.00 keV	Ex
$h\nu + \text{Sb}$	Photoionization	6.00 keV	Ex
$h\nu + \text{Te}$	Photoionization	6.00 keV	Ex
$h\nu + \text{I}$	Photoionization	6.00 keV	Ex
$h\nu + \text{Cs}$	Photoionization	6.00 keV	Ex
354. D. V. Rao, T. Takeda, Y. Itai, T. Akatsuka, S. M. Seltzer, J. H. Hubbell, R. Cesareo, A. Brunetti, G. E. Gigante
Measurements of atomic Rayleigh scattering cross-sections: A new approach based on solid angle approximation and geometrical efficiency.
 Phys. Scr. **65**, 398 (2002)

$h\nu + \text{Co}$	Elastic Scattering	15.00-22.00 keV	Ex
$h\nu + \text{Ni}$	Elastic Scattering	15.00-22.00 keV	Ex
$h\nu + \text{Cu}$	Elastic Scattering	15.00-22.00 keV	Ex
$h\nu + \text{Zn}$	Elastic Scattering	15.00-22.00 keV	Ex
$h\nu + \text{Nb}$	Elastic Scattering	15.00-22.00 keV	Ex
$h\nu + \text{Mo}$	Elastic Scattering	15.00-22.00 keV	Ex
$h\nu + \text{Pd}$	Elastic Scattering	15.00-22.00 keV	Ex
$h\nu + \text{Ag}$	Elastic Scattering	15.00-22.00 keV	Ex
$h\nu + \text{Cd}$	Elastic Scattering	15.00-22.00 keV	Ex
$h\nu + \text{In}$	Elastic Scattering	15.00-22.00 keV	Ex
$h\nu + \text{Sn}$	Elastic Scattering	15.00-22.00 keV	Ex
355. G. P. Gupta, A. Z. Msezane
Excitation energies, oscillator strengths and radiative rates in triply ionised phosphorous.
 Phys. Scr. **66**, 43 (2002)
 $h\nu + \text{P}^{3+}$ Photoexcitation Th
356. J. Migdalek
Model potential approach to core polarisation in SCF calculations.
 Phys. Scr. **T100**, 47 (2002)

$h\nu + \text{Cu}$	Photoexcitation	Th
$h\nu + \text{Rb}$	Photoexcitation	Th
$h\nu + \text{Ag}$	Photoexcitation	Th

- | | | | |
|-------------------------|-----------------|--|----|
| $h\nu + \text{Cd}$ | Photoexcitation | | Th |
| $h\nu + \text{Cs}$ | Photoexcitation | | Th |
| $h\nu + \text{Au}$ | Photoexcitation | | Th |
| $h\nu + \text{Hg}$ | Photoexcitation | | Th |
| $h\nu + \text{Ag Seq.}$ | Photoexcitation | | Th |
| $h\nu + \text{Au Seq.}$ | Photoexcitation | | Th |
| $h\nu + \text{Hg Seq.}$ | Photoexcitation | | Th |
| $h\nu + \text{Cd Seq.}$ | Photoexcitation | | Th |
357. K. L. Bell
Photoionization of ions of astrophysical interest: Theoretical survey.
 Phys. Scr. **T100**, 64 (2002)
- | | | | |
|------------------------|-----------------|--|----|
| $h\nu + \text{N}^{2+}$ | Photoionization | | Th |
| $h\nu + \text{N}^{3+}$ | Photoionization | | Th |
| $h\nu + \text{O}^{3+}$ | Photoionization | | Th |
| $h\nu + \text{O}^{4+}$ | Photoionization | | Th |
358. S. Johansson, A. Derkatch, M. P. Donnelly, H. Hartman, A. Hibbert, H. Karlsson, M. Kock, Z. S. Li, D. S. Leckrone, U. Litzen, H. Lundberg, S. Mannervik, L.-O. Norlin, H. Nilsson, J. Pickering, T. Raassen, D. Rostohar, P. Royen, A. Schmitt, M. Johanning, C. M. Sikstrom, P. L. Smith, S. Svanberg, G. M. Wahlgren
The FERRUM project: New f-value data for Fe II and astrophysical applications.
 Phys. Scr. **T100**, 71 (2002)
- | | | | |
|-------------------------|-----------------|--|----|
| $h\nu + \text{Fe}^{1+}$ | Photoexcitation | | Th |
|-------------------------|-----------------|--|----|
359. I. D. Williams, B. Srigengan, P. McKenna, W. R. Newell, J. H. Sanderson, W. A. Bryan, A. El-Zein, P. F. Taday, A. J. Langley
Short pulse laser interaction with positive ions.
 Phys. Scr. **T80**, 534 (1999)
- | | | | |
|--------------------------|-------------------|---------|----|
| $h\nu + \text{H}_2^{1+}$ | Photodissociation | 1.57 eV | Ex |
|--------------------------|-------------------|---------|----|
360. D. C. Ionescu, A. H. Sorensen, A. Balkacem
Photoionization at relativistic energies.
 Phys. Scr. **T92**, 330 (2001)
- | | | | |
|--------------------------|-----------------|-----------------|----|
| $h\nu + \text{Ca}^{19+}$ | Photoionization | 0.00-100.00 GeV | Th |
|--------------------------|-----------------|-----------------|----|
361. M. Sato, X.-M. Tong, A. Watanabe
Giant resonance in 4d photoionization of Xe-like iso-electronic sequence.
 Phys. Scr. **T92**, 388 (2001)
- | | | | |
|-------------------------|-----------------|-----------------|----|
| $h\nu + \text{Xe}$ | Photoionization | 90.00-160.00 eV | Th |
| $h\nu + \text{Cs}^{1+}$ | Photoionization | 90.00-160.00 eV | Th |
| $h\nu + \text{Ba}^{2+}$ | Photoionization | 90.00-160.00 eV | Th |

3.2.2 Electron Collisions

362. M. A. Bautista
Atomic data from the Iron Project. XLVII. Electron impact excitation of Ni III.
 Astron. Astrophys. **365**, 268 (2001)
- | | | | |
|----------------------|------------|--------------|----|
| $e + \text{Ni}^{2+}$ | Excitation | 5.00-60.00 K | Th |
|----------------------|------------|--------------|----|
363. K. Butler, C. J. Zeippen
Atomic data from the IRON Project. XLIX. Electron impact excitation of Fe XX.
 Astron. Astrophys. **372**, 1078 (2001)
- | | | | |
|-----------------------|------------|-----------|----|
| $e + \text{Fe}^{19+}$ | Excitation | 290.00 Ry | Th |
|-----------------------|------------|-----------|----|

364. K. Butler, C. J. Zeippen
Atomic data from the IRON Project. L. Electron impact excitation of Fe XIX.
Astron. Astrophys. **372**, 1083 (2001)
 $e + \text{Fe}^{18+}$ Excitation 300.00 Ry Th
365. R. Kisieliu, P. J. Storey
Effective recombination coefficients for N II lines at nebular temperatures and densities.
Astron. Astrophys. **387**, 1135 (2002)
 $e + \text{N}^{2+}$ Recombination 1.00-20.00 kK Th
366. S. Schippers, A. Mueller, G. Gwinner, J. Linkemann, A. A. Saghir, A. Wolf
Storage ring measurement of the C IV recombination rate coefficient.
Astrophys. J., Part 1 **555**, 1027 (2001)
 $e + \text{C}^{3+}$ Recombination 8.00 eV Ex
367. A. K. Bhatia, J. L. Saba
Resonance scattering of Fe XVII x-ray and extreme-ultraviolet lines.
Astrophys. J., Part 1 **563**, 434 (2001)
 $e + \text{Fe}^{16+}$ Excitation 450.00 Ry Th
368. M. F. Gu, S. M. Kahn, D. W. Savin, E. Behar, P. Beiersdorfer, G. V. Brown, D. A. Liedahl, K. J. Reed
Laboratory measurements of iron L-shell emission: 3- μ 2 transitions of Fe XXI-XXIV between 10.5 and 12.5 Å.
Astrophys. J., Part 1 **563**, 462 (2001)
 $e + \text{Fe}^{20+}$ Excitation 3.00 keV E/T
 $e + \text{Fe}^{21+}$ Excitation 3.00 keV E/T
 $e + \text{Fe}^{22+}$ Excitation 3.00 keV E/T
 $e + \text{Fe}^{23+}$ Excitation 3.00 keV E/T
369. M. Niimura, S. J. Smith, A. Chutjian
Electron excitation cross sections for the 2p²2p² ³P - λ 2s²2p² ¹D transition in O²⁺.
Astrophys. J., Part 1 **565**, 645 (2002)
 $e + \text{O}^{2+}$ Excitation 1.80-5.35 eV Ex
370. D. W. Savin, S. M. Kahn, J. Linkemann, A. A. Saghir, M. Schmitt, M. Grieser, R. Repnow, D. Schwalm, A. Wolf, T. Bartsch, A. Mueller, S. Schippers, M. H. Chen, N. R. Badnell, T. W. Gorczyca, O. Zatsarinny
Dielectronic recombination of Fe XIX forming Fe XVIII: Laboratory measurements and theoretical calculations.
Astrophys. J., Part 1 **576**, 1098 (2002)
 $e + \text{Fe}^{18+}$ Recombination 0.00-1.00 keV E/T
371. M. Bhattacharya, N. C. Deb, A. Z. Msezane, P. S. Mazumdar
Electron impact ionization of the ground state of singly ionized helium.
Can. J. Phys. **78**, 901 (2000)
 $e + \text{He}^{1+}$ Ionization 50.00-900.00 eV Th
372. B. Wallbank, J. K. Holmes
Laser-assisted elastic electron scattering from helium.
Can. J. Phys. **79**, 1237 (2001)
 $e + \text{He}$ Angular Scattering 1.00-20.00 eV Ex
 $e + \text{He}$ Elastic Scattering 1.00-20.00 eV Ex
373. R. Srivastava, R. P. McEachran, A. D. Stauffer
Electron excitation of the Group IV elements.
Can. J. Phys. **80**, 687 (2002)

e + C	Angular Scattering	25.00-40.00 eV	Th
e + Si	Angular Scattering	25.00-40.00 eV	Th
e + Ge	Angular Scattering	25.00-40.00 eV	Th
e + Sn	Angular Scattering	25.00-40.00 eV	Th
e + C	Excitation	25.00-40.00 eV	Th
e + Si	Excitation	25.00-40.00 eV	Th
e + Ge	Excitation	25.00-40.00 eV	Th
e + Sn	Excitation	25.00-40.00 eV	Th

374. H. Deutsch, K. Hilpert, K. Becker, M. Probst, T. D. Maerk

Calculated absolute electron-impact ionization cross sections for AlO, Al₂O, and WO_x (x = 1-3).

J. Appl. Phys. **89**, 1915 (2001)

e + WO	Ionization	0.01-1.00 keV	Th
e + WO ₂	Ionization	0.01-1.00 keV	Th
e + WO ₃	Ionization	0.01-1.00 keV	Th
e + O Al	Ionization	0.01-1.00 keV	Th
e + Al ₂ O	Ionization	0.01-1.00 keV	Th

375. C. Tang, Z. An, Z. Luo, M. Liu

Measurements of germanium K-shell ionization cross sections and tin L-shell x-ray production cross sections by electron impact.

J. Appl. Phys. **91**, 6739 (2002)

e + Ge	Excitation	5.00-65.00 keV	E/T
e + Sn	Excitation	5.00-65.00 keV	E/T
e + Ge	Ionization	5.00-65.00 keV	E/T
e + Sn	Ionization	5.00-65.00 keV	E/T

376. R. Peverall, S. Rosen, J. R. Peterson, M. Larsson, A. Al-Khalili, L. Vikor, J. Semaniak, R. Bobbenkamp, A. Le Padellec, A. N. Maurellis, W. J. Van der Zande

Dissociative recombination and excitation of O₂⁺: Cross sections, product yields and implications for studies of ionospheric airglows.

J. Chem. Phys. **114**, 6679 (2001)

e + O ₂ ¹⁺	Dissociation	0.00-3.00 eV	Ex
e + O ₂ ¹⁺	Recombination	0.00-3.00 eV	Ex
e + O ₂ ¹⁺	Excitation	0.00-3.00 eV	Ex

377. A. Le Padellec, F. Rabilloud, D. Pegg, A. Neau, F. Heilberg, R. V. Thomas, H. T. Schmidt, M. O. Larsson, H. Danared, A. Kaelberg, K. Andersson, D. Hanstorp

Electron-impact detachment and dissociation of C₄⁻ ions.

J. Chem. Phys. **115**, 10671 (2001)

e + C ₄ ⁻¹⁺	Ionization	40.00 eV	Ex
-----------------------------------	------------	----------	----

378. L. H. Andersen, J. Bak, S. Boye, M. Clausen, M. Hovgaard, M. J. Jensen, A. Lapierre, K. Seiersen

Resonant and nonresonant electron impact detachment of CH⁻ and BO⁻.

J. Chem. Phys. **115**, 3566 (2001)

e + BO ⁻¹⁺	Detachment	40.00 eV	Ex
e + CN ⁻¹⁺	Detachment	40.00 eV	Ex
e + BO ⁻¹⁺	Ionization	40.00 eV	Ex
e + CN ⁻¹⁺	Ionization	40.00 eV	Ex
e + BO ⁻¹⁺	Dissociation	40.00 eV	Ex
e + CN ⁻¹⁺	Dissociation	40.00 eV	Ex

379. I. Torres, R. Martinez, M. N. Sanchez Rayo, F. Castano

Evaluation of the computational methods for electron-impact total ionization cross sections: Fluoromethanes as benchmarks.

J. Chem. Phys. **115**, 4041 (2001)

- | | | | |
|-----------------------------|------------|-----------|----|
| $e + \text{CF}_4$ | Ionization | 500.00 eV | Th |
| $e + \text{CHF}_3$ | Ionization | 500.00 eV | Th |
| $e + \text{CH}_2\text{F}_2$ | Ionization | 500.00 eV | Th |
| $e + \text{CH}_3\text{F}$ | Ionization | 500.00 eV | Th |
380. R. Rejoub, B. G. Lindsay, R. F. Stebbings
Electron-impact ionization of NH_3 and ND_3 .
 J. Chem. Phys. **115**, 5053 (2001)
- | | | | |
|-------------------|------------|----------|----|
| $e + \text{NH}_3$ | Ionization | 1.00 keV | Ex |
| $e + \text{ND}_3$ | Ionization | 1.00 keV | Ex |
381. T. Harb, W. Kedzierski, J. W. McConkey
Production of ground state OH following electron impact on H_2O .
 J. Chem. Phys. **115**, 5507 (2000)
- | | | | |
|--------------------------|--------------|-----------|-----|
| $e + \text{H}_2\text{O}$ | Dissociation | 300.00 eV | E/T |
|--------------------------|--------------|-----------|-----|
382. C. Winstead, V. McKoy
Low-energy electron collisions with tetrafluoroethene, C_2F_4 .
 J. Chem. Phys. **116**, 1380 (2002)
- | | | | |
|----------------------------|--------------------|----------|----|
| $e + \text{C}_2\text{F}_4$ | Excitation | 50.00 eV | Th |
| $e + \text{C}_2\text{F}_4$ | Elastic Scattering | 50.00 eV | Th |
383. G. Hanel, B. Gstir, T. Fiegele, F. Hagelberg, K. Becker, P. Scheier, A. Snegursky, T. D. Maerk
Isotope effects in the electron impact ionization of H_2/D_2 , $\text{H}_2\text{O}/\text{D}_2\text{O}$, and $\text{C}_6\text{H}_6/\text{C}_6\text{D}_6$ near threshold.
 J. Chem. Phys. **116**, 2456 (2002)
- | | | | |
|----------------------------|------------|----------|-----|
| $e + \text{H}_2$ | Ionization | 20.00 eV | E/T |
| $e + \text{H}_2\text{O}$ | Ionization | 20.00 eV | E/T |
| $e + \text{D}_2$ | Ionization | 20.00 eV | E/T |
| $e + \text{D}_2\text{O}$ | Ionization | 20.00 eV | E/T |
| $e + \text{C}_6\text{H}_6$ | Ionization | 20.00 eV | E/T |
| $e + \text{C}_6\text{D}_6$ | Ionization | 20.00 eV | E/T |
384. C. Q. Jiao, C. A. DeJoseph, A. Garscadden
Absolute cross sections for electron impact ionization of NO_2 .
 J. Chem. Phys. **117**, 161 (2002)
- | | | | |
|-------------------|------------|-----------|----|
| $e + \text{NO}_2$ | Ionization | 200.00 eV | Ex |
|-------------------|------------|-----------|----|
385. C. Champion, J. Hanssen, P. A. Hervieux
Electron impact ionization of water molecule.
 J. Chem. Phys. **117**, 197 (2002)
- | | | | |
|--------------------------|------------|----------------|----|
| $e + \text{H}_2\text{O}$ | Ionization | 0.01-10.00 keV | Th |
|--------------------------|------------|----------------|----|
386. C. Mair, H. Deutsch, K. H. Becker, T. D. Maerk, E. Vietzke
Detection of sputtered and evaporated carbon aggregates: relative and absolute electron ionization fragmentation yields.
 J. Nucl. Mater. **290-293**, 291 (2001)
- | | | | |
|------------------|--------------|-----------------|----|
| $e + \text{C}_2$ | Dissociation | 70.00-250.00 eV | Ex |
| $e + \text{C}_3$ | Dissociation | 70.00-250.00 eV | Ex |
| $e + \text{C}_2$ | Ionization | 70.00-250.00 eV | Ex |
| $e + \text{C}_3$ | Ionization | 70.00-250.00 eV | Ex |
387. G.G.B de Souza, M.L.M Rocco, H. M. Boechat-Roberty, C. A. Lucas, Jr. Borges, I., E. Hollauer
Valence electronic excitation of the SiF_4 molecule: generalized oscillator strength for the $5t_2 \rightarrow 6a_1$ transition and ab initio calculation.
 J. Phys. B **34**, 1005 (2001)

- | | | | |
|--------------------|--------------------|----------|----|
| $e + \text{SiF}_4$ | Angular Scattering | 1.00 keV | Ex |
| $e + \text{SiF}_4$ | Excitation | 1.00 keV | Ex |
388. H. Cho, R. J. Gulley, K. Sunohara, M. Kitajima, L. J. Uhlmann, H. Tanaka, S. J. Buckman
Elastic electron scattering from C_6H_6 and C_6F_6 .
 J. Phys. B **34**, 1019 (2001)
- | | | | |
|----------------------------|--------------------|----------------|----|
| $e + \text{C}_6\text{H}_6$ | Angular Scattering | 1.10-100.00 eV | Ex |
| $e + \text{C}_6\text{F}_6$ | Angular Scattering | 1.10-100.00 eV | Ex |
| $e + \text{C}_6\text{H}_6$ | Elastic Scattering | 1.10-100.00 eV | Ex |
| $e + \text{C}_6\text{F}_6$ | Elastic Scattering | 1.10-100.00 eV | Ex |
389. K. A. Stockman, V. Karaganov, I. Bray, P.J.O. Teubner
Electron scattering from laser excited states of potassium at 3-100 eV.
 J. Phys. B **34**, 1105 (2001)
- | | | | |
|------------------|--------------------|---------------|-----|
| $e + \text{K}^*$ | Angular Scattering | 4.00-80.00 eV | E/T |
| $e + \text{K}$ | Angular Scattering | 4.00-80.00 eV | E/T |
| $e + \text{K}^*$ | Elastic Scattering | 4.00-80.00 eV | E/T |
| $e + \text{K}$ | Elastic Scattering | 4.00-80.00 eV | E/T |
390. L. Campbell, M. J. Brunger, A. M. Nolan, L. J. Kelly, A. B. Wedding, J. Harrison, P.J.O. Teubner, D. C. Cartwright, B. M. McLaughlin
Integral cross sections for electron impact excitation of electronic states of N_2 .
 J. Phys. B **34**, 1185 (2001)
- | | | | |
|--------------------|--------------------|----------------|-----|
| $e + \text{N}_2^*$ | Angular Scattering | 15.00-50.00 eV | E/T |
| $e + \text{N}_2$ | Angular Scattering | 15.00-50.00 eV | E/T |
| $e + \text{N}_2^*$ | Excitation | 15.00-50.00 eV | E/T |
| $e + \text{N}_2$ | Excitation | 15.00-50.00 eV | E/T |
391. M. Mattioli, K. B. Fournier, L. Carraro, I. H. Coffey, C. Giroud, K. D. Lawson, P. Monier-Garbet, M. O'Mullane, J. Ongena, M. E. Puiatti, F. Sattin, P. Scarin, M. Valisa
Experimental and simulated argon spectra in the 2.3-3.4 nm region from tokamak plasmas.
 J. Phys. B **34**, 127 (2001)
- | | | | |
|-----------------------|-----------------|---------------|-----|
| $e + \text{Ar}^{11+}$ | Line Broadening | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{12+}$ | Line Broadening | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{13+}$ | Line Broadening | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{14+}$ | Line Broadening | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{15+}$ | Line Broadening | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{11+}$ | De-excitation | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{12+}$ | De-excitation | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{13+}$ | De-excitation | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{14+}$ | De-excitation | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{15+}$ | De-excitation | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{11+}$ | Excitation | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{12+}$ | Excitation | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{13+}$ | Excitation | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{14+}$ | Excitation | 0.20-3.00 keV | E/T |
| $e + \text{Ar}^{15+}$ | Excitation | 0.20-3.00 keV | E/T |
392. R. Rejoub, D. R. Sieglaff, B. G. Lindsay, R. F. Stebbings
Absolute partial cross sections for electron-impact ionization of SF_6 from threshold to 1000 eV.
 J. Phys. B **34**, 1289 (2001)
- | | | | |
|-------------------|------------|---------------|----|
| $e + \text{SF}_6$ | Ionization | 0.02-1.00 keV | Ex |
|-------------------|------------|---------------|----|
393. O. Zatsarinny, S. S. Tayal
Low-energy electron collisions with atomic oxygen: R-matrix calculation with non-orthogonal orbitals.
 J. Phys. B **34**, 1299 (2001)

- | | | | |
|-----------|--------------------|---------------|----|
| $e + O^*$ | Excitation | 2.00-30.00 eV | Th |
| $e + O$ | Excitation | 2.00-30.00 eV | Th |
| $e + O^*$ | Elastic Scattering | 2.00-30.00 eV | Th |
| $e + O$ | Elastic Scattering | 2.00-30.00 eV | Th |
394. H. Drexel, G. Senn, T. Fiegele, P. Scheier, A. Stamatovic, N. J. Mason, T. D. Mark
Dissociative electron attachment to hydrogen.
 J. Phys. B **34**, 1415 (2001)
- | | | | |
|-----------|--------------|--------------|----|
| $e + H_2$ | Dissociation | 3.75-5.00 eV | Ex |
| $e + H_2$ | Attachment | 3.75-5.00 eV | Ex |
395. N. C. Deb, D.S.F Crothers
Electron impact ionization of He above the threshold.
 J. Phys. B **34**, 143 (2001)
- | | | | |
|----------|------------|----------|----|
| $e + He$ | Ionization | 25.00 eV | Th |
|----------|------------|----------|----|
396. A. K. Edwards, Q. Zheng
Excitation of the $Q_1^{-1}\Sigma_g^+$ doubly excited state of H_2 by electron impact.
 J. Phys. B **34**, 1539 (2001)
- | | | | |
|-----------|------------|-----------|----|
| $e + H_2$ | Ionization | 400.00 eV | Ex |
| $e + H_2$ | Excitation | 400.00 eV | Ex |
397. P. W. Zetner, P. V. Johnson, Y. Li, G. Csanak, R.E.H. Clark, Jr. Abdallah, J.
Electron impact excitation of the ($6s6p\ ^3P_J$) levels in ytterbium.
 J. Phys. B **34**, 1619 (2001)
- | | | | |
|----------|------------|----------|-----|
| $e + Yb$ | Excitation | 60.00 eV | E/T |
|----------|------------|----------|-----|
398. I. Kanik, P. V. Johnson, G. K. James
Electron-impact-induced emission and excitation cross sections of xenon at low energies.
 J. Phys. B **34**, 1685 (2001)
- | | | | |
|----------|------------|-----------------|----|
| $e + Xe$ | Excitation | 10.00-100.00 eV | Ex |
|----------|------------|-----------------|----|
399. F. A. Gianturco, T. Stoecklin
Low-energy electron scattering from CO_2 molecules: elastic channel calculations revisited.
 J. Phys. B **34**, 1695 (2001)
- | | | | |
|------------|--------------------|----------------|----|
| $e + CO_2$ | Angular Scattering | 0.01-100.00 eV | Th |
| $e + CO_2$ | Elastic Scattering | 0.01-100.00 eV | Th |
400. M. Khouilid, S. Cherkani-Hassani, S. Rachafi, H. Teng, P. Defrance
Electron-impact single ionization of krypton ions ($q=12-18$).
 J. Phys. B **34**, 1727 (2001)
- | | | | |
|----------------|------------|----------|----|
| $e + Kr^{12+}$ | Ionization | 5.50 keV | Ex |
| $e + Kr^{13+}$ | Ionization | 5.50 keV | Ex |
| $e + Kr^{14+}$ | Ionization | 5.50 keV | Ex |
| $e + Kr^{15+}$ | Ionization | 5.50 keV | Ex |
| $e + Kr^{16+}$ | Ionization | 5.50 keV | Ex |
| $e + Kr^{17+}$ | Ionization | 5.50 keV | Ex |
| $e + Kr^{18+}$ | Ionization | 5.50 keV | Ex |
401. A. Riahi, K. Laghdas, R.H.G. Reid, S. Rachafi, C. J. Joachain, P. Defrance
Electron-impact ionization of Ne^{7+} .
 J. Phys. B **34**, 175 (2001)
- | | | | |
|---------------|------------|------------------|----|
| $e + Ne^{7+}$ | Ionization | 10.00-80.00 a.u. | Th |
|---------------|------------|------------------|----|
402. E. M. Bahati, J. J. Jureta, D. S. Belic, S. Rachafi, P. Defrance
Electron impact ionization and dissociation of CO_2^+ to C^+ and O^+ .
 J. Phys. B **34**, 1757 (2001)

- | | | | | |
|--|------------------------|--------------|----------|----|
| | $e + \text{CO}_2^{1+}$ | Dissociation | 2.50 keV | Ex |
| | $e + \text{CO}_2^{1+}$ | Ionization | 2.50 keV | Ex |
403. T. Kroin, S. E. Michelin, M.-T. Lee
A distorted-wave study for core-excitation processes in CO by electron impact.
J. Phys. B **34**, 1829 (2001)
- | | | | | |
|--|-----------------|--------------------|------------------|----|
| | $e + \text{CO}$ | Angular Scattering | 297.00-900.00 eV | Th |
| | $e + \text{CO}$ | Excitation | 297.00-900.00 eV | Th |
404. M. Kitajima, S. Watanabe, H. Tanaka, M. Takekawa, M. Kimura, Y. Itikawa
Differential cross sections for vibrational excitation of CO₂ by 1.5-30 eV electrons.
J. Phys. B **34**, 1929 (2001)
- | | | | | |
|--|-------------------|--------------------|---------------|----|
| | $e + \text{CO}_2$ | Excitation | 1.50-30.00 eV | Ex |
| | $e + \text{CO}_2$ | Angular Scattering | 1.50-30.00 eV | Ex |
| | $e + \text{CO}_2$ | Elastic Scattering | 1.50-30.00 eV | Ex |
405. A. Cionga, F. Ehlotzky, G. Zloh
Coherent phase control in electron scattering by hydrogen atoms in a bichromatic laser field.
J. Phys. B **34**, 2057 (2001)
- | | | | | |
|--|----------------|--------------------|-----------|----|
| | $e + \text{H}$ | Angular Scattering | 100.00 eV | Th |
|--|----------------|--------------------|-----------|----|
406. R. Srivastava, R. P. McEachran, A. D. Stauffer
Excitation of the D states of magnesium.
J. Phys. B **34**, 2071 (2001)
- | | | | | |
|--|-----------------|------------|----------------|----|
| | $e + \text{Mg}$ | Excitation | 20.00-40.00 eV | Ex |
|--|-----------------|------------|----------------|----|
407. B. M. McLaughlin, K. P. Kirby
Electron collisional excitation of the $1s^2 2s^2 2p^3$ ($^4S^0_{3/2}$, $^2D^0_{5/2,3/2}$, $^2P^0_{3/2,1/2}$) fine-structure levels in Fe¹⁹⁺ ions.
J. Phys. B **34**, 2255 (2001)
- | | | | | |
|--|-----------------------|------------|---------------|----|
| | $e + \text{Fe}^{19+}$ | Excitation | 0.10-100.00 K | Th |
|--|-----------------------|------------|---------------|----|
408. N. Igual-Ruiz, B. P. Donnelly, D. T. McLaughlin, D. Cvejanovic, A. Crowe, D. V. Fursa, K. Bartschat, I. Bray
Experimental and theoretical study of electron impact excitation of the 3^3P state of helium.
J. Phys. B **34**, 2289 (2001)
- | | | | | |
|--|-----------------|------------|----------------|-----|
| | $e + \text{He}$ | Excitation | 55.00-60.00 eV | E/T |
|--|-----------------|------------|----------------|-----|
409. X.-D. Li, C. Wang, S.-S. Han, Z.-Z. Xu, Z.-H. Zhu, M.-L. Tan
Calculation of the relative abundance between He-like and Li-like Cr under coronal conditions.
J. Phys. B **34**, 2537 (2001)
- | | | | | |
|--|-----------------------|---------------|-----------|----|
| | $e + \text{Cr}^{21+}$ | Recombination | 20.00 keV | Th |
| | $e + \text{Cr}^{22+}$ | Recombination | 20.00 keV | Th |
| | $e + \text{Cr}^{21+}$ | Ionization | 20.00 keV | Th |
410. A. L. Godunov, H. Merabet, J. H. McGuire, R. F. Bruch, J. Hanni, V. S. Schipakov
Magnetic sublevel population in 1s-2p excitation of helium by fast electrons and protons.
J. Phys. B **34**, 2575 (2001)
- | | | | | |
|--|-----------------|------------|----------------|-----|
| | $e + \text{He}$ | Excitation | 3.00-8.50 a.u. | E/T |
|--|-----------------|------------|----------------|-----|
411. I. Kanik, P. V. Johnson, M. B. Das, M. A. Khakoo, S. S. Tayal
Electron-impact studies of atomic oxygen: I. Differential and integral cross sections; experiment and theory.
J. Phys. B **34**, 2647 (2001)

- | | | | | |
|--|---------|--------------------|-----------------|-----|
| | $e + O$ | Angular Scattering | 30.00-100.00 eV | E/T |
| | $e + O$ | Excitation | 30.00-100.00 eV | E/T |
412. C. Noren, I. Kanik, P. V. Johnson, P. McCartney, G. K. James, J. M. Ajello
Electron-impact studies of atomic oxygen: II. Emission cross section measurements of the $O\ I\ ^3S^0 \rightarrow\ ^3P$ transition (130.4 nm).
J. Phys. B **34**, 2667 (2001)
- | | | | | |
|--|---------|--------------|---------------|----|
| | $e + O$ | Fluorescence | 0.01-1.00 keV | Ex |
| | $e + O$ | Excitation | 0.01-1.00 keV | Ex |
413. M. Musigmann, K. Blum, D. G. Thompson
Scattering of polarized electrons from anisotropic chiral ensembles.
J. Phys. B **34**, 2679 (2001)
- | | | | | |
|--|--------------|--------------------|---------|----|
| | $e + H_2S_2$ | Angular Scattering | 5.00 eV | Th |
| | $e + H_2S_2$ | Elastic Scattering | 5.00 eV | Th |
414. Y. Fang, K. Bartschat
Resonance effects in electron-impact ionization of helium.
J. Phys. B **34**, 2747 (2001)
- | | | | | |
|--|----------|------------|------------------|----|
| | $e + He$ | Ionization | 100.00-400.00 eV | Th |
|--|----------|------------|------------------|----|
415. K. L. Baluja, N. J. Mason, L. A. Morgan, J. Tennyson
Electron collisions with Cl_2O using the R-matrix method.
J. Phys. B **34**, 2807 (2001)
- | | | | | |
|--|-------------|--------------------|-----------|----|
| | $e + Cl_2O$ | Excitation | 100.00 eV | Th |
| | $e + Cl_2O$ | Elastic Scattering | 100.00 eV | Th |
416. C. S. Trevisan, J. Tennyson
Differential cross sections for near-threshold electron impact dissociation of molecular hydrogen.
J. Phys. B **34**, 2935 (2001)
- | | | | | |
|--|-----------|--------------------|---------------|----|
| | $e + H_2$ | Angular Scattering | 7.50-14.50 eV | Th |
| | $e + H_2$ | Excitation | 7.50-14.50 eV | Th |
| | $e + H_2$ | Dissociation | 7.50-14.50 eV | Th |
417. E. M. Bahati, J. J. Jureta, D. S. Belic, H. Cherkani-Hassani, M. O. Abdellahi, P. Defrance
Electron impact dissociation and ionization of N_2^+ .
J. Phys. B **34**, 2963 (2001)
- | | | | | |
|--|----------------|--------------|----------|----|
| | $e + N_2^{1+}$ | Ionization | 2.50 keV | Ex |
| | $e + N_2^{1+}$ | Dissociation | 2.50 keV | Ex |
418. K. Muktaavat, M. K. Srivastava
A comparative study of the (e,3e) process on H^- , He and Li^+ .
J. Phys. B **34**, 2975 (2001)
- | | | | | |
|--|---------------|--------------------|----------|----|
| | $e + H^{-1+}$ | Angular Scattering | 5.60 keV | Th |
| | $e + He$ | Angular Scattering | 5.60 keV | Th |
| | $e + Li^{1+}$ | Angular Scattering | 5.60 keV | Th |
| | $e + H^{-1+}$ | Ionization | 5.60 keV | Th |
| | $e + He$ | Ionization | 5.60 keV | Th |
| | $e + Li^{1+}$ | Ionization | 5.60 keV | Th |
419. J. E. Hudson, C. Vallance, M. Bart, P. W. Harland
Absolute electron-impact ionization cross sections for a range of C_1 to C_5 chlorocarbons.
J. Phys. B **34**, 3025 (2001)

$e + C_2HCl_3$	Ionization	220.00 eV	Ex
$e + C_2HCl_5$	Ionization	220.00 eV	Ex
$e + C_2H_2Cl_2$	Ionization	220.00 eV	Ex
$e + C_2H_2Cl_4$	Ionization	220.00 eV	Ex
$e + C_2H_3Cl_3$	Ionization	220.00 eV	Ex
$e + C_2H_4Cl_2$	Ionization	220.00 eV	Ex
$e + C_2H_5Cl$	Ionization	220.00 eV	Ex
$e + C_3H_7Cl$	Ionization	220.00 eV	Ex
$e + C_4H_9Cl$	Ionization	220.00 eV	Ex
$e + C_2Cl_2$	Ionization	220.00 eV	Ex
$e + C_2Cl_4$	Ionization	220.00 eV	Ex
$e + C_2Cl_6$	Ionization	220.00 eV	Ex
$e + C_2Cl_6$	Ionization	220.00 eV	Ex
$e + CCl_4$	Ionization	220.00 eV	Ex
$e + CH_3Cl$	Ionization	220.00 eV	Ex

420. P. V. Johnson, I. Kanik

Inelastic differential electron scattering cross sections of molecular oxygen (O_2) in the 20-100 eV impact energy range.

J. Phys. B **34**, 3041 (2001)

$e + O_2$	Angular Scattering	20.00-100.00 eV	Ex
$e + O_2$	Ionization	20.00-100.00 eV	Ex
$e + O_2$	Excitation	20.00-100.00 eV	Ex

421. K. L. Baluja, A. Z. Msezane

Electron collisions with methylidyne (CH) radical using the R-matrix method.

J. Phys. B **34**, 3057 (2001)

$e + CH$	Excitation	10.00 eV	Th
$e + CH$	Elastic Scattering	10.00 eV	Th

422. A. Lahmam-Bennani, A. Duguet, M. N. Gaboriaud, I. Taouil, M. Lecas, A. Kheifets, J. Berakdar, C. Dal Cappello

Complete experiments for the double ionization of He: ($e,3e$) cross sections at 1 keV impact energy and small momentum transfer.

J. Phys. B **34**, 3073 (2001)

$e + He$	Angular Scattering	1.10 keV	Ex
$e + He$	Ionization	1.10 keV	Ex

423. A. D. Whiteford, N. R. Badnell, C. P. Ballance, M. G. O'Mullane, H. P. Summers, A. L. Thomas

A radiation-damped R-matrix approach to the electron-impact excitation of helium-like ions for diagnostic application to fusion and astrophysical plasmas.

J. Phys. B **34**, 3179 (2001)

$e + Fe^{24+}$	Excitation	$10^{5.5}-10^9$ K	Th
$e + A^{16+}$	Excitation	$10^{5.5}-10^9$ K	Th

424. M. Khouilid, S. Cherkani-Hassani, N. Adimi, S. Rachafi, P. Defrance

Electron impact double ionization of krypton ions ($q=14-17$).

J. Phys. B **34**, 3239 (2001)

$e + Kr^{14+}$	Ionization	5.00 keV	Ex
$e + Kr^{15+}$	Ionization	5.00 keV	Ex
$e + Kr^{16+}$	Ionization	5.00 keV	Ex
$e + Kr^{17+}$	Ionization	5.00 keV	Ex

425. C. P. Ballance, N. R. Badnell, K. A. Berrington

Inner-shell processes of Li- and Be-like Fe.

J. Phys. B **34**, 3287 (2001)

- | | | | |
|-----------------------|------------|------------------|----|
| $e + \text{Fe}^{22+}$ | Excitation | 138.00-800.00 Ry | Th |
| $e + \text{Fe}^{23+}$ | Excitation | 138.00-800.00 Ry | Th |
426. W. Kedzierski, A. Abdellatif, J. W. McConkey, K. Bartschat, D. V. Fursa, I. Bray
Polarization of Balmer- α radiation following electron impact on atomic hydrogen.
J. Phys. B **34**, 3367 (2001)
- | | | | |
|----------------|------------|---------------|-----|
| $e + \text{H}$ | Excitation | 0.01-1.00 keV | E/T |
|----------------|------------|---------------|-----|
427. B. Gstir, H. Deutsch, K. H. Becker, T. D. Mark
Calculated cross sections for the K-shell ionization of chromium, nickel, copper, scandium and vanadium using the DM formalism.
J. Phys. B **34**, 3377 (2001)
- | | | | |
|-----------------|------------|-----------------------|-----|
| $e + \text{Sc}$ | Ionization | 1-7 E/E _{1s} | E/T |
| $e + \text{V}$ | Ionization | 1-7 E/E _{1s} | E/T |
| $e + \text{Cr}$ | Ionization | 1-7 E/E _{1s} | E/T |
| $e + \text{Ni}$ | Ionization | 1-7 E/E _{1s} | E/T |
| $e + \text{Cu}$ | Ionization | 1-7 E/E _{1s} | E/T |
428. O. Zatsarinny, S. S. Tayal
Low-energy electron collisions with atomic sulfur: R-matrix calculation with non-orthogonal orbitals.
J. Phys. B **34**, 3383 (2001)
- | | | | |
|----------------|--------------------|--------------|----|
| $e + \text{S}$ | Angular Scattering | 0.25-3.50 Ry | Th |
| $e + \text{S}$ | Excitation | 0.25-3.50 Ry | Th |
429. T. Beyer, B. M. Nestmann, S. D. Peyerimhoff
Resonant features of inelastic electron scattering off CF₃Cl in the low-energy region.
J. Phys. B **34**, 3703 (2001)
- | | | | |
|----------------------------|--------------|---------|----|
| $e + \text{CF}_3\text{Cl}$ | Attachment | 3.00 eV | Th |
| $e + \text{CF}_3\text{Cl}$ | Excitation | 3.00 eV | Th |
| $e + \text{CF}_3\text{Cl}$ | Dissociation | 3.00 eV | Th |
430. Ol. Moreira, D. G. Thompson, B. M. McLaughlin
Vibrational excitation of H₂O by electron impact.
J. Phys. B **34**, 3737 (2001)
- | | | | |
|--------------------------|--------------------|--------------|----|
| $e + \text{H}_2\text{O}$ | Angular Scattering | 1.00-7.80 eV | Th |
| $e + \text{H}_2\text{O}$ | Excitation | 1.00-7.80 eV | Th |
431. C. P. Ballance, K. A. Berrington, B. M. McLaughlin
Rydberg structure associated with core-excited autoionizing states of the LiH radical.
J. Phys. B **34**, 3775 (2001)
- | | | | |
|-----------------------|------------|----------------|----|
| $e + \text{LiH}^{1+}$ | Excitation | 52.00-65.00 eV | Th |
|-----------------------|------------|----------------|----|
432. G. Poparic, M. Vivic, D. S. Belic
Near-threshold excitation of the b ³ Σ^+ state of carbon-monoxide by electron impact.
J. Phys. B **34**, 381 (2001)
- | | | | |
|-----------------|--------------------|----------------|----|
| $e + \text{CO}$ | Angular Scattering | 10.00-15.00 eV | Ex |
| $e + \text{CO}$ | Excitation | 10.00-15.00 eV | Ex |
433. D. Klar, M.-W. Ruf, I. I. Fabrikant, H. Hotop
Dissociative electron attachment to dipolar molecules at low energies with meV resolution: CFCl₃, 1,1,1-C₂Cl₃F₃, and HI.
J. Phys. B **34**, 3855 (2001)

- | | | | |
|---------------------------------------|--------------|--------------|-----|
| $e + \text{HI}$ | Dissociation | 0.00-4.00 eV | E/T |
| $e + \text{CFCl}_3$ | Dissociation | 0.00-4.00 eV | E/T |
| $e + \text{C}_2\text{Cl}_3\text{F}_3$ | Dissociation | 0.00-4.00 eV | E/T |
| $e + \text{HI}$ | Attachment | 0.00-4.00 eV | E/T |
| $e + \text{CFCl}_3$ | Attachment | 0.00-4.00 eV | E/T |
| $e + \text{C}_2\text{Cl}_3\text{F}_3$ | Attachment | 0.00-4.00 eV | E/T |
434. D. H. Yu, L. Pravica, J. F. Williams, N. Warrington, P. A. Hayes
Polarized electron inner-shell ionization-with-excitation of zinc atoms.
 J. Phys. B **34**, 3899 (2001)
- | | | | |
|-----------------|------------|----------------|----|
| $e + \text{Zn}$ | Ionization | 17.00-23.00 eV | Ex |
| $e + \text{Zn}$ | Excitation | 17.00-23.00 eV | Ex |
435. M. R. Tarbutt, R. Barnsley, N. J. Peacock, J. D. Silver
Wavelength measurements of the satellite transitions to the $n = 2$ resonance lines of helium-like argon.
 J. Phys. B **34**, 3979 (2001)
- | | | | |
|-----------------------|---------------|---------------|-----|
| $e + \text{Ar}^{15+}$ | De-excitation | 2.24-4.10 keV | E/T |
| $e + \text{Ar}^{15+}$ | Recombination | 2.24-4.10 keV | E/T |
| $e + \text{Ar}^{15+}$ | Excitation | 2.24-4.10 keV | E/T |
436. B. O'Rourke, F. J. Currell, H. Kuramoto, Y. M. Li, S. Ohtani, X. M. Tong, H. Watanabe
Electron-impact ionization of hydrogen-like iron ions.
 J. Phys. B **34**, 4003 (2001)
- | | | | |
|-----------------------|------------|-----------------|-----|
| $e + \text{Fe}^{25+}$ | Ionization | 10.00-50.00 keV | E/T |
|-----------------------|------------|-----------------|-----|
437. W. Kedzierski, J. Borbely, J. W. McConkey
Electron impact dissociation of OCS.
 J. Phys. B **34**, 4027 (2001)
- | | | | |
|------------------|--------------|-----------------|----|
| $e + \text{OCS}$ | Dissociation | 10.00-400.00 eV | Ex |
|------------------|--------------|-----------------|----|
438. K. Aichele, M. Steidl, U. Hartenfeller, D. Hathiramani, F. Scheuermann, M. Westermann, E. Salzborn, M. S. Pindzola
Electron-impact single ionization of multiply charged aluminium ions.
 J. Phys. B **34**, 4113 (2001)
- | | | | |
|----------------------|------------|----------|-----|
| $e + \text{Al}^{3+}$ | Ionization | 5.50 keV | E/T |
| $e + \text{Al}^{4+}$ | Ionization | 5.50 keV | E/T |
| $e + \text{Al}^{5+}$ | Ionization | 5.50 keV | E/T |
| $e + \text{Al}^{6+}$ | Ionization | 5.50 keV | E/T |
| $e + \text{Al}^{7+}$ | Ionization | 5.50 keV | E/T |
439. H. Kuest, W. Mehlhorn
Alignment after L_3 ionization of Xe atoms by electron impact near threshold.
 J. Phys. B **34**, 4155 (2001)
- | | | | |
|-----------------|------------|---------------|----|
| $e + \text{Xe}$ | Excitation | 5.00-6.00 keV | Ex |
| $e + \text{Xe}$ | Ionization | 5.00-6.00 keV | Ex |
440. P. V. Johnson, C. Spanu, P. W. Zetner
Transferred orbital angular momentum in the low-energy electron impact excitation of the $^1\text{S}_0$ - $^1\text{P}_1$ transition in barium.
 J. Phys. B **34**, 4311 (2001)
- | | | | |
|-------------------|---------------|---------------|----|
| $e + \text{Ba}$ | De-excitation | 7.00-16.00 eV | Ex |
| $e + \text{Ba}^*$ | De-excitation | 7.00-16.00 eV | Ex |
441. D. C. Griffin, D. M. Mitnik, N. R. Badnell
Electron-impact excitation of Ne^+ .
 J. Phys. B **34**, 4401 (2001)

	$e + \text{Ne}^{1+}$	Excitation	60.00 eV	Th
442.	D. M. Mitnik, D. C. Griffin, N. R. Badnell Electron-impact excitation of Ne^{5+}. J. Phys. B 34 , 4455 (2001)			
	$e + \text{Ne}^{5+}$	Excitation	15.00 Ry	Th
443.	B. M. McLaughlin, K. P. Kirby, R. Smith, N. Brickhouse, D. A. Liedahl Electron collisional excitation of the low-lying fine-structure levels in oxygen-like Fe^{18+}. J. Phys. B 34 , 4521 (2001)			
	$e + \text{Fe}^{18+}$	Excitation	1.00 Ry	Th
444.	T. Odagiri, K. Takahashi, K. Yoshikawa, N. Kouchi, Y. Hatano Forbidden doubly excited states of molecular nitrogen dissociating into two neutral atoms in electron collisions. J. Phys. B 34 , 4889 (2001)			
	$e + \text{N}_2$	Dissociation	80.00-150.00 eV	Ex
	$e + \text{N}_2$	Excitation	80.00-150.00 eV	Ex
445.	P. Defrance, T. M. Kereselidze, I. L. Noselidze, M. F. Tzulukidze Asymptotic behaviour of the total cross section for double ionization of helium-like ions by electrons. J. Phys. B 34 , 4957 (2001)			
	$e + \text{He}$	Ionization	0.50-10.00 keV	E/T
	$e + \text{Li}^{1+}$	Ionization	0.50-10.00 keV	E/T
	$e + \text{Be}^{2+}$	Ionization	0.50-10.00 keV	E/T
	$e + \text{Be}^{2+}$	Ionization	0.50-10.00 keV	E/T
	$e + \text{B}^{3+}$	Ionization	0.50-10.00 keV	E/T
	$e + \text{C}^{4+}$	Ionization	0.50-10.00 keV	E/T
	$e + \text{N}^{5+}$	Ionization	0.50-10.00 keV	E/T
446.	A. L. Godunov, J. H. McGuire, P. B. Ivanov, V. A. Shipakov, H. Merabet, R. Bruch, J. Hanni, Kh. Kh. Shakov Spatial and temporal correlation in dynamic, multi-electron quantum systems. J. Phys. B 34 , 5055 (2001)			
	$e + \text{He}$	Ionization	2.00-8.00 a.u.	Th
	$e + \text{He}$	Excitation	2.00-8.00 a.u.	Th
447.	N. R. Badnell, D. C. Griffin, D. M. Mitnik Electron-impact excitation of Fe^{21+}, including $n = 4$ levels. J. Phys. B 34 , 5071 (2001)			
	$e + \text{Fe}^{21+}$	Excitation	30.00 Ry	Th
448.	K. N. Joshipura, M. Vinodkumar, U. M. Patel Electron impact total cross sections of CH_x, NH_x and OH radicals vis-vis their parent molecules. J. Phys. B 34 , 509 (2001)			
	$e + \text{CH}$	Ionization	0.01-2.00 keV	Th
	$e + \text{CH}_2$	Ionization	0.01-2.00 keV	Th
	$e + \text{CH}_3$	Ionization	0.01-2.00 keV	Th
	$e + \text{CH}_4$	Ionization	0.01-2.00 keV	Th
	$e + \text{NH}$	Ionization	0.01-2.00 keV	Th
	$e + \text{NH}_2$	Ionization	0.01-2.00 keV	Th
	$e + \text{NH}_3$	Ionization	0.01-2.00 keV	Th
	$e + \text{OH}$	Ionization	0.01-2.00 keV	Th
	$e + \text{CH}$	Excitation	0.01-2.00 keV	Th

e + CH ₂	Excitation	0.01-2.00 keV	Th
e + CH ₃	Excitation	0.01-2.00 keV	Th
e + CH ₄	Excitation	0.01-2.00 keV	Th
e + NH	Excitation	0.01-2.00 keV	Th
e + NH ₂	Excitation	0.01-2.00 keV	Th
e + NH ₃	Excitation	0.01-2.00 keV	Th
e + OH	Excitation	0.01-2.00 keV	Th
e + CH	Elastic Scattering	0.01-2.00 keV	Th
e + CH ₂	Elastic Scattering	0.01-2.00 keV	Th
e + CH ₃	Elastic Scattering	0.01-2.00 keV	Th
e + CH ₄	Elastic Scattering	0.01-2.00 keV	Th
e + NH	Elastic Scattering	0.01-2.00 keV	Th
e + NH ₂	Elastic Scattering	0.01-2.00 keV	Th
e + NH ₃	Elastic Scattering	0.01-2.00 keV	Th
e + OH	Elastic Scattering	0.01-2.00 keV	Th
449. H. Watanabe, F. J. Currell, H. Kuramoto, Y. M. Li, S. Ohtani, B. O'Rourke, X. M. Tong The measurement of the dielectronic recombination in He-like Fe ions. J. Phys. B 34 , 5095 (2001)			
e + Fe ²⁴⁺	Recombination	4.50-8.00 keV	Ex
450. R. Curik, F. A. Gianturco, R. R. Lucchese, N. Sanna Low-energy electron scattering and resonant states of NO₂(X ²A₁). J. Phys. B 34 , 59 (2001)			
e + NO ₂	Elastic Scattering	1.00-20.00 eV	Th
451. Cz. Szmytkowski, P. Mozejko, G. Kasperski Electron scattering from disilane (Si₂H₆) molecules. Absolute total cross section measurements from 1 to 370 eV. J. Phys. B 34 , 605 (2001)			
e + Si ₂ H ₆	Ionization	1.00-370.00 eV	Ex
e + Si ₂ H ₆	Excitation	1.00-370.00 eV	Ex
e + Si ₂ H ₆	Elastic Scattering	1.00-370.00 eV	Ex
452. N. R. Badnell, D. C. Griffin Electron-impact excitation of Fe ²⁰⁺, including n = 4 levels. J. Phys. B 34 , 681 (2001)			
e + Fe ²⁰⁺	Excitation	8x10 ⁴ -8x10 ⁷ K	Th
453. M. Cascella, R. Curik, F. A. Gianturco Vibrational excitation in electron-CH₄ collisions: exchange interaction effects. J. Phys. B 34 , 705 (2001)			
e + CH ₄	Excitation	15.00 eV	E/T
454. D. R. Sieglaff, R. Rejoub, B. G. Lindsay, R. F. Stebbings Absolute partial cross sections for electron-impact ionization of CF₄ from threshold to 1000 eV. J. Phys. B 34 , 799 (2001)			
e + CF ₄	Ionization	1.00 keV	E/T
455. X. W. Fan, K. T. Leung Momentum-transfer dependence of Fano parameters for the (1s²)¹S -¿ (2s2p)¹P doubly excited transition in helium. J. Phys. B 34 , 811 (2001)			
e + He	Excitation	2.50 eV	Th

456. T. Kerkau, V. Schmidt
CO²⁺ fragmentation studied by Auger electron-ion coincidences.
 J. Phys. B **34**, 839 (2001)
- | | | | |
|--------|--------------|----------|----|
| e + CO | Ionization | 2.00 keV | Ex |
| e + CO | Dissociation | 2.00 keV | Ex |
457. M. A. Haynes, B. Lohmann
Coplanar symmetric (e,2e) cross sections for argon 3s ionization.
 J. Phys. B **34**, L131 (2001)
- | | | | |
|--------|------------|-----------------|----|
| e + Ar | Ionization | 37.00-129.00 eV | Ex |
|--------|------------|-----------------|----|
458. H. W. Van der Hart
Electron-impact ionization of He⁺: consequences of double ionization of He in strong laser fields.
 J. Phys. B **34**, L147 (2001)
- | | | | |
|----------------------|------------|-----------------|----|
| e + He ¹⁺ | Ionization | 50.00-175.00 eV | Th |
| e + He ¹⁺ | Excitation | 50.00-175.00 eV | Th |
459. M. A. Green, P.J.O. Teubner, M. J. Brunger, D. C. Cartwright, L. Campbell
Integral cross sections for electron impact excitation of the Herzberg pseudocontinuum of molecular oxygen.
 J. Phys. B **34**, L157 (2001)
- | | | | |
|--------------------|------------|---------------|----|
| e + O ₂ | Excitation | 9.00-20.00 eV | Ex |
|--------------------|------------|---------------|----|
460. Y. Fang, K. Bartschat
Convergent second-order calculations for simultaneous electron-impact ionization-excitation of helium.
 J. Phys. B **34**, L19 (2001)
- | | | | |
|--------|------------|---------------|----|
| e + He | Ionization | 0.60-1.58 keV | Th |
| e + He | Excitation | 0.60-1.58 keV | Th |
461. C. Bahrim, U. Thumm, I. I. Fabrikant
³Se and ¹Se scattering lengths for e⁻ + Rb, Cs, and Fr collisions.
 J. Phys. B **34**, L195 (2001)
- | | | | |
|--------|--------------------|---------------|----|
| e + Rb | Elastic Scattering | 0.01-0.50 meV | Th |
| e + Cs | Elastic Scattering | 0.01-0.50 meV | Th |
| e + Fr | Elastic Scattering | 0.01-0.50 meV | Th |
462. M. Terao-Dunseath, K. M. Dunseath, D. Charlo, A. Hibbert, R. J. Allan
Electron-helium scattering in a Nd-YAG laser field at collision energies near the He(1s2l) thresholds.
 J. Phys. B **34**, L263 (2001)
- | | | | |
|--------|------------|----------------|----|
| e + He | Excitation | 0.65-0.78 a.u. | Th |
|--------|------------|----------------|----|
463. P. Van Reeth, J. W. Humberston, G. Laricchia
Correlations between ionization cross sections and threshold energies in electron-, positron-, proton- and antiproton-atom collisions.
 J. Phys. B **34**, L271 (2001)
- | | | | |
|--------|------------|--------------------------|----|
| e + He | Ionization | 0.1-5 keV; 30-2.00 MeV | Th |
| e + Ne | Ionization | 0.1-5 keV; 0.30-2.00 MeV | Th |
| e + Kr | Ionization | 0.1-5 keV; 0.30-2.00 MeV | Th |
| e + Xe | Ionization | 0.1-5 keV; 0.30-2.00 MeV | Th |
464. J. E. Sienkiewicz, V. Konopinska, S. Telega, P. Syty
Critical minima in elastic electron scattering from argon.
 J. Phys. B **34**, L409 (2001)

- | | | | | |
|--|-----------------|--------------------|----------------|----|
| | $e + \text{Ar}$ | Angular Scattering | 3.00-160.00 eV | Th |
| | $e + \text{Ar}$ | Elastic Scattering | 3.00-160.00 eV | Th |
465. T. Geyer, J. M. Rost
A quasi-classical approach to fully differential ionization cross sections.
J. Phys. B **34**, L47 (2001)
- | | | | | |
|--|----------------|------------|-----------------|----|
| | $e + \text{H}$ | Ionization | 54.40-250.00 eV | Th |
|--|----------------|------------|-----------------|----|
466. J. Glosik, R. Plasil, V. Poterya, P. Kudrna, M. Tichy, A. Pysanenko
Experimental study of recombination of H_3^+ ions with electrons relevant for interstellar and planetary plasmas.
J. Phys. B **34**, L485 (2001)
- | | | | | |
|--|-----------------------|---------------|-----------------|----|
| | $e + \text{H}_3^{1+}$ | Recombination | 230.00-290.00 K | Ex |
| | $e + \text{H}_3^{1+}$ | Dissociation | 230.00-290.00 K | Ex |
467. A.C.H Smith, M. E. Bannister, Y.-S. Chung, N. Djuric, G. H. Dunn, A. Neau, D. Popovic, M. Stepanovic, B. Wallbank
Excitation of He^+ to the 2^2S and 2^2P states by electron impact.
J. Phys. B **34**, L571 (2001)
- | | | | | |
|--|----------------------|------------|----------------|-----|
| | $e + \text{He}^{1+}$ | Excitation | 40.00-42.00 eV | E/T |
|--|----------------------|------------|----------------|-----|
468. J.D.M. Vianna, M.G.R. Martins, A. M. Maniero, E.M.S. Ribeiro, L. E. Machado
A theoretical procedure to treat elastic electron-molecule collision using the configuration-interaction method.
J. Phys. B **34**, L617 (2001)
- | | | | | |
|--|-------------------|--------------------|---------------|----|
| | $e + \text{H}_2$ | Angular Scattering | 0.50-20.00 eV | Th |
| | $e + \text{CH}_4$ | Angular Scattering | 0.50-20.00 eV | Th |
| | $e + \text{H}_2$ | Elastic Scattering | 0.50-20.00 eV | Th |
| | $e + \text{CH}_4$ | Elastic Scattering | 0.50-20.00 eV | Th |
469. Y. Hahn
Optimal enhancement of recombination processes in a cold plasma.
J. Phys. B **34**, L701 (2001)
- | | | | | |
|--|-----------------------|---------------|---------------|----|
| | $e + \text{Ne}^{10+}$ | Recombination | 0.00-10.00 eV | Th |
| | $e + \text{Bi}^{83+}$ | Recombination | 0.00-10.00 eV | Th |
470. A. N. Grum-Grzhimailo, K. Bartschat
Benchmark comparisons for near-threshold electron-impact excitation of Ar metastable levels.
J. Phys. B **34**, L727 (2001)
- | | | | | |
|--|-------------------|--------------------|----------------|----|
| | $e + \text{Ar}$ | Angular Scattering | 11.50-14.00 eV | Th |
| | $e + \text{Ar}$ | Excitation | 11.50-14.00 eV | Th |
| | $e + \text{Ar}^*$ | Angular Scattering | 11.50-14.00 eV | Th |
| | $e + \text{Ar}^*$ | Excitation | 11.50-14.00 eV | Th |
471. K. M. Aggarwal, F. P. Keenan, A. Z. Msezane
Effective collision strengths for transitions among the $3s^2$, $3s3p$ and $3p^2$ configurations of Fe XV.
J. Phys. B **34**, L757 (2001)
- | | | | | |
|--|-----------------------|------------|--------------|----|
| | $e + \text{Fe}^{14+}$ | Excitation | 0.10-10.00 K | Th |
|--|-----------------------|------------|--------------|----|
472. P. Golecki, H. Klar
Exploration of the He Bethe ridge for double ionization.
J. Phys. B **34**, L779 (2001)
- | | | | | |
|--|-----------------|--------------------|----------|----|
| | $e + \text{He}$ | Angular Scattering | 2.00 keV | Th |
| | $e + \text{He}$ | Ionization | 2.00 keV | Th |

473. K. Furuya, K. Matsuo, E. Koto, K. Maruyama, Y. Hatano, T. Ogawa
Fragment ion-photon coincidence investigation of trifluoromethane by controlled electron impact.
 J. Phys. B **35**, 1015 (2002)
- | | | | |
|--------------------|--------------|-----------|----|
| $e + \text{CHF}_3$ | Fluorescence | 120.00 eV | Ex |
| $e + \text{CHF}_3$ | Dissociation | 120.00 eV | Ex |
474. M. Allan, I. I. Fabrikant
Threshold peaks and structures in vibrational excitation of CH_3I by electron impact.
 J. Phys. B **35**, 1025 (2002)
- | | | | |
|---------------------------|------------|---------|----|
| $e + \text{CH}_3\text{I}$ | Excitation | 0.80 eV | Ex |
|---------------------------|------------|---------|----|
475. C. P. Ballance, N. R. Badnell, K. A. Berrington
Electron-impact excitation of H-like Fe at high temperatures.
 J. Phys. B **35**, 1095 (2002)
- | | | | |
|-----------------------|------------|-----------------------|----|
| $e + \text{Fe}^{25+}$ | Excitation | 10^6 - $10^{8.5}$ K | Th |
|-----------------------|------------|-----------------------|----|
476. C. C. Jia, A. Lahmam-Bennani, A. Duguet, L. Avaldi, M. Lecas, C. Dal Cappello
Dynamics of the double ionization process by electron impact: Ar (e,3e) experiments at low collision energy.
 J. Phys. B **35**, 1103 (2002)
- | | | | |
|-----------------|--------------------|-----------|----|
| $e + \text{Ar}$ | Angular Scattering | 561.40 eV | Ex |
| $e + \text{Ar}$ | Ionization | 561.40 eV | Ex |
477. H. K. Tseng
Relativistic calculation of the unpolarized triple-differential cross section and the polarization correlation of the electron bremsstrahlung from atoms.
 J. Phys. B **35**, 1129 (2002)
- | | | | |
|-----------------|----------------|-------------------|----|
| $e + \text{H}$ | Bremsstrahlung | 180.00-300.00 keV | Th |
| $e + \text{Ag}$ | Bremsstrahlung | 180.00-300.00 keV | Th |
| $e + \text{Au}$ | Bremsstrahlung | 180.00-300.00 keV | Th |
478. J. N. Das
Triple differential cross sections for the (e,2e) reaction of atomic hydrogen in hyperspherical partial wave theory at low energies for asymmetric geometries.
 J. Phys. B **35**, 1165 (2002)
- | | | | |
|----------------|------------|----------|-----|
| $e + \text{H}$ | Ionization | 27.20 eV | E/T |
|----------------|------------|----------|-----|
479. A. V. Korol, A. G. Lyalin, A. V. Solovy'ov, N. B. Avdonina, R. H. Pratt
On the stripping approximation in the bremsstrahlung process.
 J. Phys. B **35**, 1197 (2002)
- | | | | |
|-----------------|----------------|----------------|-----|
| $e + \text{Ar}$ | Bremsstrahlung | 5.00-50.00 keV | E/T |
| $e + \text{Kr}$ | Bremsstrahlung | 5.00-50.00 keV | E/T |
| $e + \text{Xe}$ | Bremsstrahlung | 5.00-50.00 keV | E/T |
| $e + \text{Au}$ | Bremsstrahlung | 5.00-50.00 keV | E/T |
480. H. M. Boechat-Roberty, J. D. Freitas, D. P. Almeida, G.G.B de Souza
Generalized oscillator strength and inelastic cross sections for the Xe 4d resonances.
 J. Phys. B **35**, 1409 (2002)
- | | | | |
|-----------------|--------------------|----------|----|
| $e + \text{Xe}$ | Angular Scattering | 1.04 keV | Ex |
| $e + \text{Xe}$ | Excitation | 1.04 keV | Ex |
481. T. Geyer, J. M. Rost
A quasiclassical approach to electron impact ionization.
 J. Phys. B **35**, 1479 (2002)

- | | | | | |
|--|---------|--------------------|-----------------|----|
| | $e + H$ | Angular Scattering | 17.60-250.00 eV | Th |
| | $e + H$ | Ionization | 17.60-250.00 eV | Th |
482. I. Rozum, N. J. Mason, J. Tennyson
Electron collisions with the CF_2 radical using the R-matrix method.
J. Phys. B **35**, 1583 (2002)
- | | | | | |
|--|------------|--------------------|---------------|----|
| | $e + CF_2$ | Excitation | 0.10-10.00 eV | Th |
| | $e + CF_2$ | Elastic Scattering | 0.10-10.00 eV | Th |
483. A. Faure, J. Tennyson
R-matrix calculations for polyatomic molecular ions: electron scattering by H_3^+ and H_3O^+ .
J. Phys. B **35**, 1865 (2002)
- | | | | | |
|--|-----------------|--------------------|---------------|----|
| | $e + H_3^{1+}$ | Excitation | 1.00-22.00 eV | Th |
| | $e + H_3O^{1+}$ | Excitation | 1.00-22.00 eV | Th |
| | $e + H_3^{1+}$ | Elastic Scattering | 1.00-22.00 eV | Th |
| | $e + H_3O^{1+}$ | Elastic Scattering | 1.00-22.00 eV | Th |
484. A. Kobayashi, G. Fujiki, A. Okaji, T. Masuoka
Ionization cross section ratios of rare-gas atoms (Ne, Ar, Kr and Xe) by electron impact from threshold to 1 keV.
J. Phys. B **35**, 2087 (2002)
- | | | | | |
|--|----------|------------|----------|----|
| | $e + Ne$ | Ionization | 1.00 keV | Ex |
| | $e + Ar$ | Ionization | 1.00 keV | Ex |
| | $e + Kr$ | Ionization | 1.00 keV | Ex |
| | $e + Xe$ | Ionization | 1.00 keV | Ex |
485. J. E. Kontros, L. Szoter, I. V. Chernyshova, O. B. Shpenik
Cross sections of slow electron scattering by cadmium atoms.
J. Phys. B **35**, 2195 (2002)
- | | | | | |
|--|----------|--------------------|----------|----|
| | $e + Cd$ | Ionization | 16.00 eV | Ex |
| | $e + Cd$ | Excitation | 16.00 eV | Ex |
| | $e + Cd$ | Elastic Scattering | 16.00 eV | Ex |
486. K. A. Berrington, C. P. Ballance
Partitioned R-matrix theory.
J. Phys. B **35**, 2275 (2002)
- | | | | | |
|--|--------------|------------|---------------|----|
| | $e + O^{7+}$ | Excitation | 0.58-1.16 keV | Th |
|--|--------------|------------|---------------|----|
487. Z. Q. Wu, G. X. Han, J. Yan, J. Q. Pang
Plasma effects on electron impact ionization.
J. Phys. B **35**, 2305 (2002)
- | | | | | |
|--|----------------|------------|----------------|----|
| | $e + Ge^{1+}$ | Ionization | 2.00-40.00 keV | Th |
| | $e + Au^{48+}$ | Ionization | 2.00-40.00 keV | Th |
488. M. Kampp, P.J.P. Roche, C. T. Whelan, D. H. Madison, J. Rasch, H.R.J. Walters
The electron impact ionization of magnesium (2p).
J. Phys. B **35**, 2325 (2002)
- | | | | | |
|--|----------|--------------------|---------------|----|
| | $e + Mg$ | Angular Scattering | 0.40-1.50 keV | Th |
| | $e + Mg$ | Ionization | 0.40-1.50 keV | Th |
489. O. Zatsarinny, S. S. Tayal
R-matrix calculation with non-orthogonal orbitals for electron-impact excitation of atomic oxygen .
J. Phys. B **35**, 241 (2002)
- | | | | | |
|--|---------|------------|-----------------|----|
| | $e + O$ | Excitation | 10.00-100.00 eV | Th |
|--|---------|------------|-----------------|----|

490. O. Zatsarinny, S. S. Tayal
Electron impact collision strengths and rates for neutral sulphur using the B-spline R-matrix approach.
 J. Phys. B **35**, 2493 (2002)
 $e + S$ Excitation 0.50-5.00 Ry Th
491. L. A. Bureyeva, V. S. Lisitsa, C. Namba, D. A. Shuvaev
Radiative cascade following dielectronic recombination.
 J. Phys. B **35**, 2505 (2002)
 $e + Zn^{27+}$ Recombination $E \inf \hbar W_c$ Th
492. B. M. McLaughlin, M. P. Scott, A. G. Sunderland, C. J. Noble, V. M. Burke, P. G. Burke
Electron impact excitation of Fe III: forbidden transitions.
 J. Phys. B **35**, 2755 (2002)
 $e + Fe^{2+}$ Excitation 2×10^3 - 2×10^6 K Th
493. M. Dogan, A. Crowe
Coincidence studies of the influence of resonances on simultaneous ionization-excitation of helium by electron impact.
 J. Phys. B **35**, 2773 (2002)
 $e + He$ Ionization 100.00-400.00 eV Ex
 $e + He$ Excitation 100.00-400.00 eV Ex
494. B. M. McLaughlin, A. Daw, K. L. Bell
Electron impact excitation of the $2s^2 2p^3 [^4S^o] 3s \ ^5S_2^o$ - $2s^2 2p^4 \ ^3P_{2,1,0}$ intercombination lines and of other observationally important extreme-ultraviolet lines in Ne III.
 J. Phys. B **35**, 283 (2002)
 $e + Ne^{2+}$ Excitation 0.00-1.00 K Th
495. D. A. Biava, H. P. Saha, E. Engel, R. M. Dreizler, R. P. McEachran, M. A. Haynes, B. Lohmann, C. T. Whelan
Exchange effects in low energy electron impact ionization of the inner and outer shells of argon.
 J. Phys. B **35**, 293 (2002)
 $e + Ar$ Ionization 2.00-113.50 eV Th
496. K. L. Baluja, A. Z. Msezane
Electron collisions with the SH radical using the R-matrix method.
 J. Phys. B **35**, 437 (2002)
 $e + SH$ Excitation 10.00 eV Th
 $e + SH$ Elastic Scattering 10.00 eV Th
497. M. Allan, N. C. Craig, L. V. McCarty
Vibrational excitation of cis- and trans-1, 2-difluoroethenes by electron impact: effect of dipole moment on the threshold peaks.
 J. Phys. B **35**, 523 (2002)
 $e + C_2H_3F_2$ Excitation 4.20 eV Ex
498. M. A. Green, P.J.O. Teubner, L. Campbell, M. J. Brunger, M. Hoshino, T. Ishikawa, M. Kitajima, H. Tanaka, Y. Itikawa, M. Kimura, R. J. Buenker
Absolute differential cross sections for electron impact excitation of the 10.8-11.5 eV energy-loss states of CO₂.
 J. Phys. B **35**, 567 (2002)
 $e + CO_2$ Excitation 20.00-200.00 eV Ex

499. G. Hanel, J. Fedor, B. Gstir, M. Probst, P. Scheier, T. D. Maerk, P. Tegeder, N. J. Mason
Ionization energy studies for Cl₂O monomers and dimers.
 J. Phys. B **35**, 589 (2002)
 $e + \text{Cl}_2\text{O}$ Ionization 8.00-20.00 eV E/T
500. R. D. White, M. A. Morrison, B. A. Mason
On the use of classical transport analysis to determine cross-sections for low-energy e-H₂ vibrational excitation.
 J. Phys. B **35**, 605 (2002)
 $e + \text{H}_2$ Angular Scattering Th
 $e + \text{H}_2$ Total Scattering Th
 $e + \text{H}_2$ Elastic Scattering Th
501. R. Curik, F. A. Gianturco
A computational analysis of low-energy electron scattering from gaseous cyclopropane.
 J. Phys. B **35**, 717 (2002)
 $e + \text{C}_3\text{H}_6$ Elastic Scattering 1.00-15.00 eV Th
502. E. Joucoski, M.H.F. Bettega
Elastic scattering of low-energy electrons by NF₃.
 J. Phys. B **35**, 783 (2002)
 $e + \text{NF}_3$ Angular Scattering 60.00 eV Th
 $e + \text{NF}_3$ Elastic Scattering 60.00 eV Th
503. J. B. Qi, C. Y. Chen, H. N. Xia, Y. Zhao, Y. S. Wang
Contributions of resonant excitation double autoionization to the electron-impact ionization of Ti¹¹⁺.
 J. Phys. B **35**, 829 (2002)
 $e + \text{Ti}^{11+}$ Ionization 300.00-800.00 eV Th
504. C. Zhou, Z. An, Z. Luo
Measurement of K-shell production cross sections for Ga, Ge and Zr elements by electron impact.
 J. Phys. B **35**, 841 (2002)
 $e + \text{Ga}$ Ionization 12.00-34.00 keV Ex
 $e + \text{Ge}$ Ionization 12.00-34.00 keV Ex
 $e + \text{Zr}$ Ionization 12.00-34.00 keV Ex
505. J. L. de Pablos, P. A. Kendall, P. Tegeder, A. Willart, F. Blanco, G. Garcia, N. J. Mason
Total and elastic electron scattering cross sections from ozone at intermediate and high energies.
 J. Phys. B **35**, 865 (2002)
 $e + \text{O}_3$ Angular Scattering 0.35-5.00 keV E/T
 $e + \text{O}_3$ Ionization 0.35-5.00 keV E/T
 $e + \text{O}_3$ Dissociation 0.35-5.00 keV E/T
 $e + \text{O}_3$ Excitation 0.35-5.00 keV E/T
 $e + \text{O}_3$ Elastic Scattering 0.35-5.00 keV E/T
506. A. Makhoute, D. Khalil, M. Zitane, M. Bouzidi
The second Born approximation in electron-atom collisions in the presence of a laser field.
 J. Phys. B **35**, 957 (2002)
 $e + \text{H}$ Angular Scattering 200.00 eV Th
 $e + \text{H}$ Excitation 200.00 eV Th
 $e + \text{H}$ Elastic Scattering 200.00 eV Th

507. X. Llovet, C. Merlet, F. Salvat
Measurements of absolute cross sections for K-shell ionization of Fe and Mn by electron impact.
 J. Phys. B **35**, 973 (2002)
- | | | | |
|--------|------------|----------------|----|
| e + Mn | Ionization | 6.50-40.00 keV | Ex |
| e + Fe | Ionization | 6.50-40.00 keV | Ex |
508. K. M. Aggarwal, F. P. Keenan, P. H. Norrington, G. J. Pert, S. J. Rose
Excitation rate coefficients for transitions from the ground level of Gd XXXVII.
 J. Phys. B **35**, L127 (2002)
- | | | | |
|-----------------------|------------|-----------------|----|
| e + Gd ³⁶⁺ | Excitation | 75.00-400.00 Ry | Th |
|-----------------------|------------|-----------------|----|
509. A. Lahmam-Bennani, C. C. Jia, A. Duguet, L. Avaldi
Signature of the target two-electron momentum space wavefunction in the (e, 3e) angular distributions from the double ionization of helium and argon.
 J. Phys. B **35**, L215 (2002)
- | | | | |
|--------|--------------------|-----------|----|
| e + He | Angular Scattering | 601.00 eV | Ex |
| e + Ar | Angular Scattering | 601.00 eV | Ex |
| e + He | Ionization | 601.00 eV | Ex |
| e + Ar | Ionization | 601.00 eV | Ex |
510. A. L. Godunov, J. H. McGuire, V. S. Schipakov, A. Crowe
Excitation of the (2p²)¹D and (2s2p)¹P autoionizing states of helium by 200 eV electron impact.
 J. Phys. B **35**, L245 (2002)
- | | | | |
|--------|--------------------|-----------|----|
| e + He | Angular Scattering | 200.00 eV | Th |
| e + He | Ionization | 200.00 eV | Th |
| e + He | Excitation | 200.00 eV | Th |
511. A. Lahmam-Bennani, A. Duguet, S. Roussin
Observation of non-first-order effects in an (e, 3-1e) investigation of the double ionization of helium and molecular hydrogen.
 J. Phys. B **35**, L59 (2002)
- | | | | |
|--------------------|------------|-----------|----|
| e + H ₂ | Ionization | 600.00 eV | Ex |
| e + He | Ionization | 600.00 eV | Ex |
512. H. Deutsch, K. Becker, P. Defrance, U. Onthong, R. Parajuli, M. Probst, S. Matt, T. D. Maerk
Calculated absolute cross section for the electron-impact ionization of CO₂⁺ and N₂⁺.
 J. Phys. B **35**, L65 (2002)
- | | | | |
|-----------------------------------|------------|----------|----|
| e + CO ₂ ¹⁺ | Ionization | 5.00 keV | Th |
| e + N ₂ ¹⁺ | Ionization | 5.00 keV | Th |
513. C. Herting, G. F. Hanne
Light polarization of mercury 6s6p ¹P₁ and 6s6p ³P₁ resonant transitions excited by electron impact.
 J. Phys. B **35**, L91 (2002)
- | | | | |
|--------|------------|---------|----|
| e + Hg | Excitation | 5.50 eV | Ex |
|--------|------------|---------|----|
514. R. W. van Boeyen, J. P. Doering, J. H. Moore, M. A. Coplan, J. W. Cooper
An investigation of basic symmetries in electron-impact ionization of magnesium.
 J. Phys. B **35**, L97 (2002)
- | | | | |
|--------|--------------------|---------------|-----|
| e + Mg | Angular Scattering | 0.40-1.50 keV | E/T |
| e + Mg | Ionization | 0.40-1.50 keV | E/T |
515. S. Lepp, P. C. Stancil, A. Dalgarno
Atomic and molecular processes in the early Universe.
 J. Phys. B **35**, R57 (2002)

$e + H$	Recombination	0.10-1.00 K	Th
$e + D$	Recombination	0.10-1.00 K	Th
$e + He$	Recombination	0.10-1.00 K	Th
$e + He^{1+}$	Recombination	0.10-1.00 K	Th
$e + He^{2+}$	Recombination	0.10-1.00 K	Th
$e + Li$	Recombination	0.10-1.00 K	Th
$e + Li^{1+}$	Recombination	0.10-1.00 K	Th
$e + Li^{2+}$	Recombination	0.10-1.00 K	Th
$e + Li^{3+}$	Recombination	0.10-1.00 K	Th
$e + H$	Ionization	0.10-1.00 K	Th
$e + D$	Ionization	0.10-1.00 K	Th
$e + He$	Ionization	0.10-1.00 K	Th
$e + He^{1+}$	Ionization	0.10-1.00 K	Th
$e + He^{2+}$	Ionization	0.10-1.00 K	Th
$e + Li$	Ionization	0.10-1.00 K	Th
$e + Li^{1+}$	Ionization	0.10-1.00 K	Th
$e + Li^{2+}$	Ionization	0.10-1.00 K	Th
$e + Li^{3+}$	Ionization	0.10-1.00 K	Th

516. E. M. Bahati, J. J. Jureta, H. Cherkani-Hassani, P. Defrance
Electron impact single ionization and dissociative excitation of H_3O^+ , HD_2O^+ and D_3O^+ .
J. Phys. B **64**, L333 (2001)

$e + H_3O^{1+}$	Dissociation	0.01-2.50 keV	Ex
$e + HD_2O^{1+}$	Dissociation	0.01-2.50 keV	Ex
$e + D_3O^{1+}$	Dissociation	0.01-2.50 keV	Ex
$e + H_3O^{1+}$	Excitation	0.01-2.50 keV	Ex
$e + HD_2O^{1+}$	Excitation	0.01-2.50 keV	Ex
$e + D_3O^{1+}$	Excitation	0.01-2.50 keV	Ex
$e + H_3O^{1+}$	Recombination	0.01-2.50 keV	Ex
$e + HD_2O^{1+}$	Recombination	0.01-2.50 keV	Ex
$e + D_3O^{1+}$	Recombination	0.01-2.50 keV	Ex

517. V. Dose, P. Pecher, R. Preuss
Formulas for cross sections and rate coefficients for partial electron impact ionization of CH_4 and H_2 .
J. Phys. Chem. Ref. Data **29**, 1157 (2000)

$e + H_2$	Ionization	Th
$e + CH_4$	Ionization	Th
$e + CH_4$	Dissociation	Th

518. S. Yagi, T. Nagata
Absolute total and partial cross sections for ionization of free lanthanide atoms by electron impact.
J. Phys. Soc. Jpn. **70**, 2559 (2001)

$e + Ce$	Ionization	4.00-900.00 eV	Ex
$e + Nd$	Ionization	4.00-900.00 eV	Ex
$e + Sm$	Ionization	4.00-900.00 eV	Ex
$e + Gd$	Ionization	4.00-900.00 eV	Ex
$e + Dy$	Ionization	4.00-900.00 eV	Ex
$e + Er$	Ionization	4.00-900.00 eV	Ex
$e + Yb$	Ionization	4.00-900.00 eV	Ex

519. E. Benedito, J. M. Fernandez-Varea, F. Salvat
Mixed simulation of the multiple elastic scattering of electrons and positrons using partial-wave differential cross-sections.
Nucl. Instrum. Methods Phys. Res. B **174**, 91 (2001)

- | | | | | |
|--|---------------|--------------------|---------------|----|
| | e + Al | Elastic Scattering | 0.00-1.00 GeV | Th |
| | e + Au | Elastic Scattering | 0.00-1.00 GeV | Th |
520. A. C. Roy
Singly differential cross-sections for electron-impact ionization of atomic hydrogen.
Nucl. Instrum. Methods Phys. Res. B **179**, 163 (2001)
- | | | | | |
|--|--------------|--------------------|------------------|----|
| | e + H | Angular Scattering | 100.00-250.00 eV | Th |
| | e + H | Ionization | 100.00-250.00 eV | Th |
521. D. L. Moores
Calculations of integral cross-sections for electron and positron impact of rare gas atoms.
Nucl. Instrum. Methods Phys. Res. B **179**, 316 (2001)
- | | | | | |
|--|---------------|------------|---------------|----|
| | e + He | Ionization | 0.02-1.00 keV | Th |
| | e + Ne | Ionization | 0.02-1.00 keV | Th |
| | e + Ar | Ionization | 0.02-1.00 keV | Th |
| | e + Kr | Ionization | 0.02-1.00 keV | Th |
| | e + Xe | Ionization | 0.02-1.00 keV | Th |
522. K. An, Z. M. Luo, C. Tang
Study of cross-sections for the K-shell ionization of atoms by electron and positron impact.
Nucl. Instrum. Methods Phys. Res. B **179**, 334 (2001)
- | | | | | |
|--|---------------|------------|-----------|-----|
| | e + Sc | Ionization | 50.00 keV | E/T |
| | e + Ti | Ionization | 50.00 keV | E/T |
| | e + V | Ionization | 50.00 keV | E/T |
| | e + Cr | Ionization | 50.00 keV | E/T |
| | e + Mn | Ionization | 50.00 keV | E/T |
| | e + Fe | Ionization | 50.00 keV | E/T |
| | e + Co | Ionization | 50.00 keV | E/T |
| | e + Ni | Ionization | 50.00 keV | E/T |
| | e + Cu | Ionization | 50.00 keV | E/T |
| | e + Ag | Ionization | 50.00 keV | E/T |
523. Yu. M. Smirnov
Excitation of a singly charged barium ion in electron-atom collisions.
Opt. Spectrosc. **89**, 169 (2000)
- | | | | | |
|--|---------------|------------|----------------|----|
| | e + Ba | Ionization | 8.00-200.00 eV | Ex |
| | e + Ba | Excitation | 8.00-200.00 eV | Ex |
524. A. I. Imre, A. N. Gomonai, V. S. Vukstich, A. N. Nemet
Excitation of resonance lines of a Zn⁺ ion by electron impact.
Opt. Spectrosc. **89**, 179 (2000)
- | | | | | |
|--|----------------------------|------------|----------------|----|
| | e + Zn¹⁺ | Excitation | 5.00-200.00 eV | Ex |
|--|----------------------------|------------|----------------|----|
525. Yu. M. Smirnov
Excitation of quintet levels of MnII in electron collisions with manganese atoms.
Opt. Spectrosc. **89**, 185 (2000)
- | | | | | |
|--|---------------|------------|-----------------|----|
| | e + Mn | Ionization | 12.00-200.00 eV | Ex |
| | e + Mn | Excitation | 12.00-200.00 eV | Ex |
526. Yu. M. Smirnov
Excitation cross sections for odd triplet levels of LaII in e-La collisions.
Opt. Spectrosc. **89**, 336 (2000)
- | | | | | |
|--|---------------|------------|----------------|----|
| | e + La | Ionization | 7.00-200.00 eV | Ex |
| | e + La | Excitation | 7.00-200.00 eV | Ex |

527. O. I. Zatsarinnyi, L. A. Bandurina
R-matrix calculations of the electron-impact excitation cross sections for the Cd^+ ion.
 Opt. Spectrosc. **89**, 498 (2000)
 $\text{e} + \text{Cd}^{1+}$ Excitation 5.00-50.00 eV Th
528. Yu. M. Smirnov
Slow-electron excitation of ^3S , ^3P , and $^3\text{P}^0$ levels of the strontium atom.
 Opt. Spectrosc. **90**, 332 (2001)
 $\text{e} + \text{Sr}$ Excitation 2.00-200.00 eV Ex
529. Yu. M. Smirnov
On the cross sections for excitation of the Europium atom by slow electrons.
 Opt. Spectrosc. **91**, 184 (2001)
 $\text{e} + \text{Eu}$ Excitation 3.00-200.00 eV Ex
530. I. I. Shafranyosh, V. I. Marushka
Spectroscopic study of the decay of negative ions formed through electron interaction with metastable magnesium atoms.
 Opt. Spectrosc. **91**, 557 (2001)
 $\text{e} + \text{Mg}$ Attachment 0.20-2.00 eV Ex
 $\text{e} + \text{Mg}^*$ Attachment 0.20-2.00 eV Ex
531. A. A. Mityureva, V. V. Smirnov, G. A. Ponomarenko
Approximation of the electron excitation cross sections for triplet states excited from the 2^3S_1 metastable state in helium.
 Opt. Spectrosc. **92**, 325 (2002)
 $\text{e} + \text{He}$ Excitation 1.00-40.00 Threshold E/T
 $\text{e} + \text{He}^*$ Excitation 1.00-40.00 Threshold E/T
532. Yu. M. Smirnov
Behavior of the excitation cross sections of the perturbed series of the xenon atom.
 Opt. Spectrosc. **92**, 357 (2002)
 $\text{e} + \text{Xe}$ Excitation 10.00-250.00 eV E/T
533. G. Garcia, F. Blanco
Energy dependence of the total cross section for electron scattering by N_2 and CO molecules at energies above 1 keV.
 Phys. Lett. A **279**, 61 (2001)
 $\text{e} + \text{CO}$ Angular Scattering 0.50-2.00 keV Th
 $\text{e} + \text{N}_2$ Angular Scattering 0.50-2.00 keV Th
 $\text{e} + \text{CO}$ Elastic Scattering 0.50-2.00 keV Th
 $\text{e} + \text{N}_2$ Elastic Scattering 0.50-2.00 keV Th
534. D. Raj, A. Kumar
Elastic scattering of electrons by molecular oxygen.
 Phys. Lett. A **282**, 284 (2001)
 $\text{e} + \text{O}_2$ Angular Scattering 0.30-1.00 keV Th
 $\text{e} + \text{O}_2$ Elastic Scattering 0.30-1.00 keV Th
535. K. N. Joshipura, B. K. Antony
Total (including ionization) cross sections of electron impact on ground state and metastable Ne atoms.
 Phys. Lett. A **289**, 323 (2001)

- | | | | |
|-------------------|--------------------|---------------|----|
| $e + \text{Ne}^*$ | Elastic Scattering | 0.01-3.00 keV | Th |
| $e + \text{Ne}$ | Elastic Scattering | 0.01-3.00 keV | Th |
| $e + \text{Ne}^*$ | Ionization | 0.01-3.00 keV | Th |
| $e + \text{Ne}$ | Ionization | 0.01-3.00 keV | Th |
| $e + \text{Ne}^*$ | Total Scattering | 0.01-3.00 keV | Th |
| $e + \text{Ne}$ | Total Scattering | 0.01-3.00 keV | Th |
536. J. E. Sienkiewicz, S. Telega, P. Syty, S. Fritzsche
Differential cross section minima in elastic scattering of electrons from zinc.
 Phys. Lett. A **293**, 183 (2002)
- | | | | |
|-----------------|--------------------|----------------|----|
| $e + \text{Zn}$ | Angular Scattering | 10.00-40.00 eV | Th |
| $e + \text{Zn}$ | Elastic Scattering | 10.00-40.00 eV | Th |
537. C. Guo-xin, P. P. Ong
Relativistic calculations for Fe XXIII: Electron-impact excitation.
 Phys. Rev. A **58**, 1183 (1998)
- | | | | |
|-----------------------|------------|--------------|----|
| $e + \text{Fe}^{22+}$ | Excitation | 0.05-1.00 Ry | Th |
|-----------------------|------------|--------------|----|
538. V. Zeman, K. Bartschat, C. Noren, J. W. McConkey
Near-threshold electron-impact excitation of the vacuum-ultraviolet resonance transitions in Ne, Ar, Kr, and Xe.
 Phys. Rev. A **58**, 1275 (1998)
- | | | | |
|-----------------|------------|---------------|----|
| $e + \text{Ne}$ | Excitation | 8.00-16.00 eV | Th |
| $e + \text{Ar}$ | Excitation | 8.00-16.00 eV | Th |
| $e + \text{Kr}$ | Excitation | 8.00-16.00 eV | Th |
| $e + \text{Xe}$ | Excitation | 8.00-16.00 eV | Th |
539. W. A. Isaacs, M. Baertschy, C. W. McCurdy, T. N. Rescigno
Doubly differential cross sections for the electron impact ionization of hydrogen.
 Phys. Rev. A **63**, 030704 (2001)
- | | | | |
|----------------|--------------------|----------------|----|
| $e + \text{H}$ | Angular Scattering | 17.60-30.00 eV | Th |
| $e + \text{H}$ | Ionization | 17.60-30.00 eV | Th |
540. A. M. Machado, M. M. Fujimoto, A.M.A. Taveira, L. M. Brescansin, M.-T. Lee
Application of the method of continued fractions to multichannel studies on electronic excitation of H_2 by electron impact.
 Phys. Rev. A **63**, 032707 (2001)
- | | | | |
|------------------|------------|----------------|----|
| $e + \text{H}_2$ | Excitation | 15.00-40.00 eV | Th |
|------------------|------------|----------------|----|
541. D. V. Fursa, I. Bray
Excitation of the 3^1P state of magnesium by electron impact from the ground state.
 Phys. Rev. A **63**, 032708 (2001)
- | | | | |
|-----------------|------------|----------|----|
| $e + \text{Mg}$ | Excitation | 1.00 keV | Th |
|-----------------|------------|----------|----|
542. J. A. Shaw, M. S. Pindzola, M. Steidl, K. Aichele, U. Hartenfeller, D. Hathiramani, F. Scheuermann, M. Westermann, E. Salzborn
Electron-impact single ionization of atomic ions in the Ga isonuclear sequence.
 Phys. Rev. A **63**, 032709 (2001)
- | | | | |
|----------------------|------------|----------|----|
| $e + \text{Ga}^{1+}$ | Ionization | 5.50 keV | Th |
| $e + \text{Ga}^{2+}$ | Ionization | 5.50 keV | Th |
| $e + \text{Ga}^{3+}$ | Ionization | 5.50 keV | Th |
| $e + \text{Ga}^{4+}$ | Ionization | 5.50 keV | Th |
| $e + \text{Ga}^{5+}$ | Ionization | 5.50 keV | Th |
| $e + \text{Ga}^{6+}$ | Ionization | 5.50 keV | Th |
| $e + \text{Ga}^{7+}$ | Ionization | 5.50 keV | Th |
| $e + \text{Ga}^{8+}$ | Ionization | 5.50 keV | Th |
| $e + \text{Ga}^{9+}$ | Ionization | 5.50 keV | Th |

543. J. Yang, J. P. Doering
Asymmetric (e,2e) study of the 100-eV ionization of the $1\pi_g$, $1\pi_u$, and $3\sigma_g$ molecular orbitals of O_2 .
 Phys. Rev. A **63**, 032717 (2001)
- | | | | |
|-----------|--------------------|-----------|----|
| $e + O_2$ | Angular Scattering | 100.00 eV | Ex |
| $e + O_2$ | Ionization | 100.00 eV | Ex |
544. H. B. Pederson, R. Bilodeau, M. J. Jensen, I. V. Makassiouk, C. P. Safvan, L. H. Andersen
Electron collisions with the diatomic fluorine anion.
 Phys. Rev. A **63**, 032718 (2001)
- | | | | |
|-----------------|--------------|----------|----|
| $e + F_2^{-1+}$ | Detachment | 27.00 eV | Ex |
| $e + F_2^{-1+}$ | Dissociation | 27.00 eV | Ex |
545. G. V. Brown, P. Beiersdorfer, K. Widmann
Systematic measurement of the relative electron-impact excitation cross section of the $3d\ ^1P_1$ resonance and 3D_1 intercombination lines in mid-Z neonlike ions.
 Phys. Rev. A **63**, 032719 (2001)
- | | | | |
|----------------|------------|---------------|----|
| $e + Cr^{14+}$ | Excitation | 1.00-4.00 keV | Ex |
| $e + Mn^{15+}$ | Excitation | 1.00-4.00 keV | Ex |
| $e + Fe^{16+}$ | Excitation | 1.00-4.00 keV | Ex |
| $e + Co^{17+}$ | Excitation | 1.00-4.00 keV | Ex |
| $e + Ni^{18+}$ | Excitation | 1.00-4.00 keV | Ex |
| $e + Cu^{19+}$ | Excitation | 1.00-4.00 keV | Ex |
| $e + Zn^{21+}$ | Excitation | 1.00-4.00 keV | Ex |
| $e + Br^{35+}$ | Excitation | 1.00-4.00 keV | Ex |
| $e + Kr^{36+}$ | Excitation | 1.00-4.00 keV | Ex |
546. L. Zhengming, T. Changhuan, A. Zhu, H. Fuqing, P. Xiufeng, L. Xianguan
Selenium and yttrium K-shell ionization cross-sections by electron impact.
 Phys. Rev. A **63**, 034702 (2001)
- | | | | |
|----------|------------|-----------------|----|
| $e + Se$ | Ionization | 13.00-40.00 keV | Ex |
| $e + Y$ | Ionization | 13.00-40.00 keV | Ex |
547. A. Le Padellec, N. L. Djuric, A. Al-Khalili, H. Danared, A. M. Derkach, A. Neau, D. B. Popovic, S. Rosen, J. Semaniak, R. Thomas, M. af Ugglas, W. Zong, M. Larsson
Resonant ion-pair formation in the recombination of NO^+ with electrons: Cross-section determination.
 Phys. Rev. A **64**, 012702 (2001)
- | | | | |
|---------------|---------------|---------------|----|
| $e + NO^{1+}$ | Attachment | 8.00-18.00 eV | Ex |
| $e + NO^{1+}$ | Recombination | 8.00-18.00 eV | Ex |
548. S. A. Rangwala, S.V.K Kumar, E. Krishnakumar
Dissociative electron attachment to electronically excited CS_2 .
 Phys. Rev. A **64**, 012707 (2001)
- | | | | |
|--------------|--------------|----------|----|
| $e + CS_2^*$ | Dissociation | 10.00 eV | Ex |
| $e + CS_2$ | Dissociation | 10.00 eV | Ex |
549. H. Merabet, M. Bailey, R. Bruch, J. Hanni, S. Bliman, D. V. Fursa, I. Bray, K. Bartschat, H. C. Tseng, C. D. Lin
Cross sections and collision dynamics of the excitation of $(1snp) ^1P^0$ levels of helium, $n = 2-5$, by intermediate- and high-velocity electron, proton, and molecular-ion (H_2^+ and H_3^+) impact.
 Phys. Rev. A **64**, 012712 (2001)
- | | | | |
|----------|------------|---------------|-----|
| $e + He$ | Excitation | 0.05-1.40 keV | E/T |
|----------|------------|---------------|-----|

550. W. R. Johnson, C. Guet
Erratum: Elastic scattering of electrons from Xe, Cs⁺, and Ba²⁺ [Phys. Rev. A 49, 1041 (1994)].
 Phys. Rev. A **64**, 019901 (2001)
- | | | | |
|----------------------|--------------------|----------|----|
| e + Xe | Angular Scattering | 10.00 eV | Th |
| e + Cs ¹⁺ | Angular Scattering | 10.00 eV | Th |
| e + Ba ²⁺ | Angular Scattering | 10.00 eV | Th |
| e + Xe | Elastic Scattering | 10.00 eV | Th |
| e + Cs ¹⁺ | Elastic Scattering | 10.00 eV | Th |
| e + Ba ²⁺ | Elastic Scattering | 10.00 eV | Th |
551. C. Plottke, I. Bray
e-H scattering S-wave model for initial excited states.
 Phys. Rev. A **64**, 022704 (2001)
- | | | | |
|-------|--------------------|--------------|----|
| e + H | Angular Scattering | 1.00-7.00 Ry | Th |
| e + H | Elastic Scattering | 1.00-7.00 Ry | Th |
552. M. Baertschy, T. N. Rescigno, C. W. McCurdy
Accurate amplitudes for electron-impact ionization.
 Phys. Rev. A **64**, 022709 (2001)
- | | | | |
|-------|------------|----------------|----|
| e + H | Ionization | 15.60-54.40 eV | Th |
|-------|------------|----------------|----|
553. N. Djuric, G. H. Dunn, A. Al-Khalili, A. M. Derkach, A. Neau, S. Rosen, W. Shi, L. Viktor, W. Zong, M. Larsson, A. Le Padellec, H. Danared, M. af Ugglas
Resonant ion-pair formation and dissociative recombination in electron collisions with ground-state HF⁺ ions.
 Phys. Rev. A **64**, 022713 (2001)
- | | | | |
|----------------------|---------------|--------------|----|
| e + HF ¹⁺ | Recombination | 0.00-1.00 eV | Ex |
| e + HF ¹⁺ | Dissociation | 0.00-1.00 eV | Ex |
554. C. Bahrim, U. Thumm
Angle-differential and momentum-transfer cross sections for e⁻ + Tb, Cs, and Fr collisions at low energies: ³F⁰ shape resonances in Rb⁻, Cs⁻, and Fr⁻ ions.
 Phys. Rev. A **64**, 022716 (2001)
- | | | | |
|--------|--------------------|--------------|----|
| e + Rb | Total Scattering | 0.00-3.00 eV | Th |
| e + Cs | Total Scattering | 0.00-3.00 eV | Th |
| e + Fr | Total Scattering | 0.00-3.00 eV | Th |
| e + Rb | Angular Scattering | 0.00-3.00 eV | Th |
| e + Cs | Angular Scattering | 0.00-3.00 eV | Th |
| e + Fr | Angular Scattering | 0.00-3.00 eV | Th |
| e + Rb | Elastic Scattering | 0.00-3.00 eV | Th |
| e + Cs | Elastic Scattering | 0.00-3.00 eV | Th |
| e + Fr | Elastic Scattering | 0.00-3.00 eV | Th |
555. D. Hammer, L. Frommhold
Polarization bremsstrahlung spectra of electron – rare-gas atom collisions at temperatures from 5 to 40 kK.
 Phys. Rev. A **64**, 024705 (2001)
- | | | | |
|--------|----------------|--------------|----|
| e + He | Bremsstrahlung | 5.00-40.00 K | Th |
| e + Ne | Bremsstrahlung | 5.00-40.00 K | Th |
| e + Ar | Bremsstrahlung | 5.00-40.00 K | Th |
| e + Kr | Bremsstrahlung | 5.00-40.00 K | Th |
| e + Xe | Bremsstrahlung | 5.00-40.00 K | Th |
556. C. J. Sweeney, A. Grafe, T. W. Shyn
Measurement of absolute differential cross sections for the excitation of atomic hydrogen to its n=3 and 4 levels by electron impact.
 Phys. Rev. A **64**, 032704 (2001)

	$e + H$	Excitation	20.00-30.00 eV	Ex
557.	S. Boehm, S. Schippers, W. Shi, A. Mueller, N. Djuric, G. H. Dunn, W. Zong, B. Jelenkovic, H. Danared, N. Ekloew, P. Glans, R. Schuch Influence of electromagnetic fields on the dielectronic recombination of Ne^{7+} ions. Phys. Rev. A 64 , 032707 (2001)			
	$e + Ne^{7+}$	Recombination	18.00 eV	Ex
558.	J. B. Boffard, M. L. Keeler, G. A. Piech, L. W. Anderson, C. C. Lin Measurement of electron-impact excitation cross sections out of the neon 3P_2 metastable level. Phys. Rev. A 64 , 032708 (2001)			
	$e + Ne^*$	Excitation	450.00 eV	Ex
	$e + Ne$	Excitation	450.00 eV	Ex
559.	T.-Y. Kuo, K.-N. Huang Relativistic cross sections of the electron-impact ionization of heliumlike ions. Phys. Rev. A 64 , 032710 (2001)			
	$e + He$	Ionization	10.00 Threshold	Th
	$e + Li^{1+}$	Ionization	10.00 Threshold	Th
	$e + B^{3+}$	Ionization	10.00 Threshold	Th
	$e + C^{4+}$	Ionization	10.00 Threshold	Th
	$e + N^{5+}$	Ionization	10.00 Threshold	Th
	$e + Na^{9+}$	Ionization	10.00 Threshold	Th
	$e + Fe^{24+}$	Ionization	10.00 Threshold	Th
	$e + Ag^{45+}$	Ionization	10.00 Threshold	Th
560.	Y.-K. Kim Scaling of plane-wave Born cross sections for electron-impact excitation of neutral atoms. Phys. Rev. A 64 , 032713 (2001)			
	$e + H$	Excitation	5.00 keV	Th
	$e + He$	Excitation	5.00 keV	Th
	$e + Li$	Excitation	5.00 keV	Th
	$e + Be$	Excitation	5.00 keV	Th
	$e + Na$	Excitation	5.00 keV	Th
	$e + Mg$	Excitation	5.00 keV	Th
	$e + K$	Excitation	5.00 keV	Th
	$e + Ca$	Excitation	5.00 keV	Th
	$e + Rb$	Excitation	5.00 keV	Th
	$e + Sr$	Excitation	5.00 keV	Th
	$e + Cs$	Excitation	5.00 keV	Th
	$e + Ba$	Excitation	5.00 keV	Th
	$e + Hg$	Excitation	5.00 keV	Th
	$e + Tl$	Excitation	5.00 keV	Th
561.	D. C. Griffin, D. M. Mitnik, J. Colgan, M. S. Pindzola Electron-impact excitation of lithium. Phys. Rev. A 64 , 032718 (2001)			
	$e + Li$	Excitation	25.00 eV	Th
562.	H. L. Zhang, S. N. Nahar, A. K. Pradhan Relativistic close-coupling calculations for photoionization and recombination of Ne-like Fe XVII. Phys. Rev. A 64 , 032719 (2001)			
	$e + Fe^{17+}$	Recombination	100.00 eV	Th
	$e + Fe^{17+}$	Recombination	100.00 eV	Th

563. C. Wesdorp, F. Robicheaux, L. D. Noordam
Pulsed field recombination.
 Phys. Rev. A **64**, 033414 (2001)
 $e + \text{Li}^{1+}$ Recombination 100.00 K E/T
564. N. C. Deb, D.S.F Crothers
Semiclassical-quantal approach to the near-threshold ionization of hydrogen.
 Phys. Rev. A **64**, 034701 (2001)
 $e + \text{H}$ Ionization 16.00-18.00 eV Th
565. R. K. Nesbet, S. Mazevet, M. A. Morrison
Procedure for correcting variational R-matrix calculations for polarization response.
 Phys. Rev. A **64**, 034702 (2001)
 $e + \text{CO}_2$ Elastic Scattering 1.00 eV Th
566. S. Mazevet, M. A. Morrison, L. A. Morgan, R. K. Nesbet
Virtual-state effects on elastic scattering and vibrational excitation of CO_2 by electron impact.
 Phys. Rev. A **64**, 040701 (2001)
 $e + \text{CO}_2$ Excitation 1.00 eV Th
 $e + \text{CO}_2$ Elastic Scattering 1.00 eV Th
567. J. Lower, E. Weigold, J. Berakdar, S. Mazevet
Orbital and spin-polarization transfer in ionizing electron-atom collisions.
 Phys. Rev. A **64**, 042701 (2001)
 $e + \text{Na}$ Angular Scattering 64.00-151.00 eV Ex
 $e + \text{Na}$ Ionization 64.00-151.00 eV Ex
568. K. T. Mazon, R. Fujiwara, M.-T. Lee
Exact exchange effects on vibrational excitation of H_2 by electron impact.
 Phys. Rev. A **64**, 042705 (2001)
 $e + \text{H}_2$ Angular Scattering 1.50-100.00 eV Th
 $e + \text{H}_2$ Excitation 1.50-100.00 eV Th
569. P.-T. Howe, A. Kortyna, M. Darrach, A. Chutjian
Low-energy electron attachment to SF_6 at sub-meV resolution using a tunable laser photo-electron method.
 Phys. Rev. A **64**, 042706 (2001)
 $e + \text{SF}_6$ Attachment 127.00 meV Ex
570. A. Dutta, B. Nath, C. Sinha
Inner-shell ionization of a neon atom by electron impact.
 Phys. Rev. A **64**, 042714 (2001)
 $e + \text{Ne}$ Angular Scattering 2.70 keV Th
 $e + \text{Ne}$ Ionization 2.70 keV Th
571. W. M. Huo
Convergent series representation for the generalized oscillator strength of electron-impact ionization and an improved binary-encounter-dipole model.
 Phys. Rev. A **64**, 042719 (2001)
 $e + \text{H}_2\text{O}$ Ionization 0.01-1.00 keV Th
 $e + \text{CH}_4$ Ionization 0.01-1.00 keV Th
 $e + \text{CO}_2$ Ionization 0.01-1.00 keV Th
 $e + \text{N}_2$ Ionization 0.01-1.00 keV Th
 $e + \text{CF}_4$ Ionization 0.01-1.00 keV Th

572. A. Cionga, F. Ehlotzky, G. Zloh
Elastic electron scattering by excited hydrogen atoms in a laser field.
 Phys. Rev. A **64**, 043401 (2001)
- | | | | |
|-----------|--------------------|------------------|----|
| $e + H^*$ | Elastic Scattering | 100.00-500.00 eV | Th |
| $e + H$ | Elastic Scattering | 100.00-500.00 eV | Th |
573. P. Glans, E. Lindroth, N. R. Badnell, N. Eklow, W. Zong, E. Justiniano, R. Schuch
Dielectronic recombination of N^{4+} .
 Phys. Rev. A **64**, 043609 (2001)
- | | | | |
|--------------|---------------|---------|-----|
| $e + N^{4+}$ | Recombination | 1.60 eV | E/T |
|--------------|---------------|---------|-----|
574. M. A. Haynes, B. Lohmann
Comparative study of argon 3p electron-impact ionization at low energies.
 Phys. Rev. A **64**, 044701 (2001)
- | | | | |
|----------|--------------------|-----------|-----|
| $e + Ar$ | Angular Scattering | 113.50 eV | E/T |
| $e + Ar$ | Ionization | 113.50 eV | E/T |
575. L.-B. Zhao, T. Shirai
Theoretical study on dielectronic recombination of O^{6+} ions in metastable states.
 Phys. Rev. A **64**, 052704 (2001)
- | | | | |
|--------------|---------------|----------|-----|
| $e + O^{6+}$ | Recombination | 10.00 eV | E/T |
|--------------|---------------|----------|-----|
576. K. Aichele, W. Arnold, D. Hathiramani, F. Scheuermann, E. Salzborn, D. M. Mitnik, D. C. Griffin, J. Colgan, M. S. Pindzola
Experimental and theoretical study of electron-impact ionization of atomic ions in the Sm isonuclear sequence.
 Phys. Rev. A **64**, 052706 (2001)
- | | | | |
|----------------|------------|---------------|-----|
| $e + Sm^{1+}$ | Ionization | 0.01-1.00 keV | E/T |
| $e + Sm^{2+}$ | Ionization | 0.01-1.00 keV | E/T |
| $e + Sm^{3+}$ | Ionization | 0.01-1.00 keV | E/T |
| $e + Sm^{4+}$ | Ionization | 0.01-1.00 keV | E/T |
| $e + Sm^{5+}$ | Ionization | 0.01-1.00 keV | E/T |
| $e + Sm^{6+}$ | Ionization | 0.01-1.00 keV | E/T |
| $e + Sm^{7+}$ | Ionization | 0.01-1.00 keV | E/T |
| $e + Sm^{8+}$ | Ionization | 0.01-1.00 keV | E/T |
| $e + Sm^{9+}$ | Ionization | 0.01-1.00 keV | E/T |
| $e + Sm^{10+}$ | Ionization | 0.01-1.00 keV | E/T |
| $e + Sm^{11+}$ | Ionization | 0.01-1.00 keV | E/T |
| $e + Sm^{12+}$ | Ionization | 0.01-1.00 keV | E/T |
577. Y.-K. Kim, P. M. Stone
Ionization of boron, aluminum, gallium, and indium by electron impact.
 Phys. Rev. A **64**, 052707 (2001)
- | | | | |
|----------|------------|---------------|-----|
| $e + B$ | Ionization | 0.01-4.00 keV | E/T |
| $e + Al$ | Ionization | 0.01-4.00 keV | E/T |
| $e + Ga$ | Ionization | 0.01-4.00 keV | E/T |
| $e + In$ | Ionization | 0.01-4.00 keV | E/T |
578. D. B. Popovic, N. L. Djuric, K. Holmberg, A. Neau, G. H. Dunn
Absolute cross sections for H^+ formation from electron-impact dissociation of C_2H^+ and $C_2H_2^+$.
 Phys. Rev. A **64**, 052709 (2001)
- | | | | |
|-------------------|--------------|----------|----|
| $e + C_2H_2^{1+}$ | Dissociation | 50.00 eV | Ex |
| $e + C_2H^{1+}$ | Dissociation | 50.00 eV | Ex |

579. A. Dasgupta, K. Bartschat, D. Vaid, A. N. Grum-Grzhimailo, D. H. Madison, M. Blaha, J. L. Giuliani
Electron-impact excitation to the $4p^55s$ and $4p^55p$ levels of Kr I using different distorted-wave and close-coupling methods.
 Phys. Rev. A **64**, 052710 (2001)
 $e + \text{Kr}$ Excitation 10.00-50.00 eV E/T
580. J. N. Das
Electron-hydrogen-atom ionization study of a hyperspherical partial-wave ab initio approach for equal-energy-sharing constant- Θ_{12} geometry.
 Phys. Rev. A **64**, 054703 (2001)
 $e + \text{H}$ Ionization 30.00 eV E/T
581. D. Hammer, L. Frommhold
Erratum: Polarization bremsstrahlung spectra of electron-rare-gas atom collisions at temperatures from 5 to 40 kK [Phys. Rev. A **64, 024705 (2001)].**
 Phys. Rev. A **64**, 059901 (2001)
 $e + \text{Ar}$ Bremsstrahlung 5.00-40.00 K Th
582. A. Larson, A. E. Orel
Ion-pair formation and product branching ratios in dissociative recombination of HD^+ .
 Phys. Rev. A **64**, 062701 (2001)
 $e + \text{H}_2^{1+}$ Recombination 0.10-8.00 eV Th
 $e + \text{H}_2^{1+}$ Dissociation 0.10-8.00 eV Th
 $e + \text{HD}^{1+}$ Recombination 0.10-8.00 eV Th
 $e + \text{HD}^{1+}$ Dissociation 0.10-8.00 eV Th
583. J. G. Childers, D. B. Thompson, N.L.S. Martin
(e,2e) experiments on the autoionizing levels of Xe between the $^2P_{3/2}$ and $^2P_{1/2}$ ionic limits.
 Phys. Rev. A **64**, 062703 (2001)
 $e + \text{Xe}$ Ionization 150.00-350.00 eV Ex
584. D. M. Mitnik, D. C. Griffin, J. Colgan, M. S. Pindzola, K. Aichele, W. Arnold, D. Hathiramani, F. Scheuermann, E. Salzborn
Electron-impact ionization of Sm^{12+} ions: Resonances far beyond threshold.
 Phys. Rev. A **64**, 062705 (2001)
 $e + \text{Sm}^{12+}$ Ionization 0.20-1.02 keV E/T
585. M. T. do N. Varella, C. Winstead, V. McKoy, M. Kitajima, H. Tanaka
Low-energy electron scattering by CH_3F , CH_2F_2 , CHF_3 , and CF_4 .
 Phys. Rev. A **65**, 022702 (2002)
 $e + \text{CF}_4$ Elastic Scattering 1.50-30.00 eV E/T
 $e + \text{CHF}_3$ Elastic Scattering 1.50-30.00 eV E/T
 $e + \text{CH}_2\text{F}_2$ Elastic Scattering 1.50-30.00 eV E/T
 $e + \text{CH}_3\text{F}$ Elastic Scattering 1.50-30.00 eV E/T
586. Y.-K. Kim
Scaling of Coulomb Born cross sections for electron-impact excitation of singly charged ions.
 Phys. Rev. A **65**, 022705 (2002)
 $e + \text{He}^{1+}$ Excitation 0.01-5.00 keV Th
 $e + \text{Mg}^{1+}$ Excitation 0.01-5.00 keV Th
 $e + \text{Zn}^{1+}$ Excitation 0.01-5.00 keV Th
587. C. Champion, J. Hanssen, P. A. Hervieux
Theoretical differential and total cross sections of water-molecule ionization by electron impact.
 Phys. Rev. A **65**, 022710 (2002)

- | | | | | |
|--|------------|------------|---------------|----|
| | $e + H_2O$ | Ionization | 0.02-2.00 keV | Th |
|--|------------|------------|---------------|----|
588. P.-A. Hervieux, M. E. Madjet, H. Benali
Capture of low-energy electrons by simple closed-shell metal clusters.
 Phys. Rev. A **65**, 023202 (2002)
- | | | | | |
|--|---------------|------------|---------|----|
| | $e + Na_{20}$ | Attachment | 3.00 eV | Th |
| | $e + Na_{40}$ | Attachment | 3.00 eV | Th |
| | $e + Na_{58}$ | Attachment | 3.00 eV | Th |
589. S. Madzunkov, E. Lindroth, N. Ekloew, M. Tokman, A. Paal, R. Schuch
QED effects in lithiumlike krypton.
 Phys. Rev. A **65**, 032505 (2002)
- | | | | | |
|--|----------------|---------------|---------------|-----|
| | $e + Kr^{34+}$ | Recombination | 4.50-14.00 eV | E/T |
|--|----------------|---------------|---------------|-----|
590. L. A. Bureyeva, T. Kato, V. S. Lisitsa, C. Namba
Quasiclassical theory of dielectronic recombination in plasmas.
 Phys. Rev. A **65**, 032702 (2002)
- | | | | | |
|--|----------------|---------------|----------|----|
| | $e + C^{3+}$ | Recombination | 100.00 K | Th |
| | $e + Mg^{1+}$ | Recombination | 100.00 K | Th |
| | $e + Zn^{27+}$ | Recombination | 100.00 K | Th |
591. Jr. Stewart, M. D., J. E. Chilton, J. B. Boffard, C. C. Lin
Use of radiation trapping for measuring electron-impact excitation cross sections for higher resonance levels of rare-gas atoms.
 Phys. Rev. A **65**, 032704 (2002)
- | | | | | |
|--|----------|------------|-----------|----|
| | $e + Ne$ | Excitation | 225.00 eV | Th |
| | $e + Ar$ | Excitation | 225.00 eV | Th |
| | $e + Kr$ | Excitation | 225.00 eV | Th |
592. A. Dorn, A. Kheifets, C. D. Schroeter, B. Najjari, C. Hoehr, R. Moshhammer, J. Ullrich
Double ionization of helium by electron impact in the impulsive regime.
 Phys. Rev. A **65**, 032709 (2002)
- | | | | | |
|--|----------|------------|----------|----|
| | $e + He$ | Ionization | 2.00 keV | Ex |
|--|----------|------------|----------|----|
593. T. N. Rescigno, W. A. Isaacs, A. E. Orel, H.-D. Meyer, C. W. McCurdy
Theoretical study of resonant vibrational excitation of CO₂ by electron impact.
 Phys. Rev. A **65**, 032716 (2002)
- | | | | | |
|--|------------|------------|---------|----|
| | $e + CO_2$ | Excitation | 8.00 eV | Th |
|--|------------|------------|---------|----|
594. J. B. Qi, C. Y. Chen, Y. Zhao, H. N. Xia, Y. S. Wang
Resonant contributions to the electron-impact ionization of sodiumlike chromium.
 Phys. Rev. A **65**, 032720 (2002)
- | | | | | |
|--|----------------|------------|---------------|----|
| | $e + Cr^{13+}$ | Ionization | 0.40-1.10 keV | Th |
|--|----------------|------------|---------------|----|
595. D. V. Fursa, I. Bray, G. Csanak, R.E.H. Clark, Jr. Abdallah, J., I. Kanik, S. Trajmar
Electron-impact excitation of excited atomic barium.
 Phys. Rev. A **65**, 032723 (2002)
- | | | | | |
|--|------------|------------|-----------|----|
| | $e + Ba^*$ | Ionization | 100.00 eV | Th |
| | $e + Ba$ | Ionization | 100.00 eV | Th |
| | $e + Ba^*$ | Excitation | 100.00 eV | Th |
| | $e + Ba$ | Excitation | 100.00 eV | Th |
596. M. K. Inal, H. L. Zhang, D. H. Sampson, C. J. Fontes
Effect of inner-shell ionization on the circular polarization of the Fe²⁴⁺ (1s2s)₁ - ζ (1s²)₀ line produced by collisions with a longitudinally polarized electron beam.
 Phys. Rev. A **65**, 032727 (2002)

- | | | | | |
|--|-----------------------|------------|---------------|----|
| | $e + \text{Fe}^{24+}$ | Ionization | 0.50-2.00 keV | Th |
|--|-----------------------|------------|---------------|----|
597. S. Vucic
e-H collisions in a resonant monochromatic or bichromatic laser field.
 Phys. Rev. A **65**, 033521 (2002)
- | | | | | |
|--|----------------|--------------------|--------------------------------------|----|
| | $e + \text{H}$ | Excitation | 10^9 - 10^{11} W/cm ² | Th |
| | $e + \text{H}$ | Elastic Scattering | 10^9 - 10^{11} W/cm ² | Th |
598. D. B. Popovic, M. E. Bannister, R.E.H. Clark, Y.-S. Chung, N. Djuric, F. W. Meyer, A. Mueller, A. Neau, M. S. Pindzola, A.C.H Smith, B. Wallbank, G. H. Dunn
Absolute cross sections for electron-impact excitation of the $3d^2\ ^3F - j\ 3d4p\ ^3D, ^3F$ transitions in Ti^{2+} .
 Phys. Rev. A **65**, 034704 (2002)
- | | | | | |
|--|----------------------|------------|---------------|----|
| | $e + \text{Ti}^{2+}$ | Excitation | 9.00-10.00 eV | Ex |
|--|----------------------|------------|---------------|----|
599. D. H Jakubassa-Amundsen
Spin asymmetry in weakly relativistic (e,2e) collisions.
 Phys. Rev. A **65**, 034706 (2002)
- | | | | | |
|--|-----------------|------------|------------|----|
| | $e + \text{Ag}$ | Ionization | 300.00 keV | Th |
|--|-----------------|------------|------------|----|
600. A. Dasgupta, M. Blaha, J. L. Giuliani
Erratum: Electron-impact excitation from the ground and the metastable levels of Ar I [Phys. Rev. A **61, 012703 (2000)].**
 Phys. Rev. A **65**, 039905 (2002)
- | | | | | |
|--|-------------------|------------|-----------|----|
| | $e + \text{Ar}^*$ | Excitation | 120.00 eV | Th |
| | $e + \text{Ar}$ | Excitation | 120.00 eV | Th |
601. D. B. Milosevic and, F. Ehlotzky
Rescattering effects in soft-x-ray generation by laser-assisted electron-ion recombination.
 Phys. Rev. A **65**, 042504 (2002)
- | | | | | |
|--|-----------------|---------------|-----------|----|
| | $e + \text{H}$ | Recombination | 500.00 eV | Th |
| | $e + \text{He}$ | Recombination | 500.00 eV | Th |
602. R. S. Schappe, R. J. Edgell, E. Urban
Electron-impact excitation of nitric oxide ($\text{A } ^2\Sigma^+ - \text{X } ^2\Pi$).
 Phys. Rev. A **65**, 042701 (2002)
- | | | | | |
|--|-----------------|------------|-----------------|----|
| | $e + \text{NO}$ | Excitation | 10.00-740.00 eV | Ex |
|--|-----------------|------------|-----------------|----|
603. Y. Khajuria, L. Q. Chen, X. J. Chen, K. Z. Xu
(e,2e) triple-differential cross sections of helium and argon at 64.6 eV.
 Phys. Rev. A **65**, 042706 (2002)
- | | | | | |
|--|-----------------|--------------------|----------|----|
| | $e + \text{He}$ | Angular Scattering | 64.60 eV | Th |
| | $e + \text{Ar}$ | Angular Scattering | 64.60 eV | Th |
| | $e + \text{He}$ | Ionization | 64.60 eV | Th |
| | $e + \text{Ar}$ | Ionization | 64.60 eV | Th |
604. A. S. Alnaser, A. L. Landers, D. J. Pole, S. Hossain, O. A. Haija, T. W. Gorczyca, J. A. Tanis, H. Knutson
Superelastic scattering of electrons from metastable He-like C^{4+} and O^{6+} ions.
 Phys. Rev. A **65**, 042709 (2002)
- | | | | | |
|--|---------------------|--------------------|-------------------|-----|
| | $e + \text{C}^{4+}$ | Angular Scattering | 0.50-1.10 MeV/amu | E/T |
| | $e + \text{O}^{6+}$ | Angular Scattering | 0.50-1.10 MeV/amu | E/T |
| | $e + \text{F}^{7+}$ | Angular Scattering | 0.50-1.10 MeV/amu | E/T |
| | $e + \text{C}^{4+}$ | De-excitation | 0.50-1.10 MeV/amu | E/T |
| | $e + \text{O}^{6+}$ | De-excitation | 0.50-1.10 MeV/amu | E/T |
| | $e + \text{F}^{7+}$ | De-excitation | 0.50-1.10 MeV/amu | E/T |

$e + C^{4+*}$	Angular Scattering	0.50-1.10 MeV/amu	E/T
$e + O^{6+*}$	Angular Scattering	0.50-1.10 MeV/amu	E/T
$e + F^{7+*}$	Angular Scattering	0.50-1.10 MeV/amu	E/T
$e + C^{4+*}$	De-excitation	0.50-1.10 MeV/amu	E/T
$e + O^{6+*}$	De-excitation	0.50-1.10 MeV/amu	E/T
$e + F^{7+*}$	De-excitation	0.50-1.10 MeV/amu	E/T

605. R. Rejoub, B. G. Lindsay, R. F. Stebbings

Determination of the absolute partial and total cross sections for electron-impact ionization of the rare gases.

Phys. Rev. A **65**, 042713 (2002)

$e + He$	Ionization	1.00 keV	Ex
$e + Ne$	Ionization	1.00 keV	Ex
$e + Ar$	Ionization	1.00 keV	Ex
$e + Kr$	Ionization	1.00 keV	Ex
$e + Xe$	Ionization	1.00 keV	Ex

606. C. W. McCurdy, D. A. Horner, T. N. Rescigno

Time-dependent approach to collisional ionization using exterior complex scaling.

Phys. Rev. A **65**, 042714 (2002)

$e + H$	Angular Scattering	40.80 eV	Th
$e + H$	Ionization	40.80 eV	Th

607. M. M. Tabanli, J. L. Peacher, D. H. Madison

Electron-cadmium ionization for energies near overlapping autoionizing resonances.

Phys. Rev. A **65**, 042718 (2002)

$e + Cd$	Angular Scattering	150.00 eV	Th
$e + Cd$	Ionization	150.00 eV	Th

608. M.-T. Lee, K. T. Mazon

Electron scattering by vibrationally excited H_2 in the low-energy range.

Phys. Rev. A **65**, 042720 (2002)

$e + H_2$	De-excitation	1.00-10.00 eV	Th
$e + H_2$	Excitation	1.00-10.00 eV	Th
$e + H_2$	Angular Scattering	1.00-10.00 eV	Th
$e + H_2$	Elastic Scattering	1.00-10.00 eV	Th
$e + H_2^*$	De-excitation	1.00-10.00 eV	Th
$e + H_2^*$	Excitation	1.00-10.00 eV	Th
$e + H_2^*$	Angular Scattering	1.00-10.00 eV	Th
$e + H_2^*$	Elastic Scattering	1.00-10.00 eV	Th

609. J. Colgan, M. S. Pindzola, F. J. Robicheaux, D. C. Griffin, M. Baertschy

Time-dependent close-coupling calculations of the triple-differential cross section for electron-impact ionization of hydrogen.

Phys. Rev. A **65**, 042721 (2002)

$e + H$	Angular Scattering	54.40 eV	Th
$e + H$	Ionization	54.40 eV	Th

610. S. Schippers, S. Kieslich, A. Mueller, G. Gwinner, M. Schnell, A. Wolf, A. Covington, M. E. Bannister, L.-B. Zhao

Interference effects in the photorecombination of argonlike Sc^{3+} ions: Storage-ring experiment and theory.

Phys. Rev. A **65**, 042723 (2002)

$e + Sc^{3+}$	Recombination	45.00 eV	E/T
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611. A. Dasgupta, K. Bartschat, D. Vaid, A. N. Grum-Grzhimailo, D. H. Madison, M. Blaha, J. L. Giuliani
Electron-impact excitation from the (4p⁵5s) metastable states of krypton.
 Phys. Rev. A **65**, 042724 (2002)
- | | | | |
|-------------------|------------|----------|----|
| $e + \text{Kr}$ | Excitation | 50.00 eV | Th |
| $e + \text{Kr}^*$ | Excitation | 50.00 eV | Th |
612. A. Neau, A. Derkach, F. Hellberg, S. Rosen, R. Thomas, M. Larsson, N. Djuric, D. B. Popovic, G. H. Dunn, J. Semaniak
Resonant ion pair formation of HD⁺: Absolute cross sections for the H⁻ + D⁺ channel.
 Phys. Rev. A **65**, 044701 (2002)
- | | | | |
|-----------------------|---------------|---------------|----|
| $e + \text{H}_2^{1+}$ | Dissociation | 1.00-16.00 eV | Ex |
| $e + \text{H}_2^{1+}$ | Recombination | 1.00-16.00 eV | Ex |
| $e + \text{HD}^{1+}$ | Dissociation | 1.00-16.00 eV | Ex |
| $e + \text{HD}^{1+}$ | Recombination | 1.00-16.00 eV | Ex |
613. A. Z. Msezane, Z. Felfli, D. Bessis
Angle-optimized energy-variable method for electron differential cross-section measurements.
 Phys. Rev. A **65**, 050701 (2002)
- | | | | |
|----------------|--------------------|--------|----|
| $e + \text{H}$ | Excitation | 0-∞ eV | Th |
| $e + \text{H}$ | Angular Scattering | 0-∞ eV | Th |
614. C. Tang, Z. Luo, Z. An, F. He, X. Peng, X. Long
L-shell ionization study of indium, tin, and rhenium by low-energy electron impact.
 Phys. Rev. A **65**, 052707 (2002)
- | | | | |
|-----------------|------------|----------------|-----|
| $e + \text{In}$ | Ionization | 4.00-50.00 keV | E/T |
| $e + \text{Sn}$ | Ionization | 4.00-50.00 keV | E/T |
| $e + \text{Re}$ | Ionization | 4.00-50.00 keV | E/T |
615. N. Djuric, M. E. Bannister, A. M. Derkach, D. C. Griffin, H. F. Krause, D. B. Popovic, A.C.H Smith, B. Wallbank, G. H. Dunn
Absolute cross sections for near-threshold electron-impact excitation of the dipole-allowed transitions 3s² 1S -¿ 3s3p 1P in Cl⁵⁺ and 3s 2S -¿ 3p 2P in Cl⁶⁺.
 Phys. Rev. A **65**, 052711 (2002)
- | | | | |
|----------------------|------------|-----------------|-----|
| $e + \text{Cl}^{5+}$ | Excitation | 14.00-180.00 eV | E/T |
| $e + \text{Cl}^{6+}$ | Excitation | 14.00-180.00 eV | E/T |
| $e + \text{Cl}^{5+}$ | Ionization | 14.00-180.00 eV | E/T |
| $e + \text{Cl}^{6+}$ | Ionization | 14.00-180.00 eV | E/T |
616. N. C. Deb, D.S.F Crothers
Electron-impact ionization of atomic hydrogen close to threshold.
 Phys. Rev. A **65**, 052721 (2002)
- | | | | |
|----------------|------------|---------------|-----|
| $e + \text{H}$ | Ionization | 0.30-31.00 eV | E/T |
|----------------|------------|---------------|-----|
617. S. Boehm, S. Schippers, W. Shi, A. Mueller, N. Ekloew, R. Schuch, H. Danared, N. R. Badnell, D. M. Mitnik, D. C. Griffin
Measurement of the field-induced dielectronic-recombination-rate enhancement of O⁵⁺ ions differential in the Rydberg quantum number n.
 Phys. Rev. A **65**, 052728 (2002)
- | | | | |
|---------------------|---------------|---------------|-----|
| $e + \text{O}^{5+}$ | Recombination | 2.00-12.00 eV | E/T |
|---------------------|---------------|---------------|-----|
618. K. Bartschat, S. Riordan, G. Ver Steeg
Extraction of energy-differential ionization cross sections in time-dependent calculations.
 Phys. Rev. A **65**, 060701 (2002)
- | | | | |
|----------------|------------|----------------|----|
| $e + \text{H}$ | Ionization | 20.00-40.80 eV | Th |
|----------------|------------|----------------|----|

619. J. B. Boffard, Jr. Stewart, M. D., C. C. Lin
Excitation transfer cross sections for levels of the Ne 2p⁵3d configuration.
 Phys. Rev. A **65**, 062701 (2002)

e + Ne	Excitation	10.00-180.00 eV	Ex
--------	------------	-----------------	----
620. M.-T. Lee, I. Iga, M.G.P. Homem, L. E. Machado, L. M. Brescansin
Elastic and absorption cross sections for electron-nitrous oxide collisions.
 Phys. Rev. A **65**, 062702 (2002)

e + N ₂ O	Total Scattering	20.00-800.00 eV	E/T
e + N ₂ O	Angular Scattering	20.00-800.00 eV	E/T
e + N ₂ O	Elastic Scattering	20.00-800.00 eV	E/T
621. T. W. Gorczyca, N. R. Badnell, D. W. Savin
Shortcomings of the R-matrix method for treating dielectronic recombination.
 Phys. Rev. A **65**, 062707 (2002)

e + Fe ¹⁷⁺	Recombination	0.10-135.00 eV	Th
-----------------------	---------------	----------------	----
622. V. V. Serov, B. B. Joulakian, D. V. Pavlov, I. V. Puzynin, S. I. Vitsitsky
(e,2e) ionization of H₂⁺ by fast electron impact: Application of the exact nonrelativistic two-center continuum wave.
 Phys. Rev. A **65**, 062708 (2002)

e + H ₂ ¹⁺	Angular Scattering	2.00 keV	Th
e + H ₂ ¹⁺	Ionization	2.00 keV	Th
623. M. A. Khakoo, J. Wrkich, M. Larsen, G. Kleiban, I. Kanik, S. Trajmar, M. J. Brunger, P.J.O. Teubner, A. Crowe, C. J. Fontes, R.E.H. Clark, V. Zeman, K. Bartschat, D. H. Madison, R. Srivastava, A. D. Stauffer
Differential cross sections and cross-section ratios for the electron-impact excitation of the neon 2p⁵3s configuration.
 Phys. Rev. A **65**, 062711 (2002)

e + Ne	Angular Scattering	20.00-100.00 eV	Ex
e + Ne	Excitation	20.00-100.00 eV	Ex
624. K. Bartschat, M. P. Scott, P. G. Burke, T. Stitt, N. S. Scott, A. N. Grum-Grzhimailo, S. Riordan, G. Ver Steeg, S. I. Strakhova
Convergence of energy-differential ionization cross sections obtained from a T-matrix approach with R-matrix wave functions.
 Phys. Rev. A **65**, 062715 (2002)

e + H	Excitation	20.00 eV	Th
-------	------------	----------	----
625. M. L. Keeler, L. W. Anderson, C. C. Lin
Electron-impact ionization cross section measurements out of the 5²P excited state of rubidium.
 Phys. Rev. Lett. **85**, 3353 (2000)

e + Rb	Ionization	40.00-300.00 eV	Ex
e + Rb*	Ionization	40.00-300.00 eV	Ex
626. A. Dorn, A. S. Kheifets, C. D. Schroeter, B. Najjari, C. Hoehr, R. Moshhammer, J. Ullrich
Double ionization of helium by electron-impact: Complete pictures of the four-body breakup dynamics.
 Phys. Rev. Lett. **86**, 3755 (2001)

e + He	Ionization	2.00 keV	Ex
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627. D. Strasser, L. Lammich, S. Krohn, M. Lange, H. Kreckel, J. Levin, D. Schwalm, Z. Vager, R. Wester, A. Wolf, D. Zajfman
Two- and three-body kinematical correlation in the dissociative recombination of H₃⁺.
 Phys. Rev. Lett. **86**, 779 (2000)

- | | | | | |
|--|----------------|---------------|----------|----|
| | $e + H_3^{1+}$ | Recombination | 6.00 meV | Ex |
|--|----------------|---------------|----------|----|
628. P. A. Zavodszky, H. Aliabadi, C. P. Bhalla, P. Richard, G. Toth, J. A. Tanis
Superelastic scattering of electrons from highly charged ions with inner shell vacancies.
 Phys. Rev. Lett. **87**, 033202 (2001)
- | | | | | |
|--|--------------|---------------|---------------|----|
| | $e + F^{7+}$ | De-excitation | 0.80-4.00 keV | Ex |
|--|--------------|---------------|---------------|----|
629. M. J. Brunger, S. J. Buckman
Electron-molecule scattering cross-sections. I. Experimental techniques and data for di-atomic molecules.
 Phys. Rep. **357**, 215 (2002)
- | | | | | |
|--|---------------------------|---------------------|--|-----|
| | $e + \text{perturbation}$ | Electron Collisions | | E/T |
|--|---------------------------|---------------------|--|-----|
630. M. F. Gadi, P. Defrance, A. Makhoute, M. H. Cherkani
Application of the semi-classical approximation to the single electron-impact ionization of helium-like ions.
 Phys. Scr. **63**, 462 (2001)
- | | | | | |
|--|---------------|------------|---------------|----|
| | $e + C^{4+}$ | Ionization | 0.40-7.00 keV | Th |
| | $e + N^{5+}$ | Ionization | 0.40-7.00 keV | Th |
| | $e + O^{6+}$ | Ionization | 0.40-7.00 keV | Th |
| | $e + Ne^{8+}$ | Ionization | 0.40-7.00 keV | Th |
631. D. Tankosic, L. C. Popovic, M. S. Dimitrijevic
Electron-impact broadening parameters for Ra II spectral lines.
 Phys. Scr. **63**, 54 (2001)
- | | | | | |
|--|---------------|-----------------|--------------|----|
| | $e + Ra^{1+}$ | Line Broadening | 5.00-50.00 K | Th |
|--|---------------|-----------------|--------------|----|
632. K. M. Aggarwal, F. P. Keenan, S. J. Rose
Electron impact excitation of Al XIII: Collision strengths and rate coefficients.
 Phys. Scr. **63**, 95 (2001)
- | | | | | |
|--|----------------|------------|--------------|----|
| | $e + Al^{12+}$ | Excitation | 0.01-10.00 K | Th |
|--|----------------|------------|--------------|----|
633. N. Rakstikas, A. Kupliauskiene
The influence of valence electron state on the 2p ionization of atomic sodium by electrons.
 Phys. Scr. **64**, 230 (2001)
- | | | | | |
|--|----------|------------|---------------|----|
| | $e + Na$ | Excitation | 0.05-1.00 keV | Th |
| | $e + Na$ | Ionization | 0.05-1.00 keV | Th |
634. R. Celiberto, R. K. Janev, A. Laricchiuta
Total and dissociative electron-impact cross sections for $X^1\Sigma_g^+ \rightarrow Z^1B^1\Sigma_u^+$ and $X^1\Sigma_g^+ \rightarrow Z^1C^1\Pi_u$ transitions of vibrationally excited tritium and neuterium-tritium molecules.
 Phys. Scr. **64**, 26 (2001)
- | | | | | |
|--|-----------|--------------|-----------|----|
| | $e + H_2$ | Dissociation | 200.00 eV | Th |
| | $e + DT$ | Dissociation | 200.00 eV | Th |
| | $e + T_2$ | Dissociation | 200.00 eV | Th |
| | $e + H_2$ | Excitation | 200.00 eV | Th |
| | $e + DT$ | Excitation | 200.00 eV | Th |
| | $e + T_2$ | Excitation | 200.00 eV | Th |
635. A. Willliart, G. Garcia
Analytical formulae for total cross sections for electron scattering by atoms (N, O, F, Ne, P, S, Cl, Ar, As, Se, Br, Kr) between 0.5-10 keV.
 Phys. Scr. **64**, 343 (2001)

- | | | | |
|-----------------|--------------------|----------------|----|
| $e + \text{Ne}$ | Ionization | 0.50-10.00 keV | Th |
| $e + \text{Ar}$ | Ionization | 0.50-10.00 keV | Th |
| $e + \text{Kr}$ | Ionization | 0.50-10.00 keV | Th |
| $e + \text{Ne}$ | Excitation | 0.50-10.00 keV | Th |
| $e + \text{Ar}$ | Excitation | 0.50-10.00 keV | Th |
| $e + \text{Kr}$ | Excitation | 0.50-10.00 keV | Th |
| $e + \text{Ne}$ | Elastic Scattering | 0.50-10.00 keV | Th |
| $e + \text{Ar}$ | Elastic Scattering | 0.50-10.00 keV | Th |
| $e + \text{Kr}$ | Elastic Scattering | 0.50-10.00 keV | Th |
636. K. M. Aggarwal, F. P. Keenan
Effective collision strengths for transitions within the ground configuration of Fe XXI.
 Phys. Scr. **64**, 439 (2001)
- | | | | |
|-----------------------|------------|--------------|----|
| $e + \text{Fe}^{21+}$ | Excitation | 0.10-10.00 K | Th |
|-----------------------|------------|--------------|----|
637. C. Blancard, M. Cornille, J. Dubau
Radiative and collisional atomic data for neon-like copper.
 Phys. Scr. **64**, 452 (2001)
- | | | | |
|-----------------------|------------|-----------|----|
| $e + \text{Cu}^{19+}$ | Excitation | 140.00 eV | Th |
|-----------------------|------------|-----------|----|
638. A. Le Padellec, K. Andersson, D. Hanstorp, F. Hellberg, M. Larsson, A. Neau, S. Rosen, H. T. Schmidt, R. Thomas, J. Semaniak, D. J. Pegg, F. Osterdahl, H. Dananred, A. Kallberg
Electron scattering on CN^- .
 Phys. Scr. **64**, 467 (2001)
- | | | | |
|-----------------------|------------|----------|----|
| $e + \text{CN}^{-1+}$ | Detachment | 60.00 eV | Ex |
|-----------------------|------------|----------|----|
639. P. Kolorenc, M. Cizek, J. Horacek, G. Mil'nikov, H. Nakamura
Study of dissociative electron attachment to HI molecule by using R-matrix representation for Green's function.
 Phys. Scr. **65**, 328 (2002)
- | | | | |
|-----------------|--------------|---------|----|
| $e + \text{HI}$ | Attachment | 1.00 eV | Th |
| $e + \text{HI}$ | Dissociation | 1.00 eV | Th |
640. K. M. Aggarwal, F. P. Keenan
Electron impact excitation of carbon-like calcium.
 Phys. Scr. **65**, 383 (2002)
- | | | | |
|-----------------------|------------|-----------------|----|
| $e + \text{Ca}^{14+}$ | Excitation | 50.00-300.00 Ry | Th |
|-----------------------|------------|-----------------|----|
641. S.Y.Y. Al-Mulla, L. Joensson
Local-density approximations to the elastic scattering of electrons from Mg and Ba atoms.
 Phys. Scr. **65**, 387 (2002)
- | | | | |
|-----------------|--------------------|-----------------|----|
| $e + \text{Mg}$ | Angular Scattering | 10.00-100.00 eV | Th |
| $e + \text{Ba}$ | Angular Scattering | 10.00-100.00 eV | Th |
| $e + \text{Mg}$ | Elastic Scattering | 10.00-100.00 eV | Th |
| $e + \text{Ba}$ | Elastic Scattering | 10.00-100.00 eV | Th |
642. P. G. Burke, C. J. Noble, A. G. Sunderland, V. M. Burke
Electron collisions with iron peak elements: A computational grand challenge.
 Phys. Scr. **T100**, 55 (2002)
- | | | | |
|----------------------|------------|--------------|----|
| $e + \text{Fe}^{1+}$ | Excitation | 0.00-10.00 K | Th |
| $e + \text{Ni}^{4+}$ | Excitation | 0.00-10.00 K | Th |
643. S. Schippers
Recombination of HCl with electrons – fundamental atomic physics and applications.
 Phys. Scr. **T80**, 158 (1999)

- | | | | |
|-----------------------|---------------|-----------|----|
| $e + \text{Cl}^{14+}$ | Recombination | 170.00 eV | Ex |
| $e + \text{Sc}^{3+}$ | Recombination | 170.00 eV | Ex |
| $e + \text{Au}^{76+}$ | Recombination | 170.00 eV | Ex |
| $e + \text{U}^{88+}$ | Recombination | 170.00 eV | Ex |
| $e + \text{U}^{89+}$ | Recombination | 170.00 eV | Ex |
644. B. Srigengan, P. McKenna, P. McGuinness, I. D. Williams
Elastic scattering of electrons from argon ions.
 Phys. Scr. **T80**, 272 (1999)
- | | | | |
|----------------------|--------------------|----------|----|
| $e + \text{Ar}^{2+}$ | Elastic Scattering | 16.00 eV | Ex |
| $e + \text{Ar}^{3+}$ | Elastic Scattering | 16.00 eV | Ex |
645. J. Matsumoto, Z. Wang, H. Tanuma, A. Danjo, M. Yoshino, N. Kobayashi
Angular distribution of elastically scattered electrons from Ar^{7+} .
 Phys. Scr. **T80**, 274 (1999)
- | | | | |
|----------------------|--------------------|-----------|----|
| $e + \text{Ar}^{7+}$ | Elastic Scattering | 100.00 eV | Ex |
|----------------------|--------------------|-----------|----|
646. J. B. Greenwood, S. J. Smith, A. Chutjian
Absolute measurements of electron excitation cross sections in C^{3+} .
 Phys. Scr. **T80**, 281 (1999)
- | | | | |
|---------------------|------------|---------------|----|
| $e + \text{C}^{3+}$ | Excitation | 6.00-13.00 eV | Ex |
|---------------------|------------|---------------|----|
647. A.C.H Smith, M. E. Bannister, Y.-S. Chung, N. L. Djuric, G. H. Dunn, B. Wallbank, O. Voitke
Near-threshold electron-impact excitation of multiply-charged Be-like ions.
 Phys. Scr. **T80**, 283 (1999)
- | | | | |
|---------------------|------------|----------------|----|
| $e + \text{C}^{2+}$ | Excitation | 12.00-21.00 eV | Ex |
| $e + \text{N}^{3+}$ | Excitation | 12.00-21.00 eV | Ex |
| $e + \text{O}^{4+}$ | Excitation | 12.00-21.00 eV | Ex |
648. M. Westermann, F. Scheuermann, K. Aichele, U. Hartenfeller, D. Hathiramani, M. Steidl, E. Salzborn
Multiple ionization of C^{q+} , N^{q+} and O^{q+} ions by electron impact.
 Phys. Scr. **T80**, 285 (1999)
- | | | | |
|---------------------|------------|----------------|----|
| $e + \text{C}^{1+}$ | Ionization | 0.05-10.00 keV | Ex |
| $e + \text{O}^{1+}$ | Ionization | 0.05-10.00 keV | Ex |
| $e + \text{O}^{2+}$ | Ionization | 0.05-10.00 keV | Ex |
| $e + \text{O}^{3+}$ | Ionization | 0.05-10.00 keV | Ex |
| $e + \text{O}^{4+}$ | Ionization | 0.05-10.00 keV | Ex |
649. M. Steidl, K. Aichele, U. Hartenfeller, D. Hathiramani, F. Scheuermann, M. Westermann, E. Salzborn
Electron impact ionization of gallium ions.
 Phys. Scr. **T80**, 287 (1999)
- | | | | |
|----------------------|------------|---------------|----|
| $e + \text{Ga}^{1+}$ | Ionization | 0.01-2.00 keV | Ex |
| $e + \text{Ga}^{3+}$ | Ionization | 0.01-2.00 keV | Ex |
650. E. Sokell, F. J. Currell, H. Shimizu, S. Ohtani
On the measurement of electron impact ionisation cross-sections for highly charged ions using an electron beam ion trap (EBIT).
 Phys. Scr. **T80**, 289 (1999)
- | | | | |
|-----------------------|------------|-----------|----|
| $e + \text{Ar}^{16+}$ | Ionization | 30.00 keV | Ex |
| $e + \text{Ar}^{17+}$ | Ionization | 30.00 keV | Ex |
651. S. Cherkani-Hassani, P. Defrance, E. M. Oualim
Electron impact ionization of nickel multiply-charged ions.
 Phys. Scr. **T80**, 292 (1999)
- | | | | |
|-----------------------|------------|---------------|----|
| $e + \text{Ni}^{12+}$ | Ionization | 0.20-5.00 keV | Ex |
| $e + \text{Ni}^{14+}$ | Ionization | 0.20-5.00 keV | Ex |

652. T. Pattard, J. M. Rost
Cross sections for (multiple) ionization of ions in collisions with electrons.
 Phys. Scr. **T80**, 295 (1999)
- | | | | |
|---------------|------------|----------------|----|
| $e + H$ | Ionization | 0.40-10.00 keV | Th |
| $e + He^{1+}$ | Ionization | 0.40-10.00 keV | Th |
| $e + Li^{2+}$ | Ionization | 0.40-10.00 keV | Th |
| $e + Be^{3+}$ | Ionization | 0.40-10.00 keV | Th |
| $e + B^{4+}$ | Ionization | 0.40-10.00 keV | Th |
| $e + C^{5+}$ | Ionization | 0.40-10.00 keV | Th |
| $e + N^{6+}$ | Ionization | 0.40-10.00 keV | Th |
| $e + O^{7+}$ | Ionization | 0.40-10.00 keV | Th |
| $e + F^{8+}$ | Ionization | 0.40-10.00 keV | Th |
| $e + Ne^{9+}$ | Ionization | 0.40-10.00 keV | Th |
653. A. Hoffknecht, T. Bartsch, S. Schippers, A. Mueller, N. Eklow, P. Glans, M. Beutelspacher, M. Grieser, G. Gwinner, A. A. Saghir, A. Wolf
Recombination of F^{6+} with free electrons at very low energies.
 Phys. Scr. **T80**, 298 (1999)
- | | | | |
|--------------|---------------|----------|----|
| $e + F^{6+}$ | Recombination | 15.00 eV | Ex |
|--------------|---------------|----------|----|
654. C. Biedermann, T. Fuchs, P. Liebisch, R. Radtke, E. Behar, R. Doron
X-ray spectroscopic measurements of dielectronic recombination of highly charged krypton ions.
 Phys. Scr. **T80**, 303 (1999)
- | | | | |
|----------------|---------------|----------------|----|
| $e + Kr^{32+}$ | Recombination | 8.00-10.00 keV | Ex |
| $e + Kr^{33+}$ | Recombination | 8.00-10.00 keV | Ex |
| $e + Kr^{34+}$ | Recombination | 8.00-10.00 keV | Ex |
655. T. Bartsch, A. Mueller, W. Spies, J. Linkemann, S. Schippers, C. Brandau, H. Danared, D. R. DeWitt, H. Gao, W. Zong, R. Schuch, A. Wolf, G. Gwinner, A. A. Saghir, M. Schmitt, M. Beutelspacher, M. Grieser, G. H. Dunn
Field enhanced dielectronic recombination of Si^{11+} and Cl^{14+} ions.
 Phys. Scr. **T80**, 305 (1999)
- | | | | |
|----------------|---------------|----------|----|
| $e + Si^{11+}$ | Recombination | 35.00 eV | Ex |
| $e + Cl^{14+}$ | Recombination | 35.00 eV | Ex |
656. M. F. Gu, P. Beiersdorfer, G. V. Brown, S. M. Kahn, D. A. Liedahl, K. J. Reed, D. W. Savin
Laboratory measurements of resonant contributions to Fe XXIV line emission.
 Phys. Scr. **T80**, 310 (1999)
- | | | | |
|----------------|------------|---------------|----|
| $e + Fe^{25+}$ | Excitation | 0.70-3.00 keV | Ex |
|----------------|------------|---------------|----|
657. S. Schippers, T. Bartsch, C. Brandau, A. Mueller, G. Gwinner, J. Linkemann, A. A. Saghir, A. Wolf
Photorecombination of Sc^{3+} and Ti^{4+} ions: search for interference effects and recombination at low energies.
 Phys. Scr. **T80**, 314 (1999)
- | | | | |
|---------------|---------------|--------------|----|
| $e + Ti^{4+}$ | Recombination | 0.00-1.00 eV | Ex |
|---------------|---------------|--------------|----|
658. A. Hoffknecht, O. Uwira, S. Schennach, A. Frank, J. Haselbauer, W. Spies, N. Angert, P. H. Mokler, R. L. Becker, M. Kleinod, S. Schippers, A. Mueller
Influence of magnetic fields on recombination rates of Au^{25+} .
 Phys. Scr. **T80**, 316 (1999)
- | | | | |
|----------------|---------------|--------------|----|
| $e + Au^{25+}$ | Recombination | 0.00-1.00 eV | Ex |
|----------------|---------------|--------------|----|
659. C. Brandau, T. Bartsch, C. Boehme, F. Bosch, G. H. Dunn, B. Franzke, A. Hoffknecht, C. Knocke, H. Knopp, C. Kozhuharov, A. Kraemer, P. H. Mokler, A. Mueller, F. Nolden, S. Schippers, Z. Stachura, M. Steck, T. Stoehlker, T. Winkler, A. Wolf
Recombination measurements of the heaviest ions.
 Phys. Scr. **T80**, 318 (1999)

- | | | | |
|-----------------------|---------------|----------------|----|
| $e + \text{Au}^{76+}$ | Recombination | 3.00-100.00 eV | Ex |
| $e + \text{Pb}^{79+}$ | Recombination | 3.00-100.00 eV | Ex |
| $e + \text{U}^{89+}$ | Recombination | 3.00-100.00 eV | Ex |
| $e + \text{Bi}^{80+}$ | Recombination | 3.00-100.00 eV | Ex |
| $e + \text{Bi}^{82+}$ | Recombination | 3.00-100.00 eV | Ex |
| $e + \text{Bi}^{83+}$ | Recombination | 3.00-100.00 eV | Ex |
660. T. Steih, K. Kollmar, N. Gruen, W. Scheid
Dielectronic recombination on highly charged ions.
 Phys. Scr. **T80**, 321 (1999)
- | | | | |
|-----------------------|---------------|---------------|----|
| $e + \text{Au}^{75+}$ | Recombination | 8.00-60.00 eV | Th |
| $e + \text{Au}^{76+}$ | Recombination | 8.00-60.00 eV | Th |
661. O. Brinzaescu, J. Eichler, A. Ichihara, T. Stoehlker
Comparison between the nonrelativistic dipole approximation and the exact relativistic theory for radiative recombination.
 Phys. Scr. **T80**, 324 (1999)
- | | | | |
|-----------------------|---------------|----------------|----|
| $e + \text{Ne}^{10+}$ | Recombination | 0.06-37.00 keV | Th |
| $e + \text{U}^{92+}$ | Recombination | 0.06-37.00 keV | Th |
662. P. Richard, C. Bhalla, S. Hagmann, P. Zavodsky
Quasi-free electron-ion scattering in ion-atom collisions.
 Phys. Scr. **T80**, 87 (1999)
- | | | | |
|---------------------|--------------------|---------------|----|
| $e + \text{C}^{6+}$ | Elastic Scattering | 0.55-3.00 keV | Th |
| $e + \text{F}^{4+}$ | Elastic Scattering | 0.55-3.00 keV | Th |
| $e + \text{F}^{9+}$ | Elastic Scattering | 0.55-3.00 keV | Th |
663. K. Aichele, W. Arnold, D. Hathiramani, F. Scheuermann, E. Salzborn
Electron-impact ionization of Samarium ions.
 Phys. Scr. **T92**, 262 (2001)
- | | | | |
|----------------------|------------|---------------|----|
| $e + \text{Sm}^{1+}$ | Ionization | 0.01-1.00 keV | Ex |
| $e + \text{Sm}^{2+}$ | Ionization | 0.01-1.00 keV | Ex |
| $e + \text{Sm}^{3+}$ | Ionization | 0.01-1.00 keV | Ex |
664. S. Cherkani-Hassani, M. Khouilid, P. Defrance
Electron impact single and double ionization of Ni^{q+} ions ($q=10, 11, 13$ and 15).
 Phys. Scr. **T92**, 287 (2001)
- | | | | |
|-----------------------|------------|---------------|----|
| $e + \text{Ni}^{10+}$ | Ionization | 0.20-5.00 keV | Ex |
| $e + \text{Ni}^{11+}$ | Ionization | 0.20-5.00 keV | Ex |
| $e + \text{Ni}^{13+}$ | Ionization | 0.20-5.00 keV | Ex |
| $e + \text{Ni}^{15+}$ | Ionization | 0.20-5.00 keV | Ex |
665. C. R. Stia, O. A. Fojon, R. D. Rivaola
($e, 2e$) reactions for He^+ and Li^{2+} ions from their excited states. Scaling law.
 Phys. Scr. **T92**, 303 (2001)
- | | | | |
|----------------------|------------|----------------|----|
| $e + \text{He}^{1+}$ | Ionization | 5.00-500.00 eV | Th |
| $e + \text{Li}^{2+}$ | Ionization | 5.00-500.00 eV | Th |
666. G. Gwinner, D. W. Savin, D. Schwalm, A. Wolf, S. Schippers, A. Mueller, N. R. Badnell, M. H. Chen
Dielectronic recombination of iron L-shell ions.
 Phys. Scr. **T92**, 319 (2001)
- | | | | |
|-----------------------|---------------|-----------|----|
| $e + \text{Fe}^{17+}$ | Recombination | 120.00 eV | Ex |
| $e + \text{Fe}^{18+}$ | Recombination | 120.00 eV | Ex |
| $e + \text{Fe}^{19+}$ | Recombination | 120.00 eV | Ex |
| $e + \text{Fe}^{20+}$ | Recombination | 120.00 eV | Ex |
| $e + \text{Fe}^{21+}$ | Recombination | 120.00 eV | Ex |

667. S. Madzunkov, N. Ekloew, E. Lindroth, M. Tokman, R. Schuch
Dielectronic recombination resonances in Kr^{33+} .
 Phys. Scr. **T92**, 357 (2001)

$\text{e} + \text{Kr}^{33+}$	Recombination	3.00-14.00 eV	Ex
------------------------------	---------------	---------------	----
668. J. Matsumoto, Z. Wang, A. Danjo, M. Yoshino, H. Tanuma, N. Kobayashi
Differential cross section measurements in electron-ion collisions using a toroidal analyzer.
 Phys. Scr. **T92**, 367 (2001)

$\text{e} + \text{Ar}^{7+}$	Angular Scattering	100.00 eV	Ex
$\text{e} + \text{Ar}^{8+}$	Angular Scattering	100.00 eV	Ex
$\text{e} + \text{Ar}^{7+}$	Elastic Scattering	100.00 eV	Ex
$\text{e} + \text{Ar}^{8+}$	Elastic Scattering	100.00 eV	Ex
669. P. McKenna, I. D. Williams
Differential cross section measurements for elastic scattering of electrons from Ar^{2+} and Xe^{2+} .
 Phys. Scr. **T92**, 370 (2001)

$\text{e} + \text{Ar}^{2+}$	Angular Scattering	16.00 eV	Ex
$\text{e} + \text{Xe}^{2+}$	Angular Scattering	16.00 eV	Ex
$\text{e} + \text{Ar}^{2+}$	Elastic Scattering	16.00 eV	Ex
$\text{e} + \text{Xe}^{2+}$	Elastic Scattering	16.00 eV	Ex
670. S. Kieslich, S. Boehm, A. Mueller, S. Schippers, W. Shi, G. Gwinner, M. Schnell, A. Wolf, E. Lindroth, M. Tokman
Photorecombination of lithium-like Sc^{18+} at threshold: a challenge for atomic structure theory.
 Phys. Scr. **T92**, 376 (2001)

$\text{e} + \text{Sc}^{18+}$	Recombination	50.00 eV	Ex
------------------------------	---------------	----------	----
671. H. Knopp, H. Teng, S. Ricz, S. Schippers, A. Mueller
Interference in electron-impact ionization of C^{3+} ions: unified R-matrix calculation and experiment.
 Phys. Scr. **T92**, 379 (2001)

$\text{e} + \text{C}^{3+}$	Ionization	0.05-1.00 keV	Th
----------------------------	------------	---------------	----
672. S. Schippers, T. Bartsch, S. Boehm, G. Gwinner, D. Schwalm, A. Wolf, R. A. Phaneuf, R. H. Schuch, A. Mueller
Field enhanced dielectronic recombination of lithiumlike Ti^{19+} and Ni^{25+} ions.
 Phys. Scr. **T92**, 391 (2001)

$\text{e} + \text{Ti}^{19+}$	Recombination		Ex
$\text{e} + \text{Ni}^{25+}$	Recombination		Ex
673. S. Boehm, S. Schippers, W. Shi, A. Mueller, N. Djuric, G. H. Dunn, W. Zong, B. Jelencovic, N. Eklow, P. Glans, R. Schuch, H. Dananred, N. R. Badnell
Influence of electromagnetic fields on the dielectronic recombination of Ne^{7+} and O^{5+} ions.
 Phys. Scr. **T92**, 395 (2001)

$\text{e} + \text{O}^{5+}$	Recombination		Ex
$\text{e} + \text{Ne}^{7+}$	Recombination		Ex
674. A. Hoffknecht, C. Brandau, T. Bartsch, C. Coehme, H. Knopp, S. Schippers, A. Mueller, C. Kozhuharov, K. Beckert, F. Bosch, B. Franzke, A. Kraemer, P. H. Mokler, F. Nolden, M. Steck, Th. Stoehlker, Z. Stachura
Recombination of bare Bi^{83+} ions with electrons.
 Phys. Scr. **T92**, 398 (2001)

$\text{e} + \text{Bi}^{83+}$	Recombination	0.00-100.00 eV	Ex
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675. A. Hoffknecht, S. Schippers, A. Mueller, G. Gwinner, D. Schwalm, A. Wolf
Recombination of bare Cl^{17+} ions in an electron cooler.
 Phys. Scr. **T92**, 402 (2001)
 $\text{e} + \text{Cl}^{17+}$ Recombination 0.00-0.01 eV Ex
676. M. Tokman, P. Glans, E. Lindroth, R. Schuch, M. Bjoerkhage, H. Danared, A. Kaellberg, M. Pajek, L.-O. Norlin
Towards a determination of QED effects in Cu-like Pb recombination resonances near threshold.
 Phys. Scr. **T92**, 406 (2001)
 $\text{e} + \text{Pb}^{53+}$ Recombination 0.06 eV Th
677. H. Teng, A. Mueller, G. Hofmann, E. Salzborn, R. A. Phaneuf
Autoionizing resonances in electron-impact ionization of O^{5+} ions.
 Phys. Scr. **T92**, 441 (2001)
 $\text{e} + \text{O}^{5+}$ Ionization 400.00-750.00 eV Ex
678. A. Yu. Pigarov
Collisional radiative kinetics of molecular assisted recombination in edge plasmas.
 Phys. Scr. **T96**, 16 (2002)
 $\text{e} + \text{H}_2^{1+}$ Recombination 0.10-10.00 eV Th
 $\text{e} + \text{H}_2$ Excitation 0.10-10.00 eV Th
 $\text{e} + \text{H}_2^{1+}$ Excitation 0.10-10.00 eV Th
 $\text{e} + \text{H}_2$ Dissociation 0.10-10.00 eV Th
 $\text{e} + \text{H}_2^{1+}$ Dissociation 0.10-10.00 eV Th
 $\text{e} + \text{H}_2$ Ionization 0.10-10.00 eV Th
679. R. Celiberto, M. Capitelli, A. Laricchiuta
Towards a cross section database of excited atomic and molecular hydrogen.
 Phys. Scr. **T96**, 32 (2002)
 $\text{e} + \text{H}_2$ Excitation 100.00 eV Th
 $\text{e} + \text{H}_2$ Ionization 100.00 eV Th
 $\text{e} + \text{H}_2$ Dissociation 100.00 eV Th
680. I. I. Fabrikant, J. M. Wadehra, Y. Xu
Resonance processes in e-H_2 collisions: Dissociative attachment and dissociation from vibrationally and rotationally excited states.
 Phys. Scr. **T96**, 45 (2002)
 $\text{e} + \text{H}_2$ Attachment 5.00 eV Th
 $\text{e} + \text{H}_2$ Dissociation 5.00 eV Th
681. H. Takagi
Dissociative recombination and excitation of H_2^+ , HD^+ , and D_2^+ with electrons for various vibrational states.
 Phys. Scr. **T96**, 52 (2002)
 $\text{e} + \text{H}_2^{1+}$ Recombination 12.00 eV Th
 $\text{e} + \text{HD}^{1+}$ Recombination 12.00 eV Th
 $\text{e} + \text{D}_2^{1+}$ Recombination 12.00 eV Th
 $\text{e} + \text{H}_2^{1+}$ Dissociation 12.00 eV Th
 $\text{e} + \text{HD}^{1+}$ Dissociation 12.00 eV Th
 $\text{e} + \text{D}_2^{1+}$ Dissociation 12.00 eV Th
682. S. I. Krashenninnikov
Molecule assisted recombination (MAR): Mechanisms and plasma conditions for effective operation.
 Phys. Scr. **T96**, 7 (2002)

$e + H_2^{1+}$	Recombination	Th
$e + H_2$	Dissociation	Th
$e + H_2^{1+}$	Dissociation	Th
$e + H_2^{1+}$	Dissociation	Th
$e + H_3^{1+}$	Dissociation	Th

683. R. K. Janev

Alternative mechanisms for divertor plasma recombination.

Phys. Scr. **T96**, 94 (2002)

$e + CH_4^{1+}$	Recombination	0.10-30.00 eV	Th
$e + C_2H_4^{1+}$	Recombination	0.10-30.00 eV	Th
$e + C_2H_6^{1+}$	Recombination	0.10-30.00 eV	Th
$e + C_3H_8^{1+}$	Recombination	0.10-30.00 eV	Th
$e + CH_4^{1+}$	Dissociation	0.10-30.00 eV	Th
$e + C_2H_4^{1+}$	Dissociation	0.10-30.00 eV	Th
$e + C_2H_6^{1+}$	Dissociation	0.10-30.00 eV	Th
$e + C_3H_8^{1+}$	Dissociation	0.10-30.00 eV	Th
$e + H^{1+}$	Recombination	0.10-30.00 eV	Th
$e + H_2$	Excitation	0.10-30.00 eV	Th

3.2.3 Heavy Particle Collisions

684. M.-L. Dubernet, A. Grosjean

Collisional excitation rates of H_2O with H_2 . I. Pure rotational excitation rates with para- H_2 at very low temperatures.

Astron. Astrophys. **390**, 793 (2002)

$H_2 + H_2O$	Interchange reaction	5.00-20.00 K	Th
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685. H. Gao, V.H.S Kwong

Charge transfer of O^{5+} and O^{4+} with CO at keV energies.

Astrophys. J., Part 1 **567**, 1272 (2002)

$O^{4+} + CO$	Charge Transfer	6.80-8.50 keV	Ex
$O^{5+} + CO$	Charge Transfer	6.80-8.50 keV	Ex

686. N. Balakrishnan, M. Yan, A. Dalgarno

Quantum-mechanical study of rotational and vibrational transitions in CO induced by H atoms.

Astrophys. J., Part 1 **568**, 443 (2002)

$H + CO$	Excitation	0.01-3.00 K	Th
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687. C. Cecchi-Pestellini, E. Bodo, N. Balakrishnan, A. Dalgarno

Rotational and vibrational excitation of CO molecules by collisions with 4He atoms.

Astrophys. J., Part 1 **571**, 1015 (2002)

$He + CO$	Excitation	0.00-0.07 eV	Th
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688. A. Ekers, M. Glodz, V. Grushevsky, J. Klavins, J. Szonert

Energy transfer between the 2S and 2D states in alkalis: experiments and theory.

Can. J. Phys. **79**, 1039 (2001)

$Li + Li$	Energy Transfer	E/T
$Li^* + Li$	Energy Transfer	E/T
$Na + Na$	Energy Transfer	E/T
$Na^* + Na$	Energy Transfer	E/T
$Na + Rb$	Energy Transfer	E/T
$Na^* + Rb$	Energy Transfer	E/T

$K + Na$	Energy Transfer	E/T
$K^* + Na$	Energy Transfer	E/T
$K + K$	Energy Transfer	E/T
$K^* + K$	Energy Transfer	E/T
$K + Rb$	Energy Transfer	E/T
$K^* + Rb$	Energy Transfer	E/T
$Rb + Rb$	Energy Transfer	E/T
$Rb^* + Rb$	Energy Transfer	E/T
$Cs + Cs$	Energy Transfer	E/T
$Cs^* + Cs$	Energy Transfer	E/T

689. A. A. Vasilyev, H. Tawara, P. Richard, U. I. Safronova

Observation and analysis (synthesis) of X-ray spectrum originated from electron capture of low-energy, highly charged Xe^{q+} ($q = 26-43$) ions in single collisions with Ar atom.

Can. J. Phys. **80**, 65 (2002)

$Xe^{26+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{27+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{28+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{29+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{30+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{31+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{32+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{33+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{34+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{35+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{36+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{37+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{38+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{39+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{40+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{41+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{42+} + Ar$	Charge Transfer	0.74 keV/amu	Ex
$Xe^{43+} + Ar$	Charge Transfer	0.74 keV/amu	Ex

690. E. Traebert, H.-P. Garnir, P.-D. Dumont, T. Bastin

Singlet-triplet excitation ratios in Ne III, Ar III and N II under ion impact.

Eur. Phys. J. D **15**, 25 (2001)

$H^{1+} + N_2$	Excitation	0.01-1.00 MeV/amu	Ex
$H^{1+} + Ne$	Excitation	0.01-1.00 MeV/amu	Ex
$H^{1+} + Ar$	Excitation	0.01-1.00 MeV/amu	Ex
$H_2^{1+} + N_2$	Excitation	0.01-1.00 MeV/amu	Ex
$H_2^{1+} + N_2$	Excitation	0.01-1.00 MeV/amu	Ex
$H_2^{1+} + Ne$	Excitation	0.01-1.00 MeV/amu	Ex
$H_2^{1+} + Ar$	Excitation	0.01-1.00 MeV/amu	Ex
$H_2^{1+} + Ar$	Excitation	0.01-1.00 MeV/amu	Ex
$He^{1+} + N_2$	Excitation	0.01-1.00 MeV/amu	Ex
$He^{1+} + Ne$	Excitation	0.01-1.00 MeV/amu	Ex
$He^{1+} + Ar$	Excitation	0.01-1.00 MeV/amu	Ex
$He^{2+} + Ne$	Excitation	0.01-1.00 MeV/amu	Ex
$N_2^{1+} + N_2$	Excitation	0.01-1.00 MeV/amu	Ex
$N_2^{1+} + Ne$	Excitation	0.01-1.00 MeV/amu	Ex
$N_2^{1+} + Ar$	Excitation	0.01-1.00 MeV/amu	Ex
$Ne^{1+} + N_2$	Excitation	0.01-1.00 MeV/amu	Ex
$Ne^{1+} + Ne$	Excitation	0.01-1.00 MeV/amu	Ex
$Ne^{1+} + Ar$	Excitation	0.01-1.00 MeV/amu	Ex
$Ar^{1+} + N_2$	Excitation	0.01-1.00 MeV/amu	Ex
$Ar^{1+} + Ne$	Excitation	0.01-1.00 MeV/amu	Ex

- | | | | | |
|--|-----------------------------|------------|-------------------|----|
| | Ar¹⁺ + Ar | Excitation | 0.01-1.00 MeV/amu | Ex |
|--|-----------------------------|------------|-------------------|----|
691. D. C. Ionescu, A. Belkacem
Dynamics of ionization mechanisms in relativistic collisions involving heavy and highly-charged ions.
Eur. Phys. J. D **18**, 301 (2002)
- | | | | | |
|--|---|------------|----------------|----|
| | Au⁷⁹⁺ + U⁹¹⁺ | Ionization | 100.00 MeV/amu | Th |
|--|---|------------|----------------|----|
692. J. F. Kielkopf, N. F. Allard, A. Decrette
Study of the far wing of the Balmer α line of hydrogen perturbed by collisions with protons. Balmer α .
Eur. Phys. J. D **18**, 51 (2002)
- | | | | | |
|--|----------------------------|-----------------|--------------|-----|
| | H¹⁺ + H | Line Broadening | 4.00-10.00 K | E/T |
| | H¹⁺ + H* | Line Broadening | 4.00-10.00 K | E/T |
693. A. Nurmela, P. Pusa, E. Rauhala, J. Raesaenen
⁴He+Ni elastic scattering near the Coulomb barrier and optical model parameters.
J. Appl. Phys. **91**, 2438 (2002)
- | | | | | |
|--|-----------------------------|--------------------|----------------|-----|
| | He¹⁺ + Ni | Total Scattering | 3.90-14.30 MeV | E/T |
| | He¹⁺ + Ni | Elastic Scattering | 3.90-14.30 MeV | E/T |
694. J. S. Miller, S. H. Pullins, D. J. Levandier, Y.-H. Chiu, R. A. Dressler
Xenon charge exchange cross sections for electrostatic thruster models.
J. Appl. Phys. **91**, 984 (2002)
- | | | | | |
|--|-----------------------------|------------------------|----------------|-----|
| | Xe¹⁺ + Xe | Interaction Potentials | 1.00-300.00 eV | E/T |
| | Xe²⁺ + Xe | Interaction Potentials | 1.00-300.00 eV | E/T |
| | Xe¹⁺ + Xe | Charge Transfer | 1.00-300.00 eV | E/T |
| | Xe²⁺ + Xe | Charge Transfer | 1.00-300.00 eV | E/T |
695. E. M. Goldfield, A.J.H.M. Meijer
Time-dependent quantum mechanical calculations on H+O₂ for total angular momentum J_t=0. III. Total cross sections.
J. Chem. Phys. **113**, 11055 (2000)
- | | | | | |
|--|--------------------------|----------------------|----------|----|
| | H + O₂ | Interchange reaction | 9.04 keV | Th |
|--|--------------------------|----------------------|----------|----|
696. F. J. Aoiz, L. Banares, J. F. Castillo
On the existence of resonances in the H + D₂ -> HD(v' = 0, j' = 7) + D reaction at collision energies 0.6-1.3 eV.
J. Chem. Phys. **114**, 8237 (2001)
- | | | | | |
|--|--------------------------|----------------------|--------------|----|
| | H + H₂ | Interchange reaction | 0.60-1.30 eV | Th |
| | H + D₂ | Interchange reaction | 0.60-1.30 eV | Th |
697. B. K. Kendrick
Quantum reactive scattering calculations for the H+D₂ -> HD+D reaction.
J. Chem. Phys. **114**, 8796 (2001)
- | | | | | |
|--|--------------------------|----------------------|--------------|----|
| | H + H₂ | Interchange reaction | 0.50-1.90 eV | Th |
| | H + D₂ | Interchange reaction | 0.50-1.90 eV | Th |
698. B. Bussery-Honvault, P. Honvault, J.-M. Launay
A study of the C(¹D) + H₂ -> CH + H reaction: Global potential energy surface and quantum dynamics.
J. Chem. Phys. **115**, 10701 (2001)
- | | | | | |
|--|---------------------------|----------------------|----------------|----|
| | C + H₂ | Interchange reaction | 12.00 kcal/mol | Th |
| | C* + H₂ | Interchange reaction | 12.00 kcal/mol | Th |

699. F. J. Aoiz, L. Banares, J. F. Castillo, M. Menendez
A quantum mechanical and quasi-classical trajectory study of the $\text{Cl} + \text{H}_2$ reaction and its isotopic variants: Dependence of the integral cross section on the collision energy and reagent rotation.
 J. Chem. Phys. **115**, 2074 (2001)

$\text{Cl} + \text{H}_2$	Interchange reaction	0.10-0.40 eV	Th
--------------------------	----------------------	--------------	----
700. M. Tsuji, T. Tsuji, T. Hamagami, K. Nakano
Effects of vibrational excitation of target N_2 molecule in charge-transfer reaction of He^+ with N_2 at thermal energy.
 J. Chem. Phys. **115**, 6811 (2001)

$\text{He}^{1+} + \text{N}_2$	Charge Transfer	0.10 eV	Ex
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701. D. di Domenico, M. I. Hernandez, J. C. Martinez
Wave packet calculations for $\text{H}_2(\nu_1=10-14) + \text{H}_2(\nu_2=0-2)$: Reaction and dissociation mechanisms.
 J. Chem. Phys. **115**, 7897 (2001)

$\text{H}_2 + \text{H}_2$	Interchange reaction	5.00 eV	Th
---------------------------	----------------------	---------	----
702. S. Sukiasyan, H.-D. Meyer
Reaction cross sections for the $\text{H} + \text{D}_2(\nu_0=1) \rightarrow \text{HD} + \text{D}$ and $\text{D} + \text{H}_2(\nu_0=1) \rightarrow \text{DH} + \text{H}$ systems. A multiconfiguration time-dependent Hartree (MCTDH) wave packet propagation study.
 J. Chem. Phys. **116**, 10641 (2002)

$\text{H} + \text{H}_2$	Interchange reaction	1.60 eV	Th
$\text{H} + \text{D}_2$	Interchange reaction	1.60 eV	Th
$\text{D} + \text{H}_2$	Interchange reaction	1.60 eV	Th
703. A. P. Palov, P. Jimeno, M. D. Gray, D. Field, G. G. Balint-Kurti
Vibrationally-rotationally inelastic cross sections for $\text{H} + \text{SiO}$ collisions.
 J. Chem. Phys. **116**, 1388 (2002)

$\text{H} + \text{SiO}$	Excitation	0.20-9.60 K	Th
-------------------------	------------	-------------	----
704. D. H. Zhang, M. Yang, S.-Y. Lee
Quantum dynamics of the $\text{D}_2 + \text{OH}$ reaction.
 J. Chem. Phys. **116**, 2388 (2002)

$\text{H}_2 + \text{OH}$	Interchange reaction	0.50 eV	Th
$\text{D}_2 + \text{OH}$	Interchange reaction	0.50 eV	Th
705. T. Takayanagi
Nonadiabatic quantum reactive scattering calculations for the $\text{O}(^1\text{D}) + \text{H}_2$, D_2 , and HD reactions on the lowest three potential energy surfaces.
 J. Chem. Phys. **116**, 2439 (2002)

$\text{O} + \text{H}_2$	Interchange reaction	0.50 eV	Th
-------------------------	----------------------	---------	----
706. R. Cabrera-Trujillo, Y. Ohrn, E. Deumens, J. R. Sabin
Trajectory and molecular binding effects in stopping cross section for hydrogen beams on H_2 .
 J. Chem. Phys. **116**, 2783 (2002)

$\text{H} + \text{H}_2$	Charge Transfer	0.01-25.00 keV	Th
$\text{H}^{1+} + \text{H}$	Charge Transfer	0.01-25.00 keV	Th
$\text{H}^{1+} + \text{H}_2$	Charge Transfer	0.01-25.00 keV	Th
707. S. A. Harich, D. Dai, X. Yang, S. Der Chao, R. T. Skodje
State-to-state dynamics of $\text{H} + \text{HD} \rightarrow \text{H}_2 + \text{D}$ at 0.5 eV: A combined theoretical and experimental study.
 J. Chem. Phys. **116**, 4769 (2002)

- | | | | |
|-------------------------|----------------------|---------|----|
| $\text{H} + \text{H}_2$ | Interchange reaction | 0.50 eV | Ex |
| $\text{H} + \text{HD}$ | Interchange reaction | 0.50 eV | Ex |
708. B. D. Bean, J. D. Ayers, F. Fernandez-Alonso, R. N. Zare
State-resolved differential and integral cross sections for the reaction $\text{H} + \text{D}_2 \rightarrow \text{HD} (\nu' = 3, j = 0-7) + \text{D}$ at 1.64 eV collision energy.
J. Chem. Phys. **116**, 6634 (2002)
- | | | | |
|-------------------------|----------------------|---------|----|
| $\text{H} + \text{H}_2$ | Interchange reaction | 1.64 eV | Ex |
| $\text{H} + \text{D}_2$ | Interchange reaction | 1.64 eV | Ex |
709. F. J. Aoiz, L. Banares, J. F. Castillo
Energy dependence of forward scattering in the differential cross section of the $\text{H} + \text{D}_2 \rightarrow \text{HD} (\nu'=3, j'=0) + \text{D}$ reaction.
J. Chem. Phys. **117**, 2546 (2002)
- | | | | |
|-------------------------|----------------------|--------------|----|
| $\text{H} + \text{H}_2$ | Interchange reaction | 1.39-2.20 eV | Th |
| $\text{H} + \text{D}_2$ | Interchange reaction | 1.39-2.20 eV | Th |
710. S. Y. Lin, H. Guo
Full-dimensional quantum wave packet study of rotationally inelastic transitions in $\text{H}_2 + \text{H-2}$ collision.
J. Chem. Phys. **117**, 5183 (2002)
- | | | | |
|---------------------------|---------------|---------|----|
| $\text{H}_2 + \text{H}_2$ | De-excitation | 1.20 eV | Th |
|---------------------------|---------------|---------|----|
711. D. Voulot, D. R. Gillen, D. M. Kearns, R. W. McCullough, H. B. Gilbody
State-selective one-electron capture by slow state-prepared $\text{N}^{2+} (^2\text{P})$ ground-state ions in collisions with hydrogen atoms.
J. Phys. B **34**, 1039 (2001)
- | | | | |
|----------------------------|-----------------|---------------|----|
| $\text{N}^{2+} + \text{H}$ | Charge Transfer | 0.80-6.00 keV | Ex |
|----------------------------|-----------------|---------------|----|
712. I. Ben-Itzhak, E. Wells, D. Studanski, V. Krishnamurthi, K. D. Carnes, H. Knudsen
Double and single ionization of hydrogen molecules by fast-proton impact.
J. Phys. B **34**, 1143 (2001)
- | | | | |
|------------------------------|------------|-----------------|----|
| $\text{H}^{1+} + \text{H}_2$ | Ionization | 4.00-24.00 a.u. | Ex |
| $\text{H}^{1+} + \text{HD}$ | Ionization | 4.00-24.00 a.u. | Ex |
713. R. E. Olson, C. R. Feeler
Double-electron removal from H_2 by slow, highly charged Xe^{23+} ions.
J. Phys. B **34**, 1163 (2001)
- | | | | |
|--------------------------------|------------------|-------------------|----|
| $\text{Xe}^{23+} + \text{H}_2$ | Total Scattering | 0.00-2.60 keV/amu | Th |
| $\text{Xe}^{23+} + \text{H}_2$ | Charge Transfer | 0.00-2.60 keV/amu | Th |
714. D. Rabli, M. Gargaud, R. McCarroll
Electron capture in low-energy collisions of Si^{3+} with He.
J. Phys. B **34**, 1395 (2001)
- | | | | |
|------------------------------|-----------------|--------------------|----|
| $\text{Si}^{3+} + \text{He}$ | Charge Transfer | 1.58-250.00 eV/amu | Th |
|------------------------------|-----------------|--------------------|----|
715. L. Gulyas, P. D. Fainstein, T. Shirai
Multiple-scattering analysis of triply differential cross sections for electron emission in energetic ion-atom collisions.
J. Phys. B **34**, 1473 (2001)
- | | | | |
|----------------------------|-----------------|----------|----|
| $\text{H}^{1+} + \text{H}$ | Charge Transfer | 5.00 MeV | Th |
| $\text{H}^{1+} + \text{H}$ | Ionization | 5.00 MeV | Th |
716. P. G. Reyes, F. Castillo, H. Martinez
Experimental study of single-electron loss by Ar^+ ions in rare-gas atoms.
J. Phys. B **34**, 1485 (2001)

- | | | | |
|------------------------------|------------|---------------|----|
| $\text{Ar}^{1+} + \text{Ne}$ | Ionization | 1.50-5.00 keV | Ex |
| $\text{Ar}^{1+} + \text{Ar}$ | Ionization | 1.50-5.00 keV | Ex |
| $\text{Ar}^{1+} + \text{Kr}$ | Ionization | 1.50-5.00 keV | Ex |
| $\text{Ar}^{1+} + \text{Xe}$ | Ionization | 1.50-5.00 keV | Ex |
717. J. Fu, M. J. Fitzpatrick, J. F. Reading, R. Gayet
Finite Hilbert basis set calculations of the ejected electron energy spectrum for an ion-atom collision illustrated for proton-hydrogen scattering at 48 and 114 keV.
J. Phys. B **34**, 15 (2001)
- | | | | |
|----------------------------|------------------|------------------|----|
| $\text{H}^{1+} + \text{H}$ | Total Scattering | 48.00-114.00 keV | Th |
| $\text{H}^{1+} + \text{H}$ | Ionization | 48.00-114.00 keV | Th |
718. J.-M. Zhu, B.-L. Zhou, Z.-C. Yan
Long-range interactions for $\text{H}(1s)\text{-He}(n^{1,3}\text{P})$, $\text{H}(1s)\text{-Li}(\text{N}^2\text{P})$ and $\text{He}(1^1\text{S})\text{-Li}(n^2\text{P})$ systems.
J. Phys. B **34**, 1535 (2001)
- | | | | |
|-------------------------|------------------------|--|----|
| $\text{H} + \text{He}$ | Interaction Potentials | | Th |
| $\text{H} + \text{Li}$ | Interaction Potentials | | Th |
| $\text{He} + \text{Li}$ | Interaction Potentials | | Th |
719. M. J. Frost, S. Himmelmann, D. D. Palmer
Laser-induced fluorescence studies of elementary processes in a helium plasma following He $3^3\text{P}\text{-}2^3\text{S}$ and $3^1\text{P}\text{-}2^1\text{S}$ excitation.
J. Phys. B **34**, 1569 (2001)
- | | | | |
|-------------------------|-----------------|----------|----|
| $\text{He} + \text{He}$ | Association | 300.00 K | Ex |
| $\text{He} + \text{He}$ | De-excitation | 300.00 K | Ex |
| $\text{He} + \text{He}$ | Energy Transfer | 300.00 K | Ex |
| $\text{He} + \text{He}$ | Excitation | 300.00 K | Ex |
720. S. Demianiuk, K. Kolwas
Dynamics of spontaneous growth of light-induced sodium droplets from the vapour phase.
J. Phys. B **34**, 1651 (2001)
- | | | | |
|-------------------------|-------------|-----------------|----|
| $\text{Na} + \text{Na}$ | Association | 663.00-723.00 K | Ex |
|-------------------------|-------------|-----------------|----|
721. A. B. Voitkiv, J. Ullrich
Binary-encounter electron emission in fast atomic collisions in the presence of coherent electromagnetic radiation.
J. Phys. B **34**, 1673 (2001)
- | | | | |
|-----------------------------|------------|--|----|
| $\text{He}^{2+} + \text{H}$ | Ionization | | Th |
|-----------------------------|------------|--|----|
722. A. M. Paterson, D. J. Smith, I. S. Borthwick, R. S. Stewart
Investigation of the neon $2p$ collisional excitation transfer processes via CW laser collisionally induced fluorescence.
J. Phys. B **34**, 1815 (2001)
- | | | | |
|-------------------------|-----------------|-----------------|----|
| $\text{Ne} + \text{Ne}$ | Energy Transfer | 1.00-10.00 Torr | Ex |
|-------------------------|-----------------|-----------------|----|
723. B. G. Lindsay, R. Rejoub, D. R. Sieglaff, R. F. Stebbings
Charge transfer of keV O^+ ions with CO and H_2O .
J. Phys. B **34**, 2159 (2001)
- | | | | |
|--------------------------------------|-----------------|---------------|----|
| $\text{O}^{1+} + \text{H}_2\text{O}$ | Charge Transfer | 0.50-5.00 keV | Ex |
| $\text{O}^{1+} + \text{CO}$ | Charge Transfer | 0.50-5.00 keV | Ex |
724. E. Bichoutskaia, A. Z. Devdariani, K. Ohmori, O. Misaki, K. Ueda, Y. Sato
Spectroscopy of quasimolecular optical transitions: $\text{Ca}(4s^2^1\text{S}_0\text{-}4s4p^1\text{P}, 4s3d^1\text{D}_2)\text{-He}$. The influence of radiation width.
J. Phys. B **34**, 2301 (2001)

- | | | | | |
|--|-----------------|------------|--------------|----|
| | Ca* + He | Excitation | 2.61-2.78 eV | Th |
| | Ca + He | Excitation | 2.61-2.78 eV | Th |
725. T. Grycuk, W. Behmenburg, V. Staemmler
Quantum calculation of the excitation spectra of Li*He probing interaction potentials and dipole moments.
J. Phys. B **34**, 245 (2001)
- | | | | | |
|--|----------------|------------------------|--------------|----|
| | Li + He | Interaction Potentials | 0.50-0.99 eV | Th |
|--|----------------|------------------------|--------------|----|
726. P. C. Stancil, A. R. Turner, D. L. Cooper, D. R. Schultz, M. J. Rakovic, W. Fritsch, B. Zygelman
Electron capture in collisions of S⁴⁺ with atomic hydrogen.
J. Phys. B **34**, 2481 (2001)
- | | | | | |
|--|---------------------------|-----------------|--------------------|----|
| | S⁴⁺ + H | Charge Transfer | 0.00-10.00 MeV/amu | Th |
|--|---------------------------|-----------------|--------------------|----|
727. A. L. Godunov, H. Merabet, J. H. McGuire, R. F. Bruch, J. Hanni, V. S. Schipakov
Magnetic sublevel population in 1s-2p excitation of helium by fast electrons and protons.
J. Phys. B **34**, 2575 (2001)
- | | | | | |
|--|----------------------------|------------|----------------|-----|
| | H¹⁺ + He | Excitation | 3.00-8.50 a.u. | E/T |
|--|----------------------------|------------|----------------|-----|
728. M. I. Chibisov, R. K. Janev, X. Urbain, F. Brouillard
Electron capture and excitation in slow H⁺ + He* (n=3) collisions.
J. Phys. B **34**, 2631 (2001)
- | | | | | |
|--|-----------------------------|-----------------|---|----|
| | H¹⁺ + He* | Excitation | 2x10 ⁶ -1.3x10 ⁸ cm/s | Th |
| | H¹⁺ + He | Excitation | 2x10 ⁶ -1.3x10 ⁸ cm/s | Th |
| | H¹⁺ + He* | Charge Transfer | 2x10 ⁶ -1.3x10 ⁸ cm/s | Th |
| | H¹⁺ + He | Charge Transfer | 2x10 ⁶ -1.3x10 ⁸ cm/s | Th |
729. A. B. Voitkiv, N. Gruen
Electron cusp from projectiles in ultrarelativistic collisions with atoms.
J. Phys. B **34**, 267 (2001)
- | | | | | |
|--|------------------------------|------------|-----------|----|
| | S¹⁵⁺ + Al | Ionization | 33.00 TeV | Th |
| | Pb⁸¹⁺ + Al | Ionization | 33.00 TeV | Th |
730. D. Azinovic, S. Milosevic, G. Pichler
Resonance 2s-2p excitation of lithium in the Li + Cd system.
J. Phys. B **34**, 2715 (2001)
- | | | | | |
|--|----------------|------------|----------|----|
| | Li + Cd | Excitation | 965.00 K | Ex |
|--|----------------|------------|----------|----|
731. D. R. Flower
The rotational excitation of CO by H₂.
J. Phys. B **34**, 2731 (2001)
- | | | | | |
|--|---------------------------|-----------------|---------------|----|
| | CO + H₂ | Energy Transfer | 6.00-100.00 K | Th |
| | CO + H₂ | Excitation | 6.00-100.00 K | Th |
732. D. R. Schultz, P. C. Stancil, M. J. Rakovic
Classical/quantal correspondence in state-selective charge transfer for partially stripped ion impact on atomic hydrogen: improvements to the CTMC method.
J. Phys. B **34**, 2739 (2001)
- | | | | | |
|--|---------------------------|-----------------|---------------------|----|
| | O¹⁺ + H | Charge Transfer | 5.00-500.00 keV/amu | Th |
|--|---------------------------|-----------------|---------------------|----|
733. X. Flechard, C. Harel, H. Jouin, B. Pons, L. Adoui, F. Fremont, A. Cassimi, D. Hennecart
Single- and double-electron capture in low-energy Ne¹⁰⁺-He collisions.
J. Phys. B **34**, 2759 (2001)
- | | | | | |
|--|------------------------------|-----------------|------------------|-----|
| | Ne¹⁰⁺ + He | Charge Transfer | 50.00-150.00 keV | E/T |
|--|------------------------------|-----------------|------------------|-----|

734. E. Paul-Kwiek
Quantum close-coupling calculations of the differential cross-sections for $\text{Ba}(^1\text{P}_1) + \text{Ar} \rightarrow \text{Ba}(^3\text{P}_2) + \text{Ar}$ inelastic collisions.
 J. Phys. B **34**, 285 (2001)
- | | | | |
|-------------------------|------------------|---------|----|
| $\text{Ba} + \text{Ar}$ | Total Scattering | 0.50 eV | Th |
| $\text{Ba} + \text{Ar}$ | Excitation | 0.50 eV | Th |
735. P. D. Fainstein, L. Gulyas
State-selective multiple electron emission from argon by 1 MeV proton impact.
 J. Phys. B **34**, 3003 (2001)
- | | | | |
|-----------------------------|------------|----------|----|
| $\text{H}^{1+} + \text{Ar}$ | Ionization | 1.00 MeV | Th |
|-----------------------------|------------|----------|----|
736. C. Jupen, E. Traebert
The $2\text{p}^43\text{s}$, 3p and 3d configurations in K XI.
 J. Phys. B **34**, 3053 (2001)
- | | | | |
|----------------------------|------------|-----------|----|
| $\text{K}^{3+} + \text{C}$ | Excitation | 12.80 MeV | Ex |
| $\text{K}^{3+} + \text{C}$ | Ionization | 12.80 MeV | Ex |
737. J. A. Perez, R. E. Olson, P. Beiersdorfer
Charge transfer and x-ray emission reactions involving highly charged ions and neutral hydrogen.
 J. Phys. B **34**, 3063 (2001)
- | | | | |
|------------------------------|-----------------|---------------------|----|
| $\text{Ne}^{10+} + \text{H}$ | Charge Transfer | 0.00-100.00 keV/amu | Th |
| $\text{Ar}^{18+} + \text{H}$ | Charge Transfer | 0.00-100.00 keV/amu | Th |
| $\text{Fe}^{26+} + \text{H}$ | Charge Transfer | 0.00-100.00 keV/amu | Th |
| $\text{Kr}^{36+} + \text{H}$ | Charge Transfer | 0.00-100.00 keV/amu | Th |
| $\text{Xe}^{54+} + \text{H}$ | Charge Transfer | 0.00-100.00 keV/amu | Th |
738. S. Kitazawa, H. Ida, Y. Matsui, T. Takayanagi, K. Wakiya, K. Iemura, S. Ohtani, H. Suzuki, Y. Kanai, U. I. Safronova
Electron spectra from singlet and triplet states of Ne^{6+} produced by low energy $\text{Ne}^{8+} + \text{He}$, Ne and Ar collisions.**
 J. Phys. B **34**, 3205 (2001)
- | | | | |
|------------------------------|-----------------|-----------|----|
| $\text{Ne}^{8+} + \text{He}$ | Charge Transfer | 80.00 keV | Ex |
| $\text{Ne}^{8+} + \text{Ne}$ | Charge Transfer | 80.00 keV | Ex |
| $\text{Ne}^{8+} + \text{Ar}$ | Charge Transfer | 80.00 keV | Ex |
739. A. B. Voitkiv, N. Gruen
Radiative electron capture as a collision-stimulated transition between electron states dressed by the radiation field.
 J. Phys. B **34**, 321 (2001)
- | | | | |
|-----------------------------|-----------------|------------------|----|
| $\text{Be}^{4+} + \text{H}$ | Charge Transfer | 15.00-30.00 a.u. | Th |
|-----------------------------|-----------------|------------------|----|
740. H. Rothard, G. Lanzano, D. H. Jakubassa-Amundsen, E. De Filippo, D. Mahboub
Theory and measurement of absolute doubly differential cross sections of binary encounter electron ejection in collisions of swift heavy ions with solids.
 J. Phys. B **34**, 3261 (2001)
- | | | | |
|------------------------------|------------|---------------|-----|
| $\text{Ni}^{28+} + \text{C}$ | Ionization | 45.00 MeV/amu | E/T |
|------------------------------|------------|---------------|-----|
741. D. M. Kearns, D. R. Gillen, D. Voulot, J. B. Greenwood, R. W. McCullough, H. B. Gilbody
The role of dissociative electron capture in collisions of slow He^{2+} ions with CO .
 J. Phys. B **34**, 3401 (2001)
- | | | | |
|------------------------------|-----------------|-------------------|----|
| $\text{He}^{2+} + \text{CO}$ | Charge Transfer | 0.20-1.20 keV/amu | Ex |
| $\text{He}^{2+} + \text{CO}$ | Dissociation | 0.20-1.20 keV/amu | Ex |

742. M. Korek, A. R. Allouche
Theoretical study of the low-lying electronic states of the RbCs^+ molecular ion.
 J. Phys. B **34**, 3689 (2001)

$\text{Rb}^{1+} + \text{Cs}$	Interaction Potentials	6.00-60.00 a_0	Th
$\text{Cs}^{1+} + \text{Rb}$	Interaction Potentials	6.00-60.00 a_0	Th
743. S. S. Harilal, C. V. Bindhu, V. P. Shevelko, H.-J. Kunze
XUV diagnostics of colliding laser-produced magnesium plasmas.
 J. Phys. B **34**, 3717 (2001)

$\text{Mg}^{4+} + \text{Mg}^{9+}$	Charge Transfer	0.00-3.00 MeV/amu	Ex
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744. G. Maroulis
Static electric polarizability and hyperpolarizability of $\text{BCl}(\text{X } ^1\Sigma^+)$.
 J. Phys. B **34**, 3727 (2001)

$\text{B} + \text{Cl}$	Interaction Potentials	0.40 a_0	Th
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745. E. R. Marquina, A. Amaya-Tapia, R. Hernandez-Lamonedá, H. Martinez
Experimental and theoretical investigations of single-electron capture and loss in He^+ -Ar collisions.
 J. Phys. B **34**, 3751 (2001)

$\text{He}^{1+} + \text{Ar}$	Ionization	1.50-5.00 keV	E/T
$\text{He}^{1+} + \text{Ar}$	Excitation	1.50-5.00 keV	E/T
746. C. Koncz
Double scattered electrons in ion-atom collisions: an impulse approximation.
 J. Phys. B **34**, 3879 (2001)

$\text{U}^{28+} + \text{Xe}$	Ionization	3.60-5.88 MeV	Th
$\text{U}^{28+} + \text{Xe}$	Ionization	3.60-5.88 MeV	Th
$\text{U}^{29+} + \text{Ne}$	Ionization	3.60-5.88 MeV	Th
$\text{U}^{29+} + \text{Ne}$	Ionization	3.60-5.88 MeV	Th
$\text{U}^{28+} + \text{Xe}$	Excitation	3.60-5.88 MeV	Th
$\text{U}^{29+} + \text{Ne}$	Excitation	3.60-5.88 MeV	Th
$\text{Xe}^{40+} + \text{Xe}$	Ionization	3.60-5.88 MeV	Th
$\text{Xe}^{40+} + \text{Xe}$	Ionization	3.60-5.88 MeV	Th
$\text{Xe}^{40+} + \text{Xe}$	Excitation	3.60-5.88 MeV	Th
747. P. Graham, K.W.D. Ledingham, R. P. Singhai, S. M. Hankin, T. McCanny, X. Fang, C. Kosmidis, P. Tzallas, P. F. Taday, A. J. Langley
On the fragment ion angular distributions arising from the tetrahedral molecule CH_3I .
 J. Phys. B **34**, 4015 (2001)

$h\nu + \text{CH}_3\text{I}$	Ionization		Ex
$h\nu + \text{CH}_3\text{I}$	Excitation		Ex
$h\nu + \text{CH}_3\text{I}$	Heavy Particle Collisions		Ex
748. A. Diehl, H. Braeuning, R. Trassl, D. Hathiramani, A. Theiss, H. Kern, E. Salzbom, I. Hofmann
Charge transfer and ionization in collisions between multiply charged noble gas ions.
 J. Phys. B **34**, 4073 (2001)

$\text{Ar}^{4+} + \text{Ar}^{4+}$	Ionization	10.00-60.00 keV	Ex
$\text{Kr}^{4+} + \text{Kr}^{4+}$	Ionization	10.00-60.00 keV	Ex
$\text{Xe}^{4+} + \text{Xe}^{4+}$	Ionization	10.00-60.00 keV	Ex
$\text{Pb}^{4+} + \text{Pb}^{4+}$	Ionization	10.00-60.00 keV	Ex
$\text{Bi}^{4+} + \text{Bi}^{4+}$	Ionization	10.00-60.00 keV	Ex
$\text{Ar}^{4+} + \text{Ar}^{4+}$	Charge Transfer	10.00-60.00 keV	Ex
$\text{Kr}^{4+} + \text{Kr}^{4+}$	Charge Transfer	10.00-60.00 keV	Ex
$\text{Xe}^{4+} + \text{Xe}^{4+}$	Charge Transfer	10.00-60.00 keV	Ex
$\text{Pb}^{4+} + \text{Pb}^{4+}$	Charge Transfer	10.00-60.00 keV	Ex
$\text{Bi}^{4+} + \text{Bi}^{4+}$	Charge Transfer	10.00-60.00 keV	Ex

749. V. Venturi, M. J. Jamieson, R. Cote
Scattering lengths for collisions between sodium and potassium atoms.
 J. Phys. B **34**, 4339 (2001)
 Na + K Interaction Potentials Th
750. A. B. Voitkiv, J. Ullrich
Modification of energy and angular spectra of binary-encounter emission in fast ion-atom collisions assisted by a low-frequency electromagnetic field.
 J. Phys. B **34**, 4383 (2001)
 He²⁺ + H Ionization 12.00 a.u. Th
751. A. B. Voitkiv, J. Ullrich
On the inter-relation between ionization of light atoms by virtual and real photons.
 J. Phys. B **34**, 4513 (2001)
 H¹⁺ + H Total Scattering 1.00 GeV/amu Th
 H¹⁺ + H Ionization 1.00 GeV/amu Th
752. C. Y. Chen, C. L. Cocke, J. P. Giese, F. Melchert, I. Reiser, M. Stoeckli, E. Sidky, C. D. Lin
Studies of charge exchange in symmetric ion-ion collisions.
 J. Phys. B **34**, 469 (2001)
 He²⁺ + He¹⁺ Charge Transfer 1.80-14.80 keV E/T
 Ne²⁺ + Ne¹⁺ Charge Transfer 1.80-14.80 keV E/T
 Ar²⁺ + Ar¹⁺ Charge Transfer 1.80-14.80 keV E/T
753. P. S. Barklem, B. J. O'Mara
Comments on alternative calculations of the broadening of spectral lines of neutral sodium by H-atom collisions.
 J. Phys. B **34**, 4785 (2001)
 H + Na Line Broadening Th
754. T. Kusakabe, H. Nakanishi, A. Iida, K. Hosomi, H. Tawara, M. Sasao, Y. Nakai
Charge transfer cross sections in collisions of ground state O⁺(⁴S) ions with H₂ and various carbon-containing molecules in the low-energy region.
 J. Phys. B **34**, 4809 (2001)
 O¹⁺ + H₂ Charge Transfer 0.20-4.50 keV E/T
 O¹⁺ + CH₄ Charge Transfer 0.20-4.50 keV E/T
 O¹⁺ + CO Charge Transfer 0.20-4.50 keV E/T
 O¹⁺ + CO₂ Charge Transfer 0.20-4.50 keV E/T
 O¹⁺ + C₂H₂ Charge Transfer 0.20-4.50 keV E/T
 O¹⁺ + C₂H₆ Charge Transfer 0.20-4.50 keV E/T
 O¹⁺ + C₃H₈ Charge Transfer 0.20-4.50 keV E/T
755. D. H. Jakubassa-Amundsen
Asymmetry in the low-energy electron ejection from colliding neutral atoms.
 J. Phys. B **34**, 4865 (2001)
 C + He Ionization 0.10-0.15 MeV/amu Th
 C + He Ionization 0.10-0.15 MeV/amu Th
 Ne + He Ionization 0.10-0.15 MeV/amu Th
 Ne + He Ionization 0.10-0.15 MeV/amu Th
756. L. Sarkadi, L. Lugosi, K. Tokesi, L. Gulyas, A. Koeber
Study of the transfer ionization process by observing the electron cusp in 100-300 keV He²⁺ + He collisions.
 J. Phys. B **34**, 4901 (2001)
 He²⁺ + He Charge Transfer 100.00-300.00 keV E/T
 He²⁺ + He Ionization 100.00-300.00 keV E/T

757. G. Correge, M. Ben Arfa, P. Descourt, C. Tannous, E. Kassab, F.M.E. Tuffin
Penning and associative ionization of argon atoms by excited metastable neon.
J. Phys. B **34**, 4997 (2001)
- | | | | |
|---------------------------|-------------|---------------|----|
| $\text{Ne}^* + \text{Ar}$ | Association | 0.01-1.00 keV | Th |
| $\text{Ne} + \text{Ar}$ | Association | 0.01-1.00 keV | Th |
| $\text{Ne}^* + \text{Ar}$ | Ionization | 0.01-1.00 keV | Th |
| $\text{Ne} + \text{Ar}$ | Ionization | 0.01-1.00 keV | Th |
758. A. L. Godunov, J. H. McGuire, P. B. Ivanov, V. A. Shipakov, H. Merabet, R. Bruch, J. Hanni, Kh. Kh. Shakov
Spatial and temporal correlation in dynamic, multi-electron quantum systems.
J. Phys. B **34**, 5055 (2001)
- | | | | |
|-----------------------------|------------|----------------|----|
| $\text{H}^{1+} + \text{He}$ | Ionization | 2.00-8.00 a.u. | Th |
| $\text{H}^{1+} + \text{He}$ | Excitation | 2.00-8.00 a.u. | Th |
759. M. Glass-Maujean, S. Lauer, H. Liebel, H. Schmoranzner
Direct evidence of collisional disalignment decay time: the case of $\text{H}(31) + \text{H}_2$.
J. Phys. B **34**, 5121 (2001)
- | | | | |
|---------------------------|-----------------|----------------|----|
| $\text{H}^* + \text{H}_2$ | Energy Transfer | 2.00-7.00 km/s | Ex |
| $\text{H} + \text{H}_2$ | Energy Transfer | 2.00-7.00 km/s | Ex |
| $\text{H}^* + \text{H}_2$ | Excitation | 2.00-7.00 km/s | Ex |
| $\text{H} + \text{H}_2$ | Excitation | 2.00-7.00 km/s | Ex |
760. J. Kobus, D. Moncrieff, S. Wilson
Comparison of the polarizabilities and hyperpolarizabilities obtained from finite basis set and finite difference Hartree-Fock calculations for diatomic molecules.
J. Phys. B **34**, 5127 (2001)
- | | | | |
|------------------------|------------------------|--|----|
| $\text{H} + \text{H}$ | Interaction Potentials | | Th |
| $\text{Li} + \text{H}$ | Interaction Potentials | | Th |
| $\text{B} + \text{H}$ | Interaction Potentials | | Th |
| $\text{F} + \text{H}$ | Interaction Potentials | | Th |
761. T. Bove, B. D. DePaola, T. Ehrenreich, E. Hordsal-Pedersen, L. Kristensen, K. B. MacAdam, O. E. Povlsen
The n-dependence of electron capture from Rydberg states.
J. Phys. B **34**, 579 (2001)
- | | | | |
|--------------------------------|-----------------|--|----|
| $\text{Na}^{1+} + \text{Li}$ | Charge Transfer | 7.5×10^4 - 1.85×10^5 m/s | Ex |
| $\text{Na}^{1+} + \text{Li}^*$ | Charge Transfer | 7.5×10^4 - 1.85×10^5 m/s | Ex |
762. L. G. Gerchikov, S. A. Sheinerman
Electron correlation in double ionization of helium by fast ion impact.
J. Phys. B **34**, 647 (2001)
- | | | | |
|-----------------------------|------------|----------------|----|
| $\text{C}^{6+} + \text{He}$ | Ionization | 100.00 MeV/amu | Th |
|-----------------------------|------------|----------------|----|
763. M. Purkait, A. K. Dhara, S. Sounda, C. R. Mandal
Inelastic processes in the interactions of partially stripped ions of carbon, nitrogen and oxygen with atomic hydrogen at intermediate and high energies.
J. Phys. B **34**, 755 (2001)
- | | | | |
|----------------------------|------------|----------------------|-----|
| $\text{C}^{1+} + \text{H}$ | Ionization | 10.00-200.00 keV/amu | E/T |
| $\text{C}^{2+} + \text{H}$ | Ionization | 10.00-200.00 keV/amu | E/T |
| $\text{C}^{3+} + \text{H}$ | Ionization | 10.00-200.00 keV/amu | E/T |
| $\text{C}^{4+} + \text{H}$ | Ionization | 10.00-200.00 keV/amu | E/T |
| $\text{C}^{5+} + \text{H}$ | Ionization | 10.00-200.00 keV/amu | E/T |
| $\text{N}^{1+} + \text{H}$ | Ionization | 10.00-200.00 keV/amu | E/T |
| $\text{N}^{2+} + \text{H}$ | Ionization | 10.00-200.00 keV/amu | E/T |

$\text{N}^{3+} + \text{H}$	Ionization	10.00-200.00 keV/amu	E/T
$\text{N}^{4+} + \text{H}$	Ionization	10.00-200.00 keV/amu	E/T
$\text{N}^{5+} + \text{H}$	Ionization	10.00-200.00 keV/amu	E/T
$\text{O}^{1+} + \text{H}$	Ionization	10.00-200.00 keV/amu	E/T
$\text{O}^{2+} + \text{H}$	Ionization	10.00-200.00 keV/amu	E/T
$\text{O}^{3+} + \text{H}$	Ionization	10.00-200.00 keV/amu	E/T
$\text{O}^{4+} + \text{H}$	Ionization	10.00-200.00 keV/amu	E/T
$\text{O}^{5+} + \text{H}$	Ionization	10.00-200.00 keV/amu	E/T
$\text{C}^{1+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{C}^{2+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{C}^{3+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{C}^{4+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{C}^{5+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{N}^{1+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{N}^{2+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{N}^{3+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{N}^{4+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{N}^{5+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{O}^{1+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{O}^{2+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{O}^{3+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{O}^{4+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T
$\text{O}^{5+} + \text{H}$	Charge Transfer	10.00-200.00 keV/amu	E/T

764. A. Amaya-Tapia, R. Hernandez-Lamoneda, H. Martinez

Single-electron capture cross section in 1-500 keV H^+ -Mg collisions.

J. Phys. B **34**, 769 (2001)

$\text{H}^{1+} + \text{Mg}$	Charge Transfer	1.00-500.00 keV	E/T
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765. A. Lafosse, J. C. Houver, D. Dowek

Vector correlations in dissociative charge transfer induced in He^+ - O_2 , N_2 collisions at medium energies.

J. Phys. B **34**, 819 (2001)

$\text{He}^{1+} + \text{N}_2$	Charge Transfer	1.50-3.00 keV	Ex
$\text{He}^{1+} + \text{O}_2$	Charge Transfer	1.50-3.00 keV	Ex
$\text{He}^{1+} + \text{N}_2$	Dissociation	1.50-3.00 keV	Ex
$\text{He}^{1+} + \text{O}_2$	Dissociation	1.50-3.00 keV	Ex

766. J. Fiol, V. D. Rodriguez, R. O. Barrachina

Electron capture to the continuum by proton and positron impact.

J. Phys. B **34**, 933 (2001)

$\text{H}^{1+} + \text{Ar}$	Ionization	75.00 keV	E/T
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767. M. Cizek, J. Horacek, F.A.U. Thiel, H. Hotop

Associative detachment in low-energy collisions between hydrogen atoms and atomic halogen anions.

J. Phys. B **34**, 983 (2001)

$\text{H} + \text{F}^{-1+}$	Interaction Potentials	2.00 eV	Th
$\text{H} + \text{Cl}^{-1+}$	Interaction Potentials	2.00 eV	Th
$\text{H} + \text{Br}^{-1+}$	Interaction Potentials	2.00 eV	Th
$\text{H} + \text{F}^{-1+}$	Detachment	2.00 eV	Th
$\text{H} + \text{Cl}^{-1+}$	Detachment	2.00 eV	Th
$\text{H} + \text{Br}^{-1+}$	Detachment	2.00 eV	Th
$\text{H} + \text{F}^{-1+}$	Association	2.00 eV	Th
$\text{H} + \text{Cl}^{-1+}$	Association	2.00 eV	Th
$\text{H} + \text{Br}^{-1+}$	Association	2.00 eV	Th

768. E. Y. Sidky, C. Illescas, C. D. Lin
The role of the potential saddle in $\text{He}^{2+} + \text{H}$ impact ionization.
J. Phys. B **34**, L163 (2001)

$\text{He}^{2+} + \text{H}$	Ionization	0.50-3.00 a.u.	Th
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769. B. M. McLaughlin, C. P. Ballance, K. A. Berrington
 $^3\Delta$ bound and continuum states of the TiO molecule.
J. Phys. B **34**, L179 (2001)

$\text{Ti}^{1+} + \text{O}$	Interaction Potentials	2.00-5.00 a_0	Th
$\text{Ti}^{1+} + \text{O}^{1+}$	Interaction Potentials	2.00-5.00 a_0	Th
770. A. L. Godunov, J. H. McGuire
Independent time approximation for dynamically interacting multi-electron systems.
J. Phys. B **34**, L223 (2001)

$\text{H}^{1+} + \text{He}$	Ionization	100.00 keV	Th
$\text{H}^{1+} + \text{He}$	Excitation	100.00 keV	Th
771. P. Van Reeth, J. W. Humberston, G. Laricchia
Correlations between ionization cross sections and threshold energies in electron-, positron-, proton- and antiproton-atom collisions.
J. Phys. B **34**, L271 (2001)

$\text{H}^{1+} + \text{He}$	Ionization	0.30-2.00 MeV	Th
$\text{H}^{1+} + \text{Ne}$	Ionization	0.30-2.00 MeV	Th
$\text{H}^{1+} + \text{Kr}$	Ionization	0.30-2.00 MeV	Th
$\text{H}^{1+} + \text{Xe}$	Ionization	0.30-2.00 MeV	Th
772. M. Schulz, R. Moshhammer, D. H. Madison, R. E. Olson, P. Marchalant, C. T. Whelan, H.R.J Walters, S. Jones, M. Foster, H. Kollmus, A. Cassimi, J. Ullrich
Triply differential single ionization cross sections in coplanar and non-coplanar geometry for fast heavy ion-atom collisions.
J. Phys. B **34**, L305 (2001)

$\text{C}^{6+} + \text{He}$	Ionization	100.00 MeV/amu	E/T
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773. H. Brauning, I. Reiser, A. Diehl, A. Theiss, C. L. Cocke, E. Salzborn
Charge transfer in collisions of H_2^+ ions with He^{2+} and Ar^{2+} .
J. Phys. B **34**, L321 (2001)

$\text{H}_2^{1+} + \text{He}^{2+}$	Charge Transfer	6.10-21.20 keV/amu	Ex
$\text{H}_2^{1+} + \text{Ar}^{2+}$	Charge Transfer	6.10-21.20 keV/amu	Ex
774. P. Sobocinski, J. Rangama, J.-Y. Chesnel, M. Tarisien, L. Adoui, A. Cassimi, X. Husson, F. Fremont
Inner-shell electron capture mechanisms in slow $\text{He}^{2+} + \text{CO}$ and $\text{O}^{7+} + \text{CO}$ collisions.
J. Phys. B **34**, L367 (2001)

$\text{He}^{2+} + \text{CO}$	Ionization	14.00-70.00 keV	Ex
$\text{O}^{7+} + \text{CO}$	Ionization	14.00-70.00 keV	Ex
$\text{He}^{2+} + \text{CO}$	Charge Transfer	14.00-70.00 keV	Ex
$\text{O}^{7+} + \text{CO}$	Charge Transfer	14.00-70.00 keV	Ex
775. T. Morishita, K.-I. Hino, T. Edamura, D. Kato, S. Watanabe, M. Matsuzawa
Hyperspherical L^2 -integrable basis method for energetic proton and anti-proton impact autoionization.
J. Phys. B **34**, L475 (2001)

$\text{H}^{1+} + \text{He}$	Ionization	2.00 MeV	Th
$\text{H}^{1+} + \text{He}$	Excitation	2.00 MeV	Th
776. J. Fiol, R. E. Olson, A.C.F Santos, G. M. Sigaud, E. C. Montenegro
Simultaneous projectile and target ionization in $\text{He}^+ + \text{Ne}$ collisions.
J. Phys. B **34**, L503 (2001)

- | | | | |
|------------------------------|------------|---------------|-----|
| $\text{He}^{1+} + \text{Ne}$ | Ionization | 1.00-4.00 MeV | E/T |
| $\text{He}^{1+} + \text{Ne}$ | Ionization | 1.00-4.00 MeV | E/T |
777. B. Siegmann, U. Werner, H. O. Lutz, R. Mann
Multiple ionization and fragmentation of H_2O in collisions with fast highly charged Xe ions.
 J. Phys. B **34**, L587 (2001)
- | | | | |
|--|--------------|--------------|----|
| $\text{Xe}^{17+} + \text{H}_2\text{O}$ | Ionization | 5.90 MeV/amu | Ex |
| $\text{Xe}^{18+} + \text{H}_2\text{O}$ | Ionization | 5.90 MeV/amu | Ex |
| $\text{Xe}^{43+} + \text{H}_2\text{O}$ | Ionization | 5.90 MeV/amu | Ex |
| $\text{Xe}^{17+} + \text{H}_2\text{O}$ | Dissociation | 5.90 MeV/amu | Ex |
| $\text{Xe}^{18+} + \text{H}_2\text{O}$ | Dissociation | 5.90 MeV/amu | Ex |
| $\text{Xe}^{43+} + \text{H}_2\text{O}$ | Dissociation | 5.90 MeV/amu | Ex |
778. P. Moretto-Capelle, D. Bordenave-Montesquieu, A. Rentenier, A. Bordenave-Montesquieu
Interaction of protons with the C_{60} molecule: calculation of deposited energies and electronic stopping cross sections ($v \geq 5$ au).
 J. Phys. B **34**, L611 (2001)
- | | | | |
|---------------------------------|-----------------|----------------|----|
| $\text{H}^{1+} + \text{C}_{60}$ | Energy Transfer | 0.10-5.00 a.u. | Th |
|---------------------------------|-----------------|----------------|----|
779. R. E. Olson, J. Fiol
Mapping of the Bethe surface in single-ionization ion-atom collisions.
 J. Phys. B **34**, L625 (2001)
- | | | | |
|-------------------------------|------------|---------------------|----|
| $\text{C}^{6+} + \text{He}$ | Ionization | 3.60-100.00 MeV/amu | Th |
| $\text{Au}^{53+} + \text{He}$ | Ionization | 3.60-100.00 MeV/amu | Th |
780. G. V. Mil'nikov, H. Nakamura
Regularization of scattering calculations at R-matrix poles.
 J. Phys. B **34**, L791 (2001)
- | | | | |
|-------------------------|----------------------|---------|----|
| $\text{H} + \text{H}_2$ | Interchange reaction | 1.50 eV | Th |
|-------------------------|----------------------|---------|----|
781. M. Schulz, R. Moshhammer, L. G. Gerchikov, S. A. Sheinerman, J. Ullrich
Mapping of many-electron bound states using the correlation function.
 J. Phys. B **34**, L795 (2001)
- | | | | |
|-------------------------------|------------|--------------|----|
| $\text{Au}^{53+} + \text{He}$ | Ionization | 3.60 MeV/amu | Th |
| $\text{Au}^{53+} + \text{Ne}$ | Ionization | 3.60 MeV/amu | Th |
782. K. von Diemar, F. Melchert, K. Huber, R. Trassl, E. Salzborn, L. Opradolce, R. D. Piacentini
Total and differential charge transfer cross sections in $\text{He}^{2+} + \text{N}^{4+}$ collisions.
 J. Phys. B **34**, L93 (2001)
- | | | | |
|----------------------------------|------------------|-----------------|-----|
| $\text{He}^{2+} + \text{N}^{4+}$ | Total Scattering | 8.00-200.00 keV | E/T |
| $\text{He}^{2+} + \text{N}^{4+}$ | Charge Transfer | 8.00-200.00 keV | E/T |
783. A. W. Kleyn, A.M.C Moutinho
Negative ion formation in alkali-atom-molecule collisions.
 J. Phys. B **34**, R1 (2001)
- | | | | |
|-----------------------------------|-----------------|---------------|-----|
| $\text{Na} + \text{I}$ | Charge Transfer | 5.00-87.00 eV | E/T |
| $\text{K} + \text{O}_2$ | Charge Transfer | 5.00-87.00 eV | E/T |
| $\text{K} + \text{SnCl}_4$ | Charge Transfer | 5.00-87.00 eV | E/T |
| $\text{K} + \text{CCl}_4$ | Charge Transfer | 5.00-87.00 eV | E/T |
| $\text{K} + \text{CF}_3\text{Br}$ | Charge Transfer | 5.00-87.00 eV | E/T |
| $\text{Cs} + \text{O}_2$ | Charge Transfer | 5.00-87.00 eV | E/T |
| $\text{Cs} + \text{Ar}$ | Charge Transfer | 5.00-87.00 eV | E/T |
784. P. Sobocinski, J. Rangama, G. Laurent, L. Adoui, A. Cassimi, J.-Y. Chesnel, A. Dubois, D. Hennecart, X. Husson, F. Fremont
Evidence for highly energetic fragments following electron capture in $\text{O}^{5+} + \text{H}_2$ collisions at low impact velocities.
 J. Phys. B **35**, 1353 (2002)

- | | | | |
|----------------|-----------------|-----------------|-----|
| $O^{5+} + H_2$ | Dissociation | 0.50-105.00 keV | E/T |
| $O^{5+} + H_2$ | Charge Transfer | 0.50-105.00 keV | E/T |
785. D. Fischer, B. Feuerstein, R. D. DuBois, R. Moshhammer, J. R. Crespo Lopez-Urrutia, I. Draganic, H. Loerch, A. N. Perumal, J. Ullrich
State-resolved measurements of single-electron capture in slow Ne^{7+} - and Ne^{8+} -helium collisions.
J. Phys. B **35**, 1369 (2002)
- | | | | |
|----------------|-----------------|-----------------|-----|
| $Ne^{7+} + He$ | Charge Transfer | 56.00-72.00 keV | E/T |
| $Ne^{8+} + He$ | Charge Transfer | 56.00-72.00 keV | E/T |
786. R. E. Olson, R. L. Watson, V. Horvat, K. E. Zaharakis
Projectile and target ionization in MeV u^{-1} collisions of Xe ions with N_2 .
J. Phys. B **35**, 1893 (2002)
- | | | | |
|------------------|------------|--------------------|----|
| $Xe^{1+} + N_2$ | Ionization | 2.00-20.00 MeV/amu | Ex |
| $Xe^{1+} + N_2$ | Ionization | 2.00-20.00 MeV/amu | Ex |
| $Xe^{8+} + N_2$ | Ionization | 2.00-20.00 MeV/amu | Ex |
| $Xe^{8+} + N_2$ | Ionization | 2.00-20.00 MeV/amu | Ex |
| $Xe^{18+} + N_2$ | Ionization | 2.00-20.00 MeV/amu | Ex |
| $Xe^{18+} + N_2$ | Ionization | 2.00-20.00 MeV/amu | Ex |
787. A. Morozov, B. Krylov, G. Gerasimov, A. Arnesen, R. Hallin
A study of atomic and molecular energy transfer channels in Kr-Xe gas mixtures excited with radio frequency discharges.
J. Phys. B **35**, 1929 (2002)
- | | | | |
|-------------|-----------------|--|----|
| $Xe + Kr$ | Energy Transfer | | Ex |
| $Xe + Kr_2$ | Energy Transfer | | Ex |
788. S. Grego, J. Salgado, P. Borel, S. E. Nielsen, N. Andersen
P-state-to-P-state transitions in optically prepared atomic collisions: II. Alignment propensity for $Na(3p) \rightarrow Li(2p)$ electron transfer.
J. Phys. B **35**, 2035 (2002)
- | | | | |
|----------------|-----------------|----------------|-----|
| $Li^{1+} + Na$ | Charge Transfer | 0.10-0.40 a.u. | E/T |
|----------------|-----------------|----------------|-----|
789. D. Doweck, I. Reiser, S. Grego, N. Andersen, A. Dubois, J. C. Houver, S. E. Nielsen, C. Richter, J. Salgado, A. Svensson, J. W. Thomsen
P-state-to-P-state transitions in optically prepared atomic collisions: III. A complete analysis of $Li^{1+} + Na(3p) \rightarrow Li(2p) + Na^{+}$ differential scattering.
J. Phys. B **35**, 2051 (2002)
- | | | | |
|----------------|------------------|----------|-----|
| $Li^{1+} + Na$ | Total Scattering | 1.00 keV | E/T |
| $Li^{1+} + Na$ | Charge Transfer | 1.00 keV | E/T |
790. A. N. Perumal, R. Moshhammer, M. Schulz, J. Ullrich
Dynamics of He double ionization in the non-perturbative regime: the reduction to an effective three-particle problem.
J. Phys. B **35**, 2133 (2002)
- | | | | |
|-----------------|------------|--------------|----|
| $Au^{53+} + He$ | Ionization | 3.60 MeV/amu | Ex |
|-----------------|------------|--------------|----|
791. G. Gasaneo, J. H. Macek
Hyperspherical adiabatic eigenvalues for zero-range potentials.
J. Phys. B **35**, 2239 (2002)
- | | | | |
|----------------|------------------------|--|----|
| $He + He + He$ | Association | | Th |
| $He + He + He$ | Interaction Potentials | | Th |

792. S. Martinez, G. Bernardi, P. Focke, A. D. Gonzalez, S. Suarez
Transfer ionization and total electron emission for 25 keV amu⁻¹ He²⁺ colliding on He and H₂.
 J. Phys. B **35**, 2261 (2002)
- | | | | |
|-----------------------------------|------------------|---------------|----|
| He ²⁺ + H ₂ | Total Scattering | 25.00 keV/amu | Ex |
| He ²⁺ + He | Total Scattering | 25.00 keV/amu | Ex |
| He ²⁺ + H ₂ | Ionization | 25.00 keV/amu | Ex |
| He ²⁺ + He | Ionization | 25.00 keV/amu | Ex |
| He ²⁺ + H ₂ | Charge Transfer | 25.00 keV/amu | Ex |
| He ²⁺ + He | Charge Transfer | 25.00 keV/amu | Ex |
793. K. Gao, M. Yan, M. Feng, X. Zhu
Measurement of charge-transfer rate coefficients between Co³⁺ and Ar, N₂ at electron-volt energy.
 J. Phys. B **35**, 233 (2002)
- | | | | |
|-----------------------------------|-----------------|---------|----|
| Co ³⁺ + N ₂ | Charge Transfer | 5.60 eV | Ex |
| Co ³⁺ + Ar | Charge Transfer | 5.60 eV | Ex |
794. E. Bodo, F. A. Gianturco, A. Dalgarno
The reaction of F + D₂ at ultra-low temperatures: the effect of rotational excitation.
 J. Phys. B **35**, 2391 (2002)
- | | | | |
|--------------------|-------------|--------------|----|
| F + H ₂ | Association | 0.00-0.30 eV | Th |
| F + D ₂ | Association | 0.00-0.30 eV | Th |
795. A. L. Godunov, P. B. Ivanov, V. A. Schipakov, M. Schulz
Differential cross sections for double excitation of the autoionizing states of helium by 100-150 keV proton impact.
 J. Phys. B **35**, 2477 (2002)
- | | | | |
|----------------------|------------|-------------------|-----|
| H ¹⁺ + He | Ionization | 100.00-150.00 keV | E/T |
| H ¹⁺ + He | Excitation | 100.00-150.00 keV | E/T |
796. I. Cadez, J. B. Greenwood, A. Chutjian, R. J. Mawhorter, S. J. Smith, M. Nimura
Absolute cross sections for charge-exchange in ³He²⁺ and H⁺ impact on CO.
 J. Phys. B **35**, 2515 (2002)
- | | | | |
|-----------------------|-----------------|----------------|----|
| H ¹⁺ + CO | Charge Transfer | 1.00-14.00 keV | Ex |
| He ²⁺ + CO | Charge Transfer | 1.00-14.00 keV | Ex |
797. C. Diaz, F. Martin, A. Salin
Time-dependent close-coupling calculations of double ionization of helium by protons and antiprotons.
 J. Phys. B **35**, 2555 (2002)
- | | | | |
|----------------------|------------|---------------|-----|
| H ¹⁺ + He | Ionization | 0.20-4.00 MeV | E/T |
|----------------------|------------|---------------|-----|
798. A. B. Voitkiv, N. Gruen
Radiative electron capture with Coulomb boundary conditions.
 J. Phys. B **35**, 2593 (2002)
- | | | | |
|------------------------------------|-----------------|-------------------|----|
| H ¹⁺ + Li ²⁺ | Charge Transfer | 31.00-151.00 a.u. | Th |
| H ¹⁺ + Be ³⁺ | Charge Transfer | 31.00-151.00 a.u. | Th |
| Be ⁴⁺ + H | Charge Transfer | 31.00-151.00 a.u. | Th |
799. E. Edgu-Fry, C. L. Cocke, E. Sidky, C. D. Lin, M. Abdallah
Intermediate energy ionization of helium by proton impact.
 J. Phys. B **35**, 2603 (2002)
- | | | | |
|----------------------|------------|------------------|-----|
| H ¹⁺ + He | Ionization | 70.00-100.00 keV | E/T |
|----------------------|------------|------------------|-----|

800. C. Di Paola, F. A. Gianturco, F. Paesani, G. Delgado-Barrio, S. Miret-Artes, P. Villarreal, I. Baccarelli, T. Gonzalez-Lezana
Ground states of weakly bound three-atom systems: energies and shapes of $^4\text{He}_2\text{X}$ clusters from Monte Carlo calculations.
 J. Phys. B **35**, 2643 (2002)
- | | | | |
|--------------------------------|------------------------|-----------|----|
| $\text{He} + \text{H}^{-1+}$ | Interaction Potentials | 123.98 eV | Th |
| $\text{He} + \text{He}$ | Interaction Potentials | 123.98 eV | Th |
| $\text{He} + \text{Li}$ | Interaction Potentials | 123.98 eV | Th |
| $\text{He} + \text{Na}$ | Interaction Potentials | 123.98 eV | Th |
| $\text{He}_2 + \text{H}^{-1+}$ | Interaction Potentials | 123.98 eV | Th |
| $\text{He}_2 + \text{Li}$ | Interaction Potentials | 123.98 eV | Th |
| $\text{He}_2 + \text{Na}$ | Interaction Potentials | 123.98 eV | Th |
801. G. E. Ntamack, B. A. Huber, F. Chandezon, M. G. Kwato Njock, C. Guet
Simulation of mass spectra produced in collisions of highly charged ions with sodium clusters.
 J. Phys. B **35**, 2729 (2002)
- | | | | |
|---------------------------------|--------------|------------|----|
| $\text{Xe}^{28+} + \text{Na}_n$ | Dissociation | 560.00 keV | Ex |
| $\text{Xe}^{28+} + \text{Na}$ | Ionization | 560.00 keV | Ex |
| $\text{Xe}^{28+} + \text{Na}_n$ | Ionization | 560.00 keV | Ex |
802. L. G. Gerchikov, S. A. Sheinerman, M. Schulz, R. Moshhammer, J. Ullrich
Electron correlation in double ionization of excited helium by fast ion impact.
 J. Phys. B **35**, 2783 (2002)
- | | | | |
|-------------------------------|------------------|----------------|----|
| $\text{C}^{6+} + \text{He}^*$ | Total Scattering | 100.00 MeV/amu | Th |
| $\text{C}^{6+} + \text{He}$ | Total Scattering | 100.00 MeV/amu | Th |
| $\text{C}^{6+} + \text{He}^*$ | Ionization | 100.00 MeV/amu | Th |
| $\text{C}^{6+} + \text{He}$ | Ionization | 100.00 MeV/amu | Th |
803. M. E. Henry, R. M. Herman
Collisional broadening of Rydberg-atom transitions by ground-state alkali atoms.
 J. Phys. B **35**, 357 (2002)
- | | | | |
|-------------------------|-----------------|---------|----|
| $\text{K} + \text{K}$ | Line Broadening | 0.02 eV | Th |
| $\text{K} + \text{Rb}$ | Line Broadening | 0.02 eV | Th |
| $\text{Rb} + \text{Rb}$ | Line Broadening | 0.02 eV | Th |
804. M. E. Henry, R. M. Herman
Collisional broadening of Rydberg atom transitions by rare gas perturbers.
 J. Phys. B **35**, 373 (2002)
- | | | | |
|-------------------------|-----------------|---------|----|
| $\text{Na} + \text{He}$ | Line Broadening | 0.05 eV | Th |
| $\text{Na} + \text{Ne}$ | Line Broadening | 0.05 eV | Th |
| $\text{Na} + \text{Ar}$ | Line Broadening | 0.05 eV | Th |
| $\text{Na} + \text{Kr}$ | Line Broadening | 0.05 eV | Th |
| $\text{Na} + \text{Xe}$ | Line Broadening | 0.05 eV | Th |
| $\text{Rb} + \text{He}$ | Line Broadening | 0.05 eV | Th |
| $\text{Rb} + \text{Ne}$ | Line Broadening | 0.05 eV | Th |
| $\text{Rb} + \text{Ar}$ | Line Broadening | 0.05 eV | Th |
| $\text{Rb} + \text{Kr}$ | Line Broadening | 0.05 eV | Th |
| $\text{Rb} + \text{Xe}$ | Line Broadening | 0.05 eV | Th |
| $\text{Na} + \text{He}$ | Excitation | 0.05 eV | Th |
| $\text{Na} + \text{Ne}$ | Excitation | 0.05 eV | Th |
| $\text{Na} + \text{Ar}$ | Excitation | 0.05 eV | Th |
| $\text{Na} + \text{Kr}$ | Excitation | 0.05 eV | Th |
| $\text{Na} + \text{Xe}$ | Excitation | 0.05 eV | Th |
| $\text{Rb} + \text{He}$ | Excitation | 0.05 eV | Th |
| $\text{Rb} + \text{Ne}$ | Excitation | 0.05 eV | Th |

Rb + Ar	Excitation	0.05 eV	Th
Rb + Kr	Excitation	0.05 eV	Th
Rb + Xe	Excitation	0.05 eV	Th
Na + He	Heavy Particle Collisions	0.05 eV	Th
Na + Ne	Heavy Particle Collisions	0.05 eV	Th
Na + Ar	Heavy Particle Collisions	0.05 eV	Th
Na + Kr	Heavy Particle Collisions	0.05 eV	Th
Na + Xe	Heavy Particle Collisions	0.05 eV	Th
Rb + He	Heavy Particle Collisions	0.05 eV	Th
Rb + Ne	Heavy Particle Collisions	0.05 eV	Th
Rb + Ar	Heavy Particle Collisions	0.05 eV	Th
Rb + Kr	Heavy Particle Collisions	0.05 eV	Th
Rb + Xe	Heavy Particle Collisions	0.05 eV	Th

805. L. Nagy, A. Benedek

An improved calculation for the ionization-excitation of helium.

J. Phys. B **35**, 491 (2002)

H¹⁺ + He	Ionization	1.00-80.00 a.u.	Th
H¹⁺ + He	Excitation	1.00-80.00 a.u.	Th

806. B. Najjari, A. B. Voitkiv, J. Ullrich

On the application of Lorentz and Coulomb gauges for calculations of ionization of light targets by relativistic charged projectiles.

J. Phys. B **35**, 533 (2002)

perturbation + He	Ionization		Th
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807. S.-M. Li, J. Chen, Z.-F. Zhou

Ionization of atomic hydrogen by protons in the presence of a laser field.

J. Phys. B **35**, 557 (2002)

H¹⁺ + H	Ionization	0.00-1.00 MeV	Th
---------------------------	------------	---------------	----

808. B. Brehm, P. Wilhelms

Associative ionization in hydrogen atom-rare gas collisions between 10 and 100 eV.

J. Phys. B **35**, 691 (2002)

H + Ar	Association	10.00-100.00 eV	Ex
H + Kr	Association	10.00-100.00 eV	Ex
H + Xe	Association	10.00-100.00 eV	Ex
H + Ar	Ionization	10.00-100.00 eV	Ex
H + Kr	Ionization	10.00-100.00 eV	Ex
H + Xe	Ionization	10.00-100.00 eV	Ex

809. W. Behmenburg, A. Kaiser, H. Bettermann, T. Grycuk, V. Staemmler

The near UV emission spectra of the Li*He excimers: experimental and theoretical studies.

J. Phys. B **35**, 747 (2002)

Li + He	Fluorescence	720.00 K	E/T
Li + He	Interaction Potentials	720.00 K	E/T
Li* + He	Fluorescence	720.00 K	E/T
Li* + He	Interaction Potentials	720.00 K	E/T

810. W. S. Melo, A.C.F Santos, M. M. Sant'Anna, G. M. Sigaud, E. C. Montenegro

Multiple ionization of noble gases by 2.9 MeV proton impact: comparison with equi-velocity electron impact ionization.

J. Phys. B **35**, L187 (2002)

H¹⁺ + He	Ionization	2.00 MeV	Ex
H¹⁺ + Ne	Ionization	2.00 MeV	Ex
H¹⁺ + Ar	Ionization	2.00 MeV	Ex
H¹⁺ + Kr	Ionization	2.00 MeV	Ex
H¹⁺ + Xe	Ionization	2.00 MeV	Ex

811. M. I. Chibisov, A. A. Khuskivadze, I. I. Fabrikant
Energies and dipole moments of long-range molecular Rydberg states.
 J. Phys. B **35**, L193 (2002)
- | | | | |
|-----------------|------------------------|--|----|
| Rb + Rb | Interaction Potentials | | Th |
| Rb* + Rb | Interaction Potentials | | Th |
812. E. L. Hamilton, C. H. Greene, H. R. Sadeghpour
 J. Phys. B **35**, L199 (2002)
- | | | | |
|-----------------|------------------------|--|----|
| Rb + Rb | Interaction Potentials | | Th |
| Rb* + Rb | Interaction Potentials | | Th |
813. F. Afaneh, R. Doerner, L. Schmidt, Th. Weber, K. E. Stiebing, O. Jagutzki, H. Schmidt-Boecking
Must saddle point electrons always ride on the saddle?
 J. Phys. B **35**, L229 (2002)
- | | | | |
|--|-----------------|-----------|-----|
| He²⁺ + H₂ | Ionization | 0.81 a.u. | E/T |
| He²⁺ + He | Ionization | 0.81 a.u. | E/T |
| He²⁺ + H₂ | Charge Transfer | 0.81 a.u. | E/T |
| He²⁺ + He | Charge Transfer | 0.81 a.u. | E/T |
814. S. Lepp, P. C. Stancil, A. Dalgarno
Atomic and molecular processes in the early Universe.
 J. Phys. B **35**, R57 (2002)
- | | | | |
|---|-----------------|-------------|----|
| H¹⁺ + H⁻¹⁺ | Association | 0.10-1.00 K | Th |
| H¹⁺ + D⁻¹⁺ | Association | 0.10-1.00 K | Th |
| H¹⁺ + Li⁻¹⁺ | Association | 0.10-1.00 K | Th |
| H₂ + D¹⁺ | Association | 0.10-1.00 K | Th |
| H₂¹⁺ + H⁻¹⁺ | Association | 0.10-1.00 K | Th |
| D¹⁺ + H⁻¹⁺ | Association | 0.10-1.00 K | Th |
| D¹⁺ + D⁻¹⁺ | Association | 0.10-1.00 K | Th |
| D¹⁺ + Li⁻¹⁺ | Association | 0.10-1.00 K | Th |
| Li¹⁺ + H⁻¹⁺ | Association | 0.10-1.00 K | Th |
| Li¹⁺ + D⁻¹⁺ | Association | 0.10-1.00 K | Th |
| H¹⁺ + H⁻¹⁺ | Recombination | 0.10-1.00 K | Th |
| H¹⁺ + D⁻¹⁺ | Recombination | 0.10-1.00 K | Th |
| H¹⁺ + Li⁻¹⁺ | Recombination | 0.10-1.00 K | Th |
| H₂ + D¹⁺ | Recombination | 0.10-1.00 K | Th |
| H₂¹⁺ + H⁻¹⁺ | Recombination | 0.10-1.00 K | Th |
| D¹⁺ + H⁻¹⁺ | Recombination | 0.10-1.00 K | Th |
| D¹⁺ + D⁻¹⁺ | Recombination | 0.10-1.00 K | Th |
| D¹⁺ + Li⁻¹⁺ | Recombination | 0.10-1.00 K | Th |
| Li¹⁺ + H⁻¹⁺ | Recombination | 0.10-1.00 K | Th |
| Li¹⁺ + D⁻¹⁺ | Recombination | 0.10-1.00 K | Th |
| H¹⁺ + H⁻¹⁺ | Charge Transfer | 0.10-1.00 K | Th |
| H¹⁺ + D⁻¹⁺ | Charge Transfer | 0.10-1.00 K | Th |
| H¹⁺ + Li⁻¹⁺ | Charge Transfer | 0.10-1.00 K | Th |
| H₂ + D¹⁺ | Charge Transfer | 0.10-1.00 K | Th |
| H₂¹⁺ + H⁻¹⁺ | Charge Transfer | 0.10-1.00 K | Th |
| D¹⁺ + H⁻¹⁺ | Charge Transfer | 0.10-1.00 K | Th |
| D¹⁺ + D⁻¹⁺ | Charge Transfer | 0.10-1.00 K | Th |
| D¹⁺ + Li⁻¹⁺ | Charge Transfer | 0.10-1.00 K | Th |
| Li¹⁺ + H⁻¹⁺ | Charge Transfer | 0.10-1.00 K | Th |
| Li¹⁺ + D⁻¹⁺ | Charge Transfer | 0.10-1.00 K | Th |
815. R. Trassl, H. Brauning, K. v. Diemar, F. Melchert, E. Salzborn, I. Hofmann
Ion-ion charge exchange cross-sections for heavy ion fusion.
 Nucl. Instrum. Methods Phys. Res. A **464**, 80 (2001)

$\text{Xe}^{4+} + \text{Xe}^{4+}$	Charge Transfer	2.00-70.00 keV	Ex
$\text{Bi}^{4+} + \text{Bi}^{4+}$	Charge Transfer	2.00-70.00 keV	Ex

816. R. E. Olson

Stripping cross-sections for fast, low charge state ions.

Nucl. Instrum. Methods Phys. Res. A **464**, 93 (2001)

$\text{Xe}^{1+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Xe}^{2+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Xe}^{3+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Xe}^{4+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Xe}^{5+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Xe}^{6+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Xe}^{7+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Xe}^{8+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Xe}^{9+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Xe}^{10+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Xe}^{11+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Xe}^{12+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{U}^{10+} + \text{H}_2$	Ionization	2.60-8.40 GeV	Th
$\text{U}^{10+} + \text{N}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Bi}^{1+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Bi}^{2+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Bi}^{3+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Bi}^{4+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Bi}^{5+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Bi}^{6+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Bi}^{7+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Bi}^{8+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Bi}^{9+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Bi}^{10+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Bi}^{11+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th
$\text{Bi}^{12+} + \text{BeF}_2$	Ionization	2.60-8.40 GeV	Th

817. A. P. Jesus, B. Braizinha, J. Cruz, J. P. Ribeiro

Influence of target thickness on resonant elastic scattering of protons by ^{19}F .

Nucl. Instrum. Methods Phys. Res. B **174**, 229 (2001)

$\text{H}^{1+} + \text{F}$	Elastic Scattering	0.70-2.80 MeV	Ex
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818. I. Bogdanovic Radovic, O. Benka

Determination of H recoil cross-sections for He ions incident at 2.5-4.5 MeV and recoil angles from 30° to 60° .

Nucl. Instrum. Methods Phys. Res. B **174**, 25 (2001)

$\text{H}^{1+} + \text{He}$	Elastic Scattering	2.50-4.50 MeV	Ex
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819. M. Chiari, L. Giuntini, P. A. Mando, N. Taccetti

Proton elastic scattering cross-section on aluminium from 0.8 to 3 MeV.

Nucl. Instrum. Methods Phys. Res. B **174**, 259 (2001)

$\text{H}^{1+} + \text{Al}$	Elastic Scattering	0.80-3.00 MeV	Ex
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820. S. K. Kim, H. D. Choi

Analysis of proton elastic recoil cross section by using R-matrix theory.

Nucl. Instrum. Methods Phys. Res. B **174**, 33 (2001)

$\text{H}^{1+} + \text{He}$	Elastic Scattering	0.10-10.00 MeV	Th
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821. O. Schmelter, G. Dollinger, G. Datzmann, A. Hauptner, H. J. Koerner, P. Maier-Komor, P. Reichart

Particle-induced X-ray emission using high energy ions with respect to microprobe application.

Nucl. Instrum. Methods Phys. Res. B **179**, 469 (2001)

$\text{H}^{1+} + \text{C}$	Ionization	16.00-70.00 MeV	Ex
$\text{H}^{1+} + \text{Au}$	Ionization	16.00-70.00 MeV	Ex
$\text{H}^{1+} + \text{perturbation}$	Ionization	16.00-70.00 MeV	Ex
$\text{C}^{1+} + \text{C}$	Ionization	16.00-70.00 MeV	Ex
$\text{C}^{1+} + \text{Au}$	Ionization	16.00-70.00 MeV	Ex
$\text{C}^{1+} + \text{perturbation}$	Ionization	16.00-70.00 MeV	Ex

822. D. Mitra, A. C. Mandal, M. Sarkar, D. Bhattacharya, P. Sen, G. Lapicki
M X-ray production cross-sections of gold and lead by 4 to 12 MeV carbon ions.
 Nucl. Instrum. Methods Phys. Res. B **183**, 171 (2001)

$\text{C}^{2+} + \text{Au}$	Excitation	4.00-12.00 MeV	E/T
$\text{C}^{2+} + \text{Pb}$	Excitation	4.00-12.00 MeV	E/T
$\text{C}^{3+} + \text{Au}$	Excitation	4.00-12.00 MeV	E/T
$\text{C}^{3+} + \text{Pb}$	Excitation	4.00-12.00 MeV	E/T
$\text{C}^{4+} + \text{Au}$	Excitation	4.00-12.00 MeV	E/T
$\text{C}^{4+} + \text{Pb}$	Excitation	4.00-12.00 MeV	E/T
$\text{C}^{2+} + \text{Au}$	Ionization	4.00-12.00 MeV	E/T
$\text{C}^{2+} + \text{Pb}$	Ionization	4.00-12.00 MeV	E/T
$\text{C}^{3+} + \text{Au}$	Ionization	4.00-12.00 MeV	E/T
$\text{C}^{3+} + \text{Pb}$	Ionization	4.00-12.00 MeV	E/T
$\text{C}^{4+} + \text{Au}$	Ionization	4.00-12.00 MeV	E/T
$\text{C}^{4+} + \text{Pb}$	Ionization	4.00-12.00 MeV	E/T

823. V. P. Shevelko, I. Yu Tolstikhina, Th. Stoehlker
Stripping of fast heavy low-charged ions in gaseous targets.
 Nucl. Instrum. Methods Phys. Res. B **184**, 295 (2001)

$\text{H} + \text{H}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Xe} + \text{H}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Xe} + \text{He}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Xe} + \text{Li}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Xe} + \text{Be}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Xe} + \text{N}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Xe} + \text{F}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Xe} + \text{Ar}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Xe} + \text{Xe}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Au}^{52+} + \text{H}_2$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Au}^{52+} + \text{N}_2$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Pb} + \text{H}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Pb} + \text{He}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Pb} + \text{Li}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Pb} + \text{Be}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Pb} + \text{N}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Pb} + \text{F}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Pb} + \text{Ar}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Pb} + \text{Xe}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{1+} + \text{H}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{1+} + \text{He}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{1+} + \text{Li}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{1+} + \text{Be}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{1+} + \text{N}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{1+} + \text{F}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{1+} + \text{Ar}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{1+} + \text{Xe}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{4+} + \text{H}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{4+} + \text{He}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{4+} + \text{Li}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{4+} + \text{Be}$	Ionization	1.00-100.00 MeV/amu	Th

$\text{U}^{4+} + \text{N}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{4+} + \text{F}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{4+} + \text{Ar}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{4+} + \text{Xe}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{7+} + \text{H}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{7+} + \text{He}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{7+} + \text{Li}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{7+} + \text{Be}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{7+} + \text{N}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{7+} + \text{F}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{7+} + \text{Ar}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{7+} + \text{Xe}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{10+} + \text{H}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{10+} + \text{He}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{10+} + \text{Li}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{10+} + \text{Be}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{10+} + \text{N}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{10+} + \text{F}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{10+} + \text{Ar}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{10+} + \text{Xe}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{28+} + \text{H}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{28+} + \text{He}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{28+} + \text{Li}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{28+} + \text{Be}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{28+} + \text{N}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{28+} + \text{F}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{28+} + \text{Ar}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{U}^{28+} + \text{Xe}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Bi}^{1+} + \text{H}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Bi}^{1+} + \text{He}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Bi}^{1+} + \text{Li}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Bi}^{1+} + \text{Be}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Bi}^{1+} + \text{N}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Bi}^{1+} + \text{F}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Bi}^{1+} + \text{Ar}$	Ionization	1.00-100.00 MeV/amu	Th
$\text{Bi}^{1+} + \text{Xe}$	Ionization	1.00-100.00 MeV/amu	Th

824. M. Chiari, L. Giutini, P. A. Mando, N. Taccetti

Proton elastic scattering cross-section on boron from 0.5 to 3.3 MeV.

Nucl. Instrum. Methods Phys. Res. B **184**, 309 (2001)

$\text{H}^{1+} + \text{B}$	Elastic Scattering	0.50-3.30 MeV	Ex
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825. Z. Smit

Theoretical ionization cross-sections in the K-shell – Hydrogenic model and beyond.

Nucl. Instrum. Methods Phys. Res. B **189**, 1 (2002)

$\text{H}^{1+} + \text{Al}$	Ionization		Th
$\text{H}^{1+} + \text{Ti}$	Ionization		Th
$\text{H}^{1+} + \text{Cu}$	Ionization		Th
$\text{H}^{1+} + \text{Au}$	Ionization		Th

826. J. Miranda, C. Romo-Kroege, M. Lugo-Licona

Effect of atomic parameters on L-shell X-ray production cross-sections by proton impact with energies below 1 MeV.

Nucl. Instrum. Methods Phys. Res. B **189**, 21 (2002)

$\text{H}^{1+} + \text{perturbation}$	Ionization	1.00 MeV	E/T
$\text{H}^{1+} + \text{perturbation}$	Excitation	1.00 MeV	E/T

827. L. Rodriguez-Fernandez, J. Miranda, J. L. Ruvalcaba-Sil, E. Segundo, A. Oliver
Measurement of M-shell X-ray production induced by protons of 0.3-0.7 MeV on W, Au, Pb, Bi, Th and U.
 Nucl. Instrum. Methods Phys. Res. B **189**, 27 (2002)

$H^{1+} + W$	Excitation	0.30-0.70 MeV	Ex
$H^{1+} + Au$	Excitation	0.30-0.70 MeV	Ex
$H^{1+} + Pb$	Excitation	0.30-0.70 MeV	Ex
$H^{1+} + Th$	Excitation	0.30-0.70 MeV	Ex
$H^{1+} + U$	Excitation	0.30-0.70 MeV	Ex
$H^{1+} + Bi$	Excitation	0.30-0.70 MeV	Ex
$H^{1+} + W$	Ionization	0.30-0.70 MeV	Ex
$H^{1+} + Au$	Ionization	0.30-0.70 MeV	Ex
$H^{1+} + Pb$	Ionization	0.30-0.70 MeV	Ex
$H^{1+} + Th$	Ionization	0.30-0.70 MeV	Ex
$H^{1+} + U$	Ionization	0.30-0.70 MeV	Ex
$H^{1+} + Bi$	Ionization	0.30-0.70 MeV	Ex

828. G. Lapicki
The status of theoretical L-subshell ionization cross sections for protons.
 Nucl. Instrum. Methods Phys. Res. B **189**, 8 (2002)

$H^{1+} + Ti$	Ionization	0.30-3.50 MeV	Th
$H^{1+} + Rb$	Ionization	0.30-3.50 MeV	Th
$H^{1+} + Gd$	Ionization	0.30-3.50 MeV	Th
$H^{1+} + W$	Ionization	0.30-3.50 MeV	Th
$H^{1+} + U$	Ionization	0.30-3.50 MeV	Th
$H^{1+} + Bi$	Ionization	0.30-3.50 MeV	Th

829. I. Bogdanovic Radovic, M. Jaksic, O. Benka, A. F. Gurbich
Helium elastic scattering from carbon for 30° to 150° in the energy region from 2 to 4.8 MeV.
 Nucl. Instrum. Methods Phys. Res. B **190**, 100 (2002)

$He^{1+} + C$	Total Scattering	2.00-4.80 MeV	Ex
$He^{1+} + C$	Elastic Scattering	2.00-4.80 MeV	Ex

830. D. Strivay, G. Weber
An empirical formula for L line X-ray production cross-section of elements from Ag to U for protons below 3.5 MeV.
 Nucl. Instrum. Methods Phys. Res. B **190**, 112 (2002)

$H^{1+} + Ag$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Cd$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + In$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Sn$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Sn$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Sb$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Te$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + I$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Cs$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Ba$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + La$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Ce$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Pr$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Nd$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Eu$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Gd$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Tb$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Tb$	Ionization	0.50-3.50 MeV	Th

$H^{1+} + Dy$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Ho$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Er$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Tm$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Yb$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Lu$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Hf$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Ta$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + W$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Ir$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Pt$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Au$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Hg$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Tl$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Pb$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + U$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Bi$	Ionization	0.50-3.50 MeV	Th
$H^{1+} + Ag$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Cd$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + In$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Sn$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Sn$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Sb$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Te$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + I$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Cs$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Ba$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + La$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Ce$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Pr$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Nd$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Eu$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Gd$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Tb$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Tb$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Dy$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Ho$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Er$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Tm$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Yb$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Lu$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Hf$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Ta$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + W$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Ir$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Pt$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Au$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Hg$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Tl$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Pb$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + U$	Excitation	0.50-3.50 MeV	Th
$H^{1+} + Bi$	Excitation	0.50-3.50 MeV	Th

831. R. Mateus, A. P. Jesus, B. Braizinha, J. Cruz, J. V. Pinto, J. P. Ribeiro

Proton-induced γ -ray analysis of lithium in thick samples.

Nucl. Instrum. Methods Phys. Res. B **190**, 117 (2002)

$H^{1+} + Li$	Ionization	0.70-2.27 MeV	Ex
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|-----------------------------|------------|---------------|----|
| $\text{H}^{1+} + \text{Li}$ | Excitation | 0.70-2.27 MeV | Ex |
|-----------------------------|------------|---------------|----|
832. A. R. Ramos, A. Paul, L. Rijniers, M. F. dea Silva, J. C. Soares
Measurement of (p,p) elastic differential cross-sections for carbon, nitrogen, oxygen, aluminum and silicon in the 500-2500 keV range at 140° and 178° laboratory scattering angles.
Nucl. Instrum. Methods Phys. Res. B **190**, 95 (2002)
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|-----------------------------|--------------------|---------------|----|
| $\text{H}^{1+} + \text{C}$ | Total Scattering | 0.50-2.50 MeV | Ex |
| $\text{H}^{1+} + \text{N}$ | Total Scattering | 0.50-2.50 MeV | Ex |
| $\text{H}^{1+} + \text{O}$ | Total Scattering | 0.50-2.50 MeV | Ex |
| $\text{H}^{1+} + \text{Al}$ | Total Scattering | 0.50-2.50 MeV | Ex |
| $\text{H}^{1+} + \text{Si}$ | Total Scattering | 0.50-2.50 MeV | Ex |
| $\text{H}^{1+} + \text{C}$ | Elastic Scattering | 0.50-2.50 MeV | Ex |
| $\text{H}^{1+} + \text{N}$ | Elastic Scattering | 0.50-2.50 MeV | Ex |
| $\text{H}^{1+} + \text{O}$ | Elastic Scattering | 0.50-2.50 MeV | Ex |
| $\text{H}^{1+} + \text{Al}$ | Elastic Scattering | 0.50-2.50 MeV | Ex |
| $\text{H}^{1+} + \text{Si}$ | Elastic Scattering | 0.50-2.50 MeV | Ex |
833. W. Berky, U. C. Steinbauer, H. Baumann, A. G. Balogh
Measurement of non-Rutherford cross sections of ^4He ions on ^{14}N at a laboratory backscattering angle of 171° between 7.5 and 9.8 MeV.
Nucl. Instrum. Methods Phys. Res. B **192**, 249 (2002)
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|-----------------------------|--------------------|---------------|----|
| $\text{He}^{1+} + \text{N}$ | Total Scattering | 7.50-9.80 MeV | Ex |
| $\text{He}^{1+} + \text{N}$ | Elastic Scattering | 7.50-9.80 MeV | Ex |
834. R. K. Tripathi, J. W. Wilson, F. A. Cucinotta
A method for calculating proton-nucleus elastic cross-sections.
Nucl. Instrum. Methods Phys. Res. B **194**, 229 (2002)
- | | | | |
|-----------------------------|--------------------|----------------|----|
| $\text{H}^{1+} + \text{Be}$ | Elastic Scattering | 0.01-10.00 GeV | Th |
| $\text{H}^{1+} + \text{C}$ | Elastic Scattering | 0.01-10.00 GeV | Th |
| $\text{H}^{1+} + \text{Al}$ | Elastic Scattering | 0.01-10.00 GeV | Th |
| $\text{H}^{1+} + \text{Fe}$ | Elastic Scattering | 0.01-10.00 GeV | Th |
| $\text{H}^{1+} + \text{Pb}$ | Elastic Scattering | 0.01-10.00 GeV | Th |
| $\text{H}^{1+} + \text{U}$ | Elastic Scattering | 0.01-10.00 GeV | Th |
835. A. I. Panin, A. V. Tulub
X-OH₂⁺ (X = C,O) cations: vibrational spectra, stability, and electron capture reactions.
Opt. Spectrosc. **89**, 706 (2000)
- | | | |
|-------------------------------|------------------------|----|
| $\text{C} + \text{OH}_2^{1+}$ | Interaction Potentials | Th |
| $\text{O} + \text{OH}_2^{1+}$ | Interaction Potentials | Th |
836. A. Z. Devdariani, A. L. Zagrebin, M. G. Lednev, A. B. Alekseyev, H.-P. Liebermann, R. J. Buenker
Interaction potentials of $\text{Hg}^* + \text{He}$ at moderate interatomic separations and the radiative decay of the $\text{Hg}(6\ ^3\text{P}_2)$ metastable state in collisions with He atoms.
Opt. Spectrosc. **91**, 833 (2001)
- | | | |
|---------------------------|------------------------|----|
| $\text{He} + \text{He}$ | Interaction Potentials | Th |
| $\text{He} + \text{He}^*$ | Interaction Potentials | Th |
837. H. Liebel, S. Lauer, F. Vollweiler, R. Mueller-Albrecht, A. Ehresmann, H. Schmoranzner, G. Mentzel, K.-H. Schartner, O. Wilhelmi
Neutral photodissociation of O₂ Rydberg states accompanied by changes of the Rydberg electron's quantum numbers n and l.
Phys. Lett. A **267**, 357 (2000)
- | | | | |
|----------------------------|------------------------|----------------|-----|
| $\text{O} + \text{O}$ | Interaction Potentials | 22.70-24.80 eV | E/T |
| $\text{O} + \text{O}^{1+}$ | Interaction Potentials | 22.70-24.80 eV | E/T |

838. J. Anton, K. Schulze, D. Geschke, W.-D. Sepp, B. Fricke
A unified time-dependent description of ion-atom collisions.
 Phys. Lett. A **268**, 85 (2000)
 $\text{H}^{1+} + \text{He}$ Ionization 0.01-1.00 keV Th
839. H. J. Bulten, Z.-L. Zhou, J.F.J. van den Brand, M. Ferro-Luzzi, J. Lang
Spin-exchange effects on tensor polarization of deuterium atoms.
 Phys. Rev. A **58**, 1146 (1998)
 $\text{H} + \text{H}$ Heavy Particle Collisions Ex
 $\text{H} + \text{H}$ Elastic Scattering Ex
 $\text{D} + \text{D}$ Heavy Particle Collisions Ex
 $\text{D} + \text{D}$ Elastic Scattering Ex
840. M.-C. Bacchus-Montabonel, P. Ceyzeriat
Ab initio molecular treatment of charge transfer by Si^{4+} ions in helium.
 Phys. Rev. A **58**, 1162 (1998)
 $\text{Si}^{4+} + \text{He}$ Charge Transfer 0.00-60.00 keV Th
841. M. M. Sant'Anna, W. S. Melo, A.C.F Santos, G. M. Sigaud, E. C. Montenegro, M. B. Shah, W. E. Meyerhof
Absolute measurements of electron-loss cross sections of He^+ and C^{3+} with atomic hydrogen at intermediate velocities.
 Phys. Rev. A **58**, 1204 (1998)
 $\text{He}^{1+} + \text{H}$ Ionization 0.50-3.50 MeV Ex
 $\text{He}^{1+} + \text{H}_2$ Ionization 0.50-3.50 MeV Ex
 $\text{C}^{3+} + \text{H}$ Ionization 0.50-3.50 MeV Ex
 $\text{C}^{3+} + \text{H}_2$ Ionization 0.50-3.50 MeV Ex
842. L. An, Kh. Khayyat, M. Schulz
Fully differential cusp electron production cross sections for 75-keV $\text{H}_2^+ + \text{He}$ collisions.
 Phys. Rev. A **63**, 030703 (2001)
 $\text{H}_2^{1+} + \text{He}$ Ionization 75.00 keV Ex
843. D. Mathur
Irradiation of benzene molecules by ion-induced and light-induced intense fields.
 Phys. Rev. A **63**, 032502 (2001)
 $\text{Si}^{8+} + \text{C}_6\text{H}_6$ Ionization Ex
 $\text{Si}^{8+} + \text{C}_6\text{H}_6$ Dissociation Ex
844. R. Baranowski, M. Thachuk
Simply analytic form for the velocity–angular-momentum distribution function of drifting linear ions.
 Phys. Rev. A **63**, 032503 (2001)
 $\text{NO}^{1+} + \text{He}$ Excitation 300.00 K Th
 $\text{NO}^{1+} + \text{He}$ Elastic Scattering 300.00 K Th
845. G. Lanzano, E. De Filippo, D. Mahboub, H. Rothard, S. Aiello, A. Anzalone, S. Cavallaro, A. Elanique, E. Geraci, M. Geraci, F. Giustolisi, A. Pagano, G. Politi
Ejection of fast electrons following the impact of 45 MeV/u $^{58}\text{Ni}^{q+}$ ($q=19,28$) on solid-foil targets.
 Phys. Rev. A **63**, 032702 (2001)
 $\text{Ni}^{19+} + \text{C}$ Ionization 45.00 MeV/amu Ex
 $\text{Ni}^{19+} + \text{Al}$ Ionization 45.00 MeV/amu Ex
 $\text{Ni}^{19+} + \text{Au}$ Ionization 45.00 MeV/amu Ex
 $\text{Ni}^{28+} + \text{C}$ Ionization 45.00 MeV/amu Ex
 $\text{Ni}^{28+} + \text{Al}$ Ionization 45.00 MeV/amu Ex
 $\text{Ni}^{28+} + \text{Ni}$ Ionization 45.00 MeV/amu Ex
 $\text{Ni}^{28+} + \text{Ag}$ Ionization 45.00 MeV/amu Ex
 $\text{Ni}^{28+} + \text{Au}$ Ionization 45.00 MeV/amu Ex

846. H. Gao, Z. Fang, V.H.S Kwong
Absolute total one- and two-electron-transfer cross sections of O^{3+} and O^{2+} with CO at kilo-electron-volt energies.
 Phys. Rev. A **63**, 032704 (2001)
- | | | | |
|----------------|-----------------|----------------------|----|
| $O^{2+} + H_2$ | Charge Transfer | 188.00-304.00 eV/amu | Ex |
| $O^{2+} + CO$ | Charge Transfer | 188.00-304.00 eV/amu | Ex |
| $O^{3+} + H_2$ | Charge Transfer | 188.00-304.00 eV/amu | Ex |
| $O^{3+} + CO$ | Charge Transfer | 188.00-304.00 eV/amu | Ex |
847. J. Buldyreva, S. Benec'h, M. Chrysos
Oxygen-broadened and air-broadened linewidths for the NO infrared absorption bands by means of the exact-trajectory approach.
 Phys. Rev. A **63**, 032705 (2001)
- | | | | |
|------------|-----------------|-----------------|----|
| $N_2 + NO$ | Line Broadening | 163.00-299.00 K | Th |
| $O_2 + NO$ | Line Broadening | 163.00-299.00 K | Th |
848. S. Bliman, M. Cornille, B. A. Huber, J. Nordgren, J. E. Rubensson
Electron capture by a metastable ion in the collision of Ar^{8+} ($2p^5 3s$) $^3P_{0,2}$ + H_2 at low velocity.
 Phys. Rev. A **63**, 032710 (2001)
- | | | | |
|------------------|-----------------|-------------|-----|
| $Ar^{8+*} + H_2$ | Charge Transfer | 10.00 keV/q | E/T |
| $Ar^{8+} + H_2$ | Charge Transfer | 10.00 keV/q | E/T |
849. O. Hadjar, R. Hoekstra, R. Morgenstern, T. Schlathoelter
Projectile atomic-number effect on ion-induced fragmentation and ionization of fullerenes.
 Phys. Rev. A **63**, 033201 (2001)
- | | | | |
|--------------------|--------------|----------------|-----|
| $He^{2+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $B^{2+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $B^{3+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $C^{2+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $C^{3+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $N^{2+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $N^{3+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $O^{2+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $O^{3+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $F^{2+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $F^{3+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $Ne^{2+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $Ne^{3+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $Na^{2+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $Na^{3+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $S^{2+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $S^{3+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $Cl^{2+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $Cl^{3+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $Ar^{2+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
| $Ar^{3+} + C_{60}$ | Dissociation | 0.20-0.25 a.u. | E/T |
850. F. Gobet, B. Farizon, M. Farizon, M. J. Gaillard, J. P. Buchet, M. Carre, P. Scheier, T. D. Maerk
Cluster multifragmentation and percolation transition: A quantitative comparison for two systems of the same size.
 Phys. Rev. A **63**, 033202 (2001)
- | | | | |
|--------------------|--------------|---------------|----|
| $H_{27}^{1+} + He$ | Dissociation | 60.00 keV/amu | Ex |
|--------------------|--------------|---------------|----|
851. B. Gao
Angular-momentum-insensitive quantum-defect theory for diatomic systems.
 Phys. Rev. A **64**, 010701 (2001)

- | | | | | |
|--|----------------|--------------------|-------------------------|----|
| | Rb + Rb | Elastic Scattering | 0.00-10 ⁻³ K | Th |
|--|----------------|--------------------|-------------------------|----|
852. A. Derevianko, R. Cote, A. Dalgarno, G.-H. Jeung
Enhanced cooling of hydrogen by a buffer gas of alkali-metal atoms.
 Phys. Rev. A **64**, 011404 (2001)
- | | | | | |
|--|---------------|--------------------|------------------------------|----|
| | Na + H | Elastic Scattering | 3x10 ⁻¹¹ -2.72 eV | Th |
| | K + H | Elastic Scattering | 0.00-2.72 eV | Th |
| | Rb + H | Elastic Scattering | 0.00-2.72 eV | Th |
| | Cs + H | Elastic Scattering | 0.00-2.72 eV | Th |
853. X. Ma, Th. Stohlker, F. Bosch, O. Brinzaescu, S. Fritzsche, C. Kozhuharov, T. Ludziejewski, P. H. Mokler, Z. Stachura, A. Warczak
State-selective electron capture into He-like U⁹⁰⁺ ions in collisions with gaseous targets.
 Phys. Rev. A **64**, 012704 (2001)
- | | | | | |
|--|--|-----------------|----------------|-----|
| | U⁹⁰⁺ + N₂ | Charge Transfer | 223.00 MeV/amu | E/T |
| | U⁹⁰⁺ + Ar | Charge Transfer | 223.00 MeV/amu | E/T |
| | U⁹⁰⁺ + Kr | Charge Transfer | 223.00 MeV/amu | E/T |
| | U⁹⁰⁺ + Xe | Charge Transfer | 223.00 MeV/amu | E/T |
854. M. R. Fiori, G. Jalbert, C. E. Bielschowsky, W. Cravero
Ionization of lithium by impact of fast bare ions.
 Phys. Rev. A **64**, 012705 (2001)
- | | | | | |
|--|------------------------------|------------------|----------------|----|
| | H¹⁺ + Li | Total Scattering | 0.20-95.00 MeV | Th |
| | He²⁺ + Li | Total Scattering | 0.20-95.00 MeV | Th |
| | N⁷⁺ + Li | Total Scattering | 0.20-95.00 MeV | Th |
| | Ar¹⁸⁺ + Li | Total Scattering | 0.20-95.00 MeV | Th |
| | H¹⁺ + Li | Ionization | 0.20-95.00 MeV | Th |
| | He²⁺ + Li | Ionization | 0.20-95.00 MeV | Th |
| | N⁷⁺ + Li | Ionization | 0.20-95.00 MeV | Th |
| | Ar¹⁸⁺ + Li | Ionization | 0.20-95.00 MeV | Th |
855. I. Mancev
Single-electron capture and transfer ionization in collisions of Li³⁺ ions with helium.
 Phys. Rev. A **64**, 012708 (2001)
- | | | | | |
|--|-----------------------------|-----------------|-------------------|----|
| | Li³⁺ + He | Ionization | 0.05-5.00 MeV/amu | Th |
| | Li³⁺ + He | Charge Transfer | 0.05-5.00 MeV/amu | Th |
856. T. Kirchner, M. Horbatsch, H. J. Ludde
Nonperturbative calculation of charge-changing processes in C⁴⁺ scattering from neon atoms.
 Phys. Rev. A **64**, 012711 (2001)
- | | | | | |
|--|----------------------------|-----------------|-------------------|----|
| | C⁴⁺ + Ne | Ionization | 0.02-2.00 MeV/amu | Th |
| | C⁴⁺ + Ne | Charge Transfer | 0.02-2.00 MeV/amu | Th |
857. H. Merabet, M. Bailey, R. Bruch, J. Hanni, S. Bliman, D. V. Fursa, I. Bray, K. Bartschat, H. C. Tseng, C. D. Lin
Cross sections and collision dynamics of the excitation of (1snp) ¹P⁰ levels of helium, n = 2-5, by intermediate- and high-velocity electron, proton, and molecular-ion (H₂⁺ and H₃⁺) impact.
 Phys. Rev. A **64**, 012712 (2001)
- | | | | | |
|--|--|------------|---------------|-----|
| | H¹⁺ + He | Excitation | 0.05-1.40 keV | E/T |
| | H₂¹⁺ + He | Excitation | 0.05-1.40 keV | E/T |
| | H₃¹⁺ + He | Excitation | 0.05-1.40 keV | E/T |
858. H. Zhang, X. Flechard, A. Cassimi, L. Adoui, G. Cremer, F. Fremont, D. Hennecart
Experimental study of single, double, and multiple electron capture in slow ¹⁵N⁷⁺ + Ne collisions using recoil-ion momentum spectroscopy.
 Phys. Rev. A **64**, 012715 (2001)

- | | | | | |
|--|-----------------------------|-----------------|------------|----|
| | $\text{N}^{7+} + \text{Ne}$ | Ionization | 105.00 keV | Ex |
| | $\text{N}^{7+} + \text{Ne}$ | Charge Transfer | 105.00 keV | Ex |
859. B. C. Saha, A. Kumar
Slow electron capture by H^+ from initially excited p states of alkali-metal atoms: Effects of alignment and orientation.
 Phys. Rev. A **64**, 012721 (2001)
- | | | | | |
|--|-------------------------------|-----------------|-------------------|----|
| | $\text{H}^{1+} + \text{Na}^*$ | Charge Transfer | 0.01-1.00 keV/amu | Th |
| | $\text{H}^{1+} + \text{Na}$ | Charge Transfer | 0.01-1.00 keV/amu | Th |
| | $\text{H}^{1+} + \text{K}^*$ | Charge Transfer | 0.01-1.00 keV/amu | Th |
| | $\text{H}^{1+} + \text{K}$ | Charge Transfer | 0.01-1.00 keV/amu | Th |
860. R. C. Forrey, N. Balakrishnan, A. Dalgarno, M. R. Haggarty, E. J. Heller
Effect of quasiresonant dynamics on the predissociation of van der Waals molecules.
 Phys. Rev. A **64**, 022706 (2001)
- | | | | | |
|--|--------------------------|-----------------|----------------|----|
| | $\text{He} + \text{H}_2$ | Energy Transfer | 10^{-5} a.u. | Th |
|--|--------------------------|-----------------|----------------|----|
861. D. Rabli, M. Gargaud, R. McCarroll
Electron capture and excitation in low-energy collisions of He^{2+} with metastable 2^1S and 2^3S He.
 Phys. Rev. A **64**, 022707 (2001)
- | | | | | |
|--|------------------------------|-----------------|--------------------|----|
| | $\text{He}^{2+} + \text{He}$ | Excitation | 1.36-400.00 eV/amu | Th |
| | $\text{He}^{2+} + \text{He}$ | Charge Transfer | 1.36-400.00 eV/amu | Th |
862. I. Ali, R. D. DuBois, C. L. Cocke, S. Hagmann, C. R. Feeler, R. E. Olson
Dynamics of the fragmentation of D_2 by fast protons and slow highly charged Xe^{26+} .
 Phys. Rev. A **64**, 022712 (2001)
- | | | | | |
|--|--------------------------------|--------------|--------------------|----|
| | $\text{H}^{1+} + \text{H}_2$ | Dissociation | 0.19-50.00 keV/amu | Ex |
| | $\text{H}^{1+} + \text{D}_2$ | Dissociation | 0.19-50.00 keV/amu | Ex |
| | $\text{Xe}^{26+} + \text{H}_2$ | Dissociation | 0.19-50.00 keV/amu | Ex |
| | $\text{Xe}^{26+} + \text{D}_2$ | Dissociation | 0.19-50.00 keV/amu | Ex |
863. A. Reinkoester, U. Werner, N. M. Kabachnik, H. O. Lutz
Experimental and theoretical study of ionization and fragmentation of C_{60} by fast-proton impact.
 Phys. Rev. A **64**, 023201 (2001)
- | | | | | |
|--|---------------------------------|--------------|----------------|----|
| | $\text{H}^{1+} + \text{C}_{60}$ | Ionization | 1.00-3.50 a.u. | Ex |
| | $\text{H}^{1+} + \text{C}_{60}$ | Dissociation | 1.00-3.50 a.u. | Ex |
864. L. Chen, S. Martin, R. Bredy, J. Bernard, J. Desequelles
Dynamical fragmentation processes of C_{60}^{5+} ions in Ar^{8+} - C_{60} collisions.
 Phys. Rev. A **64**, 031201 (2001)
- | | | | | |
|--|----------------------------------|--------------|-----------|----|
| | $\text{Ar}^{8+} + \text{C}_{60}$ | Dissociation | 56.00 keV | Ex |
|--|----------------------------------|--------------|-----------|----|
865. F. Zappa, L.F.S Coelho, S. D. Magalhaes, J. C. Acquadro, T. S. Cabral, G. Jalbert, N. V. de Castro Faria
Collisional destruction of anionic carbon and silicon clusters by helium, neon, and argon atoms at intermediate velocities.
 Phys. Rev. A **64**, 032701 (2001)
- | | | | | |
|--|---------------------------------|------------|----------------|----|
| | $\text{He} + \text{Si}_2^{-1+}$ | Detachment | 0.10-1.20 a.u. | Ex |
| | $\text{He} + \text{Si}_3^{-1+}$ | Detachment | 0.10-1.20 a.u. | Ex |
| | $\text{He} + \text{Si}_4^{-1+}$ | Detachment | 0.10-1.20 a.u. | Ex |
| | $\text{He} + \text{C}_2^{-1+}$ | Detachment | 0.10-1.20 a.u. | Ex |
| | $\text{He} + \text{C}_3^{-1+}$ | Detachment | 0.10-1.20 a.u. | Ex |
| | $\text{He} + \text{C}_4^{-1+}$ | Detachment | 0.10-1.20 a.u. | Ex |
| | $\text{Ne} + \text{Si}_2^{-1+}$ | Detachment | 0.10-1.20 a.u. | Ex |
| | $\text{Ne} + \text{Si}_3^{-1+}$ | Detachment | 0.10-1.20 a.u. | Ex |

Ne + Si ₄ ⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex
Ne + C ₂ ⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex
Ne + C ₃ ⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex
Ne + C ₄ ⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex
Ar + Si ₂ ⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex
Ar + Si ₃ ⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex
Ar + Si ₄ ⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex
Ar + C ₂ ⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex
Ar + C ₃ ⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex
Ar + C ₄ ⁻¹⁺	Detachment	0.10-1.20 a.u.	Ex
He + Si ₂ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
He + Si ₃ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
He + Si ₄ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
He + C ₂ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
He + C ₃ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
He + C ₄ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
Ne + Si ₂ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
Ne + Si ₃ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
Ne + Si ₄ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
Ne + C ₂ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
Ne + C ₃ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
Ne + C ₄ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
Ar + Si ₂ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
Ar + Si ₃ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
Ar + Si ₄ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
Ar + C ₂ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
Ar + C ₃ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
Ar + C ₄ ⁻¹⁺	Ionization	0.10-1.20 a.u.	Ex
He + Si ₂ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
He + Si ₃ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
He + Si ₄ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
He + C ₂ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
He + C ₃ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
He + C ₄ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
Ne + Si ₂ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
Ne + Si ₃ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
Ne + Si ₄ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
Ne + C ₂ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
Ne + C ₃ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
Ne + C ₄ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
Ar + Si ₂ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
Ar + Si ₃ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
Ar + Si ₄ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
Ar + C ₂ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
Ar + C ₃ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex
Ar + C ₄ ⁻¹⁺	Dissociation	0.10-1.20 a.u.	Ex

866. A. Itoh, H. Tsuchida, K. Miyabe, T. Majima, Y. Nakai

Fragment ion distribution in charge-changing collisions of 2-MeV Si ions with C₆₀.

Phys. Rev. A **64**, 032702 (2001)

S + C ₆₀	Ionization	2.00 MeV	Ex
S ¹⁺ + C ₆₀	Ionization	2.00 MeV	Ex
S ²⁺ + C ₆₀	Ionization	2.00 MeV	Ex
S ⁴⁺ + C ₆₀	Ionization	2.00 MeV	Ex
S + C ₆₀	Charge Transfer	2.00 MeV	Ex
S ¹⁺ + C ₆₀	Charge Transfer	2.00 MeV	Ex
S ²⁺ + C ₆₀	Charge Transfer	2.00 MeV	Ex

$S^{4+} + C_{60}$	Charge Transfer	2.00 MeV	Ex
$S + C_{60}$	Dissociation	2.00 MeV	Ex
$S^{1+} + C_{60}$	Dissociation	2.00 MeV	Ex
$S^{2+} + C_{60}$	Dissociation	2.00 MeV	Ex
$S^{4+} + C_{60}$	Dissociation	2.00 MeV	Ex
867. M. J. Jamieson, B. Zygelman Mass dependence of scattering lengths for hydrogen atoms. Phys. Rev. A 64 , 032703 (2001)			
$H + H$	Elastic Scattering		Th
$He + He$	Elastic Scattering		Th
868. F. A. Rajgara, M. Krishnamurthy, D. Mathur, T. Nishide, T. Kitamura, H. Shiromaru, Y. Achiba, N. Kobayashi Fragmentation dynamics of CS_2^{q+} (q=3-10) molecular ions. Phys. Rev. A 64 , 032712 (2001)			
$Ar^{8+} + CS_2$	Dissociation	120.00 keV	Ex
869. A. Watanabe, H. Sato, J. P. Gu, G. Hirsch, R. J. Buenker, M. Kimura Electron capture in collisions of Al^{2+} ions with He atoms at intermediate energies. Phys. Rev. A 64 , 032717 (2001)			
$Al^{2+} + He$	Charge Transfer	0.00-1.00 MeV/amu	Th
870. R. Vandenbosch Collisionally induced multifragmentation of C_{60}. Phys. Rev. A 64 , 033201 (2001)			
$C_{60}^{-1+} + Ar$	Dissociation	45.00 keV	Ex
871. B. E. Granger, E. L. Hamilton, C. H. Greene Quantum and semiclassical analysis of long-range Rydberg molecules. Phys. Rev. A 64 , 042508 (2001)			
$H + Rb$	Interaction Potentials		Th
$H^* + Rb$	Interaction Potentials		Th
$Rb + Rb$	Interaction Potentials		Th
$Rb^* + Rb$	Interaction Potentials		Th
872. A. N. Perumal, D. N. Tripathi Unexplained features of capture and ionization for ionaligned-Rydberg-atom collisions. Phys. Rev. A 64 , 042709 (2001)			
$Na^{1+} + Na$	Ionization	0.03 a.u.	Th
$Na^{1+} + Na$	Charge Transfer	0.03 a.u.	Th
$Na^{1+} + Na^*$	Ionization	0.03 a.u.	Th
$Na^{1+} + Na^*$	Charge Transfer	0.03 a.u.	Th
873. P. J. Leo, V. Venturi, I. B. Whittingham, J. F. Babb Ultracold collisions of metastable helium atoms. Phys. Rev. A 64 , 042710 (2001)			
$He + He$	Excitation	1.00-500.00 μK	Th
$He + He$	Elastic Scattering	1.00-500.00 μK	Th
$He + He$	Interaction Potentials	1.00-500.00 μK	Th
$He^* + He^*$	Excitation	1.00-500.00 μK	Th
$He^* + He^*$	Elastic Scattering	1.00-500.00 μK	Th
$He^* + He^*$	Interaction Potentials	1.00-500.00 μK	Th

874. H. Tawara, P. Richard, U. I. Safronova, P. C. Stancil

K x-ray production in H-like Si^{13+} , S^{15+} , and Ar^{17+} ions colliding with various atom and molecule gas targets at low collision energies.

Phys. Rev. A **64**, 042712 (2001)

$\text{Si}^{13+} + \text{H}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Si}^{13+} + \text{D}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Si}^{13+} + \text{He}$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Si}^{13+} + \text{CH}_4$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Si}^{13+} + \text{CO}$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Si}^{13+} + \text{CO}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Si}^{13+} + \text{N}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Si}^{13+} + \text{O}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Si}^{13+} + \text{Ne}$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Si}^{13+} + \text{Ar}$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{S}^{15+} + \text{H}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{S}^{15+} + \text{D}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{S}^{15+} + \text{He}$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{S}^{15+} + \text{CH}_4$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{S}^{15+} + \text{CO}$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{S}^{15+} + \text{CO}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{S}^{15+} + \text{N}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{S}^{15+} + \text{O}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{S}^{15+} + \text{Ne}$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{S}^{15+} + \text{Ar}$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Ar}^{17+} + \text{H}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Ar}^{17+} + \text{D}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Ar}^{17+} + \text{He}$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Ar}^{17+} + \text{CH}_4$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Ar}^{17+} + \text{CO}$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Ar}^{17+} + \text{CO}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Ar}^{17+} + \text{N}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Ar}^{17+} + \text{O}_2$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Ar}^{17+} + \text{Ne}$	Charge Transfer	1.00-70.00 keV/amu	E/T
$\text{Ar}^{17+} + \text{Ar}$	Charge Transfer	1.00-70.00 keV/amu	E/T

875. Y. S. Tergiman, M.-C. Bacchus-Montabonel

State-selective single and double electron capture in the collision of N^{4+} with He.

Phys. Rev. A **64**, 042721 (2001)

$\text{N}^{4+} + \text{He}$	Charge Transfer	1.00-50.00 keV	Th
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876. J. R. Stallcop, H. Partridge, E. Levin

Effective potential energies and transport cross sections for atom-molecule interactions of nitrogen and oxygen.

Phys. Rev. A **64**, 042722 (2001)

$\text{H}_2 + \text{N}$	Interaction Potentials	0.10-10.00 K	Th
$\text{N}_2 + \text{N}$	Interaction Potentials	0.10-10.00 K	Th
$\text{O}_2 + \text{O}$	Interaction Potentials	0.10-10.00 K	Th
$\text{H}_2 + \text{N}$	Elastic Scattering	0.10-10.00 K	Th
$\text{N}_2 + \text{N}$	Elastic Scattering	0.10-10.00 K	Th
$\text{O}_2 + \text{O}$	Elastic Scattering	0.10-10.00 K	Th

877. A. K. Belyaev, D. Egorova, J. Grosser, T. Menzel

Electron translation and asymptotic couplings in low-energy atomic collisions.

Phys. Rev. A **64**, 052701 (2001)

$\text{H} + \text{He}$	Excitation	50.00 eV	Th
$\text{H} + \text{Na}$	Excitation	50.00 eV	Th

878. M. Zamkov, H. Aliabadi, E. P. Benis, P. Richard, H. Tawara, T.J.M. Zouros
Energy dependence of the metastable fraction in B^{3+} ($1s^2\ ^1S, 1s2s\ ^3S$) beams produced in collisions with thin-foil and gas targets.
 Phys. Rev. A **64**, 052702 (2001)
- | | | | |
|----------------|-----------------|---------------|-----|
| $B^{3+} + N_2$ | Excitation | 0.85-9.00 MeV | E/T |
| $B^{3+} + H_2$ | Charge Transfer | 0.85-9.00 MeV | E/T |
| $B^{3+} + He$ | Charge Transfer | 0.85-9.00 MeV | E/T |
879. A. V. Avdeenkov, J. L. Bohn
Ultracold collisions of oxygen molecules.
 Phys. Rev. A **64**, 052703 (2001)
- | | | | |
|-------------|------------------------|--------|----|
| $O_2 + O_2$ | Interaction Potentials | 1.00 K | Th |
| $O_2 + O_2$ | Excitation | 1.00 K | Th |
| $O_2 + O_2$ | Elastic Scattering | 1.00 K | Th |
880. S. R. Lundeen, R. A. Komara, C. W. Fehrenbach, B. D. DePaola
Experimental study of L distributions from charge capture by Si^{3+} on Rydberg atoms.
 Phys. Rev. A **64**, 052714 (2001)
- | | | | |
|----------------|-----------------|-----------|----|
| $Si^{3+} + Rb$ | Charge Transfer | 12.00 keV | Ex |
|----------------|-----------------|-----------|----|
881. B. L. Tolra, C. Drag, P. Pillet
Observation of cold state-selected cesium molecules formed by stimulated Raman photoassociation.
 Phys. Rev. A **64**, 061401 (2001)
- | | | | |
|-----------|-------------|---------|----|
| $Cs + Cs$ | Association | 0.13 mK | Ex |
|-----------|-------------|---------|----|
882. K. Iemura, S. Ohtani, H. Suzuki, J. Takeda, S. Machida, K. Tanabe, T. Takayanagi, K. Wakiya, M. Sekiguchi, Y. Kanai, S. Kitazawa, X. M. Tong, D. Kato, S. Sakaguchi, T. Watanabe, F. J. Currell
Electron spectroscopy of doubly excited states in He produced by slow collisions of He^{2+} ions with Ba atoms.
 Phys. Rev. A **64**, 062709 (2001)
- | | | | |
|----------------|-----------------|-----------------|----|
| $He^{2+} + Ba$ | Charge Transfer | 20.00-40.00 keV | Ex |
| $He^{2+} + Ba$ | Excitation | 20.00-40.00 keV | Ex |
883. V. L. Kravchuk, A. M. van den Berg, F. Fleurot, M. A. de Huu, H. Loehner, H. W. Wilschut, M. Polasik, M. Lewandowska-Robak, K. Slabkowska
K- and L-shell ionization of heavy targets by various 20- and 80-MeV/u projectiles.
 Phys. Rev. A **64**, 062710 (2001)
- | | | | |
|----------------|------------|---------------------|-----|
| $He^{1+} + Ta$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $He^{1+} + Pb$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $He^{1+} + Th$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $He^{2+} + Pb$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $C^{3+} + Ta$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $C^{3+} + Pb$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $C^{3+} + Th$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $C^{6+} + Pb$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $O^{4+} + Ta$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $O^{4+} + Pb$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $O^{4+} + Th$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $O^{8+} + Pb$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $Ne^{5+} + Ta$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $Ne^{5+} + Pb$ | Ionization | 20.00-80.00 MeV/amu | E/T |
| $Ne^{5+} + Th$ | Ionization | 20.00-80.00 MeV/amu | E/T |
884. C. McGrath, M. B. Shah, P.C.E. McCartney, J. W. McConkey
 H_2^+ (20-100-keV) collisions with H: Dissociative and nondissociative capture and ionization and pure-H-target ionization.
 Phys. Rev. A **64**, 062712 (2001)

$\text{H}_2^{1+} + \text{H}$	Ionization	20.00-100.00 keV	Ex
$\text{H}_2^{1+} + \text{H}$	Charge Transfer	20.00-100.00 keV	Ex
$\text{H}_2^{1+} + \text{H}$	Dissociation	20.00-100.00 keV	Ex

885. Y. Arimoto, N. Shimakura, T. Yamagata, K. Yonehara, M. Tanaka

Spin-exchange cross section for a $^3\text{He}^+$ ion incident on a Rb atom.

Phys. Rev. A **64**, 062714 (2001)

$\text{He}^{1+} + \text{Rb}$	Charge Transfer	0.01-10.00 keV/amu	Th
$\text{He}^{1+} + \text{Rb}$	Excitation	0.01-10.00 keV/amu	Th

886. S. G. Porsev, A. Derevianko

High-accuracy relativistic many-body calculations of van der Waals coefficients C_6 for alkaline-earth-metal atoms.

Phys. Rev. A **65**, 020701 (2002)

$\text{Be} + \text{Be}$	Interaction Potentials		Th
$\text{Mg} + \text{Mg}$	Interaction Potentials		Th
$\text{Ca} + \text{Ca}$	Interaction Potentials		Th
$\text{Sr} + \text{Sr}$	Interaction Potentials		Th
$\text{Ba} + \text{Ba}$	Interaction Potentials		Th

887. N. V. Dobrodey, A. I. Streltsov, L. S. Cederbaum

Core-ionized states and spectra of Be and Mg dimers.

Phys. Rev. A **65**, 022501 (2002)

$\text{Be} + \text{Be}$	Interaction Potentials		Th
$\text{Mg} + \text{Mg}$	Interaction Potentials		Th

888. L. F. Errea, C. Harel, H. Jouin, L. Mendez, B. Pons, A. Riera, I. Sevilá

Description of ionization in the molecular approach to atomic collisions. II.

Phys. Rev. A **65**, 022711 (2002)

$\text{He}^{2+} + \text{H}$	Ionization	64.00-225.00 keV/amu	Th
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889. R. Cabrera-Trujillo, Y. Ohrn, J. R. Sabin, E. Deumens

Molecular target and projectile angular scattering effects in stopping power and charge exchange at low-to-intermediate projectile energies.

Phys. Rev. A **65**, 024901 (2002)

$\text{H} + \text{H}$	Total Scattering	0.00-1.00 MeV	Th
$\text{H} + \text{H}$	Total Scattering	0.00-1.00 MeV	Th
$\text{H} + \text{H}_2$	Total Scattering	0.00-1.00 MeV	Th
$\text{H} + \text{H}_2$	Total Scattering	0.00-1.00 MeV	Th
$\text{H} + \text{N}$	Total Scattering	0.00-1.00 MeV	Th
$\text{H} + \text{N}$	Total Scattering	0.00-1.00 MeV	Th
$\text{H} + \text{N}_2$	Total Scattering	0.00-1.00 MeV	Th
$\text{H} + \text{N}_2$	Total Scattering	0.00-1.00 MeV	Th
$\text{H}^{1+} + \text{H}$	Total Scattering	0.00-1.00 MeV	Th
$\text{H}^{1+} + \text{H}$	Total Scattering	0.00-1.00 MeV	Th
$\text{H}^{1+} + \text{H}_2$	Total Scattering	0.00-1.00 MeV	Th
$\text{H}^{1+} + \text{H}_2$	Total Scattering	0.00-1.00 MeV	Th
$\text{H} + \text{H}$	Charge Transfer	0.00-1.00 MeV	Th
$\text{H} + \text{H}_2$	Charge Transfer	0.00-1.00 MeV	Th
$\text{H} + \text{N}$	Charge Transfer	0.00-1.00 MeV	Th
$\text{H} + \text{N}_2$	Charge Transfer	0.00-1.00 MeV	Th
$\text{H}^{1+} + \text{H}$	Charge Transfer	0.00-1.00 MeV	Th
$\text{H}^{1+} + \text{H}_2$	Charge Transfer	0.00-1.00 MeV	Th
$\text{H} + \text{H}$	Heavy Particle Collisions	0.00-1.00 MeV	Th
$\text{H} + \text{H}_2$	Heavy Particle Collisions	0.00-1.00 MeV	Th
$\text{H} + \text{N}$	Heavy Particle Collisions	0.00-1.00 MeV	Th

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|--|------------------------------|---------------------------|---------------|----|
| | $\text{H} + \text{N}_2$ | Heavy Particle Collisions | 0.00-1.00 MeV | Th |
| | $\text{H}^{1+} + \text{H}$ | Heavy Particle Collisions | 0.00-1.00 MeV | Th |
| | $\text{H}^{1+} + \text{H}_2$ | Heavy Particle Collisions | 0.00-1.00 MeV | Th |
890. M. Ehrich, U. Werner, H. O. Lutz, T. Kaneyasu, K. Ishii, K. Okuno, U. Saalman
Simultaneous charge polarization and fragmentation of N_2 molecules in slow keV collisions with Kr^{8+} ions.
 Phys. Rev. A **65**, 030702 (2002)

$\text{Kr}^{8+} + \text{N}_2$	Dissociation	19.00-171.00 eV/amu	Ex
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891. C. Illescas, B. Pons, A. Riera
Classical description of the electron capture to the continuum cusp formation in ion-atom collisions.
 Phys. Rev. A **65**, 030703 (2002)

$\text{H}^{1+} + \text{H}$	Total Scattering	0.89-2.00 a.u.	Th
$\text{H}^{1+} + \text{H}$	Ionization	0.89-2.00 a.u.	Th
892. M. Zamkov, H. Aliabadi, E. P. Benis, P. Richard, H. Tawara, T.J.M. Zouros
Absolute cross sections and decay rates for the triply excited B^{2+} ($2s2p^2\ ^2\text{D}$) resonance in electron-metastable-ion collisions.
 Phys. Rev. A **65**, 032705 (2002)

$\text{B}^{2+} + \text{H}_2$	Charge Transfer	4.00 MeV	Ex
$\text{B}^{2+*} + \text{H}_2$	Charge Transfer	4.00 MeV	Ex
$\text{B}^{2+} + \text{H}_2$	Excitation	4.00 MeV	Ex
$\text{B}^{2+*} + \text{H}_2$	Excitation	4.00 MeV	Ex
$\text{B}^{2+*} + \text{H}_2$	Excitation	4.00 MeV	Ex
$\text{B}^{2+*} + \text{B}^{2+}$	Excitation	4.00 MeV	Ex
893. A. B. Voitkiv, B. Najjari, R. Moshhammer, J. Ullrich
Helium single ionization in relativistic collisions with highly charged ions.
 Phys. Rev. A **65**, 032707 (2002)

$\text{U}^{92+} + \text{He}$	Ionization	1.00 GeV/amu	E/T
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894. A. Andalkar, R. B. Warrington
High-resolution measurement of the pressure broadening and shift of the Cs D1 and D2 lines by N_2 and He buffer gases.
 Phys. Rev. A **65**, 032708 (2002)

$\text{Cs} + \text{He}$	Line Broadening	294.00 K	Ex
$\text{Cs} + \text{N}_2$	Line Broadening	294.00 K	Ex
895. J. C. Flasher, R. C. Forrey
Cold collisions between argon atoms and hydrogen molecules.
 Phys. Rev. A **65**, 032710 (2002)

$\text{Ar} + \text{H}_2$	Interaction Potentials		Th
$\text{Ar} + \text{H}_2$	Energy Transfer		Th
$\text{Ar} + \text{H}_2$	Excitation		Th
896. V. Bazin, P. Boduch, M. Chantepie, E. Jacquet, H. Kucal, D. Lecler, J. Pascale
Excitation and alignment effects in Ar^{8+} -Cs(6s,6p) collisions at low energies.
 Phys. Rev. A **65**, 032712 (2002)

$\text{Ar}^{8+} + \text{Cs}$	Interaction Potentials	0.40-4.00 keV/amu	E/T
$\text{Ar}^{8+} + \text{Cs}$	Excitation	0.40-4.00 keV/amu	E/T
897. I. Yu. Yurova
Theory of fine-structure effects in thermal collisions of 3p-excited sodium atoms: Combined quasiclassical approximation.
 Phys. Rev. A **65**, 032726 (2002)

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|---------|-----------------|-------------|----|
| Na + Na | Energy Transfer | 0.30-2.20 K | Th |
|---------|-----------------|-------------|----|
898. B. Zarour, J. Hanssen, P. A. Hervieux, M. F. Politis, F. Martin
Charge dependence of electron capture and excitation cross sections in collisions of protons with closed-shell Na_{20+q}^{q+} clusters.
 Phys. Rev. A **65**, 033201 (2002)
- | | | | |
|--|-----------------|----------------|----|
| $\text{H}^{1+} + \text{Na}_{20}$ | Excitation | 0.04-0.16 a.u. | Th |
| $\text{H}^{1+} + \text{Na}_{21}^{1+}$ | Excitation | 0.04-0.16 a.u. | Th |
| $\text{H}^{1+} + \text{Na}_{19}^{-1+}$ | Excitation | 0.04-0.16 a.u. | Th |
| $\text{H}^{1+} + \text{Na}_{20}$ | Charge Transfer | 0.04-0.16 a.u. | Th |
| $\text{H}^{1+} + \text{Na}_{21}^{1+}$ | Charge Transfer | 0.04-0.16 a.u. | Th |
| $\text{H}^{1+} + \text{Na}_{19}^{-1+}$ | Charge Transfer | 0.04-0.16 a.u. | Th |
899. C. Zhu, A. Dalgarno, A. Derevianko
van der Waals interactions between molecular hydrogen and alkali-metal atoms.
 Phys. Rev. A **65**, 034708 (2002)
- | | | | |
|--------------------------|--------------------|--|----|
| $\text{H}_2 + \text{Li}$ | Line Broadening | | Th |
| $\text{H}_2 + \text{Na}$ | Line Broadening | | Th |
| $\text{H}_2 + \text{K}$ | Line Broadening | | Th |
| $\text{H}_2 + \text{Rb}$ | Line Broadening | | Th |
| $\text{H}_2 + \text{Cs}$ | Line Broadening | | Th |
| $\text{H}_2 + \text{Fr}$ | Line Broadening | | Th |
| $\text{H}_2 + \text{Li}$ | Elastic Scattering | | Th |
| $\text{H}_2 + \text{Na}$ | Elastic Scattering | | Th |
| $\text{H}_2 + \text{K}$ | Elastic Scattering | | Th |
| $\text{H}_2 + \text{Rb}$ | Elastic Scattering | | Th |
| $\text{H}_2 + \text{Cs}$ | Elastic Scattering | | Th |
| $\text{H}_2 + \text{Fr}$ | Elastic Scattering | | Th |
900. S. Jonsell, A. Saenz, P. Froelich, R. C. Forrey, R. Cote, A. Dalgarno
Long-range interactions between two 2s excited hydrogen atoms.
 Phys. Rev. A **65**, 042501 (2002)
- | | | | |
|---------------------------|------------------------|--|----|
| $\text{H} + \text{H}$ | Interaction Potentials | | Th |
| $\text{H}^* + \text{H}^*$ | Interaction Potentials | | Th |
901. H. Tawara, P. Richard, U. I. Safronova, A. A. Vasilyev, S. Hansen, A. S. Shlyaptseva
L x rays from low-energy (2 keV/u) ions with L-shell vacancies produced in single collisions with atoms and molecules.
 Phys. Rev. A **65**, 042509 (2002)
- | | | | |
|---------------------------------|-----------------|--------------|-----|
| $\text{Kr}^{27+} + \text{He}$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{27+} + \text{CH}_4$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{27+} + \text{N}_2$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{27+} + \text{Ne}$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{27+} + \text{Ar}$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{28+} + \text{He}$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{28+} + \text{CH}_4$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{28+} + \text{N}_2$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{28+} + \text{Ne}$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{28+} + \text{Ar}$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{29+} + \text{He}$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{29+} + \text{CH}_4$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{29+} + \text{N}_2$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{29+} + \text{Ne}$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{29+} + \text{Ar}$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{30+} + \text{He}$ | Charge Transfer | 2.00 keV/amu | E/T |
| $\text{Kr}^{30+} + \text{CH}_4$ | Charge Transfer | 2.00 keV/amu | E/T |

$\text{Kr}^{30+} + \text{N}_2$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{30+} + \text{Ne}$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{30+} + \text{Ar}$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{31+} + \text{He}$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{31+} + \text{CH}_4$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{31+} + \text{N}_2$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{31+} + \text{Ne}$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{31+} + \text{Ar}$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{32+} + \text{He}$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{32+} + \text{CH}_4$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{32+} + \text{N}_2$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{32+} + \text{Ne}$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{32+} + \text{Ar}$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{33+} + \text{He}$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{33+} + \text{CH}_4$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{33+} + \text{N}_2$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{33+} + \text{Ne}$	Charge Transfer	2.00 keV/amu	E/T
$\text{Kr}^{33+} + \text{Ar}$	Charge Transfer	2.00 keV/amu	E/T

902. N. Khelifi, W. Zrafi, B. Oujia, F. X. Gadea

Ab initio adiabatic and diabatic energies and dipole moments of the RbH molecule.

Phys. Rev. A **65**, 042513 (2002)

$\text{Rb} + \text{H}$	Interaction Potentials	Th
------------------------	------------------------	----

903. A. S. Alnaser, A. L. Landers, D. J. Pole, S. Hossain, O. A. Haija, T. W. Gorczyca, J. A. Tanis, H. Knutson
Superelastic scattering of electrons from metastable He-like C^{4+} and O^{6+} ions.

Phys. Rev. A **65**, 042709 (2002)

$\text{C}^{4+} + \text{H}_2$	Total Scattering	0.50-1.10 MeV/amu	E/T
$\text{O}^{6+} + \text{H}_2$	Total Scattering	0.50-1.10 MeV/amu	E/T
$\text{F}^{7+} + \text{H}_2$	Total Scattering	0.50-1.10 MeV/amu	E/T
$\text{C}^{4+} + \text{H}_2$	De-excitation	0.50-1.10 MeV/amu	E/T
$\text{O}^{6+} + \text{H}_2$	De-excitation	0.50-1.10 MeV/amu	E/T
$\text{F}^{7+} + \text{H}_2$	De-excitation	0.50-1.10 MeV/amu	E/T
$\text{C}^{4++} + \text{H}_2$	Total Scattering	0.50-1.10 MeV/amu	E/T
$\text{O}^{6++} + \text{H}_2$	Total Scattering	0.50-1.10 MeV/amu	E/T
$\text{F}^{7++} + \text{H}_2$	Total Scattering	0.50-1.10 MeV/amu	E/T
$\text{C}^{4++} + \text{H}_2$	De-excitation	0.50-1.10 MeV/amu	E/T
$\text{O}^{6++} + \text{H}_2$	De-excitation	0.50-1.10 MeV/amu	E/T
$\text{F}^{7++} + \text{H}_2$	De-excitation	0.50-1.10 MeV/amu	E/T

904. W. Wolff, I. Ben-Itzhak, H. E. Wolf, C. L. Cocke, M. A. Abdallah, M. Stoeckli

Comparative study of the ground-state dissociation of H_2^+ and D_2^+ induced by ionizing and electron-capture collisions with He^+ at velocities of 0.25 and 0.5 a.u.

Phys. Rev. A **65**, 042710 (2002)

$\text{He}^{1+} + \text{H}_2$	Total Scattering	0.25-0.50 a.u.	Ex
$\text{He}^{1+} + \text{D}_2$	Total Scattering	0.25-0.50 a.u.	Ex
$\text{He}^{1+} + \text{H}_2$	Charge Transfer	0.25-0.50 a.u.	Ex
$\text{He}^{1+} + \text{D}_2$	Charge Transfer	0.25-0.50 a.u.	Ex
$\text{He}^{1+} + \text{H}_2$	Ionization	0.25-0.50 a.u.	Ex
$\text{He}^{1+} + \text{D}_2$	Ionization	0.25-0.50 a.u.	Ex

905. C. S. Lee, C. H. Lin

Light emission induced from prprojectiles of H^+ , H_2^+ , and H_3^+ interacting with N_2 , N_2O , and O_2 .

Phys. Rev. A **65**, 042712 (2002)

$\text{H}^{1+} + \text{N}_2$	Dissociation	3.00-10.00 keV	Ex
$\text{H}^{1+} + \text{N}_2\text{O}$	Dissociation	3.00-10.00 keV	Ex
$\text{H}^{1+} + \text{O}_2$	Dissociation	3.00-10.00 keV	Ex
$\text{H}_2^{1+} + \text{N}_2$	Dissociation	3.00-10.00 keV	Ex
$\text{H}_2^{1+} + \text{N}_2\text{O}$	Dissociation	3.00-10.00 keV	Ex
$\text{H}_2^{1+} + \text{O}_2$	Dissociation	3.00-10.00 keV	Ex
$\text{H}_3^{1+} + \text{N}_2$	Dissociation	3.00-10.00 keV	Ex
$\text{H}_3^{1+} + \text{N}_2\text{O}$	Dissociation	3.00-10.00 keV	Ex
$\text{H}_3^{1+} + \text{O}_2$	Dissociation	3.00-10.00 keV	Ex
$\text{H}^{1+} + \text{N}_2$	Excitation	3.00-10.00 keV	Ex
$\text{H}^{1+} + \text{N}_2\text{O}$	Excitation	3.00-10.00 keV	Ex
$\text{H}^{1+} + \text{O}_2$	Excitation	3.00-10.00 keV	Ex
$\text{H}_2^{1+} + \text{N}_2$	Excitation	3.00-10.00 keV	Ex
$\text{H}_2^{1+} + \text{N}_2\text{O}$	Excitation	3.00-10.00 keV	Ex
$\text{H}_2^{1+} + \text{O}_2$	Excitation	3.00-10.00 keV	Ex
$\text{H}_3^{1+} + \text{N}_2$	Excitation	3.00-10.00 keV	Ex
$\text{H}_3^{1+} + \text{N}_2\text{O}$	Excitation	3.00-10.00 keV	Ex
$\text{H}_3^{1+} + \text{O}_2$	Excitation	3.00-10.00 keV	Ex
$\text{H}^{1+} + \text{N}_2$	Charge Transfer	3.00-10.00 keV	Ex
$\text{H}^{1+} + \text{N}_2\text{O}$	Charge Transfer	3.00-10.00 keV	Ex
$\text{H}^{1+} + \text{O}_2$	Charge Transfer	3.00-10.00 keV	Ex
$\text{H}_2^{1+} + \text{N}_2$	Charge Transfer	3.00-10.00 keV	Ex
$\text{H}_2^{1+} + \text{N}_2\text{O}$	Charge Transfer	3.00-10.00 keV	Ex
$\text{H}_2^{1+} + \text{O}_2$	Charge Transfer	3.00-10.00 keV	Ex
$\text{H}_3^{1+} + \text{N}_2$	Charge Transfer	3.00-10.00 keV	Ex
$\text{H}_3^{1+} + \text{N}_2\text{O}$	Charge Transfer	3.00-10.00 keV	Ex
$\text{H}_3^{1+} + \text{O}_2$	Charge Transfer	3.00-10.00 keV	Ex
$\text{H}^{1+} + \text{N}_2$	Fluorescence	3.00-10.00 keV	Ex
$\text{H}^{1+} + \text{N}_2\text{O}$	Fluorescence	3.00-10.00 keV	Ex
$\text{H}^{1+} + \text{O}_2$	Fluorescence	3.00-10.00 keV	Ex
$\text{H}_2^{1+} + \text{N}_2$	Fluorescence	3.00-10.00 keV	Ex
$\text{H}_2^{1+} + \text{N}_2\text{O}$	Fluorescence	3.00-10.00 keV	Ex
$\text{H}_2^{1+} + \text{O}_2$	Fluorescence	3.00-10.00 keV	Ex
$\text{H}_3^{1+} + \text{N}_2$	Fluorescence	3.00-10.00 keV	Ex
$\text{H}_3^{1+} + \text{N}_2\text{O}$	Fluorescence	3.00-10.00 keV	Ex
$\text{H}_3^{1+} + \text{O}_2$	Fluorescence	3.00-10.00 keV	Ex

906. E. Tiesinga, S. Kotochigova, P. S. Julienne

Scattering length of the ground-state Mg + Mg collision.

Phys. Rev. A **65**, 042722 (2002)

$\text{Mg} + \text{Mg}$	Elastic Scattering		Th
$\text{Mg} + \text{Mg}$	Interaction Potentials		Th

907. H. Suno, B. D. Esry, C. H. Greene, Jr. Burke, J. P.

Three-body recombination of cold helium atoms.

Phys. Rev. A **65**, 042725 (2002)

$\text{He} + \text{He} + \text{He}$	Interaction Potentials	0.00-10.00 mK	Th
$\text{He} + \text{He} + \text{He}$	Association	0.00-10.00 mK	Th

908. T. Kirchner, L. Gulyas, R. Moshhammer, M. Schulz, J. Ullrich

Doubly differential electron-emission spectra in single and multiple ionization of noble-gas atoms by fast highly-charged-ion impact.

Phys. Rev. A **65**, 042727 (2002)

$\text{Au}^{53+} + \text{Ne}$	Total Scattering	3.60 MeV/amu	Ex
$\text{Au}^{53+} + \text{Ar}$	Total Scattering	3.60 MeV/amu	Ex
$\text{Au}^{53+} + \text{Ne}$	Ionization	3.60 MeV/amu	Ex
$\text{Au}^{53+} + \text{Ar}$	Ionization	3.60 MeV/amu	Ex

909. M. Sataka, M. Imai, K. Kawatsura, K. Komaki, H. Tawara, A. Visilyev, U. I. Safronova
Comprehensive theoretical and experimental analysis of Coster-Kronig electron spectra from 64-MeV S^{12+} ions excited through He gas and C-foil targets.
 Phys. Rev. A **65**, 052704 (2002)
- | | | | |
|----------------|------------|-----------|-----|
| $S^{12+} + He$ | Ionization | 64.00 MeV | E/T |
| $S^{12+} + C$ | Ionization | 64.00 MeV | E/T |
| $S^{12+} + He$ | Excitation | 64.00 MeV | E/T |
| $S^{12+} + C$ | Excitation | 64.00 MeV | E/T |
910. A. Volpi, J. L. Bohn
Magnetic-field effects in ultracold molecular collisions.
 Phys. Rev. A **65**, 052712 (2002)
- | | | | |
|------------|--------------------|-------------|----|
| $He + O_2$ | Excitation | 0.00-5.00 K | Th |
| $He + O_2$ | Elastic Scattering | 0.00-5.00 K | Th |
911. L. Sarkadi, L. Gulyas, L. Lugosi
Postcollision interaction and two-center effects in ionizing collisions.
 Phys. Rev. A **65**, 052715 (2002)
- | | | | |
|-----------------|------------|-----------|-----|
| $H_2^{1+} + He$ | Ionization | 75.00 keV | E/T |
|-----------------|------------|-----------|-----|
912. J. Eichler, A. Ichihara
Polarization of photons emitted in radiative electron capture by bare high-Z ions.
 Phys. Rev. A **65**, 052716 (2002)
- | | | | |
|----------------|-----------------|-------------------|----|
| $Ar^{18+} + C$ | Charge Transfer | 0.00-1.00 GeV/amu | Th |
| $Kr^{36+} + C$ | Charge Transfer | 0.00-1.00 GeV/amu | Th |
| $Xe^{54+} + C$ | Charge Transfer | 0.00-1.00 GeV/amu | Th |
| $Dy^{66+} + C$ | Charge Transfer | 0.00-1.00 GeV/amu | Th |
| $Au^{79+} + C$ | Charge Transfer | 0.00-1.00 GeV/amu | Th |
| $Pb^{82+} + C$ | Charge Transfer | 0.00-1.00 GeV/amu | Th |
| $U^{92+} + C$ | Charge Transfer | 0.00-1.00 GeV/amu | Th |
913. L. Gulyas, P. D. Fainstein, T. Shirai
Extended description for electron capture in ion-atom collisions: Application of model potentials within the framework of the continuum-distorted-wave theory.
 Phys. Rev. A **65**, 052720 (2002)
- | | | | |
|----------------|-----------------|-------------------|-----|
| $H^{1+} + He$ | Charge Transfer | 0.05-1.00 MeV/amu | E/T |
| $He^{2+} + He$ | Charge Transfer | 0.05-1.00 MeV/amu | E/T |
| $Li^{2+} + He$ | Charge Transfer | 0.05-1.00 MeV/amu | E/T |
| $Li^{3+} + He$ | Charge Transfer | 0.05-1.00 MeV/amu | E/T |
| $Be^{2+} + He$ | Charge Transfer | 0.05-1.00 MeV/amu | E/T |
| $B^{2+} + He$ | Charge Transfer | 0.05-1.00 MeV/amu | E/T |
| $C^{2+} + He$ | Charge Transfer | 0.05-1.00 MeV/amu | E/T |
| $O^{2+} + He$ | Charge Transfer | 0.05-1.00 MeV/amu | E/T |
| $Mg^{2+} + He$ | Charge Transfer | 0.05-1.00 MeV/amu | E/T |
| $Si^{2+} + He$ | Charge Transfer | 0.05-1.00 MeV/amu | E/T |
914. D. R. Schultz, C. O. Reinhold, P. S. Krstic, M. R. Strayer
Ejected-electron spectrum in low-energy proton-hydrogen collisions.
 Phys. Rev. A **65**, 052722 (2002)
- | | | | |
|--------------|------------|----------------|----|
| $H^{1+} + H$ | Ionization | 1.00-25.00 keV | Th |
|--------------|------------|----------------|----|
915. F. B. Yousif, J. I. Dominguez
Dissociative excitation and fragmentation cross section of HeH^+ molecular ions in collision with He.
 Phys. Rev. A **65**, 052723 (2002)

- | | | | | |
|--|------------------------------|--------------|-----------------|----|
| | HeH¹⁺ + He | Dissociation | 5.00-400.00 keV | Ex |
| | HeH¹⁺ + He | Excitation | 5.00-400.00 keV | Ex |
916. H. Martinez
He²⁺ formation in collisions between He⁺ ions and Ne atoms.
 Phys. Rev. A **65**, 054702 (2002)
- | | | | | |
|--|-----------------------------|------------|----------------|-----|
| | He¹⁺ + Ne | Ionization | 0.00-10.00 MeV | E/T |
|--|-----------------------------|------------|----------------|-----|
917. H. Tawara, P. Richard, U. I. Safronova, P. C. Stancil
Erratum: K x-ray production in H-like Si¹³⁺, S¹⁵⁺, and Ar¹⁷⁺ ions colliding with various atom and molecule gas targets at low collision energies [Phys. Rev. A **64, 042714 (2001)].**
 Phys. Rev. A **65**, 059901 (2002)
- | | | | |
|--|-----------------|---------------------|-----|
| Si¹³⁺ + H₂ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Si¹³⁺ + D₂ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Si¹³⁺ + He | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Si¹³⁺ + CH₄ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Si¹³⁺ + CO | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Si¹³⁺ + CO₂ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Si¹³⁺ + N₂ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Si¹³⁺ + Ne | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Si¹³⁺ + Ar | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Si¹³⁺ + Ar | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| S¹⁵⁺ + H₂ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| S¹⁵⁺ + D₂ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| S¹⁵⁺ + He | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| S¹⁵⁺ + CH₄ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| S¹⁵⁺ + CO | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| S¹⁵⁺ + CO₂ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| S¹⁵⁺ + N₂ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| S¹⁵⁺ + Ne | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| S¹⁵⁺ + Ar | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| S¹⁵⁺ + Ar | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Ar¹⁷⁺ + H₂ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Ar¹⁷⁺ + D₂ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Ar¹⁷⁺ + He | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Ar¹⁷⁺ + CH₄ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Ar¹⁷⁺ + CO | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Ar¹⁷⁺ + CO₂ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Ar¹⁷⁺ + N₂ | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Ar¹⁷⁺ + Ne | Charge Transfer | 1.00-100.00 keV/amu | E/T |
| Ar¹⁷⁺ + Ar | Charge Transfer | 1.00-100.00 keV/amu | E/T |
918. V. Kokoouline, C. Drag, P. Pillet, F. Masnou-Seeuws
Lu-Fano plot for interpretation of the photoassociation spectra.
 Phys. Rev. A **65**, 062710 (2002)
- | | | | | |
|--|----------------|-------------|--|----|
| | Cs + Cs | Association | | Th |
|--|----------------|-------------|--|----|
919. D. Vrinceanu, H. R. Sadeghpour
He(1 ¹S)-He(2 ³S) collision and radiative transition at low temperatures.
 Phys. Rev. A **65**, 062712 (2002)
- | | | | | |
|--|-----------------|------------------------|---------|----|
| | He + He* | Excitation | 0.02 eV | Th |
| | He + He* | Elastic Scattering | 0.02 eV | Th |
| | He + He* | Interaction Potentials | 0.02 eV | Th |
920. E. Y. Kamber, O. Abu-Haija, S. M. Ferguson
Competition between dissociative and nondissociative single-electron capture in He²⁺-O₂ collisions.
 Phys. Rev. A **65**, 062717 (2002)

- | | | | | |
|--|-------------------------------|-----------------|---------------|----|
| | $\text{He}^{2+} + \text{O}_2$ | Charge Transfer | 0.10-1.00 keV | Ex |
| | $\text{He}^{2+} + \text{O}_2$ | Dissociation | 0.10-1.00 keV | Ex |
921. W. R. Anderson, M. P. Robinson, J.D.D. Martin, T. F. Gallagher
Dephasing of resonant energy transfer in a cold Rydberg gas.
 Phys. Rev. A **65**, 063404 (2002)
- | | | | | |
|--|-----------------------------|------------|----------------|----|
| | $\text{Rb}^* + \text{Rb}^*$ | Excitation | 3.00-3.40 V/cm | Ex |
| | $\text{Rb} + \text{Rb}$ | Excitation | 3.00-3.40 V/cm | Ex |
922. D. V. Kupriyanov, I. M. Sokolov, A. V. Slavgorodskii
Polarization-sensitive coherent control of atomic collisions with nonclassical light.
 Phys. Rev. A **65**, 063412 (2002)
- | | | | | |
|--|-------------------------|------------|--|----|
| | $\text{Mg} + \text{Ne}$ | Excitation | | Th |
|--|-------------------------|------------|--|----|
923. E. P. Benis, M. Zamkov, P. Richard, T.J.M. Zouros
Technique for the determination of the $1s2s\ ^3\text{S}$ metastable fraction in two-electron ion beams.
 Phys. Rev. A **65**, 064701 (2002)
- | | | | | |
|--|------------------------------|------------|---------------|----|
| | $\text{B}^{3+} + \text{H}_2$ | Ionization | 4.00-4.50 MeV | Ex |
|--|------------------------------|------------|---------------|----|
924. A. Volpi, J. L. Bohn
Molecular vibration in cold-collision theory.
 Phys. Rev. A **65**, 064702 (2002)
- | | | | | |
|--|--------------------------|--------------------|--------------|----|
| | $\text{He} + \text{O}_2$ | Excitation | 0.00-10.00 K | Th |
| | $\text{He} + \text{O}_2$ | Elastic Scattering | 0.00-10.00 K | Th |
925. A. Bordenave-Montesquieu, P. Moretto-Capelle, D. Bordenave-Montesquieu
Comment on "experimental study of single- and double-electron transfer in slow $\text{Ne}^{8+} + \text{He}$ collisions using photon and electron spectroscopy."
 Phys. Rev. A **65**, 066701 (2002)
- | | | | | |
|--|------------------------------|-----------------|-----------|----|
| | $\text{Ne}^{8+} + \text{He}$ | Charge Transfer | 80.00 keV | Ex |
|--|------------------------------|-----------------|-----------|----|
926. R. C. Forrey, R. Cote, A. Dalgarno, S. Jonsell, A. Saenz, P. Froelich
Collisions between metastable hydrogen atoms at thermal energies.
 Phys. Rev. Lett. **85**, 4245 (2000)
- | | | | | |
|--|---------------------------|--------------------|--|----|
| | $\text{H} + \text{H}$ | Energy Transfer | | Th |
| | $\text{H} + \text{H}$ | Fluorescence | | Th |
| | $\text{H}^* + \text{H}^*$ | Elastic Scattering | | Th |
| | $\text{H}^* + \text{H}^*$ | Energy Transfer | | Th |
| | $\text{H}^* + \text{H}^*$ | Fluorescence | | Th |
| | $\text{H} + \text{H}$ | Elastic Scattering | | Th |
927. P. Beiersdorfer, R. E. Olson, G. V. Brown, H. Chen, C. L. Harris, P. A. Neill, L. Schweikhard, S. B. Utter, K. Widmann
X-ray emission following low-energy charge exchange collisions of highly charged ions.
 Phys. Rev. Lett. **85**, 5090 (2000)
- | | | | | |
|--|------------------------------------|--------------|-------------------|-----|
| | $\text{Ar}^{17+} + \text{H}$ | Fluorescence | 0.80-11.00 eV/amu | E/T |
| | $\text{Ar}^{17+} + \text{Ar}$ | Fluorescence | 0.80-11.00 eV/amu | E/T |
| | $\text{Ar}^{17+} + \text{Ar Seq.}$ | Fluorescence | 0.80-11.00 eV/amu | E/T |
928. F. Gobet, B. Farizon, M. Farison, M. J. Gaillard, M. Carre, M. Lezius, P. Scheier, T. D. Maerk
Total, partial, and electron-capture cross sections for ionization of water vapor by 20-150 keV protons.
 Phys. Rev. Lett. **86**, 3751 (2001)
- | | | | | |
|--|--------------------------------------|--------------|-----------------|----|
| | $\text{H}^{1+} + \text{H}_2\text{O}$ | Dissociation | 20.00-50.00 keV | Ex |
| | $\text{H}^{1+} + \text{H}_2\text{O}$ | Ionization | 20.00-50.00 keV | Ex |

929. B. R. Strazisar, C. Lin, H. F. Davis
Vibrationally inelastic scattering of high-n Rydberg H atoms from N₂ and O₂.
 Phys. Rev. Lett. **86**, 3997 (2001)
- | | | | |
|---------------------------|---------------|---------|----|
| $\text{H} + \text{N}_2$ | De-excitation | 1.84 eV | Ex |
| $\text{H} + \text{O}_2$ | De-excitation | 1.84 eV | Ex |
| $\text{H} + \text{N}_2$ | Excitation | 1.84 eV | Ex |
| $\text{H} + \text{O}_2$ | Excitation | 1.84 eV | Ex |
| $\text{H}^* + \text{N}_2$ | De-excitation | 1.84 eV | Ex |
| $\text{H}^* + \text{O}_2$ | De-excitation | 1.84 eV | Ex |
| $\text{H}^* + \text{N}_2$ | Excitation | 1.84 eV | Ex |
| $\text{H}^* + \text{O}_2$ | Excitation | 1.84 eV | Ex |
930. E. Wells, K. D. Carnes, B. D. Esry, I. Ben-Itzhak
Charge transfer and elastic scattering in very slow $\text{H}^+ + \text{D}(1s)$ half collisions.
 Phys. Rev. Lett. **86**, 4803 (2001)
- | | | | |
|----------------------------|--------------------|--------------|----|
| $\text{H}^{1+} + \text{H}$ | Elastic Scattering | 0.01-1.00 eV | Ex |
| $\text{H}^{1+} + \text{H}$ | Charge Transfer | 0.01-1.00 eV | Ex |
| $\text{H}^{1+} + \text{D}$ | Elastic Scattering | 0.01-1.00 eV | Ex |
| $\text{H}^{1+} + \text{D}$ | Charge Transfer | 0.01-1.00 eV | Ex |
931. N. Stolterfoht, B. Sulik, V. Hoffmann, B. Skogvall, J. Y. Chesnel, J. Rangama, F. Fremont, D. Hennecart, A. Cassimi, X. Husson, A. L. Landers, J. A. Tanis, M. E. Galassi, R. D. Rivarola
Evidence for interference effects in electron emission from H_2 colliding with 60 MeV/u Kr^{34+} ions.
 Phys. Rev. Lett. **87**, 023201 (2001)
- | | | | |
|--------------------------------|------------|---------------|----|
| $\text{Kr}^{34+} + \text{H}_2$ | Ionization | 60.00 meV/amu | Ex |
|--------------------------------|------------|---------------|----|
932. D.S.F Crothers, D. M. McSherry, S.F.C. O'Rourke, M. B. Shah, C. McGrath, H. B. Gilbody
Magnetically quantized continuum distorted waves.
 Phys. Rev. Lett. **88**, 053201 (2002)
- | | | | |
|------------------------------|------------|------------------|-----|
| $\text{H}^{1+} + \text{H}$ | Ionization | 50.00-100.00 keV | E/T |
| $\text{H}^{1+} + \text{H}_2$ | Ionization | 50.00-100.00 keV | E/T |
933. B. Sulik, C. Koncz, K. Tokesi, A. Orban, D. Berenyi
Evidence for Fermi-shuttle ionization in intermediate velocity $\text{C}^+ + \text{Xe}$ collisions.
 Phys. Rev. Lett. **88**, 073201 (2002)
- | | | | |
|-----------------------------|------------|-----------------------|----|
| $\text{C}^{1+} + \text{Xe}$ | Ionization | 150.00-233.00 keV/amu | Ex |
|-----------------------------|------------|-----------------------|----|
934. R. S. Tantawi
Coupled-channel calculations of direct excitation in $\text{p}\bar{\nu} + \text{H}(2s)$ collisions.
 Phys. Scr. **64**, 474 (2001)
- | | | | |
|------------------------------|------------|----------------|----|
| $\text{H}^{1+} + \text{H}$ | Excitation | 0.00-10.00 keV | Th |
| $\text{H}^{1+} + \text{H}^*$ | Excitation | 0.00-10.00 keV | Th |
935. P. N. Abufager, H. F. Busnengo, A. E. Martinez, R. D. Rivarola
Electron capture from excited states of hydrogen by impact of bare ions.
 Phys. Scr. **66**, 38 (2002)
- | | | | |
|-----------------------------|-----------------|---------------|----|
| $\text{H}^{1+} + \text{H}$ | Charge Transfer | 0.00-2.50 MeV | Th |
| $\text{He}^{2+} + \text{H}$ | Charge Transfer | 0.00-2.50 MeV | Th |
936. C. R. Feeler, C. J. Wood, R. E. Olson
Fragmentation of H_2 and HD molecules by C^{6+} impact.
 Phys. Scr. **T80**, 106 (1999)
- | | | | |
|------------------------------|-----------------|-------------------|----|
| $\text{C}^{6+} + \text{H}_2$ | Dissociation | 0.00-1.00 MeV/amu | Th |
| $\text{C}^{6+} + \text{HD}$ | Dissociation | 0.00-1.00 MeV/amu | Th |
| $\text{C}^{6+} + \text{H}_2$ | Charge Transfer | 0.00-1.00 MeV/amu | Th |
| $\text{C}^{6+} + \text{HD}$ | Charge Transfer | 0.00-1.00 MeV/amu | Th |

937. H. Shiromaru, T. Nishide, T. Kitamura, J. H. Sanderson, Y. Achiba, N. Kobayashi
Dissociation scheme of highly charged triatomic molecules.
 Phys. Scr. **T80**, 110 (1999)
- | | | | |
|---------------------------------------|-----------------|------------|----|
| $\text{Ar}^{8+} + \text{CO}_2$ | Dissociation | 120.00 keV | Ex |
| $\text{Ar}^{8+} + \text{N}_2\text{O}$ | Dissociation | 120.00 keV | Ex |
| $\text{Ar}^{8+} + \text{CO}_2$ | Ionization | 120.00 keV | Ex |
| $\text{Ar}^{8+} + \text{N}_2\text{O}$ | Ionization | 120.00 keV | Ex |
| $\text{Ar}^{8+} + \text{CO}_2$ | Charge Transfer | 120.00 keV | Ex |
| $\text{Ar}^{8+} + \text{N}_2\text{O}$ | Charge Transfer | 120.00 keV | Ex |
938. R. W. McCullough
State selective electron capture studies with slow state prepared ion beams.
 Phys. Scr. **T80**, 114 (1999)
- | | | | |
|------------------------------|-----------------|----------|----|
| $\text{C}^{2+} + \text{H}_2$ | Charge Transfer | 4.00 keV | Ex |
| $\text{C}^{2+} + \text{He}$ | Charge Transfer | 4.00 keV | Ex |
| $\text{N}^{2+} + \text{H}_2$ | Charge Transfer | 4.00 keV | Ex |
| $\text{N}^{2+} + \text{He}$ | Charge Transfer | 4.00 keV | Ex |
| $\text{O}^{2+} + \text{H}_2$ | Charge Transfer | 4.00 keV | Ex |
| $\text{O}^{2+} + \text{He}$ | Charge Transfer | 4.00 keV | Ex |
939. P. Moretto-Capelle, D. Bordenave-Montesquieu, A. Bordenave-Montesquieu
Multiple capture investigated by coincident electron spectroscopy in $\text{X}^{7+} + \text{Ar}$, at 70 keV.
 Phys. Scr. **T80**, 118 (1999)
- | | | | |
|-----------------------------|-----------------|-----------|----|
| $\text{N}^{7+} + \text{Ar}$ | Charge Transfer | 70.00 keV | Ex |
| $\text{F}^{7+} + \text{Ar}$ | Charge Transfer | 70.00 keV | Ex |
940. P. Beiersdorfer, L. Schweikhard, R. Olson, G. V. Brown, S. B. Utter, J. R. Crespo Lopez-Urrutia, K. Widmann
X-ray measurements of charge transfer reactions involving cold, very highly charged ions.
 Phys. Scr. **T80**, 121 (1999)
- | | | | |
|------------------------------|-----------------|-----------------|-----|
| $\text{Xe}^{54+} + \text{H}$ | Excitation | 0.00-100.00 keV | E/T |
| $\text{Xe}^{54+} + \text{H}$ | Charge Transfer | 0.00-100.00 keV | E/T |
941. A. E. Martinez, R. D. Rivarola, R. Gayet, J. Hanssen
Double electron capture theories: second order contributions.
 Phys. Scr. **T80**, 124 (1999)
- | | | | |
|------------------------------|-----------------|----------------|----|
| $\text{He}^{2+} + \text{He}$ | Charge Transfer | 0.10-10.00 MeV | Th |
|------------------------------|-----------------|----------------|----|
942. U. Brinkmann, A. Reinkoester, B. Siegmann, U. Werner, H. O. Lutz, R. Mann
Ion-impact induced multiple ionization and fragmentation of N_2 .
 Phys. Scr. **T80**, 171 (1999)
- | | | | |
|--------------------------------|--------------|---------------|----|
| $\text{H}^{1+} + \text{N}_2$ | Dissociation | 0.06-7.00 MeV | Ex |
| $\text{He}^{1+} + \text{N}_2$ | Dissociation | 0.06-7.00 MeV | Ex |
| $\text{Bi}^{25+} + \text{N}_2$ | Dissociation | 0.06-7.00 MeV | Ex |
| $\text{Bi}^{57+} + \text{N}_2$ | Dissociation | 0.06-7.00 MeV | Ex |
| $\text{H}^{1+} + \text{N}_2$ | Ionization | 0.06-7.00 MeV | Ex |
| $\text{He}^{1+} + \text{N}_2$ | Ionization | 0.06-7.00 MeV | Ex |
| $\text{Bi}^{25+} + \text{N}_2$ | Ionization | 0.06-7.00 MeV | Ex |
| $\text{Bi}^{57+} + \text{N}_2$ | Ionization | 0.06-7.00 MeV | Ex |
943. K. Okuno, T. Kaneyasu, K. Ishii, M. Yoshino, N. Kobayashi
Double electron capture processes in collisions of $^3\text{He}^{2+}$ with N_2 , O_2 and CO at 1 keV/amu.
 Phys. Scr. **T80**, 173 (1999)
- | | | | |
|-------------------------------|-----------------|--------------|----|
| $\text{He}^{2+} + \text{CO}$ | Charge Transfer | 1.00 keV/amu | Ex |
| $\text{He}^{2+} + \text{N}_2$ | Charge Transfer | 1.00 keV/amu | Ex |
| $\text{He}^{2+} + \text{O}_2$ | Charge Transfer | 1.00 keV/amu | Ex |

944. K. Ishii, K. Okuno, N. Kobayashi
Single- and multiple-charge changing cross sections in slow collisions of Kr^{q+} ($q=7-9$) with Ne, N_2 , O_2 and CO.
 Phys. Scr. **T80**, 176 (1999)
- | | | | |
|-------------------------------|-----------------|------------------|----|
| $\text{He}^{2+} + \text{CO}$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{He}^{2+} + \text{N}_2$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{He}^{2+} + \text{O}_2$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{He}^{2+} + \text{Ne}$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{Kr}^{7+} + \text{CO}$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{Kr}^{7+} + \text{N}_2$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{Kr}^{7+} + \text{O}_2$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{Kr}^{7+} + \text{Ne}$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{Kr}^{8+} + \text{CO}$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{Kr}^{8+} + \text{N}_2$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{Kr}^{8+} + \text{O}_2$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{Kr}^{8+} + \text{Ne}$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{Kr}^{9+} + \text{CO}$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{Kr}^{9+} + \text{N}_2$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{Kr}^{9+} + \text{O}_2$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
| $\text{Kr}^{9+} + \text{Ne}$ | Charge Transfer | 0.30-1.30 eV/amu | Ex |
945. C. Caraby, M. Tarisien, A. Cassimi, L. Adoul, J. P. Grandin, D. Lelievre, A. Dubois
Fast ion-induced CO molecule fragmentation.
 Phys. Scr. **T80**, 179 (1999)
- | | | | |
|-------------------------------|--------------|--------------|----|
| $\text{Xe}^{44+} + \text{CO}$ | Ionization | 6.70 MeV/amu | Ex |
| $\text{Xe}^{44+} + \text{CO}$ | Dissociation | 6.70 MeV/amu | Ex |
946. M. Tarisien, L. Adoui, F. Fremont, A. Cassimi
RIMS for electron capture and molecular fragmentation study: He^{2+} (11 keV/u) and O^{7+} (4 keV/u) + CO collisions.
 Phys. Scr. **T80**, 182 (1999)
- | | | | |
|------------------------------|-----------------|--------------------|----|
| $\text{He}^{2+} + \text{CO}$ | Charge Transfer | 4.00-11.00 keV/amu | Ex |
| $\text{O}^{7+} + \text{CO}$ | Charge Transfer | 4.00-11.00 keV/amu | Ex |
| $\text{He}^{2+} + \text{CO}$ | Dissociation | 4.00-11.00 keV/amu | Ex |
| $\text{O}^{7+} + \text{CO}$ | Dissociation | 4.00-11.00 keV/amu | Ex |
947. L. F. Errea, J. D. Gorfinkiel, A. Macias, L. Mendez, A. Riera
Charge transfer and dissociation in $\text{C}^{q+} + \text{H}_2$ collisions.
 Phys. Scr. **T80**, 185 (1999)
- | | | | |
|------------------------------|-----------------|-------------------|----|
| $\text{C}^{2+} + \text{H}_2$ | Charge Transfer | 0.05-2.50 keV/amu | Th |
| $\text{C}^{3+} + \text{H}_2$ | Charge Transfer | 0.05-2.50 keV/amu | Th |
| $\text{C}^{4+} + \text{H}_2$ | Charge Transfer | 0.05-2.50 keV/amu | Th |
948. D. Elizaga, L. F. Errea, A. Macias, L. Mendez, A. Riera, A. Rojas
Simplified strategies to study complex ion - H_2 collisions.
 Phys. Scr. **T80**, 187 (1999)
- | | | | |
|-------------------------------|-----------------|--|----|
| $\text{Li}^{1+} + \text{H}_2$ | Charge Transfer | | Th |
| $\text{N}^{5+} + \text{H}_2$ | Charge Transfer | | Th |
949. A. Ichimura, T. Ohyama-Yamaguchi
Three-center coulombic over-barrier model for multiple electron capture by slow highly charged ions from diatomic molecules.
 Phys. Scr. **T80**, 190 (1999)
- | | | | |
|--------------------------------|-----------------|--|----|
| $\text{Ar}^{6+} + \text{N}_2$ | Charge Transfer | | Th |
| $\text{Ar}^{7+} + \text{N}_2$ | Charge Transfer | | Th |
| $\text{Ar}^{8+} + \text{N}_2$ | Charge Transfer | | Th |
| $\text{Ar}^{9+} + \text{N}_2$ | Charge Transfer | | Th |
| $\text{Ar}^{10+} + \text{N}_2$ | Charge Transfer | | Th |

950. K. von Diemar, F. Melchert, A. Pfeiffer, K. R. Bajajova, K. Huber, E. Salzborn, L. Opradolce, R. D. Piacentini
Electron capture in collisions between multiply charged ions.
 Phys. Scr. **T80**, 262 (1999)

$\text{He}^{2+} + \text{N}^{4+}$	Charge Transfer	8.00-200.00 keV	Ex
$\text{He}^{2+} + \text{O}^{5+}$	Charge Transfer	8.00-200.00 keV	Ex
951. H. Tawara, T. Tonuma, H. Kumagai, T. Imai, D. B. Uskov, L. P. Presnyakov
Experimental investigations of single-electron detachment processes from H^- ions colliding with MeV/u, highly charged ions.
 Phys. Scr. **T80**, 264 (1999)

$\text{Ar}^{14+} + \text{H}^{-1+}$	Detachment	1.00-2.00 MeV/amu	Ex
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952. A. B. Voitkiv, N. Gruen, W. Scheid
An analytical cross section for H^- neutralization in collisions with fast highly charged projectiles.
 Phys. Scr. **T80**, 267 (1999)

$\text{Ne}^{1+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Ne}^{2+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Ne}^{3+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Ne}^{4+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Ar}^{1+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Ar}^{2+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Ar}^{3+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Ar}^{4+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Ar}^{5+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Ar}^{6+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Ar}^{7+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Ar}^{8+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Xe}^{1+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Xe}^{2+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Xe}^{3+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Xe}^{4+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Xe}^{5+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Xe}^{6+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Xe}^{7+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
$\text{Xe}^{8+} + \text{H}^{-1+}$	Detachment	200.00 keV	Th
953. T. Kirchner, M. Keim, A. Achenbach, H. J. Luedde, O. J. Kroneisen, R. M. Dreizler
Basis generator method study of collisions between alpha particles and lithium-like ions.
 Phys. Scr. **T80**, 270 (1999)

$\text{C}^{3+} + \text{He}^{2+}$	Ionization	1.00-100.00 keV	Th
$\text{N}^{4+} + \text{He}^{2+}$	Ionization	1.00-100.00 keV	Th
$\text{C}^{3+} + \text{He}^{2+}$	Charge Transfer	1.00-100.00 keV	Th
$\text{N}^{4+} + \text{He}^{2+}$	Charge Transfer	1.00-100.00 keV	Th
$\text{C}^{3+} + \text{He}^{2+}$	Excitation	1.00-100.00 keV	Th
$\text{N}^{4+} + \text{He}^{2+}$	Excitation	1.00-100.00 keV	Th
954. C.-Z. Dong, J.-G. Wang, Y.-Z. Qu, J.-M. Li
Dielectronic recombination and resonant transfer excitation for Ca^{19+} ions.
 Phys. Scr. **T80**, 301 (1999)

$\text{Ca}^{19+} + \text{H}_2$	Excitation	100.00-400.00 MeV	Th
$\text{Ca}^{19+} + \text{H}_2$	Charge Transfer	100.00-400.00 MeV	Th
955. S. Hagmann, I. Ali
Momentum profiles for single- and many-electron continua in strongly perturbing collisions of heavy ions with He, Ne and Ar.
 Phys. Scr. **T80**, 329 (1999)

- | | | | |
|-------------------------|------------|-------------------|----|
| $\mathbf{F^{9+} + He}$ | Ionization | 0.35-1.50 MeV/amu | Ex |
| $\mathbf{F^{9+} + Ne}$ | Ionization | 0.35-1.50 MeV/amu | Ex |
| $\mathbf{F^{9+} + Ar}$ | Ionization | 0.35-1.50 MeV/amu | Ex |
| $\mathbf{I^{23+} + He}$ | Ionization | 0.35-1.50 MeV/amu | Ex |
| $\mathbf{I^{23+} + Ne}$ | Ionization | 0.35-1.50 MeV/amu | Ex |
| $\mathbf{I^{23+} + Ar}$ | Ionization | 0.35-1.50 MeV/amu | Ex |
956. L. C. Tribedi, P. Richard, L. Gulyas, M. E. Rudd
Low energy electron emission in a pure three body collision: $\mathbf{C^{6+} + H}$.
 Phys. Scr. **T80**, 333 (1999)

$\mathbf{C^{6+} + H}$	Ionization	2.50 MeV/amu	Ex
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957. W. Schmitt, R. Moshhammer, H. Kollmus, S. Hagmann, R. Mann, R. E. Olson, S.F.C. O'Rourke, J. Ullrich
Ultra-low energy electrons from fast heavy-ion helium collisions: The target-cusp?
 Phys. Scr. **T80**, 335 (1999)

$\mathbf{Au^{53+} + He}$	Ionization	3.60 MeV/amu	Ex
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958. B. Sulik, A. Kover, S. Ricz, C. Koncz, K. Toekesi, Gy. Viktor, J.-Y. Chesnel, N. Stolterfoht, D. Berenyi
Projectile and target contributions to the continuous electron spectra from 150 keV/u $\mathbf{C^+}$ + He, Ne collisions: Multiple ionization and multiple scattering.
 Phys. Scr. **T80**, 338 (1999)

$\mathbf{C^{1+} + He}$	Ionization	150.00 keV/amu	Ex
$\mathbf{C^{1+} + Ne}$	Ionization	150.00 keV/amu	Ex
959. U. Ramm, U. Bechthold, O. Jagutzki, M. Damrau, S. Hagmann, G. Kraft, H. D. Boettcher, H. Schmidt-Boecking
Energy dependence of binary encounter electron emission in collisions of screened heavy $\mathbf{Bi^{26+}}$ ions with He gas targets.
 Phys. Scr. **T80**, 341 (1999)

$\mathbf{Bi^{26+} + He}$	Ionization	1.40-3.60 MeV/amu	Ex
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960. C. A. Ramirez, V. D. Rodriguez, R. D. Rivarola
Double excitation of helium atoms by impact of protons and highly charged ions.
 Phys. Scr. **T80**, 344 (1999)

$\mathbf{H^{1+} + He}$	Excitation	1.50-6.00 MeV/amu	Th
$\mathbf{C^{4+} + He}$	Excitation	1.50-6.00 MeV/amu	Th
$\mathbf{C^{5+} + He}$	Excitation	1.50-6.00 MeV/amu	Th
$\mathbf{C^{6+} + He}$	Excitation	1.50-6.00 MeV/amu	Th
$\mathbf{F^{7+} + He}$	Excitation	1.50-6.00 MeV/amu	Th
$\mathbf{F^{8+} + He}$	Excitation	1.50-6.00 MeV/amu	Th
$\mathbf{F^{9+} + He}$	Excitation	1.50-6.00 MeV/amu	Th
961. B. Bapat, R. Moshhammer, W. Schmitt, H. Kollmus, R. Mann, R. Doerner, Th. Weber, K. Khayyat, A. Cassimi
Double ionization of helium by fast fully stripped ions.
 Phys. Scr. **T80**, 351 (1999)

$\mathbf{C^{6+} + He}$	Ionization	100.00 MeV/amu	Ex
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962. H. Kollmus, W. Schmitt, R. Moshhammer, R. Mann, A. Cassimi, J. Ullrich
Ionization of helium and neon by fast ion impact.
 Phys. Scr. **T80**, 354 (1999)

$\mathbf{U^{92+} + He}$	Ionization	1.00 GeV/amu	Ex
$\mathbf{U^{92+} + Ne}$	Ionization	1.00 GeV/amu	Ex

963. L. C. Tribedi, P. Richard, C. D. Lin, R. E. Olson, L. Gulyas
Doubly differential recoil-ion longitudinal momentum distributions from electron DDCS measurements in ion-atom ionization.
 Phys. Scr. **T80**, 357 (1999)
 $C^{6+} + He$ Ionization Th
964. E. Y. Kamber, S. M. Ferguson
State-selective single-electron capture in very slow $Ne^{3+,4+}$ - N_2 and O_2 collisions.
 Phys. Scr. **T80**, 359 (1999)
 $Ne^{3+} + N_2$ Charge Transfer 4.75-6.00 keV/amu Ex
 $Ne^{3+} + O_2$ Charge Transfer 4.75-6.00 keV/amu Ex
 $Ne^{4+} + N_2$ Charge Transfer 4.75-6.00 keV/amu Ex
 $Ne^{4+} + O_2$ Charge Transfer 4.75-6.00 keV/amu Ex
965. W. R. Thompson, D. J. Burns, D. Voulot, R. W. McCullough, J. Geddes, H. B. Gilbody
Low energy electron capture studies with state-prepared multiply charged ions.
 Phys. Scr. **T80**, 362 (1999)
 $O^{2+} + He$ Charge Transfer 4.00 keV Ex
 $O^{2+} + Ne$ Charge Transfer 4.00 keV Ex
 $O^{2+} + Ar$ Charge Transfer 4.00 keV Ex
966. P. Boduch, M. Chantepie, G. Cremer, E. Jacquet, H. Kucal, C. Laulhe, D. Leclerc, J. Pascale
Velocity dependence of the emitted light polarisation following single electron capture for the Kr^{8+} -Li(2s) collision system between 0.1 and 3 keV/amu.
 Phys. Scr. **T80**, 364 (1999)
 $Kr^{8+} + Li$ Charge Transfer 0.10-0.30 keV/amu Ex
 $Kr^{8+} + Li$ Excitation 0.10-0.30 keV/amu Ex
967. E. Y. Kamber, M. A. Abdallah, C. L. Cocke, M. Stoeckli
Longitudinal and transverse recoil electron capture processes in 0.5-50 keV/u C^{5+} -He collisions.
 Phys. Scr. **T80**, 367 (1999)
 $C^{5+} + He$ Charge Transfer 0.50-50.00 keV/amu Ex
968. H. Kano, H. Watanabe, H. Tanuma, N. Kobayashi
Polarization spectroscopy of excited states produced by double electron capture in the collisions of O^{6+} ions with neutral gases.
 Phys. Scr. **T80**, 370 (1999)
 $O^{6+} + H_2$ Charge Transfer 60.00-120.00 keV Ex
 $O^{6+} + He$ Charge Transfer 60.00-120.00 keV Ex
 $O^{6+} + N_2$ Charge Transfer 60.00-120.00 keV Ex
 $O^{6+} + O_2$ Charge Transfer 60.00-120.00 keV Ex
 $O^{6+} + Ne$ Charge Transfer 60.00-120.00 keV Ex
 $O^{6+} + Ar$ Charge Transfer 60.00-120.00 keV Ex
 $O^{6+} + Kr$ Charge Transfer 60.00-120.00 keV Ex
 $O^{6+} + Xe$ Charge Transfer 60.00-120.00 keV Ex
 $O^{6+} + H_2$ Excitation 60.00-120.00 keV Ex
 $O^{6+} + He$ Excitation 60.00-120.00 keV Ex
 $O^{6+} + N_2$ Excitation 60.00-120.00 keV Ex
 $O^{6+} + O_2$ Excitation 60.00-120.00 keV Ex
 $O^{6+} + Ne$ Excitation 60.00-120.00 keV Ex
 $O^{6+} + Ar$ Excitation 60.00-120.00 keV Ex
 $O^{6+} + Kr$ Excitation 60.00-120.00 keV Ex
 $O^{6+} + Xe$ Excitation 60.00-120.00 keV Ex

969. X. Ma, H. Liu, Y. Wang, Z. Yang, D. Yu, X. Chen, Z. Shen, X. Cai, Z. Liu
Multiple electron transfer in collisions of highly charged Ar ions in argon atoms.
 Phys. Scr. **T80**, 375 (1999)
- | | | | |
|-------------------------------|-----------------|------------------|----|
| $\text{Ar}^{8+} + \text{Ar}$ | Charge Transfer | 80.00-240.00 keV | Ex |
| $\text{Ar}^{9+} + \text{Ar}$ | Charge Transfer | 80.00-240.00 keV | Ex |
| $\text{Ar}^{10+} + \text{Ar}$ | Charge Transfer | 80.00-240.00 keV | Ex |
| $\text{Ar}^{11+} + \text{Ar}$ | Charge Transfer | 80.00-240.00 keV | Ex |
| $\text{Ar}^{11+} + \text{Ar}$ | Charge Transfer | 80.00-240.00 keV | Ex |
| $\text{Ar}^{12+} + \text{Ar}$ | Charge Transfer | 80.00-240.00 keV | Ex |
970. J. A. Tanis, J.-Y. Chesnel, F. Fremont, D. Hennecart, X. Husson, D. Lecler, A. Cassimi, J.-P. Grandin, B. Skogvall, M. Tscherisch, B. Sulik, J.-H. Bremer, M. Grether, N. Stolterfoht
Excitation of Li by fast (≥ 10 MeV/u) N^{7+} and Ar^{18+} projectile.
 Phys. Scr. **T80**, 381 (1999)
- | | | | |
|-------------------------------|------------|---------------------|----|
| $\text{N}^{7+} + \text{Li}$ | Excitation | 10.00-95.00 MeV/amu | Ex |
| $\text{Ar}^{18+} + \text{Li}$ | Excitation | 10.00-95.00 MeV/amu | Ex |
| $\text{N}^{7+} + \text{Li}$ | Ionization | 10.00-95.00 MeV/amu | Ex |
| $\text{Ar}^{18+} + \text{Li}$ | Ionization | 10.00-95.00 MeV/amu | Ex |
971. A. K. Saha, L. C. Tribedi, K. V. Thulasi Ram, K. G. Prasad, P. N. Tandon
Projectile 1s electron loss in collision systems $\text{F}^{8+} + \text{C}$ and $\text{O}^{7+} + \text{C}$.
 Phys. Scr. **T80**, 384 (1999)
- | | | | |
|----------------------------|------------|-----------------|-----|
| $\text{O}^{7+} + \text{C}$ | Ionization | 24.00-60.00 MeV | E/T |
| $\text{F}^{8+} + \text{C}$ | Ionization | 24.00-60.00 MeV | E/T |
972. I. Piticu, C. Ciortea, A. Enulescu, D. Fluerasu, S. Z. Szilagyi, D. Dumitriu
Non-equilibrium L-shell vacancies in Fe, Co, Ni, and Cu + Au collisions in solid targets.
 Phys. Scr. **T80**, 387 (1999)
- | | | | |
|------------------------------|------------|-------------------|----|
| $\text{Fe}^{1+} + \text{Cu}$ | Ionization | 0.10-1.50 MeV/amu | Ex |
| $\text{Co}^{1+} + \text{Cu}$ | Ionization | 0.10-1.50 MeV/amu | Ex |
| $\text{Ni}^{1+} + \text{Cu}$ | Ionization | 0.10-1.50 MeV/amu | Ex |
| $\text{Cu}^{1+} + \text{Cu}$ | Ionization | 0.10-1.50 MeV/amu | Ex |
973. I. Piticu, C. Ciortea, A. Enulescu, D. Fluerasu, S. Z. Szilagyi, M. Micu, D. Dumitriu
Statistical approach of inner-shell ionization in 0.1-1.625 MeV/u Cu + Bi collisions.
 Phys. Scr. **T80**, 389 (1999)
- | | | | |
|-------------------------|------------|-------------------|----|
| $\text{Cu} + \text{Bi}$ | Ionization | 0.10-1.62 MeV/amu | Ex |
| $\text{Cu} + \text{Bi}$ | Ionization | 0.10-1.62 MeV/amu | Ex |
974. A. K. Saha, L. C. Tribedi, B. B. Dhal, U. Tiwari, P. N. Tandon
Subshell resolved L-K electron transfer and ionization of Yb with Si ion impact.
 Phys. Scr. **T80**, 391 (1999)
- | | | | |
|------------------------------|-----------------|-------------------|----|
| $\text{Si}^{8+} + \text{Yb}$ | Ionization | 2.00-4.50 MeV/amu | Ex |
| $\text{Si}^{8+} + \text{Yb}$ | Charge Transfer | 2.00-4.50 MeV/amu | Ex |
975. U. Tiwari, A. K. Saha, B. B. Dhal, L. C. Tribedi, M. B. Kurup, P. N. Tandon, L. Gulyas
Saturation in the K-shell excitation of 120 MeV Si^{14+} ions in interaction with gas targets.
 Phys. Scr. **T80**, 393 (1999)
- | | | | |
|--------------------------------|------------|------------|----|
| $\text{Si}^{14+} + \text{He}$ | Excitation | 120.00 MeV | Ex |
| $\text{Si}^{14+} + \text{N}_2$ | Excitation | 120.00 MeV | Ex |
| $\text{Si}^{14+} + \text{Ne}$ | Excitation | 120.00 MeV | Ex |
| $\text{Si}^{14+} + \text{Ar}$ | Excitation | 120.00 MeV | Ex |
| $\text{Si}^{14+} + \text{Xe}$ | Excitation | 120.00 MeV | Ex |
976. T. Mukoyama, C.-D. Lin
Saturation effect of projectile excitation in ion-atom collisions.
 Phys. Scr. **T80**, 396 (1999)

$\text{Ca}^{18+} + \text{He}$	Excitation	8.00-40.00 MeV/amu	E/T
$\text{Ca}^{18+} + \text{N}_2$	Excitation	8.00-40.00 MeV/amu	E/T
$\text{Ca}^{18+} + \text{O}_2$	Excitation	8.00-40.00 MeV/amu	E/T
$\text{Ca}^{18+} + \text{Ne}$	Excitation	8.00-40.00 MeV/amu	E/T

977. G. M. Sigaud, W. S. Melo, M. M. Sant'Anna, A.C.F Santos, E. C. Montenegro
Saturation effects in charge-changing collisions with multiply-charged C and O ions.
 Phys. Scr. **T80**, 398 (1999)

$\text{C}^{3+} + \text{perturbation}$	Ionization	3.00 MeV	Th
$\text{O}^{5+} + \text{perturbation}$	Ionization	3.00 MeV	Th

978. H. T. Schmidt, A. Fardi, K. Haghighat, A. Langereis, J. C. Levin, L. Liljeby, I. A. Sellin, S. H. Schwartz,
 H. Cederquist
Radiative and nonradiative collisional deexcitation of metastable hydrogen-like ions.
 Phys. Scr. **T80**, 403 (1999)

$\text{He}^{1+*} + \text{Ar}$	De-excitation	6.60 keV	Ex
$\text{He}^{1+} + \text{Ar}$	De-excitation	6.60 keV	Ex
$\text{He}^{1+*} + \text{Xe}$	De-excitation	6.60 keV	Ex
$\text{He}^{1+} + \text{Xe}$	De-excitation	6.60 keV	Ex

979. K. Toekesi, Y. Awaya, T. Kambara, Y. Kanai, B. Sulik
Double K-shell vacancy production in $\text{N}^{7+} + \text{Ti}$ collisions.
 Phys. Scr. **T80**, 408 (1999)

$\text{N}^{7+} + \text{Ti}$	Ionization	50.00-500.00 MeV	Th
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980. F. D. Colavecchia, G. Gasaneo, C. R. Garibotti
A continuum correlated wave model for ion-atom collisions.
 Phys. Scr. **T80**, 411 (1999)

$\text{H}^{1+} + \text{H}$	Ionization	500.00 keV	Th
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981. T. Kirchner, H. J. Luedde, R. M. Dreizler
Many electron dynamics in collisions between highly charged ions and neon atoms.
 Phys. Scr. **T80**, 416 (1999)

$\text{F}^{9+} + \text{Ne}$	Ionization	1.00 MeV/amu	Th
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982. V. A. Sidorovich
Use of the operator approach in the collisions of highly-charged ions with few-electron atoms.
 Phys. Scr. **T80**, 418 (1999)

$\text{Li}^{3+} + \text{He}$	Excitation	1.50 MeV/amu	Th
$\text{Be}^{4+} + \text{He}$	Excitation	1.50 MeV/amu	Th
$\text{B}^{5+} + \text{He}$	Excitation	1.50 MeV/amu	Th
$\text{C}^{6+} + \text{He}$	Excitation	1.50 MeV/amu	Th
$\text{N}^{7+} + \text{He}$	Excitation	1.50 MeV/amu	Th
$\text{O}^{8+} + \text{He}$	Excitation	1.50 MeV/amu	Th
$\text{F}^{9+} + \text{He}$	Excitation	1.50 MeV/amu	Th

983. C. Illescas, A. Riera
Classical calculations of ionization and capture in $\text{A}^{q+} + \text{H}$, H_2 collisions at intermediate energies.
 Phys. Scr. **T80**, 420 (1999)

$\text{H}^{1+} + \text{H}$	Ionization		Th
$\text{H}^{1+} + \text{H}_2$	Ionization		Th
$\text{He}^{2+} + \text{H}$	Ionization		Th
$\text{He}^{2+} + \text{H}_2$	Ionization		Th
$\text{Li}^{3+} + \text{H}$	Ionization		Th

$\text{Li}^{3+} + \text{H}_2$	Ionization		Th
$\text{C}^{6+} + \text{H}$	Ionization		Th
$\text{C}^{6+} + \text{H}_2$	Ionization		Th
$\text{H}^{1+} + \text{H}$	Charge Transfer		Th
$\text{H}^{1+} + \text{H}_2$	Charge Transfer		Th
$\text{He}^{2+} + \text{H}$	Charge Transfer		Th
$\text{He}^{2+} + \text{H}_2$	Charge Transfer		Th
$\text{Li}^{3+} + \text{H}$	Charge Transfer		Th
$\text{Li}^{3+} + \text{H}_2$	Charge Transfer		Th
$\text{C}^{6+} + \text{H}$	Charge Transfer		Th
$\text{C}^{6+} + \text{H}_2$	Charge Transfer		Th

984. S. E. Corchs, O. A. Fojon, R. D. Rivarola

High-order contributions of the Born series with correct boundary conditions.

Phys. Scr. **T80**, 422 (1999)

$\text{H}^{1+} + \text{H}$	Total Scattering	5.00 MeV	Th
$\text{H}^{1+} + \text{H}$	Charge Transfer	5.00 MeV	Th

985. T. Ludziejewski, T. Stoehlker, H. Beyer, F. Bosch, S. Fritzsche, D. C. Ionescu, C. Kozhuharov, A. Kraemer, D. Liesen, P. H. Mokler, P. Rymuza, Z. Stachura, P. Swiat, A. Warczak

Two-electron processes in relativistic collisions of He-like uranium with gaseous targets.

Phys. Scr. **T80**, 426 (1999)

$\text{U}^{90+} + \text{Ar}$	Charge Transfer	223.00 MeV/amu	Ex
$\text{U}^{90+} + \text{Kr}$	Charge Transfer	223.00 MeV/amu	Ex
$\text{U}^{90+} + \text{Xe}$	Charge Transfer	223.00 MeV/amu	Ex
$\text{U}^{90+} + \text{Ar}$	Excitation	223.00 MeV/amu	Ex
$\text{U}^{90+} + \text{Kr}$	Excitation	223.00 MeV/amu	Ex
$\text{U}^{90+} + \text{Xe}$	Excitation	223.00 MeV/amu	Ex

986. K. Schulze, J. Anton, W.-D. Sepp, B. Fricke

An analysis of the MO x-ray spectra in U^{92+} -Pb collisions.

Phys. Scr. **T80**, 430 (1999)

$\text{U}^{92+} + \text{Pb}$	Fluorescence	3.00-100.00 MeV/amu	Th
$\text{U}^{92+} + \text{Pb}$	Excitation	3.00-100.00 MeV/amu	Th

987. S. Keller, R. M. Dreizler

Signatures of electron-electron interaction in fast highly charged ion-atom collisions.

Phys. Scr. **T80**, 93 (1999)

$\text{C}^{6+} + \text{He}$	Ionization	0.00-1.00 GeV/amu	Th
$\text{Se}^{28+} + \text{He}$	Ionization	0.00-1.00 GeV/amu	Th
$\text{U}^{92+} + \text{He}$	Ionization	0.00-1.00 GeV/amu	Th

988. A. Pfeiffer, F. Melchert, K. V. Diemar, K. Huber, E. Salzborn

State-selective electron capture in ion-ion collisions.

Phys. Scr. **T80**, 95 (1999)

$\text{Ar}^{6+} + \text{He}^{1+}$	Excitation	1.90 keV	Ex
$\text{Ar}^{6+} + \text{He}^{1+}$	Charge Transfer	1.90 keV	Ex

989. A. Cassimi

Recoil ion momentum spectroscopy: a microscope for HCI-atom or molecule collisions.

Phys. Scr. **T80**, 98 (1999)

$\text{He}^{1+} + \text{N}_2$	Ionization	0.05-100.00 GeV/amu	Ex
$\text{C}^{5+} + \text{He}$	Ionization	0.05-100.00 GeV/amu	Ex
$\text{Ne}^{10+} + \text{He}$	Ionization	0.05-100.00 GeV/amu	Ex
$\text{Ni}^{26+} + \text{He}$	Ionization	0.05-100.00 GeV/amu	Ex
$\text{Se}^{28+} + \text{He}$	Ionization	0.05-100.00 GeV/amu	Ex
$\text{Au}^{53+} + \text{He}$	Ionization	0.05-100.00 GeV/amu	Ex

990. J. B. Greenwood, I. D. Williams, S. J. Smith, A. Chutjian
X-ray emission from charge exchange of highly-charged ions in atoms and molecules.
 Phys. Scr. **T92**, 150 (2001)
- | | | | |
|---------------------------------------|-----------------|--|----|
| $\text{C}^{6+} + \text{H}_2\text{O}$ | Charge Transfer | | Th |
| $\text{N}^{4+} + \text{H}_2\text{O}$ | Charge Transfer | | Th |
| $\text{N}^{7+} + \text{H}_2\text{O}$ | Charge Transfer | | Th |
| $\text{O}^{5+} + \text{H}_2\text{O}$ | Charge Transfer | | Th |
| $\text{O}^{7+} + \text{H}_2\text{O}$ | Charge Transfer | | Th |
| $\text{O}^{8+} + \text{H}_2\text{O}$ | Charge Transfer | | Th |
| $\text{Ne}^{9+} + \text{H}_2\text{O}$ | Charge Transfer | | Th |
991. L. F. Errea, A. Macias, L. Mendez, I. Rabadan, A. Riera, A. Rojas
State-to-state vibrational cross sections in H^+ , C^{2+} - H_2 charge transfer reactions.
 Phys. Scr. **T92**, 202 (2001)
- | | | | |
|------------------------------|-----------------|----------------|----|
| $\text{H}^{1+} + \text{H}_2$ | Excitation | 0.20-20.00 keV | Ex |
| $\text{C}^{2+} + \text{H}_2$ | Excitation | 0.20-20.00 keV | Ex |
| $\text{H}^{1+} + \text{H}_2$ | Charge Transfer | 0.20-20.00 keV | Ex |
| $\text{C}^{2+} + \text{H}_2$ | Charge Transfer | 0.20-20.00 keV | Ex |
992. M. Seliger, K. Tokesi, C. O. Reinhold, J. Burgdoerfer, Y. Takabayashi, T. Ito, K. Komaki, T. Azuma, Y. Yamazaki
Relativistic electron transport through carbon foils.
 Phys. Scr. **T92**, 211 (2001)
- | | | | |
|------------------------------|-----------------|----------------|----|
| $\text{Ar}^{17+} + \text{C}$ | Charge Transfer | 390.00 MeV/amu | Th |
|------------------------------|-----------------|----------------|----|
993. U. Werner, B. Siegmann, R. Mann, N. M. Kabachnik, H. O. Lutz
Kinetic energy release distributions in the fragmentation of O_2 molecules induced by fast highly charged ions.
 Phys. Scr. **T92**, 244 (2001)
- | | | | |
|--------------------------------|--------------|--------------|----|
| $\text{Xe}^{18+} + \text{O}_2$ | Ionization | 5.90 MeV/amu | Ex |
| $\text{Xe}^{43+} + \text{O}_2$ | Ionization | 5.90 MeV/amu | Ex |
| $\text{Xe}^{18+} + \text{O}_2$ | Dissociation | 5.90 MeV/amu | Ex |
| $\text{Xe}^{43+} + \text{O}_2$ | Dissociation | 5.90 MeV/amu | Ex |
994. P. N. Abufager, A. E. Martinez, R. D. Rivarola, H. F. Busnengo
Electron capture from $\text{H}(2s)$ and $\text{H}(2p)$ by H^+ and higher charged ions.
 Phys. Scr. **T92**, 259 (2001)
- | | | | |
|-------------------------------|-----------------|------------------|----|
| $\text{H}^{1+} + \text{H}$ | Charge Transfer | 10.00-100.00 keV | Th |
| $\text{H}^{1+} + \text{H}^*$ | Charge Transfer | 10.00-100.00 keV | Th |
| $\text{He}^{2+} + \text{H}$ | Charge Transfer | 10.00-100.00 keV | Th |
| $\text{He}^{2+} + \text{H}^*$ | Charge Transfer | 10.00-100.00 keV | Th |
| $\text{Li}^{3+} + \text{H}$ | Charge Transfer | 10.00-100.00 keV | Th |
| $\text{Li}^{3+} + \text{H}^*$ | Charge Transfer | 10.00-100.00 keV | Th |
995. A. S. Al-Naser, A. L. Landers, D. J. Pole, H. Knutson, J. A. Tanis
Double-K-shell vacancy production in Li-like C^{3+} ions colliding with helium.
 Phys. Scr. **T92**, 265 (2001)
- | | | | |
|-----------------------------|------------|-------------------|----|
| $\text{C}^{3+} + \text{He}$ | Excitation | 0.50-2.00 MeV/amu | Ex |
| $\text{C}^{3+} + \text{He}$ | Ionization | 0.50-2.00 MeV/amu | Ex |
996. G. Toth, P. Zavodszky, C. P. Bhalla, P. Richard, S. Grabbe, H. Aliabadi
Electron elastic scattering resonances in the collision of fast hydrogenic ions with molecular hydrogen.
 Phys. Scr. **T92**, 272 (2001)

$\text{C}^{5+} + \text{H}_2$	Ionization	6.70-21.80 MeV	Ex
$\text{N}^{6+} + \text{H}_2$	Ionization	6.70-21.80 MeV	Ex
$\text{O}^{7+} + \text{H}_2$	Ionization	6.70-21.80 MeV	Ex
$\text{F}^{8+} + \text{H}_2$	Ionization	6.70-21.80 MeV	Ex

997. S. Fritzsche, Th. Stoehlker

High-Z projectile ionization: studies on the validity of first-order perturbation theory.

Phys. Scr. **T92**, 311 (2001)

$\text{Au}^{78+} + \text{C}$	Ionization	0.22-11.00 GeV/amu	Th
$\text{Au}^{78+} + \text{Al}$	Ionization	0.22-11.00 GeV/amu	Th
$\text{Au}^{78+} + \text{Ni}$	Ionization	0.22-11.00 GeV/amu	Th
$\text{Au}^{78+} + \text{Cu}$	Ionization	0.22-11.00 GeV/amu	Th
$\text{Au}^{78+} + \text{Ag}$	Ionization	0.22-11.00 GeV/amu	Th
$\text{Au}^{78+} + \text{Au}$	Ionization	0.22-11.00 GeV/amu	Th

998. K. Ishii, T. Tanabe, R. A. Lomsadze, K. Okuno

Charge-changing cross sections in collisions of C^{q+} ($q=2-5$) with He and H_2 at energies below 750 eV/u.

Phys. Scr. **T92**, 332 (2001)

$\text{C}^{2+} + \text{H}_2$	Charge Transfer	0.00-1.00 MeV/amu	Ex
$\text{C}^{2+} + \text{He}$	Charge Transfer	0.00-1.00 MeV/amu	Ex
$\text{C}^{3+} + \text{H}_2$	Charge Transfer	0.00-1.00 MeV/amu	Ex
$\text{C}^{3+} + \text{He}$	Charge Transfer	0.00-1.00 MeV/amu	Ex
$\text{C}^{4+} + \text{H}_2$	Charge Transfer	0.00-1.00 MeV/amu	Ex
$\text{C}^{4+} + \text{He}$	Charge Transfer	0.00-1.00 MeV/amu	Ex

999. M. Hoshino, M. Kitajima, Y. Kanai, Y. Nakai, H. Tanaka, Y. Yamazaki

Angular resolved energy gain spectroscopy to study double electron-capture processes in very slow C^{4+} -He collisions.

Phys. Scr. **T92**, 339 (2001)

$\text{C}^{4+} + \text{He}$	Charge Transfer	270.00-470.00 eV	Ex
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1000. T. Kaneyasu, K. Matsuda, M. Ehrich, M. Yoshino, K. Okuno

Fragmentation of N_2 and post collision effects in slow electron capture collisions of Kr^{8+} ion below 200 eV/amu.

Phys. Scr. **T92**, 341 (2001)

$\text{Kr}^{8+} + \text{N}_2$	Charge Transfer	5.00-200.00 eV/amu	Ex
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1001. R. Suzuki, A. Watanabe, H. Sato, J. P. Gu, G. Hirsch, R. J. Buenker, M. Kimura, P. C. Stancil

Charge transfer processes in collisions of Si^{4+} ions with He atoms at intermediate energies.

Phys. Scr. **T92**, 345 (2001)

$\text{Si}^{4+} + \text{He}$	Excitation	0.01-10.00 keV/amu	Th
$\text{Si}^{4+} + \text{He}$	Charge Transfer	0.01-10.00 keV/amu	Th

1002. T. Kirchner, L. Gulyas

Differential net- and multiple-ionization cross sections in fast highly-charged ion collisions with atoms.

Phys. Scr. **T92**, 348 (2001)

$\text{Au}^{53+} + \text{Ne}$	Ionization	3.60 MeV/amu	Th
$\text{Au}^{53+} + \text{Ar}$	Ionization	3.60 MeV/amu	Th

1003. A. L. Landers, D. J. Pole, A. L. Erickcek, S. M. Ferguson, J.-Y. Chesnel, B. Sulik, J. A. Tanis

Coherence in two-electron transfer in $\text{F}^{8+} + \text{Ne}$ collisions.

Phys. Scr. **T92**, 354 (2001)

$\text{F}^{8+} + \text{Ne}$	Charge Transfer	0.75-1.10 MeV/amu	Ex
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1004. X. Ma, Th. Stoeckler, F. Bosch, O. Brinzaescu, S. Fritzsche, C. Kozhuharov, P. Mokler, T. Ludziejewski, A. Warczak
Subshell differential cross sections for electron transfer in collisions of U^{90+} ions with gaseous targets.
 Phys. Scr. **T92**, 362 (2001)
- | | | | |
|-----------------|-----------------|----------------|----|
| $U^{90+} + N_2$ | Charge Transfer | 223.00 MeV/amu | Ex |
| $U^{90+} + Ar$ | Charge Transfer | 223.00 MeV/amu | Ex |
| $U^{90+} + Kr$ | Charge Transfer | 223.00 MeV/amu | Ex |
| $U^{90+} + Xe$ | Charge Transfer | 223.00 MeV/amu | Ex |
1005. L. F. Errea, A. Macias, L. Mendez, I. Rabadan, A. Riera
Influence of the metastable ion content in the initial beam in $C^{2+} + H$, H_2 and $O^{2+} + H$ collisions.
 Phys. Scr. **T92**, 365 (2001)
- | | | | |
|----------------|-----------------|----------------|----|
| $C^{2+} + H$ | Charge Transfer | 0.50-20.00 keV | Th |
| $C^{2+} + H_2$ | Charge Transfer | 0.50-20.00 keV | Th |
| $O^{2+} + H$ | Charge Transfer | 0.50-20.00 keV | Th |
| $O^{2+} + H_2$ | Charge Transfer | 0.50-20.00 keV | Th |
1006. L. F. Errea, J. D. Gorfinkiel, C. Harel, H. Jouin, A. Macias, L. Mendez, B. Pons, A. G. Riera, P. Sanz
Novel model potential treatment of charge transfer cross sections in C^{4+} and N^{5+} collisions with H_2 .
 Phys. Scr. **T92**, 373 (2001)
- | | | | |
|----------------|-----------------|--------------------|----|
| $C^{4+} + H_2$ | Charge Transfer | 0.05-60.00 keV/amu | Th |
| $N^{5+} + H_2$ | Charge Transfer | 0.05-60.00 keV/amu | Th |
1007. G. Rieger, E. H. Pinnington, C. Ciubotariu
Cross sections for photon emission following electron capture by C^{2+} , N^{3+} , N^{4+} and O^{3+} ions in collision with $Li(2s)$ atoms.
 Phys. Scr. **T92**, 385 (2001)
- | | | | |
|---------------|-----------------|-----------------|----|
| $C^{2+} + Li$ | Excitation | 18.00-27.00 keV | Ex |
| $N^{3+} + Li$ | Excitation | 18.00-27.00 keV | Ex |
| $N^{4+} + Li$ | Excitation | 18.00-27.00 keV | Ex |
| $O^{3+} + Li$ | Excitation | 18.00-27.00 keV | Ex |
| $C^{2+} + Li$ | Charge Transfer | 18.00-27.00 keV | Ex |
| $N^{3+} + Li$ | Charge Transfer | 18.00-27.00 keV | Ex |
| $N^{4+} + Li$ | Charge Transfer | 18.00-27.00 keV | Ex |
| $O^{3+} + Li$ | Charge Transfer | 18.00-27.00 keV | Ex |
1008. N. Shimakura, N. Suzuki, Y. Sakurai, S. Suzuki, M. Kimura, T. Shirai
Molecular-state treatment of electron capture and excitation in collisions of B^{q+} ($q = 1-5$) ions with He atoms.
 Phys. Scr. **T92**, 410 (2001)
- | | | | |
|---------------|-----------------|--------------------|----|
| $B^{1+} + He$ | Excitation | 0.03-20.00 keV/amu | Th |
| $B^{2+} + He$ | Excitation | 0.03-20.00 keV/amu | Th |
| $B^{3+} + He$ | Excitation | 0.03-20.00 keV/amu | Th |
| $B^{4+} + He$ | Excitation | 0.03-20.00 keV/amu | Th |
| $B^{5+} + He$ | Excitation | 0.03-20.00 keV/amu | Th |
| $B^{1+} + He$ | Charge Transfer | 0.03-20.00 keV/amu | Th |
| $B^{2+} + He$ | Charge Transfer | 0.03-20.00 keV/amu | Th |
| $B^{3+} + He$ | Charge Transfer | 0.03-20.00 keV/amu | Th |
| $B^{4+} + He$ | Charge Transfer | 0.03-20.00 keV/amu | Th |
| $B^{5+} + He$ | Charge Transfer | 0.03-20.00 keV/amu | Th |
1009. G. M. Sigaud, E. C. Montenegro
Electron loss processes in three- and four-electron systems.
 Phys. Scr. **T92**, 420 (2001)

- | | | | | |
|--|------------------------------|------------|----------------|----|
| | $\text{Li}^{1+} + \text{He}$ | Ionization | 1.00-16.00 MeV | Th |
| | $\text{Li}^{2+} + \text{He}$ | Ionization | 1.00-16.00 MeV | Th |
1010. D. Skiera, R. Trassl, K. P. Huber, H. Braeuning, E. Salzborn, M. Keim, A. Achenbach, T. Kirchner, H. J. Luedde, R. M. Dreizler
Charge-changing processes in collisions between Li-like ions and He^{2+} .
 Phys. Scr. **T92**, 423 (2001)
- | | | | | |
|--|----------------------------------|------------|------------------|----|
| | $\text{He}^{2+} + \text{B}^{2+}$ | Ionization | 10.00-256.00 keV | Ex |
| | $\text{He}^{2+} + \text{B}^{2+}$ | Ionization | 10.00-256.00 keV | Ex |
1011. G. Bednarz, A. Warczak, P. Swiat, Th. Stoehlker, H.-J. Beyer, F. Bosch, R. Dunford, S. Hagmann, E. P. Kanter, C. Kozhuharov, A. Kraemer, D. Liesen, T. Ludziejewski, X. Ma, P. H. Mokler, Z. Stachura
Double electron capture in relativistic U^{92+} collisions observed at the ESR gas-jet target.
 Phys. Scr. **T92**, 429 (2001)
- | | | | | |
|--|-------------------------------|-----------------|----------------|----|
| | $\text{U}^{92+} + \text{N}_2$ | Charge Transfer | 286.00 MeV/amu | Ex |
| | $\text{U}^{92+} + \text{Ar}$ | Charge Transfer | 286.00 MeV/amu | Ex |
1012. Th. Stoehlker, X. Ma, T. Ludziejewski, H. F. Beyer, F. Bosch, O. Brinzaescu, R. W. Dunford, J. Eichler, S. Hagmann, A. Ichihara, C. Kozhuharov, A. Kraemer, D. Liesen, P. H. Mokler, A. Ichihara, Z. Stachura, P. Swait, A. Warczek
Radiative electron capture studied for bare, decelerated uranium ions.
 Phys. Scr. **T92**, 432 (2001)
- | | | | | |
|--|-------------------------------|-----------------|----------------------|----|
| | $\text{U}^{92+} + \text{N}_2$ | Charge Transfer | 88.00-310.00 MeV/amu | Ex |
|--|-------------------------------|-----------------|----------------------|----|
1013. N. Suzuki, N. Shimakura, H. Kono
Dynamic study on resonance by using a wave packet propagation method: Electron capture in collision of N^{5+} ions with H atoms.
 Phys. Scr. **T92**, 435 (2001)
- | | | | | |
|--|----------------------------|-----------------|------------------|----|
| | $\text{N}^{5+} + \text{H}$ | Charge Transfer | 0.00-0.05 eV/amu | Th |
|--|----------------------------|-----------------|------------------|----|
1014. S. Suzuki, T. Shirai, N. Shimakura
Charge transfer in collisions of lithium ions with beryllium through oxygen ions at energies below 32 keV/a.m.u.
 Phys. Scr. **T92**, 438 (2001)
- | | | | | |
|--|-----------------------------------|-----------------|--------------------|----|
| | $\text{Li}^{1+} + \text{B}^{5+}$ | Charge Transfer | 0.01-50.00 keV/amu | Th |
| | $\text{Li}^{1+} + \text{C}^{6+}$ | Charge Transfer | 0.01-50.00 keV/amu | Th |
| | $\text{Li}^{1+} + \text{N}^{5+}$ | Charge Transfer | 0.01-50.00 keV/amu | Th |
| | $\text{Li}^{1+} + \text{O}^{6+}$ | Charge Transfer | 0.01-50.00 keV/amu | Th |
| | $\text{Li}^{1+} + \text{O}^{6+}$ | Charge Transfer | 0.01-50.00 keV/amu | Th |
| | $\text{Li}^{2+} + \text{Be}^{1+}$ | Charge Transfer | 0.01-50.00 keV/amu | Th |
| | $\text{Li}^{1+} + \text{B}^{5+}$ | Excitation | 0.01-50.00 keV/amu | Th |
| | $\text{Li}^{1+} + \text{C}^{6+}$ | Excitation | 0.01-50.00 keV/amu | Th |
| | $\text{Li}^{1+} + \text{N}^{5+}$ | Excitation | 0.01-50.00 keV/amu | Th |
| | $\text{Li}^{1+} + \text{O}^{6+}$ | Excitation | 0.01-50.00 keV/amu | Th |
| | $\text{Li}^{2+} + \text{Be}^{1+}$ | Excitation | 0.01-50.00 keV/amu | Th |
1015. A. N. Perumal, R. Moshhammer, W. Schmitt, H. Kollmlus, R. Mann, S. Hagmann, R. E. Olson, J. Ullrich
Double ionization of helium by 3.6 MeV/u Au^{53+} impact.
 Phys. Scr. **T92**, 457 (2001)
- | | | | | |
|--|-------------------------------|------------|---------|----|
| | $\text{Au}^{53+} + \text{He}$ | Ionization | 3.60 eV | Ex |
|--|-------------------------------|------------|---------|----|
1016. R. Schuch, S. Madzunkov, E. Lindroth, D. Fry
X-ray emission by a two-electron process in electron capture with slow highly charged ions.
 Phys. Scr. **T92**, 460 (2001)

- | | | | |
|--------------------------------|-----------------|-------------------|----|
| $\text{Ta}^{35+} + \text{N}_2$ | Charge Transfer | 240.00-400.00 keV | Ex |
| $\text{Ta}^{37+} + \text{N}_2$ | Charge Transfer | 240.00-400.00 keV | Ex |
| $\text{Ta}^{40+} + \text{N}_2$ | Charge Transfer | 240.00-400.00 keV | Ex |
| $\text{Ta}^{44+} + \text{N}_2$ | Charge Transfer | 240.00-400.00 keV | Ex |
| $\text{Ta}^{47+} + \text{N}_2$ | Charge Transfer | 240.00-400.00 keV | Ex |
1017. B. Sulik, K. Toekesi, C. Koncz, A. Koeber, S. Ricz, A. Orban, N. Stolterfoht, J.-Y. Chesnel, D. Berenyi
Multiple scattering of the emitted electrons in intermediate velocity $\text{C}^+ + \text{Ne}$ collisions: Search for Fermi-shuttle acceleration in experiment and CTMC calculations.
 Phys. Scr. **T92**, 463 (2001)
- | | | | |
|-----------------------------|------------|---------------|-----|
| $\text{C}^{1+} + \text{Ne}$ | Ionization | 0.02-2.00 keV | E/T |
| $\text{C}^{1+} + \text{Ne}$ | Ionization | 0.02-2.00 keV | E/T |
1018. P. D. Fainstein, R. Moshhammer, M. Schulz, W. Schmitt, H. Kollmus, R. Mann, S. Hagmann, J. Ullrich
Low-energy electron emission in fast Au^{53+} - atom collisions.
 Phys. Scr. **T92**, 65 (2001)
- | | | | |
|-------------------------------|------------|--------------|----|
| $\text{Au}^{53+} + \text{Ne}$ | Ionization | 3.60 MeV/amu | Ex |
| $\text{Au}^{53+} + \text{Ar}$ | Ionization | 3.60 MeV/amu | Ex |
1019. S. R. Lundeen, D. S. Fisher, C. W. Fehrenbach, B. D. DePaola
Experimental studies of resonant charge transfer from Rydberg states by highly-charged ions.
 Phys. Scr. **T92**, 71 (2001)
- | | | | |
|-------------------------------|-----------------|--|----|
| $\text{C}^{6+} + \text{Rb}$ | Charge Transfer | | Ex |
| $\text{Xe}^{2+} + \text{Rb}$ | Charge Transfer | | Ex |
| $\text{Xe}^{4+} + \text{Rb}$ | Charge Transfer | | Ex |
| $\text{Xe}^{8+} + \text{Rb}$ | Charge Transfer | | Ex |
| $\text{Xe}^{32+} + \text{Rb}$ | Charge Transfer | | Ex |
| $\text{Xe}^{40+} + \text{Rb}$ | Charge Transfer | | Ex |
1020. R. W. McCullough, D. R. Gillen, D. Voulot, D. M. Kearns, H. B. Gilbody
State selective electron capture by state prepared beams of multiply charged ions in atomic hydrogen.
 Phys. Scr. **T92**, 76 (2001)
- | | | | |
|----------------------------|-----------------|---------------|----|
| $\text{C}^{2+} + \text{H}$ | Charge Transfer | 1.50-6.00 keV | Ex |
| $\text{N}^{2+} + \text{H}$ | Charge Transfer | 1.50-6.00 keV | Ex |
| $\text{O}^{2+} + \text{H}$ | Charge Transfer | 1.50-6.00 keV | Ex |
1021. R. D. DuBois, I. Ali, C. L. Cocke, C. R. Feeler, R. E. Olson, J. R. Macdonald
Three-body effects in the fragmentation of D_2 by slow, highly-charged xenon.
 Phys. Scr. **T92**, 96 (2001)
- | | | | |
|--------------------------------|--------------|---------------|-----|
| $\text{H}^{1+} + \text{H}_2$ | Dissociation | 0.03-3.90 MeV | E/T |
| $\text{H}^{1+} + \text{D}_2$ | Dissociation | 0.03-3.90 MeV | E/T |
| $\text{Xe}^{26+} + \text{H}_2$ | Dissociation | 0.03-3.90 MeV | E/T |
| $\text{Xe}^{26+} + \text{D}_2$ | Dissociation | 0.03-3.90 MeV | E/T |
1022. A. Yu. Pigarov
Collisional radiative kinetics of molecular assisted recombination in edge plasmas.
 Phys. Scr. **T96**, 16 (2002)
- | | | | |
|-----------------------------------|-----------------|---------------|----|
| $\text{H}_2^{1+} + \text{H}_2$ | Excitation | 0.10-10.00 eV | Th |
| $\text{H}^{1+} + \text{H}_2$ | Dissociation | 0.10-10.00 eV | Th |
| $\text{H}^{1+} + \text{H}_2^{1+}$ | Dissociation | 0.10-10.00 eV | Th |
| $\text{H}^{1+} + \text{H}_2$ | Excitation | 0.10-10.00 eV | Th |
| $\text{H}^{1+} + \text{H}_2^{1+}$ | Excitation | 0.10-10.00 eV | Th |
| $\text{H}^{1+} + \text{H}_2$ | Charge Transfer | 0.10-10.00 eV | Th |
| $\text{H}^{1+} + \text{H}_2^{1+}$ | Charge Transfer | 0.10-10.00 eV | Th |

1023. R. Celiberto, M. Capitelli, A. Laricchiuta
Towards a cross section database of excited atomic and molecular hydrogen.
 Phys. Scr. **T96**, 32 (2002)
 $\text{H}^{1+} + \text{H}$ Charge Transfer 100.00 eV Th
1024. P. S. Krstic, D. R. Schultz, R. K. Janev
Charge transfer processes in slow collisions of protons with vibrationally excited hydrogen molecules.
 Phys. Scr. **T96**, 61 (2002)
 $\text{H}^{1+} + \text{H}_2$ Interchange reaction 10.00 eV Th
 $\text{H}^{1+} + \text{H}_2$ Dissociation 10.00 eV Th
 $\text{H}^{1+} + \text{H}_2$ Excitation 10.00 eV Th
1025. S. I. Krashenninnikov
Molecule assisted recombination (MAR): Mechanisms and plasma conditions for effective operation.
 Phys. Scr. **T96**, 7 (2002)
 $\text{H}_2^{1+} + \text{H}_2$ Interchange reaction Th
 $\text{H}^{1+} + \text{H}^{-1+}$ Charge Transfer Th
1026. J. G. Wang, P. C. Stancil
Hydrogen ion-molecule isotopomer collisions: Charge transfer and rearrangement.
 Phys. Scr. **T96**, 72 (2002)
 $\text{H}^{1+} + \text{H}_2$ Dissociation 0.00-10.00 keV E/T
 $\text{H}^{1+} + \text{HT}$ Dissociation 0.00-10.00 keV E/T
 $\text{H}^{1+} + \text{D}_2$ Dissociation 0.00-10.00 keV E/T
 $\text{H}^{1+} + \text{DT}$ Dissociation 0.00-10.00 keV E/T
 $\text{H}^{1+} + \text{T}_2$ Dissociation 0.00-10.00 keV E/T
 $\text{H}_2^{1+} + \text{H}$ Dissociation 0.00-10.00 keV E/T
 $\text{H}_2^{1+} + \text{D}$ Dissociation 0.00-10.00 keV E/T
 $\text{HD}^{1+} + \text{H}$ Dissociation 0.00-10.00 keV E/T
 $\text{HD}^{1+} + \text{D}$ Dissociation 0.00-10.00 keV E/T
 $\text{D}^{1+} + \text{H}_2$ Dissociation 0.00-10.00 keV E/T
 $\text{D}^{1+} + \text{HT}$ Dissociation 0.00-10.00 keV E/T
 $\text{D}^{1+} + \text{D}_2$ Dissociation 0.00-10.00 keV E/T
 $\text{D}^{1+} + \text{DT}$ Dissociation 0.00-10.00 keV E/T
 $\text{D}^{1+} + \text{T}_2$ Dissociation 0.00-10.00 keV E/T
 $\text{D}_2^{1+} + \text{H}$ Dissociation 0.00-10.00 keV E/T
 $\text{D}_2^{1+} + \text{D}$ Dissociation 0.00-10.00 keV E/T
 $\text{T}^{1+} + \text{H}_2$ Dissociation 0.00-10.00 keV E/T
 $\text{T}^{1+} + \text{HT}$ Dissociation 0.00-10.00 keV E/T
 $\text{T}^{1+} + \text{D}_2$ Dissociation 0.00-10.00 keV E/T
 $\text{T}^{1+} + \text{DT}$ Dissociation 0.00-10.00 keV E/T
 $\text{T}^{1+} + \text{T}_2$ Dissociation 0.00-10.00 keV E/T
 $\text{H}^{1+} + \text{H}_2$ Interchange reaction 0.00-10.00 keV E/T
 $\text{H}^{1+} + \text{HT}$ Interchange reaction 0.00-10.00 keV E/T
 $\text{H}^{1+} + \text{D}_2$ Interchange reaction 0.00-10.00 keV E/T
 $\text{H}^{1+} + \text{DT}$ Interchange reaction 0.00-10.00 keV E/T
 $\text{H}^{1+} + \text{T}_2$ Interchange reaction 0.00-10.00 keV E/T
 $\text{H}_2^{1+} + \text{H}$ Interchange reaction 0.00-10.00 keV E/T
 $\text{H}_2^{1+} + \text{D}$ Interchange reaction 0.00-10.00 keV E/T
 $\text{HD}^{1+} + \text{H}$ Interchange reaction 0.00-10.00 keV E/T
 $\text{HD}^{1+} + \text{D}$ Interchange reaction 0.00-10.00 keV E/T
 $\text{D}^{1+} + \text{H}_2$ Interchange reaction 0.00-10.00 keV E/T
 $\text{D}^{1+} + \text{HT}$ Interchange reaction 0.00-10.00 keV E/T
 $\text{D}^{1+} + \text{D}_2$ Interchange reaction 0.00-10.00 keV E/T

$D^{1+} + DT$	Interchange reaction	0.00-10.00 keV	E/T
$D^{1+} + T_2$	Interchange reaction	0.00-10.00 keV	E/T
$D_2^{1+} + H$	Interchange reaction	0.00-10.00 keV	E/T
$D_2^{1+} + D$	Interchange reaction	0.00-10.00 keV	E/T
$T^{1+} + H_2$	Interchange reaction	0.00-10.00 keV	E/T
$T^{1+} + HT$	Interchange reaction	0.00-10.00 keV	E/T
$T^{1+} + D_2$	Interchange reaction	0.00-10.00 keV	E/T
$T^{1+} + DT$	Interchange reaction	0.00-10.00 keV	E/T
$T^{1+} + T_2$	Interchange reaction	0.00-10.00 keV	E/T
$H^{1+} + H_2$	Charge Transfer	0.00-10.00 keV	E/T
$H^{1+} + HT$	Charge Transfer	0.00-10.00 keV	E/T
$H^{1+} + D_2$	Charge Transfer	0.00-10.00 keV	E/T
$H^{1+} + DT$	Charge Transfer	0.00-10.00 keV	E/T
$H^{1+} + T_2$	Charge Transfer	0.00-10.00 keV	E/T
$H_2^{1+} + H$	Charge Transfer	0.00-10.00 keV	E/T
$H_2^{1+} + D$	Charge Transfer	0.00-10.00 keV	E/T
$HD^{1+} + H$	Charge Transfer	0.00-10.00 keV	E/T
$HD^{1+} + D$	Charge Transfer	0.00-10.00 keV	E/T
$D^{1+} + H_2$	Charge Transfer	0.00-10.00 keV	E/T
$D^{1+} + HT$	Charge Transfer	0.00-10.00 keV	E/T
$D^{1+} + D_2$	Charge Transfer	0.00-10.00 keV	E/T
$D^{1+} + DT$	Charge Transfer	0.00-10.00 keV	E/T
$D^{1+} + T_2$	Charge Transfer	0.00-10.00 keV	E/T
$D_2^{1+} + H$	Charge Transfer	0.00-10.00 keV	E/T
$D_2^{1+} + D$	Charge Transfer	0.00-10.00 keV	E/T
$T^{1+} + H_2$	Charge Transfer	0.00-10.00 keV	E/T
$T^{1+} + HT$	Charge Transfer	0.00-10.00 keV	E/T
$T^{1+} + D_2$	Charge Transfer	0.00-10.00 keV	E/T
$T^{1+} + DT$	Charge Transfer	0.00-10.00 keV	E/T
$T^{1+} + T_2$	Charge Transfer	0.00-10.00 keV	E/T

1027. F. Brouillard, X. Urbain

Associative ionisation in low energy collisions.

Phys. Scr. **T96**, 86 (2002)

$H + H$	Ionization	0.05-10.00 eV	E/T
$H_2^{1+} + H^{-1+}$	Ionization	0.05-10.00 eV	E/T
$H_2^{1+} + D^{-1+}$	Ionization	0.05-10.00 eV	E/T
$D + D$	Ionization	0.05-10.00 eV	E/T
$D^{1+} + O^{-1+}$	Ionization	0.05-10.00 eV	E/T
$D_2^{1+} + H^{-1+}$	Ionization	0.05-10.00 eV	E/T
$D_2^{1+} + D^{-1+}$	Ionization	0.05-10.00 eV	E/T
$He^{1+} + H^{-1+}$	Ionization	0.05-10.00 eV	E/T
$He^{1+} + D^{-1+}$	Ionization	0.05-10.00 eV	E/T
$C^{1+} + D^{-1+}$	Ionization	0.05-10.00 eV	E/T
$C^{1+} + O^{-1+}$	Ionization	0.05-10.00 eV	E/T
$N^{1+} + O^{-1+}$	Ionization	0.05-10.00 eV	E/T
$O^{1+} + D^{-1+}$	Ionization	0.05-10.00 eV	E/T
$O^{1+} + O^{-1+}$	Ionization	0.05-10.00 eV	E/T
$H + H$	Association	0.05-10.00 eV	E/T
$H_2^{1+} + H^{-1+}$	Association	0.05-10.00 eV	E/T
$H_2^{1+} + D^{-1+}$	Association	0.05-10.00 eV	E/T
$D + D$	Association	0.05-10.00 eV	E/T
$D^{1+} + O^{-1+}$	Association	0.05-10.00 eV	E/T
$D_2^{1+} + H^{-1+}$	Association	0.05-10.00 eV	E/T
$D_2^{1+} + D^{-1+}$	Association	0.05-10.00 eV	E/T
$He^{1+} + H^{-1+}$	Association	0.05-10.00 eV	E/T
$He^{1+} + D^{-1+}$	Association	0.05-10.00 eV	E/T

$\text{C}^{1+} + \text{D}^{-1+}$	Association	0.05-10.00 eV	E/T
$\text{C}^{1+} + \text{O}^{-1+}$	Association	0.05-10.00 eV	E/T
$\text{N}^{1+} + \text{O}^{-1+}$	Association	0.05-10.00 eV	E/T
$\text{O}^{1+} + \text{D}^{-1+}$	Association	0.05-10.00 eV	E/T
$\text{O}^{1+} + \text{O}^{-1+}$	Association	0.05-10.00 eV	E/T

1028. R. K. Janev

Alternative mechanisms for divertor plasma recombination.

Phys. Scr. **T96**, 94 (2002)

$\text{H}^{1+} + \text{CH}_4$	Interchange reaction	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{C}_2\text{H}_4$	Interchange reaction	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{C}_2\text{H}_6$	Interchange reaction	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{C}_3\text{H}_8$	Interchange reaction	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{CH}_4$	Dissociation	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{C}_2\text{H}_4$	Dissociation	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{C}_2\text{H}_6$	Dissociation	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{C}_3\text{H}_8$	Dissociation	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{CH}_4$	Charge Transfer	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{C}_2\text{H}_4$	Charge Transfer	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{C}_2\text{H}_6$	Charge Transfer	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{C}_3\text{H}_8$	Charge Transfer	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{H}^{-1+}$	Excitation	0.10-30.00 eV	Th
$\text{H}^{1+} + \text{H}^{-1+}$	Charge Transfer	0.10-30.00 eV	Th

3.3 Surface Interactions

1029. R. G. Vichev, D. S. Karpuzov

Time-dependent angular and energy distributions of sputtered copper atoms.

Can. J. Phys. **78**, 865 (2000)

$\text{Be}^+ + \text{Cu}$	Sputtering	1.00 keV	Th
$\text{Be}^+ + \text{Cu}$	Sputtering	1.00 keV	Th
$\text{Ne}^+ + \text{Cu}$	Sputtering	1.00 keV	Th
$\text{Ne}^+ + \text{Cu}$	Sputtering	1.00 keV	Th
$\text{Ar}^+ + \text{Cu}$	Sputtering	1.00 keV	Th
$\text{Ar}^+ + \text{Cu}$	Sputtering	1.00 keV	Th
$\text{Cu}^+ + \text{Cu}$	Sputtering	1.00 keV	Th
$\text{Cu}^+ + \text{Cu}$	Sputtering	1.00 keV	Th
$\text{Xe}^+ + \text{Cu}$	Sputtering	1.00 keV	Th
$\text{Xe}^+ + \text{Cu}$	Sputtering	1.00 keV	Th
$\text{Au}^+ + \text{Cu}$	Sputtering	1.00 keV	Th
$\text{Au}^+ + \text{Cu}$	Sputtering	1.00 keV	Th

1030. K. Nobuhara, H. Nakanishi, H. Kasai

Interactions of atomic hydrogen with Cu(111), Pt(111), and Pd(111).

J. Appl. Phys. **88**, 6897 (2000)

$\text{H} + \text{Cu}$	Adsorption, Desorption	Th
$\text{H} + \text{Pd}$	Adsorption, Desorption	Th
$\text{H} + \text{Pt}$	Adsorption, Desorption	Th

1031. W. Yi, S.G. Yu, W. Lee, I. T. Han, T. Jeong, Y. Woo, J. Lee, S. Jin, W. Choi, J. Heo, D. Jeon, J. M. Kim

Secondary electron emission yields from MgO deposited on carbon nanotubes.

J. Appl. Phys. **89**, 4091 (2001)

$\text{e} + \text{MgO}$	Second. Elect. Emission	1.00-1.50 keV	Ex
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1032. P. Ascarelli, E. Cappelli, F. Pinzari, M. S. Rossi, S. Salvatori, P. G. Merli, A. Migliori
Secondary electron emission from diamond: Physical modeling and application to scanning electron microscopy.
 J. Appl. Phys. **89**, 689 (2001)
 e + C Second. Elect. Emission 0.50-15.00 eV E/T
1033. Z. J. Ding, X. D. Tang
Monte Carlo study of secondary electron emission.
 J. Appl. Phys. **89**, 718 (2001)
 e + Be Second. Elect. Emission 0.10-2.00 keV Th
 e + Si Second. Elect. Emission 0.10-2.00 keV Th
 e + K Second. Elect. Emission 0.10-2.00 keV Th
 e + V Second. Elect. Emission 0.10-2.00 keV Th
 e + Fe Second. Elect. Emission 0.10-2.00 keV Th
 e + Ni Second. Elect. Emission 0.10-2.00 keV Th
 e + Cu Second. Elect. Emission 0.10-2.00 keV Th
 e + Rb Second. Elect. Emission 0.10-2.00 keV Th
 e + Nb Second. Elect. Emission 0.10-2.00 keV Th
 e + Mo Second. Elect. Emission 0.10-2.00 keV Th
 e + Ag Second. Elect. Emission 0.10-2.00 keV Th
 e + Cs Second. Elect. Emission 0.10-2.00 keV Th
 e + Ta Second. Elect. Emission 0.10-2.00 keV Th
 e + W Second. Elect. Emission 0.10-2.00 keV Th
 e + Ir Second. Elect. Emission 0.10-2.00 keV Th
 e + Pt Second. Elect. Emission 0.10-2.00 keV Th
 e + Au Second. Elect. Emission 0.10-2.00 keV Th
1034. J. E. Yater, A. Shih
Secondary electron emission characteristics of C(111) and the observation of double-peaked emission spectra.
 J. Appl. Phys. **90**, 3057 (2001)
 e + C Second. Elect. Emission 3.00 keV Ex
 e + C + Cs Second. Elect. Emission 3.00 keV Ex
 e + H + C Second. Elect. Emission 3.00 keV Ex
1035. T. Ahlgren, E. Rauhala
Steady state oxygen surface content in oxygen sputtered silicon at impact energy of 5 keV per atom.
 J. Appl. Phys. **90**, 4456 (2001)
 O + Si Sputtering 5.00 keV Th
1036. C. Qian, B. Terreault
Blistering of silicon crystals by low keV hydrogen and helium ions.
 J. Appl. Phys. **90**, 5152 (2001)
 H + Si Chemical Reactions 5.00-8.00 keV Ex
 He + Si Chemical Reactions 5.00-8.00 keV Ex
 H + Si Surface Interactions 5.00-8.00 keV Ex
 He + Si Surface Interactions 5.00-8.00 keV Ex
1037. A. Hoffman, A. Laikhtman, S. Ustaze, M. Hadj Hamou, M. N. Hedhili, J.-P. Guillotin, Y. Le Coat, R. Azria
Decay of secondary electron emission and charging of hydrogenated and hydrogen-free diamond film surfaces induced by low energy electrons.
 J. Appl. Phys. **91**, 4726 (2002)
 e + C Second. Elect. Emission 5.00-20.00 eV Ex

1038. H. S. Jung, J.-K. Lee, K. S. Hong, H.-J. Youn
Ion-induced secondary electron emission behavior of sol-gel-derived MgO thin films used for protective layers in alternating current plasma display panels.
 J. Appl. Phys. **92**, 2855 (2002)

$\text{He}^+ + \text{MgO}$	Second. Elect. Emission	200.00 eV	Ex
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1039. V. K. Alimov, K. Ertl, J. Roth, K. Schmid
Retention of ion-implanted deuterium in tungsten pre-irradiated with carbon ions.
 J. Nucl. Mater. **282**, 125 (2000)

$\text{D} + \text{C} + \text{W}$	Trapping, Detrapping	10.00-100.00 keV	Ex
$\text{D} + \text{W}$	Trapping, Detrapping	10.00-100.00 keV	Ex
$\text{D} + \text{WC}$	Trapping, Detrapping	10.00-100.00 keV	Ex
1040. Y. Ueda, T. Sugai, Y. Ohtsuka, M. Nishikawa
Mechanism of chemical sputtering of graphite under high flux deuterium bombardment.
 J. Nucl. Mater. **282**, 216 (2000)

$\text{D}_3^+ + \text{C}$	Trapping, Detrapping	5.00 keV	Ex
$\text{D}_3^+ + \text{C}$	Sputtering	5.00 keV	Ex
1041. S. Nagata, K. Takahiro
Deuterium retention in tungsten and molybdenum.
 J. Nucl. Mater. **283-287**, 1038 (2000)

$\text{D} + \text{Mo}$	Trapping, Detrapping	1.00-10.00 keV	Ex
$\text{D} + \text{W}$	Trapping, Detrapping	1.00-10.00 keV	Ex
1042. H. Atsumi, M. Iseki
Hydrogen absorption process into graphite and carbon materials.
 J. Nucl. Mater. **283-287**, 1053 (2000)

$\text{H}_2 + \text{C}$	Trapping, Detrapping	1.00 K	Ex
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1043. M. Balden, M. Mayer
Removal of deuterium from co-deposited carbon-silicon layers.
 J. Nucl. Mater. **283-287**, 1057 (2000)

$\text{D}_3^+ + \text{Si}$	Trapping, Detrapping	3.00 keV	Ex
$\text{D}_3^+ + \text{Si}$	Desorption	3.00 keV	Ex
1044. M. Poon, J. W. Davis, A. A. Haasz
Effect of carbon pre-implantation on deuterium retention in tungsten.
 J. Nucl. Mater. **283-287**, 1062 (2000)

$\text{D}_3^+ + \text{C}$	Trapping, Detrapping	1.50 keV	Ex
$\text{D}_3^+ + \text{W}$	Trapping, Detrapping	1.50 keV	Ex
1045. S. Ueda, T. Ohsaka, S. Kuwajima
Sputtering studies of beryllium with helium and deuterium using molecular dynamics approach.
 J. Nucl. Mater. **283-287**, 1100 (2000)

$\text{D} + \text{Be}$	Sputtering	100.00 eV	Th
$\text{He} + \text{Be}$	Sputtering	100.00 eV	Th
1046. V. Dose, R. Preuss, J. Roth
Evaluation of chemical erosion data for carbon materials at high ion fluxes using Bayesian probability theory.
 J. Nucl. Mater. **288**, 153 (2000)

$\text{D} + \text{C}$	Desorption	15.00-50.00 eV	Th
$\text{D} + \text{C}$	Chemical Reactions	15.00-50.00 eV	Th
$\text{D} + \text{C}$	Sputtering	15.00-50.00 eV	Th

1047. K. Krieger, J. Roth
Synergistic effects by simultaneous bombardment of tungsten with hydrogen and carbon.
 J. Nucl. Mater. **290-293**, 107 (2001)
- | | | | |
|--------------|--------------------|---------------|----|
| $H^+ + W$ | Chemical Reactions | 2.40-3.00 keV | Ex |
| $C^+ + W$ | Chemical Reactions | 2.40-3.00 keV | Ex |
| $CH_3^+ + W$ | Chemical Reactions | 2.40-3.00 keV | Ex |
| $H^+ + W$ | Sputtering | 2.40-3.00 keV | Ex |
| $C^+ + W$ | Sputtering | 2.40-3.00 keV | Ex |
| $CH_3^+ + W$ | Sputtering | 2.40-3.00 keV | Ex |
1048. V. A. Kurnaev, A. V. Golubeva, A. A. Evanov, D. V. Levchuk, A. A. Pisarev, N. N. Trifonov
Trapping of eV deuterium ions by niobium at glancing incidence.
 J. Nucl. Mater. **290-293**, 112 (2001)
- | | | | |
|------------|----------------------|----------------|----|
| $D^+ + Nb$ | Trapping, Detrapping | 5.00-120.00 eV | Ex |
|------------|----------------------|----------------|----|
1049. K. Morita, N. Kishi, A. Grigoriev, S. Masuzaki, T. Muroga
TOF analysis of reflection of low-energy light ions from solid targets using coaxial impact collision ion scattering spectroscopy (CAICISS).
 J. Nucl. Mater. **290-293**, 126 (2001)
- | | | | |
|-------------|------------|---------------|----|
| $D^+ + Si$ | Reflection | 0.50-3.00 keV | Ex |
| $He^+ + Si$ | Reflection | 0.50-3.00 keV | Ex |
1050. S. Nagata, K. Takahiro
Effect of helium irradiation on trapping and thermal release of deuterium implanted in tungsten.
 J. Nucl. Mater. **290-293**, 135 (2001)
- | | | | |
|-----------|----------------------|----------|----|
| $D^+ + W$ | Trapping, Detrapping | 1.00 keV | Ex |
|-----------|----------------------|----------|----|
1051. T. Ono, T. Kawamura, T. Kenmotsu, Y. Yamamura
Simulation study on retention and reflection from tungsten carbide under high fluence of helium ions.
 J. Nucl. Mater. **290-293**, 140 (2001)
- | | | | |
|------------|----------------------|---------------|----|
| $He^+ + W$ | Trapping, Detrapping | 0.50-5.00 keV | Th |
| $He^+ + W$ | Reflection | 0.50-5.00 keV | Th |
1052. E. Salonen, K. Nordlund, J. Keinonen, C. H. Wu
Carbon erosion mechanisms in tokamak divertor materials: insight from molecular dynamics simulations.
 J. Nucl. Mater. **290-293**, 144 (2001)
- | | | | |
|-----------|--------------------|---------------|----|
| $H^+ + C$ | Chemical Reactions | 1.00-10.00 eV | Th |
| $D^+ + C$ | Chemical Reactions | 1.00-10.00 eV | Th |
| $T^+ + C$ | Chemical Reactions | 1.00-10.00 eV | Th |
| $H^+ + C$ | Sputtering | 1.00-10.00 eV | Th |
| $D^+ + C$ | Sputtering | 1.00-10.00 eV | Th |
| $T^+ + C$ | Sputtering | 1.00-10.00 eV | Th |
1053. K. Schmid, J. Roth, W. Eckstein
Influence of diffusion on W sputtering by carbon.
 J. Nucl. Mater. **290-293**, 148 (2001)
- | | | | |
|-----------|--------------------|----------|----|
| $C^+ + W$ | Chemical Reactions | 2.40 keV | Th |
| $C^+ + W$ | Sputtering | 2.40 keV | Th |
1054. E. Vietzke
Energy distributions of CD_4 and CD_3 chemically released from graphite by D^+ and D^0/Ne^+ impact.
 J. Nucl. Mater. **290-293**, 158 (2001)

- | | | | | |
|--|--------------------|----------------------|-----------|----|
| | D + C | Trapping, Detrapping | 400.00 eV | Ex |
| | D ⁺ + C | Trapping, Detrapping | 400.00 eV | Ex |
| | D + C | Chemical Reactions | 400.00 eV | Ex |
| | D ⁺ + C | Chemical Reactions | 400.00 eV | Ex |
| | D + C | Sputtering | 400.00 eV | Ex |
| | D + C | Sputtering | 400.00 eV | Ex |
| | D ⁺ + C | Sputtering | 400.00 eV | Ex |
| | D ⁺ + C | Sputtering | 400.00 eV | Ex |
1055. C. Garcia-Rosales, M. Balden
Chemical erosion of doped graphites for fusion devices.
 J. Nucl. Mater. **290-293**, 173 (2001)
- | | | | | |
|--|--------------------|--------------------|---------------|----|
| | D ⁺ + C | Chemical Reactions | 0.03-1.00 keV | Ex |
| | D ⁺ + C | Desorption | 0.03-1.00 keV | Ex |
1056. J. P. Allain, D. N. Ruzic, M. R. Hendricks
Measurements and modeling of D, He, and Li sputtering of liquid lithium.
 J. Nucl. Mater. **290-293**, 180 (2001)
- | | | | | |
|--|----------------------|------------|---------------|-----|
| | D ⁺ + Li | Sputtering | 0.20-1.00 keV | E/T |
| | He ⁺ + Li | Sputtering | 0.20-1.00 keV | E/T |
| | Li ⁺ + Li | Sputtering | 0.20-1.00 keV | E/T |
1057. J. N. Brooks, T. D. Rognlien, D. N. Ruzic, J. P. Allain
Erosion/redeposition analysis of lithium-based liquid surface divertors.
 J. Nucl. Mater. **290-293**, 185 (2001)
- | | | | | |
|--|----------------------|------------|---------------|----|
| | D ⁺ + Li | Sputtering | 0.03-4.00 keV | Th |
| | Li ⁺ + Li | Sputtering | 0.03-4.00 keV | Th |
1058. R. Bastasz, W. Eckstein
Plasma-surface interactions in liquids.
 J. Nucl. Mater. **290-293**, 19 (2001)
- | | | | | |
|--|---------|----------------------|---------------|----|
| | D + Li | Trapping, Detrapping | 0.01-5.00 keV | Th |
| | D + Sn | Trapping, Detrapping | 0.01-5.00 keV | Th |
| | T + Li | Trapping, Detrapping | 0.01-5.00 keV | Th |
| | T + Sn | Trapping, Detrapping | 0.01-5.00 keV | Th |
| | D + Li | Sputtering | 0.01-5.00 keV | Th |
| | D + Ga | Sputtering | 0.01-5.00 keV | Th |
| | D + Sn | Sputtering | 0.01-5.00 keV | Th |
| | T + Li | Sputtering | 0.01-5.00 keV | Th |
| | T + Ga | Sputtering | 0.01-5.00 keV | Th |
| | He + Li | Sputtering | 0.01-5.00 keV | Th |
| | He + Ga | Sputtering | 0.01-5.00 keV | Th |
| | Li + Li | Sputtering | 0.01-5.00 keV | Th |
| | Li + Ga | Sputtering | 0.01-5.00 keV | Th |
1059. F. Scaffidi-Argentina, C. Sand, C. H. Wu
Tritium retention in neutron-irradiated low-Z materials for use as plasma facing materials.
 J. Nucl. Mater. **290-293**, 211 (2001)
- | | | | | |
|--|--------|----------------------|--|----|
| | T + Be | Trapping, Detrapping | | Ex |
|--|--------|----------------------|--|----|
1060. R. A. Anderl, R. J. Pawelko, S. T. Schuetz
Deuterium retention in W, W1%La, C-coated W and W₂C.
 J. Nucl. Mater. **290-293**, 38 (2001)
- | | | | | |
|--|----------------------|----------------------|----------|----|
| | D + C | Trapping, Detrapping | 0.50 keV | Ex |
| | D + W | Trapping, Detrapping | 0.50 keV | Ex |
| | D + W ₂ C | Trapping, Detrapping | 0.50 keV | Ex |

1061. M. Balden, S. Picarle, J. Roth
Mechanism of the chemical erosion of SiC under hydrogen irradiation.
 J. Nucl. Mater. **290-293**, 47 (2001)

D + SiC	Sputtering	0.01-10.00 keV	Ex
D + SiC	Sputtering	0.01-10.00 keV	Ex
1062. I. Takagi, Y. Koga, H. Fujita, K. Higashi
Influence of hydrogen surface coverage on atomic particle reflection.
 J. Nucl. Mater. **290-293**, 501 (2001)

D ⁺ + Fe	Reflection		Th
D ⁺ + Ni	Reflection		Th
D ⁺ + Pd	Reflection		Th
D ⁺ + SS	Reflection		Th
1063. T. Venhaus, R. A. Causey, R. Doerner, T. Abeln
Behavior of tungsten exposed to high fluences of low energy hydrogen isotopes.
 J. Nucl. Mater. **290-293**, 505 (2001)

D ⁺ + W	Trapping, Detrapping	100.00 eV	Ex
T ⁺ + W	Trapping, Detrapping	100.00 eV	Ex
1064. R. A. Zuhr, J. Roth, W. Eckstein, U. von Toussaint, J. Luthin
Implantation, erosion, and retention of tungsten in carbon.
 J. Nucl. Mater. **290-293**, 505 (2001)

W ⁺ + C	Chemical Reactions	100.00 eV	Ex
W ⁺ + C	Sputtering	100.00 eV	Ex
1065. M. Balden, C. Garcia-Rosales, R. Behrisch, J. Roth, P. Paz, J. Etxeberria
Chemical erosion of carbon doped with different fine-grain carbides.
 J. Nucl. Mater. **290-293**, 52 (2001)

D + C	Chemical Reactions	0.03-1.00 keV	Ex
D + SiC	Chemical Reactions	0.03-1.00 keV	Ex
D + TiC	Chemical Reactions	0.03-1.00 keV	Ex
D + V ₈ C ₇	Chemical Reactions	0.03-1.00 keV	Ex
D + WC	Chemical Reactions	0.03-1.00 keV	Ex
D + ZrC	Chemical Reactions	0.03-1.00 keV	Ex
D + C	Trapping, Detrapping	0.03-1.00 keV	Ex
D + SiC	Trapping, Detrapping	0.03-1.00 keV	Ex
D + TiC	Trapping, Detrapping	0.03-1.00 keV	Ex
D + V ₈ C ₇	Trapping, Detrapping	0.03-1.00 keV	Ex
D + WC	Trapping, Detrapping	0.03-1.00 keV	Ex
D + ZrC	Trapping, Detrapping	0.03-1.00 keV	Ex
D + C	Sputtering	0.03-1.00 keV	Ex
D + C	Sputtering	0.03-1.00 keV	Ex
D + SiC	Sputtering	0.03-1.00 keV	Ex
D + SiC	Sputtering	0.03-1.00 keV	Ex
D + TiC	Sputtering	0.03-1.00 keV	Ex
D + TiC	Sputtering	0.03-1.00 keV	Ex
D + V ₈ C ₇	Sputtering	0.03-1.00 keV	Ex
D + V ₈ C ₇	Sputtering	0.03-1.00 keV	Ex
D + WC	Sputtering	0.03-1.00 keV	Ex
D + WC	Sputtering	0.03-1.00 keV	Ex
D + ZrC	Sputtering	0.03-1.00 keV	Ex
D + ZrC	Sputtering	0.03-1.00 keV	Ex
1066. A. Busnyuk, Y. Nakamura, Y. Nakahara, H. Suzuki, N. Ohyabu, A. Livshits
Membrane bias effects on plasma-driven permeation of hydrogen through niobium membrane.
 J. Nucl. Mater. **290-293**, 57 (2001)

$D^+ + Nb$	Adsorption, Desorption	2.00-200.00 eV	Ex
$D^+ + Nb$	Trapping, Detrapping	2.00-200.00 eV	Ex

1067. A.Y.K. Chen, J. W. Davis, A. A. Haasz

Methane formation in graphite and boron-doped graphite under simultaneous O^+ and H^+ irradiation.

J. Nucl. Mater. **290-293**, 61 (2001)

$H^+ + B$	Desorption	0.70-5.00 keV	Ex
$H^+ + C$	Desorption	0.70-5.00 keV	Ex
$O^+ + B$	Desorption	0.70-5.00 keV	Ex
$O^+ + C$	Desorption	0.70-5.00 keV	Ex
$H^+ + B$	Chemical Reactions	0.70-5.00 keV	Ex
$H^+ + C$	Chemical Reactions	0.70-5.00 keV	Ex
$O^+ + B$	Chemical Reactions	0.70-5.00 keV	Ex
$O^+ + C$	Chemical Reactions	0.70-5.00 keV	Ex
$H^+ + B$	Trapping, Detrapping	0.70-5.00 keV	Ex
$H^+ + C$	Trapping, Detrapping	0.70-5.00 keV	Ex
$O^+ + B$	Trapping, Detrapping	0.70-5.00 keV	Ex
$O^+ + C$	Trapping, Detrapping	0.70-5.00 keV	Ex
$H^+ + B$	Sputtering	0.70-5.00 keV	Ex
$H^+ + B$	Sputtering	0.70-5.00 keV	Ex
$H^+ + C$	Sputtering	0.70-5.00 keV	Ex
$H^+ + C$	Sputtering	0.70-5.00 keV	Ex
$O^+ + B$	Sputtering	0.70-5.00 keV	Ex
$O^+ + B$	Sputtering	0.70-5.00 keV	Ex
$O^+ + C$	Sputtering	0.70-5.00 keV	Ex
$O^+ + C$	Sputtering	0.70-5.00 keV	Ex

1068. J. W. Davis, P. B. Wright, R. G. Macaulay-Newcombe, A. A. Haasz, C. G. Hamilton

Chemical erosion of boronized films from DIII-D tiles.

J. Nucl. Mater. **290-293**, 66 (2001)

$D^+ + C$	Desorption	50.00-200.00 eV	Ex
$D^+ + C$	Chemical Reactions	50.00-200.00 eV	Ex
$D^+ + C$	Trapping, Detrapping	50.00-200.00 eV	Ex
$D^+ + C$	Sputtering	50.00-200.00 eV	Ex
$D^+ + C$	Sputtering	50.00-200.00 eV	Ex

1069. P. Goldstrass, Ch. Linsmeier

Formation of mixed layers and compounds on beryllium due to C^+ and CO^+ bombardment.

J. Nucl. Mater. **290-293**, 71 (2001)

$C^+ + Be$	Trapping, Detrapping	3.00-5.00 keV	Ex
$CO^+ + Be$	Trapping, Detrapping	3.00-5.00 keV	Ex
$C^+ + Be$	Sputtering	3.00-5.00 keV	Ex
$C^+ + Be$	Sputtering	3.00-5.00 keV	Ex
$CO^+ + Be$	Sputtering	3.00-5.00 keV	Ex
$CO^+ + Be$	Sputtering	3.00-5.00 keV	Ex

1070. P. Goldstrass, K. U. Klages, Ch. Linsmeier

Surface reactions on beryllium after carbon vapour deposition and thermal treatment.

J. Nucl. Mater. **290-293**, 76 (2001)

$C + Be$	Chemical Reactions	300.00 K	Ex
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1071. A. Grossman, R. P. Doerner, S. Luckhardt

Surface tension enhancement of TRIM sputtering yields for liquid metal targets.

J. Nucl. Mater. **290-293**, 80 (2001)

	$D^+ + Li$	Sputtering	75.00-200.00 eV	Th
	$D^+ + Ga$	Sputtering	75.00-200.00 eV	Th
	$Li^+ + Li$	Sputtering	75.00-200.00 eV	Th
	$Ga^+ + Ga$	Sputtering	75.00-200.00 eV	Th
1072.	A. A. Haasz, M. Poon, R. G. Macaulay-Newcombe, J. W. Davis Deuterium retention in single crystal tungsten. J. Nucl. Mater. 290-293 , 85 (2001)			
	$D_3^+ + W$	Trapping, Detrapping	1.50 keV	Ex
1073.	P. Jung, C. Liu, J. Chen Retention of implanted hydrogen and helium in martensitic stainless steels and their effects on mechanical properties. J. Nucl. Mater. 296 , 165 (2001)			
	$H + Fe$	Trapping, Detrapping		Ex
	$H + SS$	Trapping, Detrapping		Ex
	$He + Fe$	Trapping, Detrapping		Ex
	$He + SS$	Trapping, Detrapping		Ex
1074.	K. L. Hertz, R. A. Causey, D. F. Cowgill The effect of coatings on deuterium retention and permeation in aluminum 6061-T6 APT tritium production tubes. J. Nucl. Mater. 300 , 255 (2002)			
	$H^+ + Al$	Trapping, Detrapping	200.00-700.00 keV	Ex
	$D^+ + Al$	Trapping, Detrapping	200.00-700.00 keV	Ex
1075.	R. A. Causey Hydrogen isotope retention and recycling in fusion reactor plasma-facing components. J. Nucl. Mater. 300 , 91 (2002)			
	$H^+ + Li$	Desorption	0.10-15.00 keV	Ex
	$H^+ + Be$	Desorption	0.10-15.00 keV	Ex
	$H^+ + C$	Desorption	0.10-15.00 keV	Ex
	$H^+ + Ga$	Desorption	0.10-15.00 keV	Ex
	$H^+ + W$	Desorption	0.10-15.00 keV	Ex
	$D^+ + Li$	Desorption	0.10-15.00 keV	Ex
	$D^+ + Be$	Desorption	0.10-15.00 keV	Ex
	$D^+ + C$	Desorption	0.10-15.00 keV	Ex
	$D^+ + Ga$	Desorption	0.10-15.00 keV	Ex
	$D^+ + W$	Desorption	0.10-15.00 keV	Ex
	$H^+ + Li$	Chemical Reactions	0.10-15.00 keV	Ex
	$H^+ + Be$	Chemical Reactions	0.10-15.00 keV	Ex
	$H^+ + C$	Chemical Reactions	0.10-15.00 keV	Ex
	$H^+ + Ga$	Chemical Reactions	0.10-15.00 keV	Ex
	$H^+ + W$	Chemical Reactions	0.10-15.00 keV	Ex
	$D^+ + Li$	Chemical Reactions	0.10-15.00 keV	Ex
	$D^+ + Be$	Chemical Reactions	0.10-15.00 keV	Ex
	$D^+ + C$	Chemical Reactions	0.10-15.00 keV	Ex
	$D^+ + Ga$	Chemical Reactions	0.10-15.00 keV	Ex
	$D^+ + W$	Chemical Reactions	0.10-15.00 keV	Ex
	$H^+ + Li$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex
	$H^+ + Be$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex
	$H^+ + C$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex
	$H^+ + Ga$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex
	$H^+ + W$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex
	$D^+ + Li$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex
	$D^+ + Be$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex

$D^+ + C$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex
$D^+ + Ga$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex
$D^+ + W$	Neutraliz., Ioniz., Dissoc.	0.10-15.00 keV	Ex
$H^+ + Li$	Trapping, Detrapping	0.10-15.00 keV	Ex
$H^+ + Be$	Trapping, Detrapping	0.10-15.00 keV	Ex
$H^+ + C$	Trapping, Detrapping	0.10-15.00 keV	Ex
$H^+ + Ga$	Trapping, Detrapping	0.10-15.00 keV	Ex
$H^+ + W$	Trapping, Detrapping	0.10-15.00 keV	Ex
$D^+ + Li$	Trapping, Detrapping	0.10-15.00 keV	Ex
$D^+ + Be$	Trapping, Detrapping	0.10-15.00 keV	Ex
$D^+ + C$	Trapping, Detrapping	0.10-15.00 keV	Ex
$D^+ + Ga$	Trapping, Detrapping	0.10-15.00 keV	Ex
$D^+ + W$	Trapping, Detrapping	0.10-15.00 keV	Ex

1076. N. Matsunami, M. Sataka, A. Iwase, T. Inami, M. Kobiyama

Sputtering of nano-crystalline gold by high energy heavy ions.

J. Nucl. Mater. **302**, 206 (2002)

$S^{7+} + Au$	Sputtering	80.00-200.00 MeV	Ex
$Ni^{6+} + Au$	Sputtering	80.00-200.00 MeV	Ex
$I^{9+} + Au$	Sputtering	80.00-200.00 MeV	Ex
$I^{12+} + Au$	Sputtering	80.00-200.00 MeV	Ex

1077. K. Schmid, J. Roth

Concentration dependent diffusion of carbon in tungsten.

J. Nucl. Mater. **302**, 96 (2002)

$C + W$	Trapping, Detrapping	E/T
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1078. Y.-P. Chen

Monte Carlo simulation of gas desorption process induced by low-energy ions.

J. Nucl. Mater. **303**, 99 (2002)

$H^+ + O + Ti$	Desorption	30.00-60.00 eV	Th
$D^+ + O + Ti$	Desorption	30.00-60.00 eV	Th
$T^+ + O + Ti$	Desorption	30.00-60.00 eV	Th

1079. A. M. Borisov, W. Eckstein, E. S. Mashkova

Sputtering and ion-induced electron emission of graphite under high-dose nitrogen bombardment.

J. Nucl. Mater. **304**, 15 (2002)

$N_2^+ + C$	Second. Elect. Emission	30.00 keV	Ex
$N_2^+ + C$	Sputtering	30.00 keV	Ex

1080. E. Takacs, Z. Berenyi, J. D. Gillaspay, L. P. Ratliff, R. Minniti, J. Pedulla, R. D. Deslattes, N. Stolterfoht
Separation of inner-shell vacancy transfer mechanisms in collisions of slow Ar^{17+} ions with SiO_2 .

J. Phys. B **34**, 1277 (2001)

$Ar^{17+} + SiO_2$	Surface Interactions	130.00-200.00 keV	Ex
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1081. V. Horvat, R. L. Watson

Target-atom K-shell ionization by binary-encounter electrons.

J. Phys. B **34**, 777 (2001)

$Kr^+ + Cu$	Surface Interactions	10.00 MeV/amu	E/T
$Xe^+ + Cu$	Surface Interactions	10.00 MeV/amu	E/T
$Bi^+ + Cu$	Surface Interactions	10.00 MeV/amu	E/T

1082. M. Ertugrul, O. Sogut, O. Simsek, E. Buyukkasap

Measurement of $K\beta / K\alpha$ intensity ratios for elements in the range $22 \leq Z \leq 69$ at 59.5 keV.

J. Phys. B **34**, 909 (2001)

- | | $h\nu$ + perturbation | Surface Interactions | 59.50 keV | E/T |
|--|-----------------------|----------------------|-----------|-----|
|--|-----------------------|----------------------|-----------|-----|
1083. W. Brenig, M. F. Hlil
Reaction dynamics of H₂ and D₂ on Si(100) and Si(111).
 J. Phys. Condens. Matter **13**, R61 (2001)
- | | | | |
|---------------------|-----------------------------|---------|----|
| H ₂ + Si | Desorption | 0.30 eV | Th |
| D ₂ + Si | Desorption | 0.30 eV | Th |
| H ₂ + Si | Adsorption, Desorption | 0.30 eV | Th |
| D ₂ + Si | Adsorption, Desorption | 0.30 eV | Th |
| H ₂ + Si | Neutraliz., Ioniz., Dissoc. | 0.30 eV | Th |
| D ₂ + Si | Neutraliz., Ioniz., Dissoc. | 0.30 eV | Th |
1084. T. Zambelli, J. V. Barth, J. Winterlin
Thermal dissociation of chemisorbed oxygen molecules on Ag(110): an investigation by scanning tunnelling microscopy.
 J. Phys. Condens. Matter **14**, 4241 (2002)
- | | | | |
|---------------------|-----------------------------|----------------|----|
| O ₂ + Ag | Neutraliz., Ioniz., Dissoc. | 40.00-200.00 K | Ex |
|---------------------|-----------------------------|----------------|----|
1085. K. Kurt, V. Ramachandran, M. Maghrabi, P. D. Townsend, B. Yang
Influence of phase transitions of ice on near-surface cathodoluminescence.
 J. Phys. Condens. Matter **14**, 4319 (2002)
- | | | | |
|----------------------|----------------------|----------------|----|
| e + H ₂ O | Surface Interactions | 4.00-20.00 keV | Ex |
|----------------------|----------------------|----------------|----|
1086. A. Siber, B. Gumhalter, C. Woell
Kinematic effects in the Debye-Waller factor and sticking probabilities in low-energy atom-surface scattering.
 J. Phys. Condens. Matter **14**, 5913 (2002)
- | | | | |
|--------------|------------------------|-----------|----|
| He + Xe + Cu | Adsorption, Desorption | 45.00 meV | Th |
| He + Xe + Cu | Reflection | 45.00 meV | Th |
1087. G. Varga
Computer simulation by the quantum mechanical time-dependent wavepacket method, especially for atom/molecule-solid-surface interaction.
 J. Phys. Condens. Matter **14**, 6081 (2002)
- | | | | |
|---------|-----------------------------|--|-----|
| He + Rh | Surface Interactions | | E/T |
| He + W | Surface Interactions | | E/T |
| He + Rh | Adsorption, Desorption | | E/T |
| He + W | Adsorption, Desorption | | E/T |
| He + Rh | Neutraliz., Ioniz., Dissoc. | | E/T |
| He + W | Neutraliz., Ioniz., Dissoc. | | E/T |
| He + Rh | Reflection | | E/T |
| He + W | Reflection | | E/T |
1088. J. R. Manson, A. P. Graham, M. Li
Multiple-quantum excitation probabilities of Einstein-like modes of surface adsorbates induced by He-atom scattering.
 J. Phys. Condens. Matter **14**, 6233 (2002)
- | | | | |
|--------------|------------|-----------------|-----|
| He + Kr + Pt | Reflection | 20.00-83.00 meV | E/T |
| He + CO + Cu | Reflection | 20.00-83.00 meV | E/T |
| He + CO + Pt | Reflection | 20.00-83.00 meV | E/T |
1089. S. Nave, D. Lemoine
Quantum mechanical studies of helium atom scattering from isolated CO molecules on metal surfaces.
 J. Phys. Condens. Matter **14**, 6263 (2002)
- | | | | |
|--------------|------------|-----------|----|
| He + CO + Cu | Reflection | 20.00 meV | Th |
|--------------|------------|-----------|----|

1090. R. Ranjan, J. P. Allain, M. R. Hendricks, D. N. Ruzic
Absolute sputtering yield of Ti/TiN by Ar⁺/N⁺ at 400-700 eV.
 J. Vac. Sci. Technol. A **19**, 1004 (2001)
- | | | | |
|-----------------------|------------|------------------|----|
| N ⁺ + Ti | Sputtering | 400.00-700.00 eV | Ex |
| N ⁺ + Ti | Sputtering | 400.00-700.00 eV | Ex |
| N ⁺ + TiN | Sputtering | 400.00-700.00 eV | Ex |
| N ⁺ + TiN | Sputtering | 400.00-700.00 eV | Ex |
| Ar ⁺ + Ti | Sputtering | 400.00-700.00 eV | Ex |
| Ar ⁺ + Ti | Sputtering | 400.00-700.00 eV | Ex |
| Ar ⁺ + TiN | Sputtering | 400.00-700.00 eV | Ex |
| Ar ⁺ + TiN | Sputtering | 400.00-700.00 eV | Ex |
1091. C. C. Parks
Comparative ion yields by secondary ion mass spectrometry from microelectronic films.
 J. Vac. Sci. Technol. A **19**, 1134 (2001)
- | | | | |
|--|------------|----------|----|
| O ₂ ⁺ + Al | Sputtering | 5.50 keV | Ex |
| O ₂ ⁺ + Si | Sputtering | 5.50 keV | Ex |
| O ₂ ⁺ + SiO ₂ | Sputtering | 5.50 keV | Ex |
| O ₂ ⁺ + Ti | Sputtering | 5.50 keV | Ex |
| O ₂ ⁺ + TiSi ₂ | Sputtering | 5.50 keV | Ex |
| O ₂ ⁺ + Co | Sputtering | 5.50 keV | Ex |
| O ₂ ⁺ + Cu | Sputtering | 5.50 keV | Ex |
| O ₂ ⁺ + Ta | Sputtering | 5.50 keV | Ex |
| O ₂ ⁺ + W | Sputtering | 5.50 keV | Ex |
| O ₂ ⁺ + Pt | Sputtering | 5.50 keV | Ex |
| Cs ⁺ + Al | Sputtering | 5.50 keV | Ex |
| Cs ⁺ + Si | Sputtering | 5.50 keV | Ex |
| Cs ⁺ + Si ₃ N ₄ | Sputtering | 5.50 keV | Ex |
| Cs ⁺ + SiO ₂ | Sputtering | 5.50 keV | Ex |
| Cs ⁺ + Ti | Sputtering | 5.50 keV | Ex |
| Cs ⁺ + CoSi ₂ | Sputtering | 5.50 keV | Ex |
| Cs ⁺ + Cu | Sputtering | 5.50 keV | Ex |
| Cs ⁺ + Ta | Sputtering | 5.50 keV | Ex |
| Cs ⁺ + W | Sputtering | 5.50 keV | Ex |
| Cs ⁺ + WSi ₂ | Sputtering | 5.50 keV | Ex |
1092. V. N. Ageev, Yu. A. Kuznetsov, T. E. Madey
Resonances in electron-stimulated desorption of Eu atoms.
 J. Vac. Sci. Technol. A **19**, 1481 (2001)
- | | | | |
|--------|------------|-----------|----|
| e + Eu | Desorption | 100.00 eV | Ex |
|--------|------------|-----------|----|
1093. A. L. Hanson, P. Thieberger, D. B. Steske, V. Zajic, S. Y. Zhang, H. Ludewig
Electron emission from ion bombarded stainless-steel surfaces coated and noncoated with TiN and its relevance to the design of high intensity storage rings.
 J. Vac. Sci. Technol. A **19**, 2116 (2001)
- | | | | |
|-----------------------|-------------------------|------------------|----|
| H ⁺ + TiN | Second. Elect. Emission | 28.00-182.00 MeV | Ex |
| H ⁺ + SS | Second. Elect. Emission | 28.00-182.00 MeV | Ex |
| O ⁺ + TiN | Second. Elect. Emission | 28.00-182.00 MeV | Ex |
| O ⁺ + SS | Second. Elect. Emission | 28.00-182.00 MeV | Ex |
| Au ⁺ + TiN | Second. Elect. Emission | 28.00-182.00 MeV | Ex |
| Au ⁺ + SS | Second. Elect. Emission | 28.00-182.00 MeV | Ex |
1094. Y. Kiyota, T. Inada
Sticking coefficient of boron and phosphorus on silicon during vapor-phase doping.
 J. Vac. Sci. Technol. A **19**, 2441 (2001)
- | | | | |
|--------|------------------------|----------|----|
| B + Si | Adsorption, Desorption | 300.00 K | Ex |
| P + Si | Adsorption, Desorption | 300.00 K | Ex |

1095. T. Kondo, T. Tomii, S. Yagyu, S. Yamamoto
Rainbow scattering of CH₄ and C₂H₆ molecular beams from a LiF(001) surface: Dependence on incident kinetic energy and molecular anisotropy.
 J. Vac. Sci. Technol. A **19**, 2468 (2001)
- | | | | |
|-------------------------------------|------------|-------------------|----|
| CH ₄ + LiF | Reflection | 200.00-800.00 meV | Ex |
| C ₂ H ₆ + LiF | Reflection | 200.00-800.00 meV | Ex |
1096. O. V. Sazhin, S. F. Borisov, F. Sharipov
Accommodation coefficient of tangential momentum on atomically clean and contaminated surfaces.
 J. Vac. Sci. Technol. A **19**, 2499 (2001)
- | | | | |
|-----------------------|------------------------|----------|----|
| He + SiO ₂ | Adsorption, Desorption | 300.00 K | Ex |
| He + Ti | Adsorption, Desorption | 300.00 K | Ex |
| He + Ag | Adsorption, Desorption | 300.00 K | Ex |
| Ne + SiO ₂ | Adsorption, Desorption | 300.00 K | Ex |
| Ne + Ti | Adsorption, Desorption | 300.00 K | Ex |
| Ne + Ag | Adsorption, Desorption | 300.00 K | Ex |
| Ar + SiO ₂ | Adsorption, Desorption | 300.00 K | Ex |
| Ar + Ti | Adsorption, Desorption | 300.00 K | Ex |
| Ar + Ag | Adsorption, Desorption | 300.00 K | Ex |
| Kr + SiO ₂ | Adsorption, Desorption | 300.00 K | Ex |
| Kr + Ti | Adsorption, Desorption | 300.00 K | Ex |
| Kr + Ag | Adsorption, Desorption | 300.00 K | Ex |
1097. M. Stepanova, S. K. Dew
Estimates of differential sputtering yields for deposition applications.
 J. Vac. Sci. Technol. A **19**, 2805 (2001)
- | | | | |
|----------------------|------------|---------------|----|
| Ar ⁺ + Al | Sputtering | 0.05-1.00 keV | Th |
| Ar ⁺ + Si | Sputtering | 0.05-1.00 keV | Th |
| Ar ⁺ + Ti | Sputtering | 0.05-1.00 keV | Th |
| Ar ⁺ + V | Sputtering | 0.05-1.00 keV | Th |
| Ar ⁺ + Cr | Sputtering | 0.05-1.00 keV | Th |
| Ar ⁺ + Fe | Sputtering | 0.05-1.00 keV | Th |
| Ar ⁺ + Ni | Sputtering | 0.05-1.00 keV | Th |
| Ar ⁺ + Cu | Sputtering | 0.05-1.00 keV | Th |
| Ar ⁺ + Ge | Sputtering | 0.05-1.00 keV | Th |
| Ar ⁺ + Zr | Sputtering | 0.05-1.00 keV | Th |
| Ar ⁺ + Rh | Sputtering | 0.05-1.00 keV | Th |
| Ar ⁺ + W | Sputtering | 0.05-1.00 keV | Th |
1098. D. E. Hanson, B. C. Stephens, C. Saravanan, J. D. Kress
Molecular dynamics simulations of ion self-sputtering of Ni and Al surfaces.
 J. Vac. Sci. Technol. A **19**, 820 (2001)
- | | | | |
|----------------------|------------------------|-----------------|----|
| Al ⁺ + Al | Adsorption, Desorption | 25.00-150.00 eV | Th |
| Ni ⁺ + Ni | Adsorption, Desorption | 25.00-150.00 eV | Th |
| Al ⁺ + Al | Sputtering | 25.00-150.00 eV | Th |
| Ni ⁺ + Ni | Sputtering | 25.00-150.00 eV | Th |
1099. S.G. Yu, W. Yi, T. Jeong, J. Lee, J. Heo, C. S. Lee, D. Jeon, J. M. Kim
Secondary electron emission for layered structures.
 J. Vac. Sci. Technol. A **20**, 950 (2002)
- | | | | |
|----------------------|-------------------------|----------|----|
| e + Si | Second. Elect. Emission | 3.00 keV | Th |
| e + SiO ₂ | Second. Elect. Emission | 3.00 keV | Th |
1100. Y. T. Matulevich, T. J. Vink, L. F. Feiner, P.A. Zeijlmans van Emmichoven
Electron emission during collisions of low-energy ions with MgO(110).
 Nucl. Instrum. Methods Phys. Res. B **163**, 632 (2002)

- | | | | | |
|--|-----------------------------|-------------------------|---------------|----|
| | He⁺ + MgO | Second. Elect. Emission | 0.06-1.00 keV | Ex |
| | Ne⁺ + MgO | Second. Elect. Emission | 0.06-1.00 keV | Ex |
1101. W. Eckstein
Oscillations of sputtering yield.
 Nucl. Instrum. Methods Phys. Res. B **171**, 435 (2000)
- | | | | | |
|--|---------------------------|------------|---------------|-----|
| | W⁺ + Be | Sputtering | 0.00-1.00 MeV | E/T |
| | W⁺ + C | Sputtering | 0.00-1.00 MeV | E/T |
| | W⁺ + Si | Sputtering | 0.00-1.00 MeV | E/T |
1102. J. Krasa, L. Lasaka, M. P. Stockli, D. Fry
Secondary-electron yield from Au induced by highly charged Ta ions.
 Nucl. Instrum. Methods Phys. Res. B **173**, 281 (2001)
- | | | | |
|------------------------------|-------------------------|---------------|----|
| Ta¹¹⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta¹²⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta¹³⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta¹⁴⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta¹⁵⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta¹⁶⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta¹⁷⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta¹⁸⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta¹⁹⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta²⁰⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta²¹⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta²²⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta²³⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta²⁴⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta²⁵⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta²⁶⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta²⁷⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta²⁸⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta²⁹⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta³⁰⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta³¹⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta³²⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta³³⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta³⁴⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta³⁵⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta³⁶⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta³⁷⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta³⁸⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta³⁹⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta⁴⁰⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
| Ta⁴¹⁺ + Au | Second. Elect. Emission | 0.17-6.00 MeV | Ex |
1103. Y. Zhang, T. Zhang, Z. Xiao, H. J. Whitlow
Sputtering transients for some transition elements during high-fluence MEVVA implantation of Si.
 Nucl. Instrum. Methods Phys. Res. B **173**, 427 (2001)
- | | | | | |
|--|----------------|------------|-----------------|----|
| | V + Si | Sputtering | 30.00-50.00 keV | Ex |
| | Co + Si | Sputtering | 30.00-50.00 keV | Ex |
| | Ni + Si | Sputtering | 30.00-50.00 keV | Ex |
| | Er + Si | Sputtering | 30.00-50.00 keV | Ex |
1104. S. Jans, P. Wurz, R. Schletti, K. Bruening, K. Sekar, W. Heiland, J. Quinn, R. E. Leuchtner
Scattering of atoms and molecules off a barium zirconate surface.
 Nucl. Instrum. Methods Phys. Res. B **173**, 503 (2001)

- | | | | |
|---------------------------------|------------|---------------|----|
| $\text{H}^+ + \text{BaZrO}_3$ | Reflection | 0.50-3.00 keV | Ex |
| $\text{H}_2 + \text{BaZrO}_3$ | Reflection | 0.50-3.00 keV | Ex |
| $\text{H}_2^+ + \text{BaZrO}_3$ | Reflection | 0.50-3.00 keV | Ex |
| $\text{O} + \text{BaZrO}_3$ | Reflection | 0.50-3.00 keV | Ex |
| $\text{O}^+ + \text{BaZrO}_3$ | Reflection | 0.50-3.00 keV | Ex |
| $\text{O}_2 + \text{BaZrO}_3$ | Reflection | 0.50-3.00 keV | Ex |
| $\text{O}_2^+ + \text{BaZrO}_3$ | Reflection | 0.50-3.00 keV | Ex |
1105. G. Ramos, B.M.U. Scherzer
Radiation damage, trapping and release of deuterium in diamond and HOPG-graphite.
 Nucl. Instrum. Methods Phys. Res. B **174**, 329 (2001)
- | | | | |
|-------------------------|----------------------|----------|----|
| $\text{D}^+ + \text{C}$ | Trapping, Detrapping | 8.00 keV | Ex |
|-------------------------|----------------------|----------|----|
1106. V. I. Shulga
Sputtering of platinum by argon ions: A simulation study.
 Nucl. Instrum. Methods Phys. Res. B **174**, 423 (2001)
- | | | | |
|---------------------------|------------|----------------|----|
| $\text{Ar}^+ + \text{Pt}$ | Sputtering | 0.20-50.00 keV | Th |
|---------------------------|------------|----------------|----|
1107. V. I. Shulga
The density effects in polycrystal sputtering.
 Nucl. Instrum. Methods Phys. Res. B **174**, 77 (2001)
- | | | | |
|-------------------------------------|------------|---------------|-----|
| $\text{Ar}^+ + \text{Fe}$ | Sputtering | 0.60-1.00 keV | E/T |
| $\text{Ar}^+ + \text{perturbation}$ | Sputtering | 0.60-1.00 keV | E/T |
1108. E. Benedito, J. M. Fernandez-Varea, F. Salvat
Mixed simulation of the multiple elastic scattering of electrons and positrons using partial-wave differential cross-sections.
 Nucl. Instrum. Methods Phys. Res. B **174**, 91 (2001)
- | | | | |
|------------------------|------------|---------------|----|
| $\text{e} + \text{Al}$ | Reflection | 0.00-1.00 GeV | Th |
| $\text{e} + \text{Au}$ | Reflection | 0.00-1.00 GeV | Th |
1109. V. Bandourko, T. T. Lay, Y. Takeda, C. G. Lee, N. Kishimoto
Ion-induced photon emission of magnesium aluminate spinel during 60 keV Cu^- implantation.
 Nucl. Instrum. Methods Phys. Res. B **175-177**, 68 (2001)
- | | | | |
|---|------------|-----------|----|
| $\text{Cu}^{-1+} + \text{Al}_2\text{O}_3$ | Reflection | 60.00 keV | Ex |
| $\text{Cu}^{-1+} + \text{MgO}$ | Reflection | 60.00 keV | Ex |
| $\text{Cu}^{-1+} + \text{Al}_2\text{O}_3$ | Sputtering | 60.00 keV | Ex |
| $\text{Cu}^{-1+} + \text{MgO}$ | Sputtering | 60.00 keV | Ex |
1110. M. Caron, F. Haranger, H. Rothard, B. Ban d'Etat, P. Boduch, A. Clouvas, C. Potiriadis, R. Neugebauer, T. Jallowy
Electronic sputtering by swift highly charged ions of nitrogen on amorphous carbon.
 Nucl. Instrum. Methods Phys. Res. B **179**, 167 (2001)
- | | | | |
|---|-------------------------|--------------------|----|
| $\text{C}^{6+} + \text{C} + \text{N}$ | Desorption | 6.00-13.00 MeV/amu | Ex |
| $\text{Ar}^{17+} + \text{C} + \text{N}$ | Desorption | 6.00-13.00 MeV/amu | Ex |
| $\text{Ni}^{24+} + \text{C} + \text{N}$ | Desorption | 6.00-13.00 MeV/amu | Ex |
| $\text{Ge}^{28+} + \text{C} + \text{N}$ | Desorption | 6.00-13.00 MeV/amu | Ex |
| $\text{Xe}^{44+} + \text{C} + \text{N}$ | Desorption | 6.00-13.00 MeV/amu | Ex |
| $\text{Ta}^{54+} + \text{C} + \text{N}$ | Desorption | 6.00-13.00 MeV/amu | Ex |
| $\text{Ta}^{54+} + \text{C}$ | Second. Elect. Emission | 6.00-13.00 MeV/amu | Ex |
1111. I. A. Wojciechowski, P. Bertrand, M. V. Medvedeva, V. Kh. Ferleger
The degree of positive ionization of sputtered metal clusters.
 Nucl. Instrum. Methods Phys. Res. B **179**, 32 (2001)

- | | | | | |
|--|----------------------------|------------|--|----|
| | Ar⁺ + Fe | Sputtering | | Th |
| | Ar⁺ + Nb | Sputtering | | Th |
| | Ar⁺ + Ag | Sputtering | | Th |
| | Ar⁺ + Ta | Sputtering | | Th |
1112. A. Goehlich, D. Gillmann, H. F. Doebele
An experimental investigation of angular resolved energy distributions of atoms sputtered from evaporated aluminum films.
Nucl. Instrum. Methods Phys. Res. B **179**, 351 (2001)
- | | | | | |
|--|----------------------------|------------|------------------|----|
| | Ar⁺ + Al | Sputtering | 200.00-500.00 eV | Ex |
| | Xe⁺ + Al | Sputtering | 200.00-500.00 eV | Ex |
1113. V. I. Shulga
Density and binding effects in low-energy sputtering.
Nucl. Instrum. Methods Phys. Res. B **179**, 485 (2001)
- | | | | | |
|--|--------------------------------------|------------|-----------------|----|
| | Ar⁺ + perturbation | Reflection | 50.00-500.00 eV | Th |
| | Ar⁺ + perturbation | Sputtering | 50.00-500.00 eV | Th |
1114. J. Vukanic, R. Simovic
Reflection coefficients of light ions for the inverse-square interaction potential.
Nucl. Instrum. Methods Phys. Res. B **179**, 497 (2001)
- | | | | | |
|--|----------------|------------|----------------|----|
| | H + Fe | Reflection | 2.00-50.00 keV | Th |
| | H + Cu | Reflection | 2.00-50.00 keV | Th |
| | H + Au | Reflection | 2.00-50.00 keV | Th |
| | D + Fe | Reflection | 2.00-50.00 keV | Th |
| | D + Cu | Reflection | 2.00-50.00 keV | Th |
| | D + Au | Reflection | 2.00-50.00 keV | Th |
| | He + Fe | Reflection | 2.00-50.00 keV | Th |
| | He + Cu | Reflection | 2.00-50.00 keV | Th |
| | He + Au | Reflection | 2.00-50.00 keV | Th |
1115. T. T. Nuver, L. C. Karssen, H. Rudolph, P.A. Zeijlmans van Emmichoven, A. Niehaus
Preferential ejection of sputtered and reflected atoms in the keV bombardment of Cu(110) with noble gas ions.
Nucl. Instrum. Methods Phys. Res. B **179**, 503 (2001)
- | | | | | |
|--|----------------------------|------------|----------|----|
| | Ar⁺ + Cu | Reflection | 5.00 keV | Th |
| | Kr⁺ + Cu | Reflection | 5.00 keV | Th |
| | Xe⁺ + Cu | Reflection | 5.00 keV | Th |
| | Ar⁺ + Cu | Sputtering | 5.00 keV | Th |
| | Kr⁺ + Cu | Sputtering | 5.00 keV | Th |
| | Xe⁺ + Cu | Sputtering | 5.00 keV | Th |
1116. E. C. Viljoen, E. Taglauer, J. du Plessis
A novel method to determine the ion sputter coefficient of dilute segregating impurities.
Nucl. Instrum. Methods Phys. Res. B **179**, 515 (2001)
- | | | | | |
|--|----------------------------|------------|----------|----|
| | Ar⁺ + Sn | Sputtering | 3.00 keV | Ex |
|--|----------------------------|------------|----------|----|
1117. V. K. Egorov, E. V. Egorov
Luminescence kinetics of PbWO₄ crystal at excitation by H⁺ ion beam.
Nucl. Instrum. Methods Phys. Res. B **179**, 536 (2001)
- | | | | | |
|--|---|----------------------|----------|----|
| | H⁺ + PbWO₄ | Surface Interactions | 0.90 MeV | Th |
|--|---|----------------------|----------|----|
1118. D. Danailov, R. Pfandzelter, T. Igel, H. Winter, K. Gaertner
Deduction of the He-Fe interaction potential in eV-range from experimental data by computer simulation in grazing ion-surface scattering: Row-model.
Nucl. Instrum. Methods Phys. Res. B **180**, 265 (2001)

	He + Fe	Reflection	15.00 keV	Th
1119.	T. Aoki, S. Chiba, J. Matsuo, I. Yamada, J. P. Biersack Molecular dynamics and Monte-Carlo simulation of sputtering and mixing by ion irradiation. Nucl. Instrum. Methods Phys. Res. B 180 , 312 (2001)			
	Ar ⁺ + Si	Sputtering	30.00-500.00 eV	Th
1120.	M. H. Shapiro, E. Trovato, T. A. Tombrello Depth of origin of atoms sputtered from crystalline targets. Nucl. Instrum. Methods Phys. Res. B 180 , 58 (2001)			
	Ar ⁺ + Cu	Sputtering	0.60-8.00 keV	Th
	Ar ⁺ + Rb	Sputtering	0.60-8.00 keV	Th
	Ar ⁺ + Cs	Sputtering	0.60-8.00 keV	Th
	Ar ⁺ + W	Sputtering	0.60-8.00 keV	Th
	Ar ⁺ + Au	Sputtering	0.60-8.00 keV	Th
	Xe ⁺ + Cu	Sputtering	0.60-8.00 keV	Th
	Xe ⁺ + Rb	Sputtering	0.60-8.00 keV	Th
	Xe ⁺ + Cs	Sputtering	0.60-8.00 keV	Th
	Xe ⁺ + W	Sputtering	0.60-8.00 keV	Th
	Xe ⁺ + Au	Sputtering	0.60-8.00 keV	Th
1121.	E. M. Bringa, R. E. Johnson Angular dependence of the sputtering yield from a cylindrical track. Nucl. Instrum. Methods Phys. Res. B 180 , 99 (2001)			
	He ⁺ + O ₂	Sputtering	2.00 MeV	Th
1122.	A. Niehaus, P.A. Zeijlmans van Emmichoven, I. F. Urazgil'din, B. van Someren Electron emission during ion-surface interactions. Nucl. Instrum. Methods Phys. Res. B 182 , 1 (2001)			
	H ⁺ + Al	Second. Elect. Emission	4.00 keV	Th
	H ⁺ + Cu	Second. Elect. Emission	4.00 keV	Th
1123.	J. Schou, B. Stenum, R. Pedrys Sputtering of solid deuterium by He-ions. Nucl. Instrum. Methods Phys. Res. B 182 , 116 (2001)			
	He ⁺ + D	Sputtering	4.00-10.00 keV	Ex
1124.	T. Sekioka, M. Terasawa, T. Mitamura, M. P. Stoeckli, U. Lehnert, C. W. Fehrenbach Electronic excitation effects on secondary ion emission in highly charged ion-solid interaction. Nucl. Instrum. Methods Phys. Res. B 182 , 121 (2001)			
	Xe ¹⁵⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁵⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁵⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁵⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁶⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁶⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁶⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁶⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁷⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁷⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁷⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁷⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁸⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
	Xe ¹⁸⁺ + Si	Sputtering	0.76-3.00 MeV	Ex

Xe¹⁸⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe¹⁸⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe¹⁹⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe¹⁹⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe¹⁹⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe¹⁹⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe²⁰⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe²⁰⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe²⁰⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe²⁰⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe²¹⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe²¹⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe²¹⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe²¹⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe²²⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe²²⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe²²⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe²²⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe²³⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe²³⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe²³⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe²³⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe²⁴⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe²⁴⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe²⁴⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe²⁴⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe²⁵⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe²⁵⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe²⁵⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe²⁵⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe²⁶⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe²⁶⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe²⁶⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe²⁶⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe²⁷⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe²⁷⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe²⁷⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe²⁷⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe²⁸⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe²⁸⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe²⁸⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe²⁸⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe²⁹⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe²⁹⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe²⁹⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe²⁹⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe³⁰⁺ + C	Sputtering	0.76-3.00 MeV	Ex
Xe³⁰⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe³⁰⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe³⁰⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe³⁰⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe³¹⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe³¹⁺ + Si	Sputtering	0.76-3.00 MeV	Ex
Xe³¹⁺ + Ni	Sputtering	0.76-3.00 MeV	Ex
Xe³¹⁺ + Cu	Sputtering	0.76-3.00 MeV	Ex
Xe³²⁺ + Al	Sputtering	0.76-3.00 MeV	Ex
Xe³²⁺ + Si	Sputtering	0.76-3.00 MeV	Ex

$\text{Xe}^{32+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{32+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{33+} + \text{Al}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{33+} + \text{Si}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{33+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{33+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{34+} + \text{Al}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{34+} + \text{Si}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{34+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{34+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{35+} + \text{Al}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{35+} + \text{Si}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{35+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{35+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{36+} + \text{C}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{36+} + \text{Al}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{36+} + \text{Si}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{36+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{36+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{37+} + \text{Al}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{37+} + \text{Si}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{37+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{37+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{38+} + \text{Al}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{38+} + \text{Si}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{38+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{38+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{39+} + \text{Al}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{39+} + \text{Si}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{39+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{39+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{40+} + \text{Al}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{40+} + \text{Si}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{40+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{40+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{41+} + \text{Al}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{41+} + \text{Si}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{41+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{41+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{42+} + \text{Al}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{42+} + \text{Si}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{42+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{42+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{43+} + \text{Al}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{43+} + \text{Si}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{43+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{43+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{44+} + \text{C}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{44+} + \text{Al}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{44+} + \text{Si}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{44+} + \text{Ni}$	Sputtering	0.76-3.00 MeV	Ex
$\text{Xe}^{44+} + \text{Cu}$	Sputtering	0.76-3.00 MeV	Ex

1125. R. E. Silverans, J. Bastiaansen, V. Philipsen, E. Vandeweert, P. Lievens

Sputtering of metals: Probing and modelling the emission of atoms in different electronic states.

Nucl. Instrum. Methods Phys. Res. B **182**, 127 (2001)

- | | | | |
|---------------------------|------------|----------------|----|
| $\text{Ar}^+ + \text{Co}$ | Sputtering | 3.00-15.00 keV | Ex |
| $\text{Ar}^+ + \text{Ni}$ | Sputtering | 3.00-15.00 keV | Ex |
| $\text{Ar}^+ + \text{Cu}$ | Sputtering | 3.00-15.00 keV | Ex |
| $\text{Ar}^+ + \text{Sr}$ | Sputtering | 3.00-15.00 keV | Ex |
| $\text{Ar}^+ + \text{Ag}$ | Sputtering | 3.00-15.00 keV | Ex |
1126. N. Shinde, K. Morita, S. D. Dhole, D. Ishikawa
Anomalous high yield of doubly charged Si ions sputtered from cleaned Si surface by keV neutral Ar impact.
 Nucl. Instrum. Methods Phys. Res. B **182**, 135 (2001)
- | | | | |
|-------------------------|------------|-----------|----|
| $\text{Ar} + \text{Si}$ | Sputtering | 11.00 keV | Ex |
|-------------------------|------------|-----------|----|
1127. G. Hayderer, S. Cernusca, V. Hoffmann, D. Niemann, N. Stolterfoht, M. Schmid, P. Varga, HP. Winter, F. Aumayr
Sputtering of Au and Al_2O_3 surfaces by slow highly charged ions.
 Nucl. Instrum. Methods Phys. Res. B **182**, 143 (2001)
- | | | | |
|---|------------|---------------|----|
| $\text{Ar}^+ + \text{Al}_2\text{O}_3$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Ar}^+ + \text{Au}$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Ar}^{3+} + \text{Al}_2\text{O}_3$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Ar}^{3+} + \text{Au}$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Ar}^{8+} + \text{Al}_2\text{O}_3$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Ar}^{8+} + \text{Au}$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Ar}^{9+} + \text{Al}_2\text{O}_3$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Ar}^{9+} + \text{Au}$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Xe}^{9+} + \text{Al}_2\text{O}_3$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Xe}^{9+} + \text{Au}$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Xe}^{14+} + \text{Al}_2\text{O}_3$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Xe}^{14+} + \text{Au}$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Xe}^{19+} + \text{Al}_2\text{O}_3$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Xe}^{19+} + \text{Au}$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Xe}^{25+} + \text{Al}_2\text{O}_3$ | Sputtering | 0.10-1.50 keV | Ex |
| $\text{Xe}^{25+} + \text{Au}$ | Sputtering | 0.10-1.50 keV | Ex |
1128. H. Winter, H. Eder, F. Aumayr, J. Loerincik, Z. Sroubek
Slow-ion induced electron emission from clean metal surfaces: "Subthreshold kinetic emission" and "potential excitation of plasmons."
 Nucl. Instrum. Methods Phys. Res. B **182**, 15 (2001)
- | | | | |
|---------------------------|-------------------------|----------------|----|
| $\text{H}^+ + \text{Al}$ | Second. Elect. Emission | 3.00-10.00 keV | Th |
| $\text{H}^+ + \text{Au}$ | Second. Elect. Emission | 3.00-10.00 keV | Th |
| $\text{He}^+ + \text{Au}$ | Second. Elect. Emission | 3.00-10.00 keV | Th |
| $\text{C}^+ + \text{Au}$ | Second. Elect. Emission | 3.00-10.00 keV | Th |
| $\text{Ne}^+ + \text{Al}$ | Second. Elect. Emission | 3.00-10.00 keV | Th |
| $\text{Ne}^+ + \text{Au}$ | Second. Elect. Emission | 3.00-10.00 keV | Th |
| $\text{Xe}^+ + \text{Au}$ | Second. Elect. Emission | 3.00-10.00 keV | Th |
| $\text{Au}^+ + \text{Au}$ | Second. Elect. Emission | 3.00-10.00 keV | Th |
1129. A. Hoffman, R. Azria
Surface temperature effects on the dynamics of H^- low energy electron stimulated desorption from diamond films.
 Nucl. Instrum. Methods Phys. Res. B **182**, 155 (2001)
- | | | | |
|----------------------------------|------------|---------------|----|
| $\text{e} + \text{H} + \text{C}$ | Desorption | 7.00-18.00 eV | Ex |
|----------------------------------|------------|---------------|----|
1130. K. Bruening, T. Schlathoelter, W. Heiland
Molecule dissociation at low energies on $\text{Pt}(110)$.
 Nucl. Instrum. Methods Phys. Res. B **182**, 162 (2001)
- | | | | |
|--------------------------|-----------------------------|---------------|----|
| $\text{N}_2 + \text{Pt}$ | Neutraliz., Ioniz., Dissoc. | 1.00-2.00 keV | Ex |
| $\text{N}_2 + \text{Pt}$ | Reflection | 1.00-2.00 keV | Ex |

1131. C. E. Sosolik, B. H. Cooper

Heavy atom-surface scattering at hyperthermal energies.

Nucl. Instrum. Methods Phys. Res. B **182**, 167 (2001)

$\text{Rb}^+ + \text{Cu}$	Reflection	10.00-250.00 eV	Ex
$\text{Rb}^+ + \text{Cu}$	Reflection	10.00-250.00 eV	Ex

1132. R. Beikler, E. Taglauer

Trajectory resolved analysis of LEIS energy spectra: Neutralization and surface structure.

Nucl. Instrum. Methods Phys. Res. B **182**, 180 (2001)

$\text{He}^+ + \text{Al}$	Reflection	0.50-2.00 keV	E/T
$\text{He}^+ + \text{Al}$	Reflection	0.50-2.00 keV	E/T
$\text{He}^+ + \text{TiO}_2$	Reflection	0.50-2.00 keV	E/T
$\text{He}^+ + \text{TiO}_2$	Reflection	0.50-2.00 keV	E/T
$\text{He}^+ + \text{Ni}$	Reflection	0.50-2.00 keV	E/T
$\text{He}^+ + \text{Ni}$	Reflection	0.50-2.00 keV	E/T
$\text{He}^+ + \text{Cu}$	Reflection	0.50-2.00 keV	E/T
$\text{He}^+ + \text{Cu}$	Reflection	0.50-2.00 keV	E/T
$\text{He}^+ + \text{Rb}$	Reflection	0.50-2.00 keV	E/T
$\text{He}^+ + \text{Rb}$	Reflection	0.50-2.00 keV	E/T
$\text{He}^+ + \text{Au}$	Reflection	0.50-2.00 keV	E/T
$\text{He}^+ + \text{Au}$	Reflection	0.50-2.00 keV	E/T
$\text{Ne}^+ + \text{Al}$	Reflection	0.50-2.00 keV	E/T
$\text{Ne}^+ + \text{Al}$	Reflection	0.50-2.00 keV	E/T
$\text{Ne}^+ + \text{TiO}_2$	Reflection	0.50-2.00 keV	E/T
$\text{Ne}^+ + \text{TiO}_2$	Reflection	0.50-2.00 keV	E/T
$\text{Ne}^+ + \text{Ni}$	Reflection	0.50-2.00 keV	E/T
$\text{Ne}^+ + \text{Ni}$	Reflection	0.50-2.00 keV	E/T
$\text{Ne}^+ + \text{Cu}$	Reflection	0.50-2.00 keV	E/T
$\text{Ne}^+ + \text{Cu}$	Reflection	0.50-2.00 keV	E/T
$\text{Ne}^+ + \text{Rb}$	Reflection	0.50-2.00 keV	E/T
$\text{Ne}^+ + \text{Rb}$	Reflection	0.50-2.00 keV	E/T
$\text{Ne}^+ + \text{Au}$	Reflection	0.50-2.00 keV	E/T
$\text{Ne}^+ + \text{Au}$	Reflection	0.50-2.00 keV	E/T
$\text{Ar}^+ + \text{Al}$	Reflection	0.50-2.00 keV	E/T
$\text{Ar}^+ + \text{Al}$	Reflection	0.50-2.00 keV	E/T
$\text{Ar}^+ + \text{TiO}_2$	Reflection	0.50-2.00 keV	E/T
$\text{Ar}^+ + \text{TiO}_2$	Reflection	0.50-2.00 keV	E/T
$\text{Ar}^+ + \text{Ni}$	Reflection	0.50-2.00 keV	E/T
$\text{Ar}^+ + \text{Ni}$	Reflection	0.50-2.00 keV	E/T
$\text{Ar}^+ + \text{Cu}$	Reflection	0.50-2.00 keV	E/T
$\text{Ar}^+ + \text{Cu}$	Reflection	0.50-2.00 keV	E/T
$\text{Ar}^+ + \text{Rb}$	Reflection	0.50-2.00 keV	E/T
$\text{Ar}^+ + \text{Rb}$	Reflection	0.50-2.00 keV	E/T
$\text{Ar}^+ + \text{Au}$	Reflection	0.50-2.00 keV	E/T
$\text{Ar}^+ + \text{Au}$	Reflection	0.50-2.00 keV	E/T

1133. C. L. Quinteros, T. Tzvetkov, X. Qin, D. C. Jacobs

Reactive scattering of O^+ on oxidized Si(001).

Nucl. Instrum. Methods Phys. Res. B **182**, 187 (2001)

$\text{O}^+ + \text{Si}$	Reflection	10.00-150.00 eV	Ex
$\text{O}^+ + \text{Si}$	Reflection	10.00-150.00 eV	Ex
$\text{O}^+ + \text{SiO}$	Reflection	10.00-150.00 eV	Ex
$\text{O}^+ + \text{SiO}$	Reflection	10.00-150.00 eV	Ex
$\text{O}^+ + \text{Si}$	Sputtering	10.00-150.00 eV	Ex
$\text{O}^+ + \text{SiO}$	Sputtering	10.00-150.00 eV	Ex

1134. S.-C. Park, K.-W. Maeng, T. Pradeep, H. J. Kang
Reactive ion scattering from pure and mixed HCl, NH₃ and D₂O surfaces.
 Nucl. Instrum. Methods Phys. Res. B **182**, 193 (2001)
- | | | | |
|------------------------------------|--------------------|----------|----|
| Cs ⁺ + D ₂ O | Chemical Reactions | 30.00 eV | Ex |
| Cs ⁺ + NH ₃ | Chemical Reactions | 30.00 eV | Ex |
| Cs ⁺ + HCl | Chemical Reactions | 30.00 eV | Ex |
| Cs ⁺ + D ₂ O | Reflection | 30.00 eV | Ex |
| Cs ⁺ + NH ₃ | Reflection | 30.00 eV | Ex |
| Cs ⁺ + HCl | Reflection | 30.00 eV | Ex |
| Cs ⁺ + D ₂ O | Sputtering | 30.00 eV | Ex |
| Cs ⁺ + NH ₃ | Sputtering | 30.00 eV | Ex |
| Cs ⁺ + HCl | Sputtering | 30.00 eV | Ex |
1135. R.J.W.E. Lahaye, H. Kang
Low energy scattering of Cs⁺ from Pt(111): A model study on angular and energy distributions.
 Nucl. Instrum. Methods Phys. Res. B **182**, 207 (2001)
- | | | | |
|----------------------|------------|----------------|----|
| Cs ⁺ + Pt | Reflection | 5.00-100.00 eV | Th |
|----------------------|------------|----------------|----|
1136. R. Pfandzelter, T. Hecht, H. Winter
Angular distributions of fast noble gas atoms and ions after grazing scattering from a Cu(110) surface.
 Nucl. Instrum. Methods Phys. Res. B **182**, 213 (2001)
- | | | | |
|----------------------|------------|----------|-----|
| He ⁺ + Cu | Reflection | 3.00 keV | E/T |
| Ne ⁺ + Cu | Reflection | 3.00 keV | E/T |
| Ar ⁺ + Cu | Reflection | 3.00 keV | E/T |
| Kr ⁺ + Cu | Reflection | 3.00 keV | E/T |
| Xe ⁺ + Cu | Reflection | 3.00 keV | E/T |
1137. J. Luthin, H. Plank, J. Roth, Ch. Linsmeier
Ion beam-induced carbide formation at the titanium-carbon interface.
 Nucl. Instrum. Methods Phys. Res. B **182**, 218 (2001)
- | | | | |
|----------------------|--------------------|---------------|----|
| He ⁺ + C | Chemical Reactions | 0.50-5.00 keV | Ex |
| He ⁺ + Ti | Chemical Reactions | 0.50-5.00 keV | Ex |
| Ar ⁺ + C | Chemical Reactions | 0.50-5.00 keV | Ex |
| Ar ⁺ + Ti | Chemical Reactions | 0.50-5.00 keV | Ex |
1138. A. Mertens, K. Maass, S. Lederer, H. Winter, H. Eder, J. Stoeckl, HP. Winter, F. Aumayr, J. Viefhaus, U. Becker
Studies on electron emission during grazing impact of keV-hydrogen atoms on a LiF(001) surface via translational spectroscopy.
 Nucl. Instrum. Methods Phys. Res. B **182**, 23 (2001)
- | | | | |
|---------|-------------------------|----------------|----|
| H + LiF | Second. Elect. Emission | 1.00-20.00 keV | Ex |
|---------|-------------------------|----------------|----|
1139. L. Wirtz, C. Lemell, C. O. Reinhold, L. Haegg, J. Burgdoerfer
Vertical incidence of slow Ne¹⁰⁺ ions on an LiF surface: Suppression of the trampoline effect.
 Nucl. Instrum. Methods Phys. Res. B **182**, 36 (2001)
- | | | | |
|-------------------------|-----------------------------|-----------|----|
| Ne ¹⁰⁺ + LiF | Neutraliz., Ioniz., Dissoc. | 1.00 a.u. | Th |
|-------------------------|-----------------------------|-----------|----|
1140. L. Guillemot, E. M. Staicu-Casagrande, S. Lacombe, V. A. Esaulov, L. Pasquali, S. Nannarone, M. Canepa, L. Vergara, O. Grizzi
Positive ion neutralisation on chlorine covered silver surfaces.
 Nucl. Instrum. Methods Phys. Res. B **182**, 41 (2001)

$\text{He}^+ + \text{Cl}$	Reflection	1.00-4.00 keV	Ex
$\text{He}^+ + \text{Ag}$	Reflection	1.00-4.00 keV	Ex
$\text{H}^+ + \text{Cl}$	Neutraliz., Ioniz., Dissoc.	1.00-4.00 keV	Ex
$\text{H}^+ + \text{Ag}$	Neutraliz., Ioniz., Dissoc.	1.00-4.00 keV	Ex
$\text{Ne}^+ + \text{Cl}$	Neutraliz., Ioniz., Dissoc.	1.00-4.00 keV	Ex
$\text{Ne}^+ + \text{Ag}$	Neutraliz., Ioniz., Dissoc.	1.00-4.00 keV	Ex
$\text{Ar}^+ + \text{Cl}$	Neutraliz., Ioniz., Dissoc.	1.00-4.00 keV	Ex
$\text{Ar}^+ + \text{Ag}$	Neutraliz., Ioniz., Dissoc.	1.00-4.00 keV	Ex

1141. R. A. Baragiola, C. A. Dukes, P. Riccardi

Plasmon excitation in ion-solid interactions.

Nucl. Instrum. Methods Phys. Res. B **182**, 73 (2001)

$\text{e} + \text{Be}$	Second. Elect. Emission	0.05-4.50 keV	Ex
$\text{e} + \text{Mg}$	Second. Elect. Emission	0.05-4.50 keV	Ex
$\text{e} + \text{Al}$	Second. Elect. Emission	0.05-4.50 keV	Ex
$\text{He}^+ + \text{Be}$	Second. Elect. Emission	0.05-4.50 keV	Ex
$\text{He}^+ + \text{Mg}$	Second. Elect. Emission	0.05-4.50 keV	Ex
$\text{He}^+ + \text{Al}$	Second. Elect. Emission	0.05-4.50 keV	Ex
$\text{Ne}^+ + \text{Be}$	Second. Elect. Emission	0.05-4.50 keV	Ex
$\text{Ne}^+ + \text{Mg}$	Second. Elect. Emission	0.05-4.50 keV	Ex
$\text{Ne}^+ + \text{Al}$	Second. Elect. Emission	0.05-4.50 keV	Ex
$\text{Ar}^+ + \text{Be}$	Second. Elect. Emission	0.05-4.50 keV	Ex
$\text{Ar}^+ + \text{Mg}$	Second. Elect. Emission	0.05-4.50 keV	Ex
$\text{Ar}^+ + \text{Al}$	Second. Elect. Emission	0.05-4.50 keV	Ex

1142. P. Riccardi, P. Barone, M. Camarca, N. Mandarino, F. Xu, A. Oliva, R. A. Baragiola

Bulk plasmon excitation in the interaction of Ne^+ and Ar^+ ions with polycrystalline Al surfaces.

Nucl. Instrum. Methods Phys. Res. B **182**, 84 (2001)

$\text{Ne}^+ + \text{Al}$	Second. Elect. Emission	5.00 keV	Ex
$\text{Ar}^+ + \text{Al}$	Second. Elect. Emission	5.00 keV	Ex

1143. N. Stolterfoht, J.-H. Bremer, V. Hoffmann, M. Roesler, R. Baragiola, I. De Gortari

Mechanisms for plasmon production by hollow atoms above and below an Al surface.

Nucl. Instrum. Methods Phys. Res. B **182**, 89 (2001)

$\text{Ne}^{4+} + \text{Al}$	Second. Elect. Emission	1.00-4.00 keV	Ex
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1144. A. Tolstogouзов, S. Daolio, C. Pagura

Hyperthermal and low-energy Ne^+ scattering from Au and Pt surfaces.

Nucl. Instrum. Methods Phys. Res. B **183**, 116 (2001)

$\text{Ne}^+ + \text{Pt}$	Reflection	40.00-140.00 eV	Ex
$\text{Ne}^+ + \text{Au}$	Reflection	40.00-140.00 eV	Ex

1145. M. Yasuda, K. Tamura, H. Kawata, K. Murata, M. Kotera

A Monte Carlo study of spin-polarized electron backscattering from gold thin films.

Nucl. Instrum. Methods Phys. Res. B **183**, 196 (2001)

$\text{e} + \text{Au}$	Reflection	20.00-100.00 keV	Ex
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1146. M. Mayer, M. Schneider

Scattering cross-sections for ^6Li and ^7Li ions from carbon below 5.5 MeV.

Nucl. Instrum. Methods Phys. Res. B **183**, 221 (2001)

$\text{Li}^+ + \text{C}$	Reflection	1.70-5.50 MeV	Ex
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1147. Z. W. Deng, R. Souda

A SIMS study on positive and negative ions sputtered from graphite by mass-separated low energy Ne^+ , N_2^+ and N^+ ions.

Nucl. Instrum. Methods Phys. Res. B **183**, 260 (2001)

- | | | | | |
|--|---------------------------|------------|------------------|----|
| | $\text{N}^+ + \text{C}$ | Sputtering | 100.00-800.00 eV | Ex |
| | $\text{N}_2^+ + \text{C}$ | Sputtering | 100.00-800.00 eV | Ex |
| | $\text{Ne}^+ + \text{C}$ | Sputtering | 100.00-800.00 eV | Ex |
1148. K. Khalal-Kouache, A. C. Chami, M. Boudjema, P. Benoit-Cattin, C. Benazeth, Y. Boudouma
Transport theory and Monte Carlo simulation of the scattering of low energy Li^+ ions from a polycrystalline nickel surface.
Nucl. Instrum. Methods Phys. Res. B **183**, 279 (2001)
- | | | | | |
|--|---------------------------|------------|----------|-----|
| | $\text{Li}^+ + \text{Ni}$ | Reflection | 4.00 keV | E/T |
|--|---------------------------|------------|----------|-----|
1149. T. Telbizova, T. Chevolleau, W. Moeller
Nitrogen incorporation and loss during ion nitriding of Al.
Nucl. Instrum. Methods Phys. Res. B **184**, 347 (2001)
- | | | | | |
|--|--------------------------|--------------------|----------|----|
| | $\text{N}^+ + \text{Al}$ | Chemical Reactions | 1.60 keV | Ex |
|--|--------------------------|--------------------|----------|----|
1150. M. Richard-Viard, S. Abidi, C. Benazeth, P. Benoit-Cattin, P. Cafarelli
Azimuthal dependence of charge exchange in grazing scattering of 4 keV ions on a NaCl(100) surface: Role of the trajectory.
Nucl. Instrum. Methods Phys. Res. B **184**, 490 (2001)
- | | | | | |
|--|-----------------------------|------------|----------------|----|
| | $\text{D}^+ + \text{NaCl}$ | Reflection | 2.00-10.00 keV | Th |
| | $\text{O}^+ + \text{NaCl}$ | Reflection | 2.00-10.00 keV | Th |
| | $\text{F}^+ + \text{NaCl}$ | Reflection | 2.00-10.00 keV | Th |
| | $\text{Na}^+ + \text{NaCl}$ | Reflection | 2.00-10.00 keV | Th |
| | $\text{Fe}^+ + \text{NaCl}$ | Reflection | 2.00-10.00 keV | Th |
1151. V. I. Shulga
Density effects in sputtering at normal and oblique ion bombardment.
Nucl. Instrum. Methods Phys. Res. B **187**, 178 (2002)
- | | | | | |
|--|-------------------------------------|------------|-----------------|----|
| | $\text{Ar}^+ + \text{Ge}$ | Sputtering | 0.05-100.00 keV | Th |
| | $\text{Ar}^+ + \text{perturbation}$ | Sputtering | 0.05-100.00 keV | Th |
1152. D. S. Karpuzov, N. S. McIntyre
High-energy particle emission from galena and pyrite bombarded by Cs and O ions.
Nucl. Instrum. Methods Phys. Res. B **187**, 311 (2002)
- | | | | | |
|--|-------------------------------|------------|----------------|-----|
| | $\text{O}_2^+ + \text{FeS}_2$ | Sputtering | 6.50-10.00 keV | E/T |
| | $\text{O}_2^+ + \text{PbS}$ | Sputtering | 6.50-10.00 keV | E/T |
| | $\text{Cs}^+ + \text{FeS}_2$ | Sputtering | 6.50-10.00 keV | E/T |
| | $\text{Cs}^+ + \text{PbS}$ | Sputtering | 6.50-10.00 keV | E/T |
1153. J. Lorincik, Z. Sroubek
Doubly charged ion emission in sputtering of monocrystalline fluorides.
Nucl. Instrum. Methods Phys. Res. B **187**, 447 (2002)
- | | | | | |
|--|--------------------------------|------------|---------------|----|
| | $\text{Ar}^+ + \text{CaCeF}_2$ | Sputtering | 0.50-5.00 keV | Ex |
| | $\text{Ar}^+ + \text{CaF}_2$ | Sputtering | 0.50-5.00 keV | Ex |
1154. J. P. Holgado, A. Barranco, F. Yubero, J. P. Espinos, A. R. Gonzalez-Eliphe
Ion beam effects in SiO_x ($x \geq 2$) subjected to low energy Ar^+ , He^+ and N_2^+ bombardment.
Nucl. Instrum. Methods Phys. Res. B **187**, 465 (2002)
- | | | | | |
|--|-------------------------------|--------------------|---------------|----|
| | $\text{He}^+ + \text{SiO}$ | Chemical Reactions | 0.50-5.00 keV | Ex |
| | $\text{He}^+ + \text{SiO}_2$ | Chemical Reactions | 0.50-5.00 keV | Ex |
| | $\text{N}_2^+ + \text{SiO}$ | Chemical Reactions | 0.50-5.00 keV | Ex |
| | $\text{N}_2^+ + \text{SiO}_2$ | Chemical Reactions | 0.50-5.00 keV | Ex |
| | $\text{Ar}^+ + \text{SiO}$ | Chemical Reactions | 0.50-5.00 keV | Ex |
| | $\text{Ar}^+ + \text{SiO}_2$ | Chemical Reactions | 0.50-5.00 keV | Ex |

1155. C. Klein, R. Groetzschel, M. Maeder, W. Moeller
Charge state distributions of heavy ions after scattering at surface atoms.
 Nucl. Instrum. Methods Phys. Res. B **190**, 122 (2002)
- | | | | |
|---------------------------|------------|---------------|----|
| $\text{Li}^+ + \text{Au}$ | Reflection | 1.00-6.00 MeV | Ex |
| $\text{Fe}^+ + \text{Au}$ | Reflection | 1.00-6.00 MeV | Ex |
| $\text{Cs}^+ + \text{Au}$ | Reflection | 1.00-6.00 MeV | Ex |
1156. R. J. Brooks, D. E. Hole, P. D. Townsend
Ion beam induced luminescence of materials.
 Nucl. Instrum. Methods Phys. Res. B **190**, 136 (2002)
- | | | | |
|--|----------------------|---------------|----|
| $\text{H}^+ + \text{Al}_2\text{O}_3$ | Surface Interactions | 0.40-3.00 MeV | Ex |
| $\text{H}^+ + \text{SiO}_2$ | Surface Interactions | 0.40-3.00 MeV | Ex |
| $\text{H}^+ + \text{Nb}_2\text{O}_5$ | Surface Interactions | 0.40-3.00 MeV | Ex |
| $\text{H}^+ + \text{LiO}_2$ | Surface Interactions | 0.40-3.00 MeV | Ex |
| $\text{H}_2^+ + \text{Al}_2\text{O}_3$ | Surface Interactions | 0.40-3.00 MeV | Ex |
| $\text{H}_2^+ + \text{SiO}_2$ | Surface Interactions | 0.40-3.00 MeV | Ex |
| $\text{H}_2^+ + \text{Nb}_2\text{O}_5$ | Surface Interactions | 0.40-3.00 MeV | Ex |
| $\text{H}_2^+ + \text{LiO}_2$ | Surface Interactions | 0.40-3.00 MeV | Ex |
1157. C. S. Lee, Z. M. Lin, Z. M. Yen, C. H. Lin
Light emission from oxygen covered Al and Cu surfaces.
 Nucl. Instrum. Methods Phys. Res. B **190**, 141 (2002)
- | | | | |
|--------------------------------------|----------------------|----------------|----|
| $\text{Ne}^+ + \text{O} + \text{Al}$ | Desorption | 5.00-20.00 keV | Ex |
| $\text{Ne}^+ + \text{O} + \text{Cu}$ | Desorption | 5.00-20.00 keV | Ex |
| $\text{Ar}^+ + \text{O} + \text{Al}$ | Desorption | 5.00-20.00 keV | Ex |
| $\text{Ar}^+ + \text{O} + \text{Cu}$ | Desorption | 5.00-20.00 keV | Ex |
| $\text{Ne}^+ + \text{Al}$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $\text{Ne}^+ + \text{Cu}$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $\text{Ar}^+ + \text{Al}$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $\text{Ar}^+ + \text{Cu}$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $\text{Ne}^+ + \text{Al}$ | Sputtering | 5.00-20.00 keV | Ex |
| $\text{Ne}^+ + \text{Cu}$ | Sputtering | 5.00-20.00 keV | Ex |
| $\text{Ar}^+ + \text{Al}$ | Sputtering | 5.00-20.00 keV | Ex |
| $\text{Ar}^+ + \text{Cu}$ | Sputtering | 5.00-20.00 keV | Ex |
| $\text{Ne}^+ + \text{Al}$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $\text{Ne}^+ + \text{Cu}$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $\text{Ar}^+ + \text{Al}$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $\text{Ar}^+ + \text{Cu}$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $\text{Ne}^+ + \text{Al}$ | Sputtering | 5.00-20.00 keV | Ex |
| $\text{Ne}^+ + \text{Cu}$ | Sputtering | 5.00-20.00 keV | Ex |
| $\text{Ar}^+ + \text{Al}$ | Sputtering | 5.00-20.00 keV | Ex |
| $\text{Ar}^+ + \text{Cu}$ | Sputtering | 5.00-20.00 keV | Ex |
1158. V. Bandourko, N. Umeda, N. Kishimoto
Real-time evolution of ion-surface interactions of MgAl_2O_3 and LiNbO_3 detected by ion-induced photon spectroscopy.
 Nucl. Instrum. Methods Phys. Res. B **190**, 146 (2002)
- | | | | |
|---|------------|-----------|----|
| $\text{Cu}^+ + \text{MgAl}_2\text{O}_3$ | Desorption | 60.00 keV | Ex |
| $\text{Cu}^+ + \text{MgO}$ | Desorption | 60.00 keV | Ex |
| $\text{Cu}^+ + \text{LiNbO}_3$ | Desorption | 60.00 keV | Ex |
1159. D. I. Hoxley, D. N. Jamieson, S. Prawer, V. Richter, R. Kalish
High ion-beam induced electron yields from polycrystalline diamond.
 Nucl. Instrum. Methods Phys. Res. B **190**, 151 (2002)
- | | | | |
|--------------------------|-------------------------|---------------|----|
| $\text{H}^+ + \text{C}$ | Second. Elect. Emission | 0.04-2.00 MeV | Ex |
| $\text{He}^+ + \text{C}$ | Second. Elect. Emission | 0.04-2.00 MeV | Ex |
| $\text{Ar}^+ + \text{C}$ | Second. Elect. Emission | 0.04-2.00 MeV | Ex |

1160. H. Kudo, K. Haruyama, T. Kinoshita, S. Seki, K. Narumi, H. Naramoto
Carbon KVV Auger electron emission from highly oriented pyrolytic graphite bombarded by fast protons.
 Nucl. Instrum. Methods Phys. Res. B **190**, 160 (2002)

$H^+ + C$	Second. Elect. Emission	1.00-2.00 MeV	Ex
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1161. M. Sasaki, P. J. Scanlon, S. Ermolov, H. H. Brongersma
Neutralization of He ions scattered from Ca surface.
 Nucl. Instrum. Methods Phys. Res. B **190**, 27 (2002)

$He^+ + Al$	Reflection	1.00-3.00 keV	Ex
$He^+ + Ca$	Reflection	1.00-3.00 keV	Ex
$He^+ + Cu$	Reflection	1.00-3.00 keV	Ex
1162. H. Khemliche, A. G. Borisov, A. Momeni, P. Roncin
Exciton and trion formation during neutralization of Ne^+ at a LiF(0 0 1) surface.
 Nucl. Instrum. Methods Phys. Res. B **191**, 221 (2002)

$Ne^+ + LiF$	Second. Elect. Emission	2.00 keV	Ex
$Ne^+ + LiF$	Neutraliz., Ioniz., Dissoc.	2.00 keV	Ex
$Ne^+ + LiF$	Reflection	2.00 keV	Ex
1163. Q. Lu, G. Zhao, Z. Zhou
Theoretical study on the role of bound electron in backward secondary electron emission induced by He^+ incident on solid surfaces.
 Nucl. Instrum. Methods Phys. Res. B **192**, 267 (2002)

$He^+ + C$	Second. Elect. Emission	0.50-3.50 keV	Th
$He^+ + Al$	Second. Elect. Emission	0.50-3.50 keV	Th
$He^+ + Cu$	Second. Elect. Emission	0.50-3.50 keV	Th
1164. M. Wieser, P. Wurz, K. Bruening, W. Heiland
Scattering of atoms and molecules off a magnesium oxide surface.
 Nucl. Instrum. Methods Phys. Res. B **192**, 370 (2002)

$H^+ + MgO$	Reflection	0.09-3.00 keV	Ex
$H_2^+ + MgO$	Reflection	0.09-3.00 keV	Ex
$C + MgO$	Reflection	0.09-3.00 keV	Ex
$C^+ + MgO$	Reflection	0.09-3.00 keV	Ex
$O + MgO$	Reflection	0.09-3.00 keV	Ex
$O^+ + MgO$	Reflection	0.09-3.00 keV	Ex
$O_2 + MgO$	Reflection	0.09-3.00 keV	Ex
$O_2 + MgO$	Reflection	0.09-3.00 keV	Ex
$O_2^+ + MgO$	Reflection	0.09-3.00 keV	Ex
1165. J. Cazaux
A new analytical approach for the transport and the emission yield of secondary electrons from insulators.
 Nucl. Instrum. Methods Phys. Res. B **192**, 381 (2002)

$e + C$	Second. Elect. Emission	4.00 keV	Th
$e + C$	Second. Elect. Emission	4.00 keV	Th
1166. E. Parilis
Sweeping-out-electrons effect under impact of large molecules and clusters.
 Nucl. Instrum. Methods Phys. Res. B **193**, 240 (2002)

$H^+ + C$	Second. Elect. Emission	40.00-240.00 keV	Th
$H_2^+ + C$	Second. Elect. Emission	40.00-240.00 keV	Th
$H_3^+ + C$	Second. Elect. Emission	40.00-240.00 keV	Th
$HeH^+ + C$	Second. Elect. Emission	40.00-240.00 keV	Th

1167. N.-T. H. Kim-Ngan, W. Soszka
Low energy ion scattering from Fe₃O₄ thin film surfaces.
 Nucl. Instrum. Methods Phys. Res. B **193**, 391 (2002)

He ⁺ + Fe ₃ O ₄	Reflection	5.00-6.50 keV	Ex
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1168. R. Zemih, M. Boudjema, C. Benazeth, Y. Boudouma, A. C. Chami
Image potential effect on the specular reflection coefficient of alkali ions scattered from a nickel surface at low energy.
 Nucl. Instrum. Methods Phys. Res. B **193**, 396 (2002)

He ⁺ + Ni	Reflection	4.00 keV	Ex
Li ⁺ + Ni	Reflection	4.00 keV	Ex
Ne ⁺ + Ni	Reflection	4.00 keV	Ex
Na ⁺ + Ni	Reflection	4.00 keV	Ex
1169. Z. Zhou, C. Oubre, S. B. Hill, P. Nordlander, F. B. Dunning
Ionization of xenon Rydberg atoms at surfaces.
 Nucl. Instrum. Methods Phys. Res. B **193**, 403 (2002)

Xe ¹⁷⁺ + Au	Neutraliz., Ioniz., Dissoc.		Ex
Xe ²⁰⁺ + Au	Neutraliz., Ioniz., Dissoc.		Ex
1170. N. Pauly, A. Dubus, M. Roesler
Electron capture and loss processes for protons in aluminium: Comparison between conduction band electron-hole assisted and plasmon assisted Auger processes.
 Nucl. Instrum. Methods Phys. Res. B **193**, 414 (2002)

H ⁺ + Al	Second. Elect. Emission	25.00-50.00 keV	Th
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1171. N. Kishi, K. Morita
Differential scattering cross-sections, inelastic energy losses and ion fractions in backscattering of keV He⁺ ions from monolayer metal adsorbates on solid surfaces measured by means of CAICISS.
 Nucl. Instrum. Methods Phys. Res. B **193**, 419 (2002)

He + C	Reflection	0.50-3.00 keV	Ex
He + Si	Reflection	0.50-3.00 keV	Ex
He + Ag	Reflection	0.50-3.00 keV	Ex
He + Sn	Reflection	0.50-3.00 keV	Ex
He + Sb	Reflection	0.50-3.00 keV	Ex
He + Pb	Reflection	0.50-3.00 keV	Ex
He + Bi	Reflection	0.50-3.00 keV	Ex
He ⁺ + C	Reflection	0.50-3.00 keV	Ex
He ⁺ + Si	Reflection	0.50-3.00 keV	Ex
He ⁺ + Ag	Reflection	0.50-3.00 keV	Ex
He ⁺ + Sn	Reflection	0.50-3.00 keV	Ex
He ⁺ + Sb	Reflection	0.50-3.00 keV	Ex
He ⁺ + Pb	Reflection	0.50-3.00 keV	Ex
He ⁺ + Bi	Reflection	0.50-3.00 keV	Ex
1172. R. Souda
Charge transfer processes during ion scattering and stimulated desorption of secondary ions from gas-condensed dielectric surfaces.
 Nucl. Instrum. Methods Phys. Res. B **193**, 433 (2002)

e + H ₂ O + Ar	Desorption	100.00-500.00 eV	Ex
H ⁺ + H ₂ O	Reflection	100.00-500.00 eV	Ex
H ⁺ + CO	Reflection	100.00-500.00 eV	Ex
H ⁺ + Ar	Reflection	100.00-500.00 eV	Ex
H ⁺ + Kr	Reflection	100.00-500.00 eV	Ex
H ⁺ + Xe	Reflection	100.00-500.00 eV	Ex

1173. J. E. Gayone, E. A. Sanchez, O. Grizzi, L. I. Vergara, Jr. Passeggi, M.C.G., R. Vidal, J. Ferron
Recoil-ion fractions in collisions of keV Ar⁺ and Kr⁺ ions with clean and adsorbate covered GaAs(110) surfaces.
 Nucl. Instrum. Methods Phys. Res. B **193**, 440 (2002)

Ar ⁺ + GaAs	Sputtering	5.00 keV	Ex
Kr ⁺ + GaAs	Sputtering	5.00 keV	Ex
1174. G. G. Ross, M. Gauthier
Experimental charge fractions of hydrogen scattered from insulators at 50-340 keV.
 Nucl. Instrum. Methods Phys. Res. B **193**, 449 (2002)

H ⁺ + Si	Reflection	50.00-340.00 keV	Ex
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1175. J. Dai, J. R. Manson
Classical theory for scattering of rigid molecules from surfaces.
 Nucl. Instrum. Methods Phys. Res. B **193**, 497 (2002)

C ₂ H ₂ + LiF	Reflection	242.00 meV	Th
C ₂ H ₂ + LiF	Reflection	242.00 meV	Th
1176. F. W. Meyer, V. A. Morozov, J. Mrogenda, C. R. Vane, S. Datz
Large-angle back-scattering of Ar^{q+} (q=1-13) during quasi-binary collisions with CsI(100) in the energy range 10 eV/q-2.8 keV/q: Energy loss analysis and scattered charge state distributions.
 Nucl. Instrum. Methods Phys. Res. B **193**, 508 (2002)

Ar ⁺ + CsI	Reflection	3.00-30.00 keV	Ex
Ar ²⁺ + CsI	Reflection	3.00-30.00 keV	Ex
Ar ³⁺ + CsI	Reflection	3.00-30.00 keV	Ex
Ar ⁴⁺ + CsI	Reflection	3.00-30.00 keV	Ex
Ar ⁵⁺ + CsI	Reflection	3.00-30.00 keV	Ex
Ar ⁶⁺ + CsI	Reflection	3.00-30.00 keV	Ex
Ar ⁷⁺ + CsI	Reflection	3.00-30.00 keV	Ex
Ar ⁸⁺ + CsI	Reflection	3.00-30.00 keV	Ex
Ar ⁹⁺ + CsI	Reflection	3.00-30.00 keV	Ex
Ar ¹⁰⁺ + CsI	Reflection	3.00-30.00 keV	Ex
Ar ¹¹⁺ + CsI	Reflection	3.00-30.00 keV	Ex
1177. N. Stolterfoht, J. H. Bremer, V. Hoffmann, M. Roesler, R. A. Baragiola
Auger transitions and plasmon decay produced by hollow atoms at an Al(111) surface.
 Nucl. Instrum. Methods Phys. Res. B **193**, 523 (2002)

Ne ⁴⁺ + Al	Second. Elect. Emission	1.00-4.00 keV	Ex
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1178. F. W. Meyer, V. A. Morozov
Comparative study of surface-lattice-site resolved neutralization of slow multicharged ions during large-angle quasi-binary collisions with Au(110): Simulation and experiment.
 Nucl. Instrum. Methods Phys. Res. B **193**, 530 (2002)

Ar ⁹⁺ + Au	Reflection	20.00 keV	Ex
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1179. Z. M. Luo, C. Gou, Q. Hou
Theoretical calculations of the self-reflection coefficients for some species of ions.
 Nucl. Instrum. Methods Phys. Res. B **193**, 576 (2002)

Li ⁺ + Li	Reflection	0.00-1.00 keV	Th
Be ⁺ + Be	Reflection	0.00-1.00 keV	Th
B ⁺ + B	Reflection	0.00-1.00 keV	Th
C ⁺ + C	Reflection	0.00-1.00 keV	Th
Si ⁺ + Si	Reflection	0.00-1.00 keV	Th
Ni ⁺ + Ni	Reflection	0.00-1.00 keV	Th
Mo ⁺ + Mo	Reflection	0.00-1.00 keV	Th
W ⁺ + W	Reflection	0.00-1.00 keV	Th

1180. M. Alducin, V. M. Silkin, J. I. Juaristi, E. V. Chulkov
Effect of surface band structure in the energy loss of ions at surfaces.
 Nucl. Instrum. Methods Phys. Res. B **193**, 585 (2002)
 $\text{H}^+ + \text{Cu}$ Reflection 8.00-25.00 keV Th
1181. S. Cernusca, A. Diem, HP. Winter, F. Aumayr, J. Loerincik, Z. Sroubek
Kinetic electron emission from highly oriented pyrolytic graphite surfaces induced by singly charged ions.
 Nucl. Instrum. Methods Phys. Res. B **193**, 616 (2002)
 $\text{H}^+ + \text{C}$ Second. Elect. Emission 0.10-5.00 keV Ex
 $\text{H}_2^+ + \text{C}$ Second. Elect. Emission 0.10-5.00 keV Ex
 $\text{H}_3^+ + \text{C}$ Second. Elect. Emission 0.10-5.00 keV Ex
 $\text{C}^+ + \text{C}$ Second. Elect. Emission 0.10-5.00 keV Ex
 $\text{N}^+ + \text{C}$ Second. Elect. Emission 0.10-5.00 keV Ex
 $\text{O}^+ + \text{C}$ Second. Elect. Emission 0.10-5.00 keV Ex
1182. A. Dubus, N. Pauly, M. Roesler, H. Rothard, M. Beuve, M. Caron, B. Gervais, A. Clouvas, C. Potiradis
Experimental and theoretical study of the ratio between the electron emission yield and the electronic stopping power for protons incident on thin carbon foils.
 Nucl. Instrum. Methods Phys. Res. B **193**, 621 (2002)
 $\text{H}^+ + \text{C}$ Second. Elect. Emission 0.20-9.20 MeV E/T
1183. A. Itoh, T. Majima, F. Obata, Y. Hamamoto, A. Yogo
Secondary electron emission from Au by medium energy atomic and molecular ions.
 Nucl. Instrum. Methods Phys. Res. B **193**, 626 (2002)
 $\text{H}^+ + \text{Au}$ Second. Elect. Emission 0.20-3.00 MeV Ex
 $\text{H}_2^+ + \text{Au}$ Second. Elect. Emission 0.20-3.00 MeV Ex
 $\text{H}_3^+ + \text{Au}$ Second. Elect. Emission 0.20-3.00 MeV Ex
 $\text{He}^+ + \text{Au}$ Second. Elect. Emission 0.20-3.00 MeV Ex
 $\text{HeH}^+ + \text{Au}$ Second. Elect. Emission 0.20-3.00 MeV Ex
 $\text{C}^+ + \text{Au}$ Second. Elect. Emission 0.20-3.00 MeV Ex
 $\text{N}^+ + \text{Au}$ Second. Elect. Emission 0.20-3.00 MeV Ex
 $\text{O}^+ + \text{Au}$ Second. Elect. Emission 0.20-3.00 MeV Ex
 $\text{O}_2^+ + \text{Au}$ Second. Elect. Emission 0.20-3.00 MeV Ex
 $\text{Co}^+ + \text{Au}$ Second. Elect. Emission 0.20-3.00 MeV Ex
1184. M. Steinbatz, A. Schinner, E. Steinbauer, O. Benka
Electron emission yield from thin Al and insulating layers induced by 3 MeV He^{2+} and 3 keV electron impact.
 Nucl. Instrum. Methods Phys. Res. B **193**, 638 (2002)
 $\text{e} + \text{Al}$ Second. Elect. Emission 3.00 MeV; 3 keV Ex
 $\text{e} + \text{Al}_2\text{O}_3$ Second. Elect. Emission 3.00 MeV; 3 keV Ex
 $\text{e} + \text{Cu}$ Second. Elect. Emission 3.00 MeV; 3 keV Ex
 $\text{e} + \text{CeO}_2$ Second. Elect. Emission 3.00 MeV; 3 keV Ex
 $\text{e} + \text{CaF}_2$ Second. Elect. Emission 3.00 MeV; 3 keV Ex
 $\text{He}^{2+} + \text{Al}$ Second. Elect. Emission 3.00 MeV; 3 keV Ex
 $\text{He}^{2+} + \text{Al}_2\text{O}_3$ Second. Elect. Emission 3.00 MeV; 3 keV Ex
 $\text{He}^{2+} + \text{Cu}$ Second. Elect. Emission 3.00 MeV; 3 keV Ex
 $\text{He}^{2+} + \text{CeO}_2$ Second. Elect. Emission 3.00 MeV; 3 keV Ex
 $\text{He}^{2+} + \text{CaF}_2$ Second. Elect. Emission 3.00 MeV; 3 keV Ex
1185. J. Stoeckl, HP. Winter, F. Aumayr, S. Lederer, A. Mertens, K. Maass, H. Winter
Formation of surface excitons and electron emission during grazing impact of hydrogen atoms on LiF(001).
 Nucl. Instrum. Methods Phys. Res. B **193**, 645 (2002)
 $\text{H} + \text{LiF}$ Second. Elect. Emission 0.30-1.50 keV Ex

1186. T. Zapfel, S. Hagmann, H. Rothard, J. Ullrich, G. Kraft, H. Schmidt-Boecking, K. O. Groeneveld
Experimental study of electron ejection by heavy ion irradiation of solids: Observation of forward and backward emitted electron jets.
 Nucl. Instrum. Methods Phys. Res. B **193**, 651 (2002)
- | | | | |
|-----------------------------|-------------------------|-------------------|----|
| $\text{F}^{5+} + \text{C}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{5+} + \text{Al}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{5+} + \text{Au}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{6+} + \text{C}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{6+} + \text{Al}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{6+} + \text{Au}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{7+} + \text{C}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{7+} + \text{Al}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{7+} + \text{Au}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{8+} + \text{C}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{8+} + \text{Al}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{8+} + \text{Au}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{9+} + \text{C}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{9+} + \text{Al}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
| $\text{F}^{9+} + \text{Au}$ | Second. Elect. Emission | 1.50-2.00 MeV/amu | Ex |
1187. J. C. Lancaster, F. J. Kontur, P. Nordlander, G. K. Walters, F. B. Dunning
The dynamics of He^+ ion neutralization at metal surfaces: spin dependent studies.
 Nucl. Instrum. Methods Phys. Res. B **193**, 656 (2002)
- | | | | |
|---------------------------|-----------------------------|-----------------|----|
| $\text{He}^+ + \text{Al}$ | Second. Elect. Emission | 16.00-500.00 eV | Ex |
| $\text{He}^+ + \text{Cu}$ | Second. Elect. Emission | 16.00-500.00 eV | Ex |
| $\text{He}^+ + \text{Au}$ | Second. Elect. Emission | 16.00-500.00 eV | Ex |
| $\text{He}^+ + \text{Al}$ | Neutraliz., Ioniz., Dissoc. | 16.00-500.00 eV | Ex |
| $\text{He}^+ + \text{Cu}$ | Neutraliz., Ioniz., Dissoc. | 16.00-500.00 eV | Ex |
| $\text{He}^+ + \text{Au}$ | Neutraliz., Ioniz., Dissoc. | 16.00-500.00 eV | Ex |
1188. K. Kimura, S. Usui, K. Maeda, K. Nakajima
Ion scattering on crystalline surfaces: Effects of surface track potential on secondary electron emission.
 Nucl. Instrum. Methods Phys. Res. B **193**, 661 (2002)
- | | | | |
|--------------------------------|-------------------------|--------------|----|
| $\text{H}^+ + \text{SnTe}$ | Reflection | 0.50 MeV/amu | Ex |
| $\text{H}^+ + \text{KCl}$ | Reflection | 0.50 MeV/amu | Ex |
| $\text{He}^{2+} + \text{SnTe}$ | Reflection | 0.50 MeV/amu | Ex |
| $\text{He}^{2+} + \text{KCl}$ | Reflection | 0.50 MeV/amu | Ex |
| $\text{Li}^{2+} + \text{SnTe}$ | Reflection | 0.50 MeV/amu | Ex |
| $\text{Li}^{2+} + \text{KCl}$ | Reflection | 0.50 MeV/amu | Ex |
| $\text{H}^+ + \text{SnTe}$ | Second. Elect. Emission | 0.50 MeV/amu | Ex |
| $\text{H}^+ + \text{KCl}$ | Second. Elect. Emission | 0.50 MeV/amu | Ex |
| $\text{He}^{2+} + \text{SnTe}$ | Second. Elect. Emission | 0.50 MeV/amu | Ex |
| $\text{He}^{2+} + \text{KCl}$ | Second. Elect. Emission | 0.50 MeV/amu | Ex |
| $\text{Li}^{2+} + \text{SnTe}$ | Second. Elect. Emission | 0.50 MeV/amu | Ex |
| $\text{Li}^{2+} + \text{KCl}$ | Second. Elect. Emission | 0.50 MeV/amu | Ex |
1189. J. A. Yarmoff, H. T. Than, Z. Sroubek
The role of adsorbates in the Na^+ -induced kinetic emission of electrons from $\text{Ru}(0001)$.
 Nucl. Instrum. Methods Phys. Res. B **193**, 667 (2002)
- | | | | |
|---------------------------------------|-------------------------|---------------|----|
| $\text{Na}^+ + \text{Na} + \text{Ru}$ | Second. Elect. Emission | 0.12-1.62 keV | Ex |
| $\text{Na}^+ + \text{Cl} + \text{Ru}$ | Second. Elect. Emission | 0.12-1.62 keV | Ex |
| $\text{Na}^+ + \text{Ru}$ | Second. Elect. Emission | 0.12-1.62 keV | Ex |
| $\text{Na}^+ + \text{I} + \text{Ru}$ | Second. Elect. Emission | 0.12-1.62 keV | Ex |

1190. A. A. Dzhurakhalov, V. Kh. Ferleger, S. E. Rahmatov, N. A. Teshabaeva
Polarization of radiation of particles scattered under grazing angles from metal surfaces with submonolayer oxygen coverage.
 Nucl. Instrum. Methods Phys. Res. B **193**, 695 (2002)
- | | | | |
|-------------|------------|-----------------|----|
| $H^+ + Ni$ | Reflection | 25.00-80.00 keV | Th |
| $Ar^+ + Ni$ | Reflection | 25.00-80.00 keV | Th |
1191. I. S. Sharodi, Y. A. Bandurin, S. S. Pop
Ion-photon emission during ion bombardment of beryllium surface.
 Nucl. Instrum. Methods Phys. Res. B **193**, 699 (2002)
- | | | | |
|--------------|----------------------|----------------|----|
| $H^+ + Be$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $H_2^+ + Be$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $H_3^+ + Be$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $He^+ + Be$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $Ne^+ + Be$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $Kr^+ + Be$ | Surface Interactions | 5.00-20.00 keV | Ex |
| $H^+ + Be$ | Reflection | 5.00-20.00 keV | Ex |
| $H_2^+ + Be$ | Reflection | 5.00-20.00 keV | Ex |
| $H_3^+ + Be$ | Reflection | 5.00-20.00 keV | Ex |
| $He^+ + Be$ | Reflection | 5.00-20.00 keV | Ex |
| $Ne^+ + Be$ | Reflection | 5.00-20.00 keV | Ex |
| $Kr^+ + Be$ | Reflection | 5.00-20.00 keV | Ex |
1192. R. Pfandzelter, H. Winter
Emission of spin-polarized electrons during grazing scattering of multiply charged N ions from a Fe(100) surface.
 Nucl. Instrum. Methods Phys. Res. B **193**, 713 (2002)
- | | | | |
|---------------|-------------------------|------------|----|
| $N^+ + Fe$ | Second. Elect. Emission | 150.00 keV | Ex |
| $N^{2+} + Fe$ | Second. Elect. Emission | 150.00 keV | Ex |
| $N^{4+} + Fe$ | Second. Elect. Emission | 150.00 keV | Ex |
| $N^{5+} + Fe$ | Second. Elect. Emission | 150.00 keV | Ex |
| $N^{6+} + Fe$ | Second. Elect. Emission | 150.00 keV | Ex |
1193. N. G. van der Berg, B. Malherbe, R. Q. Odendaal, S. A. Goodman, K. Premachandra
Argon bombardment-induced topography and sputter yields on $Si_{0.84}Ge_{0.16}$.
 Nucl. Instrum. Methods Phys. Res. B **193**, 739 (2002)
- | | | | |
|-------------|------------|---------------|----|
| $Ar^+ + Si$ | Sputtering | 0.50-5.00 keV | Ex |
| $Ar^+ + Ge$ | Sputtering | 0.50-5.00 keV | Ex |
1194. S. Ninomiya, N. Imanishi, J. Xue, S. Gomi, M. Imai
Material-dependent emission mechanism of secondary atomic ions from solids under MeV-energy heavy ion bombardment.
 Nucl. Instrum. Methods Phys. Res. B **193**, 745 (2002)
- | | | | |
|---------------|------------|---------------|----|
| $Si^+ + Al$ | Sputtering | 0.50-5.00 MeV | Ex |
| $Si^+ + Si$ | Sputtering | 0.50-5.00 MeV | Ex |
| $Si^+ + GaAs$ | Sputtering | 0.50-5.00 MeV | Ex |
| $Si^+ + GaP$ | Sputtering | 0.50-5.00 MeV | Ex |
1195. T. Sekioka, M. Terasawa, M. Sataka, S. Kitazawa, M. Niibe
Electronic excitation effects on secondary ion emission from a foil of conducting material bombarded by high energy heavy ions.
 Nucl. Instrum. Methods Phys. Res. B **193**, 751 (2002)
- | | | | |
|-------------|------------|-------------------|----|
| $Au^+ + Cu$ | Sputtering | 100.00-300.00 MeV | Ex |
| $Au^+ + Au$ | Sputtering | 100.00-300.00 MeV | Ex |

1196. T. Jalowy, R. Neugebauer, M. Hattass, J. Fiol, F. Afaneh, J.A.M. Pereira, V. Collado, E. F. da Silveira, H. Schmidt-Boecking, K. O. Groeneveld
Dynamics of secondary ion emission: Novel energy and angular spectrometry.
 Nucl. Instrum. Methods Phys. Res. B **193**, 762 (2002)

$\text{Ar} + \text{H}_2 + \text{Al}$	Desorption	570.00 keV	Ex
$\text{Ar} + \text{H}_2 + \text{Al}$	Sputtering	570.00 keV	Ex
1197. M. Fama, D. A. Bahr, B. D. Teolis, A. Baragiola
Ion beam induced chemistry: the case of ozone synthesis and its influence on the sputtering of solid oxygen.
 Nucl. Instrum. Methods Phys. Res. B **193**, 775 (2002)

$\text{H}^+ + \text{O}_2$	Chemical Reactions	100.00 keV	Ex
$\text{H}^+ + \text{O}_2$	Sputtering	100.00 keV	Ex
1198. R. Heinrich, A. Wucher
Self-sputtering of silver using polyatomic projectiles.
 Nucl. Instrum. Methods Phys. Res. B **193**, 781 (2002)

$\text{Ag}^+ + \text{Ag}$	Sputtering	21.00 keV	Ex
$\text{Ag}_2^+ + \text{Ag}$	Sputtering	21.00 keV	Ex
$\text{Ag}_3^+ + \text{Ag}$	Sputtering	21.00 keV	Ex
1199. C. Staudt, A. Wucher, S. Neukermans, E. Janssens, F. Vanhoutte, E. Vandeweert, R. E. Silverans, P. Lievens
Internal excitation of sputtered neutral indium clusters.
 Nucl. Instrum. Methods Phys. Res. B **193**, 787 (2002)

$\text{Xe}^+ + \text{In}$	Sputtering	15.00 keV	Ex
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1200. E. E. Zhurkin, A. S. Kolesnikov
Molecular dynamics study of Al and Ni₃Al sputtering by Al clusters bombardment.
 Nucl. Instrum. Methods Phys. Res. B **193**, 822 (2002)

$\text{Al}_2^+ + \text{Al}$	Sputtering	0.20-1.00 keV	Th
$\text{Al}_2^+ + \text{Ni}_3\text{Al}$	Sputtering	0.20-1.00 keV	Th
1201. N. Matsunami, M. Sataka, A. Iwase
Electronic sputtering of oxides by high energy heavy ion impact.
 Nucl. Instrum. Methods Phys. Res. B **193**, 830 (2002)

$\text{Ni}^+ + \text{SiO}_2$	Sputtering	89.00 MeV	Ex
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1202. M. A. Karolewski
Classical dynamics simulations of directional effects in sputtering from a bimetallic surface: c(2x2)-Pb/Cu(100).
 Nucl. Instrum. Methods Phys. Res. B **194**, 26 (2002)

$\text{Ar}^+ + \text{Cu}$	Sputtering	3.00 keV	Th
$\text{Ar}^+ + \text{Pb}$	Sputtering	3.00 keV	Th
1203. H. S. Cruz-Galindo, K. Michaelian, A. Martinez-Davalos, E. Belmont-Moreno, S. Galindo
Luminescence model with quantum impact parameter for low energy ions.
 Nucl. Instrum. Methods Phys. Res. B **194**, 319 (2002)

$\text{H}^+ + \text{CsI}$	Surface Interactions	20.00 MeV	Th
$\text{He}^+ + \text{CsI}$	Surface Interactions	20.00 MeV	Th
$\text{C}^+ + \text{CsI}$	Surface Interactions	20.00 MeV	Th
1204. D. R. Gillen, W. G. Graham, A. Goelich
Sputtering of copper atoms by keV atomic and molecular ions: A comparison of experiment with analytical and computer based models.
 Nucl. Instrum. Methods Phys. Res. B **194**, 409 (2002)

- | | | | |
|-----------------------------|------------|---------------|----|
| $\text{CF}_2^+ + \text{Cu}$ | Sputtering | 1.80-3.60 keV | Ex |
| $\text{N}^+ + \text{Cu}$ | Sputtering | 1.80-3.60 keV | Ex |
| $\text{Ar}^+ + \text{Cu}$ | Sputtering | 1.80-3.60 keV | Ex |
1205. M. H. Shapiro, T. A. Tombrello
Simulation of sputtering following ion bombardment at a target step.
Nucl. Instrum. Methods Phys. Res. B **194**, 425 (2002)
- | | | | |
|---------------------------|------------|----------|----|
| $\text{Ar}^+ + \text{Cu}$ | Sputtering | 5.00 keV | Th |
|---------------------------|------------|----------|----|
1206. G. Lanzano, E. De Filippo, D. Mahboub, H. Rothard, S. Aiello, A. Anzalone, S. Cavallaro, A. Elanique, E. Geraci, M. Geraci, F. Giustolisi, A. Pagano, G. Politi
Ejection of fast electrons following the impact of 45 MeV/u $^{58}\text{Ni}^{q+}$ (q=19,28) on solid-foil targets.
Phys. Rev. A **63**, 032702 (2001)
- | | | | |
|-------------------------------|-------------------------|---------------|----|
| $\text{Ni}^{19+} + \text{C}$ | Second. Elect. Emission | 45.00 MeV/amu | Ex |
| $\text{Ni}^{19+} + \text{Al}$ | Second. Elect. Emission | 45.00 MeV/amu | Ex |
| $\text{Ni}^{19+} + \text{Au}$ | Second. Elect. Emission | 45.00 MeV/amu | Ex |
| $\text{Ni}^{28+} + \text{C}$ | Second. Elect. Emission | 45.00 MeV/amu | Ex |
| $\text{Ni}^{28+} + \text{Al}$ | Second. Elect. Emission | 45.00 MeV/amu | Ex |
| $\text{Ni}^{28+} + \text{Ni}$ | Second. Elect. Emission | 45.00 MeV/amu | Ex |
| $\text{Ni}^{28+} + \text{Ag}$ | Second. Elect. Emission | 45.00 MeV/amu | Ex |
| $\text{Ni}^{28+} + \text{Au}$ | Second. Elect. Emission | 45.00 MeV/amu | Ex |
1207. N. P. Wang, E. A. Garcia, R. C. Monreal, F. Flores, E. C. Goldberg, H. H. Brongersma, P. Bauer
Low-energy ion neutralization at surfaces: Resonant and Auger processes.
Phys. Rev. A **64**, 012901 (2001)
- | | | | |
|---------------------------|-----------------------------|---------------|----|
| $\text{He}^+ + \text{Al}$ | Neutraliz., Ioniz., Dissoc. | 0.10-3.00 keV | Th |
| $\text{He}^+ + \text{Pd}$ | Neutraliz., Ioniz., Dissoc. | 0.10-3.00 keV | Th |
1208. D. G. Arbo, M. S. Gravielle, J. E. Miraglia
Second-order dielectric stopping of ions in a free-electron gas.
Phys. Rev. A **64**, 022902 (2001)
- | | | | |
|--------------------------|-----------------------------|------------|----|
| $\text{H} + \text{Al}$ | Adsorption, Desorption | 100.00 keV | Th |
| $\text{H}^+ + \text{Al}$ | Adsorption, Desorption | 100.00 keV | Th |
| $\text{H} + \text{Al}$ | Neutraliz., Ioniz., Dissoc. | 100.00 keV | Th |
| $\text{H}^+ + \text{Al}$ | Neutraliz., Ioniz., Dissoc. | 100.00 keV | Th |
1209. P. Karmakar, P. Agarwal, P. Y. Nabhiraj, D. K. Bose, R. K. Bhandari, D. Ghose
Secondary-electron emission from a single-crystalline aluminum surface induced by multiply charged oxygen ions.
Phys. Rev. A **64**, 034901 (2001)
- | | | | |
|-----------------------------|-------------------------|-----------|----|
| $\text{O}^+ + \text{Al}$ | Second. Elect. Emission | 0.60 a.u. | Ex |
| $\text{O}^{2+} + \text{Al}$ | Second. Elect. Emission | 0.60 a.u. | Ex |
| $\text{O}^{3+} + \text{Al}$ | Second. Elect. Emission | 0.60 a.u. | Ex |
| $\text{O}^{4+} + \text{Al}$ | Second. Elect. Emission | 0.60 a.u. | Ex |
| $\text{O}^{5+} + \text{Al}$ | Second. Elect. Emission | 0.60 a.u. | Ex |
| $\text{O}^{6+} + \text{Al}$ | Second. Elect. Emission | 0.60 a.u. | Ex |
| $\text{O}^{7+} + \text{Al}$ | Second. Elect. Emission | 0.60 a.u. | Ex |
1210. K. Tokesi, L. Wirtz, C. Lemell, J. Burgdoerfer
Hollow-ion formation in microcapillaries.
Phys. Rev. A **64**, 042902 (2001)
- | | | | |
|-------------------------------|------------|--------------|----|
| $\text{N}^{6+} + \text{Ni}$ | Reflection | 2.10 keV/amu | Th |
| $\text{Ne}^{10+} + \text{Ni}$ | Reflection | 2.10 keV/amu | Th |

1211. M. S. Gravielle, J. E. Miraglia

Energy and electron spectra after grazing-ion-surface collisions.

Phys. Rev. A **65**, 022901 (2002)

$H^+ + Al$	Reflection	700.00 keV	Th
$H^+ + Al$	Second. Elect. Emission	700.00 keV	Th

1212. G. A. Machicoane, T. Schenkel, T. R. Niedermayr, M. W. Newmann, A. V. Hamza, A. V. Barnes, J. W. McDonald, J. A. Tanis, D. H. Schneider

Internal dielectronic excitation in highly charged ions colliding with surfaces.

Phys. Rev. A **65**, 042903 (2002)

$Xe^{26+} + C$	Surface Interactions	182.00-441.00 keV	Ex
$Xe^{26+} + Si$	Surface Interactions	182.00-441.00 keV	Ex
$Xe^{26+} + SiO_2$	Surface Interactions	182.00-441.00 keV	Ex
$Xe^{26+} + Ag$	Surface Interactions	182.00-441.00 keV	Ex
$Xe^{26+} + Au$	Surface Interactions	182.00-441.00 keV	Ex
$Xe^{27+} + C$	Surface Interactions	182.00-441.00 keV	Ex
$Xe^{27+} + Si$	Surface Interactions	182.00-441.00 keV	Ex
$Xe^{27+} + SiO_2$	Surface Interactions	182.00-441.00 keV	Ex
$Xe^{27+} + Ag$	Surface Interactions	182.00-441.00 keV	Ex
$Xe^{27+} + Au$	Surface Interactions	182.00-441.00 keV	Ex
$Ho^{39+} + C$	Surface Interactions	182.00-441.00 keV	Ex
$Ho^{39+} + Si$	Surface Interactions	182.00-441.00 keV	Ex
$Ho^{39+} + SiO_2$	Surface Interactions	182.00-441.00 keV	Ex
$Ho^{39+} + Ag$	Surface Interactions	182.00-441.00 keV	Ex
$Ho^{39+} + Au$	Surface Interactions	182.00-441.00 keV	Ex
$Ho^{40+} + C$	Surface Interactions	182.00-441.00 keV	Ex
$Ho^{40+} + Si$	Surface Interactions	182.00-441.00 keV	Ex
$Ho^{40+} + SiO_2$	Surface Interactions	182.00-441.00 keV	Ex
$Ho^{40+} + Ag$	Surface Interactions	182.00-441.00 keV	Ex
$Ho^{40+} + Au$	Surface Interactions	182.00-441.00 keV	Ex
$Au^{51+} + C$	Surface Interactions	182.00-441.00 keV	Ex
$Au^{51+} + Si$	Surface Interactions	182.00-441.00 keV	Ex
$Au^{51+} + SiO_2$	Surface Interactions	182.00-441.00 keV	Ex
$Au^{51+} + Ag$	Surface Interactions	182.00-441.00 keV	Ex
$Au^{51+} + Au$	Surface Interactions	182.00-441.00 keV	Ex
$Au^{52+} + C$	Surface Interactions	182.00-441.00 keV	Ex
$Au^{52+} + Si$	Surface Interactions	182.00-441.00 keV	Ex
$Au^{52+} + SiO_2$	Surface Interactions	182.00-441.00 keV	Ex
$Au^{52+} + Ag$	Surface Interactions	182.00-441.00 keV	Ex
$Au^{52+} + Au$	Surface Interactions	182.00-441.00 keV	Ex
$Th^{62+} + C$	Surface Interactions	182.00-441.00 keV	Ex
$Th^{62+} + Si$	Surface Interactions	182.00-441.00 keV	Ex
$Th^{62+} + SiO_2$	Surface Interactions	182.00-441.00 keV	Ex
$Th^{62+} + Ag$	Surface Interactions	182.00-441.00 keV	Ex
$Th^{62+} + Au$	Surface Interactions	182.00-441.00 keV	Ex
$Th^{63+} + C$	Surface Interactions	182.00-441.00 keV	Ex
$Th^{63+} + Si$	Surface Interactions	182.00-441.00 keV	Ex
$Th^{63+} + SiO_2$	Surface Interactions	182.00-441.00 keV	Ex
$Th^{63+} + Ag$	Surface Interactions	182.00-441.00 keV	Ex
$Th^{63+} + Au$	Surface Interactions	182.00-441.00 keV	Ex
$Xe^{26+} + C$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$Xe^{26+} + Si$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$Xe^{26+} + SiO_2$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$Xe^{26+} + Ag$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$Xe^{26+} + Au$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$Xe^{27+} + C$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$Xe^{27+} + Si$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex

$\text{Xe}^{27+} + \text{SiO}_2$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Xe}^{27+} + \text{Ag}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Xe}^{27+} + \text{Au}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Ho}^{39+} + \text{C}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Ho}^{39+} + \text{Si}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Ho}^{39+} + \text{SiO}_2$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Ho}^{39+} + \text{Ag}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Ho}^{39+} + \text{Au}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Ho}^{40+} + \text{C}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Ho}^{40+} + \text{Si}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Ho}^{40+} + \text{SiO}_2$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Ho}^{40+} + \text{Ag}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Ho}^{40+} + \text{Au}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Au}^{51+} + \text{C}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Au}^{51+} + \text{Si}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Au}^{51+} + \text{SiO}_2$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Au}^{51+} + \text{Ag}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Au}^{51+} + \text{Au}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Au}^{52+} + \text{C}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Au}^{52+} + \text{Si}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Au}^{52+} + \text{SiO}_2$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Au}^{52+} + \text{Ag}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Au}^{52+} + \text{Au}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Th}^{62+} + \text{C}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Th}^{62+} + \text{Si}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Th}^{62+} + \text{SiO}_2$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Th}^{62+} + \text{Ag}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Th}^{62+} + \text{Au}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Th}^{63+} + \text{C}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Th}^{63+} + \text{Si}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Th}^{63+} + \text{SiO}_2$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Th}^{63+} + \text{Ag}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex
$\text{Th}^{63+} + \text{Au}$	Neutraliz., Ioniz., Dissoc.	182.00-441.00 keV	Ex

1213. J. Loerincik, Z. Sroubek, H. Eder, F. Aumayr, HP. Winter

Kinetic electron emission from clean polycrystalline gold induced by impact of slow C^+ , N^+ , O^+ , Ne^+ , and Au^+ ions.

Phys. Rev. B **62**, 16116 (2000)

$\text{C}^+ + \text{Au}$	Second. Elect. Emission	0.10-30.00 keV	Th
$\text{N}^+ + \text{Au}$	Second. Elect. Emission	0.10-30.00 keV	Th
$\text{O}^+ + \text{Au}$	Second. Elect. Emission	0.10-30.00 keV	Th
$\text{Ne}^+ + \text{Au}$	Second. Elect. Emission	0.10-30.00 keV	Th
$\text{Xe}^+ + \text{Au}$	Second. Elect. Emission	0.10-30.00 keV	Th
$\text{Au}^+ + \text{Au}$	Second. Elect. Emission	0.10-30.00 keV	Th

1214. A. C. Lavery, C. E. Sosolik, B. H. Cooper

Surface trapping during hyperthermal energy scattering.

Phys. Rev. B **62**, 16126 (2000)

$\text{O} + \text{Cu}$	Adsorption, Desorption	600.00 eV	E/T
$\text{Na} + \text{Cu}$	Adsorption, Desorption	600.00 eV	E/T
$\text{O} + \text{Cu}$	Trapping, Detrapping	600.00 eV	E/T
$\text{Na} + \text{Cu}$	Trapping, Detrapping	600.00 eV	E/T
$\text{O} + \text{Cu}$	Reflection	600.00 eV	E/T
$\text{Na} + \text{Cu}$	Reflection	600.00 eV	E/T

1215. Y. Tang, J. R. Manson, K.-H. Rieder

Detection of high-energy adsorbate vibrational modes by atom-surface scattering.

Phys. Rev. B **62**, 17120 (2000)

He + C₂H₂ + Cu	Reflection	1.00 eV	Th
He + CO + Cu	Reflection	1.00 eV	Th
Ne + C₂H₂ + Cu	Reflection	1.00 eV	Th
Ne + CO + Cu	Reflection	1.00 eV	Th

1216. M. M. Albert, N. H. Tolk

Absolute total cross sections for electron-stimulated desorption of hydrogen and deuterium from silicon(111) measured by second harmonic generation.

Phys. Rev. B **63**, 035308 (2001)

e + H + Si	Desorption	50.00-300.00 eV	Ex
e + (D + Si)	Desorption	50.00-300.00 eV	Ex

1217. A. Hoffman, A. Laikhtman, S. Ustaze, M. H. Hamou, M. N. Hedhili, J. P. Guillotin, Y. Le Coat, D. Teillet-Billy, R. Azria

Dissociative electron attachment and dipolar dissociation of H⁻ electron stimulated desorption from hydrogenated diamond films.

Phys. Rev. B **63**, 045401 (2001)

e + H + C	Desorption	2.00-45.00 eV	Ex
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1218. A. G. Borisov, J. P. Gauyacq, V. Sidis, A. K. Kazansky

Negative-ion conversion of fluorine atoms in grazing scattering from a LiF(001) surface: A coupled cluster approach.

Phys. Rev. B **63**, 045407 (2001)

F + LiF	Neutraliz., Ioniz., Dissoc.		Th
F + LiF	Reflection		Th

1219. K. Sekar, J. Scheer, K. Bruening, W. Heiland, I. A. Wojciechowski, V. Kh. Ferleger

Interaction of molecular hydrogen ions with the LiF(100) surface.

Phys. Rev. B **63**, 045411 (2001)

H₂⁺ + LiF	Neutraliz., Ioniz., Dissoc.	0.60-4.00 keV	Ex
H₂⁺ + LiF	Reflection	0.60-4.00 keV	Ex

1220. H. Gnaser

Ionization probability of sputtered negative cluster ions: Dependence on surface work function and emission velocity.

Phys. Rev. B **63**, 045415 (2001)

Cs⁺ + C	Sputtering	14.50 keV	Ex
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1221. R. Souda

Ion-surface charge exchange during sputtering and low-energy H⁺ scattering from Ar, Kr, and Xe layers formed on metal surfaces.

Phys. Rev. B **63**, 113407 (2001)

H⁺ + Ar	Reflection	0.10-2.00 keV	Ex
H⁺ + Kr	Reflection	0.10-2.00 keV	Ex
H⁺ + Xe	Reflection	0.10-2.00 keV	Ex
Ar⁺ + Ar	Reflection	0.10-2.00 keV	Ex
Ar⁺ + Kr	Reflection	0.10-2.00 keV	Ex
Ar⁺ + Xe	Reflection	0.10-2.00 keV	Ex
H⁺ + Ar	Sputtering	0.10-2.00 keV	Ex
H⁺ + Kr	Sputtering	0.10-2.00 keV	Ex
H⁺ + Xe	Sputtering	0.10-2.00 keV	Ex
Ar⁺ + Ar	Sputtering	0.10-2.00 keV	Ex
Ar⁺ + Kr	Sputtering	0.10-2.00 keV	Ex
Ar⁺ + Xe	Sputtering	0.10-2.00 keV	Ex

1222. M. Li, J. R. Manson, A. P. Graham
Experimental and theoretical analysis of the multiphonon excitation probability for Einstein-like modes in atom-surface scattering.
 Phys. Rev. B **63**, 155410 (2001)
- | | | | |
|---------------------------------------|--------------------|-----------|-----|
| $\text{He}^+ + \text{CO} + \text{Cu}$ | Reflection | 40.30 meV | E/T |
| $\text{He}^+ + \text{CO} + \text{Pt}$ | Reflection | 40.30 meV | E/T |
| $\text{He}^+ + \text{CO} + \text{Cu}$ | Chemical Reactions | 40.30 meV | E/T |
| $\text{He}^+ + \text{CO} + \text{Pt}$ | Chemical Reactions | 40.30 meV | E/T |
1223. M. C. Torralba, C. M. Slutzky, E. A. Garcia, E. C. Goldberg
Elastic and inelastic processes in the scattering of positive ions of hydrogen and helium from a LiF surface.
 Phys. Rev. B **63**, 195411 (2001)
- | | | | |
|----------------------------|------------|------------------|----|
| $\text{H}^+ + \text{LiF}$ | Reflection | 100.00-500.00 eV | Th |
| $\text{He}^+ + \text{LiF}$ | Reflection | 100.00-500.00 eV | Th |
1224. E. Salonen, K. Nordlund, J. Keinonen, C. H. Wu
Swift chemical sputtering of amorphous hydrogenated carbon.
 Phys. Rev. B **63**, 195415 (2001)
- | | | | |
|-------------------------|------------|---------------|----|
| $\text{H}^+ + \text{C}$ | Sputtering | 1.00-35.00 eV | Th |
|-------------------------|------------|---------------|----|
1225. R. Gauantes, S. Miret-Artes, F. Borondo
Quantum manifestations of chaos in elastic atom-surface scattering.
 Phys. Rev. B **63**, 235401 (2001)
- | | | | |
|-------------------------|------------|-----------------|-----|
| $\text{He} + \text{Cu}$ | Reflection | 15.00-75.00 meV | E/T |
|-------------------------|------------|-----------------|-----|
1226. A. Hoffman, S. Ustaze, M. H. Hamou, M. N. Hedhili, Y. Le Coat, R. Azria, M. Tronc
Temperature-induced ion kinetic energy relaxation and yield of H^+ dissociative electron attachment from hydrogenated diamond films.
 Phys. Rev. B **63**, 245404 (2001)
- | | | | |
|----------------------------------|------------|---------------|----|
| $\text{e} + \text{H} + \text{C}$ | Desorption | 7.00-18.00 eV | Ex |
|----------------------------------|------------|---------------|----|
1227. A. Hoffman, S. Ustaze, M. H. Hamou, M. N. Hedhili, J. P. Guillotin, Y. Le Coat, R. Azria, M. Tronc
Mechanisms and dynamics of electron-stimulated desorption of D^- from deuterated diamond surfaces: Surface versus subsurface stimulated desorption.
 Phys. Rev. B **63**, 245417 (2001)
- | | | | |
|----------------------------------|------------|---------------|----|
| $\text{e} + \text{D} + \text{C}$ | Desorption | 5.00-35.00 eV | Ex |
|----------------------------------|------------|---------------|----|
1228. K. Chouffani, I. Endo, H. Uberall
Planar and axial coherent bremsstrahlung of type A from a 17-MeV electron beam in a diamond crystal.
 Phys. Rev. B **64**, 014304 (2001)
- | | | | |
|-----------------------|----------------------|-----------|----|
| $\text{e} + \text{C}$ | Surface Interactions | 17.00 MeV | Ex |
|-----------------------|----------------------|-----------|----|
1229. M. Y. Mao, P. B. Miranda, D. S. Kim, Y. R. Shen
Kinetics of molecular hydrogen dissociative adsorption on Si(111) studied by sum-frequency vibrational spectroscopy and second harmonic generation.
 Phys. Rev. B **64**, 035415 (2001)
- | | | | |
|--------------------------|-----------------------------|----------|----|
| $\text{H}_2 + \text{Si}$ | Neutraliz., Ioniz., Dissoc. | 300.00 K | Ex |
| $\text{H}_2 + \text{Si}$ | Trapping, Detrapping | 300.00 K | Ex |
| $\text{H}_2 + \text{Si}$ | Adsorption, Desorption | 300.00 K | Ex |
1230. E. Hayakawa, F. Khanom, T. Yoshifuku, S. Shimokawa, A. Namiki, T. Ando
Hot-complex-mediated abstraction and desorption of D adatoms by H on Si (100).
 Phys. Rev. B **65**, 033405 (2002)

H + (D + Si) Desorption Ex

1231. T. Andersson, F. Althoff, P. Linde, S. Andersson, K. Burke

Probing a cold surface with slow heavy-atom scattering: Experimental results and theoretical calculations.

Phys. Rev. B **65**, 045409 (2002)

H ₂ + Cu	Reflection	32.00-46.00 meV	E/T
D ₂ + Cu	Reflection	32.00-46.00 meV	E/T
He + Cu	Reflection	32.00-46.00 meV	E/T
Ne + Cu	Reflection	32.00-46.00 meV	E/T
Ar + Cu	Reflection	32.00-46.00 meV	E/T
Kr + Cu	Reflection	32.00-46.00 meV	E/T

1232. A. Mertens, S. Lederer, K. Maass, H. Winter, J. Stoeckl, HP. Winter, F. Aumayr

Excitation vs electron emission near the kinetic thresholds for grazing impact of hydrogen atoms on LiF(001).

Phys. Rev. B **65**, 132410 (2002)

H + LiF	Reflection	350.00-800.00 eV	Ex
H + LiF	Second. Elect. Emission	350.00-800.00 eV	Ex

1233. S. Bouneau, A. Brunelle, S. Della-Negra, J. Depauw, D. Jacquet, Y. Le Beyec, M. Pautrat, M. Fallavier, J. C. Poizat, H. H. Andersen

Very large gold and silver sputtering yields induced by keV to MeV energy Au_n clusters (n = 1-13).

Phys. Rev. B **65**, 144106 (2002)

Au ⁺ + Ag	Sputtering	0.02-5.00 MeV	Ex
Au ⁺ + Au	Sputtering	0.02-5.00 MeV	Ex
Au ₂ ⁺ + Ag	Sputtering	0.02-5.00 MeV	Ex
Au ₂ ⁺ + Au	Sputtering	0.02-5.00 MeV	Ex

1234. R. Cortenraad, A. W. Denier van der Gon, H. H. Brongersma, S. N. Ermolov, V. G. Glebovsky

Work function dependent neutralization of low-energy noble gas ions.

Phys. Rev. B **65**, 195414 (2002)

He ⁺ + Ba	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex
He ⁺ + W	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex
He ⁺ + Re	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex
Ne ⁺ + Ba	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex
Ne ⁺ + W	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex
Ne ⁺ + Re	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex
Ar ⁺ + Ba	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex
Ar ⁺ + W	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex
Ar ⁺ + Re	Neutraliz., Ioniz., Dissoc.	2.00-5.00 keV	Ex
He ⁺ + Ba	Reflection	2.00-5.00 keV	Ex
He ⁺ + W	Reflection	2.00-5.00 keV	Ex
He ⁺ + Re	Reflection	2.00-5.00 keV	Ex
Ne ⁺ + Ba	Reflection	2.00-5.00 keV	Ex
Ne ⁺ + W	Reflection	2.00-5.00 keV	Ex
Ne ⁺ + Re	Reflection	2.00-5.00 keV	Ex
Ar ⁺ + Ba	Reflection	2.00-5.00 keV	Ex
Ar ⁺ + W	Reflection	2.00-5.00 keV	Ex
Ar ⁺ + Re	Reflection	2.00-5.00 keV	Ex

1235. C. Staudt, A. Wucher, J. Bastiaansen, V. Philipsen, E. Vandeweert, P. Lievens, R. E. Silverans, Z. Sroubek

Sputtering of Ag atoms into metastable excited states.

Phys. Rev. B **66**, 085415 (2002)

Ar ⁺ + Ag	Sputtering	5.00-15.00 keV	E/T
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1236. M. Stepanova, S. K. Dew, I. P. Soshnikov
Sputtering from ion-beam-roughened Cu surfaces.
 Phys. Rev. B **66**, 125407 (2002)

$\text{Ar}^+ + \text{Cu}$	Sputtering	400.00-800.00 eV	E/T
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1237. M. Caron, H. Rothard, M. Beuve, B. Gervais
Multiple ionisation and high charge effects in electron spectra from impact of 9 MeV/u ions on carbon.

$\text{C}^{6+} + \text{C}$	Second. Elect. Emission	9.00 MeV/amu	Ex
$\text{Ca}^{20+} + \text{C}$	Second. Elect. Emission	9.00 MeV/amu	Ex
$\text{Mo}^{39+} + \text{C}$	Second. Elect. Emission	9.00 MeV/amu	Ex
1238. N. Matsunami, E. Hatanaka, J. Kondoh, H. Hosaka, K. Tsumori, H. Sakaue, H. Tawara
Secondary charged particle emission from proton conductive oxides by ion impact.
 Phys. Scr. **65**, 278 (2002)

$\text{H}^+ + \text{SrCeYbO}$	Second. Elect. Emission	1.00-100.00 keV	Ex
$\text{H}_2^+ + \text{SrCeYbO}$	Second. Elect. Emission	1.00-100.00 keV	Ex
$\text{H}_3^+ + \text{SrCeYbO}$	Second. Elect. Emission	1.00-100.00 keV	Ex
$\text{Ar}^+ + \text{SrCeYbO}$	Second. Elect. Emission	1.00-100.00 keV	Ex
1239. H. Jouin, F. A. Gutierrez, S. Jequier, C. Harel
Surface plasmon mediated hydrogenic ion neutralization at metallic surfaces.
 Phys. Scr. **T80**, 215 (1999)

$\text{H}^+ + \text{Li}$	Reflection		Th
$\text{H}^+ + \text{Mg}$	Reflection		Th
$\text{H}^+ + \text{In}$	Reflection		Th
$\text{H}^+ + \text{Au}$	Reflection		Th
$\text{H}^+ + \text{Li}$	Neutraliz., Ioniz., Dissoc.		Th
$\text{H}^+ + \text{Mg}$	Neutraliz., Ioniz., Dissoc.		Th
$\text{H}^+ + \text{In}$	Neutraliz., Ioniz., Dissoc.		Th
$\text{H}^+ + \text{Au}$	Neutraliz., Ioniz., Dissoc.		Th
1240. J. Ducree, J. Mrogenda, E. Reckels, H. J. Andrae
Fingerprints of early K-auger emission from slow highly charged ions approaching surfaces.
 Phys. Scr. **T80**, 217 (1999)

$\text{O}^{6+} + \text{Al}$	Second. Elect. Emission	78.00-91.00 eV	Ex
$\text{O}^{6+} + \text{Si}$	Second. Elect. Emission	78.00-91.00 eV	Ex
$\text{O}^{7+} + \text{Al}$	Second. Elect. Emission	78.00-91.00 eV	Ex
$\text{O}^{7+} + \text{Si}$	Second. Elect. Emission	78.00-91.00 eV	Ex
$\text{Ne}^{9+} + \text{Al}$	Second. Elect. Emission	78.00-91.00 eV	Ex
1241. J. Ducree, H. J. Andrae, U. Thumm
Improved dynamic simulation of highly charged ion-surface collisions.
 Phys. Scr. **T80**, 220 (1999)

$\text{N}^{6+} + \text{Al}$	Reflection	70.00 eV	Th
$\text{N}^{6+} + \text{Al}$	Neutraliz., Ioniz., Dissoc.	70.00 eV	Th
1242. F. W. Meyer, V. A. Morozov
Multicharged ion-surface interaction studies at ORNL with decelerated beams.
 Phys. Scr. **T80**, 226 (1999)

$\text{O}^{6+} + \text{Au}$	Reflection	2.50 keV	Ex
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1243. W. Huang, H. Lebius, R. Schuch, M. Grether, N. Stolterfoht
Neutralization rates of slow highly charged Ar ions in single and double scattering from a Au(111) surface.
 Phys. Scr. **T80**, 228 (1999)

Ar⁶⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex
Ar⁷⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex
Ar⁸⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex
Ar⁹⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex
Ar¹⁰⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex
Ar¹¹⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex
Ar¹²⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex
Ar¹³⁺ + Au	Neutraliz., Ioniz., Dissoc.	4.00 keV	Ex
Ar⁶⁺ + Au	Reflection	4.00 keV	Ex
Ar⁷⁺ + Au	Reflection	4.00 keV	Ex
Ar⁸⁺ + Au	Reflection	4.00 keV	Ex
Ar⁹⁺ + Au	Reflection	4.00 keV	Ex
Ar¹⁰⁺ + Au	Reflection	4.00 keV	Ex
Ar¹¹⁺ + Au	Reflection	4.00 keV	Ex
Ar¹²⁺ + Au	Reflection	4.00 keV	Ex
Ar¹³⁺ + Au	Reflection	4.00 keV	Ex

1244. P. Roncin, M. Barat, J. P. Atanas, J. Villette, V. A. Morozov

Energy loss and secondary electron measurements in collisions at grazing angle of 10 keV O^{q+} ions on LiF surface.

Phys. Scr. **T80**, 231 (1999)

O²⁺ + LiF	Reflection	10.00 keV	Ex
O³⁺ + LiF	Reflection	10.00 keV	Ex
O⁵⁺ + LiF	Reflection	10.00 keV	Ex
O⁶⁺ + LiF	Reflection	10.00 keV	Ex
O²⁺ + LiF	Second. Elect. Emission	10.00 keV	Ex
O³⁺ + LiF	Second. Elect. Emission	10.00 keV	Ex
O⁵⁺ + LiF	Second. Elect. Emission	10.00 keV	Ex
O⁶⁺ + LiF	Second. Elect. Emission	10.00 keV	Ex

1245. L. Ding, C. McGrath, J. M. Woolsey, M. B. Shah, R. W. McCullough, J. Geddes

Potential and kinetic electron emission by Xe⁺ and Xe¹⁰⁺ ions on clean polycrystalline copper.

Phys. Scr. **T80**, 234 (1999)

Xe⁺ + Cu	Reflection	2.00-10.00 keV	Ex
Xe²⁺ + Cu	Reflection	2.00-10.00 keV	Ex
Xe³⁺ + Cu	Reflection	2.00-10.00 keV	Ex
Xe⁴⁺ + Cu	Reflection	2.00-10.00 keV	Ex
Xe⁵⁺ + Cu	Reflection	2.00-10.00 keV	Ex
Xe⁶⁺ + Cu	Reflection	2.00-10.00 keV	Ex
Xe⁷⁺ + Cu	Reflection	2.00-10.00 keV	Ex
Xe⁸⁺ + Cu	Reflection	2.00-10.00 keV	Ex
Xe⁹⁺ + Cu	Reflection	2.00-10.00 keV	Ex
Xe¹⁰⁺ + Cu	Reflection	2.00-10.00 keV	Ex
Xe⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex
Xe²⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex
Xe³⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex
Xe⁴⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex
Xe⁵⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex
Xe⁶⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex
Xe⁷⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex
Xe⁸⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex
Xe⁹⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex
Xe¹⁰⁺ + Cu	Second. Elect. Emission	2.00-10.00 keV	Ex

1246. H. Eder, C. Lemell, F. Aumayr, HP. Winter

Projectile charge effects in ion-induced kinetic electron emission from solid surfaces.

Phys. Scr. **T80**, 236 (1999)

$\text{C}^+ + \text{Au}$	Second. Elect. Emission	5.00 keV/amu	Ex
$\text{C}^{2+} + \text{Au}$	Second. Elect. Emission	5.00 keV/amu	Ex
$\text{N}^+ + \text{Au}$	Second. Elect. Emission	5.00 keV/amu	Ex
$\text{N}^{2+} + \text{Au}$	Second. Elect. Emission	5.00 keV/amu	Ex
$\text{N}^{3+} + \text{Au}$	Second. Elect. Emission	5.00 keV/amu	Ex
$\text{O}^+ + \text{Au}$	Second. Elect. Emission	5.00 keV/amu	Ex
$\text{O}^{2+} + \text{Au}$	Second. Elect. Emission	5.00 keV/amu	Ex
$\text{O}^{3+} + \text{Au}$	Second. Elect. Emission	5.00 keV/amu	Ex
$\text{Ne}^+ + \text{Au}$	Second. Elect. Emission	5.00 keV/amu	Ex
$\text{Ne}^{2+} + \text{Au}$	Second. Elect. Emission	5.00 keV/amu	Ex
$\text{Ne}^{3+} + \text{Au}$	Second. Elect. Emission	5.00 keV/amu	Ex

1247. K. Hosaka, H. Tawara

Secondary electron emission yields from clean Cu surfaces under low-energy singly and doubly charged ion impact.

Phys. Scr. **T80**, 238 (1999)

$\text{Ar}^+ + \text{Cu}$	Second. Elect. Emission	2.40-125.00 eV/amu	Ex
$\text{Ar}^{2+} + \text{Cu}$	Second. Elect. Emission	2.40-125.00 eV/amu	Ex
$\text{Kr}^+ + \text{Cu}$	Second. Elect. Emission	2.40-125.00 eV/amu	Ex
$\text{Kr}^{2+} + \text{Cu}$	Second. Elect. Emission	2.40-125.00 eV/amu	Ex

1248. Y. Takabayashi, T. Ito, T. Azuma, K. Komaki, Y. Yamazaki, H. Tawara, M. Torikoshi, A. Kitagawa, E. Takada, T. Murakami

Convoy electron production and ionization in 390 MeV/u Ar^{17+} ion collisions with thin foils.

Phys. Scr. **T80**, 249 (1999)

$\text{Ar}^{17+} + \text{C}$	Second. Elect. Emission	390.00 MeV/amu	Ex
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1249. D. H Jakubassa-Amundsen

Theory of binary encounter electron transmission through foil targets.

Phys. Scr. **T80**, 252 (1999)

$\text{Ar}^{18+} + \text{C}$	Second. Elect. Emission	13.60-93.00 MeV/amu	Th
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1250. N. Okabayashi, K. Kuroki, Y. Tsuruta, T. Azuma, K. Komaki, Y. Yamazaki

Measurements of potential sputtered H^+ with 2D position sensitive detector.

Phys. Scr. **T80**, 555 (1999)

$\text{Xe}^{7+} + \text{C}$	Sputtering	700.00 eV	Ex
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1251. D. Niemann

Electron emission from highly-charged ions interacting with metal surfaces.

Phys. Scr. **T80**, 61 (1999)

$\text{Ne}^{9+} + \text{Al}$	Second. Elect. Emission	0.14-4.50 keV	Th
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1252. H. Khemliche, C. Laulhe, S. Hoekstra, R. Hoekstra, R. Morgenstern

Hollow atom dynamics on thin films.

Phys. Scr. **T80**, 66 (1999)

$\text{O}^{7+} + \text{Au}$	Second. Elect. Emission	3.60-6.15 keV	Ex
$\text{O}^{7+} + \text{LiF}$	Second. Elect. Emission	3.60-6.15 keV	Ex

1253. V. A. Morozov, F. W. Meyer, P. Roncin

Multi-coincidence studies as a technique for the investigation of ion-surface interaction.

Phys. Scr. **T80**, 69 (1999)

$\text{H}^+ + \text{LiF}$	Reflection	2.00 keV	Ex
$\text{O}^{2+} + \text{LiF}$	Reflection	2.00 keV	Ex
$\text{O}^{3+} + \text{LiF}$	Reflection	2.00 keV	Ex
$\text{O}^{5+} + \text{LiF}$	Reflection	2.00 keV	Ex

	O⁶⁺ + LiF	Reflection	2.00 keV	Ex
	H⁺ + LiF	Second. Elect. Emission	2.00 keV	Ex
	O²⁺ + LiF	Second. Elect. Emission	2.00 keV	Ex
	O³⁺ + LiF	Second. Elect. Emission	2.00 keV	Ex
	O⁵⁺ + LiF	Second. Elect. Emission	2.00 keV	Ex
	O⁶⁺ + LiF	Second. Elect. Emission	2.00 keV	Ex
1254.	C. Lemell, J. Stoeckl, J. Burgdoerfer, G. Betz, HP. Winter, F. Aumayr Separation of kinetic and potential electron emission in HCl-surface interactions. Phys. Scr. T80 , 76 (1999)			
	Ar⁶⁺ + Au	Second. Elect. Emission	0.45 keV/amu	Ex
1255.	P. Kornejew, W. Bohmeyer, H.-D. Reiner, C. H. Wu Chemical erosion of CFC at high ion flux densities. Phys. Scr. T91 , 29 (2001)			
	D⁺ + C	Chemical Reactions	9.00 eV	Ex
	D⁺ + C	Sputtering	9.00 eV	Ex
1256.	J. Roth Synopsis of erosion and redeposition. Phys. Scr. T91 , 65 (2001)			
	D⁺ + C	Chemical Reactions	20.00-300.00 eV	E/T
	D⁺ + C	Sputtering	20.00-300.00 eV	E/T
1257.	J. Stockl, C. Lemell, H. P. Winter, F. Aumayr Electron emission in grazing HCl-LiF(001) collisions. Phys. Scr. T92 , 135 (2001)			
	Ar²⁺ + LiF	Second. Elect. Emission	450.00-900.00 eV/amu	Ex
	Ar⁸⁺ + LiF	Second. Elect. Emission	450.00-900.00 eV/amu	Ex
	Ar⁹⁺ + LiF	Second. Elect. Emission	450.00-900.00 eV/amu	Ex
1258.	HP. Winter, F. Aumayr Interaction of slow HCl with solid surfaces: What do we know, what should we know? Phys. Scr. T92 , 15 (2001)			
	Ar⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T
	Ar⁴⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T
	Ar⁸⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T
	Ar⁹⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T
	Xe¹⁵⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T
	Xe²⁰⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T
	Xe²⁵⁺ + SiO₂	Desorption	0.10-10.00 keV	E/T
	Ar⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T
	Ar⁴⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T
	Ar⁸⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T
	Ar⁹⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T
	Xe¹⁵⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T
	Xe²⁰⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T
	Xe²⁵⁺ + SiO₂	Sputtering	0.10-10.00 keV	E/T
	Ne⁺ + Al	Second. Elect. Emission	0.10-10.00 keV	E/T
	Ne²⁺ + Al	Second. Elect. Emission	0.10-10.00 keV	E/T
	Ne³⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T
	Ne⁴⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T
	Ne⁵⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T
	Ne⁶⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T
	Ne⁷⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T
	Ne⁸⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T
	Ne⁹⁺ + Au	Second. Elect. Emission	0.10-10.00 keV	E/T

1259. F. W. Meyer, V. A. Morozov, S. Datz, R. Vane
Charge fraction measurements for 2.4-35 keV Ar^{q+} ($q = 2-13$) projectiles backscattered from Au(110).
 Phys. Scr. **T92**, 182 (2001)
- | | | | |
|-------------------------------|------------|----------------|----|
| $\text{Ar}^{2+} + \text{Au}$ | Reflection | 2.40-35.00 keV | Ex |
| $\text{Ar}^{3+} + \text{Au}$ | Reflection | 2.40-35.00 keV | Ex |
| $\text{Ar}^{4+} + \text{Au}$ | Reflection | 2.40-35.00 keV | Ex |
| $\text{Ar}^{5+} + \text{Au}$ | Reflection | 2.40-35.00 keV | Ex |
| $\text{Ar}^{6+} + \text{Au}$ | Reflection | 2.40-35.00 keV | Ex |
| $\text{Ar}^{7+} + \text{Au}$ | Reflection | 2.40-35.00 keV | Ex |
| $\text{Ar}^{8+} + \text{Au}$ | Reflection | 2.40-35.00 keV | Ex |
| $\text{Ar}^{9+} + \text{Au}$ | Reflection | 2.40-35.00 keV | Ex |
| $\text{Ar}^{10+} + \text{Au}$ | Reflection | 2.40-35.00 keV | Ex |
| $\text{Ar}^{11+} + \text{Au}$ | Reflection | 2.40-35.00 keV | Ex |
| $\text{Ar}^{12+} + \text{Au}$ | Reflection | 2.40-35.00 keV | Ex |
| $\text{Ar}^{13+} + \text{Au}$ | Reflection | 2.40-35.00 keV | Ex |
1260. M. Caron, A. Clouvas, R. Neugebauer, C. Potiradis, H. Rothard
Electronic sputtering of hydrogen from carbon induced by swift highly charged ions.
 Phys. Scr. **T92**, 205 (2001)
- | | | | |
|---|------------|--------------------|----|
| $\text{Ar}^{17+} + \text{N}_2 + \text{C}$ | Desorption | 6.00-13.00 MeV/amu | Ex |
|---|------------|--------------------|----|
1261. Z. D. Pesic, V. Hoffman, D. Niemann, N. Stolterfoht, Gy. Viktor, R. Schuch
Degree of the neutralization of highly charged Ar ions scattered at different angles from a Au surface.
 Phys. Scr. **T92**, 237 (2001)
- | | | | |
|-------------------------------|------------|---------------|----|
| $\text{Ar}^{7+} + \text{Au}$ | Reflection | 2.00-8.00 keV | Ex |
| $\text{Ar}^{8+} + \text{Au}$ | Reflection | 2.00-8.00 keV | Ex |
| $\text{Ar}^{9+} + \text{Au}$ | Reflection | 2.00-8.00 keV | Ex |
| $\text{Ar}^{10+} + \text{Au}$ | Reflection | 2.00-8.00 keV | Ex |
| $\text{Ar}^{11+} + \text{Au}$ | Reflection | 2.00-8.00 keV | Ex |
| $\text{Ar}^{12+} + \text{Au}$ | Reflection | 2.00-8.00 keV | Ex |
| $\text{Ar}^{13+} + \text{Au}$ | Reflection | 2.00-8.00 keV | Ex |
1262. X. T. Zheng, R. Hutton, Y. Zou
L electron populations of hollow ions produced in collisions of energetic Ar ions with metallic targets.
 Phys. Scr. **T92**, 256 (2001)
- | | | | |
|---------------------------|------------|-----------------|----|
| $\text{Ar}^+ + \text{Mg}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Al}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Ti}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{V}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Cr}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Fe}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Co}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Ni}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Cu}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Zn}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Y}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Nb}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Mo}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Sn}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Nd}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Tb}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Ho}$ | Reflection | 43.00-95.00 MeV | Ex |
| $\text{Ar}^+ + \text{Ta}$ | Reflection | 43.00-95.00 MeV | Ex |

1263. C. Auth, H. Winter
Energy loss and charge fractions of multicharged chlorine ions after grazing scattering from an Al(111) surface.
 Phys. Scr. **T92**, 35 (2001)
- | | | | |
|-------------------------------|------------|------------------|----|
| $\text{Cl}^+ + \text{Al}$ | Sputtering | 50.00-600.00 keV | Ex |
| $\text{Cl}^{2+} + \text{Al}$ | Sputtering | 50.00-600.00 keV | Ex |
| $\text{Cl}^{3+} + \text{Al}$ | Sputtering | 50.00-600.00 keV | Ex |
| $\text{Cl}^{4+} + \text{Al}$ | Sputtering | 50.00-600.00 keV | Ex |
| $\text{Cl}^{5+} + \text{Al}$ | Sputtering | 50.00-600.00 keV | Ex |
| $\text{Cl}^{6+} + \text{Al}$ | Sputtering | 50.00-600.00 keV | Ex |
| $\text{Cl}^{7+} + \text{Al}$ | Sputtering | 50.00-600.00 keV | Ex |
| $\text{Cl}^{8+} + \text{Al}$ | Sputtering | 50.00-600.00 keV | Ex |
| $\text{Cl}^{9+} + \text{Al}$ | Sputtering | 50.00-600.00 keV | Ex |
| $\text{Cl}^{10+} + \text{Al}$ | Sputtering | 50.00-600.00 keV | Ex |
1264. C. T. McGrath, Z. Szilagy, M. B. Shah, R. W. McCullough, J. M. Woosley, R. Trassl, E. Salzborn
Secondary electron/reflected particle coincidence studies during slow highly charged ion-surface interactions.
 Phys. Scr. **T92**, 40 (2001)
- | | | | |
|------------------------------|-------------------------|---------------|----|
| $\text{He}^+ + \text{Al}$ | Reflection | 2.00-8.00 keV | Ex |
| $\text{Ne}^+ + \text{Al}$ | Reflection | 2.00-8.00 keV | Ex |
| $\text{Ne}^{2+} + \text{Al}$ | Reflection | 2.00-8.00 keV | Ex |
| $\text{Ne}^{3+} + \text{Al}$ | Reflection | 2.00-8.00 keV | Ex |
| $\text{Ne}^{4+} + \text{Al}$ | Reflection | 2.00-8.00 keV | Ex |
| $\text{He}^+ + \text{Al}$ | Second. Elect. Emission | 2.00-8.00 keV | Ex |
| $\text{Ne}^+ + \text{Al}$ | Second. Elect. Emission | 2.00-8.00 keV | Ex |
| $\text{Ne}^{2+} + \text{Al}$ | Second. Elect. Emission | 2.00-8.00 keV | Ex |
| $\text{Ne}^{3+} + \text{Al}$ | Second. Elect. Emission | 2.00-8.00 keV | Ex |
| $\text{Ne}^{4+} + \text{Al}$ | Second. Elect. Emission | 2.00-8.00 keV | Ex |
1265. G. Lanzano, E. De Filippo, D. Mahboub, H. Rothard, C. Volant, S. Aiello, A. Anzalone, N. Arena, S. Cavallaro, E. Geraci, M. Geraci, F. Giustolisi, A. Pagano, G. Politi
Absolute cross sections for fast electron ejection by swift highly charged ions and evidence for "Fermi shuttle" acceleration.
 Phys. Scr. **T92**, 68 (2001)
- | | | | |
|-------------------------------|-------------------------|---------------------|----|
| $\text{Ne}^{19+} + \text{C}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ne}^{19+} + \text{Al}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ne}^{19+} + \text{Ni}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ne}^{19+} + \text{Ag}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ne}^{19+} + \text{Au}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ne}^{28+} + \text{C}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ne}^{28+} + \text{Al}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ne}^{28+} + \text{Ni}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ne}^{28+} + \text{Ag}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ne}^{28+} + \text{Au}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ar}^{18+} + \text{C}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ar}^{18+} + \text{Al}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ar}^{18+} + \text{Ni}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ar}^{18+} + \text{Ag}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
| $\text{Ar}^{18+} + \text{Au}$ | Second. Elect. Emission | 45.00-95.00 MeV/amu | Ex |
1266. S. Nagata, K. Takahiro
Effect of carbon and oxygen enriched layer on retention and release of deuterium implanted in tungsten and molybdenum.
 Phys. Scr. **T94**, 106 (2001)
- | | | | |
|----------------------------|----------------------|-----------|----|
| $\text{D}_2^+ + \text{Mo}$ | Trapping, Detrapping | 10.00 keV | Ex |
| $\text{D}_2^+ + \text{W}$ | Trapping, Detrapping | 10.00 keV | Ex |

1267. A. Pisarev, V. Shestakov, S. Kulsartov, A. Vaitonene
Surface effects in diffusion measurements: deuterium permeation through Martenstic steel.
 Phys. Scr. **T94**, 121 (2001)
 $D^+ + Fe$ Trapping, Detrapping E/T
 $D^+ + SS$ Trapping, Detrapping E/T
1268. B. M. Oliver, F. A. Garner, M. L. Hamilton, T. J. Venhaus, R. A. Causey, S. A. Maloy
Hydrogen release from 800 MeV proton-irradiated tungsten rods.
 Phys. Scr. **T94**, 137 (2001)
 $H^+ + W$ Trapping, Detrapping 800.00 MeV Ex
1269. K. Ohkoshi, S. Tohda, K. Shimura, K. Yamaguchi, T. Terai, M. Yamawaki
Atom-driven permeation of neuterium through Nb.
 Phys. Scr. **T94**, 16 (2001)
 $H + Nb$ Trapping, Detrapping 0.30 eV Ex
1270. V. K. Alimov, K. Ertl, J. Roth, K. Schmid
Deuterium retention and lattice damage in tungsten irradiated with D ions.
 Phys. Scr. **T94**, 34 (2001)
 $D^+ + W$ Trapping, Detrapping 6.00 keV Ex
1271. H. Wipf
Solubility and diffusion of hydrogen in pure metals and alloys.
 Phys. Scr. **T94**, 43 (2001)
 $H + V$ Trapping, Detrapping Th
 $H + FeTi$ Trapping, Detrapping Th
 $H + Ni$ Trapping, Detrapping Th
 $H + Cu$ Trapping, Detrapping Th
 $H + Nb$ Trapping, Detrapping Th
 $H + Ta$ Trapping, Detrapping Th
 $H + NiTi$ Trapping, Detrapping Th
1272. R. Kirchheim
Solubility and diffusivity of hydrogen in complex materials.
 Phys. Scr. **T94**, 58 (2001)
 $H + Pd$ Trapping, Detrapping Th
1273. A. P. Zakharov, A. E. Gorodetsky
Behavior of deuterium implanted into W, Be and BeO.
 Phys. Scr. **T94**, 68 (2001)
 $D^+ + Be$ Trapping, Detrapping 1.80-8.00 keV Ex
 $D^+ + BeO$ Trapping, Detrapping 1.80-8.00 keV Ex
 $D^+ + W$ Trapping, Detrapping 1.80-8.00 keV Ex
1274. F. Scaffidi-Argentina, C. Sand, C. H. Wu
Tritium and helium retention in neutron-irradiated beryllium.
 Phys. Scr. **T94**, 83 (2001)
 $D^+ + Be$ Trapping, Detrapping Ex
 $T^+ + Be$ Trapping, Detrapping Ex
1275. R. A. Causey, T. J. Venhaus
The use of tungsten in fusion reactors: a review of the hydrogen retention and migration properties.
 Phys. Scr. **T94**, 9 (2001)
 $H^+ + W$ Trapping, Detrapping 1.00 keV E/T
 $D^+ + W$ Trapping, Detrapping 1.00 keV E/T

1276. C. S. Lee, T. M. Lin
Oxygen sticking coefficient and sputtering yields at an Al(111) surface by ion bombardment.
 Surf. Sci. **469**, 219 (2000)
- | | | | |
|--------------------------------------|------------------------|-----------------|----|
| $\text{Ar}^+ + \text{O} + \text{Al}$ | Desorption | 10.00-20.00 keV | Ex |
| $\text{Ar}^+ + \text{O} + \text{Al}$ | Sputtering | 10.00-20.00 keV | Ex |
| $\text{O}_2 + \text{Al}$ | Adsorption, Desorption | 10.00-20.00 keV | Ex |
1277. O. Grizzi, E. A. Sanchez, J. E. Gayone, L. Guillemot, V. A. Esaulov, R. A. Baragiola
Formation of autoionizing Ne in grazing collisions with an Al(111) surface.**
 Surf. Sci. **469**, 71 (2000)
- | | | | |
|---------------------------|-------------------------|----------------|----|
| $\text{Ne}^+ + \text{Al}$ | Second. Elect. Emission | 3.00-50.00 keV | Ex |
| $\text{Ne}^+ + \text{Al}$ | Reflection | 3.00-50.00 keV | Ex |
1278. M. R. Salazar, J. D. Kress, A. Redondo
Dissociation of molecular oxygen on unpromoted and cesium promoted Ag(110) surfaces.
 Surf. Sci. **469**, 80 (2000)
- | | | | |
|--------------------------------------|-----------------------------|----------|----|
| $\text{O}_2 + \text{Ag}$ | Neutraliz., Ioniz., Dissoc. | 300.00 K | Th |
| $\text{O}_2 + \text{Cs} + \text{Ag}$ | Neutraliz., Ioniz., Dissoc. | 300.00 K | Th |
1279. B. A. Chuikov, V. D. Osovskii, Yu. G. Ptushinskii, V. G. Sukretnyi
Influence of the flux of H_2 and D_2 molecules on kinetics of low-temperature (down to 5 K) adsorption on the W(110) surface.
 Surf. Sci. **473**, 143 (2001)
- | | | | |
|-------------------------|------------------------|----------|----|
| $\text{H}_2 + \text{W}$ | Adsorption, Desorption | 300.00 K | Ex |
| $\text{D}_2 + \text{W}$ | Adsorption, Desorption | 300.00 K | Ex |
1280. H. Sellers, J. Anderson
Dissociation and recombination rate constants for N_2 on Cu and Ni group transition metal surfaces.
 Surf. Sci. **475**, 11 (2001)
- | | | | |
|--------------------------|-----------------------------|----------|----|
| $\text{N}_2 + \text{Ni}$ | Adsorption, Desorption | 300.00 K | Th |
| $\text{N}_2 + \text{Cu}$ | Adsorption, Desorption | 300.00 K | Th |
| $\text{N}_2 + \text{Pd}$ | Adsorption, Desorption | 300.00 K | Th |
| $\text{N}_2 + \text{Ag}$ | Adsorption, Desorption | 300.00 K | Th |
| $\text{N}_2 + \text{Pt}$ | Adsorption, Desorption | 300.00 K | Th |
| $\text{N}_2 + \text{Au}$ | Adsorption, Desorption | 300.00 K | Th |
| $\text{N}_2 + \text{Ni}$ | Neutraliz., Ioniz., Dissoc. | 300.00 K | Th |
| $\text{N}_2 + \text{Cu}$ | Neutraliz., Ioniz., Dissoc. | 300.00 K | Th |
| $\text{N}_2 + \text{Pd}$ | Neutraliz., Ioniz., Dissoc. | 300.00 K | Th |
| $\text{N}_2 + \text{Ag}$ | Neutraliz., Ioniz., Dissoc. | 300.00 K | Th |
| $\text{N}_2 + \text{Pt}$ | Neutraliz., Ioniz., Dissoc. | 300.00 K | Th |
| $\text{N}_2 + \text{Au}$ | Neutraliz., Ioniz., Dissoc. | 300.00 K | Th |
1281. J. T. Kindt, J. C. Tully
Dynamical corrugation: simulations of the sticking of CO on Cu(100).
 Surf. Sci. **477**, 149 (2001)
- | | | | |
|-------------------------|------------------------|---------|----|
| $\text{CO} + \text{Cu}$ | Adsorption, Desorption | 1.50 eV | Th |
|-------------------------|------------------------|---------|----|
1282. M. A. Karolewski, R. G. Cavell
Sputtering and secondary ion emission from Cu/Ni(100).
 Surf. Sci. **480**, 47 (2001)
- | | | | |
|---------------------------------------|--------------------|----------|----|
| $\text{Ar}^+ + \text{Cu} + \text{Ni}$ | Chemical Reactions | 5.00 keV | Ex |
| $\text{Ar}^+ + \text{Cu} + \text{Ni}$ | Desorption | 5.00 keV | Ex |
| $\text{Ar}^+ + \text{Cu} + \text{Ni}$ | Sputtering | 5.00 keV | Ex |

1283. E. Balazs, G. Varga, L. Fustoss
Comparison of 3D classical and quantum mechanical He scattering on Rh(311).
 Surf. Sci. **482-485**, 1145 (2001)
 He + Rh Reflection Th
1284. O.M.N Teodoro, A.M.C Moutinho
Simulation of sputtering induced by light ions.
 Surf. Sci. **482-485**, 1392 (2001)
 He + Ba Sputtering 0.25-2.50 keV Th
 Ar + Ba Sputtering 0.25-2.50 keV Th
1285. C. Eibl, A. Winkler
Time-of-flight studies on desorbing and on scattered D₂ molecules from a V(111) + S surface.
 Surf. Sci. **482-485**, 201 (2001)
 D₂ + V Desorption 300.00 K Ex
 D₂ + V Reflection 300.00 K Ex
 D₂ + V Neutraliz., Ioniz., Dissoc. 300.00 K Ex
1286. B. Kloetzer, K. Kayek, C. Konvicka, E. Lundgren, P. Varga
Oxygen-induced surface phase transformation of Pd(111): sticking, adsorption and desorption kinetics.
 Surf. Sci. **482-485**, 237 (2001)
 O₂ + Pd Adsorption, Desorption 300.00 K Ex
 O₂ + Pd Neutraliz., Ioniz., Dissoc. 300.00 K Ex
 O₂ + Pd Desorption 300.00 K Ex
1287. L. Bech, J. Onsgaard, S. V. Hoffman, P. J. Godowski
CO dissociation on K-modified Cu(112) and Cu(117).
 Surf. Sci. **482-485**, 243 (2001)
 CO + Cu Neutraliz., Ioniz., Dissoc. 300.00 K Ex
1288. Y. Miura, W. A. Dino, H. Kasai, A. Okiji
Orientational effects on the molecular diffraction dynamics of H₂ scattered from Cu(001).
 Surf. Sci. **482-485**, 306 (2001)
 H₂ + Cu Reflection 50.00-450.00 meV Th
1289. R. Azria, Y. Le Coat, M. H. Hamou, M. N. Hedhili, S. Ustaze, M. Tronc, A. Hoffman
Dissociative electron attachment in H⁻ electron stimulated desorption from hydrogenated diamond surfaces.
 Surf. Sci. **482-485**, 324 (2001)
 e + H + C Desorption 5.00-45.00 eV Ex
1290. S. F. Belykh, I. A. Wojciechowski, V. V. Palitsin, A. V. Zinoviev, A. Adriaens, F. Adams
Effect of the electronic subsystem excitation on the ionisation probability of atoms sputtered from metals by atomic and molecular projectiles.
 Surf. Sci. **488**, 141 (2001)
 Au⁻¹⁺ + Nb Sputtering 6.00-18.00 keV Th
 Au⁻¹⁺ + Ta Sputtering 6.00-18.00 keV Th
 Au₂⁻¹⁺ + Nb Sputtering 6.00-18.00 keV Th
 Au₂⁻¹⁺ + Ta Sputtering 6.00-18.00 keV Th
 Au₃⁻¹⁺ + Nb Sputtering 6.00-18.00 keV Th
 Au₃⁻¹⁺ + Ta Sputtering 6.00-18.00 keV Th
1291. C. S. Lee, T. M. Yen, J. H. Lin
Light emission from an oxygen covered copper surface by ion bombardment.
 Surf. Sci. **488**, 379 (2001)

- | | | | |
|----------------------------|------------------------|----------------|----|
| O + Cu | Adsorption, Desorption | 5.00-20.00 keV | Ex |
| Ne⁺ + Cu | Sputtering | 5.00-20.00 keV | Ex |
| Ne⁺ + Cu | Sputtering | 5.00-20.00 keV | Ex |
| Ar⁺ + Cu | Sputtering | 5.00-20.00 keV | Ex |
| Ar⁺ + Cu | Sputtering | 5.00-20.00 keV | Ex |
1292. Z. W. Deng, R. Souda
Dissociative thermal-electron attachment at a surface: CN⁻ emission from nitrogen ion irradiated graphite.
 Surf. Sci. **488**, 393 (2001)
- | | | | |
|--------------------------------------|--------------------|----------------|----|
| N₂⁺ + C | Chemical Reactions | 5.00-800.00 eV | Ex |
| N₂⁺ + C | Desorption | 5.00-800.00 eV | Ex |
| N₂⁺ + C | Sputtering | 5.00-800.00 eV | Ex |
1293. J. Wang, Y. Wang, K. Jacobi
Dissociation of CO on the Ru(11120) surface.
 Surf. Sci. **488**, 83 (2001)
- | | | | |
|----------------|------------|----------|----|
| CO + Ru | Reflection | 300.00 K | Th |
|----------------|------------|----------|----|
1294. R. Pfandzelter, M. Ostwald, H. Winter
Spin-polarized electron emission induced by impact of protons and electrons on Cr/Fe(100).
 Surf. Sci. **488**, 90 (2001)
- | | | | |
|---------------------------|-------------------------|----------------|----|
| e + Cr | Second. Elect. Emission | 4.00-25.00 keV | Th |
| H⁺ + Cr | Second. Elect. Emission | 4.00-25.00 keV | Th |
1295. A. Logadottir, J. K. Korskov
The effect of strain for N₂ dissociation on Fe surfaces.
 Surf. Sci. **489**, 135 (2001)
- | | | | |
|---------------------------|-----------------------------|--|----|
| N₂ + Fe | Neutraliz., Ioniz., Dissoc. | | Th |
| N₂ + Ru | Neutraliz., Ioniz., Dissoc. | | Th |
1296. H. Busse, M. R. Voss, D. Jerdev, B. E. Koel, M. T. Paffett
Adsorption and reaction of gaseous H(D) atoms with D(H) adatoms on Pt(111) and Sn/Pt(111) surface alloys.
 Surf. Sci. **490**, 133 (2001)
- | | | | |
|---------------|------------------------|--------|----|
| H + Sn | Trapping, Detrapping | 1.30 K | Ex |
| H + Pt | Trapping, Detrapping | 1.30 K | Ex |
| D + Sn | Trapping, Detrapping | 1.30 K | Ex |
| D + Pt | Trapping, Detrapping | 1.30 K | Ex |
| H + Sn | Adsorption, Desorption | 1.30 K | Ex |
| H + Pt | Adsorption, Desorption | 1.30 K | Ex |
| D + Sn | Adsorption, Desorption | 1.30 K | Ex |
| D + Pt | Adsorption, Desorption | 1.30 K | Ex |
1297. R.J.W.E. Lahaye, H. Kang
Energy exchange in structure scattering: a molecular dynamics study for Cs⁺ from Pt(111).
 Surf. Sci. **490**, 327 (2001)
- | | | | |
|----------------------------|------------|-----------------|----|
| Cs⁺ + Pt | Reflection | 25.00-100.00 eV | Th |
|----------------------------|------------|-----------------|----|
1298. J. Mrogenda, E. Reckels, H. J. Andrae
Deconvolution of Auger electron spectra of hyperthermal highly charged ions at metal surfaces.
 Surf. Sci. **490**, 43 (2001)

- | | | | |
|-----------------------------|-------------------------|---------------|----|
| C⁴⁺ + Al | Second. Elect. Emission | 0.01-1.00 keV | Th |
| C⁵⁺ + Al | Second. Elect. Emission | 0.01-1.00 keV | Th |
| N⁶⁺ + Al | Second. Elect. Emission | 0.01-1.00 keV | Th |
| O⁶⁺ + Al | Second. Elect. Emission | 0.01-1.00 keV | Th |
| O⁷⁺ + Al | Second. Elect. Emission | 0.01-1.00 keV | Th |
| Ne⁸⁺ + Al | Second. Elect. Emission | 0.01-1.00 keV | Th |
| Ne⁹⁺ + Al | Second. Elect. Emission | 0.01-1.00 keV | Th |
| Ar⁸⁺ + Al | Second. Elect. Emission | 0.01-1.00 keV | Th |
| Ar⁹⁺ + Al | Second. Elect. Emission | 0.01-1.00 keV | Th |
1299. W. A. Dino, H. Kasai, A. Okiji
H₂ dissociation dynamics on an alloy surface – controlling the dynamics via orientation.
 Surf. Sci. **493**, 278 (2001)
- | | | | |
|---|-----------------------------|----------|----|
| H₂ + Cu₃Pt | Adsorption, Desorption | 7.60 meV | Th |
| H₂ + Cu₃Pt | Neutraliz., Ioniz., Dissoc. | 7.60 meV | Th |
1300. Y. Xu, M. Mavrikakis
Adsorption and dissociation of O₂ on Cu(111): thermochemistry, reaction barrier and the effect of strain.
 Surf. Sci. **494**, 131 (2001)
- | | | | |
|---------------------------|-----------------------------|--|----|
| O₂ + Cu | Neutraliz., Ioniz., Dissoc. | | Th |
|---------------------------|-----------------------------|--|----|
1301. M. Bernheim
Energy threshold and ion yield for H⁻ ions ejected from Si(111):H(1x1) during low energy electron collisions: study of ESD process in relation with atom manipulation in STM.
 Surf. Sci. **494**, 145 (2001)
- | | | | |
|-------------------|------------|----------|----|
| e + H + Si | Desorption | 12.00 eV | Ex |
|-------------------|------------|----------|----|
1302. A. Losch, H. Niehus
Charge exchange by scattering of 3 keV Ne at Al(111) and KBr(100).
 Surf. Sci. **494**, 265 (2001)
- | | | | |
|-----------------------------|------------|----------|----|
| Ne⁺ + Al | Reflection | 3.00 keV | Ex |
| Ne⁺ + Al | Reflection | 3.00 keV | Ex |
| Ne⁺ + KBr | Reflection | 3.00 keV | Ex |
| Ne⁺ + KBr | Reflection | 3.00 keV | Ex |
1303. I. Vaquila, I. L. Bolotin, T. Ito, B. N. Makarenko, J. W. Rabalais
Ion fraction map of He⁺ scattered from a Se(100)-(2x1) surface.
 Surf. Sci. **496**, 187 (2002)
- | | | | |
|----------------------------|------------|----------|----|
| He⁺ + Si | Reflection | 5.00 keV | Ex |
|----------------------------|------------|----------|----|
1304. R. Souda, M. Kato
Capture and loss of valence electrons during low-energy proton scattering from rare-gas solid surfaces.
 Surf. Sci. **496**, 231 (2002)
- | | | | |
|---------------------------|------------|-----------------|----|
| H⁺ + Ar | Reflection | 10.00-500.00 eV | Ex |
| H⁺ + Kr | Reflection | 10.00-500.00 eV | Ex |
| H⁺ + Xe | Reflection | 10.00-500.00 eV | Ex |
1305. R. C. Egeberg, S. Ullmann, I. Alstrup, C. B. Mullins, I. Chorkendorff
Dissociation of CH₄ on Ni(111) and Ru(0001).
 Surf. Sci. **497**, 183 (2002)
- | | | | |
|----------------------------|-----------------------------|----------|----|
| CH₄ + Ni | Adsorption, Desorption | 300.00 K | Ex |
| CH₄ + Ru | Adsorption, Desorption | 300.00 K | Ex |
| CH₄ + Ni | Neutraliz., Ioniz., Dissoc. | 300.00 K | Ex |
| CH₄ + Ru | Neutraliz., Ioniz., Dissoc. | 300.00 K | Ex |

1306. N. V. Petrova, I. N. Yakovkin, Yu. G. Ptushinskii
Monte-Carlo simulation of kinetics of H₂ molecular adsorption.
 Surf. Sci. **497**, 349 (2002)
- | | | | |
|---------------------|-----------------------------|----------|----|
| H ₂ + Mo | Neutraliz., Ioniz., Dissoc. | 300.00 K | Th |
| H ₂ + W | Neutraliz., Ioniz., Dissoc. | 300.00 K | Th |
| H ₂ + Mo | Adsorption, Desorption | 300.00 K | Th |
| H ₂ + W | Adsorption, Desorption | 300.00 K | Th |
1307. C.-L. Kao, A. Carlsson, R. J. Madix
The adsorption dynamics of molecular carbon dioxide on Pt(111) and Pd(111).
 Surf. Sci. **497**, 356 (2002)
- | | | | |
|----------------------|-----------------------------|-------------------|----|
| CO ₂ + Pd | Neutraliz., Ioniz., Dissoc. | 8.50-38.00 kJ/mol | Ex |
| CO ₂ + Pt | Neutraliz., Ioniz., Dissoc. | 8.50-38.00 kJ/mol | Ex |
| CO ₂ + Pd | Adsorption, Desorption | 8.50-38.00 kJ/mol | Ex |
| CO ₂ + Pt | Adsorption, Desorption | 8.50-38.00 kJ/mol | Ex |
1308. M. V. R. Murty
Sputtering: the material erosion tool.
 Surf. Sci. **500**, 523 (2002)
- | | | | |
|----------------------|----------------------|-----------------|----|
| Ne ⁺ + Si | Surface Interactions | 0.10-300.00 keV | Ex |
| Ar ⁺ + Si | Surface Interactions | 0.10-300.00 keV | Ex |
| Ar ⁺ + Cu | Surface Interactions | 0.10-300.00 keV | Ex |
| Kr ⁺ + Si | Surface Interactions | 0.10-300.00 keV | Ex |
| Kr ⁺ + Cu | Surface Interactions | 0.10-300.00 keV | Ex |
| Xe ⁺ + Si | Surface Interactions | 0.10-300.00 keV | Ex |
| Ne ⁺ + Si | Sputtering | 0.10-300.00 keV | Ex |
| Ar ⁺ + Si | Sputtering | 0.10-300.00 keV | Ex |
| Ar ⁺ + Cu | Sputtering | 0.10-300.00 keV | Ex |
| Kr ⁺ + Si | Sputtering | 0.10-300.00 keV | Ex |
| Kr ⁺ + Cu | Sputtering | 0.10-300.00 keV | Ex |
| Xe ⁺ + Si | Sputtering | 0.10-300.00 keV | Ex |
1309. E. A. Sanchez, O. Grizzi, V. A. Esaulov
Autoionising state production in N⁺, O⁺, Ne⁺ and Ar⁺ scattering on clean and K covered Al(111) surfaces.
 Surf. Sci. **501**, 132 (2002)
- | | | | |
|----------------------|-------------------------|----------------|----|
| N ⁺ + Al | Second. Elect. Emission | 5.00-50.00 keV | Ex |
| N ⁺ + K | Second. Elect. Emission | 5.00-50.00 keV | Ex |
| O ⁺ + Al | Second. Elect. Emission | 5.00-50.00 keV | Ex |
| O ⁺ + K | Second. Elect. Emission | 5.00-50.00 keV | Ex |
| Ne ⁺ + Al | Second. Elect. Emission | 5.00-50.00 keV | Ex |
| Ne ⁺ + K | Second. Elect. Emission | 5.00-50.00 keV | Ex |
| Ar ⁺ + Al | Second. Elect. Emission | 5.00-50.00 keV | Ex |
| Ar ⁺ + K | Second. Elect. Emission | 5.00-50.00 keV | Ex |
| N ⁺ + Al | Reflection | 5.00-50.00 keV | Ex |
| N ⁺ + K | Reflection | 5.00-50.00 keV | Ex |
| O ⁺ + Al | Reflection | 5.00-50.00 keV | Ex |
| O ⁺ + K | Reflection | 5.00-50.00 keV | Ex |
| Ne ⁺ + Al | Reflection | 5.00-50.00 keV | Ex |
| Ne ⁺ + K | Reflection | 5.00-50.00 keV | Ex |
| Ar ⁺ + Al | Reflection | 5.00-50.00 keV | Ex |
| Ar ⁺ + K | Reflection | 5.00-50.00 keV | Ex |
| N ⁺ + Al | Sputtering | 5.00-50.00 keV | Ex |
| N ⁺ + K | Sputtering | 5.00-50.00 keV | Ex |
| O ⁺ + Al | Sputtering | 5.00-50.00 keV | Ex |
| O ⁺ + K | Sputtering | 5.00-50.00 keV | Ex |

$\text{Ne}^+ + \text{Al}$	Sputtering	5.00-50.00 keV	Ex
$\text{Ne}^+ + \text{K}$	Sputtering	5.00-50.00 keV	Ex
$\text{Ar}^+ + \text{Al}$	Sputtering	5.00-50.00 keV	Ex
$\text{Ar}^+ + \text{K}$	Sputtering	5.00-50.00 keV	Ex

1310. A. Ozer, J. R. Manson

Comparison of one-dimensional and three-dimensional models for the energy accommodation coefficient.

Surf. Sci. **502/503**, 347 (2002)

$\text{H}_2 + \text{Cu}$	Adsorption, Desorption	0.05 eV	Th
$\text{H}_2 + \text{Pd}$	Adsorption, Desorption	0.05 eV	Th
$\text{D}_2 + \text{Cu}$	Adsorption, Desorption	0.05 eV	Th
$\text{D}_2 + \text{Pd}$	Adsorption, Desorption	0.05 eV	Th
$\text{H}_2 + \text{Cu}$	Neutraliz., Ioniz., Dissoc.	0.05 eV	Th
$\text{H}_2 + \text{Pd}$	Neutraliz., Ioniz., Dissoc.	0.05 eV	Th
$\text{D}_2 + \text{Cu}$	Neutraliz., Ioniz., Dissoc.	0.05 eV	Th
$\text{D}_2 + \text{Pd}$	Neutraliz., Ioniz., Dissoc.	0.05 eV	Th

1311. J. Lorincik, Z. Sroubek, S. Cernusca, A. Diem, HP. Winter, F. Aumayr

Ion induced kinetic electron emission from highly oriented pyrolytic graphite by impact of H^+ , C^+ , N^+ , and O^+ .

Surf. Sci. **504**, 59 (2002)

$\text{H}^+ + \text{C}$	Second. Elect. Emission	0.10-30.00 keV	Ex
$\text{C}^+ + \text{C}$	Second. Elect. Emission	0.10-30.00 keV	Ex
$\text{N}^+ + \text{C}$	Second. Elect. Emission	0.10-30.00 keV	Ex
$\text{O}^+ + \text{C}$	Second. Elect. Emission	0.10-30.00 keV	Ex

1312. Z. S. Wang, G. R. Darling, S. Holloway

Vibration-rotational coupling of H_2 molecules scattering from a Cu(111) surface.

Surf. Sci. **504**, 66 (2002)

$\text{H}_2 + \text{Cu}$	Reflection	0.50-1.50 eV	Th
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1313. M. Medvedeva, I. Wojciechowski, B. J. Garrison

Effect of mass and incidence angle of keV energy polyatomic projectiles in silicon sputtering.

Surf. Sci. **505**, 349 (2002)

$\text{Al}^+ + \text{Si}$	Sputtering	1.50-3.00 keV	Th
$\text{Al}^+ + \text{Si}$	Sputtering	1.50-3.00 keV	Th
$\text{Al}_2^+ + \text{Si}$	Sputtering	1.50-3.00 keV	Th
$\text{Al}_2^+ + \text{Si}$	Sputtering	1.50-3.00 keV	Th
$\text{Au}^+ + \text{Si}$	Sputtering	1.50-3.00 keV	Th
$\text{Au}^+ + \text{Si}$	Sputtering	1.50-3.00 keV	Th
$\text{Au}_2^+ + \text{Si}$	Sputtering	1.50-3.00 keV	Th
$\text{Au}_2^+ + \text{Si}$	Sputtering	1.50-3.00 keV	Th

1314. J.A.M.C. Silva, J. Wolfgang, A. G. Borisov, J. P. Gauyacq, P. Nordlander, D. Teillet-Billy

Effect of a surface Al adatom on the resonant charge transfer between an H^- ion and an Al(111) surface.

Surf. Sci. **506**, 145 (2002)

$\text{H}^{-1+} + \text{Al}$	Neutraliz., Ioniz., Dissoc.		Th
------------------------------	-----------------------------	--	----

1315. J. D. Fuhr, J. O. Sofo, A. Saul

Coverage dependence study of the adsorption of Pd on $\text{MoS}_2(0001)$.

Surf. Sci. **506**, 161 (2002)

$\text{Pd} + \text{MoS}_2$	Adsorption, Desorption		Th
----------------------------	------------------------	--	----

1316. D.T.P. Watson, J. van Dijk, J.J.W. Harris, D. A. King
Coverage dependence of the dissociative sticking probability of methane on Pt110-(1x2).
 Surf. Sci. **506**, 243 (2002)
- | | | | |
|---------------------------|-----------------------------|-------------------|----|
| $\text{CH}_4 + \text{Pt}$ | Neutraliz., Ioniz., Dissoc. | 100.00-600.00 meV | Ex |
| $\text{CH}_4 + \text{Pt}$ | Adsorption, Desorption | 100.00-600.00 meV | Ex |
1317. R. Souda
Electron-stimulated ion and neutral desorption from D_2O adsorbed on rare-gas-solid substrates.
 Surf. Sci. **511**, 147 (2002)
- | | | | |
|---|------------|----------|----|
| $\text{e} + \text{D}_2\text{O} + \text{Ar}$ | Desorption | 1.00 keV | Ex |
| $\text{e} + \text{D}_2\text{O} + \text{Kr}$ | Desorption | 1.00 keV | Ex |
1318. J. M. Gottfried, K. J. Schmidt, S.L.M. Schroeder, K. Christmann
Spontaneous and electron-induced adsorption of oxygen on Au(110)-(1x2).
 Surf. Sci. **511**, 65 (2002)
- | | | | |
|--------------------------|------------------------|----------|----|
| $\text{O}_2 + \text{Au}$ | Adsorption, Desorption | 300.00 K | Ex |
|--------------------------|------------------------|----------|----|
1319. S. Tsurubuchi, T. Nimura
Survival probability of an excited sputtered Al atom in the $4s^2S_{1/2}$ state from a polycrystalline Al surface as a function of surface-oxygen coverage.
 Surf. Sci. **513**, 539 (2002)
- | | | | |
|---------------------------|-----------------------------|-----------|----|
| $\text{Ar}^+ + \text{Al}$ | Neutraliz., Ioniz., Dissoc. | 40.00 keV | Ex |
| $\text{Ar}^+ + \text{Al}$ | Sputtering | 40.00 keV | Ex |
1320. M. Kato, R. Souda
Study of quasi-resonant neutralization of low energy H^+ ion colliding with rare-gas solid surfaces in terms of hole localization and delocalization.
 Surf. Sci. **513**, 71 (2002)
- | | | | |
|--------------------------|-----------------------------|-----------------|----|
| $\text{H}^+ + \text{Ar}$ | Reflection | 10.00-500.00 eV | Ex |
| $\text{H}^+ + \text{Kr}$ | Reflection | 10.00-500.00 eV | Ex |
| $\text{H}^+ + \text{Xe}$ | Reflection | 10.00-500.00 eV | Ex |
| $\text{H}^+ + \text{Ar}$ | Neutraliz., Ioniz., Dissoc. | 10.00-500.00 eV | Ex |
| $\text{H}^+ + \text{Kr}$ | Neutraliz., Ioniz., Dissoc. | 10.00-500.00 eV | Ex |
| $\text{H}^+ + \text{Xe}$ | Neutraliz., Ioniz., Dissoc. | 10.00-500.00 eV | Ex |
1321. L. Siller, M.R.C. Hunt, J. W. Brown, J.-M. Coquel, P. Rudolf
Nitrogen ion irradiation of Au(110): formation of gold nitride.
 Surf. Sci. **513**, 78 (2002)
- | | | | |
|--------------------------|--------------------|---------------|----|
| $\text{N}^+ + \text{Au}$ | Chemical Reactions | 0.50-2.00 keV | Ex |
|--------------------------|--------------------|---------------|----|
1322. Yu. Bandurin, S. Lacombe, L. Guillemot, V. A. Esaulov
Surface plasmon excitation in hydrogen and helium ion scattering on Ag.
 Surf. Sci. **513**, L413 (2002)
- | | | | |
|------------------------------|----------------------|----------------|----|
| $\text{H}^{-1+} + \text{Ag}$ | Surface Interactions | 0.50-15.00 keV | Ex |
| $\text{H}^+ + \text{Ag}$ | Surface Interactions | 0.50-15.00 keV | Ex |
| $\text{He} + \text{Ag}$ | Surface Interactions | 0.50-15.00 keV | Ex |
| $\text{He}^+ + \text{Ag}$ | Surface Interactions | 0.50-15.00 keV | Ex |
| $\text{He}^{2+} + \text{Ag}$ | Surface Interactions | 0.50-15.00 keV | Ex |
1323. I. Nakamura, T. Fujitani, H. Hamada
Adsorption and decomposition of NO on Pd surfaces.
 Surf. Sci. **514**, 409 (2002)
- | | | | |
|-------------------------|-----------------------------|----------|----|
| $\text{NO} + \text{Pd}$ | Neutraliz., Ioniz., Dissoc. | 300.00 K | Ex |
| $\text{NO} + \text{Pd}$ | Adsorption, Desorption | 300.00 K | Ex |

1324. H. Okada, K. Inagaki, H. Goto, K. Endo, K. Hirose, Y. Mori
First-principles molecular-dynamics calculations and STM observations of dissociative adsorption of Cl₂ and F₂ on Si(001) surface.
 Surf. Sci. **515**, 287 (2002)
- | | | | |
|----------------------------|-----------------------------|----------|----|
| F₂ + Si | Neutraliz., Ioniz., Dissoc. | 300.00 K | Ex |
| Cl₂ + Si | Neutraliz., Ioniz., Dissoc. | 300.00 K | Ex |
1325. Y. Hoshino, S. Semba, T. Okazawa, Y. Kido
A₂- and energy-dependent charge fractions for medium energy He ions after a large-angle single collision at solid surfaces.
 Surf. Sci. **515**, 305 (2002)
- | | | | |
|--|------------|----------|----|
| He⁺ + NiSi₂ | Reflection | 1.80 keV | Ex |
| He⁺ + MgO | Reflection | 1.80 keV | Ex |
| He⁺ + KI | Reflection | 1.80 keV | Ex |
1326. M. Beutl, J. Lesnik
The influence of subsurface vanadium on the absorption of hydrogen and carbon monoxide on Pd(111).
 Vacuum **61**, 113 (2000)
- | | | | |
|--------------------------|------------------------|-----------|----|
| H₂ + V | Adsorption, Desorption | 88.00 meV | Ex |
| D₂ + V | Adsorption, Desorption | 88.00 meV | Ex |
| CO + V | Adsorption, Desorption | 88.00 meV | Ex |
1327. D. A. Konov, A. S. Mosunov, G. V. Adamov, L. B. Shelyakin, V. E. Yurasova
Angular dependence of sputtering for nickel in ferro and paramagnetic states.
 Vacuum **64**, 47 (2000)
- | | | | |
|----------------------------|------------|-----------|-----|
| Ne⁺ + Ni | Sputtering | 10.00 keV | E/T |
|----------------------------|------------|-----------|-----|
1328. Yu. N. Devyatko, S. V. Rogozhkin
Theoretical aspects of sputtering of magnetic materials near the Curie point.
 Vacuum **66**, 123 (2002)
- | | | | |
|----------------------------|------------|-----------|----|
| Ar⁺ + Ni | Sputtering | 20.00 keV | Th |
|----------------------------|------------|-----------|----|
1329. Yu. N. Cheblukov, A. Yu. Didyk, A. Halil, V. K. Semina, A. E. Stepanov, A. L. Suvorov, N. A. Vasiliev
Sputtering of metals by heavy ions in the inelastic energy loss range.
 Vacuum **66**, 133 (2002)
- | | | | |
|----------------------------|------------|---------------|----|
| Kr⁺ + Ni | Sputtering | 0.20-1.40 GeV | Ex |
| Kr⁺ + Au | Sputtering | 0.20-1.40 GeV | Ex |
| Au⁺ + Ti | Sputtering | 0.20-1.40 GeV | Ex |
| Au⁺ + Zr | Sputtering | 0.20-1.40 GeV | Ex |
| Au⁺ + Au | Sputtering | 0.20-1.40 GeV | Ex |
| U⁺ + Au | Sputtering | 0.20-1.40 GeV | Ex |
1330. A. M. Borisov, E. S. Mashkova, E. S. Parilis
The sweeping-out-electrons effect in electron emission under molecular ion bombardment.
 Vacuum **66**, 145 (2002)
- | | | | |
|---------------------------------------|-------------------------|-----------------|----|
| N⁺ + C | Second. Elect. Emission | 15.00-34.00 keV | Ex |
| N⁺ + Cr | Second. Elect. Emission | 15.00-34.00 keV | Ex |
| N⁺ + Au | Second. Elect. Emission | 15.00-34.00 keV | Ex |
| N₂⁺ + C | Second. Elect. Emission | 15.00-34.00 keV | Ex |
| N₂⁺ + Cr | Second. Elect. Emission | 15.00-34.00 keV | Ex |
| N₂⁺ + Au | Second. Elect. Emission | 15.00-34.00 keV | Ex |

3.4 Data Collection, Bibliography, Progress Report

1331. I. S. Lim, J. K. Laerdahl, P. Schwerdtfeger
Fully relativistic coupled-cluster static dipole polarizabilities of the positively charged alkali ions from Li^+ to 119^+ .
 J. Chem. Phys. **116**, 172 (2002)
 perturbation¹⁺ Data Coll., Biblio., Progress Report Ex
1332. R. A. Causey
Hydrogen isotope retention and recycling in fusion reactor plasma-facing components.
 J. Nucl. Mater. **300**, 91 (2002)
- | | | | |
|-----------------------------|--------------------------------------|----------------|----|
| $\text{H}^{1+} + \text{Li}$ | Data Coll., Biblio., Progress Report | 0.10-15.00 keV | Ex |
| $\text{H}^{1+} + \text{Be}$ | Data Coll., Biblio., Progress Report | 0.10-15.00 keV | Ex |
| $\text{H}^{1+} + \text{C}$ | Data Coll., Biblio., Progress Report | 0.10-15.00 keV | Ex |
| $\text{H}^{1+} + \text{Ga}$ | Data Coll., Biblio., Progress Report | 0.10-15.00 keV | Ex |
| $\text{H}^{1+} + \text{W}$ | Data Coll., Biblio., Progress Report | 0.10-15.00 keV | Ex |
| $\text{D}^{1+} + \text{Li}$ | Data Coll., Biblio., Progress Report | 0.10-15.00 keV | Ex |
| $\text{D}^{1+} + \text{Be}$ | Data Coll., Biblio., Progress Report | 0.10-15.00 keV | Ex |
| $\text{D}^{1+} + \text{C}$ | Data Coll., Biblio., Progress Report | 0.10-15.00 keV | Ex |
| $\text{D}^{1+} + \text{Ga}$ | Data Coll., Biblio., Progress Report | 0.10-15.00 keV | Ex |
| $\text{D}^{1+} + \text{W}$ | Data Coll., Biblio., Progress Report | 0.10-15.00 keV | Ex |
1333. A. Yu. Pigarov
Collisional radiative kinetics of molecular assisted recombination in edge plasmas.
 Phys. Scr. **T96**, 16 (2002)
- | | | | |
|------------------------------|--------------------------------------|---------------|----|
| $\text{e} + \text{H}^{-1+}$ | Data Coll., Biblio., Progress Report | 0.10-10.00 eV | Th |
| $\text{e} + \text{H}^{-1+}$ | Data Coll., Biblio., Progress Report | 0.10-10.00 eV | Th |
| $\text{e} + \text{H}_2^{1+}$ | Data Coll., Biblio., Progress Report | 0.10-10.00 eV | Th |
| $\text{e} + \text{H}_2^{1+}$ | Data Coll., Biblio., Progress Report | 0.10-10.00 eV | Th |
1334. R. Celiberto, M. Capitelli, A. Laricchiuta
Towards a cross section database of excited atomic and molecular hydrogen.
 Phys. Scr. **T96**, 32 (2002)
- | | | | |
|-------------------------|--------------------------------------|-----------|----|
| $\text{e} + \text{H}_2$ | Data Coll., Biblio., Progress Report | 100.00 eV | Th |
|-------------------------|--------------------------------------|-----------|----|
1335. H. Takagi
Dissociative recombination and excitation of H_2^+ , HD^+ , and D_2^+ with electrons for various vibrational states.
 Phys. Scr. **T96**, 52 (2002)
- | | | | |
|------------------------------|--------------------------------------|----------|----|
| $\text{e} + \text{H}_2^{1+}$ | Data Coll., Biblio., Progress Report | 12.00 eV | Th |
| $\text{e} + \text{HD}^{1+}$ | Data Coll., Biblio., Progress Report | 12.00 eV | Th |
| $\text{e} + \text{D}_2^{1+}$ | Data Coll., Biblio., Progress Report | 12.00 eV | Th |
1336. J. G. Wang, P. C. Stancil
Hydrogen ion-molecule isotopomer collisions: Charge transfer and rearrangement.
 Phys. Scr. **T96**, 72 (2002)
- | | | | |
|------------------------------|--------------------------------------|----------------|-----|
| $\text{H}^{1+} + \text{H}_2$ | Data Coll., Biblio., Progress Report | 0.00-10.00 keV | E/T |
| $\text{H}^{1+} + \text{H}_2$ | Data Coll., Biblio., Progress Report | 0.00-10.00 keV | E/T |
| $\text{H}^{1+} + \text{HT}$ | Data Coll., Biblio., Progress Report | 0.00-10.00 keV | E/T |
| $\text{H}^{1+} + \text{HT}$ | Data Coll., Biblio., Progress Report | 0.00-10.00 keV | E/T |
| $\text{H}^{1+} + \text{D}_2$ | Data Coll., Biblio., Progress Report | 0.00-10.00 keV | E/T |
| $\text{H}^{1+} + \text{D}_2$ | Data Coll., Biblio., Progress Report | 0.00-10.00 keV | E/T |
| $\text{H}^{1+} + \text{DT}$ | Data Coll., Biblio., Progress Report | 0.00-10.00 keV | E/T |
| $\text{H}^{1+} + \text{DT}$ | Data Coll., Biblio., Progress Report | 0.00-10.00 keV | E/T |
| $\text{H}^{1+} + \text{T}_2$ | Data Coll., Biblio., Progress Report | 0.00-10.00 keV | E/T |
| $\text{H}^{1+} + \text{T}_2$ | Data Coll., Biblio., Progress Report | 0.00-10.00 keV | E/T |

$\text{H}_2^{1+} + \text{H}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{H}_2^{1+} + \text{H}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{H}_2^{1+} + \text{D}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{H}_2^{1+} + \text{D}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{HD}^{1+} + \text{H}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{HD}^{1+} + \text{H}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{HD}^{1+} + \text{D}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{HD}^{1+} + \text{D}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}^{1+} + \text{H}_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}^{1+} + \text{H}_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}^{1+} + \text{HT}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}^{1+} + \text{HT}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}^{1+} + \text{D}_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}^{1+} + \text{D}_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}^{1+} + \text{DT}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}^{1+} + \text{DT}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}^{1+} + \text{T}_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}^{1+} + \text{T}_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}_2^{1+} + \text{H}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}_2^{1+} + \text{H}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}_2^{1+} + \text{D}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{D}_2^{1+} + \text{D}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{T}^{1+} + \text{H}_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{T}^{1+} + \text{H}_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{T}^{1+} + \text{HT}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{T}^{1+} + \text{HT}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{T}^{1+} + \text{D}_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{T}^{1+} + \text{D}_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{T}^{1+} + \text{DT}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{T}^{1+} + \text{DT}$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{T}^{1+} + \text{T}_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T
$\text{T}^{1+} + \text{T}_2$	Data Coll., Biblio., Progress Report	0.00-10.00 keV	E/T

3.5 Fusion Research of General Interest

1337. S. Lepp, P. C. Stancil, A. Dalgarno

Atomic and molecular processes in the early Universe.

J. Phys. B **35**, R57 (2002)

$\text{h}\nu + \text{H}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{h}\nu + \text{H}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{h}\nu + \text{D}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{h}\nu + \text{D}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{h}\nu + \text{He}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{h}\nu + \text{He}^{1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{h}\nu + \text{Li}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{h}\nu + \text{Li}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{h}\nu + \text{Li}^{1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{h}\nu + \text{Li}^{2+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{e} + \text{H}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{e} + \text{D}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{e} + \text{He}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{e} + \text{He}^{1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{e} + \text{He}^{2+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{e} + \text{Li}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{e} + \text{Li}^{1+}$	Fusion Research of General Interest	0.10-1.00 K	Th

$e + \text{Li}^{2+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$e + \text{Li}^{3+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{H}^{1+} + \text{H}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{H}^{1+} + \text{D}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{H}^{1+} + \text{Li}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{H}_2 + \text{D}^{1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{H}_2^{1+} + \text{H}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{D}^{1+} + \text{H}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{D}^{1+} + \text{D}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{D}^{1+} + \text{Li}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{Li}^{1+} + \text{H}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th
$\text{Li}^{1+} + \text{D}^{-1+}$	Fusion Research of General Interest	0.10-1.00 K	Th

3.6 Particle Beam-Matter Interactions

1338. A. I. Titov, S. O. Kucheyev, V. S. Belyakov, A. Yu. Azarov
Damage buildup in Si under bombardment with MeV heavy atomic and molecular ions.
J. Appl. Phys. **90**, 3867 (2001)
- | | | | |
|--------------------------------|----------------------------------|---------------|----|
| $\text{Bi}_2^{1+} + \text{Si}$ | Particle Beam-Matter interaction | 0.50-1.00 MeV | Ex |
| $\text{Bi}^{1+} + \text{Si}$ | Particle Beam-Matter interaction | 0.50-1.00 MeV | Ex |
1339. J. J. Serrano, J. M. Blanco, B. Guzman, H. De Witte, W. Vandervorst
Stopping cross sections for 0.3-2.5 MeV protons in GaN and InP.
J. Appl. Phys. **90**, 4871 (2001)
- | | | | |
|-------------------------|----------------------------------|---------------|----|
| $\text{H} + \text{InP}$ | Particle Beam-Matter interaction | 0.30-2.50 MeV | Ex |
| $\text{H} + \text{GaN}$ | Particle Beam-Matter interaction | 0.30-2.50 MeV | Ex |
1340. K. Shibata, K. Tsubuku, T. Nishimoto, J. Hasegawa, M. Ogawa, Y. Oguri
Experimental study on the feasibility of hot plasmas as stripping media for MeV heavy ions.
J. Appl. Phys. **91**, 4833 (2002)
- | | | | |
|-----------------------------|----------------------------------|----------------|----|
| $\text{C}^{1+} + \text{H}$ | Particle Beam-Matter interaction | 350.00 keV/amu | Ex |
| $\text{C}^{1+} + \text{Li}$ | Particle Beam-Matter interaction | 350.00 keV/amu | Ex |
| $\text{O}^{1+} + \text{H}$ | Particle Beam-Matter interaction | 350.00 keV/amu | Ex |
| $\text{O}^{1+} + \text{Li}$ | Particle Beam-Matter interaction | 350.00 keV/amu | Ex |
| $\text{F}^{1+} + \text{H}$ | Particle Beam-Matter interaction | 350.00 keV/amu | Ex |
| $\text{F}^{1+} + \text{Li}$ | Particle Beam-Matter interaction | 350.00 keV/amu | Ex |
1341. V. K. Alimov, K. Ertl, J. Roth, K. Schmid
Retention of ion-implanted deuterium in tungsten pre-irradiated with carbon ions.
J. Nucl. Mater. **282**, 125 (2000)
- | | | | |
|----------------------------------|----------------------------------|------------------|----|
| $\text{D} + \text{C} + \text{W}$ | Particle Beam-Matter interaction | 10.00-100.00 keV | Ex |
| $\text{D} + \text{W}$ | Particle Beam-Matter interaction | 10.00-100.00 keV | Ex |
| $\text{D} + \text{WC}$ | Particle Beam-Matter interaction | 10.00-100.00 keV | Ex |
1342. R. A. Zuhr, J. Roth, W. Eckstein, U. von Toussaint, J. Luthin
Implantation, erosion, and retention of tungsten in carbon.
J. Nucl. Mater. **290-293**, 505 (2001)
- | | | | |
|----------------------------|----------------------------------|-----------|----|
| $\text{W}^{1+} + \text{C}$ | Particle Beam-Matter interaction | 100.00 eV | Ex |
|----------------------------|----------------------------------|-----------|----|
1343. A.Y.K. Chen, J. W. Davis, A. A. Haasz
Methane formation in graphite and boron-doped graphite under simultaneous O^+ and H^+ irradiation.
J. Nucl. Mater. **290-293**, 61 (2001)

- | | | | | |
|--|--------------|----------------------------------|---------------|----|
| | $H^{1+} + B$ | Particle Beam-Matter interaction | 0.70-5.00 keV | Ex |
| | $H^{1+} + C$ | Particle Beam-Matter interaction | 0.70-5.00 keV | Ex |
| | $O^{1+} + B$ | Particle Beam-Matter interaction | 0.70-5.00 keV | Ex |
| | $O^{1+} + C$ | Particle Beam-Matter interaction | 0.70-5.00 keV | Ex |
1344. A. A. Haasz, M. Poon, R. G. Macaulay-Newcombe, J. W. Davis
Deuterium retention in single crystal tungsten.
 J. Nucl. Mater. **290-293**, 85 (2001)
- | | | | | |
|--|----------------|----------------------------------|----------|----|
| | $D_3^{1+} + W$ | Particle Beam-Matter interaction | 1.50 keV | Ex |
|--|----------------|----------------------------------|----------|----|
1345. N. Matsunami, M. Sataka, A. Iwase, T. Inami, M. Kobiyama
Sputtering of nano-crystalline gold by high energy heavy ions.
 J. Nucl. Mater. **302**, 206 (2002)
- | | | | | |
|--|----------------|----------------------------------|------------------|----|
| | $S^{7+} + Au$ | Particle Beam-Matter interaction | 80.00-200.00 MeV | Ex |
| | $Ni^{6+} + Au$ | Particle Beam-Matter interaction | 80.00-200.00 MeV | Ex |
| | $I^{9+} + Au$ | Particle Beam-Matter interaction | 80.00-200.00 MeV | Ex |
| | $I^{12+} + Au$ | Particle Beam-Matter interaction | 80.00-200.00 MeV | Ex |
1346. H. Rothard, G. Lanzano, D. H Jakubassa-Amundsen, E. De Filippo, D. Mahboub
Theory and measurement of absolute doubly differential cross sections of binary encounter electron ejection in collisions of swift heavy ions with solids.
 J. Phys. B **34**, 3261 (2001)
- | | | | | |
|--|----------------|----------------------------------|---------------|-----|
| | $Ni^{28+} + C$ | Particle Beam-Matter interaction | 45.00 MeV/amu | E/T |
|--|----------------|----------------------------------|---------------|-----|
1347. P. Moretto-Capelle, D. Bordenave-Montesquieu, A. Rentenier, A. Bordenave-Montesquieu
Interaction of protons with the C_{60} molecule: calculation of deposited energies and electronic stopping cross sections ($v \geq 5$ au).
 J. Phys. B **34**, L611 (2001)
- | | | | | |
|--|-------------------|----------------------------------|----------------|----|
| | $H^{1+} + C_{60}$ | Particle Beam-Matter interaction | 0.10-5.00 a.u. | Th |
|--|-------------------|----------------------------------|----------------|----|
1348. K. Parodi, S. Squarcia
Improvement of low-energy stopping power algorithms in the FLUKA simulation program.
 Nucl. Instrum. Methods Phys. Res. A **456**, 352 (2001)
- | | | | | |
|--|---------------|----------------------------------|---------------------|----|
| | $H^{1+} + H$ | Particle Beam-Matter interaction | 0.00-100.00 MeV/amu | Th |
| | $H^{1+} + C$ | Particle Beam-Matter interaction | 0.00-100.00 MeV/amu | Th |
| | $H^{1+} + O$ | Particle Beam-Matter interaction | 0.00-100.00 MeV/amu | Th |
| | $He^{2+} + H$ | Particle Beam-Matter interaction | 0.00-100.00 MeV/amu | Th |
| | $He^{2+} + C$ | Particle Beam-Matter interaction | 0.00-100.00 MeV/amu | Th |
| | $He^{2+} + O$ | Particle Beam-Matter interaction | 0.00-100.00 MeV/amu | Th |
1349. A. Sakumi, K. Shibata, R. Sato, K. Tsubuku, T. Nishimoto, J. Hasegawa, M. Ogawa, Y. Oguri, T. Katayama
Energy dependence of the stopping power of MeV ^{16}O ions in a laser-produced plasma.
 Nucl. Instrum. Methods Phys. Res. A **464**, 231 (2001)
- | | | | | |
|--|--------------|----------------------------------|-------------------|----|
| | $e + O^{2+}$ | Particle Beam-Matter interaction | 0.10-0.80 MeV/amu | Ex |
|--|--------------|----------------------------------|-------------------|----|
1350. J. Hasegawa, Y. Nakajima, K. Sakai, M. Yoshida, S. Fukata, K. Nishigori, M. Kojima, Y. Oguri, M. Nakajima, K. Horioka, M. Ogawa, U. Neuner, T. Murakami
Energy loss of 6 MeV/u iron ions in partially ionized helium plasma.
 Nucl. Instrum. Methods Phys. Res. A **464**, 237 (2001)
- | | | | | |
|--|----------------|----------------------------------|--------------|----|
| | $e + Fe^{21+}$ | Particle Beam-Matter interaction | 6.00 MeV/amu | Ex |
| | $e + Fe^{25+}$ | Particle Beam-Matter interaction | 6.00 MeV/amu | Ex |
1351. A. Golubev, V. Turtikov, A. Fertman, I. Roudskoy, B. Sharkov, M. Geissel, U. Neuner, M. Roth, A. Tauschwitz, H. Wahl, D.H.H. Hofmann, U. Funk, W. Suss, J. Jacoby
Experimental investigation of the effective charge state of ions in beam-plasma interaction.
 Nucl. Instrum. Methods Phys. Res. A **464**, 247 (2001)

$e + C^{1+}$	Particle Beam-Matter interaction	3.60-11.40 MeV/amu	Ex
$e + Kr^{1+}$	Particle Beam-Matter interaction	3.60-11.40 MeV/amu	Ex
$e + Pb^{1+}$	Particle Beam-Matter interaction	3.60-11.40 MeV/amu	Ex

1352. D. Gardes, M. Chabot, M. Nectoux, G. Maynard, C. Deutsch, G. Belyaev
Experimental analysis of the stopping cross sections and of the charge changing processes for Cl^{q+} projectiles at the maximum of the stopping power.

Nucl. Instrum. Methods Phys. Res. A **464**, 253 (2001)

$e + Cl^{7+}$	Particle Beam-Matter interaction	0.06-1.03 MeV	Ex
$Cl^{7+} + D_2$	Particle Beam-Matter interaction	0.06-1.03 MeV	Ex
$Cl^{7+} + C$	Particle Beam-Matter interaction	0.06-1.03 MeV	Ex

1353. G. Maynard, K. Katsonis, C. Deutsch, G. Zwicknagel, M. Chabot, D. Gardes
Modeling of swift heavy ions interaction with dense matter.

Nucl. Instrum. Methods Phys. Res. A **464**, 86 (2001)

$Cl^{10+} + H_2$	Particle Beam-Matter interaction	1.50 MeV/amu	Th
$Cl^{11+} + H_2$	Particle Beam-Matter interaction	1.50 MeV/amu	Th
$Cl^{12+} + H_2$	Particle Beam-Matter interaction	1.50 MeV/amu	Th
$Cl^{13+} + H_2$	Particle Beam-Matter interaction	1.50 MeV/amu	Th
$Cl^{14+} + H_2$	Particle Beam-Matter interaction	1.50 MeV/amu	Th
$Cl^{15+} + H_2$	Particle Beam-Matter interaction	1.50 MeV/amu	Th

1354. R. E. Olson

Stripping cross-sections for fast, low charge state ions.

Nucl. Instrum. Methods Phys. Res. A **464**, 93 (2001)

$Xe^{1+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Xe^{2+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Xe^{3+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Xe^{4+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Xe^{5+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Xe^{6+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Xe^{7+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Xe^{8+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Xe^{9+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Xe^{10+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Xe^{11+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Xe^{12+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$U^{10+} + H_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$U^{10+} + N_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Bi^{1+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Bi^{2+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Bi^{3+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Bi^{4+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Bi^{5+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Bi^{6+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Bi^{7+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Bi^{8+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Bi^{9+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Bi^{10+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Bi^{11+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th
$Bi^{12+} + BeF_2$	Particle Beam-Matter interaction	2.60-8.40 GeV	Th

1355. A. Hakim, A. Fahli, M. Toulemonde, D. Lelievre
Stopping powers of Al, Havar, Ni, Ti and Ta media for 9.67 MeV/u ^{58}Ni and 9.5 MeV/u ^{18}O ions.

$O^{1+} + Al$	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex
---------------	----------------------------------	-------------------	----

$O^{1+} + Ti$	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex
$O^{1+} + Ni$	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex
$O^{1+} + Ta$	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex
$Ni^{1+} + Al$	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex
$Ni^{1+} + Ti$	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex
$Ni^{1+} + Ni$	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex
$Ni^{1+} + Ta$	Particle Beam-Matter interaction	9.50-9.70 MeV/amu	Ex

1356. X. Tordoir, T. Bastin, P.-D. Dumont, H.-P. Garnir

Equilibrium charge-state distributions of sodium ions in carbon foil.

Nucl. Instrum. Methods Phys. Res. B **173**, 275 (2001)

$Na^{1+} + C$	Particle Beam-Matter interaction	0.43-1.66 MeV	Ex
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1357. Y. Mejaddem, D. S. Belkic, S. Hyodynmaa, A. Brahme

Calculations of electron energy loss straggling.

Nucl. Instrum. Methods Phys. Res. B **173**, 397 (2001)

$e + H_2O$	Particle Beam-Matter interaction	10.00-44.00 MeV	Th
$e + Be$	Particle Beam-Matter interaction	10.00-44.00 MeV	Th
$e + C$	Particle Beam-Matter interaction	10.00-44.00 MeV	Th
$e + Al$	Particle Beam-Matter interaction	10.00-44.00 MeV	Th
$e + Cu$	Particle Beam-Matter interaction	10.00-44.00 MeV	Th
$e + Pb$	Particle Beam-Matter interaction	10.00-44.00 MeV	Th

1358. X. Liu, P. Liu, Y. Xia, R. Wang, Y. Ma, M. Zhao, J. Zhang

Range distribution and electronic stopping powers for fluorine ions in $^{19}F^+$ - implanted potassium titanyl phosphate and $LiNbO_3$.

Nucl. Instrum. Methods Phys. Res. B **174**, 1 (2001)

$F^{1+} + LiNbO_3$	Particle Beam-Matter interaction	50.00-330.00 keV	Ex
$F^{1+} + LiNbO_3$	Particle Beam-Matter interaction	50.00-330.00 keV	Ex

1359. M. Fama, G. H. Lantschner, J. C. Eckardt, N. R. Arista

Angular dependence of the energy loss of ions in solids: Computer simulations and analysis of models.

Nucl. Instrum. Methods Phys. Res. B **174**, 16 (2001)

$H^{1+} + Al$	Particle Beam-Matter interaction	100.00 keV	Th
$H^{1+} + Al$	Particle Beam-Matter interaction	100.00 keV	Th

1360. P. K. Diwan, A. K. Sharma, S. Kumar

Stopping power for heavy ions ($3 \leq Z \leq 35$) in solids at energies 0.5-2.5 MeV/n.

Nucl. Instrum. Methods Phys. Res. B **174**, 267 (2001)

$C^{1+} + C$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$C^{1+} + Al$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$C^{1+} + Ni$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$C^{1+} + Cu$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$C^{1+} + Ag$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$C^{1+} + Ta$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$C^{1+} + Au$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$O^{1+} + C$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$O^{1+} + Al$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$O^{1+} + Ni$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$O^{1+} + Cu$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$O^{1+} + Ag$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$O^{1+} + Ta$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$O^{1+} + Au$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$Al^{1+} + C$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$Al^{1+} + Al$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex

$\text{Al}^{1+} + \text{Ni}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Al}^{1+} + \text{Cu}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Al}^{1+} + \text{Ag}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Al}^{1+} + \text{Ta}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Al}^{1+} + \text{Au}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cl}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cl}^{1+} + \text{Al}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cl}^{1+} + \text{Ni}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cl}^{1+} + \text{Cu}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cl}^{1+} + \text{Ag}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cl}^{1+} + \text{Ta}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cl}^{1+} + \text{Au}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cu}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cu}^{1+} + \text{Al}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cu}^{1+} + \text{Ni}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cu}^{1+} + \text{Cu}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cu}^{1+} + \text{Ag}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cu}^{1+} + \text{Ta}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex
$\text{Cu}^{1+} + \text{Au}$	Particle Beam-Matter interaction	0.50-2.50 MeV/amu	Ex

1361. P. Sigmund, A. Schinner

Effective charge and related/unrelated quantities in heavy-ion stopping.

Nucl. Instrum. Methods Phys. Res. B **174**, 535 (2001)

$\text{He}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th
$\text{Be}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th
$\text{Be}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th
$\text{O}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th
$\text{O}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th
$\text{O}^{1+} + \text{Al}$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th
$\text{Ar}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th
$\text{Ar}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th
$\text{Ar}^{1+} + \text{Al}$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th
$\text{Xe}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th
$\text{Xe}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.01-100.00 MeV/amu	Th

1362. K.-M. Wang, H.-K. Hu, F. Q. Lu, F. Z. Chen, J.-H. Zhang, X.-D. Liu, B.-R. Shi, Y.-G. Liu

Mean projected range and range straggling of Bi^+ ions implanted into lithium triborate.

Nucl. Instrum. Methods Phys. Res. B **174**, 65 (2001)

$\text{Bi}^{1+} + \text{LiB}_3\text{O}_5$	Particle Beam-Matter interaction	100.00-350.00 keV	Ex
$\text{Bi}^{1+} + \text{LiB}_3\text{O}_5$	Particle Beam-Matter interaction	100.00-350.00 keV	Ex

1363. J. E. Valdes, P. Vargas, N. R. Arista

Differences in the energy loss of protons and positive muons in solids.

Nucl. Instrum. Methods Phys. Res. B **174**, 9 (2001)

$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	2.50-25.00 keV	Th
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1364. I. E. Mozolevski

High energy ion range and deposited energy calculation using the Boltzmann-Fokker-Planck splitting of the Boltzmann transport equation.

Nucl. Instrum. Methods Phys. Res. B **175-177**, 113 (2001)

$\text{As}^{1+} + \text{Si}$	Particle Beam-Matter interaction	100.00 keV	Th
$\text{As}^{1+} + \text{Si}$	Particle Beam-Matter interaction	100.00 keV	Th

1365. G. Schiwietz, P. L. Grande

Improved charge-state formulas.

Nucl. Instrum. Methods Phys. Res. B **175-177**, 125 (2001)

	perturbation¹⁺ + C	Particle Beam-Matter interaction	5.00 MeV/amu	Th
	perturbation¹⁺ + C	Particle Beam-Matter interaction	5.00 MeV/amu	Th
1366.	J. P. De Souza, M. Behar, J. F. Dias, J.H.R Dos Santos Range parameters of ¹⁸O implanted into Si and SiO₂. Nucl. Instrum. Methods Phys. Res. B 175-177 , 46 (2001)			
	O¹⁺ + Si	Particle Beam-Matter interaction	25.00-200.00 keV	Ex
	O¹⁺ + Si	Particle Beam-Matter interaction	25.00-200.00 keV	Ex
	O¹⁺ + SiO₂	Particle Beam-Matter interaction	25.00-200.00 keV	Ex
	O¹⁺ + SiO₂	Particle Beam-Matter interaction	25.00-200.00 keV	Ex
1367.	J. C. Eckardt, G. H. Lantschner Experimental energy straggling of protons in thin solid foils. Nucl. Instrum. Methods Phys. Res. B 175-177 , 93 (2001)			
	H¹⁺ + C	Particle Beam-Matter interaction	10.00-200.00 keV	Ex
	H¹⁺ + Al	Particle Beam-Matter interaction	10.00-200.00 keV	Ex
	H¹⁺ + Mn	Particle Beam-Matter interaction	10.00-200.00 keV	Ex
	H¹⁺ + Cu	Particle Beam-Matter interaction	10.00-200.00 keV	Ex
	H¹⁺ + Zn	Particle Beam-Matter interaction	10.00-200.00 keV	Ex
	H¹⁺ + Se	Particle Beam-Matter interaction	10.00-200.00 keV	Ex
	H¹⁺ + Ag	Particle Beam-Matter interaction	10.00-200.00 keV	Ex
	H¹⁺ + Sb	Particle Beam-Matter interaction	10.00-200.00 keV	Ex
	H¹⁺ + Au	Particle Beam-Matter interaction	10.00-200.00 keV	Ex
	H¹⁺ + Bi	Particle Beam-Matter interaction	10.00-200.00 keV	Ex
1368.	D. L. da Silva, G. de M. Azevedo, M. Behar, J. F. Dias, P. L. Grande Random energy loss and straggling study of Li into Si. Nucl. Instrum. Methods Phys. Res. B 175-177 , 98 (2001)			
	Li¹⁺ + Si	Particle Beam-Matter interaction	0.28-8.50 MeV	Ex
	Li¹⁺ + Si	Particle Beam-Matter interaction	0.28-8.50 MeV	Ex
	Li¹⁺ + Si	Particle Beam-Matter interaction	0.28-8.50 MeV	Ex
1369.	H. Paul, A. Schinner An empirical approach to the stopping power of solids and gases for ions from ₃Li to ₁₈Ar. Nucl. Instrum. Methods Phys. Res. B 179 , 299 (2001)			
	Li¹⁺ + Be	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + C	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + N	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + O	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Ne	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Al	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Si	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Ar	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Ti	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Cu	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Kr	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Ag	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Sn	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Xe	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Pt	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Au	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + Pb	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Li¹⁺ + U	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Be¹⁺ + Be	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Be¹⁺ + C	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
	Be¹⁺ + N	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th

$\text{Ar}^{1+} + \text{Ti}$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
$\text{Ar}^{1+} + \text{Cu}$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
$\text{Ar}^{1+} + \text{Kr}$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
$\text{Ar}^{1+} + \text{Kr}$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
$\text{Ar}^{1+} + \text{Ag}$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
$\text{Ar}^{1+} + \text{Sn}$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
$\text{Ar}^{1+} + \text{Xe}$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
$\text{Ar}^{1+} + \text{Pt}$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
$\text{Ar}^{1+} + \text{Au}$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
$\text{Ar}^{1+} + \text{Pb}$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th
$\text{Ar}^{1+} + \text{U}$	Particle Beam-Matter interaction	0.00-1.00 GeV/amu	Th

1370. M. S. Gravielle, D. G. Arbo, J. E. Miraglia

Binary contribution to the stopping in fast ion-surface collisions.

Nucl. Instrum. Methods Phys. Res. B **182**, 29 (2001)

$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	700.00 keV	Th
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1371. P. Bauer, D. Semrad

How to predict physical and chemical state effects in electronic stopping.

Nucl. Instrum. Methods Phys. Res. B **182**, 62 (2001)

$\text{H} + \text{Mg}$	Particle Beam-Matter interaction	10.00-600.00 keV	Th
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1372. A. Sarasola, J. D. Fuhr, V. H. Ponce, A. Arnau

Study of the validity of the local density approximation in calculating stopping power and related quantities.

Nucl. Instrum. Methods Phys. Res. B **182**, 67 (2001)

$\text{H}^{1+} + \text{H}$	Particle Beam-Matter interaction	0.00-3.60 MeV	Th
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1373. G. Kuri, G. Materlik

Measured transverse straggling of MeV Sn and Sb ions implanted in SiO_2 targets.

Nucl. Instrum. Methods Phys. Res. B **183**, 189 (2001)

$\text{Sn}^{1+} + \text{SiO}_2$	Particle Beam-Matter interaction	1.35-3.60 MeV	E/T
$\text{Sn}^{1+} + \text{SiO}_2$	Particle Beam-Matter interaction	1.35-3.60 MeV	E/T
$\text{Sb}^{1+} + \text{SiO}_2$	Particle Beam-Matter interaction	1.35-3.60 MeV	E/T
$\text{Sb}^{1+} + \text{SiO}_2$	Particle Beam-Matter interaction	1.35-3.60 MeV	E/T

1374. W. H. Trzaska, T. Alanko, V. Lyapin, J. Raeisaenen

A novel method for obtaining continuous stopping power curves.

Nucl. Instrum. Methods Phys. Res. B **183**, 203 (2001)

$\text{Ar}^{1+} + \text{C}$	Particle Beam-Matter interaction	1.00-25.00 MeV	E/T
$\text{Ar}^{1+} + \text{Ni}$	Particle Beam-Matter interaction	1.00-25.00 MeV	E/T
$\text{Ar}^{1+} + \text{Au}$	Particle Beam-Matter interaction	1.00-25.00 MeV	E/T

1375. Y. Zhang, G. Possnert, H. J. Whitlow

Measurements of the mean energy-loss of swift heavy ions in carbon with high precision.

Nucl. Instrum. Methods Phys. Res. B **183**, 34 (2001)

$\text{Li}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex
$\text{Be}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex
$\text{B}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex
$\text{C}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex
$\text{N}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex
$\text{O}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex
$\text{F}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex
$\text{Na}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex
$\text{Mg}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex
$\text{Al}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex

$\text{Si}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex
$\text{Cr}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex
$\text{Mn}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex
$\text{Fe}^{1+} + \text{C}$	Particle Beam-Matter interaction	0.03-0.90 MeV/amu	Ex

1376. J. E. Bateman

A new model for electron ranges in solid materials.

Nucl. Instrum. Methods Phys. Res. B **184**, 478 (2001)

$\text{e} + \text{Al}$	Particle Beam-Matter interaction	1.00-50.00 keV	Th
$\text{e} + \text{Cu}$	Particle Beam-Matter interaction	1.00-50.00 keV	Th
$\text{e} + \text{Au}$	Particle Beam-Matter interaction	1.00-50.00 keV	Th

1377. X. Liu, P. Liu, F. Chen, M. Zhao, Y. Ma, M. Ying, J. Zhang, Q. Lu, C. Wang

Electronic stopping powers for fluorine ions in $^{19}\text{F}^{+}$ -implanted tin-oxide films prepared by APCVD.

Nucl. Instrum. Methods Phys. Res. B **187**, 431 (2002)

$\text{F}^{1+} + \text{SnO}_2$	Particle Beam-Matter interaction	50.00-180.00 keV	Ex
$\text{F}^{1+} + \text{SnO}_2$	Particle Beam-Matter interaction	50.00-180.00 keV	Ex
$\text{F}^{1+} + \text{SnO}_2$	Particle Beam-Matter interaction	50.00-180.00 keV	Ex

1378. S. Heredia-Avalos, R. Garcia-Molina, I. Abril

Spatial and energy distributions of the fragments resulting from the dissociation of swift molecular ions in solids.

Nucl. Instrum. Methods Phys. Res. B **190**, 131 (2002)

$\text{B}^{1+} + \text{Si}$	Particle Beam-Matter interaction	4.00 MeV	Th
$\text{B}^{1+} + \text{Si}$	Particle Beam-Matter interaction	4.00 MeV	Th
$\text{B}^{1+} + \text{Si}$	Particle Beam-Matter interaction	4.00 MeV	Th
$\text{B}_3^{1+} + \text{Si}$	Particle Beam-Matter interaction	4.00 MeV	Th
$\text{B}_3^{1+} + \text{Si}$	Particle Beam-Matter interaction	4.00 MeV	Th
$\text{B}_3^{1+} + \text{Si}$	Particle Beam-Matter interaction	4.00 MeV	Th

1379. A. Blazevic, H. G. Bohlen, W. Von Oertzen

Stopping power of swift neon ions in dependence on the charge state in the non-equilibrium regime.

Nucl. Instrum. Methods Phys. Res. B **190**, 64 (2002)

$\text{Ne}^{6+} + \text{C}$	Particle Beam-Matter interaction	2.00 MeV/amu	Ex
$\text{Ne}^{7+} + \text{C}$	Particle Beam-Matter interaction	2.00 MeV/amu	Ex
$\text{Ne}^{8+} + \text{C}$	Particle Beam-Matter interaction	2.00 MeV/amu	Ex
$\text{Ne}^{9+} + \text{C}$	Particle Beam-Matter interaction	2.00 MeV/amu	Ex
$\text{Ne}^{10+} + \text{C}$	Particle Beam-Matter interaction	2.00 MeV/amu	Ex

1380. Y. Zhang, G. Possnert

Electronic stopping power of swift heavy ions in carbon.

Nucl. Instrum. Methods Phys. Res. B **190**, 69 (2002)

$\text{He}^{1+} + \text{C}$	Particle Beam-Matter interaction	100.00-800.00 keV/amu	Ex
$\text{Be}^{1+} + \text{C}$	Particle Beam-Matter interaction	100.00-800.00 keV/amu	Ex
$\text{C}^{1+} + \text{C}$	Particle Beam-Matter interaction	100.00-800.00 keV/amu	Ex
$\text{Al}^{1+} + \text{C}$	Particle Beam-Matter interaction	100.00-800.00 keV/amu	Ex

1381. M. Behar, C. Cohen, J.H.R Dos Santos, P. L. Grande

Energy loss measurements of H_2 and H_3 molecular beams along random and $[110]$ directions of Si.

Nucl. Instrum. Methods Phys. Res. B **190**, 74 (2002)

$\text{H}_2^{1+} + \text{Si}$	Particle Beam-Matter interaction	0.60-2.10 MeV	Ex
$\text{H}_3^{1+} + \text{Si}$	Particle Beam-Matter interaction	0.60-2.10 MeV	Ex

1382. L. L. Araujo, P. L. Grande, M. Behar, J.H.R Dos Santos
Random stopping power and energy straggling of ^{16}O ions into amorphous Si target.
 Nucl. Instrum. Methods Phys. Res. B **190**, 79 (2002)
 $\text{O}^{1+} + \text{Si}$ Particle Beam-Matter interaction 0.30-13.50 MeV Ex
1383. H. J. Whitlow, H. Timmers, R. G. Elliman, T.D.M. Weijers, Y. Zhang, J. Uribastera, D. J. O'Connor
Measurements of Si ion stopping in amorphous silicon.
 Nucl. Instrum. Methods Phys. Res. B **190**, 84 (2002)
 $\text{Si}^{1+} + \text{Si}$ Particle Beam-Matter interaction 0.10-3.30 MeV/amu Ex
1384. I. Abril, R. Garcia-Molina, N. R. Arista, C. F. Sanz-Navarro
Electronic energy loss of swift protons in the oxides Al_2O_3 , SiO_2 and ZrO_2 .
 Nucl. Instrum. Methods Phys. Res. B **190**, 89 (2002)
 $\text{H}^{1+} + \text{Al}_2\text{O}_3$ Particle Beam-Matter interaction 0.00-1.00 MeV Ex
 $\text{H}^{1+} + \text{SiO}_2$ Particle Beam-Matter interaction 0.00-1.00 MeV Ex
 $\text{H}^{1+} + \text{ZrO}_2$ Particle Beam-Matter interaction 0.00-1.00 MeV Ex
1385. K. J. Coakley, H. H. Chen-Mayer, G. P. Lamaze, D. S. Simons, P. E. Thompson
Calibration of a stopping power model for silicon based on analysis of neutron depth profiling and secondary ion mass spectrometry measurements.
 Nucl. Instrum. Methods Phys. Res. B **192**, 349 (2002)
 $\text{He}^{1+} + \text{Si}$ Particle Beam-Matter interaction 1.47-1.78 MeV Th
1386. H. Weick, A. H. Sorensen, H. Geissel, C. Scheidenberger, F. Attallah, V. Chichkine, S. Elisseev, M. Hausmann, H. Irnich, Y. Litvinov
Energy-loss straggling of (200-1000) MeV/u uranium ions.
 Nucl. Instrum. Methods Phys. Res. B **193**, 1 (2002)
 $\text{U}^{91+} + \text{Be}$ Particle Beam-Matter interaction 0.20-1.00 GeV/amu E/T
 $\text{U}^{91+} + \text{Be}$ Particle Beam-Matter interaction 0.20-1.00 GeV/amu E/T
 $\text{U}^{91+} + \text{Al}$ Particle Beam-Matter interaction 0.20-1.00 GeV/amu E/T
 $\text{U}^{91+} + \text{Al}$ Particle Beam-Matter interaction 0.20-1.00 GeV/amu E/T
 $\text{U}^{91+} + \text{Pb}$ Particle Beam-Matter interaction 0.20-1.00 GeV/amu E/T
 $\text{U}^{91+} + \text{Pb}$ Particle Beam-Matter interaction 0.20-1.00 GeV/amu E/T
1387. C. Ciorte, D. Dumitriu, S. E. Enescu, A. Enulescu, D. Flueraşu, I. Piticu, Z. S. Szilagy
Inner-shell vacancy production and mean charge states of MeV/u Fe, Co, Ni and Cu ions in Au and Bi solid targets.
 Nucl. Instrum. Methods Phys. Res. B **193**, 109 (2002)
 $\text{Fe}^{1+} + \text{Au}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Fe}^{1+} + \text{Au}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Fe}^{1+} + \text{Bi}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Fe}^{1+} + \text{Bi}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Co}^{1+} + \text{Au}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Co}^{1+} + \text{Au}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Co}^{1+} + \text{Bi}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Co}^{1+} + \text{Bi}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Ni}^{1+} + \text{Au}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Ni}^{1+} + \text{Au}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Ni}^{1+} + \text{Bi}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Ni}^{1+} + \text{Bi}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Cu}^{1+} + \text{Au}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Cu}^{1+} + \text{Au}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Cu}^{1+} + \text{Bi}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex
 $\text{Cu}^{1+} + \text{Bi}$ Particle Beam-Matter interaction 0.10-1.50 MeV/amu Ex

1388. S. Heredia-Avalos, R. Garcia-Molina
Projectile polarization effects in the energy loss of swift ions in solids.
 Nucl. Instrum. Methods Phys. Res. B **193**, 15 (2002)

$\text{H} + \text{Al}$	Particle Beam-Matter interaction	1.00-100.00 keV	Th
$\text{H}^{1+} + \text{Al}$	Particle Beam-Matter interaction	1.00-100.00 keV	Th
1389. K. Czerski, A. Huke, P. Heide, G. Schiwietz
Solid-state effects in d+d fusion reactions.
 Nucl. Instrum. Methods Phys. Res. B **193**, 183 (2002)

$\text{H} + \text{H}$	Particle Beam-Matter interaction	5.00-60.00 keV	Ex
$\text{H} + \text{He}$	Particle Beam-Matter interaction	5.00-60.00 keV	Ex
1390. C. D. Denton, I. Abril, M. D. Barriga-Carrasco, R. Garcia-Molina, G. H. Lantschner, J. C. Eckardt, N. R. Arista
Effect of the neutral charge fraction in the Coulomb explosion of H_2^+ ions through aluminum foils.
 Nucl. Instrum. Methods Phys. Res. B **193**, 198 (2002)

$\text{H}_2^{1+} + \text{Al}$	Particle Beam-Matter interaction	25.00-100.00 keV/amu	Ex
$\text{H}_2^{1+} + \text{Al}$	Particle Beam-Matter interaction	25.00-100.00 keV/amu	Ex
1391. G. Maynard, M. Sarrazin, K. Katsonis, K. Dimitriou
Quantum and classical stopping cross-sections of swift heavy ions derived from the evolution with time of the Wigner function.
 Nucl. Instrum. Methods Phys. Res. B **193**, 20 (2002)

$\text{Ne}^{6+} + \text{C}$	Particle Beam-Matter interaction	2.00 MeV/amu	Th
$\text{Ne}^{7+} + \text{C}$	Particle Beam-Matter interaction	2.00 MeV/amu	Th
$\text{Ne}^{8+} + \text{C}$	Particle Beam-Matter interaction	2.00 MeV/amu	Th
$\text{Ne}^{9+} + \text{C}$	Particle Beam-Matter interaction	2.00 MeV/amu	Th
$\text{Ne}^{10+} + \text{C}$	Particle Beam-Matter interaction	2.00 MeV/amu	Th
1392. H.-W. Li, Y.-N. Wang, Z. L. Miskovic
Influence of wake-potential asymmetry on charge states and Coulomb explosion of fast molecular ions in solids.
 Nucl. Instrum. Methods Phys. Res. B **193**, 204 (2002)

$\text{N}_2^{1+} + \text{Al}$	Particle Beam-Matter interaction		Th
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1393. Z. L. Miskovic, F. O. Goodman, W.-K. Liu
Fluctuating charge-state effects on energy spectra of fast ions in solids.
 Nucl. Instrum. Methods Phys. Res. B **193**, 26 (2002)

$\text{H} + \text{Al}$	Particle Beam-Matter interaction		Th
$\text{He} + \text{Al}$	Particle Beam-Matter interaction		Th
1394. J. C. Moreno-Marin, I. Abril, R. Garcia-Molina
Stopping power calculation of rubidium and strontium for protons.
 Nucl. Instrum. Methods Phys. Res. B **193**, 30 (2002)

$\text{H}^{1+} + \text{Rb}$	Particle Beam-Matter interaction	0.00-1.00 MeV	Th
$\text{H}^{1+} + \text{Rb}$	Particle Beam-Matter interaction	0.00-1.00 MeV	Th
$\text{H}^{1+} + \text{Sr}$	Particle Beam-Matter interaction	0.00-1.00 MeV	Th
$\text{H}^{1+} + \text{Sr}$	Particle Beam-Matter interaction	0.00-1.00 MeV	Th
1395. S. Ouichaoui, B. Bouzid
Energy loss straggling of swift heavy ions below 100 MeV/u.
 Nucl. Instrum. Methods Phys. Res. B **193**, 36 (2002)

$\text{O}^{1+} + \text{Al}$	Particle Beam-Matter interaction		Th
$\text{O}^{1+} + \text{Al}$	Particle Beam-Matter interaction		Th

1396. J. E. Valdes, P. Vargas, C. D. Denton, N. R. Arista
Energy loss straggling of low-velocity protons and deuterons channeled in Au₁₀₀.
 Nucl. Instrum. Methods Phys. Res. B **193**, 43 (2002)
- | | | | |
|-----------------------------|----------------------------------|----------------|----|
| $\text{H}^{1+} + \text{Au}$ | Particle Beam-Matter interaction | 2.50-25.00 keV | Th |
| $\text{H}^{1+} + \text{Au}$ | Particle Beam-Matter interaction | 2.50-25.00 keV | Th |
| $\text{D}^{1+} + \text{Au}$ | Particle Beam-Matter interaction | 2.50-25.00 keV | Th |
| $\text{D}^{1+} + \text{Au}$ | Particle Beam-Matter interaction | 2.50-25.00 keV | Th |
1397. P. Sigmund, A. Schinner
Binary theory of light-ion stopping.
 Nucl. Instrum. Methods Phys. Res. B **193**, 49 (2002)
- | | | | |
|------------------------------|----------------------------------|----------------|----|
| $\text{H} + \text{C}$ | Particle Beam-Matter interaction | 0.00-10.00 MeV | Th |
| $\text{H} + \text{Al}$ | Particle Beam-Matter interaction | 0.00-10.00 MeV | Th |
| $\text{H}^{1+} + \text{C}$ | Particle Beam-Matter interaction | 0.00-10.00 MeV | Th |
| $\text{H}^{1+} + \text{Al}$ | Particle Beam-Matter interaction | 0.00-10.00 MeV | Th |
| $\text{He} + \text{C}$ | Particle Beam-Matter interaction | 0.00-10.00 MeV | Th |
| $\text{He} + \text{Al}$ | Particle Beam-Matter interaction | 0.00-10.00 MeV | Th |
| $\text{He}^{1+} + \text{C}$ | Particle Beam-Matter interaction | 0.00-10.00 MeV | Th |
| $\text{He}^{1+} + \text{Al}$ | Particle Beam-Matter interaction | 0.00-10.00 MeV | Th |
| $\text{He}^{2+} + \text{C}$ | Particle Beam-Matter interaction | 0.00-10.00 MeV | Th |
| $\text{He}^{2+} + \text{Al}$ | Particle Beam-Matter interaction | 0.00-10.00 MeV | Th |
1398. L. G. Glazov
Multiple-peak structures in energy-loss spectra of swift ions.
 Nucl. Instrum. Methods Phys. Res. B **193**, 56 (2002)
- | | | | |
|-----------------------------|----------------------------------|-----------|----|
| $\text{He}^{1+} + \text{C}$ | Particle Beam-Matter interaction | 32.00 MeV | Th |
| $\text{He}^{2+} + \text{C}$ | Particle Beam-Matter interaction | 32.00 MeV | Th |
1399. M. Alducin, V. M. Silkin, J. I. Juaristi, E. V. Chulkov
Effect of surface band structure in the energy loss of ions at surfaces.
 Nucl. Instrum. Methods Phys. Res. B **193**, 585 (2002)
- | | | | |
|-----------------------------|----------------------------------|----------------|----|
| $\text{H}^{1+} + \text{Cu}$ | Particle Beam-Matter interaction | 8.00-25.00 keV | Th |
|-----------------------------|----------------------------------|----------------|----|
1400. A. Dubus, N. Pauly, M. Roesler, H. Rothard, M. Beuve, M. Caron, B. Gervais, A. Clouvas, C. Potiradis
Experimental and theoretical study of the ratio between the electron emission yield and the electronic stopping power for protons incident on thin carbon foils.
 Nucl. Instrum. Methods Phys. Res. B **193**, 621 (2002)
- | | | | |
|----------------------------|----------------------------------|---------------|-----|
| $\text{H}^{1+} + \text{C}$ | Particle Beam-Matter interaction | 0.20-9.20 MeV | E/T |
|----------------------------|----------------------------------|---------------|-----|
1401. M. Bianconi, G. G. Bentini, R. Lotti, R. Nipoti
Charge states distribution of 0.16-3.3 MeV He ions transmitted through silicon.
 Nucl. Instrum. Methods Phys. Res. B **193**, 66 (2002)
- | | | | |
|------------------------------|----------------------------------|---------------|-----|
| $\text{He}^{1+} + \text{Si}$ | Particle Beam-Matter interaction | 0.16-3.30 MeV | E/T |
|------------------------------|----------------------------------|---------------|-----|
1402. M. Imai, M. Sataka, S. Kitazawa, K. Komaki, K. Kawatsura, H. Shibata, H. Tawara, T. Azuma, Y. Kanai, Y. Yamazaki
Angular momentum distributions of Rydberg state electrons of Be-like sulfur produced through foil penetration.
 Nucl. Instrum. Methods Phys. Res. B **193**, 674 (2002)
- | | | | |
|-----------------------------|----------------------------------|--------------|----|
| $\text{S}^{7+} + \text{C}$ | Particle Beam-Matter interaction | 2.50 MeV/amu | Ex |
| $\text{S}^{10+} + \text{C}$ | Particle Beam-Matter interaction | 2.50 MeV/amu | Ex |
| $\text{S}^{12+} + \text{C}$ | Particle Beam-Matter interaction | 2.50 MeV/amu | Ex |
| $\text{S}^{13+} + \text{C}$ | Particle Beam-Matter interaction | 2.50 MeV/amu | Ex |
1403. D. Emfietzoglou, M. Moscovitch
Inelastic collision characteristics of electrons in liquid water.
 Nucl. Instrum. Methods Phys. Res. B **193**, 71 (2002)

- | | | | | |
|--|------------|----------------------------------|----------------|----|
| | $e + H_2O$ | Particle Beam-Matter interaction | 0.01-10.00 keV | Th |
| | $e + H_2O$ | Particle Beam-Matter interaction | 0.01-10.00 keV | Th |
1404. T. Minami, C. O. Reinhold, M. Seliger, J. Burgdoerfer, C. Fourment, B. Gervais, E. Lamour, J.-P. Rozet, D. Vernhet
Evidence of collisional coherences in the transport of hydrogenic krypton through amorphous carbon foils.
Nucl. Instrum. Methods Phys. Res. B **193**, 79 (2002)
- | | | | | |
|--|----------------|----------------------------------|---------------|-----|
| | $Kr^{35+} + C$ | Particle Beam-Matter interaction | 60.00 MeV/amu | E/T |
|--|----------------|----------------------------------|---------------|-----|
1405. H. Ogawa, N. Sakamoto, H. Tsuchida
Angular distribution of 2.5-MeV H^0 atoms transmitted through a thin carbon foil in frozen charge state.
Nucl. Instrum. Methods Phys. Res. B **193**, 85 (2002)
- | | | | | |
|--|---------|----------------------------------|----------|----|
| | $H + C$ | Particle Beam-Matter interaction | 2.50 MeV | Ex |
| | $H + C$ | Particle Beam-Matter interaction | 2.50 MeV | Ex |
1406. M. Fama, G. H. Lantschner, J. C. Eckardt, N. R. Arista, J. E. Gayone, E. Sanchez, F. Lovey
Energy loss and angular dispersion of 2-200 keV protons in amorphous silicon.
Nucl. Instrum. Methods Phys. Res. B **193**, 91 (2002)
- | | | | | |
|--|---------------|----------------------------------|-----------------|----|
| | $H^{1+} + Si$ | Particle Beam-Matter interaction | 2.00-200.00 keV | Ex |
| | $H^{1+} + Si$ | Particle Beam-Matter interaction | 2.00-200.00 keV | Ex |
1407. N. P. Barradas, C. Jeynes, R. P. Webb, E. Wendler
Accurate determination of the stopping power of 4He in Si using Bayesian inference.
Nucl. Instrum. Methods Phys. Res. B **194**, 15 (2002)
- | | | | | |
|--|----------------|----------------------------------|----------------|----|
| | $H^{1+} + Si$ | Particle Beam-Matter interaction | 1.00-12.00 MeV | Th |
| | $He^{1+} + Si$ | Particle Beam-Matter interaction | 1.00-12.00 MeV | Th |
1408. H. H. Andersen, A. Csete, T. Ichioka, H. Knudsen, S. P. Moller, U. I. Uggerhoj
An apparatus to measure stopping powers for low-energy antiprotons and protons.
Nucl. Instrum. Methods Phys. Res. B **194**, 217 (2002)
- | | | | | |
|--|---------------|----------------------------------|---------------|----|
| | $H^{1+} + C$ | Particle Beam-Matter interaction | 0.00-3.00 MeV | Ex |
| | $H^{1+} + C$ | Particle Beam-Matter interaction | 0.00-3.00 MeV | Ex |
| | $H^{1+} + Al$ | Particle Beam-Matter interaction | 0.00-3.00 MeV | Ex |
| | $H^{1+} + Al$ | Particle Beam-Matter interaction | 0.00-3.00 MeV | Ex |
| | $H^{1+} + Si$ | Particle Beam-Matter interaction | 0.00-3.00 MeV | Ex |
| | $H^{1+} + Si$ | Particle Beam-Matter interaction | 0.00-3.00 MeV | Ex |
| | $H^{1+} + Ni$ | Particle Beam-Matter interaction | 0.00-3.00 MeV | Ex |
| | $H^{1+} + Ni$ | Particle Beam-Matter interaction | 0.00-3.00 MeV | Ex |
| | $H^{1+} + Au$ | Particle Beam-Matter interaction | 0.00-3.00 MeV | Ex |
| | $H^{1+} + Au$ | Particle Beam-Matter interaction | 0.00-3.00 MeV | Ex |
1409. P. Baving, H. W. Becker, C. Rolfs, H. Zabel
Stopping power of He ions in niobium from a comparison of RBS and X-ray reflectivity measurements.
Nucl. Instrum. Methods Phys. Res. B **194**, 363 (2002)
- | | | | | |
|--|----------------|----------------------------------|---------------|----|
| | $He^{1+} + Nb$ | Particle Beam-Matter interaction | 0.40-2.80 MeV | Ex |
|--|----------------|----------------------------------|---------------|----|
1410. J. W. Wilson, J. Tweed, H. Tai, R. K. Tripathi
A simple model for straggling evaluation.
Nucl. Instrum. Methods Phys. Res. B **194**, 389 (2002)
- | | | | | |
|--|----------------|----------------------------------|-----------------|----|
| | $H^{1+} + O_2$ | Particle Beam-Matter interaction | 5.00-100.00 MeV | Th |
| | $H^{1+} + Al$ | Particle Beam-Matter interaction | 5.00-100.00 MeV | Th |

1411. S. Heredia-Avalos, R. Garcia-Molina

Energy loss of swift oxygen molecular ions traversing amorphous carbon foils.

Phys. Lett. A **275**, 73 (2000)

$\text{O}^{1+} + \text{C}$	Particle Beam-Matter interaction	5.00 MeV	Th
$\text{O}_2^{-1+} + \text{C}$	Particle Beam-Matter interaction	5.00 MeV	Th
$\text{O}_2^{1+} + \text{C}$	Particle Beam-Matter interaction	5.00 MeV	Th

1412. M. Penalba, J. I. Juaristi, E. Zarate, A. Arnau, P. Bauer

Electronic stopping power of Al_2O_3 and SiO_2 for H, He, and N.

Phys. Rev. A **64**, 012902 (2001)

$\text{H}^{1+} + \text{Al}_2\text{O}_3$	Particle Beam-Matter interaction	0.20-5.00 a.u.	E/T
$\text{H}^{1+} + \text{SiO}_2$	Particle Beam-Matter interaction	0.20-5.00 a.u.	E/T
$\text{He}^{1+} + \text{Al}_2\text{O}_3$	Particle Beam-Matter interaction	0.20-5.00 a.u.	E/T
$\text{He}^{1+} + \text{SiO}_2$	Particle Beam-Matter interaction	0.20-5.00 a.u.	E/T
$\text{N}^{1+} + \text{Al}_2\text{O}_3$	Particle Beam-Matter interaction	0.20-5.00 a.u.	E/T
$\text{N}^{1+} + \text{SiO}_2$	Particle Beam-Matter interaction	0.20-5.00 a.u.	E/T

1413. N. R. Arista

Interaction of ions and molecules with surface modes in cylindrical channels in solids.

Phys. Rev. A **64**, 032901 (2001)

$\text{H}^{1+} + \text{Al}_2\text{O}_3$	Particle Beam-Matter interaction	80.00 a.u.	Th
$\text{H}^{1+} + \text{Ag}$	Particle Beam-Matter interaction	80.00 a.u.	Th

1414. S. P. Moller, V. Biryukov, S. Datz, P. Grafstroem, H. Knudsen, H. F. Krause, C. Scheidenberger, U. I. Uggerhoj, C. R. Vane

Random and channeled energy loss of 33.2-TeV Pb nuclei in silicon single crystals.

Phys. Rev. A **64**, 032902 (2001)

$\text{Pb}^{82+} + \text{Si}$	Particle Beam-Matter interaction	160.00 GeV/amu	Ex
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1415. C. M. Kwei, J. J. Chou, J. Yao, C. J. Tung

Electronic stopping powers of solids for slow atoms.

Phys. Rev. A **64**, 042901 (2001)

$\text{C} + \text{Al}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{C} + \text{Ni}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{C} + \text{Ag}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{C} + \text{Au}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{N} + \text{Al}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{N} + \text{Ni}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{N} + \text{Ag}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{N} + \text{Au}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{O} + \text{Al}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{O} + \text{Ni}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{O} + \text{Ag}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{O} + \text{Au}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{F} + \text{Al}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{F} + \text{Ni}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{F} + \text{Ag}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{F} + \text{Au}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{Ne} + \text{Al}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{Ne} + \text{Ni}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{Ne} + \text{Ag}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{Ne} + \text{Au}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{Na} + \text{Al}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{Na} + \text{Ni}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{Na} + \text{Ag}$	Particle Beam-Matter interaction	0.82 a.u.	Th
$\text{Na} + \text{Au}$	Particle Beam-Matter interaction	0.82 a.u.	Th

Mg + Al	Particle Beam-Matter interaction	0.82 a.u.	Th
Mg + Ni	Particle Beam-Matter interaction	0.82 a.u.	Th
Mg + Ag	Particle Beam-Matter interaction	0.82 a.u.	Th
Mg + Au	Particle Beam-Matter interaction	0.82 a.u.	Th
Al + Al	Particle Beam-Matter interaction	0.82 a.u.	Th
Al + Ni	Particle Beam-Matter interaction	0.82 a.u.	Th
Al + Ag	Particle Beam-Matter interaction	0.82 a.u.	Th
Al + Au	Particle Beam-Matter interaction	0.82 a.u.	Th
Si + Al	Particle Beam-Matter interaction	0.82 a.u.	Th
Si + Ni	Particle Beam-Matter interaction	0.82 a.u.	Th
Si + Ag	Particle Beam-Matter interaction	0.82 a.u.	Th
Si + Au	Particle Beam-Matter interaction	0.82 a.u.	Th
P + Al	Particle Beam-Matter interaction	0.82 a.u.	Th
P + Ni	Particle Beam-Matter interaction	0.82 a.u.	Th
P + Ag	Particle Beam-Matter interaction	0.82 a.u.	Th
P + Au	Particle Beam-Matter interaction	0.82 a.u.	Th
S + Al	Particle Beam-Matter interaction	0.82 a.u.	Th
S + Ni	Particle Beam-Matter interaction	0.82 a.u.	Th
S + Ag	Particle Beam-Matter interaction	0.82 a.u.	Th
S + Au	Particle Beam-Matter interaction	0.82 a.u.	Th
Cl + Al	Particle Beam-Matter interaction	0.82 a.u.	Th
Cl + Ni	Particle Beam-Matter interaction	0.82 a.u.	Th
Cl + Ag	Particle Beam-Matter interaction	0.82 a.u.	Th
Cl + Au	Particle Beam-Matter interaction	0.82 a.u.	Th
Ar + Al	Particle Beam-Matter interaction	0.82 a.u.	Th
Ar + Ni	Particle Beam-Matter interaction	0.82 a.u.	Th
Ar + Ag	Particle Beam-Matter interaction	0.82 a.u.	Th
Ar + Au	Particle Beam-Matter interaction	0.82 a.u.	Th

1416. M. Zamkov, H. Aliabadi, E. P. Benis, P. Richard, H. Tawara, T.J.M. Zouros
Energy dependence of the metastable fraction in B^{3+} ($1s^2\ ^1S, 1s2s\ ^3S$) beams produced in collisions with thin-foil and gas targets.
 Phys. Rev. A **64**, 052702 (2001)

$B^{2+} + C$	Particle Beam-Matter interaction	0.85-9.00 MeV	E/T
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1417. Z. L. Miskovic, W.-K. Liu, F. O. Goodman, Y.-N. Wang
Ion-charge distribution in fast, partially stripped clusters passing thin foils.
 Phys. Rev. A **64**, 064901 (2001)

Na ₂₀ + Al	Particle Beam-Matter interaction	2.00-5.00 a.u.	Th
Na ₁₀ + Al	Particle Beam-Matter interaction	2.00-5.00 a.u.	Th
Na ₃₀ + Al	Particle Beam-Matter interaction	2.00-5.00 a.u.	Th
Na ₅₀ + Al	Particle Beam-Matter interaction	2.00-5.00 a.u.	Th
Na ₁₀₀ + Al	Particle Beam-Matter interaction	2.00-5.00 a.u.	Th
Na ₂₀₀ + Al	Particle Beam-Matter interaction	2.00-5.00 a.u.	Th

1418. T. Minami, C. O. Reinhold, M. Seliger, J. Burgdoerfer, C. Fourment, E. Lamour, J.-P. Rozet, D. Vernhet, B. Gervais
Quantum transport of the internal state of Kr^{35+} ions through amorphous carbon foils.
 Phys. Rev. A **65**, 032901 (2002)

Kr^{35+}	Particle Beam-Matter interaction	60.00 MeV/amu	Th
$Kr^{35+} + C$	Particle Beam-Matter interaction	60.00 MeV/amu	Th
$Kr^{35+} + C$	Particle Beam-Matter interaction	60.00 MeV/amu	Th
$Kr^{35+} + C$	Particle Beam-Matter interaction	60.00 MeV/amu	Th

1419. D. G. Arbo, M. S. Gravielle, J. E. Miraglia, J. C. Eckardt, G. H. Lantschner, M. Fama, N. R. Arista
Energy straggling of protons through thin solid foils.
 Phys. Rev. A **65**, 042901 (2002)

- | | | | |
|-----------------------------|----------------------------------|---------------|-----|
| $\text{H}^{1+} + \text{Al}$ | Particle Beam-Matter interaction | 0.01-1.00 MeV | E/T |
| $\text{H}^{1+} + \text{Si}$ | Particle Beam-Matter interaction | 0.01-1.00 MeV | E/T |
| $\text{H}^{1+} + \text{Zn}$ | Particle Beam-Matter interaction | 0.01-1.00 MeV | E/T |
| $\text{H}^{1+} + \text{Au}$ | Particle Beam-Matter interaction | 0.01-1.00 MeV | E/T |
1420. H. Bichsel
Shell corrections in stopping powers.
 Phys. Rev. A **65**, 052709 (2002)
- | | | | |
|-----------------------------|----------------------------------|----------------|-----|
| $\text{H}^{1+} + \text{Al}$ | Particle Beam-Matter interaction | 0.30-10.00 MeV | E/T |
| $\text{H}^{1+} + \text{Si}$ | Particle Beam-Matter interaction | 0.30-10.00 MeV | E/T |
1421. M. Zamkov, E. P. Benis, P. Richard, T.J.M. Zouros
Fraction of metastable $1s2s\ ^3\text{S}$ ions in fast He-like beams ($Z=5-9$) produced in collisions with carbon foils.
 Phys. Rev. A **65**, 062706 (2002)
- | | | | |
|----------------------------|----------------------------------|-------------------|----|
| $\text{B}^{3+} + \text{C}$ | Particle Beam-Matter interaction | 0.50-2.00 MeV/amu | Ex |
| $\text{C}^{4+} + \text{C}$ | Particle Beam-Matter interaction | 0.50-2.00 MeV/amu | Ex |
| $\text{N}^{5+} + \text{C}$ | Particle Beam-Matter interaction | 0.50-2.00 MeV/amu | Ex |
| $\text{O}^{6+} + \text{C}$ | Particle Beam-Matter interaction | 0.50-2.00 MeV/amu | Ex |
| $\text{F}^{7+} + \text{C}$ | Particle Beam-Matter interaction | 0.50-2.00 MeV/amu | Ex |
1422. Y. Fujino, Y. Igarashi, S. Nagata
Ion-beam irradiation of Cu and a Cu-Ni alloy single-crystal specimens: Proposed atom movement mechanism.
 Phys. Rev. B **63**, 100101 (2001)
- | | | | |
|------------------------------|----------------------------------|------------|-----|
| $\text{Au}^{1+} + \text{Cu}$ | Particle Beam-Matter interaction | 300.00 keV | E/T |
|------------------------------|----------------------------------|------------|-----|
1423. H. O. Funsten, S. M. Ritzau, R. W. Harper
Negative helium ions exiting a carbon foil at keV energies.
 Phys. Rev. B **63**, 155416 (2001)
- | | | | |
|-----------------------------|----------------------------------|----------------|----|
| $\text{He}^{1+} + \text{C}$ | Particle Beam-Matter interaction | 8.00-80.00 keV | Ex |
|-----------------------------|----------------------------------|----------------|----|
1424. R. Pinzon, H. M. Urbassek
Implantation and damage under oblique low-energy Si self-bombardment.
 Phys. Rev. B **63**, 195319 (2001)
- | | | | |
|------------------------------|----------------------------------|-----------|----|
| $\text{Si}^{1+} + \text{Si}$ | Particle Beam-Matter interaction | 100.00 eV | Th |
|------------------------------|----------------------------------|-----------|----|
1425. G. de M. Azevedo, M. Behar, J. F. Dias, P. L. Grande, D. L. da Silva, G. Schiwietz
Random and channeling stopping powers of He and Li ions in Si.
 Phys. Rev. B **65**, 075203 (2002)
- | | | | |
|------------------------------|----------------------------------|---------------|----|
| $\text{He}^{1+} + \text{Si}$ | Particle Beam-Matter interaction | 0.20-9.00 MeV | Ex |
| $\text{Li}^{1+} + \text{Si}$ | Particle Beam-Matter interaction | 0.20-9.00 MeV | Ex |
1426. Yu. V. Arkhipov, F. B. Baimbetov, A. E. Davletov, K. V. Starikov
Stopping power in semiclassical, collisional plasmas.
 Phys. Scr. **63**, 194 (2001)
- | | | | |
|----------------------------|----------------------------------|--|----|
| $\text{e} + \text{B}^{1+}$ | Particle Beam-Matter interaction | | Th |
|----------------------------|----------------------------------|--|----|
1427. Y. Takabayashi, T. Ito, T. Azuma, K. Komaki, Y. Yamazaki, H. Tawara, M. Torikoshi, A. Kitagawa, E. Takada, T. Murakami
Convoy electron production and ionization in 390 MeV/u Ar^{17+} ion collisions with thin foils.
 Phys. Scr. **T80**, 249 (1999)
- | | | | |
|------------------------------|----------------------------------|----------------|----|
| $\text{Ar}^{17+} + \text{C}$ | Particle Beam-Matter interaction | 390.00 MeV/amu | Ex |
|------------------------------|----------------------------------|----------------|----|

1428. V. V. Balashov, I. V. Bodrenko
Charge-exchange effects in angular resolved energy-loss spectra of HCI propagating through matter.
 Phys. Scr. **T80**, 254 (1999)
 $\text{Li}^{2+} + \text{C}$ Particle Beam-Matter interaction 63.40 MeV Th
1429. T. Ito, T. Azuma, K. Komaki, Y. Yamazaki, M. Torikoshi, A. Kitagawa, E. Takada, T. Murakami
Direct observation of energy loss of charge-frozen hydrogen-like Ar ions.
 Phys. Scr. **T80**, 256 (1999)
 $\text{Ar}^{17+} + \text{Si}$ Particle Beam-Matter interaction 1.60-1.90 GeV/amu Ex
 $\text{Ar}^{18+} + \text{Si}$ Particle Beam-Matter interaction 1.60-1.90 GeV/amu Ex
1430. D. Vernhet, J.-P. Rozet, E. Lamour, B. Gervais, C. Fourment, L. J. Dube
Core and Rydberg state populations for HCI projectiles in solids.
 Phys. Scr. **T80**, 83 (1999)
 $\text{Ar}^{18+} + \text{C}$ Particle Beam-Matter interaction 13.60 MeV/amu E/T
 $\text{Ar}^{18+} + \text{C}$ Particle Beam-Matter interaction 13.60 MeV/amu E/T
1431. P. Sigmund, A. Schinner
Nonperturbative theory of charge-dependent heavy-ion stopping.
 Phys. Scr. **T92**, 222 (2001)
 $\text{C}^{1+} + \text{C}$ Particle Beam-Matter interaction 0.01-100.00 MeV/amu Th
 $\text{O}^{1+} + \text{C}$ Particle Beam-Matter interaction 0.01-100.00 MeV/amu Th
 $\text{O}^{1+} + \text{Al}$ Particle Beam-Matter interaction 0.01-100.00 MeV/amu Th
 $\text{Ni}^{1+} + \text{C}$ Particle Beam-Matter interaction 0.01-100.00 MeV/amu Th
1432. D. Vernhet, C. Fourment, E. Lamour, J.-P. Rozet, B. Gervais, L. J. Dube, F. Martin, T. Minami, C. O. Reinhold, M. Seliger, J. Burgdoerfer
Transport of Kr^{35+} inner-shells through solid carbon foils.
 Phys. Scr. **T92**, 233 (2001)
 $\text{Kr}^{35+} + \text{C}$ Particle Beam-Matter interaction 33.00-60.00 MeV/amu Ex
 $\text{Kr}^{36+} + \text{C}$ Particle Beam-Matter interaction 33.00-60.00 MeV/amu Ex
1433. H. Brauning, P. H. Mokler, D. Liesen, F. Bosch, B. Franzke, A. Kraemer, C. Kozhuharov, T. Ludziejewski, X. Ma, F. Nolden, M. Steck, Th. Stoehlker, R. W. Dunford, E. P. Kanter, G. Bednarz, A. Warczak, Z. Stachura, L. Tribedi, T. Kambara, D. Dauvergne, R. Kirsch, C. Cohen
Multiple electron capture by 46 MeV/u Pb^{81+} ions from solid targets.
 Phys. Scr. **T92**, 43 (2001)
 $\text{Pb}^{81+} + \text{C}$ Particle Beam-Matter interaction 46.00 MeV/amu Ex
1434. A. P. Zakharov, A. E. Gorodetsky
Behavior of deuterium implanted into W, Be and BeO.
 Phys. Scr. **T94**, 68 (2001)
 $\text{D}^{1+} + \text{Be}$ Particle Beam-Matter interaction 1.80-8.00 keV Ex
 $\text{D}^{1+} + \text{BeO}$ Particle Beam-Matter interaction 1.80-8.00 keV Ex
 $\text{D}^{1+} + \text{W}$ Particle Beam-Matter interaction 1.80-8.00 keV Ex
1435. A. M. Borisov, E. S. Mashkova, E. S. Parilis
The sweeping-out-electrons effect in electron emission under molecular ion bombardment.
 Vacuum **66**, 145 (2002)
 $\text{N}^{1+} + \text{C}$ Particle Beam-Matter interaction 15.00-34.00 keV Ex

3.7 Interactions of Atomic Particles with Fields

1436. V. R. Gonzalez, J. A. Aparicio, J. A. del Val, S. Mar
Stark width and shift measurements of visible Si III lines.
Astron. Astrophys. **363**, 1177 (2000)
 Si^{2+} Inter. of Atomic part. with Fields 1.66-3.26 eV Ex
1437. L. C. Popovic, N. Milovanovic, M. S. Dimitrijevic
The electron-impact broadening effect in hot star atmospheres: The case of singly- and doubly-ionized zirconium.
Astron. Astrophys. **365**, 656 (2001)
 $\text{e} + \text{Zr}^{1+}$ Inter. of Atomic part. with Fields 10.00 K Th
 $\text{e} + \text{Zr}^{2+}$ Inter. of Atomic part. with Fields 10.00 K Th
1438. S. Djenize, S. Bukvic, D. Miskovic
Stark widths and shifts of triply ionized argon spectral lines.
Astron. Astrophys. **367**, 737 (2000)
 Ar^{3+} Inter. of Atomic part. with Fields 3.10-4.96 eV Ex
1439. A. Sreckovic, M. S. Dimitrijevic, S. Djenize
Stark broadening in O III spectrum.
Astron. Astrophys. **371**, 354 (2001)
 O^{2+} Inter. of Atomic part. with Fields 17.00-54.00 K Ex
1440. S. Djenize, A. Sreckovic, M. Jelisavcic, S. Bukvic
Experimental Stark widths and shifts of triply ionized sulfur spectral lines.
Astron. Astrophys. **389**, 1086 (2002)
 S^{3+} Inter. of Atomic part. with Fields 4.00 eV Ex
1441. B. Wallbank, J. K. Holmes
Laser-assisted elastic electron scattering from helium.
Can. J. Phys. **79**, 1237 (2001)
 $\text{e} + \text{He}$ Inter. of Atomic part. with Fields 1.00-20.00 eV Ex
1442. T. K. Fang, K. T. Chung
Electric-field effects on He ground-state photoionization.
J. Phys. B **34**, 1245 (2001)
 He Inter. of Atomic part. with Fields 65.00-72.00 eV Th
1443. K. T. Chung, T. K. Fang, Y. K. Ho
Resonance of helium in a DC field.
J. Phys. B **34**, 165 (2001)
 He Inter. of Atomic part. with Fields $0\text{-}7 \times 10^{-5}$ a.u. Th
1444. S. Demianiuk, K. Kolwas
Dynamics of spontaneous growth of light-induced sodium droplets from the vapour phase.
J. Phys. B **34**, 1651 (2001)
 $\text{Na} + \text{Na}$ Inter. of Atomic part. with Fields 663.00-723.00 K Ex
1445. A. B. Voitkiv, J. Ullrich
Binary-encounter electron emission in fast atomic collisions in the presence of coherent electromagnetic radiation.
J. Phys. B **34**, 1673 (2001)
 $\text{He}^{2+} + \text{H}$ Inter. of Atomic part. with Fields Th

1446. M. Mijatovic, E. A. Solov'ev, K. Taulbjerg
Dynamics of alkali Rydberg atoms in time-varying external fields.
 J. Phys. B **34**, 1897 (2001)

Li	Inter. of Atomic part. with Fields	Th
Li*	Inter. of Atomic part. with Fields	Th
1447. M. V. Ivanov, P. Schmelcher
The boron atom and boron positive ion in strong magnetic fields.
 J. Phys. B **34**, 2031 (2001)

B*	Inter. of Atomic part. with Fields	Th
B	Inter. of Atomic part. with Fields	Th
B^{1+*}	Inter. of Atomic part. with Fields	Th
B¹⁺	Inter. of Atomic part. with Fields	Th
1448. A. Cionga, F. Ehlotzky, G. Zloh
Coherent phase control in electron scattering by hydrogen atoms in a bichromatic laser field.
 J. Phys. B **34**, 2057 (2001)

e + H	Inter. of Atomic part. with Fields	100.00 eV	Th
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1449. O. Reusch, C. Dieste, S. Garnica, G. v. Oppen
Precision measurements of electric-field 1snl singlet-triplet anticrossings of He I using radio frequency spectroscopy.
 J. Phys. B **34**, 2145 (2001)

He + He	Inter. of Atomic part. with Fields	12.00 keV	E/T
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1450. M. Kubasik, A. Cebo, E. Hertz, R. Chaux, B. Lavorel, O. Faucher
Shaping of a ground state rotational wavepacket by frequency-chirped pulses.
 J. Phys. B **34**, 2437 (2001)

N₂	Inter. of Atomic part. with Fields		Ex
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1451. M. V. Ivanov
Complex rotation in two-dimensional mesh calculations for quantum systems in uniform electric fields.
 J. Phys. B **34**, 2447 (2001)

H	Inter. of Atomic part. with Fields		Th
H₂¹⁺	Inter. of Atomic part. with Fields		Th
1452. A. de Castro, J. A. Aparicio, J. A. del Val, V. R. Gonzalez, S. Mar
Measurement of Stark broadening and shift constants of singly ionized krypton lines.
 J. Phys. B **34**, 3275 (2001)

Kr¹⁺	Inter. of Atomic part. with Fields	16.00-24.50 K	Ex
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1453. S. A. Babin, Yu. I. Belousov, S. I. Kablukov, D. A. Shapiro, U. Hinze, M. Klug, B. Wellegehausen
Probe-field spectra of N-scheme in strong inhomogeneous fields.
 J. Phys. B **34**, 3641 (2001)

Na₂	Inter. of Atomic part. with Fields		Ex
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1454. A. B. Voitkiv, J. Ullrich
Modification of energy and angular spectra of binary-encounter emission in fast ion-atom collisions assisted by a low-frequency electromagnetic field.
 J. Phys. B **34**, 4383 (2001)

He²⁺ + H	Inter. of Atomic part. with Fields	12.00 a.u.	Th
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1455. D. Townsend, A. L. Goodgame, S. R. Procter, S. R. Mackenzie, T. P. Softley
Deflection of krypton Rydberg atoms in the field of an electric dipole.
 J. Phys. B **34**, 439 (2001)
 Kr Inter. of Atomic part. with Fields E/T
1456. Th. Wrubel, S. Buescher, H.-J. Kunze, S. Ferri
Balmer- α transition of He II: measurements and calculations.
 J. Phys. B **34**, 461 (2001)
 He Inter. of Atomic part. with Fields 30.00 eV E/T
1457. K. Kim, M. Kwon, H. D. Park, H. S. Moon, H. S. Rawat, K. An, J. B. Kim
Electromagnetically induced absorption spectra depending on intensities and detunings of the coupling field in Cs vapour.
 J. Phys. B **34**, 4801 (2001)
 Cs Inter. of Atomic part. with Fields 1.46 eV E/T
1458. Y. Makdisi, G. Philip, K. S. Bhatia, J.-P. Connerade
The $J = 2$ even-parity spectrum for high members of the Sr I $5snd\ ^{1,3}D_2$ Rydberg series in the presence of electric fields and weak collisions.
 J. Phys. B **34**, 521 (2001)
 Sr + He Inter. of Atomic part. with Fields 1.03 K Ex
 Sr* + He Inter. of Atomic part. with Fields 1.03 K Ex
 Sr + Ar Inter. of Atomic part. with Fields 1.03 K Ex
 Sr* + Ar Inter. of Atomic part. with Fields 1.03 K Ex
 Sr + Xe Inter. of Atomic part. with Fields 1.03 K Ex
 Sr* + Xe Inter. of Atomic part. with Fields 1.03 K Ex
1459. M. Bouzidi, A. Makhoute, D. Khalil, A. Maquet, C. J. Joachain
On the second Born approximation for laser-assisted electron-atom collisions.
 J. Phys. B **34**, 737 (2001)
 e + H Inter. of Atomic part. with Fields 200.00 eV Th
1460. M. Terao-Dunseath, K. M. Dunseath, D. Charlo, A. Hibbert, R. J. Allan
Electron-helium scattering in a Nd-YAG laser field at collision energies near the He(1s2l) thresholds.
 J. Phys. B **34**, L263 (2001)
 e + He Inter. of Atomic part. with Fields 0.65-0.78 a.u. Th
 He Inter. of Atomic part. with Fields 0.65-0.78 a.u. Th
1461. E. Cormier, D. Garzella, P. Breger, P. Agostini, G. Cheriaux, C. LeBlanc
Above-threshold ionization contrast and channel closure in argon.
 J. Phys. B **34**, L9 (2001)
 Ar Inter. of Atomic part. with Fields $6 \cdot 10^{13}$ W/cm² Th
1462. N. Hay, R. Velotta, M. B. Mason, M. Castillejo, J. P. Marangos
High-order harmonic generation efficiency increased by controlled dissociation of molecular iodine.
 J. Phys. B **35**, 1051 (2002)
 I Inter. of Atomic part. with Fields Ex
 I₂ Inter. of Atomic part. with Fields Ex
1463. C. Colon, A. Alonso-Medina
Stark broadening parameters predictions and regularities of singly ionized lead.
 J. Phys. B **35**, 1143 (2002)
 Pb¹⁺ Inter. of Atomic part. with Fields 11.00-24.00 K E/T

1464. A. Neogi, M. Martins, C. McGuinness, G. O'Sullivan, E. T. Kennedy, J.-P. Mosnier, P. van Kampen, J. T. Costello
Vacuum-ultraviolet absorption spectrum of the Rb^{2+} ion in a laser generated plasma.
 J. Phys. B **35**, 1329 (2002)
 Rb^{2+} Inter. of Atomic part. with Fields 110.00-150.00 eV E/T
1465. X. J. Liu, J. W. Cao, M. S. Zhan, J.-P. Connerade
Scaled-energy spectroscopy of strontium $M=0$ Rydberg atoms in an electric field.
 J. Phys. B **35**, 2069 (2002)
 Sr^* Inter. of Atomic part. with Fields Ex
 Sr Inter. of Atomic part. with Fields Ex
1466. E. Oks
Reduction of spectral line shifts due to the acceleration of electrons by the ion field in plasmas.
 J. Phys. B **35**, 2251 (2002)
 H Inter. of Atomic part. with Fields Th
1467. Z. Q. Wu, G. X. Han, J. Yan, J. Q. Pang
Plasma effects on electron impact ionization.
 J. Phys. B **35**, 2305 (2002)
 $e + \text{Ge}^{1+}$ Inter. of Atomic part. with Fields 2.00-40.00 keV Th
 $e + \text{Au}^{48+}$ Inter. of Atomic part. with Fields 2.00-40.00 keV Th
1468. A. Devdariani, E. Bichoutskaia, E. Tchesnokov, T. Bichoutskaia, D.S.F Crothers, E. Leboucher-Dalimier, P. Sauvan, P. Angelo
Semiclassical analytical approach to the description of quasimolecular optical transitions.
 J. Phys. B **35**, 2469 (2002)
 $\text{Ca} + \text{He}$ Inter. of Atomic part. with Fields 0.00-1.00 K E/T
1469. J. Rao, K. T. Taylor
The closed orbits and the photo-excitation scaled spectrum of the hydrogen atom in crossed fields.
 J. Phys. B **35**, 2627 (2002)
 H^* Inter. of Atomic part. with Fields Th
 H Inter. of Atomic part. with Fields Th
1470. M. Forre, D. Fregenal, J. C. Day, T. Ehrenreich, J.-P. Hansen, B. Henningsen, E. Horsdal-Pedersen, L. Nyvang, O. E. Povlsen, K. Taulbjerg, I. Vogelius
Dynamics of a single Rydberg shell in time dependent external fields.
 J. Phys. B **35**, 410 (2002)
 Li Inter. of Atomic part. with Fields Ex
1471. N. M. Cann, A. J. Thakkar
Quadrupole oscillator strengths for the helium isoelectronic sequence: $n\ ^1\text{S}-m\ ^1\text{D}$, $^3\text{S}-m\ ^3\text{D}$, $n\ ^1\text{P}-m\ ^1\text{P}$, and $n\ ^3\text{P}-m\ ^3\text{P}$ transitions with $n \leq 7$ and $m \leq 7$.
 J. Phys. B **35**, 421 (2002)
 He Inter. of Atomic part. with Fields Th
1472. S.-M. Li, J. Chen, Z.-F. Zhou
Ionization of atomic hydrogen by protons in the presence of a laser field.
 J. Phys. B **35**, 557 (2002)
 $\text{H}^{1+} + \text{H}$ Inter. of Atomic part. with Fields 0.00-1.00 MeV Th

1473. V. I. Usachenko, V. A. Pazdersky
High-order harmonic generation in a strong laser field: an alternative quantum-mechanical model.
 J. Phys. B **35**, 761 (2002)

H ⁻¹⁺	Inter. of Atomic part. with Fields		Th
He	Inter. of Atomic part. with Fields		Th
Ar	Inter. of Atomic part. with Fields		Th
Xe	Inter. of Atomic part. with Fields		Th
1474. A. Makhoute, D. Khalil, M. Zitane, M. Bouzidi
The second Born approximation in electron-atom collisions in the presence of a laser field.
 J. Phys. B **35**, 957 (2002)

e + H	Inter. of Atomic part. with Fields	200.00 eV	Th
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1475. E. A. Volkova, A. M. Popov, O. V. Tikhonova
Resonant multiphoton ionization of the 1s state of a hydrogen atom in a strong laser field.
 Opt. Spectrosc. **88**, 1 (2000)

H	Inter. of Atomic part. with Fields	5.00 eV	Th
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1476. J. Shertzer, C. H. Greene
Nonadiabatic dipole polarizabilities of H₂⁺ and D₂⁺ ground states.
 Phys. Rev. A **58**, 1082 (1998)

H ₂ ¹⁺	Inter. of Atomic part. with Fields		Th
D ₂ ¹⁺	Inter. of Atomic part. with Fields		Th
1477. R. J. Rafac, C. E. Tanner
Measurement of the ratio of the cesium D-line transition strengths.
 Phys. Rev. A **58**, 1087 (1998)

Cs	Inter. of Atomic part. with Fields		Ex
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1478. D. Azinovic, R. Bruckmeier, C. Wunderlich, H. Figger, G. Theodorakopoulos, I. D. Petsalakis
Dynamics on the ground-state potential surfaces of H₃ and its isotopomers from their uv spectra.
 Phys. Rev. A **58**, 1115 (1998)

H ₃	Inter. of Atomic part. with Fields	3.10-6.20 eV	Ex
HD ₂	Inter. of Atomic part. with Fields	3.10-6.20 eV	Ex
D ₃	Inter. of Atomic part. with Fields	3.10-6.20 eV	Ex
1479. M. Meyer, A. Marquette, A. N. Grum-Grzhimailo, U. Kleiman, B. Lohmann
Polarization analysis of fluorescence probing the alignment of Xe⁺ ions in the resonant Auger decay of the Xe* 4d_{5/2}⁻¹6p photoexcited state.
 Phys. Rev. A **64**, 022703 (2001)

Xe	Inter. of Atomic part. with Fields	2.03-3.10 eV	Ex
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1480. P. Schmelcher, T. Detmer, L. S. Cederbaum
Excited states of the hydrogen molecule in magnetic fields: The triplet Σ states of the parallel configuration.
 Phys. Rev. A **64**, 023410 (2001)

H	Inter. of Atomic part. with Fields		Th
H + H	Inter. of Atomic part. with Fields		Th
1481. S. Boehm, S. Schippers, W. Shi, A. Mueller, N. Djuric, G. H. Dunn, W. Zong, B. Jelenkovic, H. Danared, N. Ekloew, P. Glans, R. Schuch
Influence of electromagnetic fields on the dielectronic recombination of Ne⁷⁺ ions.
 Phys. Rev. A **64**, 032707 (2001)

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|--|----------------------|------------------------------------|----------|----|
| | $e + \text{Ne}^{7+}$ | Inter. of Atomic part. with Fields | 18.00 eV | Ex |
|--|----------------------|------------------------------------|----------|----|
1482. K. A. Bates, J. Masae, C. Vasilescu, D. Schumacher
Highly perturbed states of barium in a static electric field.
 Phys. Rev. A **64**, 033409 (2001)
- | | | | | |
|--|-----------|------------------------------------|--|----|
| | Ba | Inter. of Atomic part. with Fields | | Ex |
|--|-----------|------------------------------------|--|----|
1483. O. V. Gritsenko, E. J. Baerends
Orbital structure of the Kohn-Sham exchange potential and exchange kernel and the field-counteracting potential for molecules in an electric field.
 Phys. Rev. A **64**, 042506 (2001)
- | | | | | |
|--|-----------------------|------------------------------------|--|----|
| | He₂ | Inter. of Atomic part. with Fields | | Th |
|--|-----------------------|------------------------------------|--|----|
1484. A. Cionga, F. Ehlotzky, G. Zloh
Elastic electron scattering by excited hydrogen atoms in a laser field.
 Phys. Rev. A **64**, 043401 (2001)
- | | | | | |
|--|------------------|------------------------------------|------------------|----|
| | $e + \text{H}$ | Inter. of Atomic part. with Fields | 100.00-500.00 eV | Th |
| | $e + \text{H}^*$ | Inter. of Atomic part. with Fields | 100.00-500.00 eV | Th |
1485. X. Guan, B. Li, L. Wu
Strong magnetic-field effects on the states of the helium negative ion below the He (N=2) threshold.
 Phys. Rev. A **64**, 043402 (2001)
- | | | | | |
|--|-------------------------|------------------------------------|--|----|
| | He⁻¹⁺ | Inter. of Atomic part. with Fields | | Th |
|--|-------------------------|------------------------------------|--|----|
1486. I. Kawata, H. Kono, A. D. Bandrauk
Mechanism of enhanced ionization of linear H₃⁺ in intense laser fields.
 Phys. Rev. A **64**, 043411 (2001)
- | | | | | |
|--|-----------------------------------|------------------------------------|--|----|
| | H₃¹⁺ | Inter. of Atomic part. with Fields | | Th |
|--|-----------------------------------|------------------------------------|--|----|
1487. J. S. Cohen
Reexamination of over-the-barrier and tunneling ionization of the hydrogen atom in an intense field.
 Phys. Rev. A **64**, 043412 (2001)
- | | | | | |
|--|----------|------------------------------------|--|----|
| | H | Inter. of Atomic part. with Fields | | Th |
|--|----------|------------------------------------|--|----|
1488. G. D. Gillen, M. A. Walker, L. D. van Woerkom
Enhanced double ionization with circularly polarized light.
 Phys. Rev. A **64**, 043413 (2001)
- | | | | | |
|--|-----------|------------------------------------|---------|----|
| | Mg | Inter. of Atomic part. with Fields | 1.55 eV | Ex |
|--|-----------|------------------------------------|---------|----|
1489. B. L. Tolra, C. Drag, P. Pillet
Observation of cold state-selected cesium molecules formed by stimulated Raman photoassociation.
 Phys. Rev. A **64**, 061401 (2001)
- | | | | | |
|--|----------------|------------------------------------|---------|----|
| | Cs + Cs | Inter. of Atomic part. with Fields | 0.13 mK | Ex |
|--|----------------|------------------------------------|---------|----|
1490. X. Chu, S.-I. Chu
Time-dependent density-functional theory for molecular processes in strong fields: Study of multiphoton processes and dynamical response of individual valence electrons of N₂ in intense laser fields.
 Phys. Rev. A **64**, 063404 (2001)
- | | | | | |
|--|----------------------|------------------------------------|--------------|----|
| | N₂ | Inter. of Atomic part. with Fields | 1.17-1.55 eV | Th |
|--|----------------------|------------------------------------|--------------|----|

1491. W. Chism, L. E. Reichl
Rydberg atoms in circular polarization: Classical stabilization in optical frequency fields.
 Phys. Rev. A **65**, 021404 (2002)
H Inter. of Atomic part. with Fields 10^{12} - 10^{15} W/cm² Th
1492. L. N. Gaier, C. H. Keitel
Relativistic classical Monte Carlo simulations of stabilization of hydrogenlike ions in intense laser pulses.
 Phys. Rev. A **65**, 023406 (2002)
H Inter. of Atomic part. with Fields Th
He¹⁺ Inter. of Atomic part. with Fields Th
Li²⁺ Inter. of Atomic part. with Fields Th
1493. G. N. Rockwell, V. F. Hoffman, Th. Clausen, R. Bluemel
Realistic three-dimensional computations of microwave-ionization curves of hydrogen Rydberg atoms.
 Phys. Rev. A **65**, 025401 (2002)
H Inter. of Atomic part. with Fields 200.00-500.00 V/cm Th
1494. W. Becken, P. Schmelcher
Electromagnetic transitions of the helium atom in a strong magnetic field.
 Phys. Rev. A **65**, 033416 (2002)
He Inter. of Atomic part. with Fields Th
1495. S. Vucic
e-H collisions in a resonant monochromatic or bichromatic laser field.
 Phys. Rev. A **65**, 033521 (2002)
e + H Inter. of Atomic part. with Fields 10^9 - 10^{11} W/cm² Th
1496. D. B. Milosevic and, F. Ehlötzky
Rescattering effects in soft-x-ray generation by laser-assisted electron-ion recombination.
 Phys. Rev. A **65**, 042504 (2002)
e + H Inter. of Atomic part. with Fields 500.00 eV Th
e + He Inter. of Atomic part. with Fields 500.00 eV Th
1497. A. Datta, S. S. Bhattacharyya, B. Kim
Effects of chirping on the dissociation dynamics of H₂ in a two-frequency laser field.
 Phys. Rev. A **65**, 043404 (2002)
H₂ Inter. of Atomic part. with Fields 13.10-13.10 eV Th
1498. K. Ishikawa, K. Midorikawa
Two-photon ionization of He⁺ as a nonlinear optical effect in the soft-x-ray region.
 Phys. Rev. A **65**, 043405 (2002)
He¹⁺ Inter. of Atomic part. with Fields 40.60-42.00 eV Th
1499. A. Volpi, J. L. Bohn
Magnetic-field effects in ultracold molecular collisions.
 Phys. Rev. A **65**, 052712 (2002)
He + O₂ Inter. of Atomic part. with Fields 0.00-5.00 K Th
1500. S. Boehm, S. Schippers, W. Shi, A. Mueller, N. Ekloew, R. Schuch, H. Danared, N. R. Badnell, D. M. Mitnik, D. C. Griffin
Measurement of the field-induced dielectronic-recombination-rate enhancement of O⁵⁺ ions differential in the Rydberg quantum number n.
 Phys. Rev. A **65**, 052728 (2002)

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|--|--------------|------------------------------------|---------------|-----|
| | $e + O^{5+}$ | Inter. of Atomic part. with Fields | 2.00-12.00 eV | E/T |
|--|--------------|------------------------------------|---------------|-----|
1501. S. Freund, R. Ubert, E. Floethmann, K. Welge, D. M. Wang, J. B. Delos
Absorption and recurrence spectra of hydrogen in crossed electric and magnetic fields.
Phys. Rev. A **65**, 053408 (2002)
- | | | | | |
|--|----------|------------------------------------|---------|-----|
| | H | Inter. of Atomic part. with Fields | 3.40 eV | E/T |
|--|----------|------------------------------------|---------|-----|
1502. M. Forre, H. M. Nilsen, J. P. Hansen
Dynamics of a H(n) atom in time-dependent electric and magnetic fields.
Phys. Rev. A **65**, 053409 (2002)
- | | | | | |
|--|----------|------------------------------------|--|-----|
| | H | Inter. of Atomic part. with Fields | | E/T |
|--|----------|------------------------------------|--|-----|
1503. V. Kokoouline, C. Drag, P. Pillet, F. Masnou-Seeuws
Lu-Fano plot for interpretation of the photoassociation spectra.
Phys. Rev. A **65**, 062710 (2002)
- | | | | | |
|--|----------------|------------------------------------|--|----|
| | Cs + Cs | Inter. of Atomic part. with Fields | | Th |
|--|----------------|------------------------------------|--|----|
1504. W. R. Anderson, M. P. Robinson, J.D.D. Martin, T. F. Gallagher
Dephasing of resonant energy transfer in a cold Rydberg gas.
Phys. Rev. A **65**, 063404 (2002)
- | | | | | |
|--|------------------|------------------------------------|----------------|----|
| | Rb* + Rb* | Inter. of Atomic part. with Fields | 3.00-3.40 V/cm | Ex |
| | Rb + Rb | Inter. of Atomic part. with Fields | 3.00-3.40 V/cm | Ex |
1505. R. G. DeVoe, C. Kurtsiefer
Experimental study of anomalous heating and trap instabilities in a microscopic ^{137}Ba ion trap.
Phys. Rev. A **65**, 063407 (2002)
- | | | | | |
|--|-----------------------------|------------------------------------|--|----|
| | Ba^{1+} | Inter. of Atomic part. with Fields | | Ex |
|--|-----------------------------|------------------------------------|--|----|
1506. C. M. Dion, A. Ben Haj-Yedder, E. Cancès, C. Le Bris, A. Keller, O. Atabek
Optimal laser control of orientation: The kicked molecule.
Phys. Rev. A **65**, 063408 (2002)
- | | | | | |
|--|------------|------------------------------------|--------------|----|
| | HCN | Inter. of Atomic part. with Fields | 0.06-0.17 eV | Th |
|--|------------|------------------------------------|--------------|----|
1507. D. V. Kupriyanov, I. M. Sokolov, A. V. Slavgorodskii
Polarization-sensitive coherent control of atomic collisions with nonclassical light.
Phys. Rev. A **65**, 063412 (2002)
- | | | | | |
|--|----------------|------------------------------------|--|----|
| | Mg + Ne | Inter. of Atomic part. with Fields | | Th |
|--|----------------|------------------------------------|--|----|
1508. A. Hoffknecht, O. Uwira, S. Schennach, A. Frank, J. Haselbauer, W. Spies, N. Angert, P. H. Mokler, R. L. Becker, M. Kleinod, S. Schippers, A. Mueller
Influence of magnetic fields on recombination rates of Au^{25+} .
Phys. Scr. **T80**, 316 (1999)
- | | | | | |
|--|-----------------------|------------------------------------|--------------|----|
| | $e + \text{Au}^{25+}$ | Inter. of Atomic part. with Fields | 0.00-1.00 eV | Ex |
|--|-----------------------|------------------------------------|--------------|----|
1509. S. Schippers, T. Bartsch, S. Boehm, G. Gwinner, D. Schwalm, A. Wolf, R. A. Phaneuf, R. H. Schuch, A. Mueller
Field enhanced dielectronic recombination of lithiumlike Ti^{19+} and Ni^{25+} ions.
Phys. Scr. **T92**, 391 (2001)
- | | | | | |
|--|-----------------------|------------------------------------|--|----|
| | $e + \text{Ti}^{19+}$ | Inter. of Atomic part. with Fields | | Ex |
| | $e + \text{Ni}^{25+}$ | Inter. of Atomic part. with Fields | | Ex |
1510. S. Boehm, S. Schippers, W. Shi, A. Mueller, N. Djuric, G. H. Dunn, W. Zong, B. Jelencovic, N. Eklow, P. Glans, R. Schuch, H. Dananred, N. R. Badnell
Influence of electromagnetic fields on the dielectronic recombination of Ne^{7+} and O^{5+} ions.
Phys. Scr. **T92**, 395 (2001)

$e + O^{5+}$	Inter. of Atomic part. with Fields	Ex
$e + Ne^{7+}$	Inter. of Atomic part. with Fields	Ex

1511. A. Hoffknecht, C. Brandau, T. Bartsch, C. Coehme, H. Knopp, S. Schippers, A. Mueller, C. Kozhuharov, K. Beckert, F. Bosch, B. Franzke, A. Kraemer, P. H. Mokler, F. Nolden, M. Steck, Th. Stoehlker, Z. Stachura

Recombination of bare Bi^{83+} ions with electrons.

Phys. Scr. **T92**, 398 (2001)

$e + Bi^{83+}$	Inter. of Atomic part. with Fields	0.00-100.00 eV	Ex
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